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MOTOROLA INC.

SCHOTTKY TTL DATA

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Prepared by
Technical Information Center

Low Power Schottky (LSTTL) has become the industry standard logic in recent years, replacing the original 7400 TTL with lower power and higher speeds. In addition to offering the standard LS TTL circuits, Motorola offers the Advanced Low Power Schottky TTL family (ALS) and the FAST Schottky TTL family. Complete specifications for each of these families are provided in data sheet form. Functional selector guides not only provide an overview of already introduced devices but planned introduction dates of new products.

This book also provides data sheets for TTL RAMs/PROMs and information regarding circuit characteristics, design considerations and testing, reliability data and package outlines.

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Series D
Third Printing

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SCHOTTKY TTL

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TTL in Perspective

Since its introduction, TTL has become the most popular digital logic family. It has evolved from gold doped saturated logic, to Schottky clamped logic and finally to Advanced Schottky clamped logic. The popularity of TTL stems from its ease of use, low cost, medium-to-high speed operation, and good output drive capability.

Motorola offers three Schottky clamped TTL logic families — LS, ALS, and FAST™. All three families are pin and functionally compatible and can easily be combined in a system to achieve maximum performance at minimum cost.

LS, Low-Power Schottky, is currently the largest and most popular of the three. It is low-cost and provides moderate speed at low power.

ALS, Advanced Low-Power Schottky, offers an improved speed — power product compared to LS as a result of advanced MOSAIC (oxide isolated) processing. Other important features of ALS include improved noise margins, reduced input currents, and superior line driving characteristics.

FAST™, another advanced Schottky TTL line, offers a 20-to-30 percent improvement in speed over standard Schottky logic at about 20 percent of the power. As with ALS, FAST™ offers improved noise margins, reduced input currents and superior line driving characteristics. Additionally, FAST designs incorporate powerdown circuitry on three-state outputs, and buffered outputs on all storage devices. These design improvements provide the logic designer with additional flexibility and more reliable system operation.

TTL Family Comparisons

General Characteristics for Schottky TTL Logic

(ALL MAXIMUM RATINGS)		LS		ALS			FAST		
Characteristic	**Symbol**	**54LSxxx**	**74LSxxx**	**54ALSxxx**	**74ALSxxx**		**54Fxxx**	**74Fxxx**	**Units**
Operating Voltage Range	V_{CC}	5 ± 10%	5 ± 5%	5 ± 10%	5 ± 10%	5 ± 5%	5 ± 10%	5 ± 5%	Vdc
Operating Temperature Range	T_A	−55 to 125	0 to 70	−55 to 125	0 to 70	0 to 70	−55 to 125	0 to 70	°C
Input Current	I_{IH}	20	20	20	20	20	20	20	μA
	I_{IL}	−400	−400	−100	−100	−100	−600	−600	
Output Drive	I_{OH}	−0.4	−0.4	−0.4	−0.4	−0.4	−1.0	−1.0	mA
Standard Output	I_{OL}	4.0	8.0	4.0	8.0	8.0	20	20	mA
	I_{SC}	−20 to −100	−20 to −100	−25 to −150	−25 to −150	−25 to −150	−60 to −150	−60 to −150	mA
	I_{OH}	−12	−15	−12	−15	−15	−12	−15	mA
Buffer Output	I_{OL}	12	24	12	24	24	48	64	mA
	I_{SC}	−40 to −225	−40 to −225	−50 to −225	−50 to −225	−50 to −225	−100 to −225	−100 to −225	mA
Buffer Line Driving Capability: Minimum R_t into 2.5 V		178	84	178	84	84	43	32	Ω
Minimum R_t into 5.0 V		381	189	381	189	189	95	71	Ω

Speed/Power Characteristics for Schottky TTL Logic(1)

(ALL TYPICAL RATINGS)

Characteristic	Symbol	LS	ALS	FAST	Units
Quiescent Supply Current/Gate	I_G	0.4	0.2	1.1	mA
Power/Gate (Quiescent)	P_G	2.0	1.0	5.5	mW
Propagation Delay	t_p	9.0	5.0	3.7	ns
Speed Power Product	—	18	5.0	19.2	pJ
Clock Frequency (D-F/F)	f_{max}	33	35	125	MHz
Clock Frequency (Counter)	f_{max}	40	45	125	MHz

NOTES: 1. Specifications are shown for the following conditions:
a) V_{CC} = 5.0 Vdc (AC);
b) T_A = 25°C
c) C_L = 50 pF for ALS, FAST; 15 pF for LS

FAST is a trademark of Fairchild Camera and Instrument Corporation.
MOSAIC I is a trademark of Motorola Inc.

High Performance ALS-TTL-Compatible Macrocell Arrays

MCA500ALS MCA1300ALS MCA2800ALS

In addition to standard logic lines, Motorola also offers a variety of TTL-compatible Macrocell Arrays. These products provide a means for developing economical custom LSI/VLSI logic circuits. Performance is achieved by the combination of an advanced MOSAIC I (Motorola Oxide-Isolated Self-Aligned Implanted Circuit) oxide isolated bipolar integrated circuit process and a series gated emitter-coupled logic (ECL) macrocell circuit technology. Input and output circuits provide level translation to and from the internal array logic for standard TTL/MOS interface.

Each cell within the arrays contains a number of unconnected transistors and resistors. Stored within a computer are the specifications to automatically interconnect these elements forming SSI/MSI logic cells (rather than simple gates) called macrocells. These macrocells take the form of standard logic blocks such as dual type D flip-flops, dual full adders, quad latches and many other pre-defined "library" functions. Presently, the macrocell library for the ALS-TTL arrays contains more than 80 logic functions.

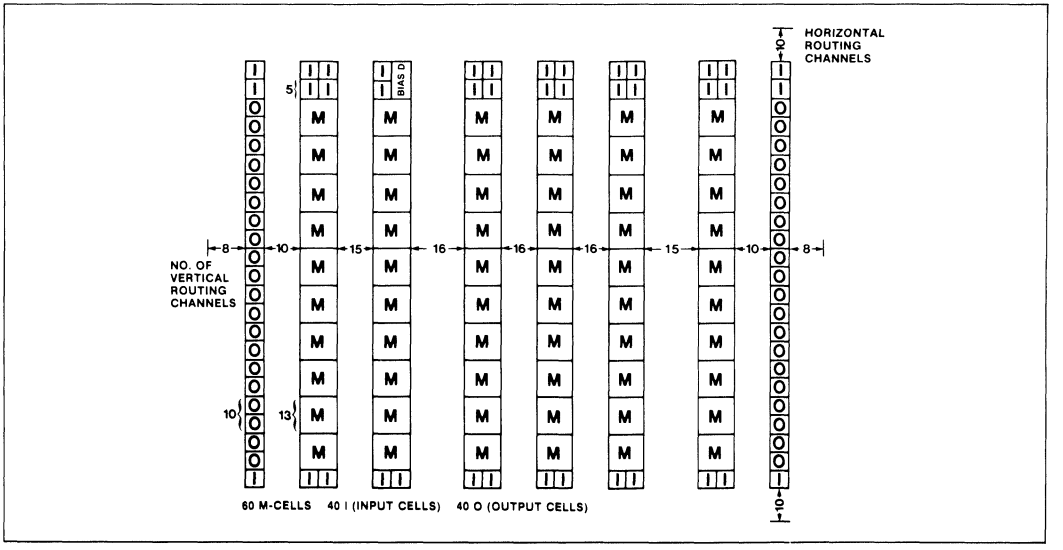
Generating an LSI/VLSI design is simply a matter of selecting the appropriate macrocells and describing the proper interconnection network to implement the design. Motorola's CAD (Computer-Aided-Design) interface provides automatic placement and routing of the cells (interconnection of the cell itself is automatically accomplished when placed), full logic and fault-testing capabilities, AC delay simulations, generation of test tapes and custom metallization to complete the IC processing sequence.

The ability to stockpile fully diffused wafers provides a very fast turnaround time (the time from customer notification of a completed design to delivery of finished parts) of currently nine weeks.

ALS-TTL MCA Selection Chart

	MCA 500ALS	MCA 1300ALS	MCA 2800ALS
Configuration			
Max Gate Equivalent	533	1280	2720
Major Macrocells	24	60	130
I/O Ports	57	76	120
Input/Interface Cells	26	40	
Output Macrocells	24	40	
Performance			
Max Gate Delay (M Cell)	4.0 ns	3.0 ns	1.1 ns
Max Toggle Frequency	80 MHz	80 MHz	125 MHz
Maximum Power Dissipation	1.0 W	1.4 W	2.5 W
Packages			
Dual-In-Line	28, 40, 48	40, 48	—
Chip Carrier	68	68, 84	149PG
Temperature Range	0–70°C	0–70°C	0–70°C
Supply Voltage	5.0 V ±5%	5.0 V ±5%	5.0 V ±5%
Availability	Now	Now	Now

Typical MCA Layout — 1300ALS



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LS TTL

SN54LS00 Series (−55 to +125°C)
SN74LS00 Series (0 to +70°C)

Suffix: N . . . Plastic (only 74-series)
J . . . Ceramic (54/74 series)

Device	Function	Samples	Pins
LS00	Quad 2-Input NAND Gate	A	14
LS01	Quad 2-Input NAND Gate, Open-Collector	A	14
LS02	Quad 2-Input NOR Gate	A	14
LS03	Quad 2-Input NAND Gate, Open-Collector	A	14
LS04	Hex Inverter	A	14
LS05	Hex Inverter, Open-Collector	A	14
LS08	Quad 2-Input AND Gate	A	14
LS09	Quad 2-Input AND Gate, Open-Collector	A	14
LS10	Triple 3-Input NAND Gate	A	14
LS11	Triple 3-Input AND Gate	A	14
LS12	Triple 3-Input NAND Gate, Open-Collector	A	14
LS13	Dual 4-Input Schmitt Trigger	A	14
LS14	Hex Schmitt Trigger	A	14
LS15	Triple 3-Input AND Gate, Open-Collector	A	14
LS20	Dual 4-Input NAND Gate	A	14
LS21	Dual 4-Input AND Gate	A	14
LS22	Dual 4-Input NAND Gate, Open-Collector	A	14
LS26	Quad 2-Input NAND, High Voltage	A	14
LS27	Triple 3-Input NOR Gate	A	14
LS28	Quad 2-Input NOR Buffer	A	14
LS30	8-Input NAND Gate	A	14
LS32	Quad 2-Input OR Gate	A	14
LS33	Quad 2-Input NOR Buffer, Open-Collector	A	14
LS37	Quad 2-Input NAND Buffer	A	14
LS38	Quad 2-Input NAND Buffer, Open-Collector	A	14
LS40	Dual 4-Input NAND Buffer	A	14
LS42	1-of-10 Decoder	A	16
LS47	BCD to 7-Segment Decoder/Driver, Open-Collector	A	16
LS48	BCD to 7-Segment Decoder/Driver, with Pull-Ups	A	16
LS49	BCD to 7-Segment Decoder/Driver, Open-Collector	A	16
LS51	Dual AND-OR-INVERT Gate	A	14
LS54	3-2-2-3 Input AND-OR-INVERT Gate	A	14
LS55	2-Wide 4-Input AND-OR-INVERT Gate	A	14
LS73A	Dual JK Flip-Flop	A	14
LS74A	Dual D Flip-Flop	A	14
LS75	4-Bit Bi-Stable Latch with Q and $\overline{Q}$	A	16
LS76A	Dual JK Flip-Flop	A	16
LS77	4-Bit Bi-Stable Latch	A	14
LS78A	Dual JK Flip-Flop with Preset	A	14
LS83A	4-Bit Full Adder	A	16
LS85	4-Bit Magnitude Comparator	A	16
LS86	Quad Exclusive OR Gate	A	14

A = Announced

Device	Function	Samples	Pins
LS90	Decade Counter	A	14
LS91	8-Bit Shift Register Serial-In/Serial-Out	A	14
LS92	Divide-By-12 Counter	A	14
LS93	4-Bit Binary Counter	A	14
LS95B	4-Bit Shift Register	A	14
LS107A	Dual JK Flip-Flop with Clear	A	14
LS109A	Dual JK Flip-Flop with Preset	A	16
LS112A	Dual JK Edge-Triggered Flip-Flop	A	16
LS113A	Dual JK Edge-Triggered Flip-Flop	A	14
LS114A	Dual JK Edge-Triggered Flip-Flop	A	14
LS122	Retriggerable Monostable Multivibrator	A	14
LS123	Dual Retriggerable Monostable Multivibrator	A	16
LS125A	Quad Buffer, Low Enable, 3-State	A	14
LS126A	Quad Buffer, High Enable, 3-State	A	14
LS132	Quad 2-Input Schmitt Trigger	A	14
LS133	13-Input NAND Gate	A	16
LS136	Quad Exclusive OR Gate, Open-Collector	A	14
LS137	3-Line to 8-Line Decoder/Demultiplexer	A	16
LS138	1-of-8 Decoder/Demultiplexer	A	16
LS139	Dual 1-of-4 Decoder/Demultiplexer	A	16
LS145	1-of-10 Decoder/Driver, Open-Collector	A	16
LS147	10-Line Decimal to 4-Line Priority Encoder	A	16
LS148	8-Input to 3-Line Priority Encoder	A	16
LS151	8-Input Multiplexer	A	16
LS153	Dual 4-Input Multiplexer	A	16
LS155	Dual 1-of-4 Decoder	A	16
LS156	Dual 1-of-4 Decoder, Open-Collector	A	16
LS157	Quad 2-Input Multiplexer, Non-Inverting	A	16
LS158	Quad 2-Input Multiplexer, Inverting	A	16
LS160	BCD Decade Counter, Asynchronous Reset (9310 Type)	A	16
LS161A	4-Bit Binary Counter, Asynchronous Reset (9316 Type)	A	16
LS162A	BCD Decade Counter, Synchronous Reset	A	16
LS163A	4-Bit Binary Counter, Synchronous Reset	A	16
LS164	8-Bit Serial-In/Parallel-Out Shift Register	A	14
LS165	8-Bit Parallel-In/Serial-Out Shift Register	A	16
LS166	8-Bit Parallel-In/Serial-Out Shift Register	A	16
LS168	Up/Down Decade Counter	A	16
LS169	Up/Down Binary Counter	A	16
LS170	4 x 4 Register File, Open-Collector	A	16
LS173A	4-Bit D Register, 3-State	A	16
LS174	Hex D Flip-Flop with Clear	A	16
LS175	Quad D Flip-Flop with Clear	A	16
LS181	4-Bit ALU	A	24
LS182	Look Ahead Carry Generator	A	16
LS183	Dual Carry/Save Full Adder	A	14
LS190	Up/Down Decade Counter	A	16
LS191	Up/Down Binary Counter	A	16
LS192	Up/Down Decade Counter with Clear	A	16
LS193	Up/Down Binary Counter with Clear	A	16
LS194A	4-Bit Right/Left Shift Register	A	16
LS195A	4-Bit Shift Register (9300 Type)	A	16
LS196	Decade Counter, Asynchronously Presettable	A	14
LS197	4-Bit Binary Counter, Asynchronously Presettable	A	14

Device	Function	Samples	Pins
LS221	Dual One-Shot (Very Stable)	A	16
LS240	Octal Bus/Line Driver, Inverting 3-State	A	20
LS241	Octal Bus/Line Driver, 3-State	A	20
LS242	Quad Bus Transceiver, Inverting, 3-State	A	14
LS243	Quad Bus Transceiver, Non-Inverting, 3-State	A	14
LS244	Octal Driver, Non-Inverting, 3-State	A	20
LS245	Octal Bus Transceiver, Non-Inverting, 3-State	A	20
LS247	BCD to 7-Segment Decoder/Driver, Open-Collector	A	16
LS248	BCD to 7-Segment Decoder/Driver with Pull-Ups	A	16
LS249	BCD to 7-Segment Decoder/Driver, Open-Collector	A	16
LS251	8-Input Multiplexer, 3-State	A	16
LS253	Dual 4-Input Multiplexer, 3-State	A	16
LS256	Dual 4-Bit Addressable Latch	A	16
LS257A	Quad 2-Input Multiplexer, Non-Inverting, 3-State	A	16
LS258A	Quad 2-Input Multiplexer, Inverting 3-State	A	16
LS259	8-Bit Addressable Latch (9334)	A	16
LS260	Dual 5-Input NOR Gate	A	14
LS266	Quad Exclusive NOR Gate, Open-Collector	A	14
LS273	Octal D Flip-Flop with Clear	A	20
LS279	Quad Set/Reset Latch	A	16
LS280	8-Bit Odd/Even Parity Generator/Checker	A	14
LS283	4-Bit Full Adder (Rotated LS83A)	A	16
LS290	Decade Counter (Divide By 2 and 5)	A	14
LS293	4-Bit Binary Counter	A	16
LS295A	4-Bit Shift Register, 3-State	A	14
LS298	Quad 2-Multiplexer, with Output Register	A	16
LS299	8-Bit Shift/Storage Register, 3-State	A	20
LS322A	8-Bit Shift Register with Sign Extend, 3-State	A	20
LS323	8-Bit Shift/Storage Register, 3-State	A	20
LS348	8-Input to 3-Line Priority Encoder, 3-State	A	16
LS352	Dual 4-Multiplexer (Inverting LS153)	A	16
LS353	Dual 4-Multiplexer (3-State LS352)	A	16
LS365A	Hex Buffer, Common Enable, 3-State	A	16
LS366A	Hex Inverter, Common Enable, 3-State	A	16
LS367A	Hex Buffer, 4-Bit and 2-Bit, 3-State	A	16
LS368A	Hex Inverter, 4-Bit and 2-Bit, 3-State	A	16
LS373	Octal Transparent Latch, 3-State	A	20
LS374	Octal D Flip-Flop, 3-State	A	20
LS375	Quad Latch	A	16
LS377	Octal D Flip-Flop with Enable	A	20
LS378	Hex D Flip-Flop with Enable	A	16
LS379	4-Bit D Flip-Flop with Enable	A	16
LS385	Quad 4-Bit Adder/Subtractor	A	20
LS386	2-Input Quad/Exclusive OR Gate	A	14
LS390	Dual Decade Counter	A	16
LS393	Dual 4-Bit Binary Counter	A	14
LS395	4-Bit Shift Register, 3-State	A	16
LS398	Quad 2-Input Multiplexer with Output Register	A	20
LS399	Quad 2-Input Multiplexer with Output Register	A	16

Device	Function	Samples	Pins
LS490	Dual Decade Counter	A	16
LS540	Octal Buffer/Line Driver, 3-State	A	20
LS541	Octal Buffer/Line Driver, 3-State	A	20
LS568	Decade Up/Down Counter, 3-State	A	20
LS569	Binary Up/Down Counter, 3-State	A	20
LS604	16-to-8 Multiplexer, 3-State	A	28
LS605	16-to-8 Multiplexer, Open-Collector	A	28
LS606	16-to-8 Multiplexer, 3-State	A	28
LS607	16-to-8 Multiplexer, Open-Collector	A	28
LS620	Octal Transceiver with Storage, 3-State	A	20
LS621	Octal Transceiver with Storage, Open-Collector	A	20
LS622	Octal Transceiver with Storage, Open-Collector	A	20
LS623	Octal Transceiver with Storage, 3-State	A	20
LS640	Octal Bus Transceiver, Inverting, 3-State	A	20
LS641	Octal Bus Transceiver, Non-Inverting, Open-Collector	A	20
LS642	Octal Bus Transceiver, Inverting, Open-Collector	A	20
LS643	Octal Bus Transceiver, True, Inverting, 3-State	A	20
LS644	Octal Bus Transceiver, True, Inverting, Open-Collector	A	20
LS645	Octal Bus Transceiver, Non-Inverting, 3-State	A	20
LS668	Synchronous 4-Bit Up/Down Decade Counter	A	16
LS669	Synchronous 4-Bit Up/Down Binary Counter	A	16
LS670	4 x 4 Register File, 3-State	A	16
LS673	16-Bit Serial-In/Serial-Out Shift Register, 3-State	A	24
LS674	16-Bit Parallel-In/Serial-Out Shift Register, 3-State	A	24
LS682	8-Bit Magnitude Comparator	A	20
LS683	8-Bit Magnitude Comparator, Open-Collector	A	20
LS684	8-Bit Magnitude Comparator	A	20
LS685	8-Bit Magnitude Comparator, Open-Collector	A	20
LS686	8-Bit Magnitude Comparator with Enable	A	24
LS687	8-Bit Magnitude Comparator with Enable	A	24
LS688	8-Bit Magnitude Comparator	A	20
LS689	8-Bit Magnitude Comparator, Open-Collector	A	20
LS716	Programmable Decade Counter (MC4016)	A	16
LS718	Programmable Binary Counter (MC4018)	A	16
LS724	Voltage Controlled Multivibrator	A	8
LS748	8-Input to 3-Line Priority Encoder	A	16
LS783*	Synchronous Address Multiplexer (MC6883)	A	40
LS795	Octal Buffer (81LS95), 3-State	A	20
LS796	Octal Buffer (81LS96), 3-State	A	20
LS797	Octal Buffer (81LS97), 3-State	A	20
LS798	Octal Buffer (81LS98), 3-State	A	20
LS848	8-Input to 3-Line Priority Encoder, 3-State	A	16

*74LS only.

1

FAST TTL

MC54F00 Series (−55 to +125°C)
MC74F00 Series (0 to +70°C)

Suffix: N . . . Plastic (only 74-series)
J . . . Ceramic (54/74 series)

Device	Function	Samples	Pins
F00	Quad 2-Input NAND Gate	A	14
F02	Quad 2-Input NOR Gate	A	14
F04	Hex Inverter	A	14
F08	Quad 2-Input AND Gate	A	14
F10	Triple 3-Input NAND Gate	A	14
F11	Triple 3-Input AND Gate	A	14
F20	Dual 4-Input NAND Gate	A	14
F32	Quad 2-Input OR Gate	A	14
F64	4-2-2-3 Input AND-OR-INVERT Gate	A	14
F74	Dual D Flip-Flop	A	14
F86	Quad Ex/OR Gate	3Q83	14
F109	Dual J-K Flip-Flop w/Preset	A	16
F112	Dual J-K Flip-Flop	3Q83	16
F113	Dual J-K Flip-Flop	3Q83	14
F114	Dual J-K Flip-Flop	3Q83	14
F138	1-of-8 Decoder/Demultiplexer	3Q83	16
F139	Dual 1-of-4 Decoder/Demultiplexer	3Q83	16
F151	8-Input Multiplexer	4Q83	16
F153	Dual 4-Input Multiplexer	A	16
F157	Quad 2-Input Multiplexer	4Q83	16
F158	Quad 2-Input Multiplexer	4Q83	16
F160	BCD Decade Counter, Asynchronous Reset	4Q83	16
F161	4-Bit Binary Counter, Asynchronous Reset	4Q83	16
F162	BCD Decade Counter, Synchronous Reset	4Q83	16
F163	4-Bit Binary Counter, Synchronous Reset	4Q83	16
F168	Up/Down Decade Counter	1H84	16
F169	Up/Down Binary Counter	1H84	16
F174	Hex D Flip-Flop	3Q83	16
F175	Quad D Flip-Flop	3Q83	16
F181	4-Bit ALU	1H84	24
F182	Look Ahead Carry Generator	1H84	16
F189	64-Bit RAM/3-State	2H84	16
F190	Up/Down Decade Counter	4Q83	16
F191	Up/Down Binary Counter	4Q83	16
F192	Up/Down Decade Counter with Clear	4Q83	16
F193	Up/Down Binary Counter with Clear	4Q83	16
F194	Universal Shift Register	4Q83	16
F195	4-Bit Shift Register	4Q83	16
F240	Octal Bus/Line Driver/Inverting/3-State	A	20
F241	Octal Bus/Line Driver/3-State	A	20
F242	Quad Bus Transceiver/Inverting/3-State	A	14
F243	Quad Bus Transceiver/Non-Inverting/ 3-State	A	14
F244	Octal Bus Driver/Non-Inverting/3-State	A	20
F245	Octal Bus Transceiver	A	20
F251	8-Input Multiplexer/3-State	4Q83	16
F253	Dual 4-Input Multiplexer/3-State	A	16
F257	Quad 2-Input Multiplexer/3-State	4Q83	16
F258	Quad 2-Input Multiplexer, Inverting/3-State	4Q83	16
F280	9-Bit Odd/Even Parity Gen/Checker	2H84	14
F283	4-Bit Full Adder	2H84	20
F289	64-Bit RAM, Open-Collector	2H84	16
F299	8-Bit Shift/Store Register	1H84	20
F323	8-Bit Universal Shift/Storage Register	1H84	20
F350	4-Bit Shifter/3-State	1H84	16
F352	Dual 4-Input Multiplexer	A	16
F353	Dual 4-Input Multiplexer/3-State	A	20
F373	Octal Transparent Latch/3-State	3Q83	16
F374	Octal D Flip-Flop/3-State	A	16
F378	Hex Parallel D Register w/Enable	3Q83	20
F379	Quad Parallel Register w/Enable	3Q83	20
F381	4-Bit ALU	1H84	20
F382	4-Bit ALU	1H84	20
F521	Octal Comparitor	1Q84	20
F533	Octal Transparent Latch/3-State	A	20
F534	Octal D Flip-Flop/3-State	A	20
F537	1-of-10 Decoder/3-State	1H84	20
F538	1-of-8 Decoder/3-State	1H84	20
F539	1-of-4 Decoder/3-State	1H84	20
F620	Octal Bus Transceiver/Inverting/3-State	3Q83	20
F623	Octal Bus Transceiver/3-State	3Q83	20
F640	Octal Bus Transceiver/Inverting/3-State	3Q83	20
F643	Octal Bus Transceiver/Inverting/True/ 3-State	3Q83	20
F2960	Error Detection and Correction Unit (EDAC)	3Q83	48
F2961	EDAC Bus Buffer, Inverting	1H84	24
F2962	EDAC Bus Buffer, Non-Inverting	1H84	24
F2968	Dynamic Memory Controller	4Q83	48
F2969	Memory Timing Controller w/EDAC	4Q83	48
F2970	Memory Timing Controller w/o EDAC	4Q83	24

ALS TTL

SN54ALS00 Series (−55 to +125°C)
SN74ALS00 Series (0 to +70°C)

Suffix: N . . . Plastic (only 74-series)
J . . . Ceramic (54/74 series)

Device	Function	Samples	Pins
ALS00	Quad 2-Input NAND Gate	A	14
ALS01	Quad 2-Input NAND Gate, Open-Collector	4Q83	14
ALS02	Quad 2-Input NOR Gate	A	14
ALS03	Quad 2-Input NAND Gate, Open-Collector	A	14
ALS04	Hex Inverter	A	14
ALS05	Hex Inverter, Open-Collector	A	14
ALS08	Quad 2-Input AND Gate	A	14
ALS09	Quad 2-Input AND Gate, Open-Collector	A	14
ALS10	Triple 3-Input NAND Gate	A	14
ALS11	Triple 3-Input AND Gate	A	14
ALS12	Triple 3-Input NAND Gate, Open-Collector	A	14
ALS13	Dual 4-Input Schmitt Trigger	4Q83	14
ALS14	Hex Schmitt Trigger	4Q83	14
ALS15	Triple 3-Input NAND Gate, Open-Collector	A	14
ALS20	Dual 4-Input NAND Gate	A	14
ALS21	Dual 4-Input AND Gate	A	14
ALS22	Dual 4-Input NAND Gate, Open-Collector	A	14
ALS27	Triple 3-Input NOR Gate	A	14
ALS28	Quad 2-Input NOR Buffer	4Q83	14
ALS32	Quad 2-Input OR Gate	4Q83	14
ALS33	Quad 2-Input NOR Buffer, Open-Collector	4Q83	14

Device	Function	Samples	Pins
ALS37	Quad 2-Input NAND Buffer	A	14
ALS38	Quad 2-Input NAND Buffer, Open-Collector	A	14
ALS40	Dual 4-Input NAND Buffer	4Q83	14
ALS51	Dual 2-Wide, 2-3-Input AND-OR-INVERT Gate	A	14
ALS55	2-Wide, 4-Input AND-OR-INVERT Gate	A	14
ALS74	Dual D Flip-Flop	A	14
ALS91	8-Bit Serial-In/Serial-Out Shift Register	1H84	14
ALS109	Dual J-K Flip-Flop w/Preset	4Q83	16
ALS132	Quad 2-Input Schmitt Trigger	4Q83	14
ALS138	1-of-8 Decoder/Demultiplexer	4Q83	16
ALS139	Dual 1-of-4 Decoder/Demultiplexer	4Q83	16
ALS151	8-Input Multiplexer	3Q83	16
ALS153	Dual 4-Input Multiplexer	1Q84	16
ALS157	Quad 2-Input Multiplexer/Non-Inverting	A	16
ALS158	Quad 2-Input Multiplexer/Inverting	A	16
ALS160	BCD Decade Counter/Asynchronous Reset (9310 Type)	A	16
ALS161	4-Bit Binary Counter, Asynchronous Reset (9316 Type)	A	16
ALS162	BCD Decade Counter/Synchronous Reset	A	16
ALS163	4-Bit Binary Counter/Synchronous Reset	A	16
ALS164	8-Bit Serial-In/Parallel-Out Shift Register	1H84	14
ALS168	4-Bit Up/Down Decade Counter/ Synchronous Reset	4Q83	16
ALS169	4-Bit Up/Down Binary Counter/ Synchronous Reset	4Q83	16
ALS190	Up/Down Decade Counter	A	16
ALS191	Up/Down Binary Counter	A	16
ALS192	Up/Down Decade Counter w/Clear	A	16
ALS193	Up/Down Binary Counter w/Clear	A	16
ALS238	1-of-8 Decoder/Demultiplexer/(Active High)	4Q83	16
ALS239	Dual 1-of-4 Decoder/Demultiplexer/ (Active High)	4Q83	16
ALS240	Octal Bus/Line Driver/Inverting/3-State	A	20
ALS241	Octal Bus/Line Driver/3-State	A	20
ALS242	Quad Bus Transceiver/Inverting/3-State	A	14
ALS243	Quad Bus Transceiver/Non-Inverting/ 3-State	A	14
ALS244	Octal Driver/Non-Inverting/3-State	A	20
ALS245	Octal Bus Transceiver/Non-Inverting/ 3-State	A	20
ALS251	8-Input Multiplexer/3-State	3Q83	16
ALS253	Dual 4-Input Multiplexer/3-State	1H84	16
ALS257	Quad 2-Input Multiplexer/Non-Inverting/ 3-State	1H84	16
ALS258	Quad 2-Input Multiplexer/Inverting/3-State	1H84	16
ALS273	Octal D Flip-Flop w/Clear	A	20
ALS352	Dual 4-Multiplexer/Inverting ALS153	1H84	16
ALS353	Dual 4-Multiplexer/3-State ALS352	1H84	16
ALS373	Octal Transparent Latch/3-State	3Q83	20
ALS374	Octal D Flip-Flop/3-State	3Q83	20
ALS377	Octal D Flip-Flop w/Enable	A	20
ALS533	Octal Transparent Latch/Inverting	1H84	20
ALS534	Octal D-Type Flip-Flop/Inverting	1H84	20
ALS537	1-of-10 Decoder/3-State	1H84	20
ALS538	1-of-8 Decoder/3-State	1H84	20
ALS539	Dual 1-of-4 Decoder/3-State	1H84	20
ALS540	Octal Buffer/3-State	4Q83	20
ALS541	Octal Buffer/3-State	4Q83	20
ALS560	4-Bit Decade Counter/3-State	A	20
ALS561	4-Bit Binary Counter/3-State	A	20
ALS563	8-Bit Latch/3-State	1H84	20
ALS564	Octal D Flip-Flop/3-State	1H84	20
ALS568	Decade Up/Down Counter/3-State	4Q83	20
ALS569	Binary Up/Down Counter/3-State	4Q83	20
ALS573	Octal Transparent Latch/3-State	1H84	20
ALS574	Octal D Flip-Flop/3-State	1H84	20

Device	Function	Samples	Pins
ALS575	Octal D Flip-Flop/Synchronous Clear/ 3-State	1H84	20
ALS576	Octal D Flip-Flop/Inverting/3-State	1H84	20
ALS577	Octal D Flip-Flop/Inverting/Synchronous Clear/3-State	1H84	20
ALS580	Octal Transparent Latch/Inverting/3-State	1H84	20
ALS620	Octal Transceiver w/Storage/3-State	A	20
ALS621	Octal Transceiver w/Storage/ Open-Collector	A	20
ALS622	Octal Transceiver w/ Storage/ Open-Collector	A	20
ALS623	Octal Transceiver w/Storage/3-State	A	20
ALS638	Octal Bus Transceiver/Inverting/3-State	A	20
ALS639	Octal Bus Transceiver/3-State	A	20
ALS640	Octal Bus Transceiver/Inverting/3-State	A	20
ALS641	Octal Bus Transceiver/Non-Inverting/ Open-Collector	A	20
ALS642	Octal Bus Transceiver/Inverting/ Open-Collector	A	20
ALS643	Octal Bus TransceiverTrue/Inverting/3-State	A	20
ALS644	Octal Bus Transceiver/True/Inverting/ Open-Collector	A	20
ALS646	Octal Transceiver/Latch/Multiplexer/ Non-Inverting/3-State	1H84	24
ALS647	Octal Transceiver/Latch/Multiplexer/ Non-Inverting/Open-Collector	1H84	24
ALS648	Octal Transceiver/Latch/Multiplexer/ Inverting/3-State	1H84	24
ALS649	Octal Transceiver/Latch/Multiplexer/ Inverting/Open-Collector	1H84	24
ALS651	Octal Bus Transceiver/Register/3-State	1H84	24
ALS652	Octal Bus Transceiver/Register/3-State	1H84	24
ALS653	Octal Bus Transceiver/Register	1H84	24
ALS654	Octal Bus Transceiver/Register	1H84	24
ALS671	Bidirectional Shift Register/Latch/ Multiplexer/3-State	4Q83	20
ALS672	Bidirectional Shift Register/Latch/ Multiplexer/3-State	4Q83	20
ALS690	Decade Counter/Latch/Multiplexer/ Asynchronous Reset/3-State	A	20
ALS691	Binary Counter/Latch/Multiplexer/ Asynchronous Reset/3-State	A	20
ALS692	Decade Counter/Latch/Multiplexer/ Synchronous Reset/3-State	A	20
ALS693	Binary Counter/Latch/Multiplexer/ Synchronous Reset/3-State	A	20
ALS694	Decade Counter/Latch/Multiplexer/ Synchronous/Asynchronous Reset/ 3-State	A	20
ALS695	Binary Counter/Latch/Multiplexer/ Synchronous/Asynchronous Reset/ 3-State	A	20
ALS696	Decade Counter/Register/Multiplexer/ 3-State	4Q83	20
ALS697	Binary Counter/Register/Multiplexer/3-State	4Q83	20
ALS698	Decade Counter/Register/Multiplexer/ 3-State	4Q83	20
ALS699	Binary Counter/Register/Multiplexer/3-State	4Q83	20
ALS790	Error Detection and Correction Circuit	see F2960	
ALS873	Octal Transparent Latch	2H84	24
ALS874	Octal D Flip-Flop	2H84	24
ALS876	Octal D Flip-Flop/Inverting	2H84	24
ALS878	Dual 4-Bit D Flip-Flop/Synchronous Clear 3-State	2H84	24
ALS879	Dual 4-Bit D Flip-Flop/Inverting Synchronous Clear/3-State	2H84	24
ALS880	Octal Transparent Latch/Inverting	2H84	24

1

TTL Memories

MCM76xxx Series PROM
MCM93xxx Series RAM

***Suffix: D . . . Ceramic DIP**
P . . . Plastic DIP
C . . . 0 to +75°C (Commercial)
M . . . −55 to +125°C (Military)

***Example: MCM7621DC, MCM7621DM, etc.**

Device	Function	T_{AA} (ns)	Samples	Pins
MCM27S25	512 x 8 PROM, 3-State, Registered	30/15*	2Q84	24
MCM27S27	512 x 8 PROM, 3-State, Registered	35/20*	2Q84	22
MCM27S35	1k x 8 PROM, 3-State, Registered	35/20*	2Q84	24
MCM27S37	1k x 8 PROM, 3-State, Registered	35/20*	2Q84	24
MCM27S45	2k x 8 PROM, 3-State, Registered	35/20*	1Q84	24
MCM27S47	2k x 8 PROM, 3-State, Registered	35/20*	1Q84	24
MCM7621	512 x 4 PROM, 3-State	70	A	16
MCM7621A	512 x 4 PROM, 3-State	60	A	16
MCM7641	512 x 8 PROM, 3-State	70	A	24
MCM7641A	512 x 8 PROM, 3-State	60	A	24
MCM7643	1024 x 4 PROM, 3-State	70	A	18
MCM7643A	1024 x 4 PROM, 3-State	50	A	18
MCM7649	512 x 8 PROM, 3-State	70	A	20
MCM7649A	512 x 8 PROM, 3-State	50	3Q83	20
MCMXXXXX	512 x 8 PROM, 3-State	35	1984	20
MCM7681	1024 x 8 PROM, 3-State	70	A	24
MCM7681A	1024 x 8 PROM, 3-State	50	3Q83	24
MCMXXXXX	1k x 8 PROM, 3-State	35	1984	24
MCM7685	2048 x 4 PROM, 3-State	70	A	18
MCM7685A	2048 x 4 PROM, 3-State	55	A	18
MCM76161	2048 x 8 PROM, 3-State	70	A	24
MCM76161A	2048 x 8 PROM, 3-State	60	A	24
MCMXXXXXX	2k x 8 PROM, 3-State	35	1984	24
MCM76165A	4096 x 4 PROM, 3-State	50	3Q83	20
MCM93422	256 x 4 RAM, 3-State	45	A	22
MCM93L422	256 x 4 RAM, 3-State	60	A	22
MCM93415	1024 x 1 RAM, Open-Collector	45	A	18
MCM93425	1024 x 1 RAM, 3-State	45	A	18

*For Registered PROMs, t_{SA}/t_{PHL} (Address setup time propagation delay, clock to output)

Abbreviations

S = Synchronous
A = Asynchronous
B = Both Synchronous and Asynchronous

2S = 2-State Output
3S = 3-State Output
OC = Open-Collector Output

P = Planned (See Numeric List for latest availability status.)

Inverters

Description	Type of Output	No.	LS	ALS	FAST
Hex	2S	04	X	X	X
	OC	05	X	X	

AND Gates

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	2S	08	X	X	X
	OC	09	X	X	
Triple 3-Input	2S	11	X	X	X
	OC	15	X	X	
Dual 4-Input	2S	21	X	X	

NAND Gates

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	2S	00	X	X	X
	OC	01	X	X	
	OC	03	X	X	
Quad 2-Input, High Voltage	OC	26	X		
Triple 3-Input	2S	10	X	X	X
	OC	12	X	X	
Dual 4-Input	2S	20	X	X	X
	OC	22	X	X	
8-Input	2S	30	X		
13-Input	2S	133	X		

OR

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	2S	32	X	P	X

NOR

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	2S	2	X	X	X
Triple 3-Input	2S	27	X	X	
Dual 5-Input	2S	260	X		

Exclusive OR

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	2S	86	X		P
	OC	136	X		
	2S	386	X		

Exclusive NOR

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input	OC	266	X		

AND-OR-INVERT Gates

Description	Type of Output	No.	LS	ALS	FAST
Dual 2-Wide, 2-Input/3-Input	2S	51	X	X	
4-Wide, 2-3-2-3-Input	2S	54	X		
2-Wide, 4-Input	2S	55	X	X	
4-Wide, 4-2-2-3-Input	2S	64			X

Schmitt Triggers

Description	Type of Output	No.	LS	ALS	FAST
Dual 4-Input NAND Gate	2S	13	X	P	
Hex, Inverting	2S	14	X	P	
Quad 2-Input NAND Gate	2S	132	X	P	

SSI Flip-Flops

Description	Clock Edge	No.	LS	ALS	FAST
Dual D w/Set & Clear	Pos	74	X	X	X
Dual JK w/Set	Neg	113	X		P
Dual JK w/Clear	Neg	73	X		
	Neg	107	X		
Dual JK w/Set & Clear	Neg	76	X		
	Neg	78	X		
	Neg	112	X		P
	Neg	114	X		P
Dual $J\overline{K}$ w/Set & Clear	Pos	109	X	P	X

Multiplexers

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-to-1, Non-Inverting	2S	157	X	X	P
	3S	257	X	P	P
Quad 2-to-1, Inverting	2S	158	X	X	P
	3S	258	X	P	P
Dual 4-to-1, Non-Inverting	2S	153	X	P	X
	3S	253	X	P	X
Dual 4-to-1, Inverting	2S	352	X	P	X
	3S	353	X	P	X
8-to-1	2S	151	X	P	P
	3S	251	X	P	P
Quad 2-to-1 with Output Register	2S	298	X		
	2S	398	X		
	2S	399	X		

Encoders

Description	Type of Output	No.	LS	ALS	FAST
10- to 4-Line BCD	2S	147	X		
8- to 3-Line Priority Encoder	2S	148	X		
	3S	348	X		
	2S	748	X		
	3S	848	X		

Register Files

Description	Type of Output	No.	LS	ALS	FAST
4 x 4	OC	170	X		
	3S	670	X		

Decoders/Demultiplexers

Description	Type of Output	No.	LS	ALS	FAST
Dual 1-of-4	2S	139	X	P	P
	2S	155	X		
	OC	156	X		
	2S	239		P	
	3S	539		P	P
1-of-8	2S	138	X	P	P
	2S	238		P	
	3S	538		P	P
1-of-8 with Latch	2S	137	X		
1-of-10	2S	42	X		
	3S	537		P	P

Latches

Description	No. of Bits	Type of Output	No.	LS	ALS	FAST
Transparent, Non-Inverting	4	2S	77	X		
	8	3S	373	X	P	P
	8	3S	573		P	
Transparent, Inverting	8	3S	533		P	X
	8	3S	563		P	
	8	3S	580		P	
Transparent, Q and $\overline{Q}$ Outputs	4	2S	75	X		
	4	2S	375	X		
Quad Set-Reset Latch	4	2S	279	X		
Addressable	8	2S	259	X		
Dual 4-Bit Addressable	4	2S	256	X		
Dual 4-Bit Transparent, Non-Inverting	8	3S	873		P	
Dual 4-Bit Transparent, Inverting	8	3S	880		P	

Shift Registers

Description	No. of Bits	Type of Output	Mode*				No.	LS	ALS	FAST
			SR	SL	Hold	Reset				
Serial In-Serial Out	8	2S	X				91	X	P	
Serial In-Parallel Out	8	2S	X			A	164	X	P	
Parallel In-Serial Out	8	2S	X		X		165	X		
	8	2S	X		X	A	166	X		
	16	3S	X		X		674	X		
Parallel In-Parallel Out	4	2S	X				95	X		
	4	2S	X	X	X	A	194	X		P
	4	2S	X			A	195	X		P
	4	3S	X				295	X		
	4	3S	X			A	395	X		
Parallel In-Parallel Out, Bidirectional	8	3S	X	X	X	A	299	X		
	8	3S	X	X	X	S	323	X		P
Sign Extended Bidirectional	8	3S	X		X	A	322	X		
Serial In-Parallel Out with Storage Register	16	2S/3S	X		X	S	673	X		
Parallel In-Parallel Out with Storage Register/Mux	4	3S	X	X	X	A	671		P	
	4	3S	X	X	X	S	672		P	

* SR = Shift Right
SL = Shift Left

Asynchronous Counters — Negative Edge-Triggered*

Description	Load	Set	Reset	No.	LS	ALS	FAST
Decade (2/5)		X	X	90	X		
	X		X	196	X		
		X	X	290	X		
Dual Decade (2/5)			X	390	X		
Dual Decade		X	X	490	X		
Modulo 12 (2/6)			X	92	X		
4-Bit Binary (2/8)			X	93	X		
	X		X	197	X		
			X	293	X		
Dual 4-Bit Binary			X	393	X		
Divide-By-N (0–9)	X		X	716*	X		
Divide-By-N (0–15)	X		X	718*	X		

*The 716 and 718 are positive edge-triggered.

Display Decoders/Drivers with Open-Collector Outputs*

Description	No.	LS	ALS	FAST
1-of-10	145	X		
BCD-to-7 Segment	47	X		
	48*	X		
	49	X		
	247	X		
	248*	X		
	249	X		

*The 48 and 248 have internal pullup resistors to V_{CC} on their outputs.

Cascadable* Synchronous Counters — Positive Edge-Triggered

Description	Type of Output	Load	Reset	No.	LS	ALS	FAST
Decade	2S	S	A	160	X	X	P
	2S	S	S	162	X	X	P
	3S	B	B	560		P	
Decade,	2S	S		168	X	P	P
Up/Down	2S	A		190	X	X	P
	2S	A	A	192	X	X	P
	3S	S	B	568	X	P	
	2S	S		668	X		
4-Bit Binary	2S	S	A	161	X	X	P
	2S	S	S	163	X	X	P
	3S	B	B	561		P	
4-Bit Binary,	2S	S		169	X	P	P
Up/Down	2S	A		191	X	X	P
	2S	A	A	193	X	X	P
	3S	S	B	569	X	P	
	2S	S		669	X		
Decade with	3S	S	A	690		P	
Latch/Mux	3S	S	S	692		P	
	3S	S	S	694		P	
Decade with	3S	S	A	696		P	
Register/Mux	3S	S	S	698		P	
4-Bit Binary w/	3S	S	A	691		P	
Latch/Mux	3S	S	S	693		P	
	3S	S	S	695		P	
4-Bit Binary w/	3S	S	A	697		P	
Register/Mux	3S	S	S	699		P	

*The 192 and 193 do not provide a clock enable for synchronous cascading.

MSI Flip-Flops/Registers

Description	No. of Bits	Type of Output	Set or Reset	Clock Enable	No.	LS	ALS	FAST
D-Type, Non-Inverting	4	3S	A	X	173	X		
	4	2S		X	377	X	X	
	6	2S	A		174	X		P
	6	2S		X	378	X		P
	8	2S	A		273	X	X	
	8	3S			374	X	P	X
	8	3S			574		P	
	8	3S	S		575		P	
D-Type, Inverting	8	3S			534		P	X
	8	3S			564		P	
	8	3S			576		P	
	8	3S	S		577		P	
D-Type, Q and $\overline{Q}$ Outputs	4	2S	A		175	X		P
	4	2S		X	379	X		P
Dual 4-Bit, Non-Inverting	8	3S	A		874		P	
	8	3S	S		878		P	
Dual 4-Bit, Inverting	8	3S	A		876		P	
	8	3S	S		879		P	
Dual 8-Bit with Multiplexers	16	3S			604	X		
	16	OC			605	X		
	16	3S			606	X		
	16	OC			607	X		

Arithmetic Operators

Description	No.	LS	ALS	FAST
4-Bit Adder	83	X		
	283	X		P
4-Bit ALU	181	X		P
	381			P
	382			P
Look Ahead Carry Generator	182	X		P
Quad 4-Bit Adder/Subtracter	385	X		
Dual Carry/Save Full Adder	183	X		
4-Bit Barrel Shifter	350			P

Magnitude Comparitors

Description	Type of Output	P=Q	P>Q	P<Q	No.	LS	ALS	FAST
4-Bit	2S	X	X	X	85	X		
8-Bit	2S	X	X		682	X		
	OC	X	X		683	X		
	2S	X	X		684	X		
	OC	X	X		685	X		
	2S	X			521			P
8-Bit with	2S	X	X		686	X		
Output	OC	X	X		687	X		
Enable	2S	X			688	X		
	OC	X			689	X		

Parity Generators/Checkers

Description	No.	LS	ALS	FAST
9-Bit Odd/Even Parity Generator/ Checker	280	X		P

Dynamic Memory Support

Description	No.	LS	ALS	Fast
Synchronous Address Multiplexer (MC6883)	783	X		
Error Detection and Correction Circuit (EDAC)	2960			P
EDAC Bus Buffer	2961			P
	2962			P
Dynamic Memory Controller	2968			P
Dynamic Memory Timing Controller with EDAC	2969			P
Dynamic Memory Timing Controller without EDAC	2970			P

VCOs and Multivibrators

Description	No.	LS	ALS	FAST
Retriggerable Monostable Multivibrator	122	X		
Dual 122	123	X		
Precision Non-Retriggerable Monostable Multivibrator	221	X		
Voltage/Crystal Controlled Oscillator	724	X		

Buffers/Line Drivers

Description	Type of Output	No.	LS	ALS	FAST
Quad 2-Input NOR	2S	28	X	P	
	OC	33	X	P	
Quad 2-Input NAND	2S	37	X	X	
	OC	38	X	X	
Dual 4-Input NAND	2S	40	X	P	
Quad, Non-Inverting	3S	125	X		
	3S	126	X		
Hex, Non-Inverting	3S	365	X		
	3S	367	X		
Hex, Inverting	3S	366	X		
	3S	368	X		
Octal, Non-Inverting	3S	241	X	X	P
	3S	244	X	X	P
	3S	541	X	P	
	3S	795	X		
	3S	797	X		
Octal, Inverting	3S	240	X	X	P
	3S	540	X	P	
	3S	796	X		
	3S	798	X		

Transceivers

Description	Type of Output	No.	LS	ALS	FAST
Quad, Non-Inverting	3S	243	X	X	P
Quad, Inverting	3S	242	X	X	P
Octal, Non-Inverting	3S	245	X	X	X
	3S	645	X		
	OC	621	X	X	
	3S	623	X	X	X
	3S/OC	639		X	
	OC	641	X	X	
Octal, Inverting	3S	620	X	X	X
	OC	622	X	X	
	3S/OC	638		X	
	3S	640	X	X	X
	OC	642	X	X	
	3S	643	X	X	X
	OC	644	X	X	
Octal, Non-Inverting with Register/Mux	3S	646		P	
	OC	647		P	
	3S	652		P	
	OC/3S	654		P	
Octal, Inverting with Register/Mux	3S	648		P	
	OC	649		P	
	3S	651		P	
	OC/3S	653		P	

RAM

Description	Type of Output	No.	LS	ALS	FAST
16-by-4	3S	189			P
	OC	289			P

Circuit Characteristics 2

SCHOTTKY TTL

FAMILY CHARACTERISTICS

LS TTL

The Low Power Schottky (LSTTL) family combines a current and power reduction improvement over standard 7400 TTL by a factor of 5. This is accomplished by using Schottky diode clamping to prevent saturation and advanced processing.

ALS TTL

The Advanced Low Power Schottky TTL family (ALS TTL) provides a 50% power reduction compared to standard 54/74 LS TTL and yet offers improved circuit performance over standard LS due to Motorola's state-of-the-art oxide isolated process (MOSAIC). ALS also differs from LS in that PNP transistors on the input stage are utilized to lower input currents and raise thresholds.

FAST TTL

The FAST Schottky TTL family provides a 75-80% power reduction compared to standard Schottky (54/74S) TTL and yet offers a 20-40% improvement in circuit performance over the standard Schottky due to the MOSAIC process. Also, FAST circuits contain additional circuitry to provide a flatter power/frequency curve. The input configuration of FAST uses a lower input current which translates into higher fanout.

CIRCUIT FEATURES

Circuit features of LS, ALS and FAST are best understood by examining the TTL 2-input NAND gate of each family (Figures 2-1-a,b,c). The input/output circuits of other functions are almost identical.

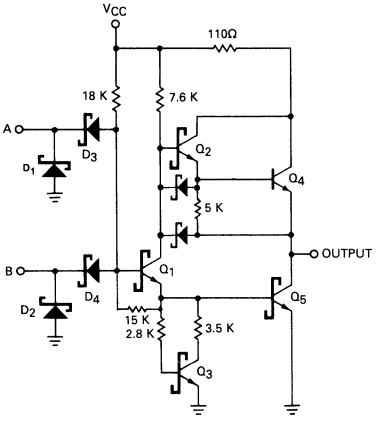


FIGURE 2-1a
LS00 — 2-INPUT NAND GATE

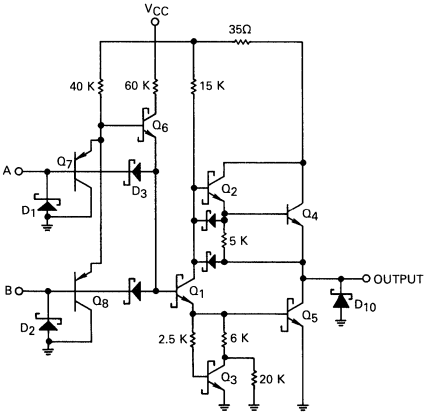


FIGURE 2-1b
ALS00 — 2-INPUT NAND GATE

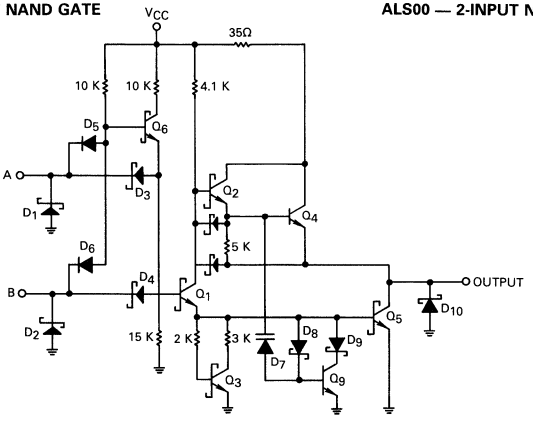


FIGURE 2-1c
F00 — 2-INPUT NAND GATE

INPUT CONFIGURATION. Motorola LSTTL circuits do not use the multi-emitter input structure that originally gave TTL its name. Most LS elements use a DTL type input circuit with Schottky diodes to perform the AND function, as exemplified by D3 and D4 in Figure 2-1a. Compared to the classical multi-emitter structure, this circuit is faster and increases the input breakdown voltage. Inputs of this type are tested for leakage with an applied input voltage of 7.0 V and the input breakdown voltage is typically 15 V or more.

The ALS00 differs from the LS00 in that Q6, Q7 and Q8 have been added to reduce input current (I_{IL}) by a factor of 4, and increase input threshold from approximately 1.1 to 1.5 volts.

The F00 input configuration utilizes a PN diode (D5 and D6) rather than the PNP transistor used in ALS. This is required due to the high speed response of FAST™ logic. The PNP transistor, a relatively large device in current bipolar logic technology, has an associated capacitance large enough to make the gate input susceptible to ac noise. The PN diode results in much better ac noise immunity at the expense of increased input current.

Another input arrangement often used in LS MSI has three diodes connected as shown in Figure 2-2. This configuration gives a slightly higher input threshold than that of Figure 2-1a. A third input configuration that is sometimes used in LS TTL employs a vertical PNP transistor as shown in Figure 2-3. As with the ALS input, this arrangement also gives a higher input threshold and has the additional advantage of reducing the amount of current that the signal source must sink. Both the diode cluster arrangement and the PNP input configuration have breakdown voltage ratings greater than 7.0 V.

All inputs are provided with clamping diodes, exemplified by D1 and D2 in Figure 2-1a,b,c. These diodes conduct when an input signal goes negative, which limits undershoot and helps to control ringing on long signal lines following a HIGH-to-LOW transition. These diodes are intended only for the suppression of transient currents and should not be used as steady-state clamps in interface applications. A clamp current exceeding 2 mA and with a duration greater than 500 ns can activate a parasitic lateral NPN transistor, which in turn can steal current from internal nodes of an LS circuit and thus cause logic errors.

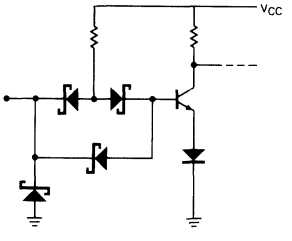


FIGURE 2-2
DIODE CLUSTER INPUT

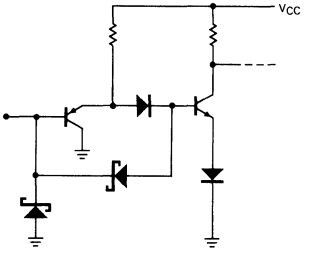


FIGURE 2-3
PNP INPUT

INPUT CHARACTERISTICS — Figure 2-4 shows the typical input characteristics of LS, ALS, and FAST™. Typical transfer characteristics can be found in Figure 2-5 and input threshold variation with temperature information is provided in Table 2-1.

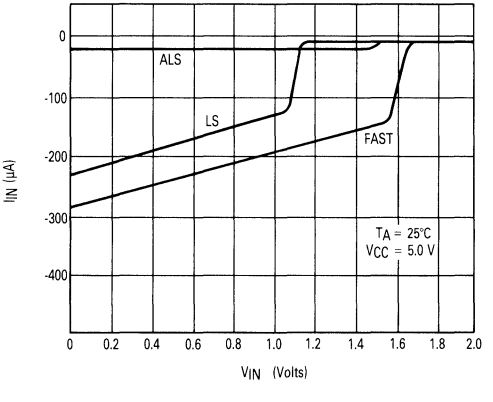


FIGURE 2-4
TYPICAL INPUT CURRENT VS. INPUT VOLTAGE

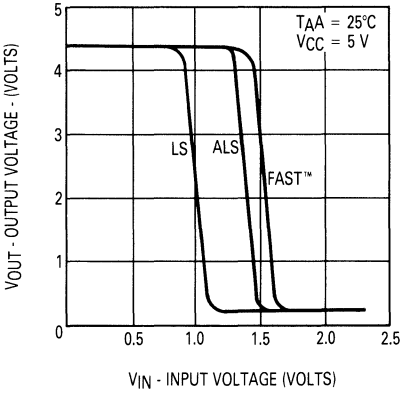


FIGURE 2-5
TYPICAL OUTPUT vs
INPUT VOLTAGE CHARACTERISTIC

	-55°C	+25°C	+125°C
FAST	1.8	1.5	1.3
ALS	1.8	1.5	1.3
S	1.5	1.3	1.1
LS	1.2	1.0	0.8

TABLE 2.1
TYPICAL INPUT THRESHOLD VARIATION WITH TEMPERATURE

OUTPUT CONFIGURATION. The output circuitry of LSTTL has several features not found in conventional TTL. A few of these features are discussed below.

Referring to Figures 2-1a,b,c, the base of the pull-down output transistor Q5 is returned to ground through Q3 and a pair of resistors instead of through a simple resistor. This arrangement is called a squaring network since it squares up the transfer characteristics (Figure 2-5) by preventing conduction in the phase splitter Q1 until the input voltage rises high enough to allow Q1 to supply base current to Q5. The squaring network also improves the propagation delay by providing a low resistance path to discharge capacitance at the base of Q5 during turn-off.

The output pull-up circuit is a 2-transistor Darlington circuit with the base of the output transistor returned through a 5k resistor to the output terminals, unlike 74H and 74S where it is returned to ground which is a more power consuming configuration. This configuration allows the output to pull up to one V_{BE} below V_{CC} for low values of output current.

The ALS00 and F00 outputs include clamping diodes to limit undershoot and control ringing on long signal lines. As with the input diode clamps, these diodes are intended for transient suppression only and should not be used as steady state clamps.

The F00 output configuration also includes additional circuitry to improve the rise time and decrease the power consumption at high operating frequencies. This circuit, which consists of Q9, D7, D8, and D9 causes Q5 to off more quickly on LOW to HIGH output transitions.

Figure 2-6 shows the extra circuitry used to obtain the "high Z" condition in 3-state ouputs. When the Output Enable signal is HIGH, both the phase splitter and the Darlington pull-up are turned off. In this condition the output circuitry is non-conducting, which allows the outputs of two or more such circuits to be connected together in a bus application wherein only one output is enabled at any particular time.

FAST™ 3-state outputs have some additional circuitry due to the nature of the environment in which they are used. The effective capacitive load of a 3-state output tends to increase at high bus rates. The addition of Q10 reduces this effect by clamping the base of Q5 low when the device is in the high impedance state. In the high Z state, the output capacitance is about 5 pF for 24 mA outputs and about 12 pF for 64 mA outputs.

An additional feature of many FAST™ 3-state devices is the incorporation of power-up circuitry to guarantee that the output will not sink current if the device is disabled during the application or removal of power.

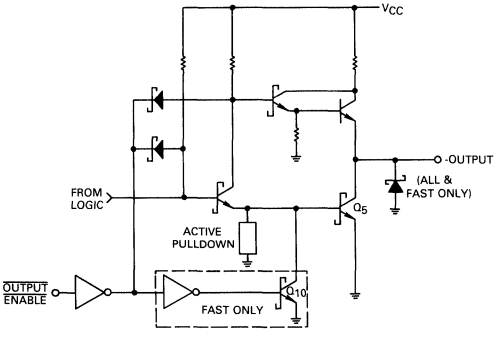


FIGURE 2-6
TYPICAL 3-STATE OUTPUT CONTROL

OUTPUT CHARACTERISTICS. Figure 2-7 shows the LOW-state output characteristics for LS, ALS and FAST™. For LOW I_{OL} values, the pull-down transistor is clamped out of deep saturation to shorten the turn-off delay. Figure 2-8 shows the HIGH-state output characteristics.

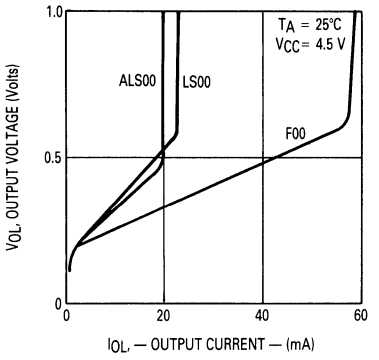


FIGURE 2-7a — OUTPUT LOW CHARACTERISTIC

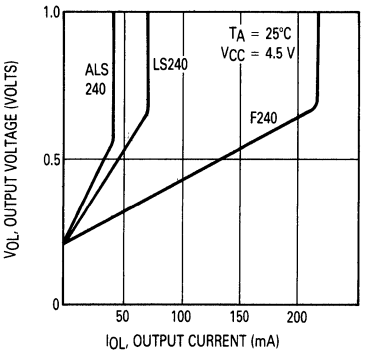


FIGURE 2-7b — OUTPUT LOW CHARACTERISTIC

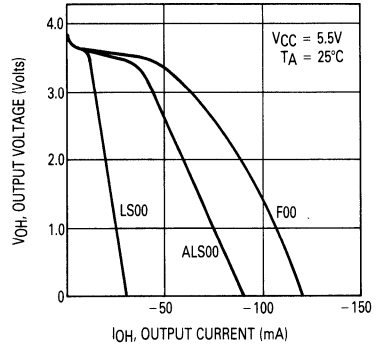


FIGURE 2-8a — OUTPUT HIGH CHARACTERISTIC

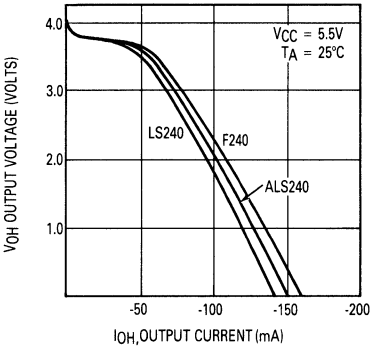


FIGURE 2-8b — OUTPUT HIGH CHARACTERISTIC

AC SWITCHING CHARACTERISTICS. The propagation through a logic element depends on power supply voltage, ambient temperature, and output load. The effect of each of these parameters on ac propagation is shown in Figures 2-9 through 2-11.

The delay through a logic element will increase to some extent when multiple outputs switch simultaneously due to inductance internal to the IC package. This effect can be seen by comparing Figures 2-11e and 2-11f.

For LS TTL, limits are guaranteed at 25°C, V_{CC} = 5.0 V, and Cl = 15 pF (normally, resistive load has minimal effect on propagation delay). ALS and FAST™ TTL limits are guaranteed over the commercial or military temperature and supply voltage ranges and with Cl = 50 pF.

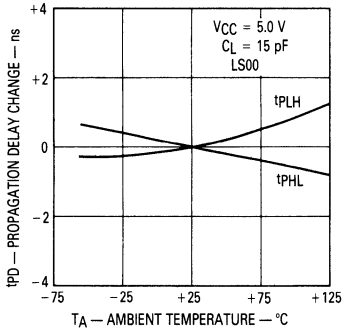


FIGURE 2-9

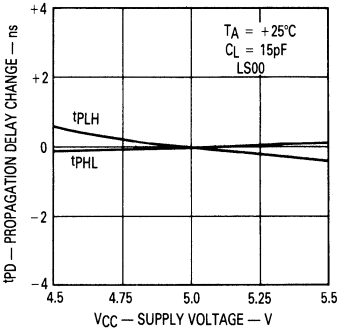


FIGURE 2-10

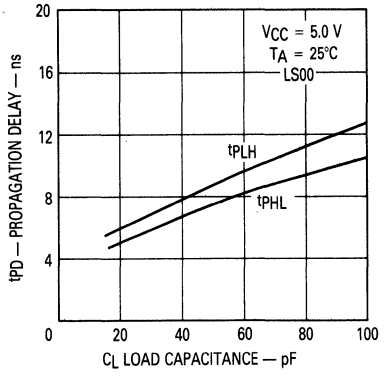


FIGURE 2-11a*

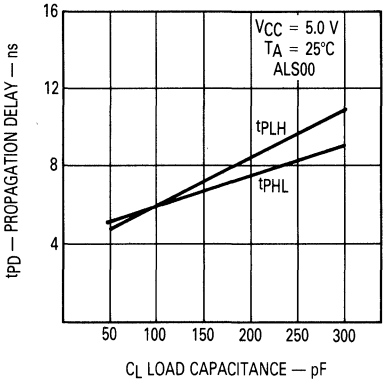


FIGURE 2-11b*

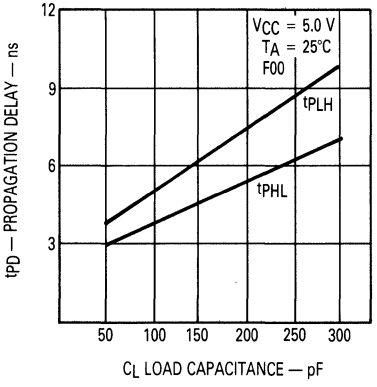


FIGURE 2-11c*

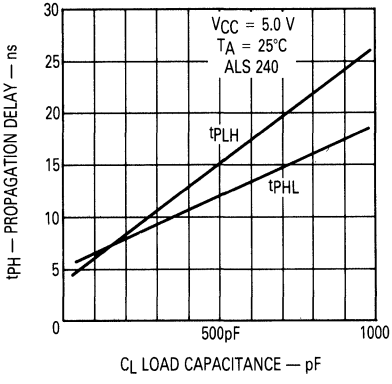


FIGURE 2-11d*

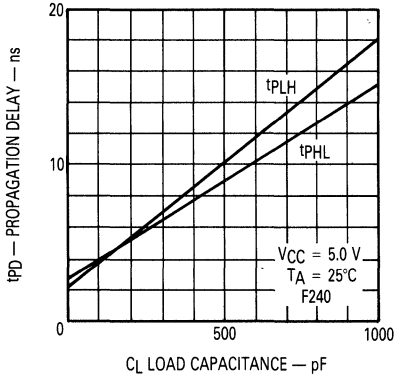


FIGURE 2-11e*

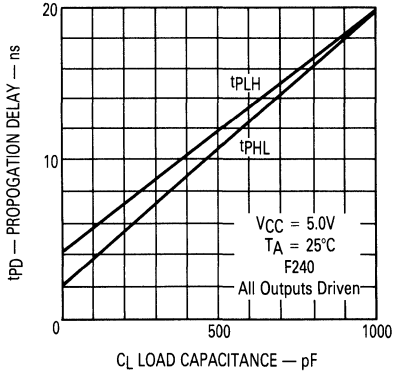


FIGURE 2-11f

*Data for Figures 2-11a through 2-11e was taken with only one output switching at a time. Figure 2-11F data was taken with all 8 inputs of the F240 tied together.

Design Considerations
Symbol Definitions and Testing

3

SCHOTTKY TTL

SELECTING TTL LOGIC. TTL Families may be mixed in a system for optimum performance. For instance, in new designs, ALS would commonly be used in non-critical speed paths to minimize power consumption while FAST™ TTL would be used in high speed paths. The ratio of ALS to FAST™ will depend on overall system design goals.

NOISE IMMUNITY. When mixing TTL families it is often desirable to know the guaranteed noise immunity for both LOW and HIGH logic levels. Table 3.1 lists the guaranteed logic levels for various TTL families and can be used to calculate noise margin. Table 3.2 specifies these noise margins for systems containing LS, S, ALS and/or FAST™ TTL. Note that Table 3.2 represents "worst case" limits and assumes a maximum power supply and temperature variation across the IC's which are interconnected, as well as maximum rated load. Increased noise immunity can be achieved by designing with de-creased maximum allowable operating ranges.

TABLE 3.1
Worst Case TTL Logic Levels

Electrical Characteristics

		Military (—55 to ±125°C)				Commercial (0 to 70°C)				
	TTL Families	V_{IL}	V_{IH}	V_{OL}	V_{OH}	V_{IL}	V_{IH}	V_{OL}	V_{OH}	**UNITS**
TTL	Standard TTL 9000, 54/74	0.8	2.0	0.4	2.4	0.8	2.0	0.4	2.4	V
HTTL	High Speed TTL 54H/74H	0.8	2.0	0.4	2.4	0.8	2.0	0.4	2.4	V
LPTTL	Low Power TTL 93L00 (MSI)	0.7	2.0	0.3	2.4	0.8	2.0	0.3	2.4	V
STTL	Schottky TTL 54S/74S, 93S00	0.8	2.0	0.5	2.5	0.8	2.0	0.5	2.7	V
LSTTL	Low Power Schottky TTL 54LS/74LS	0.7	2.0	0.4	2.5	0.8	2.0	0.5	2.7	V
ALS TTL (5% V_{CC})	Advanced LS TTL, 54ALS/74ALS					0.8	2.0	0.5	2.75	V
(10% V_{CC})		0.8	2.0	0.4	2.5	0.8	2.0	0.5	2.5	V
FAST TTL(5% V_{CC})	Advanced S TTL, 54F/74F					0.8	2.0	0.5	2.7	V
(10% V_{CC})		0.8	2.0	0.5	2.5	0.8	2.0	0.5	2.5	V

V_{OL} and V_{OH} are the voltages generated at the output V_{IL} and V_{IH} are the voltage required at the input to generate the appropriate levels. The numbers given above are guaranteed worst-case values.

TABLE 3.2a
LOW Level Noise Margins (Military)

From \ To	LS	S	ALS	FAST	Units
LS	300	400	400	400	mV
S	200	300	300	300	mV
ALS	300	400	400	400	mV
FAST™	200	300	300	300	mV

From "V_{OL}" to "V_{IL}"

TABLE 3.2b
HIGH Level Noise Margins (Military)

From \ To	LS	S	ALS	FAST	Units
LS	500	500	500	500	mV
S	500	500	500	500	mV
ALS	500	500	500	500	mV
FAST™	500	500	500	500	mV

From "V_{OH}" to "V_{IH}"

TABLE 3.2c
LOW Level Noise Margins (Commercial)

From \ To	LS	S	ALS	FAST	Units
LS	300	300	300	300	mV
S	300	300	300	300	mV
ALS	300	300	300	300	mV
FAST™	300	300	300	300	mV

From "V_{OL}" to "V_{IL}"

TABLE 3.2d
HIGH Level Noise Margins (Commercial)

From \ To	LS	S	ALS	FAST	Units
LS	700	700	700	700	mV
S	700	700	700	700	mV
ALS (5% V_{CC})	750	750	750	750	mV
FAST (5% V_{CC})	700	700	700	700	mV
ALS (10% V_{CC})	500	500	500	500	mV
FAST (10% V_{CC})	500	500	500	500	mV

From "V_{OH}" to "V_{IH}"

POWER CONSUMPTION. With the exception of ECL, all logic families exhibit increased power consumption at high frequencies. Figure 3.1 shows this characteristic for common logic families. As indicated in the figure, TTL devices are more efficient at high frequencies than CMOS.

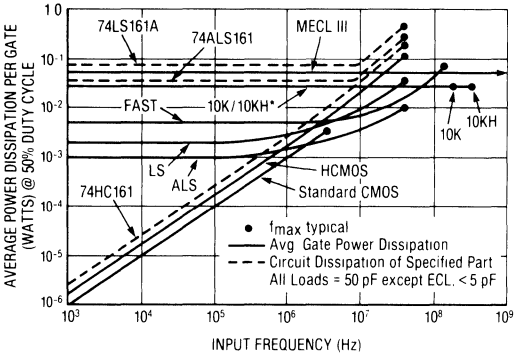


FIGURE 3-1
AVERAGE GATE POWER DISSIPATION versus FREQUENCY

3

FAN-IN AND FAN-OUT. In order to simplify designing with Motorola TTL devices, the input and output loading parameters of all families are normalized to the following values:

1 TTL Unit Load (U.L.) = 40 μA in the HIGH state (Logic "1")
1 TTL Unit Load (U.L.) = 1.6 mA in the LOW state (Logic "0")

Input loading and output drive factors of all products described in this handbook are related to these definitions.

EXAMPLES — INPUT LOAD

1. A 7400 gate, which has a maximum I_{IL} of 1.6 mA and I_{IH} of 40 μA is specified as having an input load factor of 1 U.L. (Also called a fan-in of 1 load.)

2. The 74LS95B which has a value of I_{IL} = 0.8 mA and I_{IH} of 40 μA on the CP terminal, is specified as having an input LOW load factor of

$$\frac{0.8\text{ mA}}{1.6\text{ mA}} \text{ or } 0.5\text{ U.L.} \quad \text{and an input HIGH load factor of} \quad \frac{40\ \mu\text{A}}{40\ \mu\text{A}} \text{ or } 1\text{ U.L.}$$

3. The 74LS00 gate which has an I_{IL} of 0.4 mA and an I_{IH} of 20 μA, has an input LOW load factor of

$$\frac{0.4\text{ mA}}{1.6\text{ mA}} \text{ or } 0.25\text{ U.L.} \quad \text{an input HIGH load factor of} \quad \frac{20\ \mu\text{A}}{40\ \mu\text{A}} \text{ or } 0.5\text{ U.L.}$$

EXAMPLES — OUTPUT DRIVE

1. The output of the 7400 will sink 16 mA in the LOW (logic "0") state and source 800 μA in the HIGH (logic "1") state. The normalized output LOW drive factor is therefore

$$\frac{16\text{ mA}}{1.6\text{ mA}} = 10\text{ U.L.}$$

and the output HIGH drive factor is

$$\frac{800\ \mu\text{A}}{40\ \mu\text{A}} \text{ or } 20\text{ U.L.}$$

2. The output of the 74LS00 will sink 8.0 mA in the LOW state and source 400 μA in the HIGH state. The normalized output LOW drive factor is

$$\frac{8.0\ \text{mA}}{1.6\ \text{mA}} \text{ or 5 U.L.}$$

and the output HIGH drive factor is

$$\frac{400\ \mu\text{A}}{40\ \mu\text{A}} \text{ or 10 U.L.}$$

Relative load and drive factors for the basic TTL families are given in Table 3.3.

FAMILY	INPUT LOAD		OUTPUT DRIVE	
	HIGH	LOW	HIGH	LOW
74LS00	0.5 U.L.	0.25 U.L.	10 U.L.	5 U.L.
7400	1 U.L.	1 U.L.	20 U.L.	10 U.L.
9000	1 U.L.	1 U.L.	20 U.L.	10 U.L.
74H00	1.25 U.L.	1.25 U.L.	25 U.L.	12.5 U.L.
74S00	1.25 U.L.	1.25 U.L.	25 U.L.	12.5 U.L.
74 ALS	0.5 U.L.	0.0625 U.L.	10 U.L.	5 U.L.
74 FAST	0.5 U.L.	0.375 U.L.	25 U.L.	12.5 U.L.

TABLE 3.3

Values for MSI devices vary significantly from one element to another. Consult the appropriate data sheet for actual characteristics.

WIRED-OR APPLICATIONS. Certain TTL devices are provided with an "open" collector output to permit the Wired-OR (actually Wired-AND) function. This is achieved by connecting open collector outputs together and adding an external pull-up resistor.

The value of the pull-up resistor is determined by considering the fan-out of the OR tie and the number of devices in the OR tie. The pull-up resistor value is chosen from a range between maximum value (established to maintain the required V_{OH} with all the OR tied outputs HIGH) and a minimum value (established so that the OR tie fan-out is not exceeded when only one output is LOW).

MINIMUM AND MAXIMUM PULL-UP RESISTOR VALUES

$$R_{X(MIN)} = \frac{V_{CC(MAX)} - V_{OL}}{I_{OL} - N_2(LOW) \bullet 1.6\ \text{mA}} \qquad R_{X(MAX)} = \frac{V_{CC(MIN)} - V_{OH}}{N_1 \bullet I_{OH} + N_2(HIGH) \bullet 40\ \mu\text{A}}$$

where:

R_X = External Pull-up Resistor
N_1 = Number of Wired-OR Outputs
N_2 = Number of Input Unit Loads (U.L.) being Driven
$I_{OH} = I_{CEX}$ = Output HIGH Leakage Current
I_{OL} = LOW Level Fan-out Current of Driving Element
V_{OL} = Output LOW Voltage Level (0.5 V)
V_{OH} = Output HIGH Voltage Level (2.4 V)
V_{CC} = Power Supply Voltage

Example: Four 74LS03 gate outputs driving four other LS gates or MSI inputs.

$$R_{X(MIN)} = \frac{5.25\ V - 0.5\ V}{8\ mA - 1.6\ mA} = \frac{4.75\ V}{6.4\ mA} = 742\ \Omega$$

$$R_{X(MAX)} = \frac{4.75\ V - 2.4\ V}{4 \bullet 100\ \mu A + 2 \bullet 40\ \mu A} = \frac{2.35\ V}{0.48\ mA} = 4.9\ k\Omega$$

where:

$N_1 = 4$
N_2 (HIGH) $= 4 \bullet 0.5$ U.L. $= 2$ U.L.
N_2 (LOW) $= 4 \bullet 0.25$ U.L. $= 1$ U.L.
$I_{OH} = 100\ \mu A$
$I_{OL} = 8\ mA$
$V_{OL} = 0.5\ V$
$V_{OH} = 2.4\ V$

Any value of pull-up resistor between 742 Ω and 4.9 kΩ can be used. The lower values yield the fastest speeds while the higher values yield the lowest power dissipation.

3

UNUSED INPUTS. For best noise immunity and switching speed, unused TTL inputs should not be left floating, but should be held between 2.4 V and the absolute maximum input voltage.

Two possible ways of handling unused inputs are:

1. Connect unused input to V_{CC}. LS, ALS and FAST™ TTL inputs have a breakdown voltage > 7.0 V and require, therefore, no series resistor.

2. Connect the unused input to the output of an unused gate that is forced HIGH.

CAUTION: *Do not connect an unused LS, ALS or FAST™ input to another input of the same NAND or AND function. This method, recommended for normal TTL, increases the input coupling capacitance and thus reduces the ac noise immunity.*

INPUT CAPACITANCE. As a rule of thumb, LS, ALS and FAST™ TTL inputs have an average capacitance of 5 pF for DIP packages. For an input that serves more than one internal function, each additional function adds approximately 1.5 pF.

LINE DRIVING — Because of its superior capacitive drive charateristics, TTL logic is often used in line driving applications which require various termination techniques to maintain signal integrity. Parameters associated with this application are listed in Table 3.4.

It is also often necessary to construct load lines to determine reflection waveforms in line driving applications. The input and output characteristic graphs of section 2 (Figs. 2-4, 2-7 and 2-8) can be very useful for this purpose.

OUTPUT RISE AND FALL TIMES provide important information in determining reflection waveforms and crosstalk coefficients. Typical rise and fall times are approximately 6.0 ns for ALS and LS and about 2.0 ns for FAST with a 50 pF load (measured 10-90%). Output rise and fall times become longer as capacitive load is increased.

INTERCONNECTION DELAYS. For those parts of a system in which timing is critical, designers should take into account the finite delay along the interconnections. These range from about 0.12 to 0.15 ns/inch for the type of interconnections normally used in TTL systems. Exceptions occur in systems using ground planes to reduce ground noise during a logic transition; ground planes give higher distributed capacitance and delays of about 0.15 to 0.22 ns/inch.

Most interconnections on a logic board are short enough that the wiring and load capacitance can be treated as a lumped capacitance for purposes of estimating their effect on the propagation delay of the driving circuit. When an interconnection is long enough that its delay is one-fourth to one-half of the signal transition time, the driver output waveform exhibits noticeable slope changes during a transition. This is evidence that during the initial portion of the output voltage transition the driver sees the characteristic impedance of the interconnection (normally 100 Ω to 200 Ω), which for transient conditions appears as a resistor returned to the quiescent voltage existing just before the beginning of the transition. This characteristic impedance forms a voltage divider with the driver output impedance, tending to produce a signal transition having the same rise or fall time as in the no-load condition but with a reduced amplitude. This attenuated signal travels to the far end of the interconnection, which is essentially an unterminated transmission line, where upon the signal starts doubling. Simultaneously, a reflection voltage is generated which has the same amplitude and polarity as the original signal, e.g., if the driver output signal is positive-going the reflection will be positive-going, and as it travels back toward the driver it adds to the line voltage. At the instant the reflection arrives at the driver it adds algebraically to the still-rising driver output, accelerating the transition rate and producing the noticeable change in slope.

(ALL MAXIMUM RATINGS)		LS		ALS			FAST		
Characteristic	Symbol	54LSxxx	74LSxxx	54ALxxx	74ALSxxx		54Fxxx	74Fxxx	Units
Operating Voltage Range	V_{CC}	5 ± 10%	5 ± 5%	5 ± 10%	5 ± 10%	5 ± 5%	5 ± 10%	5 ± 5%	Vdc
Output Drive:	I_{OH}	−0.4	−0.4	−0.4	−0.4	−0.4	−1.0	−1.0	mA
Standard Output	I_{OL}	4.0	8.0	4.0	8.0	8.0	20	20	mA
	I_{sc}	−20 to −100	−20 to −100	−25 to −150	−25 to −150	−25 to −150	−60 to −150	−60 to −150	mA
Buffer Output	I_{OH}	−12	−15	−12	−12	−15	−12	−15	mA
	I_{OL}	12	24	12	12	24	48	64	mA
	I_{SC}	−40 to −225	−40 to −225	−50 to −225	−50 to −225	−50 to −225	−100 to −225	−100 to −225	mA
Buffer Line Driving Capability:									
Minimum R_t into 2.5 v		178	84	178	84	84	43	32	Ω
Minimum R_t into 5.0 v		381	189	381	189	189	95	71	Ω

TABLE 3.4
OUTPUT CHARACTERISTICS FOR SCHOTTKY TTL LOGIC

3

If an interconnection is of such length that its delay is longer than half the signal transition time, the attenuated output of the driver has time to reach substantial completion before the reflection arrives. In the limit, the waveform observed at the driver output is a 2-step signal with a pedestal. In this circumstance the first load circuit to receive a full signal is the one at the far end, because of the doubling effect, while the last one to receive a full signal is the one nearest the driver since it must wait for the reflection to complete the transition. Thus, in a worst-case situation, the net contribution to the overall delay is twice the delay of the interconnection because the initial part of the signal must travel to the far end of the line and the reflection must return.

When load circuits are distributed along an interconnection, the input capacitance of each will cause a small reflection having a polarity opposite that of the signal transition, and each capacitance also slows the transition rate of the signal as it passes by. The series of small reflections, arriving back at the driver, is subtractive and has the effect of reducing the apparent amplitude of the signal. The successive slowing of the transition rate of the transmitted signal means that it takes longer for the signal to rise or fall to the threshold level of any particular load circuit. A rough but workable approach is to treat the load capacitances as an increase in the intrinsic distributed capacitance of the interconnection. Increasing the distributed capacitance of a transmission line reduces its impedance and increases its delay. A good approximation for ordinary TTL interconnections is that distributed load capacitance decreases the characteristic impedance by about one-third and increases the delay by one-half.

ABSOLUTE MAXIMUM RATINGS (above which the useful life may be impaired)

	LS	ALS	FAST
Storage Temperature	−65°C to +150°C	−65°C to +150°C	−65°C to +150°C
Temperature (Ambient) Under Bias	−55°C to +125°C	−55°C to +125°C	−55°C to +125°C
V_{CC} Pin Potential to Ground Pin	−0.5 V to +7.0 V	−0.5 V to +7.0 V	−0.5 V to +7.0 V
*Input Voltage (dc) Diode Inputs	−0.5 V to 15 V	−0.5 V to 5.5 V	−0.5 V to 5.5 V
*Input Current (dc)	−30 mA to +5.0 mA	−30 mA to +5.0 mA	−30 mA to +5.0 mA
Voltage Applied to Open Collector Outputs (Output HIGH)	−0.5 V to +10 V	−0.5 V to +5.5 V	−0.5 V to +5.5 V
High Level Voltage Applied to Disabled 3-State Output	5.5 V	5.5 V	5.5 V

*Either input voltage limit or input circuit limit is sufficient to protect the inputs — Circuits with 5.5 V maximum limits are listed below.

Device types having inputs limited to 5.5 V are as follows:

SN74LS242/243, SN74LS245 — Inputs connected to outputs.
SN74LS640/641/642/645 — Inputs connected to outputs.
SN74LS299/322A/323 — Certain Inputs.
SN74LS673/674 — Certain Inputs.

DEFINITION OF SYMBOLS AND TERMS USED IN THIS DATABOOK

CURRENTS — Positive current is defined as conventional current flow into a device. Negative current is defined as conventional current flow out of a device. All current limits are specified as absolute values.

I_{CC} **Supply Current** — The current flowing into the V_{CC} supply terminal of a circuit with the specified input conditions and the outputs open. When not specified, input conditions are chosen to guarantee worst case operation.

I_{IH} **Input HIGH current** — The current flowing into an input when a specified HIGH voltage is applied.

I_{IL} **Input LOW current** — The current flowing out of an input when a specified LOW voltage is applied.

I_{OH} **Output HIGH current.** The leakage current flowing into a turned off open collector output with a specified HIGH output voltage applied. For devices with a pull-up circuit, the I_{OH} is the current flowing out of an output which is in the HIGH state.

I_{OL} **Output LOW current** — The current flowing into an output which is in the LOW state.

I_{OS} **Output short-circuit current** — The current flowing out of an output which is in the HIGH state when that output is short circuit to ground (or other specified potential).

I_{OZH} **Output off current HIGH** — The current flowing into a disabled 3-state output with a specified HIGH output voltage applied.

I_{OZL} **Output off current LOW** — The current flowing out of a disabled 3-state output with a specified LOW output voltage applied.

3

VOLTAGES — All voltages are referenced to ground. Negative voltage limits are specified as absolute values (*i.e.,* -10 V is greater than -1.0 V).

V_{CC} **Supply voltage** — The range of power supply voltage over which the device is guaranteed to operate within the specified limits.

$V_{IK(MAX)}$ **Input clamp diode voltage** — The most negative voltage at an input when 18 mA is forced out of that input terminal. This parameter guarantees the integrity of the input diode which is intended to clamp negative ringing at the input terminal.

V_{IH} **Input HIGH voltage** — The range of input voltages that represents a logic HIGH in the system.

$V_{IH(MIN)}$ **Minimum input HIGH voltage** — The minimum allowed input HIGH in a logic system. This value represents the guaranteed input HIGH threshold for the device.

V_{IL} **Input LOW voltage** — The range of input voltages that represents a logic LOW in the system.

$V_{IL(MAX)}$ **Maximum input LOW voltage** — The maximum allowed input LOW in a system. This value represents the guaranteed input LOW threshold for the device.

$V_{OH(MIN)}$ **Output HIGH voltage** — The minimum voltage at an output terminal for the specified output current I_{OH} and at the minimum value of V_{CC}.

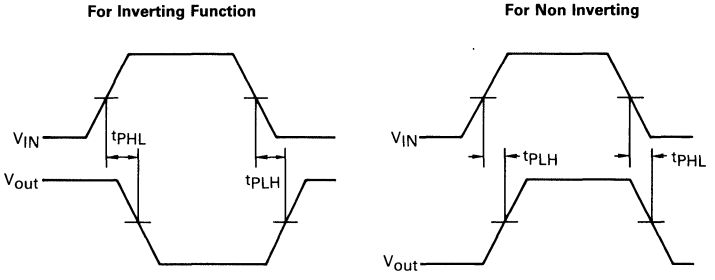
$V_{OL(MAX)}$ **Output LOW voltage** — The maximum voltage at an output terminal sinking the maximum specified load current I_{OL}.

V_{T+} **Positive-going threshold voltage** — The input voltage of a variable threshold device (*i.e.,* Schmitt Trigger) that is interpreted as a V_{IH} as the input transition rises from below $V_{T-(MIN)}$.

V_{T-} **Negative-going threshold voltage** — The input voltage of a variable threshold device (*i.e.,* Schmitt Trigger) that is interpreted as a V_{IL} as the input transition falls from above $V_{T+(MAX)}$.

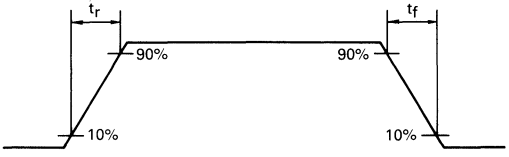
t_{PLH} **Propagation delay LOW-TO-HIGH:**
The time delay from when the input is 1.3 V (1.5 for FAST) to when the output reaches 1.3 V (1.5 for FAST), while the output changes to a logic HIGH.

t_{PHL} **Propagation delay HIGH-TO-LOW:**
The time delay from when the input is 1.3 V (1.5 for FAST) to when the output reaches 1.3 V (1.5 for FAST), while the output changes to a logic LOW.



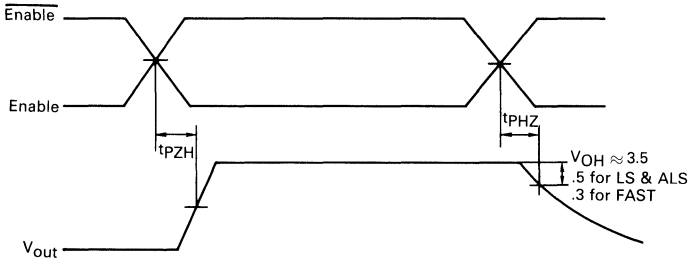
t_r **Waveform Rise Time:**
LOW to HIGH logic transition time, measured from the 10% to 90% points of the waveform.

t_f **Waveform Fall Time:**
HIGH to LOW logic transition time, measured the 90% to the 10% points of the waveform.



t_{PHZ} **Output disable time: HIGH to Z**
The time delay between the specified amplitude point on the enable input and when the output falls 0.5 V (0.3 V for FAST) from the steady-state HIGH level.

t_{PZH} **Output enable time: Z to HIGH**
The time delay between the specified amplitude points on the enable input and the output, when the output is going from a disabled state to a logic HIGH state.

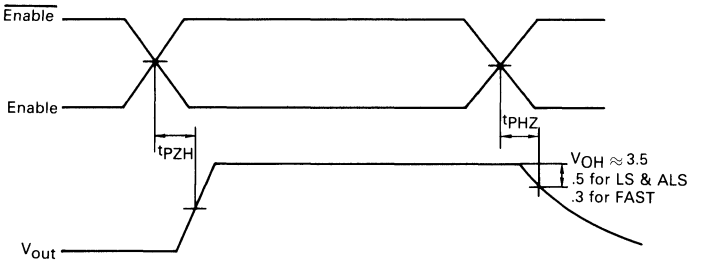


t_{PLZ} **Output disable time: LOW to Z**

The time delay between the specified amplitude point on the enable input and when the output rises 0.5 V (0.3 V for FAST) from the steady-state LOW level.

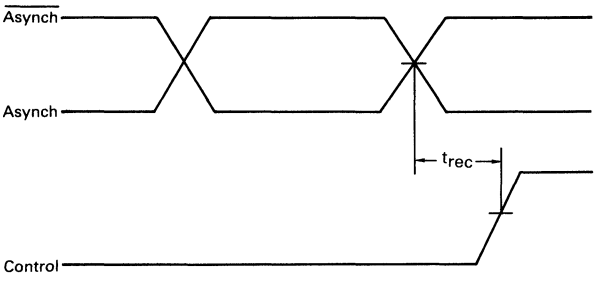
t_{PZL} **Output enable time: Z to LOW**

The time delay between the specified amplitude points on the enable input and the output when the output is going from a disabled state to a logic LOW state.



t_{rec} **Recovery time**

Time required between an asynchronous signal (SET, RESET, CLEAR or PARALLEL load) and the active edge of a synchronous control signal, to insure that the device will properly respond to the synchronous signal.

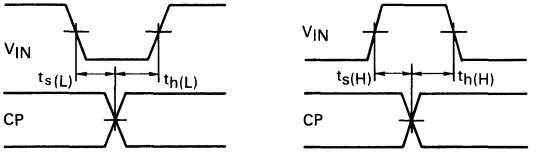


t_h **Hold Time**

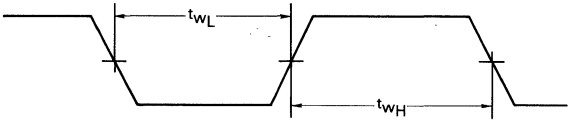
The interval of time from the active edge of the control signal (usually the clock) to when the data to be recognized is no longer required to ensure proper interpretation of the data. A negative hold time indicates that the data may be removed at some time prior to the active edge of the control signal.

t_s **Setup time**

The interval of time during which the data to be recognized is required to remain constant prior to the active edge of the control signal to ensure proper data recognition.



t_W or t_{pw} **Pulse width**
The time between the specified amplitude points (1.3 V for LS & ALS, 1.5 V for FAST) on the leading and trailing edges of a pulse.



f_{MAX} **Toggle frequency/operating frequency**
The maximum rate at which clock pulses meeting the clock requirements *(i.e.,* t_{WH}, t_{WL}, and t_r, t_f) may be applied to a sequential circuit. Above this frequency the device may cease to function.

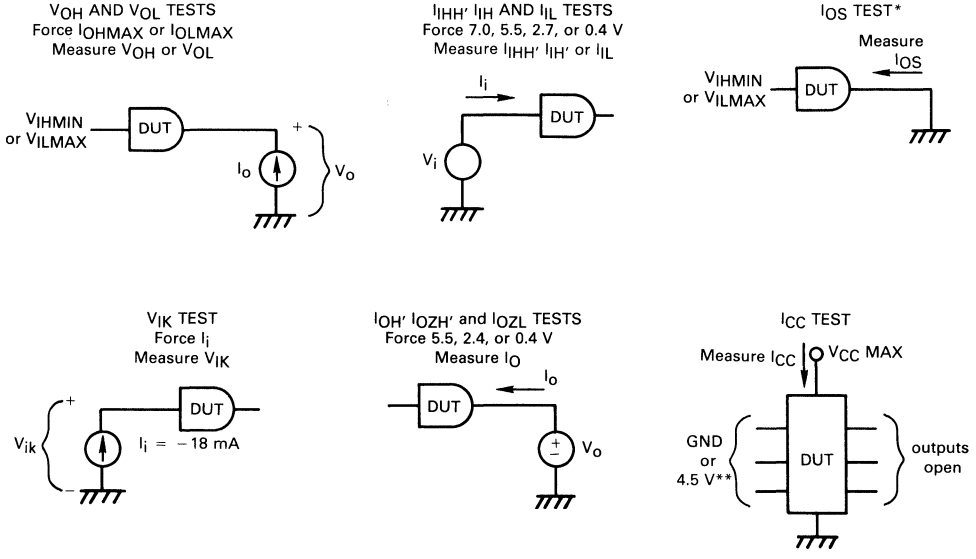
f_{MAX}min **Guaranteed maximum clock frequency**
The lowest possible value for f_{MAX}.

3

TESTING

DC TEST CIRCUITS

The following test circuits and forcing functions represent Motorola's typical DC test procedures



*The test for I_O (ALS devices) is performed in the same manner as I_{OS} except 2.25 volts is forced on the output instead of 0.0 V.
**Unless otherwise indicated, input conditions are selected to produce a worst case condition.

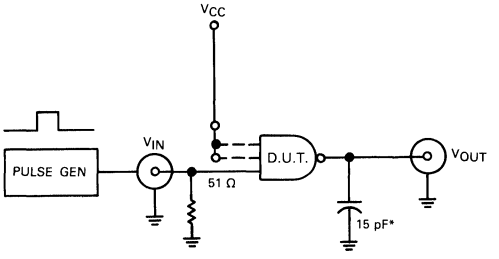
AC TEST CIRCUITS The following test circuits and conditions represent Motorola's typical test procedures. AC waveforms and terminology can be found on pages 3-8 to 3-10.

Proper testing requires that care be taken in the construction of AC test fixtures. This is especially true of FAST™ TTL.

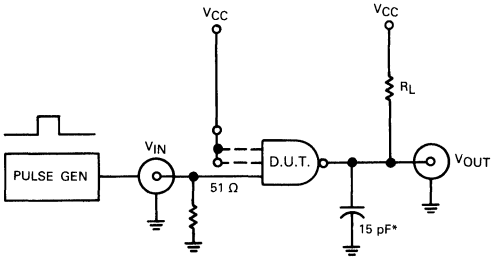
Maintaining a 50 Ω environment on the ac test fixture, as well as the use of multilayer boards with internal V_{CC} and ground planes is highly recommended for FAST™ TTL. Bypassing with both electrolytic and high quality RF type capacitors should be provided on the board. Lead lengths for all components should be kept as short as possible (Motorola uses and recommends chip capacitors and resistors for ac test fixtures). Following these rules will result in cleaner waveforms as well as better correlation between Motorola and the FAST™ TTL consumer.

LS TEST CIRCUITS

Test Circuit for Standard Output Devices

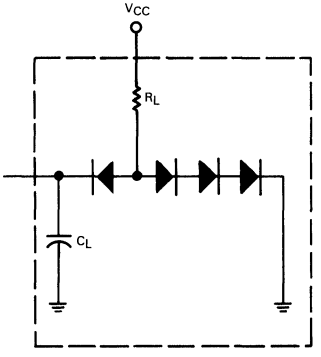


Test Circuit for Open Collector Output Devices



*includes all probe and jig capacitance

Optional LS Load (Guaranteed—Not Tested)

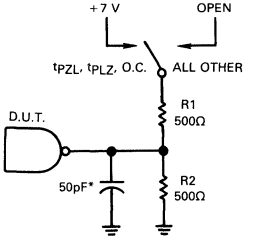


PULSE GENERATOR SETTINGS (UNLESS OTHERWISE SPECIFIED)

	LS	ALS	FAST
Frequency =	1MHZ	1MHZ	1MHZ
Duty Cycle =	50%	50%	50%
$^1T_{LH}$ (t_r) =	6 ns (15)*	6ns	2.5ns
$^1T_{HL}$ (t_f) =	6ns (15)*	6ns	2.5ns
Amplitude =	0 to 3 V	0 to 3 V	0 to 3 V

*The specified propagation delay limits can be guaranteed with a 15 ns input rise time on all parameters except those requiring narrow pulse widths. Any frequency measurement over 15 MHz or pulse width less than 30 ns must be performed with a 6 ns input rise time.

ALS and FAST TEST CIRCUITS



*includes all probe and jig capacitance

Note: for ALS open collector outputs with I_{OL} = 8 mA, replace R1 and R2 with 1000 Ω resistors.

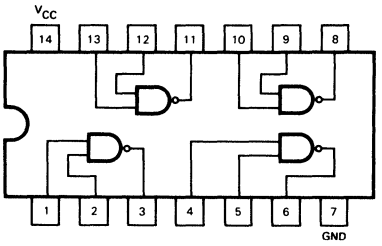
LS Data Sheets

4

SCHOTTKY TTL

MOTOROLA

SN54LS00
SN74LS00



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

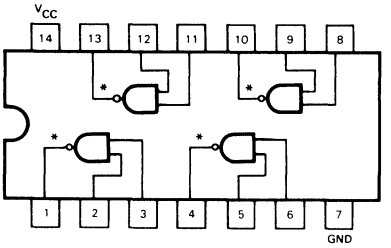
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX
	Total, Output LOW				4.4		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		9.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	C_L = 15 pF

MOTOROLA

SN54LS01
SN74LS01



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

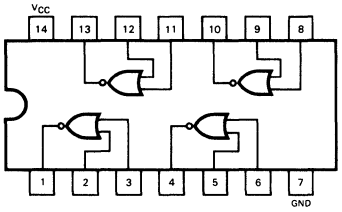
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX	
	Total, Output LOW				4.4			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	

MOTOROLA

SN54LS02
SN74LS02



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NOR GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				3.2	mA	V_{CC} = MAX	
	Total, Output LOW				5.4			

AC CHARACTERISTICS: T_A = 25°C

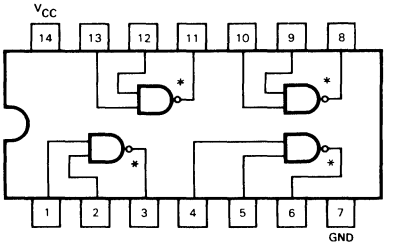
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		10	15	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	

MOTOROLA

SN54LS03
SN74LS03

QUAD 2-INPUT NAND GATE

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX	
	Total, Output LOW				4.4			

AC CHARACTERISTICS: T_A = 25°C

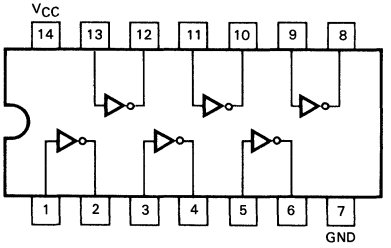
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	

MOTOROLA

SN54LS04
SN74LS04

HEX INVERTER

LOW POWER SCHOTTKY



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				2.4	mA	V_{CC} = MAX
	Total, Output LOW				6.6		

AC CHARACTERISTICS: T_A = 25°C

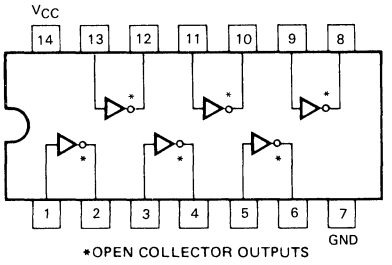
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		9.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	C_L = 15 pF

MOTOROLA

SN54LS05
SN74LS05

HEX INVERTER

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

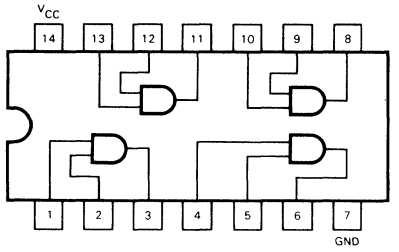
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				2.4	mA	V_{CC} = MAX	
	Total, Output LOW				6.6			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	

MOTOROLA

SN54LS08
SN74LS08



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT AND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

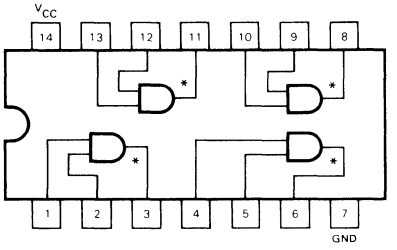
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				4.8	mA	V_{CC} = MAX
	Total, Output LOW				8.8		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		8.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	20	ns	C_L = 15 pF

MOTOROLA

SN54LS09
SN74LS09



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT AND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

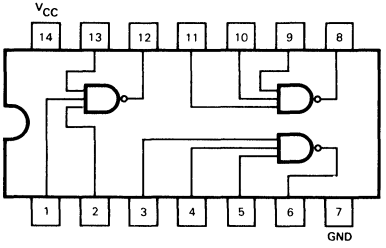
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current Total, Output HIGH				4.8	mA	V_{CC} = MAX
	Total, Output LOW				8.8		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		20	35	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		17	35	ns	

MOTOROLA

SN54LS10
SN74LS10



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

TRIPLE 3-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

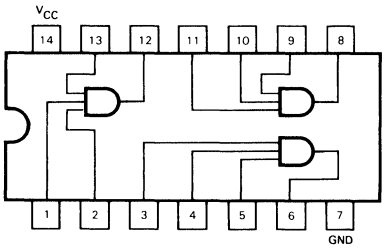
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				1.2	mA	V_{CC} = MAX	
	Total, Output LOW				3.3			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		9.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	C_L = 15 pF

MOTOROLA

SN54LS11
SN74LS11



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

TRIPLE 3-INPUT AND GATE

LOW POWER SCHOTTKY

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				3.6	mA	V_{CC} = MAX	
	Total, Output LOW				6.6			

AC CHARACTERISTICS: T_A = 25°C

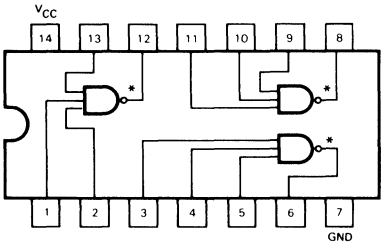
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		8.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	20	ns	C_L = 15 pF

MOTOROLA

SN54LS12
SN74LS12

TRIPLE 3-INPUT NAND GATE

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUT

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				1.4	mA	V_{CC} = MAX	
	Total, Output LOW				3.3			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	

MOTOROLA

SN54LS/74LS13
SN54LS/74LS14

SCHMITT TRIGGERS
DUAL GATE/HEX INVERTER

LOW POWER SCHOTTKY

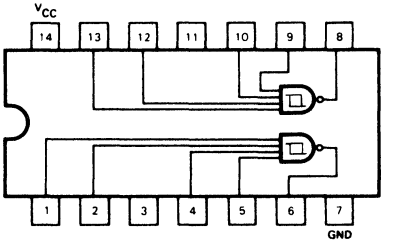
DESCRIPTION — The SN54LS/74LS13 and SN54LS/74LS14 contain logic gates/inverters which accept standard TTL input signals and provide standard TTL output levels. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals. Additionally, they have greater noise margin than conventional inverters.

Each circuit contains a Schmitt trigger followed by a Darlington level shifter and a phase splitter driving a TTL totem pole output. The Schmitt trigger uses positive feedback to effectively speed-up slow input transitions, and provide different input threshold voltages for positive and negative-going transitions. This hysteresis between the positive-going and negative-going input thresholds (typically 800 mV) is determined internally by resistor ratios and is essentially insensitive to temperature and supply voltage variations.

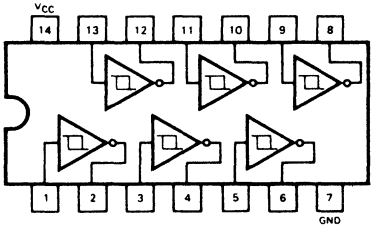
4

LOGIC AND CONNECTION DIAGRAMS

SN54LS/74LS13



SN54LS/74LS14



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

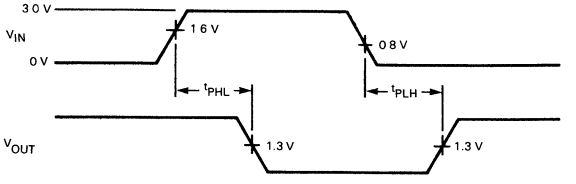
SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{T+}	Positive-Going Threshold Voltage		1.5		2.0	V	V_{CC} = 5.0 V
V_{T-}	Negative-Going Threshold Voltage		0.6		1.1	V	V_{CC} = 5.0 V
V_{T+}-V_{T-}	Hysteresis		0.4	0.8		V	V_{CC} = 5.0 V
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = −400 μA, V_{IN} = V_{IL}
		74	2.7	3.4			
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	V_{CC} = MIN, I_{OL} = 4.0 mA, V_{IN} = 2.0 V
		74		0.35	0.5	V	V_{CC} = MIN, I_{OL} = 8.0 mA, V_{IN} = 2.0 V
I_{T+}	Input Current at Positive-Going Threshold			−0.14		mA	V_{CC} = 5.0 V, V_{IN} = V_{T+}
I_{T-}	Input Current at Negative-Going Threshold			−0.18		mA	V_{CC} = 5.0 V, V_{IN} = V_{T-}
I_{IH}	Input HIGH Current			1.0	20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX, V_{OUT} = 0 V
I_{CC}	Power Supply Current Total, Output HIGH	LS13		2.9	6.0	mA	V_{CC} = MAX
		LS14		8.6	16		
	Total, Output LOW	LS13		4.1	7.0		
		LS14		12	21		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	MAX LS13	MAX LS14	UNITS	TEST CONDITIONS
t_{PLH}	Propagation Delay, Input to Output	22	22	ns	V_{CC} = 5.0 V, C_L = 15 pF
t_{PHL}	Propagation Delay, Input to Output	27	22	ns	



V_{IN} VERSUS V_{OUT} TRANSFER FUNCTION

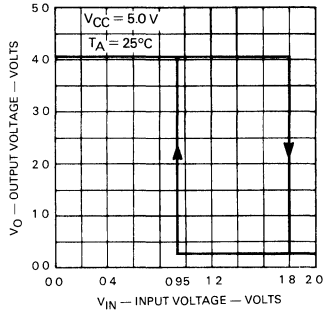


Fig. 1

THRESHOLD VOLTAGE AND HYSTERESIS VERSUS POWER SUPPLY VOLTAGE

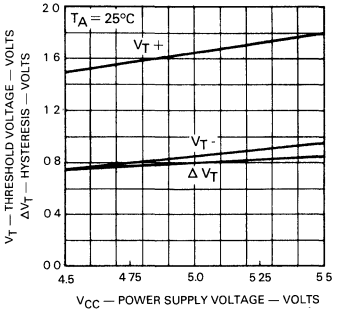


Fig. 2

THRESHOLD VOLTAGE HYSTERESIS VERSUS TEMPERATURE

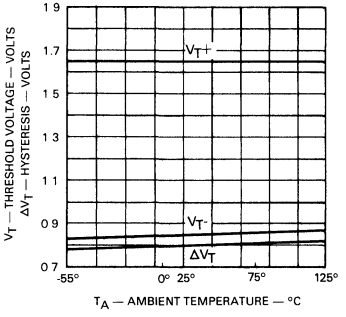
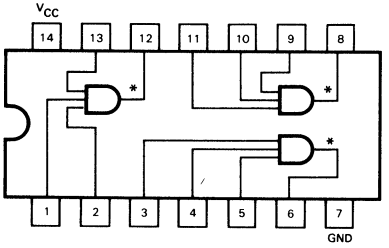


Fig. 3

4

MOTOROLA

SN54LS15
SN74LS15



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

TRIPLE 3-INPUT AND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

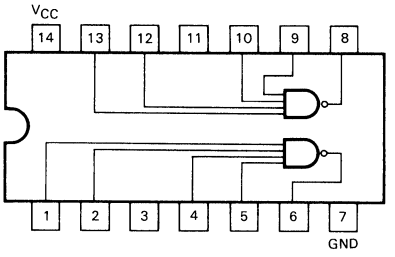
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current Total, Output HIGH				3.6	mA	V_{CC} = MAX
	Total, Output LOW				6.6		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		20	35	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		17	35	ns	

MOTOROLA

SN54LS20
SN74LS20



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 4-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

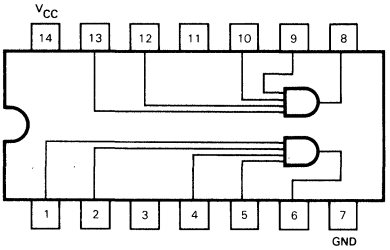
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				0.8	mA	V_{CC} = MAX	
	Total, Output LOW				2.2			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		9.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	C_L = 15 pF

MOTOROLA

SN54LS21
SN74LS21



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 4-INPUT AND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

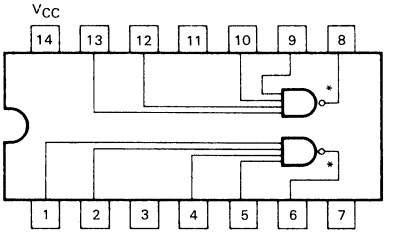
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				2.4	mA	V_{CC} = MAX
	Total, Output LOW				4.4		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		8.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	20	ns	C_L = 15 pF

MOTOROLA

SN54LS22
SN74LS22



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 4-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				0.8	mA	V_{CC} = MAX	
	Total, Output LOW				2.2			

AC CHARACTERISTICS: T_A = 25°C

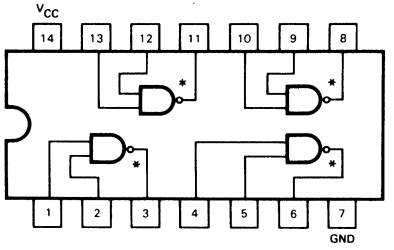
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	

MOTOROLA

SN54LS26
SN74LS26

QUAD 2-INPUT NAND BUFFER

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			15	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			1000	μA	V_{CC} = MIN, V_{OH} = MAX	
		54,74			50	μA	V_{CC} = MIN, V_{OH} = 12 V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.4 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX	
	Total, Output LOW				4.4			

AC CHARACTERISTICS: T_A = 25°C

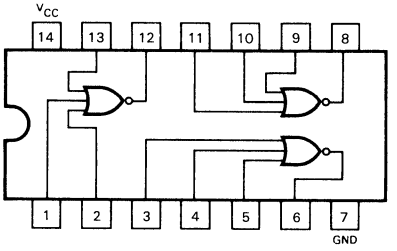
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		17	32	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		15	28	ns	C_L = 15 pF, R_L = 2.0 kΩ

MOTOROLA

SN54LS27
SN74LS27

TRIPLE 3-INPUT NOR GATE

LOW POWER SCHOTTKY



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5 0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 , 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

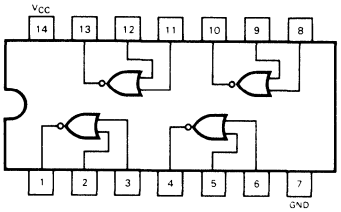
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				4.0	mA	V_{CC} = MAX	
	Total, Output LOW				6.8			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		10	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		10	15	ns	C_L = 15 pF

MOTOROLA

SN54LS28
SN74LS28



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NOR BUFFER

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−1.2	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

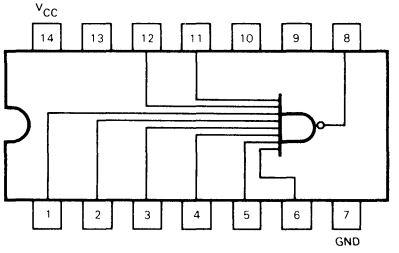
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				3.6	mA	V_{CC} = MAX
	Total, Output LOW				13.8		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Propagation Delay		12	24	ns	V_{CC} = 5.0 V C_L = 45 pF, R_L = 667 Ω
t_{PHL}	Propagation Delay		12	24	ns	

MOTOROLA

SN54LS30
SN74LS30



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

8-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

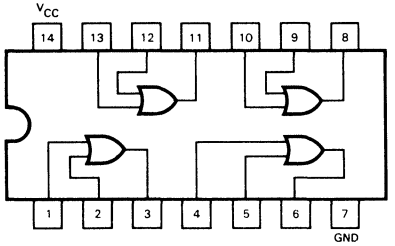
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				0.5	mA	V_{CC} = MAX	
	Total, Output LOW				1.1			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		8.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		13	20	ns	C_L = 15 pF

MOTOROLA

SN54LS32
SN74LS32



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT OR GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

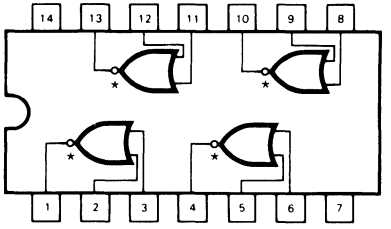
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				6.2	mA	V_{CC} = MAX
	Total, Output LOW				9.8		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		14	22	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		14	22	ns	C_L = 15 pF

MOTOROLA

SN54LS33
SN74LS33



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NOR BUFFER

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

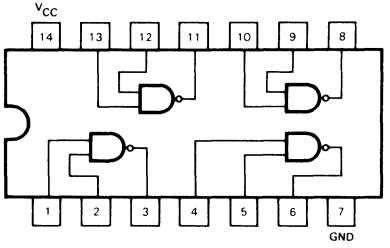
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			250	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				3.6	mA	V_{CC} = MAX	
	Total, Output LOW				13.8			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		20	32	ns	V_{CC} = 5.0 V, R_L = 667 Ω
t_{PHL}	Turn On Delay, Input to Output		18	28	ns	C_L = 45 pF

MOTOROLA

SN54LS37
SN74LS37



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NAND BUFFER

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−1.2	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				2.0	mA	V_{CC} = MAX	
	Total, Output LOW				12			

AC CHARACTERISTICS: T_A = 25°C

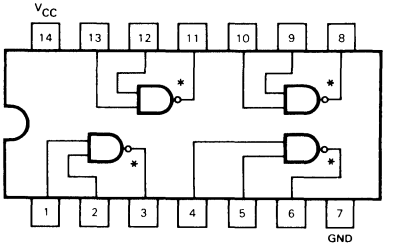
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		12	24	ns	V_{CC} = 5.0 V, R_L = 667 Ω
t_{PHL}	Turn On Delay, Input to Output		12	24	ns	C_L = 45 pF

MOTOROLA

SN54LS38
SN74LS38

QUAD 2-INPUT NAND BUFFER

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

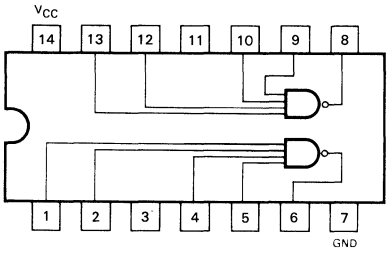
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			250	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.4 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current Total, Output HIGH				2.0	mA	V_{CC} = MAX
	Total, Output LOW				12		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		20	32	ns	V_{CC} = 5.0 V, R_L = 667 Ω
t_{PHL}	Turn On Delay, Input to Output		18	28	ns	C_L = 45 pF

MOTOROLA

SN54LS40
SN74LS40



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 4-INPUT NAND BUFFER

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−1.2	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				1.0	mA	V_{CC} = MAX	
	Total, Output LOW				6.0			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		12	24	ns	V_{CC} = 5.0 V, R_L = 667 Ω
t_{PHL}	Turn On Delay, Input to Output		12	24	ns	C_L = 45 pF

MOTOROLA

SN54LS42
SN74LS42

ONE-OF-TEN DECODER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS42 is a Multipurpose Decoder designed to accept four BCD inputs and provide ten mutually exclusive outputs. The LS42 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

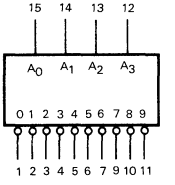
- **MULTI-FUNCTON CAPABILITY**
- **MUTUALLY EXCLUSIVE OUTPUTS**
- **DEMULTIPLEXING CAPABILITY**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
$A_0 - A_3$	Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{0}$ to $\overline{9}$	Outputs, Active LOW (Note b)	10 U.L.	5(2.5) U.L.

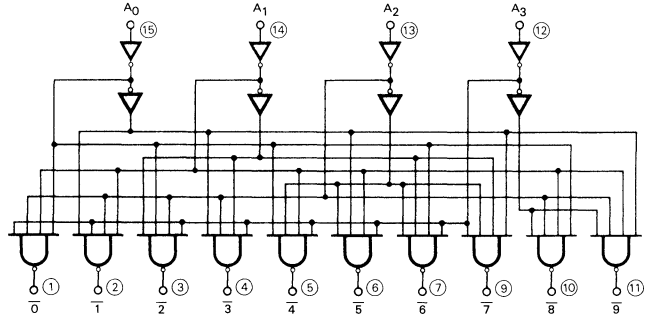
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



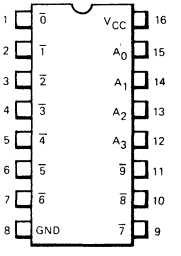
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
( ) = Pin Numbers

CONNECTION DIAGRAM DIP
(TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The LS42 decoder accepts four active HIGH BCD inputs and provides ten mutually exclusive active LOW outputs, as shown by logic symbol or diagram. The active LOW outputs facilitate addressing other MSI units with LOW input enables.

The logic design of the LS42 ensures that all outputs are HIGH when binary codes greater than nine are applied to the inputs.

The most significant input A_3 produces a useful inhibit function when the LS42 is used as a one-of-eight decoder. The A_3 input can also be used as the Data input in an 8-output demultiplexer application.

TRUTH TABLE

A_0	A_1	A_2	A_3	$\overline{0}$	$\overline{1}$	$\overline{2}$	$\overline{3}$	$\overline{4}$	$\overline{5}$	$\overline{6}$	$\overline{7}$	$\overline{8}$	$\overline{9}$
L	L	L	L	L	H	H	H	H	H	H	H	H	H
H	L	L	L	H	L	H	H	H	H	H	H	H	H
L	H	L	L	H	H	L	H	H	H	H	H	H	H
H	H	L	L	H	H	H	L	H	H	H	H	H	H
L	L	H	L	H	H	H	H	L	H	H	H	H	H
H	L	H	L	H	H	H	H	H	L	H	H	H	H
L	H	H	L	H	H	H	H	H	H	L	H	H	H
H	H	H	L	H	H	H	H	H	H	H	L	H	H
L	L	L	H	H	H	H	H	H	H	H	H	L	H
H	L	L	H	H	H	H	H	H	H	H	H	H	L
L	H	L	H	H	H	H	H	H	H	H	H	H	H
H	H	L	H	H	H	H	H	H	H	H	H	H	H
L	L	H	H	H	H	H	H	H	H	H	H	H	H
H	L	H	H	H	H	H	H	H	H	H	H	H	H
L	H	H	H	H	H	H	H	H	H	H	H	H	H
H	H	H	H	H	H	H	H	H	H	H	H	H	H

H = HIGH Voltage Level
L = LOW Voltage Level

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				13	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay (2 Levels)		15 15	25 25	ns	Fig. 2	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay (3 Levels)		20 20	30 30	ns	Fig. 1	

AC WAVEFORMS

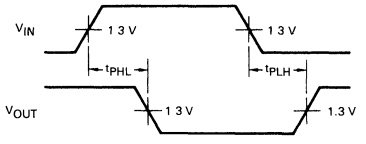


Fig. 1

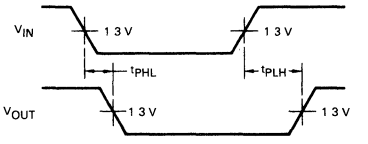


Fig. 2

MOTOROLA

SN54LS47
SN74LS47

BCD TO 7-SEGMENT DECODER/DRIVER
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS47 are Low Power Schottky BCD to 7-Segment Decoder/Drivers consisting of NAND gates, input buffers and seven AND-OR-INVERT gates. They offer active LOW, high sink current outputs for driving indicators directly. Seven NAND gates and one driver are connected in pairs to make BCD data and its complement available to the seven decoding AND-OR-INVERT gates. The remaining NAND gate and three input buffers provide lamp test, blanking input/ripple-blanking output and ripple-blanking input.

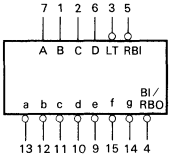
The circuits accept 4-bit binary-coded-decimal (BCD) and, depending on the state of the auxiliary inputs, decodes this data to drive a 7-segment display indicator. The relative positive-logic output levels, as well as conditions required at the auxiliary inputs, are shown in the truth tables. Output configurations of the SN54LS/74LS47 are designed to withstand the relatively high voltages required for 7-segment indicators.

These outputs will withstand 15 V with a maximum reverse current of 250 μA. Indicator segments requiring up to 24 mA of current may be driven directly from the SN74LS47 high performance output transistors. Display patterns for BCD input counts above nine are unique symbols to authenticate input conditions.

The SN54LS/74LS47 incorporates automatic leading and/or trailing-edge zero-blanking control (RBI and RBO). Lamp test (LT) may be performed at any time which the BI/RBO node is a HIGH level. This device also contains an overriding blanking input (BI) which can be used to control the lamp intensity or to inhibit the outputs.

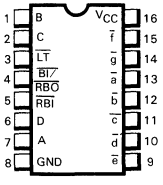
- **LAMP INTENSITY MODULATION CAPABILITY**
- **OPEN COLLECTOR OUTPUTS**
- **LAMP TEST PROVISION**
- **LEADING/TRAILING ZERO SUPPRESSION**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM
DIP (TOP VIEW)



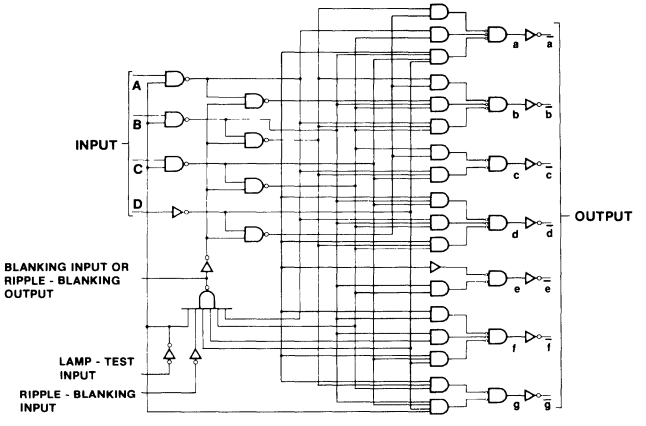
J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

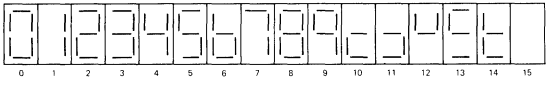
PIN NAMES

		LOADING (Note a)	
		HIGH	LOW
A, B, C, D	BCD Inputs	0.5 U.L.	0.25 U.L.
$\overline{RBI}$	Ripple Blanking Input	0.5 U.L.	0.25 U.L.
$\overline{LT}$	Lamp Test Input	0.5 U.L.	0:25 U.L.
$\overline{BI/RBO}$	Blanking Input or Ripple Blanking Output	0.5 U.L.	0.75 U.L.
		1.2 U.L.	2.0 U.L.
$\bar{a}$, to $\bar{g}$	Outputs	Open-Collector	15 (7.5) U.L.

Notes:
a) 1 Unit Load (U.L.) = 40 μA HIGH, 1.6 mA LOW
b) Output current measured at V_{OUT} = 0.5 V
Output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM





NUMERICAL DESIGNATIONS – RESULTANT DISPLAYS

TRUTH TABLE

	INPUTS						OUTPUTS								
DECIMAL OR FUNCTION	$\overline{LT}$	$\overline{RBI}$	D	C	B	A	$\overline{BI/RBO}$	$\overline{a}$	$\overline{b}$	$\overline{c}$	$\overline{d}$	$\overline{e}$	$\overline{f}$	$\overline{g}$	NOTE
0	H	H	L	L	L	L	H	L	L	L	L	L	L	H	A
1	H	X	L	L	L	H	H	H	L	L	H	H	H	H	A
2	H	X	L	L	H	L	H	L	L	H	L	L	H	L	
3	H	X	L	L	H	H	H	L	L	L	L	H	H	L	
4	H	X	L	H	L	L	H	H	L	L	H	H	L	L	
5	H	X	L	H	L	H	H	L	H	L	L	H	L	L	
6	H	X	L	H	H	L	H	H	H	L	L	L	L	L	
7	H	X	L	H	H	H	H	L	L	L	H	H	H	H	
8	H	X	H	L	L	L	H	L	L	L	L	L	L	L	
9	H	X	H	L	L	H	H	L	L	L	H	H	L	L	
10	H	X	H	L	H	L	H	H	H	H	L	L	H	L	
11	H	X	H	L	H	H	H	H	H	L	L	H	H	L	
12	H	X	H	H	L	L	H	H	L	H	H	H	L	L	
13	H	X	H	H	L	H	H	L	H	H	L	H	L	L	
14	H	X	H	H	H	L	H	H	H	H	L	L	L	L	
15	H	X	H	H	H	H	H	H	H	H	H	H	H	H	
$\overline{BI}$	X	X	X	X	X	X	L	H	H	H	H	H	H	H	B
$\overline{RBI}$	H	L	L	L	L	L	L	H	H	H	H	H	H	H	C
$\overline{LT}$	L	X	X	X	X	X	H	L	L	L	L	L	L	L	D

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

NOTES:

(A) $\overline{BI/RBO}$ is wire-AND logic serving as blanking input (BI) and/or ripple-blanking output ($\overline{RBO}$). The blanking out (BI) must be open or held at a HIGH level when output functions 0 through 15 are desired, and ripple-blanking input ($\overline{RBI}$) must be open or at a HIGH level if blanking of a decimal 0 is not desired. X = input may be HIGH or LOW.

(B) When a LOW level is applied to the blanking input (forced condition) all segment outputs go to a LOW level regardless of the state of any other input condition.

(C) When ripple-blanking input ($\overline{RBI}$) and inputs A, B, C, and D are at LOW level, with the lamp test input at HIGH level, all segment outputs go to a HIGH level and the ripple-blanking output (RBO) goes to a LOW level (response condition).

(D) When the blanking input/ripple-blanking output ($\overline{BI/RBO}$) is open or held at a HIGH level, and a LOW level is applied to lamp test input, all segment outputs go to a LOW level.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High $\overline{BI/RBO}$	54,74			−50	μA
I_{OL}	Output Current — Low $\overline{BI/RBO}$ $\overline{BI/RBO}$	54 74			1.6 3.2	mA
$V_{O\ (off)}$	Off-State Output Voltage $\overline{a}$ to $\overline{g}$	54,74			15	V
$I_{O\ (on)}$	On-State Output Current $\overline{a}$ to $\overline{g}$ $\overline{a}$ to $\overline{g}$	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (Unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Threshold Voltage for All Inputs
V_{IL}	Input LOW Voltage	54 74			0.7 0.8	V	Guaranteed Input LOW Threshold Voltage for All Inputs
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage, $\overline{BI/RBO}$		2.4	4.2		V	V_{CC} = MIN, I_{OH} = −50 μA, V_{IN} = V_{IN} or V_{IL} per Truth Table
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 1.6 mA; V_{CC} = MIN, V_{IN} = V_{IN}
	$\overline{BI/RBO}$	74		0.35	0.5	V	I_{OL} = 3.2 MA; or V_{IL} per Truth Table
$I_{O\ (off)}$	Off-State Output Current $\overline{a}$ thru $\overline{g}$				250	μA	V_{CC} = MAX, V_{IN} = V_{IN} or V_{IL} per Truth Table, V_O (off) = 15 V
$V_{O\ (on)}$	On-State Output Voltage	54,74		0.25	0.4	V	$I_{O(on)}$ = 12 mA; V_{CC} = MAX, V_{IN} = V_{IH}
	$\overline{a}$ thru $\overline{g}$	74		0.35	0.5	V	$I_{O(on)}$ = 24 MA; or V_{IL} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current $\overline{BI/RBO}$ Any Input except $\overline{BI/RBO}$				−1.2 −0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS} $\overline{BI/RBO}$	Output Short Circuit Current		−0.3		−2.0	mA	V_{CC} = MAX, V_{OUT} = 0 V
I_{CC}	Power Supply Current			7.0	13	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL} t_{PLH}	Propagation Delay, Address Input to Segment Output			100 100	ns ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PHL} t_{PLH}	Propagation Delay, $\overline{RBI}$ Input To Segment Output			100 100	ns ns	

AC WAVEFORMS

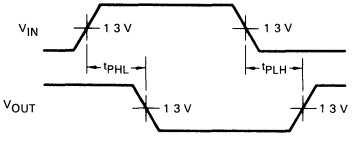


Fig. 1

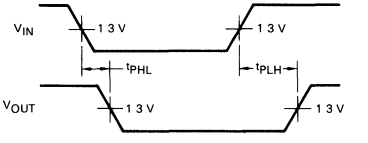


Fig. 2

MOTOROLA

SN54LS/74LS48
SN54LS/74LS49

BCD TO 7-SEGMENT DECODER

LOW POWER SCHOTTKY

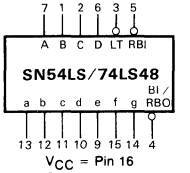
DESCRIPTION — The SN54LS/74LS48 and SN54LS/74LS49 are BCD to 7-Segment Decoders consisting of NAND gates, input buffers and seven AND-OR-INVERT gates. The LS49 offers active HIGH open-collector outputs for current-sourcing applications to drive logic circuits or discrete, active components. Seven NAND gates and one driver are connected in pairs to make BCD data and its complement available to the seven decoding AND-OR-INVERT gates. The remaining NAND gate and three input buffers provide lamp test, blanking input/ripple-blanking input for the LS48. Four NAND gates and four input buffers provide BCD data and its complement and a buffer provides blanking input for the LS49.

The circuits accept 4-bit binary-coded-decimal (BCD) and, depending on the state of the auxiliary inputs, decodes this data to drive other components. The relative positive logic output levels, as well as conditions required at the auxiliary inputs, are shown in the truth tables.

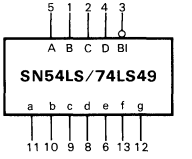
The LS48 circuit incorporates automatic leading and/or trailing edge zero-blanking control (RBI and RBO). Lamp Test (LT) may be activated any time when the BI/RBO node is HIGH. Both devices contain an overriding blanking input (BI) which can be used to control the lamp intensity or to inhibit the outputs.

- **LAMP INTENSITY MODULATION CAPABILITY**
- **INTERNAL PULL-UPS ELIMINATE NEED FOR EXTERNAL RESISTORS ON SN54LS/74LS48**
- **OPEN COLLECTOR OUTPUTS ON SN54LS/74LS49**
- **INPUT CLAMP DIODES ELIMINATE HIGH-SPEED TERMINATION EFFECTS**

LOGIC SYMBOL

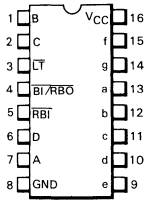


V_{CC} = Pin 16
GND = Pin 8



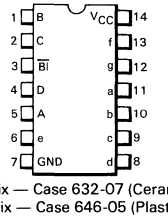
V_{CC} = Pin 14
GND = Pin 7

DIP (TOP VIEW)
SN54LS/74LS48



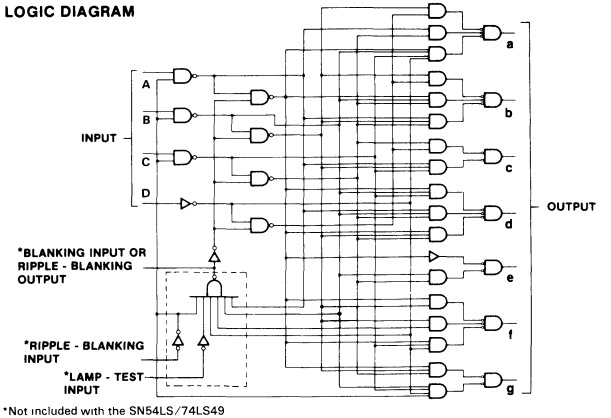
J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

SN54LS/74LS49



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

LOGIC DIAGRAM



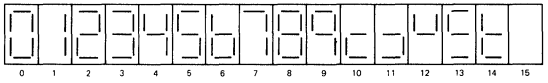
*Not included with the SN54LS/74LS49

4

PIN NAMES

		LOADING (Note a) HIGH	LOW
A, B, C, D,	BCD Inputs	0.5 U.L.	0.25 U.L.
$\overline{RBI}$	Ripple Blanking (Active Low) Input	0.5 U.L.	0.25 U.L.
$\overline{LT}$	Lamp Test (Active Low) Input	0.5 U.L.	0.75 U.L.
$\overline{BI/RBO}$	Blanking Input or Ripple Blanking Output (Active Low)	1.2 U.L. 0.5 U.L.	2(1) U.L. 0.25 U.L.
$\overline{BI}$	Blanking (Active Low) Input	Open Collector	3.75 (1.25) U.L. (48)
a to g	Outputs (Note b)	Open Collector	5 (2.5) U.L. (49)

NOTES:
a) Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b) Output current measured at V_{OUT} = 0.5 V
Output LOW drive factor is SN54LS/74LS48: 1.25 U.L. for Military (54), 3.75 U.L. for Commercial (74).
SN54LS/74LS49: 2.5 U.L. for Military (54), 5 U.L. for Commercial (74) Temperature Ranges.



NUMERICAL DESIGNATIONS – RESULTANT DISPLAYS

4

TRUTH TABLE
SN54LS/74LS48

	INPUTS							OUTPUTS							
DECIMAL OR FUNCTION	$\overline{LT}$	$\overline{RBI}$	D	C	B	A	$\overline{BI/RBO}$	a	b	c	d	e	f	g	NOTE
0	H	H	L	L	L	L	H	H	H	H	H	H	H	L	1
1	H	X	L	L	L	H	H	L	H	H	L	L	L	L	1
2	H	X	L	L	H	L	H	H	H	L	H	H	L	H	
3	H	X	L	L	H	H	H	H	H	H	H	L	L	H	
4	H	X	L	H	L	L	H	L	H	H	L	L	H	H	
5	H	X	L	H	L	H	H	H	L	H	H	L	H	H	
6	H	X	L	H	H	L	H	L	L	H	H	H	H	H	
7	H	X	L	H	H	H	H	H	H	H	L	L	L	L	
8	H	X	H	L	L	L	H	H	H	H	H	H	H	H	
9	H	X	H	L	L	H	H	H	H	H	L	L	H	H	
10	H	X	H	L	H	L	H	L	L	L	H	H	L	H	
11	H	X	H	L	H	H	H	L	L	H	H	L	L	H	
12	H	X	H	H	L	L	H	L	H	L	L	L	H	H	
13	H	X	H	H	L	H	H	H	L	L	H	L	H	H	
14	H	X	H	H	H	L	H	L	L	L	H	H	H	H	
15	H	X	H	H	H	H	H	L	L	L	L	L	L	L	
$\overline{BI}$	X	X	X	X	X	X	L	L	L	L	L	L	L	L	2
$\overline{RBI}$	H	L	L	L	L	L	L	L	L	L	L	L	L	L	3
$\overline{LT}$	L	X	X	X	X	X	H	H	H	H	H	H	H	H	4

NOTES:
(1) $\overline{BI/RBO}$ is wired-AND logic serving as blanking input ($\overline{BI}$) and/or ripple-blanking output ($\overline{RBO}$). The blanking out ($\overline{BI}$) must be open or held at a HIGH level when output functions 0 through 15 are desired, and ripple-blanking input ($\overline{RBI}$) must be open or at a HIGH level if blanking of a decimal 0 is not desired. X=input may be HIGH or LOW.
(2) When a LOW level is applied to the blanking input (forced condition) all segment outputs go to a LOW level, regardless of the state of any other input condition.
(3) When ripple-blanking input ($\overline{RBI}$) and inputs A, B, C, and D are at LOW level, with the lamp test input at HIGH level, all segment outputs go to a HIGH level and the ripple-blanking output ($\overline{RBO}$) goes to a LOW level (response condition).
(4) When the blanking input/ripple-blanking output ($\overline{BI/RBO}$) is open or held at a HIGH level, and a LOW level is applied to lamp-test input, all segment outputs go to a LOW level.

TRUTH TABLE
SN54LS/74LS49

	INPUTS					OUTPUTS							
DECIMAL OR FUNCTION	D	C	B	A	$\overline{BI}$	a	b	c	d	e	f	g	NOTE
0	L	L	L	L	H	H	H	H	H	H	H	L	1
1	L	L	L	H	H	L	H	H	L	L	L	L	
2	L	L	H	L	H	H	H	L	H	H	L	H	
3	L	L	H	H	H	H	H	H	H	L	L	H	
4	L	H	L	L	H	L	H	H	L	L	H	H	
5	L	H	L	H	H	H	L	H	H	L	H	H	
6	L	H	H	L	H	L	L	H	H	H	H	H	
7	L	H	H	H	H	H	H	H	L	L	L	L	
8	H	L	L	L	H	H	H	H	H	H	H	H	
9	H	L	L	H	H	H	H	H	L	L	H	H	
10	H	L	H	L	H	L	L	L	H	H	L	H	
11	H	L	H	H	H	L	L	H	H	L	L	H	
12	H	H	L	L	H	L	H	L	L	L	H	H	
13	H	H	L	H	H	H	L	L	H	L	H	H	
14	H	H	H	L	H	L	L	L	H	H	H	H	
15	H	H	H	H	H	L	L	L	L	L	L	L	
$\overline{BI}$	X	X	X	X	L	L	L	L	L	L	L	L	2

NOTES:
(1) The blanking input must be open or held at a HIGH level when output functions 0 through 15 are desired.
(2) When a LOW level is applied to the blanking input all segment outputs go to a LOW level regardless of the state of any other input condition. X = input may be HIGH or LOW.

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High $\bar{a}$ to $\bar{g}$	54,74			−100	μA
I_{OH}	Output Current — High $\overline{BI/RBO}$	54,74			−50	μA
I_{OL}	Output Current — Low $\bar{a}$ to $\bar{g}$	54 74			2.0 6.0	mA
I_{OL}	Output Current — Low $\overline{BI/RBO}$ $\overline{BI/RBO}$	54 74			1.6 3.2	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54 74			0.7 0.8	V	Guaranteed Input LOW Voltage for All Inputs
V_{IK}	Input Clamp Diode Voltage				−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage		2.4	4.2		μA	V_{CC} = MIN, I_{OH} = −50 μA, V_{IN} = V_{IH} or U.L. per Truth Table
I_O	Output Current $\bar{a}$ to $\bar{g}$		−2.0	−1.3		mA	V_{CC} = MIN, V_O = 0.85 V Input Conditioner as for V_{OH}
V_{OL}	Output LOW Voltage	54,74			0.4	V	I_{OL} = 2.0 mA; V_{CC}=MIN, V_{IH}=2.0 V
	$\bar{a}$ to $\bar{g}$	74			0.5	V	I_{OL} = 6.0 mA; V_{IL} = V_{IL} MAX
V_{OL}	Output LOW Voltage	54,74			0.4	V	I_{OL} = 1.6 mA; V_{CC}=MAX, V_{IH}=2.0 V
	$\overline{BI/RBO}$	74			0.5	V	I_{OL} = 3.2 mA; V_{IL} = V_{IL} MAX
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	(Except $\overline{BI/RBO}$)				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current (Except $\overline{BI/RBO}$)				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{IL}	Input LOW Current $\overline{BI/RBO}$				−1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current			25	38	mA	V_{CC} = MAX

AC CHARACTERISTICS: V_{CC} = 5.0 V T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL}	Propagation delay time, HIGH-to-LOW level output from A Input			100	ns	C_L = 15 pF, R_L = 4.0 kΩ
t_{PLH}	Propagation delay time, LOW-to-HIGH level output from A Input			100	ns	
t_{PHL}	Propagation delay time, HIGH-to-LOW level output from $\overline{RBI}$ Input			100	ns	C_L = 15 pF, R_L = 6.0 kΩ
t_{PLH}	Propagation delay time, LOW-to-HIGH level output from $\overline{RBI}$ Input			100	ns	

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

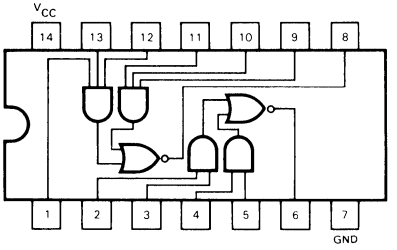
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage
V_{IL}	Input LOW Voltage	54			0.7	V	Guarantee Input LOW Voltage
		74			0.8	V	
V_{IK}	Input Clamp Diode Voltage				−1.5	V	V_{CC} = MIN, I_{IN} = -18 mA
I_{OH}	Output HIGH Current				250	μA	V_{CC} = MIN, V_{IH} = 2.0 V V_{IL} = V_{IL} MAX, V_{OH} = 5.5 V
V_{OL}	Output LOW Voltage	54,74			0.4	V	I_{OL} = 4.0 mA; V_{CC} = MIN, V_{IH} = 2.0 V
		74			0.5	V	I_{OL} = 8.0 mA; V_{IL} = V_{IL} MAX
I_{IH}	Input Current HIGH				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input Current LOW				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current			8.0	15	mA	V_{CC} = MAX

AC CHARACTERISTICS: V_{CC} = 5.0 V, TA = 25°

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL}	Propagation delay time, HIGH-to-LOW level output from A Input			100	ns	C_L = 15 pF, R_L = 2.0 kΩ
t_{PLH}	Propagation delay time, LOW-to-HIGH level output from A Input			100	ns	
t_{PHL}	Propagation delay time, HIGH-to-LOW level output from $\overline{RBI}$ Input			100	ns	C_L = 15 pF, R_L = 6.0 kΩ
t_{PLH}	Propagation delay time, LOW-to-HIGH level output from $\overline{RBI}$ Input			100	ns	

MOTOROLA

SN54LS51
SN74LS51



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 2-WIDE 2-INPUT/ 3-INPUT AND-OR-INVERT GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

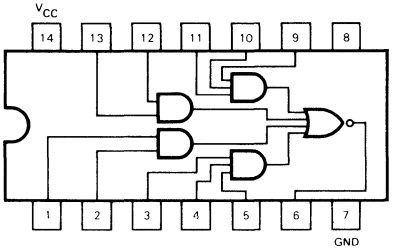
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX	
	Total, Output LOW				2.8			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		12	20	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		12.5	20	ns	C_L = 15 pF

MOTOROLA

SN54LS54
SN74LS54



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

3-2-2-3-INPUT AND-OR-INVERT GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				1.6	mA	V_{CC} = MAX	
	Total, Output LOW				2.0			

AC CHARACTERISTICS: T_A = 25°C

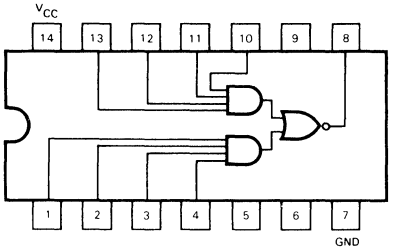
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		12	20	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		12.5	20	ns	C_L = 15 pF

MOTOROLA

SN54LS55
SN74LS55

2-WIDE 4-INPUT AND-OR-INVERT GATE

LOW POWER SCHOTTKY



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				0.8	mA	V_{CC} = MAX	
	Total, Output LOW				1.3			

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		12	20	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		12.5	20	ns	C_L = 15 pF

MOTOROLA

SN54LS73A
SN74LS73A

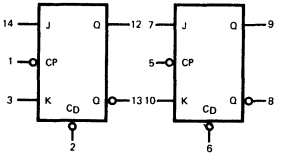
DESCRIPTION — The SN54LS/74LS73A offers individual J, K, clear, and clock inputs. These dual flip-flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The logic level of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the truth table as long as minimum set-up times are observed. Input data is transferred to the outputs on the negative-going edge of the clock pulse.

DUAL JK NEGATIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

4

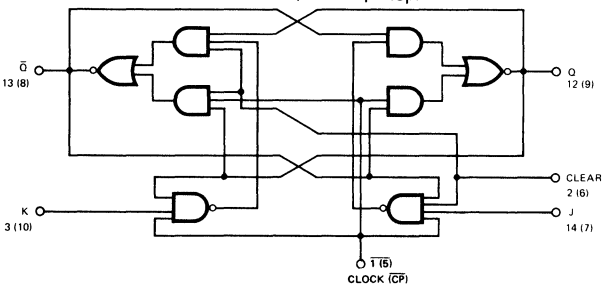
LOGIC SYMBOL



V_{CC} = Pin 4
GND = Pin 11

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

LOGIC DIAGRAM (Each Flip-Flop)



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K Clear Clock			20 60 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		J, K Clear Clock			0.1 0.3 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	J, K Clear, Clock			−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS			OUTPUTS	
	$\overline{C}_D$	J	K	Q	$\overline{Q}$
Reset (Clear)	L	X	X	L	H
Toggle	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	l	h	L	H
Load "1" (Set)	H	h	l	H	L
Hold	H	l	l	q	$\overline{q}$

H, h = HIGH Voltage Level
L, l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

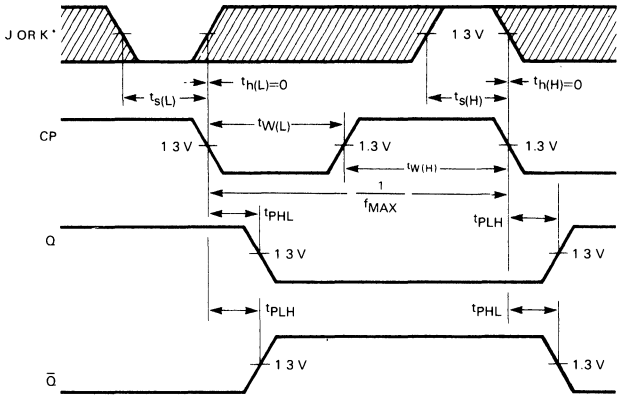
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
f_{MAX}	Maximum Clock Frequency	30	45		MHz	Fig. 1	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH}	Propagation Delay,		15	20	ns	Fig. 1	
t_{PHL}	Clock to Output		15	20	ns		

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
t_W	Clock Pulse Width High	20			ns	Fig. 1	$V_{CC} = 5.0$ V
t_W	Set Pulse Width	25			ns	Fig. 2	
t_s	Setup Time	20			ns	Fig. 1	
t_h	Hold Time	0			ns		

AC WAVEFORMS

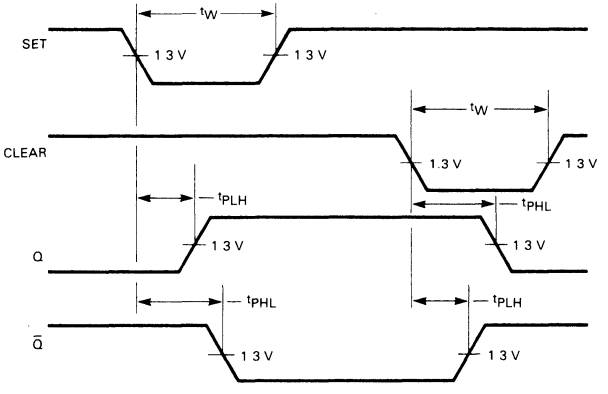
Fig. 1 CLOCK TO OUTPUT DELAYS, DATA SET-UP AND HOLD TIMES, CLOCK PULSE WIDTH



*The shaded areas indicate when the input is permitted to change for predicatable output performance.

4

Fig. 2 SET AND CLEAR TO OUTPUT DELAYS, SET AND CLEAR PULSE WIDTHS



MOTOROLA

SN54LS74A
SN54LS74A

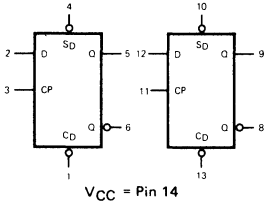
DUAL D-TYPE POSITIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION - The SN54LS/74LS74A dual edge-triggered flip-flop utilizes Schottky TTL circuitry to produce high speed D-type flip-flops. Each flip-flop has individual clear and set inputs, and also complementary Q and $\overline{Q}$ outputs.

Information at input D is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the HIGH or the LOW level, the D input signal has no effect.

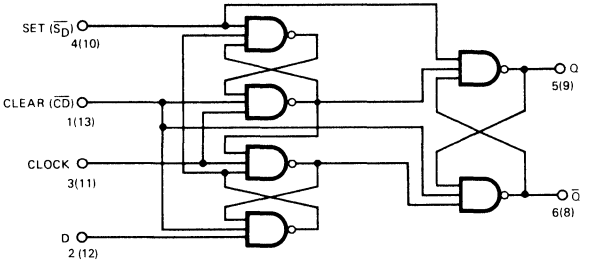
LOGIC SYMBOL



V_{CC} = Pin 14
GND = Pin 7

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

LOGIC DIAGRAM
(EACH FLIP-FLOP)



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input High Current Data, Clock Set, Clear				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	Data, Clock Set, Clear				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current Data, Clock Set, Clear				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				8.0	mA	V_{CC} = MAX	

MODE SELECT — TRUTH TABLE

OPERATING MODE	INPUTS			OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	D	Q	$\overline{Q}$
Set	L	H	X	H	L
Reset (Clear)	H	L	X	L	H
*Undetermined	L	L	X	H	H
Load "1" (Set)	H	H	h	H	L
Load "0" (Reset)	H	H	l	L	H

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the LOW to HIGH clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

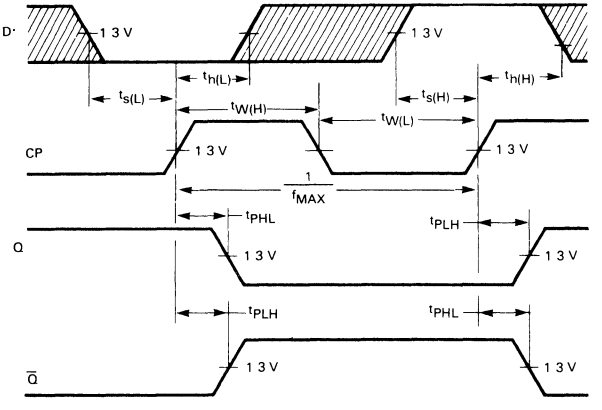
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
f_{MAX}	Maximum Clock Frequency	25	33		MHz	Fig. 1	$V_{CC} = 5.0$ V, $C_L = 15$ pF
t_{PLH}	Clock, Clear, Set to Output		13	25	ns	Fig. 1	
t_{PHL}			25	40	ns		

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
$t_{W(H)}$	Clock	25			ns	Fig. 1	$V_{CC} = 5.0$ V
$t_{W(L)}$	Clear, Set	25			ns	Fig. 2	
t_s	Data Setup Time — HIGH	20			ns	Fig. 1	
	LOW	20			ns		
t_h	Hold Time	5.0			ns	Fig. 1	

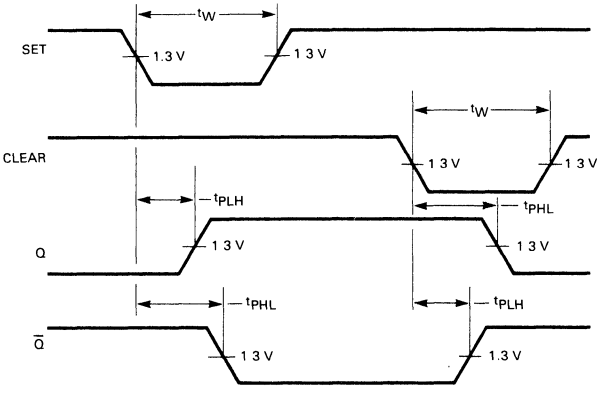
AC WAVEFORMS

Fig. 1 CLOCK TO OUTPUT DELAYS,
DATA SET-UP AND HOLD TIMES, CLOCK PULSE WIDTH



*The shaded areas indicate when the input is permitted to change for predicatable output performance

Fig. 2 SET AND CLEAR TO OUTPUT DELAYS,
SET AND CLEAR PULSE WIDTHS



MOTOROLA

SN54LS/74LS75
SN54LS/74LS77

4-BIT D LATCH

LOW POWER SCHOTTKY

DESCRIPTION — The TTL/MSI SN54LS/74LS75 and SN54LS/74LS77 are latches used as temporary storage for binary information between processing units and input/output or indicator units. Information present at a data (D) input is transferred to the Q output when the Enable is HIGH and the Q output will follow the data input as long as the Enable remains HIGH. When the Enable goes LOW, the information (that was present at the data input at the time the transition occurred) is retained at the Q output until the Enable is permitted to go HIGH.

The SN54LS/74LS75 features complementary Q and $\overline{Q}$ output from a 4-bit latch and is available in the 16-pin packages. For higher component density applications the SN54LS/74LS77 4-bit latch is available in the 14-pin package with $\overline{Q}$ outputs omitted.

PIN NAMES		LOADING (Note a) HIGH	LOW
D_1–D_4	Data Inputs	0.5 U.L.	0.25 U.L.
E_{0-1}	Enable Input Latches 0, 1	2.0 U.L.	1.0 U.L.
E_{2-3}	Enable Input Latches 2, 3	2.0 U.L.	1.0 U.L.
Q_1–Q_4	Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q_1}$–$\overline{Q_4}$	Complimentary Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.

Notes:
a. 1 Unit Load (U.L.) = 40 μA HIGH
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

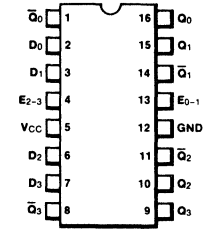
TRUTH TABLE
(Each latch)

t_n	t_{n+1}
D	Q
H	H
L	L

NOTES:
t_n = bit time before enable negative-going transition
t_{n+1} = bit time after enable negative-going transition

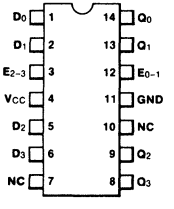
CONNECTION DIAGRAMS
DIP (TOP VIEW)

SN54LS/74LS75



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

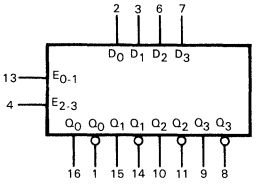
SN54LS/74LS77



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

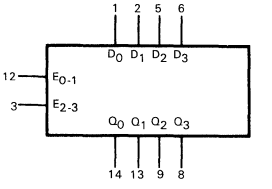
LOGIC SYMBOLS

SN54LS/74LS75



V_{CC} = Pin 5
GND = Pin 12

SN54LS/74LS77



V_{CC} = Pin 4
GND = Pin 11
NC = Pin 7,10

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	D Input E Input			20 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		D Input E Input			0.1 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	D Input E Input			−0.4 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				12	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Data to Q		15 9.0	27 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Data to $\overline{Q}$		12 7.0	20 15	ns	
t_{PLH} t_{PHL}	Propagation Delay, Enable to Q		15 14	27 25	ns	
t_{PLH} t_{PHL}	Propagation Delay, Enable to $\overline{Q}$		16 7.0	30 15	ns	

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DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

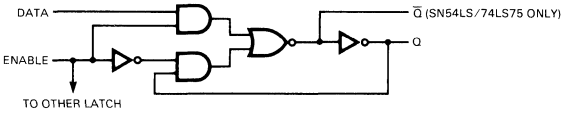
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	D Input E Input			20 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		D Input E Input			0.1 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	D Input E Input			−0.4 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				13	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Data to Q		11 9.0	19 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Enable to Q		10 10	18 18	ns	

LOGIC DIAGRAM



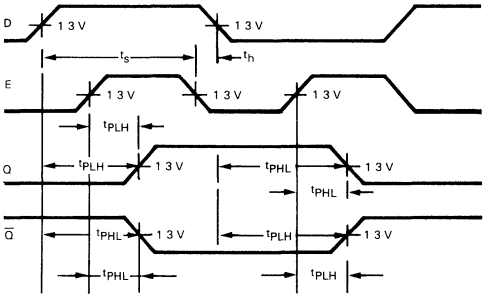
GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Enable Pulse Width High	20			ns	$V_{CC} = 5.0$ V
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

AC WAVE FORMS



DEFINITION OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from HIGH-to-LOW in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from HIGH-to-LOW that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from HIGH-to-LOW and still be recognized.

MOTOROLA

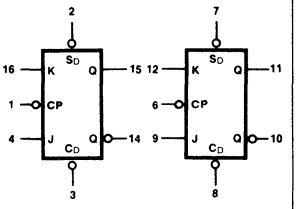
SN54LS76A
SN74LS76A

DUAL JK FLIP-FLOP WITH SET AND CLEAR

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS76A offers individual J, K, Clock Pulse, Direct Set and Direct Clear inputs. These dual flip-flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The Logic Level of the J and K inputs will perform according to the Truth Table as long as minimum set-up times are observed. Input data is transferred to the outputs on the HIGH-to-LOW clock transitions.

LOGIC SYMBOL



V_{CC} = Pin 5
GND = Pin 13

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

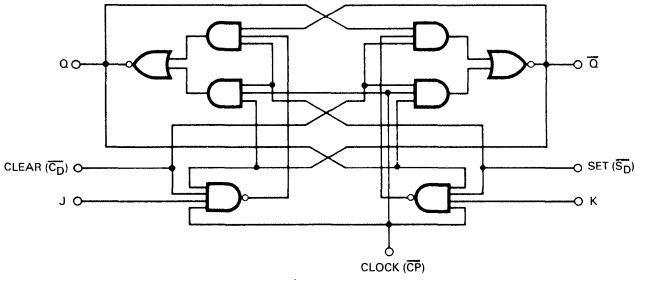
MODE SELECT — TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	J	K	Q	$\overline{Q}$
Set	L	H	X	X	H	L
Reset (Clear)	H	L	X	X	L	H
*Undetermined	L	L	X	X	H	H
Toggle	H	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	H	l	h	L	H
Load "1" (Set)	H	H	h	l	H	L
Hold	H	H	l	l	q	$\overline{q}$

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Immaterial
l,h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH-to-LOW clock transition.

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K Clear Clock			20 60 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		J, K Clear Clock			0.1 0.3 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	J, K Clear, Clock			−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	45		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH}	Clock, Clear, Set to Output		15	20	ns	
t_{PHL}			15	20	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width High	20			ns	V_{CC} = 5.0 V
t_W	Clear Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

SN54LS78A
SN74LS78A

DUAL JK FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS78A offers individual J, K, and Direct Set inputs as well as common Clock Pulse and Common Direct Clear Inputs. These dual Flip-Flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The Logic Level of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the Truth Table as long as minimum setup times are observed. Input data is transferred to the outputs on the HIGH-to-LOW Clock Transition.

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

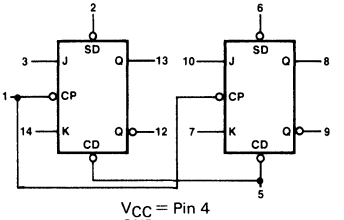
MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	J	K	Q	$\overline{Q}$
Set	L	H	X	X	H	L
Reset (Clear)	H	L	X	X	L	H
*Undetermined	L	L	X	X	H	H
Toggle	H	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	H	l	h	L	H
Load "1" (Set)	H	H	h	l	H	L
Hold	H	H	l	l	q	$\overline{q}$

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H, h = HIGH Voltage Level
L, l = LOW Voltage Level
X = Immaterial
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH-to-LOW clock transition.

LOGIC SYMBOL



V_{CC} = Pin 4
GND = Pin 11

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current J, K Clear Set Clock				 20 120 60 160	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	 J, K Clear Set Clock				 0.1 0.6 0.3 0.8	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current J, K Set Clock, Clear				 −0.4 −0.8 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX, V_{OUT} = 0 V
I_{CC}	Power Supply Current			4.0	6.0	mA	V_{CC} = MAX, V_{CP} = 0 V

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	45		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH}	Clear, Clock, Set to Output		15	20	ns	
t_{PHL}			15	20	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width High	20			ns	V_{CC} = 5.0 V
t_W	Clear Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

SN54LS83A
SN74LS83A

4-BIT BINARY FULL ADDER WITH FAST CARRY

LOW POWER SCHOTTKY

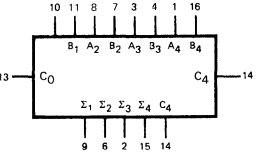
DESCRIPTION — The SN54LS/74LS83A is a high-speed 4-Bit Binary Full Adder with internal carry lookahead. It accepts two 4-bit binary words ($A_1 - A_4$, $B_1 - B_4$) and a Carry Input (C_0). It generates the binary Sum outputs ($\Sigma 1 - \Sigma 4$) and the Carry Output (C_4) from the most significant bit. The LS83A operates with either active HIGH or active LOW operands (positive or negative logic). The SN54LS/74LS283 is recommended for new designs since it is identical in function with this device and features standard corner power pins.

PIN NAMES

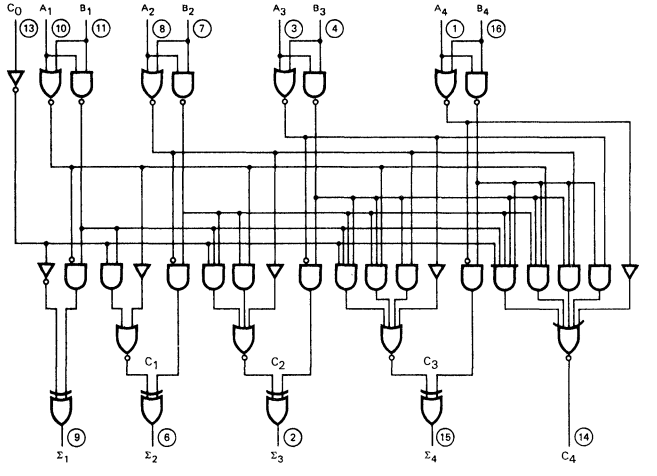
		LOADING (Note a) HIGH	LOW
$A_1 - A_4$	Operand A Inputs	1.0 U.L.	0.5 U.L.
$B_1 - B_4$	Operand B Inputs	1.0 U.L.	0.5 U.L.
C_0	Carry Input	0.5 U.L.	0.25 U.L.
$\Sigma 1 - \Sigma 4$	Sum Outputs (Note b)	10 U.L.	5(2.5) U.L.
C_4	Carry Output (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for commercial (74) Temperature Ranges.

LOGIC SYMBOL

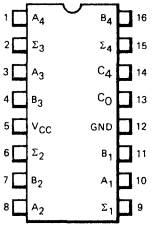


LOGIC DIAGRAM



VCC = Pin 5
GND = Pin 12
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE.
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS83A adds two 4-bit binary words (A plus B) plus the incoming carry. The binary sum appears on the sum outputs (Σ_1— Σ_4) and outgoing carry (C_4) outputs.

$$C_0 + (A_1+B_1)+2(A_2+B_2)+4(A_3+B_3)+8(A_4+B_4) = \Sigma_1+2\Sigma_2+4\Sigma_3+8\Sigma_4+16C_4$$

Where: (+) = plus

Due to the symmetry of the binary add function the LS83A can be used with either all inputs and outputs active HIGH (positive logic) or with all inputs and outputs active LOW (negative logic). Note that with active HIGH Inputs, Carry Input can not be left open, but must be held LOW when no carry in is intended.

Example:

	C_0	A_1	A_2	A_3	A_4	B_1	B_2	B_3	B_4	Σ_1	Σ_2	Σ_3	Σ_4	C_4	
Logic Levels	L	L	H	L	H	H	L	L	H	H	H	L	L	H	
Active HIGH	0	0	1	0	1	1	0	0	1	1	1	0	0	1	(10+9 = 19)
Active LOW	1	1	0	1	0	0	1	1	0	0	0	1	1	0	(carry+5+6 = 12)

Interchanging inputs of equal weight does not affect the operation, thus C_0, A_1, B_1, can be arbitrarily assigned to pins 10, 11, 13, etc.

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FUNCTIONAL TRUTH TABLE

$C_{(n-1)}$	A_n	B_n	Σ_n	C_n
L	L	L	L	L
L	L	H	H	L
L	H	L	H	L
L	H	H	L	H
H	L	L	H	L
H	L	H	L	H
H	H	L	L	H
H	H	H	H	H

C_1 — C_3 are generated internally
C_0 — is an external input
C_4 — is an output generated internally

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current C_0 A or B				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	C_0 A or B				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current C_0 A or B				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current All Inputs Grounded All Inputs at 4.5 V, Except B All Inputs at 4.5 V				39 34 34	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, C_0 Input to any Σ Output		16 15	24 24	ns	V_{CC} = 5.0 V C_L = 15 pF Figures 1 and 2
t_{PLH} t_{PHL}	Propagation Delay, Any A or B Input to Σ Outputs		15 15	24 24	ns	
t_{PLH} t_{PHL}	Propagation Delay, C_0 Input to C_4 Output		11 15	17 22	ns	
t_{PLH} t_{PHL}	Propagation Delay, Any A or B Input to C_4 Output		11 12	17 17	ns	

AC WAVEFORMS

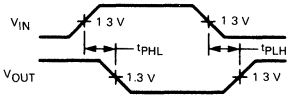


Fig. 1

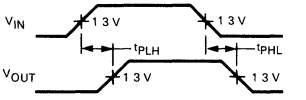


Fig. 2

MOTOROLA

SN54LS85
SN74LS85

4-BIT MAGNITUDE COMPARATOR

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS85 is a 4-Bit Magnitude Comparator which compares two 4-bit words (A, B), each word having four Parallel Inputs (A_0-A_3, B_0-B_3); A_3, B_3 being the most significant inputs. Operation is not restricted to binary codes, the device will work with any monotonic code. Three Outputs are provided: "A greater than B" ($O_{A>B}$), "A less than B" ($O_{A<B}$), "A equal to B" ($O_{A=B}$). Three Expander Inputs, $I_{A>B}$, $I_{A<B}$, $I_{A=B}$, allow cascading without external gates. For proper compare operation, the Expander Inputs to the least significant position must be connected as follows: $I_{A<B} = I_{A>B} = L$, $I_{A=B} = H$. For serial (ripple) expansion, the $O_{A>B}$, $O_{A<B}$ and $O_{A=B}$ Outputs are connected respectively to the $I_{A>B}$, $I_{A<B}$, and $I_{A=B}$ inputs of the next most significant comparator, as shown in Figure 1. Refer to Applications section of data sheet for high speed method of comparing large words.

The Truth Table on the following page describes the operation of the SN54LS/74LS85 under all possible logic conditions. The upper 11 lines describe the normal operation under all conditions that will occur in a single device or in a series expansion scheme. The lower five lines describe the operation under abnormal conditions on the cascading inputs. These conditions occur when the parallel expansion technique is used.

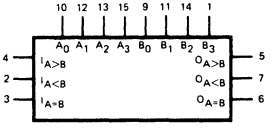
- **EASILY EXPANDABLE**
- **BINARY OR BCD COMPARISON**
- **$O_{A>B}$, $O_{A<B}$, AND $O_{A=B}$ OUTPUTS AVAILABLE**

PIN NAMES

		LOADING (Note a) HIGH	LOW
A_0-A_3, B_0-B_3	Parallel Inputs	1.5 U.L.	0.75 U.L.
$I_{A=B}$	A =B Expander Inputs	1.5 U.L.	0.75 U.L.
$I_{A<B}$, $I_{A>B}$	A < B, A > B, Expander Inputs	0.5 U.L.	0.25 U.L.
$O_{A>B}$	A Greater Than B Output (Note b)	10 U.L.	5 (2.5) U.L.
$O_{A<B}$	B Greater Than A Output (Note b)	10 U.L.	5 (2.5) U.L.
$O_{A=B}$	A Equal to B Output (Note b)	10 U.L.	5 (2.5) U.L.

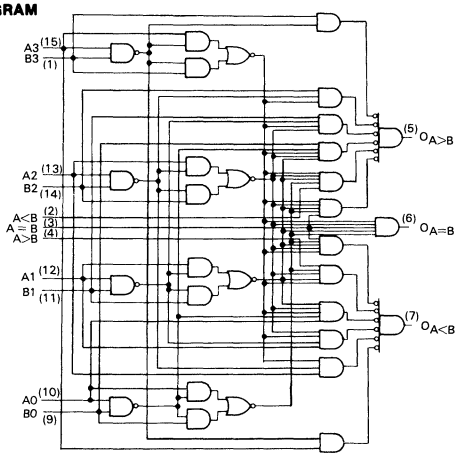
Notes:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL

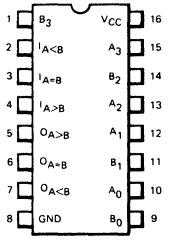


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

TRUTH TABLE

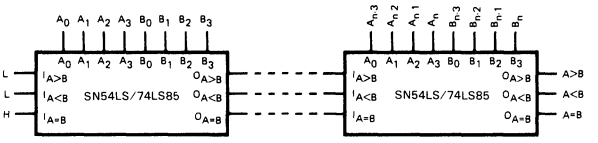
COMPARING INPUTS				CASCADING INPUTS			OUTPUTS		
A_3,B_3	A_2,B_2	A_1,B_1	A_0,B_0	$I_{A>B}$	$I_{A<B}$	$I_{A=B}$	$O_{A>B}$	$O_{A<B}$	$O_{A=B}$
$A_3>B_3$	X	X	X	X	X	X	H	L	L
$A_3<B_3$	X	X	X	X	X	X	L	H	L
$A_3=B_3$	$A_2>B_2$	X	X	X	X	X	H	L	L
$A_3=B_3$	$A_2<B_2$	X	X	X	X	X	L	H	L
$A_3=B_3$	$A_2=B_2$	$A_1>B_1$	X	X	X	X	H	L	L
$A_3=B_3$	$A_2=B_2$	$A_1<B_1$	X	X	X	X	L	H	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0>B_0$	X	X	X	H	L	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0<B_0$	X	X	X	L	H	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0=B_0$	H	L	L	H	L	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0=B_0$	L	H	L	L	H	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0=B_0$	X	X	H	L	L	H
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0=B_0$	H	H	L	L	L	L
$A_3=B_3$	$A_2=B_2$	$A_1=B_1$	$A_0=B_0$	L	L	L	H	H	L

H = HIGH Level
L = LOW Level
X = IMMATERIAL

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA



L = LOW Level
H = HIGH Level

Fig. 1. COMPARING TWO n-BIT WORDS

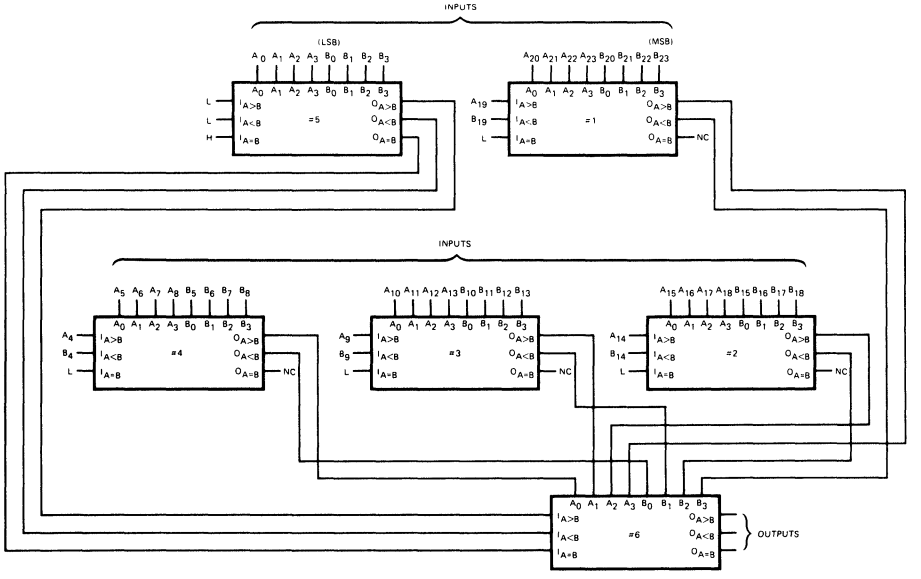
APPLICATIONS

Figure 2 shows a high speed method of comparing two 24-bit words with only two levels of device delay. With the technique shown in Figure 1, six levels of device delay result when comparing two 24-bit words. The parallel technique can be expanded to any number of bits, see Table I.

TABLE I

WORD LENGTH	NUMBER OF PKGS.
1-4 Bits	1
5-24 Bits	2 - 6
25-120 Bits	8 - 31

NOTE:
The SN54LS/74LS85 can be used as a 5-bit comparator only when the outputs are used to drive the A_0-A_3 and B_0-B_3 inputs of another SN54LS/74LS85 as shown in Figure 2 in positions #1, 2, 3, and 4



MSB = Most Significant Bit
LSB = Least Significant Bit

L = LOW Level
H = HIGH Level
NC = No Connection

Fig. 2. COMPARISON OF TWO 24-BIT WORDS

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current A<B, A>B				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	Other Inputs				60			
	A<B, A>B				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
	Other Inputs				0.3			
I_{IL}	Input LOW Current A<B, A>B				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
	Other Inputs				−1.2			
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				20	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Any A or B to A < B, A > B		24 20	36 30	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Any A or B to A = B		27 23	45 45	ns	
t_{PLH} t_{PHL}	A < B or A = B to A > B		14 11	22 17	ns	
t_{PLH} t_{PHL}	A = B to A = B		13 13	20 26	ns	
t_{PLH} t_{PHL}	A > B or A = B to A < B		14 11	22 17	ns	

AC WAVEFORMS

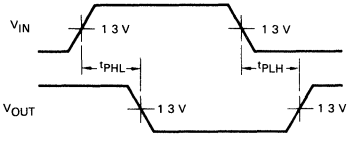


Fig. 3

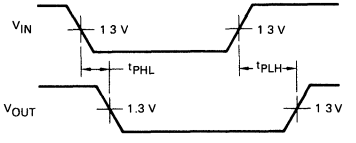
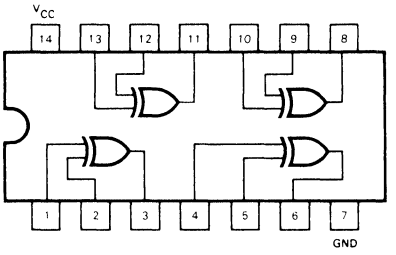


Fig. 4

MOTOROLA

SN54LS86
SN74LS86

QUAD 2-INPUT EXCLUSIVE OR GATE
LOW POWER SCHOTTKY



TRUTH TABLE

IN		OUT
A	B	Z
L	L	L
L	H	H
H	L	H
H	H	L

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Other Input LOW		12 10	23 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Other Input HIGH		20 13	30 22	ns	

MOTOROLA

SN54LS/74LS90
SN54LS/74LS92
SN54LS/74LS93

DECADE COUNTER; DIVIDE-BY-TWELVE COUNTER; 4-BIT BINARY COUNTER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS90, SN54LS/74LS92 and SN54LS/74LS93 are high-speed 4-bit ripple type counters partitioned into two sections. Each counter has a divide-by-two section and either a divide-by-five (LS90), divide-by-six (LS92) or divide-by-eight (LS93) section which are triggerd by a HIGH-to-LOW transition on the clock inputs. Each section can be used separately or tied together (Q to $\overline{CP}$) to form BCD, bi-quinary, modulo-12, or modulo-16 counters. All of the counters have a 2-input gated Master Reset (Clear), and the LS90 also has a 2-input gated Master Set (Preset 9).

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

- **LOW POWER CONSUMPTION . . . TYPICALLY 45 mW**
- **HIGH COUNT RATES . . . TYPICALLY 42 MHz**
- **CHOICE OF COUNTING MODES . . . BCD, BI-QUINARY, DIVIDE-BY-TWELVE, BINARY**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

4

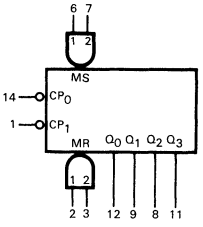
PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{CP}_0$	Clock (Active LOW going edge) Input to ÷2 Section	0.5 U.L.	1.5 U.L.
$\overline{CP}_1$	Clock (Active LOW going edge) Input to ÷5 Section (LS90), ÷6 Section (LS92)	0.5 U.L.	2.0 U.L.
$\overline{CP}_1$	Clock (Active LOW going edge) Input to ÷8 Section (LS93)	0.5 U.L.	1.0 U.L.
MR_1, MR_2	Master Reset (Clear) Inputs	0.5 U.L.	0.25 U.L.
MS_1, MS_2	Master Set (Preset-9, LS90) Inputs	0.5 U.L.	0.25 U.L.
Q_0	Output from ÷2 Section (Notes b & c)	10 U.L.	5(2.5) U.L.
Q_1, Q_2, Q_3	Outputs from ÷5 (LS90), ÷6 (LS92), ÷8 (LS93) Sections (Note b)	10 U.L.	5(2.5) U.L.

Notes:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military, (54) and 5 U.L. for commercial (74) Temperature Ranges.
c. The Q_0 Outputs are guaranteed to drive the full fan-out plus the $\overline{CP}_1$ input of the device.
d. To insure proper operation the rise (t_r) and fall time (t_f) of the clock must be less than 100 ns.

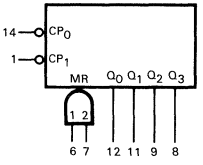
LOGIC SYMBOL

LS90



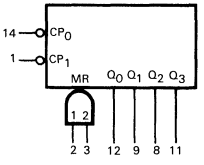
V_{CC} = Pin 5
GND = Pin 10
NC = Pins 4, 13

LS92



V_{CC} = Pin 5
GND = Pin 10
NC = Pins 2, 3, 4, 13

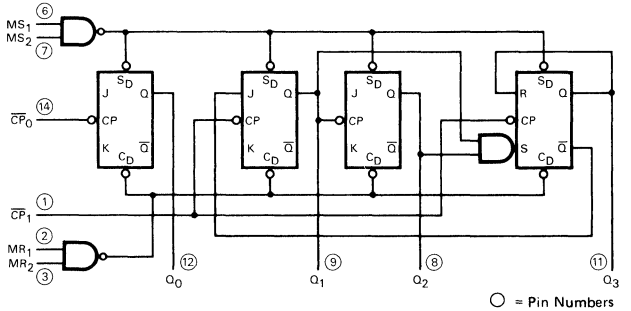
LS93



V_{CC} = Pin 5
GND = Pin 10
NC = Pins 4, 6, 7, 13

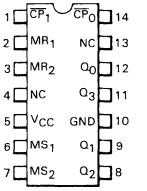
LOGIC DIAGRAM

LS90



○ = Pin Numbers
V_{CC} = Pin 5
GND = Pin 10

CONNECTION DIAGRAM
DIP (TOP VIEW)

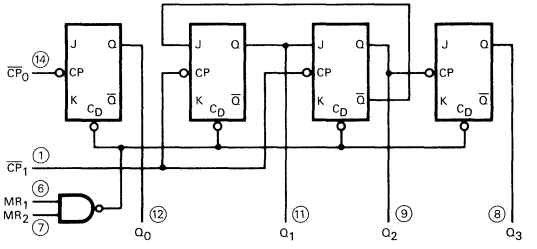


NC = No Internal Connection

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

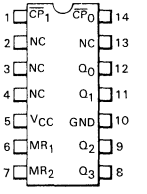
LOGIC DIAGRAM

LS92



○ = Pin Numbers
V_{CC} = Pin 5
GND = Pin 10

CONNECTION DIAGRAM
DIP (TOP VIEW)

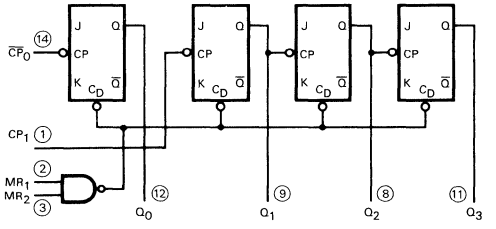


NC = No Internal Connection

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

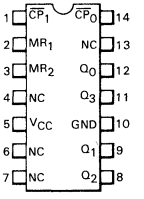
LOGIC DIAGRAM

LS93



○ = Pin Numbers
V_{CC} = Pin 5
GND = Pin 10

CONNECTION DIAGRAM
DIP (TOP VIEW)



NC = No Internal Connection

NOTE.
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The LS90, LS92, and LS93 are 4-bit ripple type Decade, Divide-By-Twelve, and Binary Counters respectively. Each device consists of four master/slave flip-flops which are internally connected to provide a divide-by-two section and a divide-by-five (LS90), divide-by-six (LS92), or divide-by-eight (LS93) section. Each section has a separate clock input which initiates state changes of the counter on the HIGH-to-LOW clock transition. State changes of the Q outputs do not occur simultaneously because of internal ripple delays. Therefore, decoded output signals are subject to decoding spikes and should not be used for clocks or strobes. The Q_0 output of each device is designed and specified to drive the rated fan-out plus the $\overline{CP}_1$ input of the device.

A gated AND asynchronous Master Reset ($MR_1 \bullet MR_2$) is provided on all counters which overrides and clocks and resets (clears) all the flip-flops. A gated AND asynchronous Master Set ($MS_1 \bullet MS_2$) is provided on the LS90 which overrides the clocks and the MR inputs and sets the outputs to nine (HLLH).

Since the output from the divide-by-two section is not internally connected to the succeeding stages, the devices may be operated in various counting modes.

LS90

A. BCD Decade (8421) Counter — The $\overline{CP}_1$ input must be externally connected to the Q_0 output. The $\overline{CP}_0$ input receives the incoming count and a BCD count sequence is produced.

B. Symmetrical Bi-quinary Divide-By-Ten Counter — The Q_3 output must be externally connected to the $\overline{CP}_0$ input. The input count is then applied to the $\overline{CP}_1$ input and a divide-by-ten square wave is obtained at output Q_0.

C. Divide-By-Two and Divide-By-Five Counter — No external interconnections are required. The first flip-flop is used as a binary element for the divide-by-two function ($\overline{CP}_0$ as the input and Q_0 as the output). The $\overline{CP}_1$ input is used to obtain binary divide-by-five operation at the Q_3 output.

LS92

A. Modulo 12, Divide-By-Twelve Counter — The $\overline{CP}_1$ input must be externally connected to the Q_0 output. The $\overline{CP}_0$ input receives the incoming count and Q_3 produces a symmetrical divide-by-twelve square wave output.

B. Divide-By-Two and Divide-By-Six Counter — No external interconnections are required. The first flip-flop is used as a binary element for the divide-by-two function. The $\overline{CP}_1$ input is used to obtain divide-by-three operation at the Q_1 and Q_2 outputs and divide-by-six operation at the Q_3 output.

LS93

A. 4-Bit Ripple Counter — The output Q_0 must be externally connected to input $\overline{CP}_1$. The input count pulses are applied to input $\overline{CP}_0$. Simultaneous divisions of 2, 4, 8, and 16 are performed at the Q_0, Q_1, Q_2, and Q_3 outputs as shown in the truth table.

B. 3-Bit Ripple Counter — The input count pulses are applied to input $\overline{CP}_1$. Simultaneous frequency divisions of 2, 4, and 8 are available at the Q_1, Q_2, and Q_3 outputs. Independent use of the first flip-flop is available if the reset function coincides with reset of the 3-bit ripple-through counter.

LS90
MODE SELECTION

RESET/SET INPUTS				OUTPUTS			
MR_1	MR_2	MS_1	MS_2	Q_0	Q_1	Q_2	Q_3
H	H	L	X	L	L	L	L
H	H	X	L	L	L	L	L
X	X	H	H	H	L	L	H
L	X	L	X	Count			
X	L	X	L	Count			
L	X	X	L	Count			
X	L	L	X	Count			

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

LS92 AND LS93
MODE SELECTION

RESET INPUTS		OUTPUTS			
MR_1	MR_2	Q_0	Q_1	Q_2	Q_3
H	H	L	L	L	L
L	H	Count			
H	L	Count			
L	L	Count			

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

LS90
BCD COUNT SEQUENCE

COUNT	OUTPUT			
	Q_0	Q_1	Q_2	Q_3
0	L	L	L	L
1	H	L	L	L
2	L	H	L	L
3	H	H	L	L
4	L	L	H	L
5	H	L	H	L
6	L	H	H	L
7	H	H	H	L
8	L	L	L	H
9	H	L	L	H

NOTE: Output Q_0 is connected to Input $\overline{CP}_1$ for BCD count.

LS92
TRUTH TABLE

COUNT	OUTPUT			
	Q_0	Q_1	Q_2	Q_3
0	L	L	L	L
1	H	L	L	L
2	L	H	L	L
3	H	H	L	L
4	L	L	H	L
5	H	L	H	L
6	L	L	L	H
7	H	L	L	H
8	L	H	L	H
9	H	H	L	H
10	L	L	H	H
11	H	L	H	H

Note: Output Q_0 connected to input $\overline{CP}_1$.

LS93
TRUTH TABLE

COUNT	OUTPUT			
	Q_0	Q_1	Q_2	Q_3
0	L	L	L	L
1	H	L	L	L
2	L	H	L	L
3	H	H	L	L
4	L	L	H	L
5	H	L	H	L
6	L	H	H	L
7	H	H	H	L
8	L	L	L	H
9	H	L	L	H
10	L	H	L	H
11	H	H	L	H
12	L	L	H	H
13	H	L	H	H
14	L	H	H	H
15	H	H	H	H

Note: Output Q_0 connected to input $\overline{CP}_1$.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current MS, MR $\overline{CP}_0$ $\overline{CP}_1$ (LS90, LS92) $\overline{CP}_1$ (LS93)				−0.4 −2.4 −3.2 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				15	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V, $C_L = 15$ pF

SYMBOL	PARAMETER	LIMITS									UNITS
		LS90			LS92			LS93			
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
f_{MAX}	$\overline{CP}_0$ Input Clock Frequency	32			32			32			MHz
f_{MAX}	$\overline{CP}_1$ Input Clock Frequency	16			16			16			MHz
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}_0$ Input to Q_0 Output		10 12	16 18		10 12	16 18		10 12	16 18	ns
t_{PLH} t_{PHL}	$\overline{CP}_0$ Input to Q_3 Output		32 34	48 50		32 34	48 50		46 46	70 70	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_1 Output		10 14	16 21		10 14	16 21		10 14	16 21	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_2 Output		21 23	32 35		10 14	16 21		21 23	32 35	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_3 Output		21 23	32 35		21 23	32 35		34 34	51 51	ns
t_{PLH}	MS Input to Q_0 and Q_3 Outputs		20	30							ns
t_{PHL}	MS Input to Q_1 and Q_2 Outputs		26	40							ns
t_{PHL}	MR Input to Any Output		26	40		26	40		26	40	ns

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS						UNITS
		LS90		LS92		LS93		
		MIN	MAX	MIN	MAX	MIN	MAX	
t_W	$\overline{CP}_0$ Pulse Width	15		15		15		ns
t_W	$\overline{CP}_1$ Pulse Width	30		30		30		ns
t_W	MS Pulse Width	15						ns
t_W	MR Pulse Width	15		15		15		ns
t_{rec}	Recovery Time MR to $\overline{CP}$	25		25		25		ns

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from HIGH-to-LOW in order to recognize and transfer HIGH data to the Q outputs.

AC WAVE FORMS

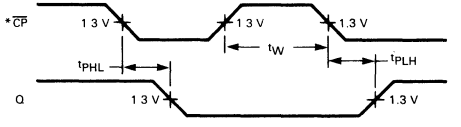


Fig. 1

*The number of Clock Pulses required between the t_{PHL} and t_{PLH} measurements can be determined from the appropriate Truth Tables.

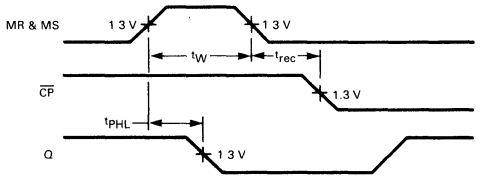


Fig. 2

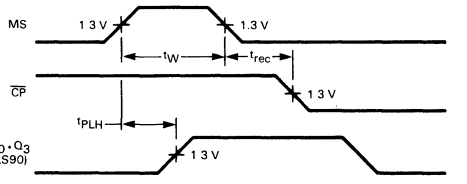


Fig. 3

MOTOROLA

SN54LS91
SN74LS91

8-BIT SHIFT REGISTERS

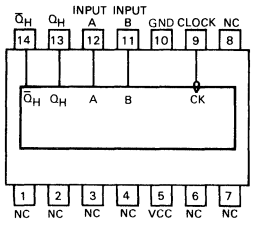
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS91 is an 8-Bit Serial-In/Serial Out Shift Register. This device features eight R-S master-slave flip-flops, input gating and a clock driver. By gating single-rail data and input control thru inputs A, B, and an internal inverter, complementary inputs to the first bit of the shift register are formed. An inverting clock driver provides the drive for the internal common clock line. The clock pulse inverter driver causes this circuitry to shift information one-bit on the positive edge of the input clock pulse.

FUNCTION TABLE

INPUTS AT t_n		OUTPUTS AT t_{n+8}	
A	B	Q_H	$\overline{Q}_H$
H	H	H	L
L	X	L	H
X	L	L	H

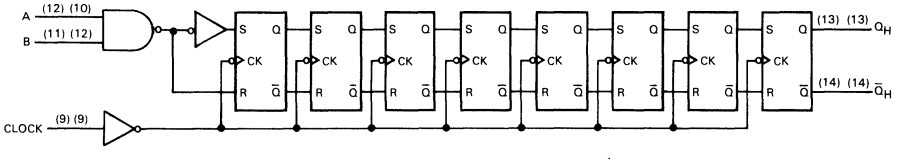
H = HIGH, L = LOW
X = Irrelevant
t_n = Reference bit time
t_{n+8} = Bit time after 8 LOW to High Clock transition



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

FUNCTIONAL BLOCK DIAGRAM

(DUAL-IN-LINE) (FLAT PACKAGE)



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				20	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	10	18		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay LOW to HIGH Propagation Delay HIGH to LOW		24 27	40 40	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width Low	25			ns	V_{CC} = 5.0 V
t_s	Setup Time	25			ns	
t_h	Hold Time	0			ns	

4

MOTOROLA

SN54LS95B
SN74LS95B

4-BIT SHIFT REGISTER

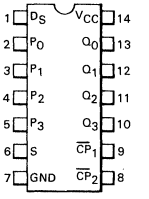
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS95B is a 4-Bit Shift Register with serial and parallel synchronous operating modes. The serial shift right and parallel load are activated by separate clock inputs which are selected by a mode control input. The data is transferred from the serial or parallel D inputs to the Q outputs synchronous with the HIGH to LOW transition of the appropriate clock input.

The LS95B is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **SYNCHRONOUS, EXPANDABLE SHIFT RIGHT**
- **SYNCHRONOUS SHIFT LEFT CAPABILITY**
- **SYNCHRONOUS PARALLEL LOAD**
- **SEPARATE SHIFT AND LOAD CLOCK INPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

CONNECTION DIAGRAM
DIP (TOP VIEW)



V_{CC} = Pin 14
GND = Pin 7

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

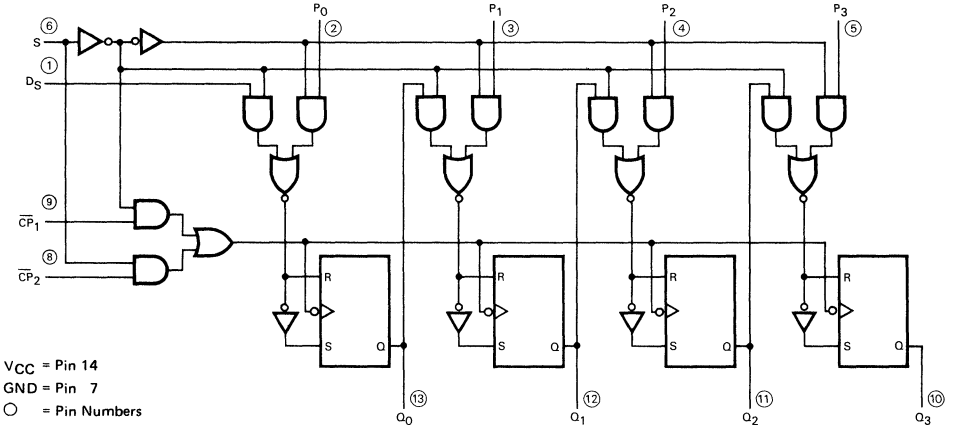
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

PIN NAMES

		LOADING (Note a) HIGH	LOW
S	Mode Control Input	0.5 U.L.	0.25 U.L.
D_S	Serial Data Input	0.5 U.L.	0.25 U.L.
$P_0 - P_3$	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
$\overline{CP}_1$	Serial Clock (Active LOW Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{CP}_2$	Parallel Clock (Active LOW Going Edge) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_3$	Parallel Outputs (Note b)	10 U.L.	5(2.5)U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM



V_{CC} = Pin 14
GND = Pin 7
○ = Pin Numbers

FUNCTIONAL DESCRIPTION — The LS95B is a 4-Bit Shift Register with serial and parallel synchronous operating modes. It has a Serial (D_S) and four Parallel (P_0 — P_3) Data inputs and four Parallel Data outputs (Q_0 — Q_3). The serial or parallel mode of operation is controlled by a Mode Control input (S) and two Clock Inputs ($\overline{CP}_1$) and ($\overline{CP}_2$). The serial (right-shift) or parallel data transfers occur synchronous with the HIGH to LOW transition of the selected clock input.

When the Mode Control input (S) is HIGH, $\overline{CP}_2$ is enabled. A HIGH to LOW transition on enabled $\overline{CP}_2$ transfers parallel data from the P_0 — P_3 inputs to the Q_0 — Q_3 outputs.

When the Mode Control input (S) is LOW, $\overline{CP}_1$ is enabled. A HIGH to LOW transition on enabled $\overline{CP}_1$ transfers the data from Serial input (D_S) to Q_0 and shifts the data in Q_0 to Q_1, Q_1 to Q_2, and Q_2 to Q_3 respectively (right-shift). A left-shift is accomplished by externally connecting Q_3 to P_2, Q_2 to P_1, and Q_1 to P_0, and operating the LS95B in the parallel mode (S = HIGH).

For normal operation, S should only change states when both Clock inputs are LOW. However, changing S from LOW to HIGH while $\overline{CP}_2$ is HIGH, or changing S from HIGH to LOW while $\overline{CP}_1$ is HIGH and $\overline{CP}_2$ is LOW will not cause any changes on the register outputs.

MODE SELECT — TRUTH TABLE

OPERATING MODE	INPUTS					OUTPUTS			
	S	$\overline{CP}_1$	$\overline{CP}_2$	D_S	P_n	Q_0	Q_1	Q_2	Q_3
Shift	L	↓	X	l	X	L	q_0	q_1	q_2
	L	↓	X	h	X	H	q_0	q_1	q_2
Parallel Load	H	X	↓	X	P_n	P_0	P_1	P_2	P_3
Mode Change	↓	L	L	X	X	No Change			
	↑	L	L	X	X	No Change			
	↓	H	L	X	X	No Change			
	↑	H	L	X	X	Undetermined			
	↓	L	H	X	X	Undetermined			
	↑	L	H	X	X	No Change			
	↓	H	H	X	X	Undetermined			
	↑	H	H	X	X	No Change			

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
l = LOW Voltage Level one set-up time prior to the HIGH to LOW clock transition.
h = HIGH Voltage Level one set-up time prior to the HIGH to LOW clock transition.
p_n = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				21	mA	V_{CC} = MAX

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	36		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	$\overline{CP}$ to Output		18 21	27 32	ns ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	$\overline{CP}$ Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	20			ns	
t_s	Mode Control Setup Time	20			ns	
t_h	Mode Control Hold Time	20			ns	

DESCRIPTIONS OF TERMS:

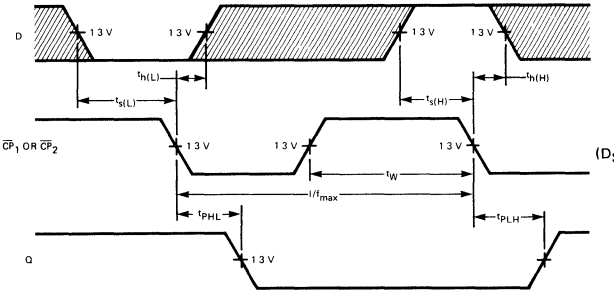
SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from HIGH to LOW in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from HIGH to LOW that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from HIGH to LOW and still be recognized.

4

AC WAVEFORMS

The shaded areas indicate when the input is permitted to change for predictable output performance.



*The Data Input is (D_S for $\overline{CP}_1$) or (P_n for $\overline{CP}_2$).

Fig. 1

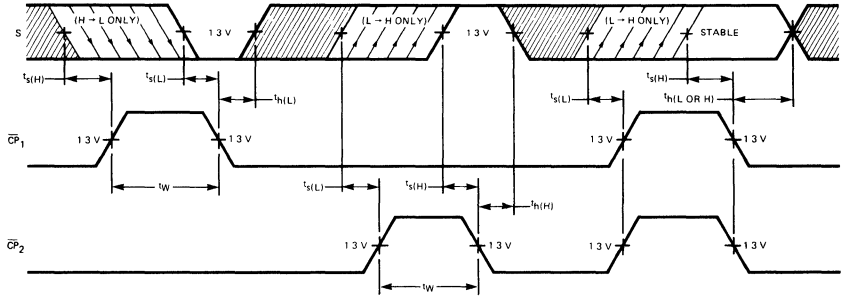


Fig. 2

MOTOROLA

SN54LS107A
SN74LS107A

DESCRIPTION — The SN54LS/74LS107A is a Dual JK Flip-Flop with individual J, K, Direct Clear and Clock Pulse inputs. Output changes are initiated by the HIGH-to-LOW transition of the clock. A LOW signal on CD input overrides the other inputs and makes the Q output LOW.

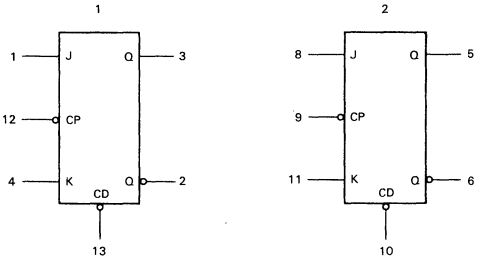
The SN54LS/74LS107A is the same as the SN54LS/74LS73A but has corner power pins.

DUAL JK FLIP-FLOP

LOW POWER SCHOTTKY

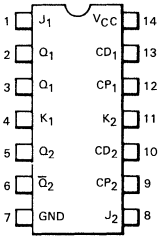
4

LOGIC SYMBOL



V_{CC} = 14
GND = 7

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K Clear Clock			20 60 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		J, K Clear Clock			0.1 0.3 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	J, K Clear and Clock			−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	45		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH}	Propagation Delay,		15	20	ns	
t_{PHL}	Clock to Output		15	20	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width	20			ns	V_{CC} = 5.0 V
t_W	Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

4

MOTOROLA

SN54LS109A
SN74LS109A

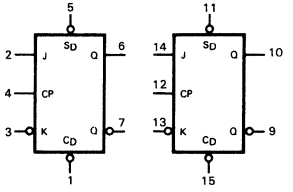
DUAL JK POSITIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS109A consists of two high speed completely independent transition clocked $J\overline{K}$ flip-flops. The clocking operation is independent of rise and fall times of the clock waveform. The $J\overline{K}$ design allows operation as a D flip-flop by simply connecting the J and $\overline{K}$ pins together.

4

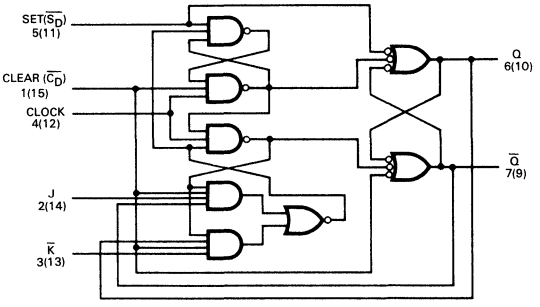
LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LOGIC DIAGRAM



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current J, $\overline{K}$, Clock Set, Clear				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	J, $\overline{K}$, Clock Set, Clear				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current J, $\overline{K}$, Clock Set, Clear				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				8.0	mA	V_{CC} = MAX

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	J	$\overline{K}$	Q	$\overline{Q}$
Set	L	H	X	X	H	L
Reset (Clear)	H	L	X	X	L	H
*Undetermined	L	L	X	X	H	H
Load "1" (Set)	H	H	h	h	H	L
Hold	H	H	l	h	q	$\overline{q}$
Toggle	H	H	h	l	$\overline{q}$	q
Load "0" (Reset)	H	H	l	l	L	H

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the LOW to HIGH clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	33		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH}	Clock, Clear, Set to Output		13	25	ns	
t_{PHL}			25	40	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock High Clear, Set Pulse Width	25			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time — HIGH	35			ns	
	LOW	25			ns	
t_h	Hold Time	5.0			ns	

MOTOROLA

SN54LS112A
SN74LS112A

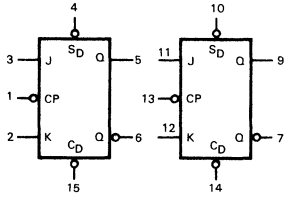
DUAL JK NEGATIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS112A dual JK flip-flop features individual J, K, clock, and asynchronous set and clear inputs to each flip-flop. When the clock goes HIGH, the inputs are enabled and data will be accepted. The logic level of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the truth table as long as minimum set-up and hold time are observed. Input data is transferred to the outputs on the negative-going edge of the clock pulse.

4

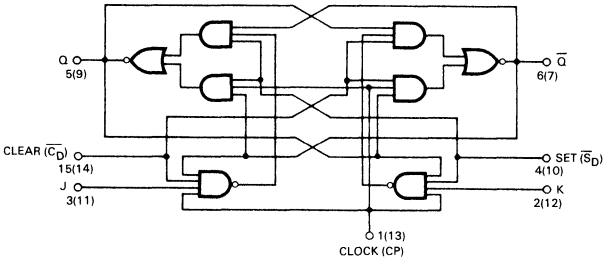
LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LOGIC DIAGRAM (EACH FLIP-FLOP)



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		Set, Clear			60		
		Clock			80		
		J, K			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		Set, Clear			0.3		
		Clock			0.4		
I_{IL}	Input LOW Current	J, K			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Clear, Set, Clk			−0.8		
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	J	K	Q	$\overline{Q}$
Set	L	H	X	X	H	L
Reset (Clear)	H	L	X	X	L	H
*Undetermined	L	L	X	X	H	H
Toggle	H	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	H	l	h	L	H
Load "1" (Set)	H	H	h	l	H	L
Hold	H	H	l	l	q	$\overline{q}$

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	30	45		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH}	Propagation Delay, Clock		15	20	ns	
t_{PHL}	Clear, Set to Output		15	20	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width High	20			ns	$V_{CC} = 5.0$ V
t_W	Clear, Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

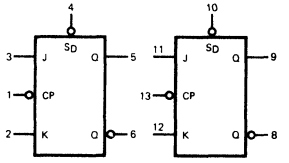
SN54LS113A
SN74LS113A

DUAL JK NEGATIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS113A offers individual J, K, set, and clock inputs. These monolithic dual flip-flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The logic level of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the truth table as long as minimum setup times are observed. Input data is transferred to the outputs on the negative-going edge of the clock pulse.

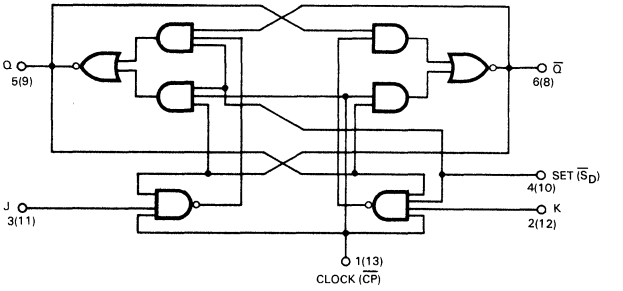
LOGIC SYMBOL



V_{CC} = Pin 14
GND = Pin 7

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

LOGIC DIAGRAM
(EACH FLIP-FLOP)



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		Set			60		
		Clock			80		
		J, K			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		Set			0.3		
		Clock			0.4		
I_{IL}	Input LOW Current	J, K			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Set, Clock			−0.8		
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS			OUTPUTS	
	$\overline{S}_D$	J	K	Q	$\overline{Q}$
Set	L	X	X	H	L
Toggle	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	l	h	L	H
Load "1" (Set)	H	h	l	H	L
Hold	H	l	l	q	$\overline{q}$

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	30	45		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH}	Propagation Delay, Clock		15	20	ns	
t_{PHL}	Set to Output		15	20	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width High	20			ns	$V_{CC} = 5.0$ V
t_W	Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

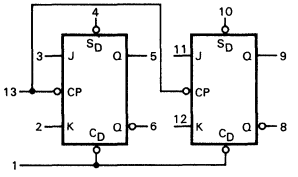
SN54LS114A
SN74LS114A

DUAL JK NEGATIVE EDGE-TRIGGERED FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS114A offers common clock and common clear inputs and individual J, K, and set inputs. These monolithic dual flip-flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The logic level of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the truth table as long as minimum set-up times are observed. Input data is transferred to the outputs on the negative-going edge of the clock pulse.

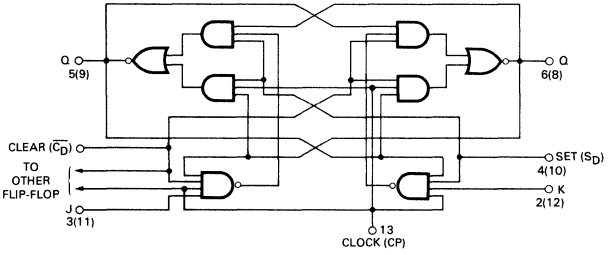
LOGIC SYMBOL



V_{CC} = Pin 14
GND = Pin 7

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

LOGIC DIAGRAM
(EACH FLIP-FLOP)



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	J, K Set Clear Clock			20 60 120 160	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		J, K Set Clear Clock			0.1 0.3 0.6 0.8	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	J, K Set Clear, Clock			−0.4 −0.8 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				6.0	mA	V_{CC} = MAX

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS	
	$\overline{S}_D$	$\overline{C}_D$	J	K	Q	$\overline{Q}$
Set	L	H	X	X	H	L
Reset (Clear)	H	L	X	X	L	H
*Undetermined	L	L	X	X	H	H
Toggle	H	H	h	h	$\overline{q}$	q
Load "0" (Reset)	H	H	l	h	L	H
Load "1" (Set)	H	H	h	l	H	L
Hold	H	H	l	l	q	$\overline{q}$

*Both outputs will be HIGH while both $\overline{S}_D$ and $\overline{C}_D$ are LOW, but the output states are unpredictable if $\overline{S}_D$ and $\overline{C}_D$ go HIGH simultaneously.

H,h = HIGH Voltage Level
L,l = LOW Voltage Level
X = Don't Care
l, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	30	45		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH}	Propagation Delay, Clock,		15	20	ns	
t_{PHL}	Clear, Set to Output		15	20	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width High	20			ns	$V_{CC} = 5.0$ V
t_W	Clear, Set Pulse Width	25			ns	
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

SN54LS/74LS122
SN54LS/74LS123

RETRIGGERABLE MONOSTABLE MULTIVIBRATORS

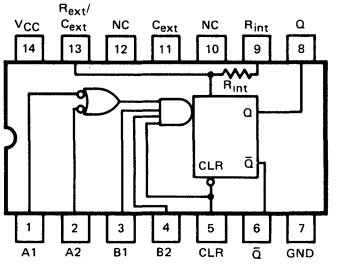
LOW POWER SCHOTTKY

DESCRIPTION — These d-c triggered multivibrators feature pulse width control by three methods. The basic pulse width is programmed by selection of external resistance and capacitance values. The LS122 has an internal timing resistor that allows the circuits to be used with only an external capacitor. Once triggered, the basic pulse width may be extended by retriggering the gated low-level-active (A) or high-level-active (B) inputs, or be reduced by use of the overriding clear.

The LS122 and LS123 have Schmitt trigger inputs to ensure jitter-free triggering from the B input with transition rates as slow as 0.1 millivolt per nanosecond.

- **OVERRIDING CLEAR TERMINATES OUTPUT PULSE**
- **COMPENSATED FOR V_{CC} AND TEMPERATURE VARIATIONS**
- **D-C TRIGGERED FROM ACTIVE-HIGH OR ACTIVE-LOW GATED LOGIC INPUTS**
- **RETRIGGERABLE FOR VERY LONG OUTPUT PULSES, UP TO 100% DUTY CYCLE**
- **INTERNAL TIMING RESISTORS ON LS122**

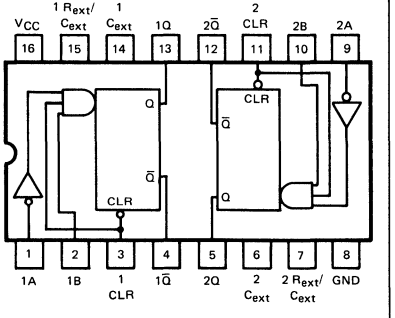
SN54LS/74LS122
(TOP VIEW) (SEE NOTES 1 THRU 4)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NC — NO internal connection

SN54LS/74LS123
(TOP VIEW) (SEE NOTES 1 THRU 4)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LS122
FUNCTIONAL TABLE

INPUTS					OUTPUTS	
CLEAR	A1	A2	B1	B2	Q	Q̄
L	X	X	X	X	L	H
X	H	H	X	X	L	H
X	X	X	L	X	L	H
X	X	X	X	L	L	H
H	L	X	↑	H	⎍	⎎
H	L	X	H	↑	⎍	⎎
H	X	L	↑	H	⎍	⎎
H	X	L	H	↑	⎍	⎎
H	H	↓	H	H	⎍	⎎
H	↓	↓	H	H	⎍	⎎
H	↓	H	H	H	⎍	⎎
↑	L	X	H	H	⎍	⎎
↑	X	L	H	H	⎍	⎎

LS123
FUNCTIONAL TABLE

INPUTS			OUTPUTS	
CLEAR	A	B	Q	Q̄
L	X	X	L	H
X	H	X	L	H
X	X	L	L	H
H	L	↑	⎍	⎎
H	↓	H	⎍	⎎
↑	L	H	⎍	⎎

NOTES:

1. An external timing capacitor may be connected between C_{ext} and R_{ext}/C_{ext} (positive).
2. To use the internal timing resistor of the LS122, connect R_{int} to V_{CC}.
3. For improved pulse width accuracy connect an external resistor between R_{ext}/C_{ext} and V_{CC} with R_{int} open-circuited.
4. To obtain variable pulse widths, connect an external variable resistance between R_{int}/C_{ext} and V_{CC}.

TYPICAL APPLICATION DATA

The output pulse t_W is a function of the external components, C_{ext} and R_{ext} or C_{ext} and R_{int} on the LS122. For values of $C_{ext} \geqslant 1000$ pF, the output pulse at $V_{CC} = 5.0$ V and $V_{RC} = 5.0$ V (see Figures 1, 2, and 3) is given by

$$t_W = K\ R_{ext}\ C_{ext}$$ where K is nominally 0.45

If C_{ext} is on pF and R_{ext} is in kΩ then t_W is in nanoseconds.

The C_{ext} terminal of the LS122 and LS123 is an internal connection to ground, however for the best system performance C_{ext} should be hard-wired to ground.

Care should be taken to keep R_{ext} and C_{ext} as close to the monostable as possible with a minimum amount of inductance between the R_{ext}/C_{ext} junction and the R_{ext}/C_{ext} pin. Good groundplane and adequate bypassing should be designed into the system for optimum performance to insure that no false triggering occurs.

It should be noted that the C_{ext} pin is internally connected to ground on the LS122 and LS123, but not on the LS221. Therefore, if C_{ext} is hard-wired externally to ground, substitution of a LS221 onto a LS123 socket will cause the LS221 to become non-functional.

The switching diode is not needed for electrolytic capacitance application and should not be used on the LS122 and LS123.

To find the value of K for $C_{ext} \geqslant 1000$ pF, refer to Figure 4. Variations on V_{CC} or V_{RC} can cause the value of K to change, as can the temperature of the LS123, LS122. Figures 5 and 6 show the behaviour of the circuit shown in Figures 1 and 2 if separate power supplies are used for V_{CC} and V_{RC}. If V_{CC} is tied to V_{RC}, Figure 7 shows how K will vary with V_{CC} and temperature. Remember, the changes in R_{ext} and C_{ext} with temperature are not calculated and included in the graph.

As long as $C_{ext} \geqslant 1000$ pF and $5K \leqslant R_{ext} \leqslant 260$ K (SN74LS122/123) or $5K \leqslant R_{ext} \leqslant 160$ K (SN54LS122/123), the change in K with respect to R_{ext} is negligable.

If $C_{ext} \leqslant 1000$ pF the graph shown on Figure 8 can be used to determine the output pulse width. Figure 9 shows how K will change for $C_{ext} \leqslant 1000$ pF if V_{CC} and V_{RC} are connected to the same power supply. The pulse width t_W in nanoseconds is approximated by

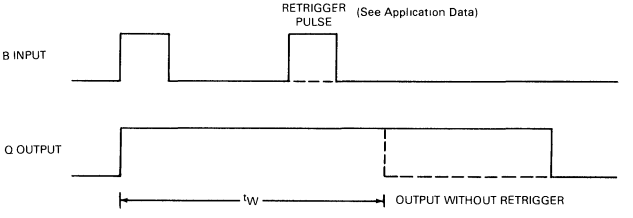
$$t_W = 6 + 0.05\ C_{ext}\ (pF) + 0.45\ R_{ext}\ (k\Omega)\ C_{ext} + 11.6\ R_{ext}$$

In order to trim the output pulse width, it is necessary to include a variable resistor between V_{CC} and the R_{ext}/C_{ext} pin or between V_{CC} and the R_{ext} pin of the LS122. Figure 10, 11, and 12 show how this can be done. R_{ext} remote should be kept as close to the monostable as possible.

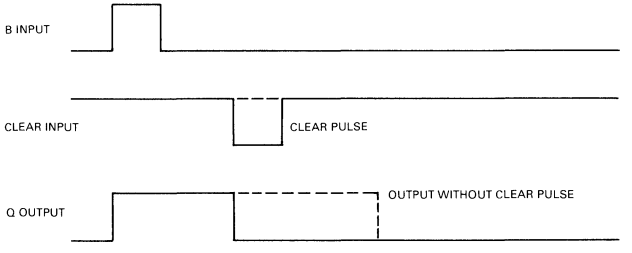
Retriggering of the part, as shown in Figure 3, must not occur before C_{ext} is discharged or the retrigger pulse will not have any effect. The discharge time of C_{ext} in nanoseconds is guaranteed to be less than 0.22 C_{ext} (pF) and is typically 0.05 C_{ext} (pF).

For the smallest possible deviation in output pulse widths from various devices, it is suggested that C_{ext} be kept $\geqslant 1000$ pF.

WAVEFORMS



EXTENDING PULSE WIDTH



OVERRIDING THE OUTPUT PULSE

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA
R_{ext}	External Timing Resistance	54 74	5.0 5.0		180 260	kΩ
C_{ext}	External Capacitance	54,74	No Restriction			
R_{ext}/C_{ext}	Wiring Capacitance at R_{ext}/C_{ext} Terminal	54,74			50	pF

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current	LS122			11	mA	V_{CC} = MAX	
		LS123			20			

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Propagation Delay, A to Q		23	33	ns	C_{ext} = 0 C_L = 15 pF R_{ext} = 5.0 kΩ R_L = 2.0 kΩ
t_{PHL}	Propagation Delay, A to $\overline{Q}$		32	45		
t_{PLH}	Propagation Delay, B to Q		23	44	ns	
t_{PHL}	Propagation Delay, B to $\overline{Q}$		34	56		
t_{PLH}	Propagation Delay, Clear to $\overline{Q}$		28	45	ns	
t_{PHL}	Propagation Delay, Clear to Q		20	27		
$t_{W\ min}$	A or B to Q		116	200	ns	
t_{WQ}	A to B to Q	4.0	4.5	5.0	μs	C_{ext} = 1000 pF, R_{ext} = 10 kΩ, C_L = 15 pF, R_L = 2.0 kΩ

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS
t_W	Pulse Width	40			ns

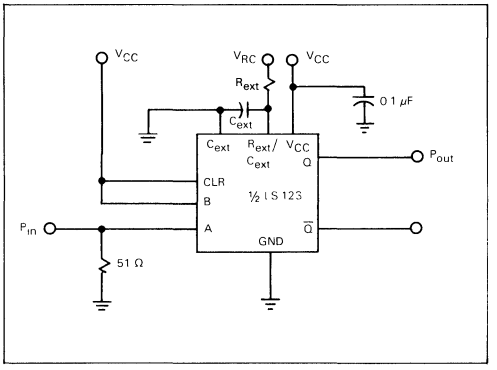


Fig. 1

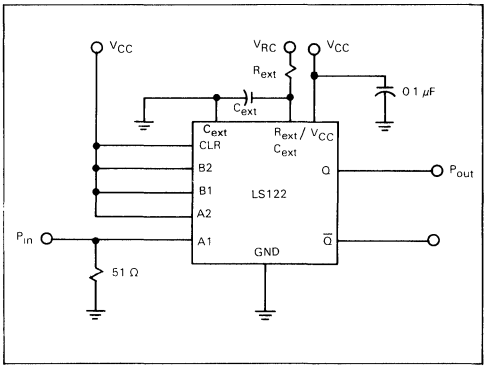


Fig. 2

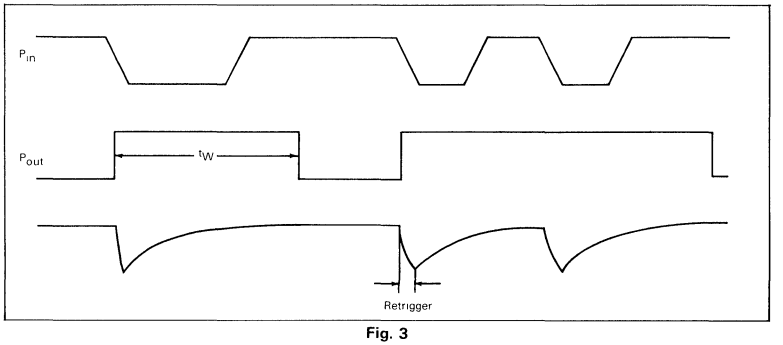


Fig. 3

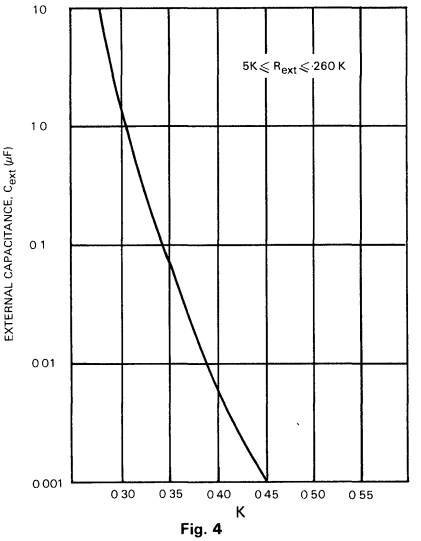


Fig. 4

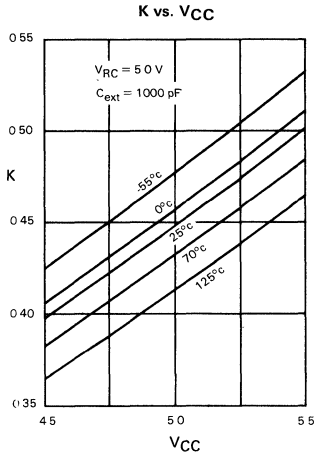


Fig. 5

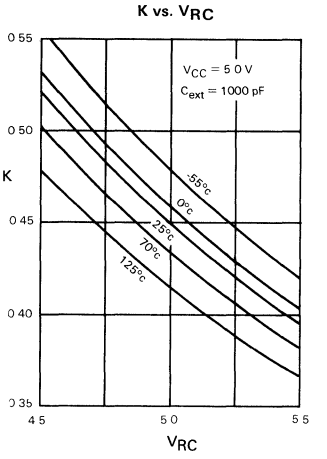


Fig. 6

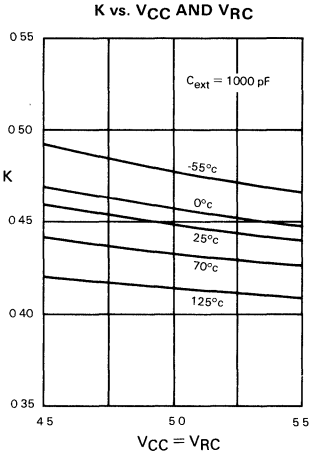


Fig. 7

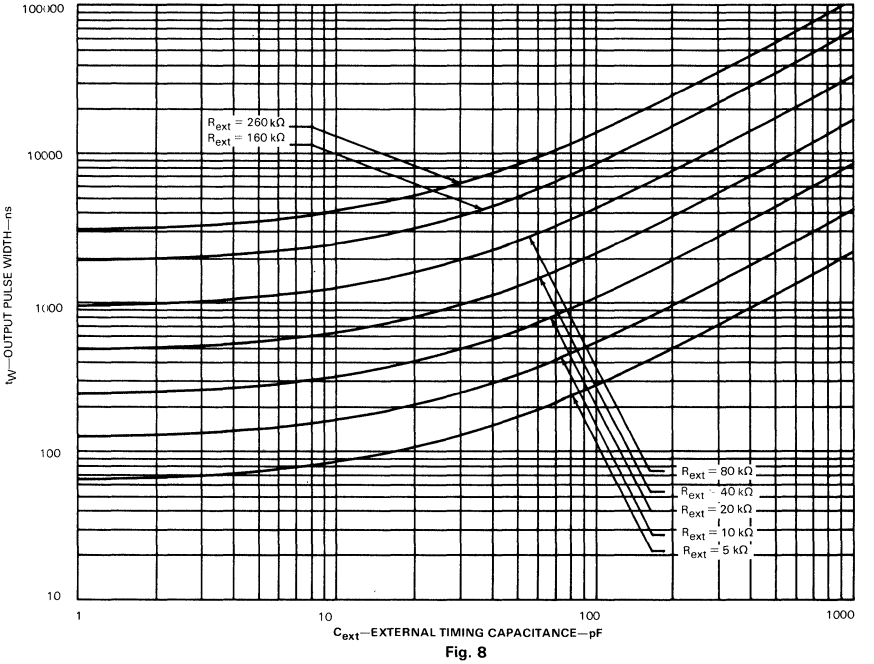


Fig. 8

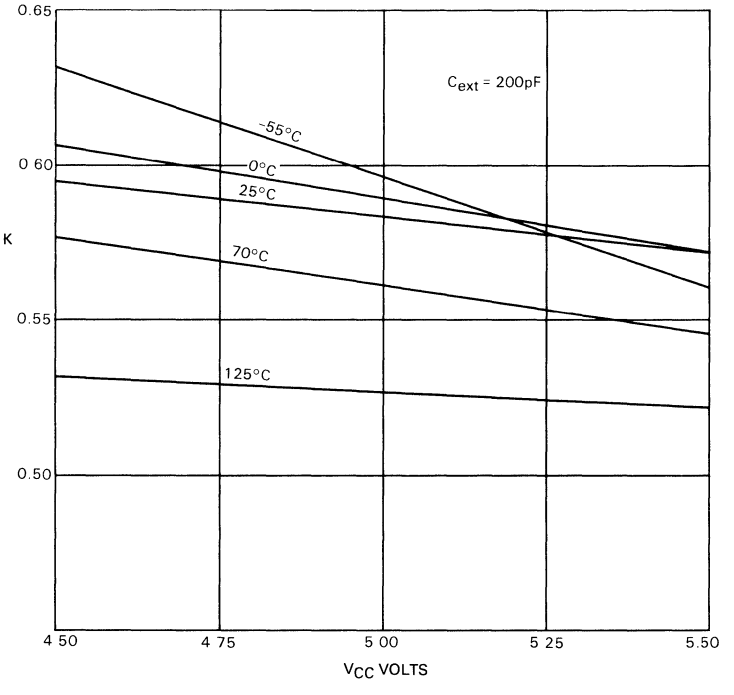


Fig. 9

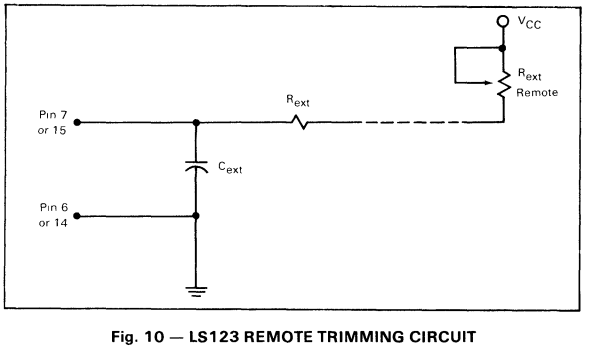


Fig. 10 — LS123 REMOTE TRIMMING CIRCUIT

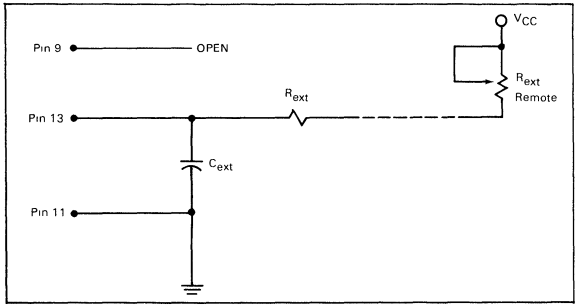


Fig. 11—LS122 REMOTE TRIMMING CIRCUIT WITHOUT R_{ext}

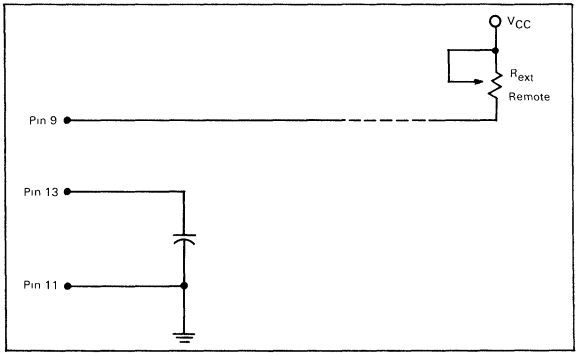


Fig. 12—LS122 REMOTE TRIMMING CIRCUIT WITH R_{int}

MOTOROLA

SN54LS/74LS125A
SN54LS/74LS126A

QUAD 3-STATE BUFFERS

LOW POWER SCHOTTKY

TRUTH TABLES

LS125A

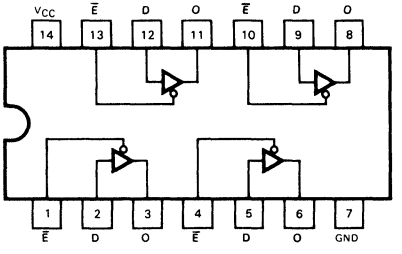
INPUTS		OUTPUT
$\overline{E}$	D	
L	L	L
L	H	H
H	X	(Z)

LS126A

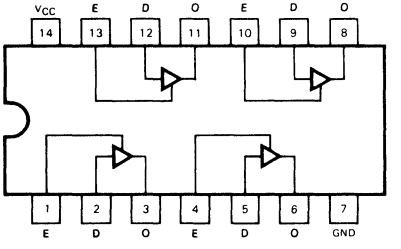
INPUTS		OUTPUT
E	D	
H	L	L
H	H	H
L	X	(Z)

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
(Z) = High Impedance (off)

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)



LS125A



LS126A

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.4			V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.4			V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4V	
I_{OS}	Short Circuit Current		−40		−225	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current	LS125A			20	mA	V_{CC} = MAX,	V_{IN} = 0 V, V_E = 4.5 V
		LS126A			22			V_{IN} = 0 V, V_E = 0 V

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH}	Propagation Delay, Data to Output	LS125A		9.0	15	ns	Fig. 2	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH}		LS126A		9.0	15			
t_{PHL}		LS125A		7.0	18			
t_{PHL}		LS126A		8.0	18			
t_{PZH}	Output Enable Time to HIGH Level	LS125A		12	20	ns	Figs. 4, 5	
		LS126A		16	25			
t_{PZL}	Output Enable Time to LOW Level	LS125A		15	25	ns	Figs. 3, 5	
		LS126A		21	35			
t_{PHZ}	Output Disable Time from HIGH Level	LS125A			20	ns	Figs. 4, 5	$V_{CC} = 5.0$ V $C_L = 5.0$ pF $R_L = 667\ \Omega$
		LS126A			25			
t_{PLZ}	Output Disable Time from LOW Level	LS125A			20	ns	Figs. 3, 5	
		LS126A			25			

Fig. 1

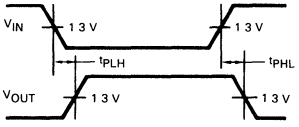


Fig. 2

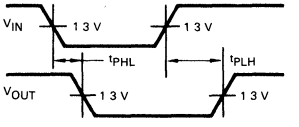


Fig. 3

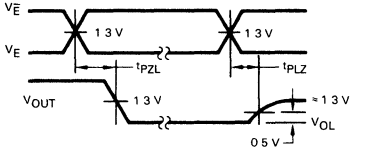


Fig. 4

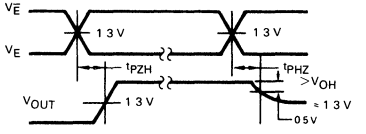
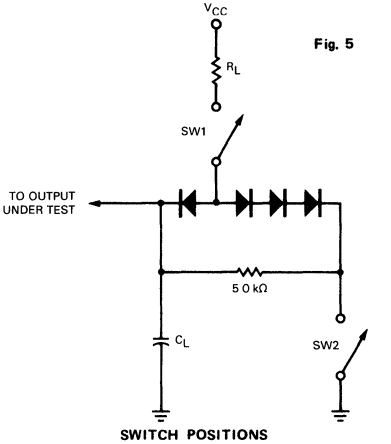


Fig. 5



SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

MOTOROLA

SN54LS132
SN74LS132

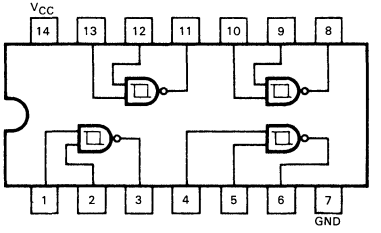
QUAD 2-INPUT SCHMITT TRIGGER NAND GATE

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS132 contains four 2-Input NAND Gates which accept standard TTL input signals and provide standard TTL output levels. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals. Additionally, they have greater noise margin than conventional NAND Gates.

Each circuit contains a 2-input Schmitt trigger followed by a Darlington level shifter and a phase splitter driving a TTL totem pole output. The Schmitt trigger uses positive feedback to effectively speed-up slow input transitions, and provide different input threshold voltages for positive and negative-going transitions. This hysteresis between the positive-going and negative-going input thresholds (typically 800 mV) is determined internally by resistor ratios and is essentially insensitive to temperature and supply voltage variations. As long as one input remains at a more positive voltage than V_{T+} (MAX), the gate will respond to the transitions of the other input as shown in Figure 1.

LOGIC AND CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

V_{IN} VERSUS V_{OUT} TRANSFER FUNCTION

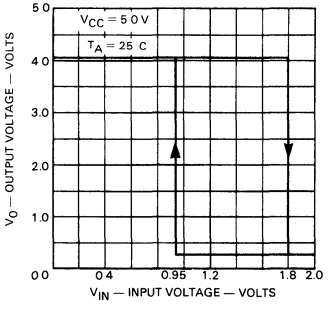


Fig. 1

4

GUARANTEED OPERATING RANGES

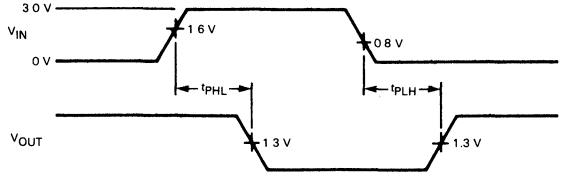
SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{T+}	Positive-Going Threshold Voltage		1.5		2.0	V	V_{CC} = 5.0 V
V_{T-}	Negative-Going Threshold Voltage		0.6		1.1	V	V_{CC} = 5.0 V
V_{T+}-V_{T-}	Hysteresis		0.4	0.8		V	V_{CC} = 5.0 V
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = −400μA, V_{IN} = V_{IL}
		74	2.7	3.4			
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	V_{CC} = MIN, I_{OL} = 4.0 mA, V_{IN} = 2.0 V
		74		0.35	0.5	V	V_{CC} = MIN, I_{OL} = 8.0 mA, V_{IN} = 2.0 V
I_{T+}	Input Current at Positive-Going Threshold			−0.14		mA	V_{CC} = 5.0 V, V_{IN} = V_{T+}
I_{T-}	Input Current at Negative-Going Threshold			−0.18		mA	V_{CC} = 5.0 V, V_{IN} = V_{T-}
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−20		−100	mA	V_{CC} = MAX, V_{OUT} = 0 V
I_{CC}	Power Supply Current Total, Output HIGH			5.9	11	mA	V_{CC} = MAX, V_{IN} = 0 V
	Total, Output LOW			8.2	14	mA	V_{CC} = MAX, V_{IN} = 4.5 V

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output			22	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output			22	ns	C_L = 15 pF



THRESHOLD VOLTAGE AND HYSTERESIS VERSUS POWER SUPPLY VOLTAGE

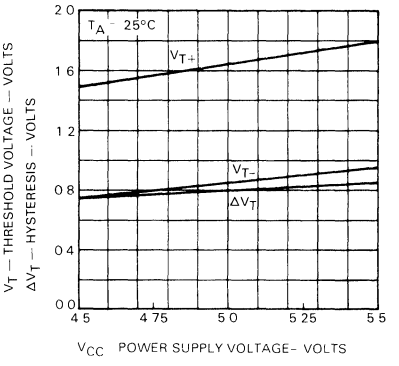


Fig. 2

THRESHOLD VOLTAGE AND HYSTERESIS VERSUS TEMPERATURE

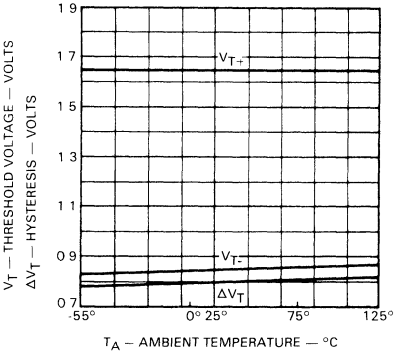
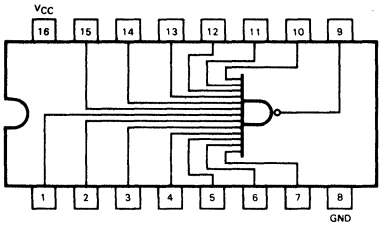


Fig. 3

4

MOTOROLA

SN54LS133
SN74LS133



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

13-INPUT NAND GATE

LOW POWER SCHOTTKY

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				0.5	mA	V_{CC} = MAX
	Total, Output LOW				1.1		

AC CHARACTERISTICS: T_A = 25°C

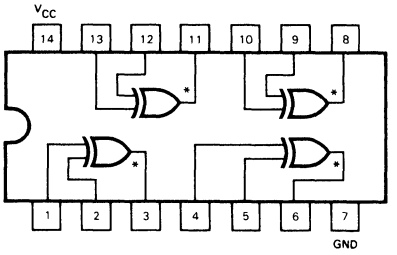
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		10	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		40	59	ns	C_L = 15 pF

MOTOROLA

SN54LS136
SN74LS136

QUAD 2-INPUT EXCLUSIVE OR GATE

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

TRUTH TABLE

IN		OUT
A	B	Z
L	L	L
L	H	H
H	L	H
H	H	L

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				40	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

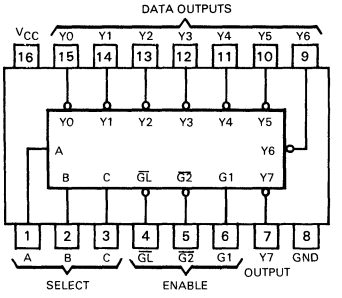
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Other Input LOW		18 18	30 30	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PLH} t_{PHL}	Propagation Delay, Other Input HIGH		18 18	30 30	ns	

MOTOROLA

SN54LS137
SN74LS137

3-LINE TO 8-LINE DECODERS/DEMULTIPLEXERS WITH ADDRESS LATCHES

LOW POWER SCHOTTKY



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

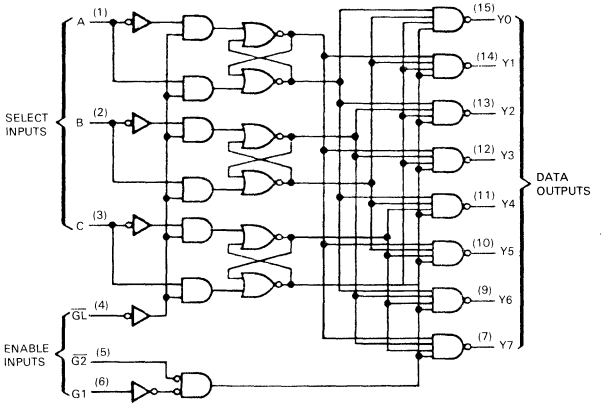
DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				18	mA	V_{CC} = MAX

FUNCTION TABLE

INPUTS						OUTPUTS							
ENABLE			SELECT										
$\overline{GL}$	G1	$\overline{G2}$	C	B	A	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
X	X	H	X	X	X	H	H	H	H	H	H	H	H
X	L	X	X	X	X	H	H	H	H	H	H	H	H
L	H	L	L	L	L	L	H	H	H	H	H	H	H
L	H	L	L	L	H	H	L	H	H	H	H	H	H
L	H	L	L	H	L	H	H	L	H	H	H	H	H
L	H	L	L	H	H	H	H	H	L	H	H	H	H
L	H	L	H	L	L	H	H	H	H	L	H	H	H
L	H	L	H	L	H	H	H	H	H	H	L	H	H
L	H	L	H	H	L	H	H	H	H	H	H	L	H
L	H	L	H	H	H	H	H	H	H	H	H	H	L
H	H	L	X	X	X	Output corresponding to stored address, L; all others, H							

H = high level, L = low level, X = irrelevant



AC CHARACTERISTICS: $V_{CC} = 5.0$ V, $T_A = 25°C$

SYMBOL	PARAMETER	LEVELS OF DELAY	LIMITS			UNIT	TEST CONDITIONS
			MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay Time, A,B,C to Y	2 4		11 25	17 38	ns	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay Time, A,B,C to Y	3 3		16 19	24 29	ns	
t_{PLH} t_{PHL}	Propagation Delay Time, Enable $\overline{G2}$ to Y	2 2		13 16	21 27	ns	
t_{PLH} t_{PHL}	Propagation Delay Time, Enable G1 to Y	3 3		14 18	21 27	ns	
t_{PLH} t_{PHL}	Propagation Delay Time, Enable $\overline{GL}$ to Y	3 4		18 25	27 38	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Pulse Width — Enable at $\overline{GL}$	15			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, A,B,C	10			ns	
t_h	Hold Time, A,B,C	10			ns	

MOTOROLA

SN54LS138
SN74LS138

1-OF-8-DECODER/ DEMULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS138 is a high speed 1-of-8 Decoder/Demultiplexer. This device is ideally suited for high speed bipolar memory chip select address decoding. The multiple input enables allow parallel expansion to a 1-of-24 decoder using just three LS138 devices or to a 1-of-32 decoder using four LS138s and one inverter. The LS138 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **DEMULTIPLEXING CAPABILITY**
- **MULTIPLE INPUT ENABLE FOR EASY EXPANSION**
- **TYPICAL POWER DISSIPATION OF 32 mW**
- **ACTIVE LOW MUTUALLY EXCLUSIVE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

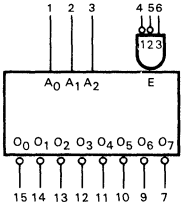
PIN NAMES

$A_0 - A_2$	Address Inputs
$\overline{E}_1, \overline{E}_2$	Enable (Active LOW) Inputs
E_3	Enable (Active HIGH) Input
$\overline{O}_0 - \overline{O}_7$	Active LOW Outputs (Note b)

LOADING (Note a)	
HIGH	LOW
0.5 U.L.	0.25 U.L.
0.5 U.L.	0.25 U.L.
0.5 U.L.	0.25 U.L.
10 U.L.	5(2.5) U.L.

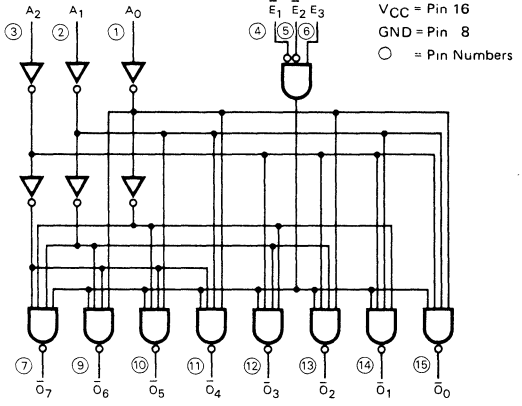
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL

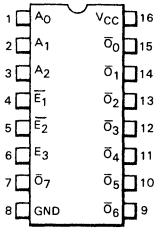


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION – The LS138 is a high speed 1-of-8 Decoder/Demultiplexer fabricated with the low power Schottky barrier diode process. The decoder accepts three binary weighted inputs (A_0, A_1, A_2) and when enabled provides eight mutually exclusive active LOW outputs ($\overline{O}_0$-$\overline{O}_7$). The LS138 features three Enable inputs, two active LOW ($\overline{E}_1$, $\overline{E}_2$) and one active HIGH (E_3). All outputs will be HIGH unless $\overline{E}_1$ and $\overline{E}_2$ are LOW and E_3 is HIGH. This multiple enable function allows easy parallel expansion of the device to a 1-of-32 (5 lines to 32 lines) decoder with just four LS138s and one inverter. (See Figure a.)

The LS138 can be used as an 8-output demultiplexer by using one of the active LOW Enable inputs as the data input and the other Enable inputs as strobes. The Enable inputs which are not used must be permanently tied to their appropriate active HIGH or active LOW state.

TRUTH TABLE

INPUTS						OUTPUTS							
$\overline{E}_1$	$\overline{E}_2$	E_3	A_0	A_1	A_2	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$	$\overline{O}_4$	$\overline{O}_5$	$\overline{O}_6$	$\overline{O}_7$
H	X	X	X	X	X	H	H	H	H	H	H	H	H
X	H	X	X	X	X	H	H	H	H	H	H	H	H
X	X	L	X	X	X	H	H	H	H	H	H	H	H
L	L	H	L	L	L	L	H	H	H	H	H	H	H
L	L	H	H	L	L	H	L	H	H	H	H	H	H
L	L	H	L	H	L	H	H	L	H	H	H	H	H
L	L	H	H	H	L	H	H	H	L	H	H	H	H
L	L	H	L	L	H	H	H	H	H	L	H	H	H
L	L	H	H	L	H	H	H	H	H	H	L	H	H
L	L	H	L	H	H	H	H	H	H	H	H	L	H
L	L	H	H	H	H	H	H	H	H	H	H	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

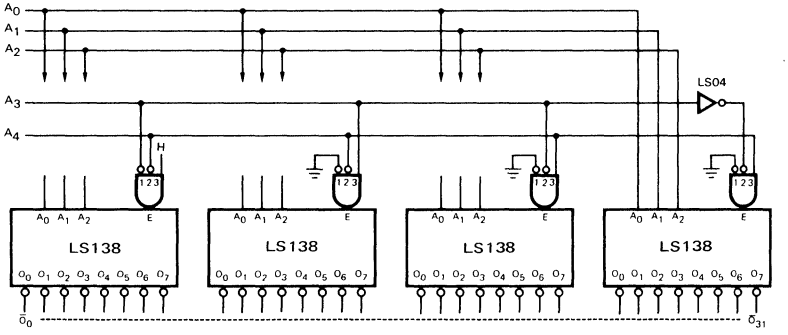


Fig. a.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LEVEL OF DELAY	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay Address to Output	2 2		13 27	20 41	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Address to Output	3 3		18 26	27 39	ns	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output	2 2		12 21	18 32	ns	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output	3 3		17 25	26 38	ns	

AC WAVEFORMS

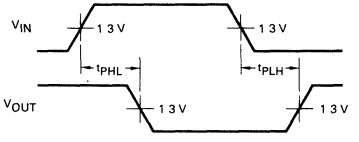


Fig. 1

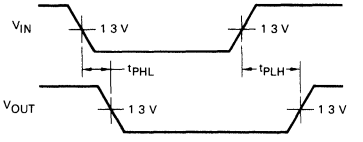


Fig. 2

MOTOROLA

SN54LS139
SN74LS139

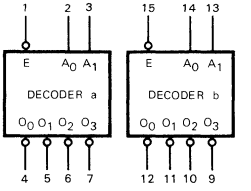
DUAL 1-OF-4 -DECODER/ DEMULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS139 is a high speed Dual 1-of-4 Decoder/Demultiplexer. The device has two independent decoders, each accepting two inputs and providing four mutually exclusive active LOW Outputs. Each decoder has an active LOW Enable input which can be used as a data input for a 4-output demultiplexer. Each half of the LS139 can be used as a function generator providing all four minterms of two variables. The LS139 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **TWO COMPLETELY INDEPENDENT 1-OF- 4 DECODERS**
- **ACTIVE LOW MUTUALLY EXCLUSIVE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

LOGIC SYMBOL



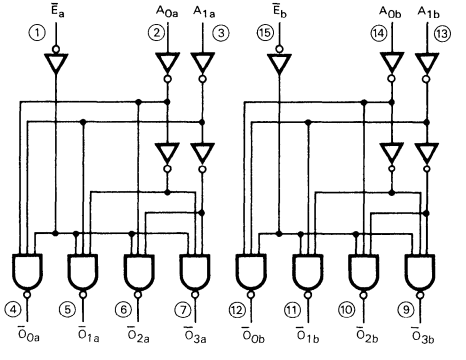
V_{CC} = Pin 16
GND = Pin 8

PIN NAMES

		LOADING (Note a) HIGH	LOW
A_0, A_1	Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
$\overline{O}_0 - \overline{O}_3$	Active LOW Outputs (Note b)	10 U.L.	5 (2.5) U.L.

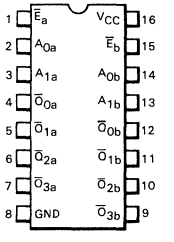
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The LS139 is a high speed dual 1-of-4 decoder/demultiplexer fabricated with the Schottky barrier diode process. The device has two independent decoders, each of which accept two binary weighted inputs (A_0, A_1) and provide four mutually exclusive active LOW outputs ($\overline{O}_0$-$\overline{O}_3$). Each decoder has an active LOW Enable ($\overline{E}$). When $\overline{E}$ is HIGH all outputs are forced HIGH. The enable can be used as the data input for a 4-output demultiplexer application.

Each half of the LS139 generates all four minterms of two variables. These four minterms are useful in some applications, replacing multiple gate functions as shown in Fig. a, and thereby reducing the number of packages required in a logic network.

TRUTH TABLE

INPUTS			OUTPUTS			
$\overline{E}$	A_0	A_1	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$
H	X	X	H	H	H	H
L	L	L	L	H	H	H
L	H	L	H	L	H	H
L	L	H	H	H	L	H
L	H	H	H	H	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

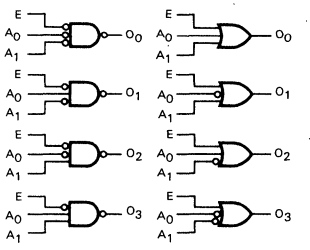


Fig. a

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				11	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LEVEL OF DELAY	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay Address to Output	2 2		13 22	20 33	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Address to Output	3 3		18 25	29 38	ns	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output	2 2		16 21	24 32	ns	

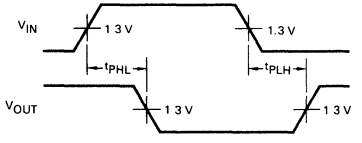


Fig. 1

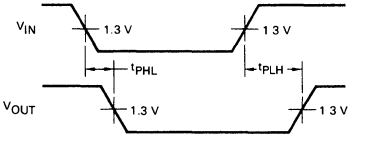


Fig. 2

MOTOROLA

SN54LS145
SN74LS145

1-OF-10 DECODER/DRIVER OPEN-COLLECTOR

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS145, 1-of-10 Decoder/Driver, is designed to accept BCD inputs and provide appropriate outputs to drive 10-digit incandescent displays. All outputs remain off for all invalid binary input conditions. It is designed for use as indicator/relay drivers or as an open-collector logic circuit driver. Each of the high breakdown output transistors will sink up to 80 mA of current. Typical power dissipation is 35 mW. This device is fully compatible with all TTL families.

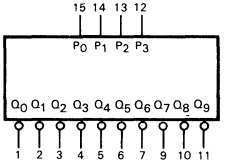
- **LOW POWER VERSION OF 54/74145**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a)	
		HIGH	LOW
P_0, P_1, P_2, P_3	BCD Inputs	0.5 U.L.	0.25 U.L.
$\overline{Q}_0$ to $\overline{Q}_9$	Outputs (Note b)	Open Collector	15 (7.5) U.L.

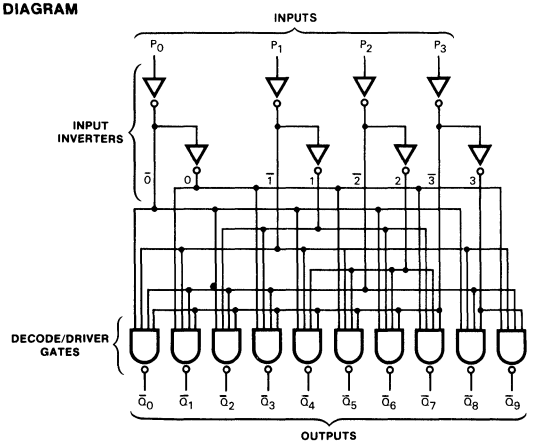
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial (74) Temperature Ranges

LOGIC SYMBOL

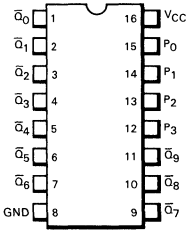


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

TRUTH TABLE

INPUTS				OUTPUTS									
P_3	P_2	P_1	P_0	$\overline{Q}_0$	$\overline{Q}_1$	$\overline{Q}_2$	$\overline{Q}_3$	$\overline{Q}_4$	$\overline{Q}_5$	$\overline{Q}_6$	$\overline{Q}_7$	$\overline{Q}_8$	$\overline{Q}_9$
L	L	L	L	L	H	H	H	H	H	H	H	H	H
L	L	L	H	H	L	H	H	H	H	H	H	H	H
L	L	H	L	H	H	L	H	H	H	H	H	H	H
L	L	H	H	H	H	H	L	H	H	H	H	H	H
L	H	L	L	H	H	H	H	L	H	H	H	H	H
L	H	L	H	H	H	H	H	H	L	H	H	H	H
L	H	H	L	H	H	H	H	H	H	L	H	H	H
L	H	H	H	H	H	H	H	H	H	H	L	H	H
H	L	L	L	H	H	H	H	H	H	H	H	L	H
H	L	L	H	H	H	H	H	H	H	H	H	H	L
H	L	H	L	H	H	H	H	H	H	H	H	H	H
H	L	H	H	H	H	H	H	H	H	H	H	H	H
H	H	L	L	H	H	H	H	H	H	H	H	H	H
H	H	L	H	H	H	H	H	H	H	H	H	H	H
H	H	H	L	H	H	H	H	H	H	H	H	H	H
H	H	H	H	H	H	H	H	H	H	H	H	H	H

H = HIGH Voltage Level
L = LOW Voltage Level

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			15	V
I_{OL}	Output Current — Low	54 74			12 24	mA

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			250	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
		54,74		2.3	3.0	V	I_{OL} = 80 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current				13	mA	V_{CC} = MAX, V_{IN} = GND

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL} t_{PLH}	Propagation Delay P_n Input to Q_n Output			50 50	ns	V_{CC} = 5.0 V C_L = 45 pF

AC WAVEFORMS

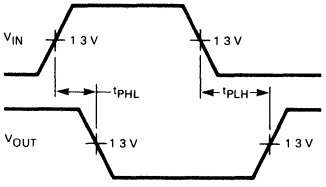


Fig. 1

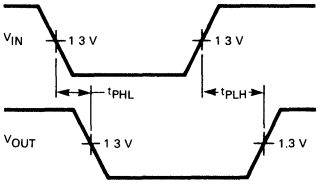


Fig. 2

MOTOROLA

SN54LS/74LS147
SN54LS/74LS148
SN54LS/74LS748

10-LINE-TO-4-LINE AND 8-LINE-TO-3-LINE PRIORITY ENCODERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS147 and the SN54LS/74LS148 are Priority Encoders. They provide priority decoding of the inputs to ensure that only the highest order data line is encoded. Both devices have data inputs and outputs which are active at the low logic level.

The LS147 encodes nine data lines to four-line (8-4-2-1) BCD. The implied decimal zero condition does not require an input condition because zero is encoded when all nine data lines are at a high logic level.

The LS148 encodes eight data lines to three-line (4-2-1) binary (octal). By providing cascading circuitry (Enable Input EI and Enable Output EO) octal expansion is allowed without needing external circuitry.

The SN54LS/74LS748 is a proprietary Motorola part incorporating a built-in deglitcher network which minimizes glitches on the GS output. The glitch occurs on the negative going transition of the EI input when data inputs 0-7 are at logical ones.

The only dc parameter differences between the LS148 and the LS748 are that (1) Pin 10 (input 0) has a fan-in of 2 on the LS748 versus a fan-in of 1 on the LS148; (2) Pins 1, 2, 3, 4, 11, 12 and 13 (inputs 1, 2, 3, 4, 5, 6, 7) have a fan-in of 3 on the LS748 versus a fan-in of 2 on the LS148.

The only ac difference is that t_{PHL} from EI to EO is changed from 40 to 45 ns.

SN54LS/74LS147
FUNCTION TABLE

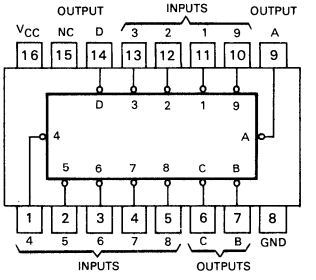
INPUTS									OUTPUTS			
1	2	3	4	5	6	7	8	9	D	C	B	A
H	H	H	H	H	H	H	H	H	H	H	H	H
X	X	X	X	X	X	X	X	L	L	H	H	L
X	X	X	X	X	X	X	L	H	L	H	H	H
X	X	X	X	X	X	L	H	H	H	L	L	L
X	X	X	X	X	L	H	H	H	H	L	L	H
X	X	X	X	L	H	H	H	H	H	L	H	L
X	X	X	L	H	H	H	H	H	H	L	H	H
X	X	L	H	H	H	H	H	H	H	H	L	L
X	L	H	H	H	H	H	H	H	H	H	L	H
L	H	H	H	H	H	H	H	H	H	H	H	L

SN54LS/74LS148
SN54LS/74LS748
FUNCTION TABLE

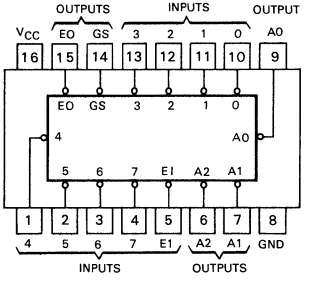
INPUTS									OUTPUTS				
EI	0	1	2	3	4	5	6	7	A2	A1	A0	GS	EO
H	X	X	X	X	X	X	X	X	H	H	H	H	H
L	H	H	H	H	H	H	H	H	H	H	H	H	L
L	X	X	X	X	X	X	X	L	L	L	L	L	H
L	X	X	X	X	X	X	L	H	L	L	H	L	H
L	X	X	X	X	X	L	H	H	L	H	L	L	H
L	X	X	X	X	L	H	H	H	L	H	H	L	H
L	X	X	X	L	H	H	H	H	H	L	L	L	H
L	X	X	L	H	H	H	H	H	H	L	H	L	H
L	X	L	H	H	H	H	H	H	H	H	L	L	H
L	L	H	H	H	H	H	H	H	H	H	H	L	H

H = high logic level, L = low logic level, X = irrelevant

SN54LS/74LS147
(TOP VIEW)



SN54LS/74LS148
SN54LS/74LS748
(TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

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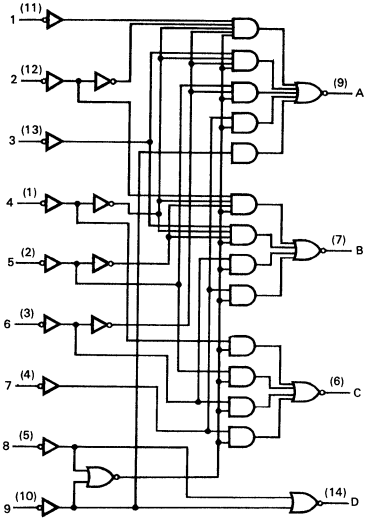
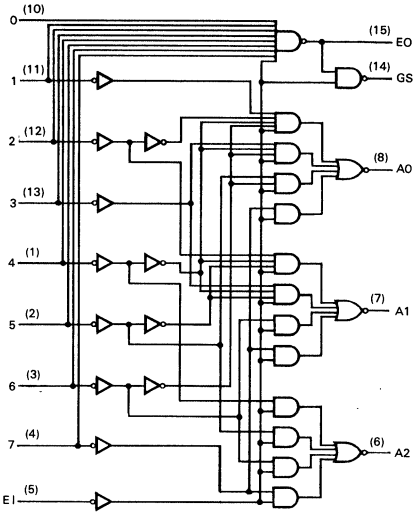
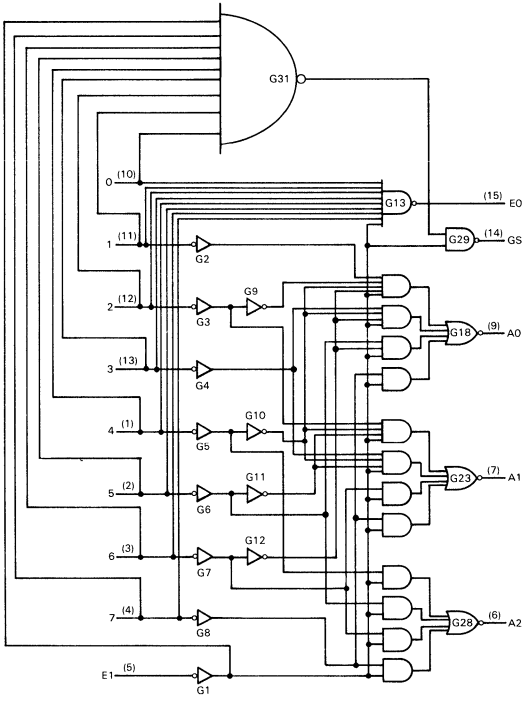
FUNCTIONAL BLOCK DIAGRAMS



SN54LS/74LS147



SN54LS/74LS148



SN54LS/74LS748

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current All Others Input 0 (LS748) Inputs 1-7 (LS148) Inputs 1-7 (LS748)				20 40 40 60	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	All Others Input 0 (LS748) Inputs 1-7 (LS148) Inputs 1-7 (LS748)				0.1 0.2 0.2 0.3	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current All others Input 0 (LS748) Inputs 1-7 (LS148) Inputs 1-7 (LS748)				−0.4 −0.8 −0.8 −1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				20	mA	V_{CC} = MAX, Inputs 7, EI, GND, Others Open
					17	mA	V_{CC} = MAX, All open

4

AC CHARACTERISTICS: $V_{CC} = 5.0$ V, $T_A = 25°C$

SN54LS/74LS147

SYMBOL	FROM (INPUT)	TO (OUTPUT)	WAVEFORM	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNIT	TEST CONDITIONS
t_{PLH}	Any	Any	In-phase		12	18	ns	
t_{PHL}			output		12	18		$C_L = 15$ pF,
t_{PLH}	Any	Any	Out-of-phase		21	33	ns	$R_L = 2$ kΩ
t_{PHL}			output		15	23		

SN54LS/74LS148
SN54LS/74LS748

SYMBOL	FROM (INPUT)	TO (OUTPUT)	WAVEFORM	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNIT	TEST CONDITIONS
t_{PLH}	1 thru 7	A0, A1, or A2	In-phase		14	18	ns	
t_{PHL}			output		15	25		
t_{PLH}	1 thru 7	A0, A1, or A2	Out-of-phase		20	36	ns	
t_{PHL}			output		16	29		
t_{PLH}	0 thru 7	EO	Out-of-phase		7.0	18	ns	
t_{PHL}			output		25	40		$C_L = 15$ pF,
t_{PLH}	0 thru 7	GS	In-phase		35	55	ns	$R_L = 2$ kΩ,
t_{PHL}			output		9.0	21		
t_{PLH}	EI	A0, A1, or A2	In-phase		16	25	ns	
t_{PHL}			output		12	25		
t_{PLH}	EI	GS	In-phase		12	17	ns	
t_{PHL}			output		14	36		
t_{PLH}	EI	EO	In-phase		12	21	ns	
t_{PHL}			output		28 30	40 45		(LS148) (LS748)

MOTOROLA

SN54LS151
SN74LS151

8-INPUT MULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The TTL/MSI SN54LS/74LS151 is a high speed 8-Input Digital Multiplexer. It provides, in one package, the ability to select one bit of data from up to eight sources. The LS151 can be used as a universal function generator to generate any logic function of four variables. Both assertion and negation outputs are provided.

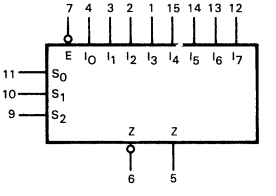
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **ON-CHIP SELECT LOGIC DECODING**
- **FULLY BUFFERED COMPLEMENTARY OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
$S_0 - S_2$	Select Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
$I_0 - I_7$	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
Z	Multiplexer Output (Note b)	10 U.L.	5 (2.5) U.L.
$\overline{Z}$	Complementary Multiplexer Output (Note b)	10 U.L.	5 (2.5) U.L.

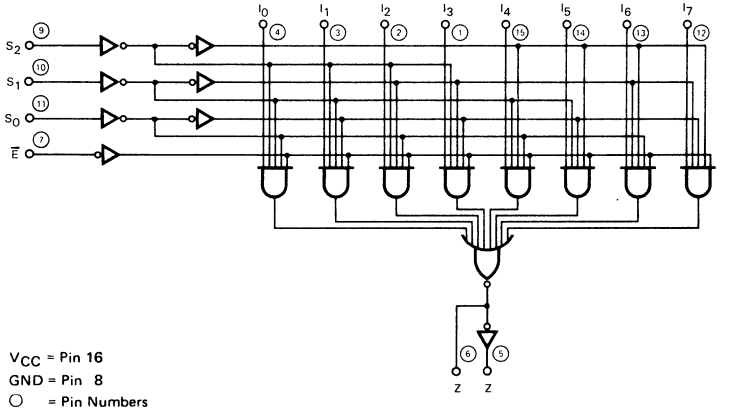
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



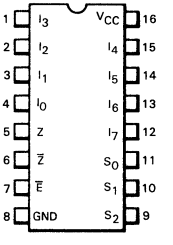
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

4

FUNCTIONAL DESCRIPTION — The LS151 is a logical implementation of a single pole, 8-position switch with the switch position controlled by the state of three Select inputs, S_0, S_1, S_2. Both assertion and negation outputs are provided. The Enable input (E) is active LOW. When it is not activated, the negation output is HIGH and the assertion output is LOW regardless of all other inputs. The logic function provided at the output is:

$$Z = \overline{E} \cdot (I_0 \cdot \overline{S}_0 \cdot \overline{S}_1 \cdot \overline{S}_2 + I_1 \cdot S_0 \cdot \overline{S}_1 \cdot \overline{S}_2 + I_2 \cdot \overline{S}_0 \cdot S_1 \cdot \overline{S}_2 + I_3 \cdot S_0 \cdot S_1 \cdot \overline{S}_2 + I_4 \cdot \overline{S}_0 \cdot \overline{S}_1 \cdot S_2 + I_5 \cdot S_0 \cdot \overline{S}_1 \cdot S_2 + I_6 \cdot \overline{S}_0 \cdot S_1 \cdot S_2 + I_7 \cdot S_0 \cdot S_1 \cdot S_2).$$

The LS151 provides the ability, in one package, to select from eight sources of data or control information. By proper manipulation of the inputs, the LS151 can provide any logic function of four variables and its negation.

TRUTH TABLE

$\overline{E}$	S_2	S_1	S_0	I_0	I_1	I_2	I_3	I_4	I_5	I_6	I_7	$\overline{Z}$	Z
H	X	X	X	X	X	X	X	X	X	X	X	H	L
L	L	L	L	L	X	X	X	X	X	X	X	H	L
L	L	L	L	H	X	X	X	X	X	X	X	L	H
L	L	L	H	X	L	X	X	X	X	X	X	H	L
L	L	L	H	X	H	X	X	X	X	X	X	L	H
L	L	H	L	X	X	L	X	X	X	X	X	H	L
L	L	H	L	X	X	H	X	X	X	X	X	L	H
L	L	H	H	X	X	X	L	X	X	X	X	H	L
L	L	H	H	X	X	X	H	X	X	X	X	L	H
L	H	L	L	X	X	X	X	L	X	X	X	H	L
L	H	L	L	X	X	X	X	H	X	X	X	L	H
L	H	L	H	X	X	X	X	X	L	X	X	H	L
L	H	L	H	X	X	X	X	X	H	X	X	L	H
L	H	H	L	X	X	X	X	X	X	L	X	H	L
L	H	H	L	X	X	X	X	X	X	H	X	L	H
L	H	H	H	X	X	X	X	X	X	X	L	H	L
L	H	H	H	X	X	X	X	X	X	X	H	L	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay Select to Output Z		27 18	43 30	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Select to Output $\overline{Z}$		14 20	23 32	ns	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output Z		26 20	42 32	ns	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output $\overline{Z}$		15 18	24 30	ns	
t_{PLH} t_{PHL}	Propagation Delay Data to Output Z		20 16	32 26	ns	
t_{PLH} t_{PHL}	Propagation Delay Data to Output $\overline{Z}$		13 12	21 20	ns	

AC WAVEFORMS

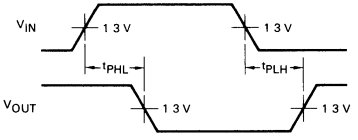


Fig. 1

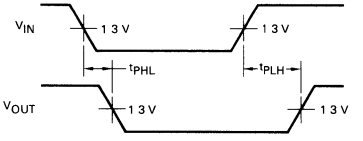


Fig. 2

MOTOROLA

SN54LS153
SN74LS153

DUAL 4-INPUT MULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS153 is a very high speed Dual 4-Input Multiplexer with common select inputs and individual enable inputs for each section. It can select two bits of data from four sources. The two buffered outputs present data in the true (non-inverted) form. In addition to multiplexer operation, the LS153 can generate any two functions of three variables. The LS153 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

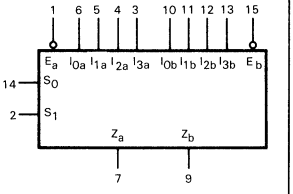
- **MULTIFUNCTION CAPABILITY**
- **NON-INVERTING OUTPUTS**
- **SEPARATE ENABLE FOR EACH MULTIPLEXER**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S_0	Common Select Input	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_0, I_1	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
Z	Multiplexer Output (Note b)	10 U.L.	5 (2.5) U.L.

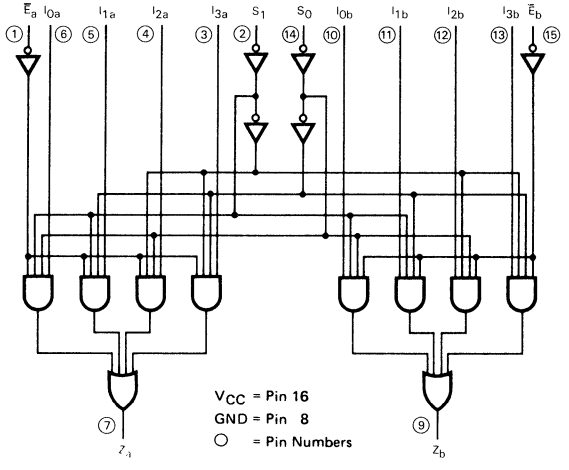
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



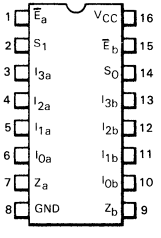
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

FUNCTIONAL DESCRIPTION — The LS153 is a Dual 4-Input Multiplexer fabricated with Low Power, Schottky barrier diode process for high speed. It can select two bits of data from up to four sources under the control of the common Select Inputs (S_0, S_1). The two 4-input multiplexer circuits have individual active LOW Enables ($\overline{E}_a$, $\overline{E}_b$) which can be used to strobe the outputs independently. When the Enables ($\overline{E}_a$, $\overline{E}_b$) are HIGH, the corresponding outputs (Z_a, Z_b) are forced LOW.

The LS153 is the logic implementation of a 2-pole, 4-position switch, where the position of the switch is determined by the logic levels supplied to the two Select Inputs. The logic equations for the outputs are shown below.

$$Z_a = \overline{E}_a \cdot (I_{0a} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1a} \cdot \overline{S}_1 \cdot S_0 + I_{2a} \cdot S_1 \cdot \overline{S}_0 + I_{3a} \cdot S_1 \cdot S_0)$$
$$Z_b = \overline{E}_b \cdot (I_{0b} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1b} \cdot \overline{S}_1 \cdot S_0 + I_{2b} \cdot S_1 \cdot \overline{S}_0 + I_{3b} \cdot S_1 \cdot S_0)$$

The LS153 can be used to move data from a group of registers to a common output bus. The particular register from which the data came would be determined by the state of the Select Inputs. A less obvious application is a function generator. The LS153 can generate two functions of three variables. This is useful for implementing highly irregular random logic.

TRUTH TABLE

SELECT INPUTS		INPUTS (a or b)					OUTPUT
S_0	S_1	$\overline{E}$	I_0	I_1	I_2	I_3	Z
X	X	H	X	X	X	X	L
L	L	L	L	X	X	X	L
L	L	L	H	X	X	X	H
H	L	L	X	L	X	X	L
H	L	L	X	H	X	X	H
L	H	L	X	X	L	X	L
L	H	L	X	X	H	X	H
H	H	L	X	X	X	L	L
H	H	L	X	X	X	H	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay Data to Output		10 17	15 26	ns	Fig. 2	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Select to Output		19 25	29 38	ns	Fig. 1	
t_{PLH} t_{PHL}	Propagation Delay Enable to Output		16 21	24 32	ns	Fig. 2	

AC WAVEFORMS

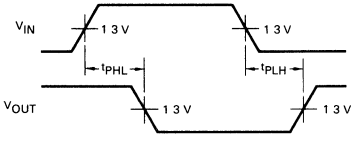


Fig. 1

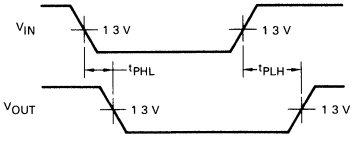


Fig. 2

MOTOROLA

SN54LS/74LS155
SN54LS/74LS156

DUAL 1-OF-4 DECODER/ DEMULTIPLEXER

LS156-OPEN-COLLECTOR
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS155 and SN54LS/74LS156 are high speed Dual 1-of-4 Decoder/Demultiplexers. These devices have two decoders with common 2-bit Address inputs and separate gated Enable inputs. Decoder "a" has an Enable gate with one active HIGH and one active LOW input. Decoder "b" has two active LOW Enable inputs. If the Enable functions are satisfied, one output of each decoder will be LOW as selected by the address inputs. The LS156 has open collector outputs for wired-OR (DOT-AND) decoding and function generator applications.

The LS155 and LS156 are fabricated with the Schottky barrier diode process for high speed and are completely compatible with all Motorola TTL families.

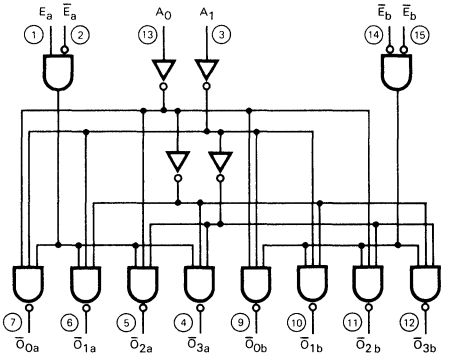
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **COMMON ADDRESS INPUTS**
- **TRUE OR COMPLEMENT DATA DEMULTIPLEXING**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
A_0, A_1	Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}_a$, $\overline{E}_b$	Enable (Active LOW) Inputs	0.5 U.L.	0.25 U.L.
E_a	Enable (Active HIGH) Input	0.5 U.L.	0.25 U.L.
$\overline{O}_0 - \overline{O}_3$	Active LOW Outputs (Note b)	10 U.L.	5 (2.5) U.L.

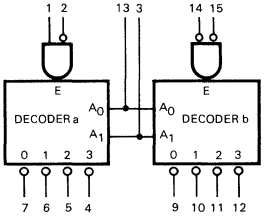
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges. The HIGH level drive for the LS156 must be established by an external resistor.

LOGIC DIAGRAM



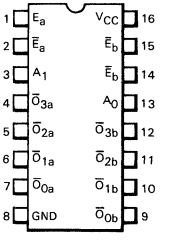
V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

NOTE.
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS155 and LS156 are Dual 1-of-4 Decoder/Demultiplexers with common Address inputs and separate gated Enable inputs. When enabled, each decoder section accepts the binary weighted Address inputs (A_0, A_1) and provides four mutually exclusive active LOW outputs ($\overline{O}_0$–$\overline{O}_3$). If the Enable requirements of each decoder are not met, all outputs of that decoder are HIGH.

Each decoder section has a 2-input enable gate. The enable gate for Decoder "a" requires one active HIGH input and one active LOW input ($E_a \cdot \overline{E}_a$). In demultiplexing applications, Decoder "a" can accept either true or complemented data by using the $\overline{E}_a$ or E_a inputs respectively. The enable gate for Decoder "b" requires two active LOW inputs ($\overline{E}_b \cdot \overline{E}_b$). The LS155 or LS156 can be used as a 1-of-8 Decoder/Demultiplexer by tying E_a to $\overline{E}_b$ and relabeling the common connection as (A_2). The other $\overline{E}_b$ and $\overline{E}_a$ are connected together to form the common enable.

The LS155 and LS156 can be used to generate all four minterms of two variables. These four minterms are useful in some applications replacing multiple gate functions as shown in Fig. a. The LS156 has the further advantage of being able to AND the minterm functions by tying outputs together. Any number of terms can be wired-AND as shown below.

$$f = (E + A_0 + A_1) \cdot (E + \overline{A}_0 + A_1) \cdot (E + A_0 + \overline{A}_1) \cdot (E + \overline{A}_0 + \overline{A}_1)$$

where $E = E_a + \overline{E}_a$; $E = E_b + E_b$

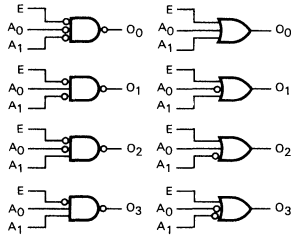


Fig. a

TRUTH TABLE

ADDRESS		ENABLE "a"		OUTPUT "a"				ENABLE "b"		OUTPUT "b"			
A_0	A_1	E_a	$\overline{E}_a$	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$	$\overline{E}_b$	$\overline{E}_b$	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$
X	X	L	X	H	H	H	H	H	X	H	H	H	H
X	X	X	H	H	H	H	H	X	H	H	H	H	H
L	L	H	L	L	H	H	H	L	L	L	H	H	H
H	L	H	L	H	L	H	H	L	L	H	L	H	H
L	H	H	L	H	H	L	H	L	L	H	H	L	H
H	H	H	L	H	H	H	L	L	L	H	H	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX	

AC CHARACTERISTICS T_A = 25°C

SYMBOL	PARAMETER	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay Address, $\overline{E}_a$ or $\overline{E}_b$ to Output	10 19	15 30	ns	Fig. 1	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Address to Output	17 19	26 30	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay E_a to Output	18 18	27 27	ns	Fig. 1	

AC WAVEFORMS

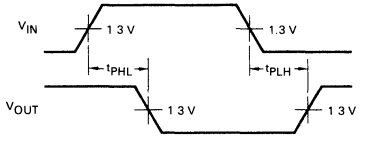


Fig. 1

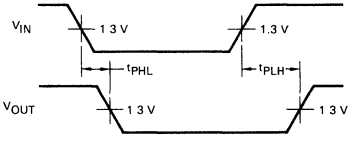


Fig. 2

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54, 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX	

AC CHARACTERISTICS T_A = 25°C

SYMBOL	PARAMETER	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay Address, $\overline{E}_a$ or $\overline{E}_b$ to Output	25 34	40 51	ns	Fig. 1	V_{CC} = 5.0 V C_L = 15 pF R_L = 2 kΩ
t_{PLH} t_{PHL}	Propagation Delay Address to Output	31 34	46 51	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay E_a to Output	32 32	48 48	ns	Fig. 1	

AC WAVEFORMS

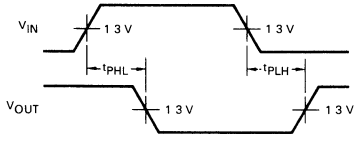


Fig. 1

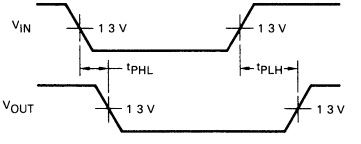


Fig. 2

MOTOROLA

SN54LS157
SN74LS157

QUAD 2-INPUT MULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS157 is a high speed Quad 2-Input Multiplexer. Four bits of data from two sources can be selected using the common Select and Enable inputs. The four buffered outputs present the selected data in the true (non-inverted) form. The LS157 can also be used to generate any four of the 16 different functions of two variables. The LS157 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

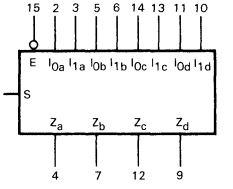
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **NON-INVERTING OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S	Common Select Input	1.0 U.L.	0.5 U.L.
$\overline{E}$	Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
$I_{0a} - I_{0d}$	Data Inputs from Source 0	0.5 U.L.	0.25 U.L.
$I_{1a} - I_{1d}$	Data Inputs from Source 1	0.5 U.L.	0.25 U.L.
$Z_a - Z_d$	Multiplexer Outputs (Note b)	10 U.L.	5 (2.5) U.L.

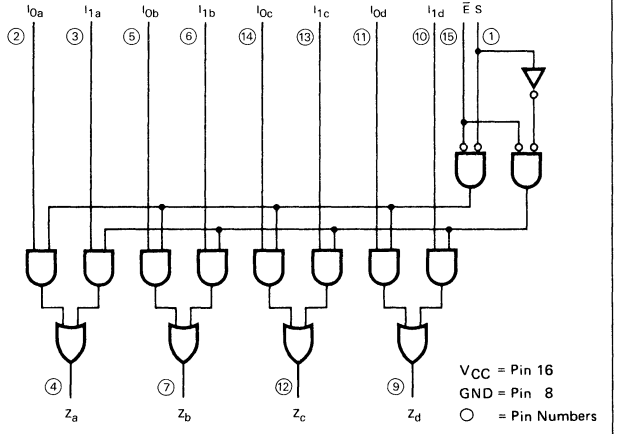
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL

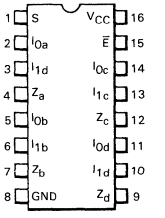


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS157 is a Quad 2-Input Multiplexer fabricated with the Schottky barrier diode process for high speed. It selects four bits of data from two sources under the control of a common Select Input (S). The Enable Input ($\overline{E}$) is active LOW. When $\overline{E}$ is HIGH, all of the outputs (Z) are forced LOW regardless of all other inputs.

The LS157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select Input. The logic equations for the outputs are shown below:

$$Z_a = \overline{E} \cdot (I_{1a} \cdot S + I_{0a} \cdot \overline{S}) \qquad Z_b = \overline{E} \cdot (I_{1b} \cdot S + I_{0b} \cdot \overline{S})$$

$$Z_c = \overline{E} \cdot (I_{1c} \cdot S + I_{0c} \cdot \overline{S}) \qquad Z_d = \overline{E} \cdot (I_{1d} \cdot S + I_{0d} \cdot \overline{S})$$

A common use of the LS157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select Input. A less obvious use is as a function generator. The LS157 can generate any four of the 16 different functions of two variables with one variable common. This is useful for implementing highly irregular logic.

TRUTH TABLE

ENABLE	SELECT INPUT	INPUTS		OUTPUT
$\overline{E}$	S	I_0	I_1	Z
H	X	X	X	L
L	H	X	L	L
L	H	X	H	H
L	L	L	X	L
L	L	H	X	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current I_0, I_1				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	$\overline{E}, S$				40		
	I_0, I_1				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
	$\overline{E}, S$				0.2		
I_{IL}	Input LOW Current I_0, I_1				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	$\overline{E}, S$				−0.8		
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				16	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay Data to Output		9.0 9.0	14 14	ns	Fig. 2	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Enable to Output		13 14	20 21	ns	Fig. 1	
t_{PLH} t_{PHL}	Propagation Delay Select to Output		15 18	23 27	ns	Fig. 2	

AC WAVEFORMS

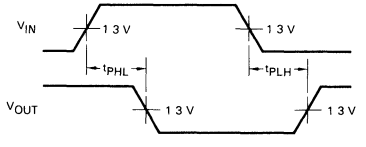


Fig. 1

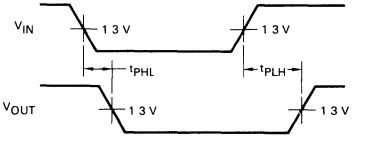


Fig. 2

MOTOROLA

SN54LS158
SN74LS158

QUAD 2-INPUT MULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS158 is a high speed Quad 2-Input Multiplexer. It selects four bits of data from two sources using the common Select and Enable inputs. The four buffered outputs present the selected data in the inverted form. The LS158 can also generate any four of the 16 different functions of two variables. The LS158 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

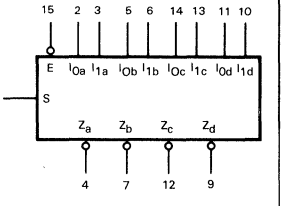
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **INVERTED OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S	Common Select Input	1.0 U.L.	0.5 U.L.
$\overline{E}$	Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
$I_{0a} - I_{0d}$	Data Inputs from Source 0	0.5 U.L.	0.25 U.L.
$I_{1a} - I_{1d}$	Data Inputs from Source 1	0.5 U.L.	0.25 U.L.
$\overline{Z}_a - \overline{Z}_d$	Inverted Outputs (Note b)	10 U.L.	5 (2.5) U.L.

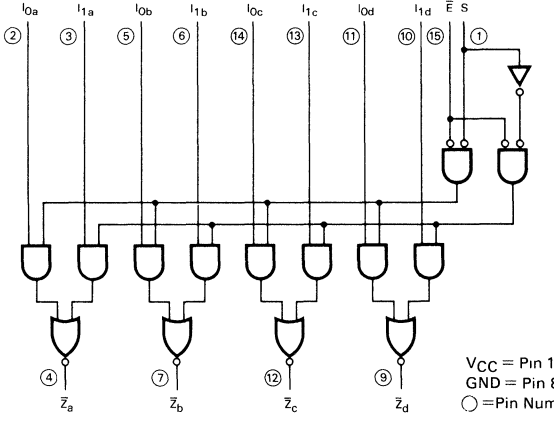
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



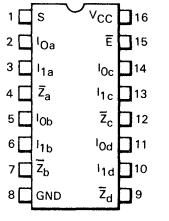
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS158 is a Quad 2-Input Multiplexer fabricated with the Schottky barrier diode process for high speed. It selects four bits of data from two sources under the control of a common Select Input (S) and presents the data in inverted form at the four outputs. The Enable Input ($\overline{E}$) is active LOW. When $\overline{E}$ is HIGH, all of the outputs ($\overline{Z}$) are forced HIGH regardless of all other inputs.

The LS158 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select Input.

A common use of the LS158 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select Input. A less obvious use is as a function generator. The LS158 can generate four functions of two variables with one variable common. This is useful for implementing gating functions.

TRUTH TABLE

ENABLE	SELECT INPUT	INPUTS		OUTPUT
$\overline{E}$	S	I_0	I_1	$\overline{Z}$
H	X	X	X	H
L	L	L	X	H
L	L	H	X	L
L	H	X	L	H
L	H	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current I_0, I_1				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	$\bar{E}, S$				40		
	I_0, I_1				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
	$\bar{E}, S$				0.2		
I_{IL}	Input LOW Current I_0, I_1				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	$\bar{E}, S$				−0.8		
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				8.0	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH}	Propagation Delay		7.0	12	ns	Fig. 2	V_{CC} = 5.0 V, C_L = 15 pF
t_{PHL}	Data to Output		10	15			
t_{PLH}	Propagation Delay		11	17	ns	Fig. 1	
t_{PHL}	Enable to Output		18	24			
t_{PLH}	Propagation Delay		13	20	ns	Fig. 2	
t_{PHL}	Select to Output		16	24			

AC WAVEFORMS

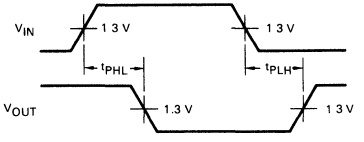


Fig. 1

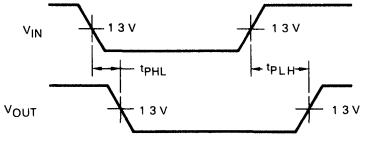


Fig. 2

MOTOROLA

SN54LS/74LS160A
SN54LS/74LS161A
SN54LS/74LS162A
SN54LS/74LS163A

BCD DECADE COUNTERS/ 4-BIT BINARY COUNTERS

LOW POWER SCHOTTKY

DESCRIPTION — The LS160A/161A/162A/163A are high-speed 4-bit synchronous counters. They are edge-triggered, synchronously presettable, and cascadable MSI building blocks for counting, memory addressing, frequency division and other applications. The LS160A and LS162A count modulo 10 (BCD). The LS161A and LS163A count modulo 16 (binary.)

The LS160A and LS161A have an asynchronous Master Reset (Clear) input that overrides, and is independent of, the clock and all other control inputs. The LS162A and LS163A have a Synchronous Reset (Clear) input that overrides all other control inputs, but is active only during the rising clock edge.

	BCD (Modulo 10)	Binary (Modulo 16)
Asynchronous Reset	LS160A	LS161A
Synchronous Reset	LS162A	LS163A

- **SYNCHRONOUS COUNTING AND LOADING**
- **TWO COUNT ENABLE INPUTS FOR HIGH SPEED SYNCHRONOUS EXPANSION**
- **TERMINAL COUNT FULLY DECODED**
- **EDGE-TRIGGERED OPERATION**
- **TYPICAL COUNT RATE OF 35 MHz**

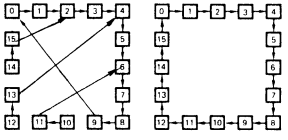
PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{PE}$	Parallel Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
P_0-P_3	Parallel Inputs	0.5 U.L.	0.25 U.L.
CEP	Count Enable Parallel Input	0.5 U.L.	0.25 U.L.
CET	Count Enable Trickle Input	1.0 U.L.	0.5 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$\overline{SR}$	Synchronous Reset (Active LOW) Input	1.0 U.L.	0.5 U.L.
Q_0-Q_3	Parallel Outputs (Note b)	10 U.L.	5 (2.5) U.L.
TC	Terminal Count Output (Note b)	10 U.L.	5 (2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commerical (74) Temperature Ranges.

STATE DIAGRAM

LS160A • LS162A **LS161A • LS163A**

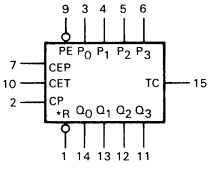


LOGIC EQUATIONS

Count Enable = CEP • CET • PE
TC for LS160A & LS162A = CET • Q_0 • $\overline{Q_1}$ • $\overline{Q_2}$ • Q_3
TC for LS161A & LS163A = CET • Q_0 • Q_1 • Q_2 • Q_3
Preset = $\overline{PE}$ • CP + (rising clock edge)
Reset = $\overline{MR}$ (LS160A & LS161A)
Reset = $\overline{SR}$ • CP + (rising clock edge) (LS162A & LS163A)

NOTE:
The LS160A and LS162A can be preset to any state, but will not count beyond 9. If preset to state 10, 11, 12, 13, 14, or 15, it will return to its normal sequence within two clock pulses.

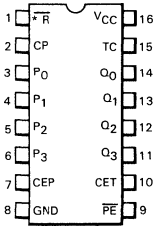
LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

*MR for LS160A and LS161A
*SR for LS162A and LS163A

CONNECTION DIAGRAMS
DIP (TOP VIEW)



*MR for LS160A and LS161A
*SR for LS162A and LS163A

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS160A/161A/162A/163A are 4-bit synchronous counters with a synchronous Parallel Enable (Load) feature. These counters consist of four edge-triggered D flip-flops with the appropriate data routing networks feeding the D inputs. All changes of the Q outputs (except due to the asynchronous Master Reset in the LS160A and LS161A) occur as a result of, and synchronous with, the LOW to HIGH transition of the Clock input (CP). As long as the set-up time requirements are met, there are no special timing or activity constraints on any of the mode control or data inputs.

Three control inputs — Parallel Enable ($\overline{PE}$), Count Enable Parallel (CEP) and Count Enable Trickle (CET) — select the mode of operation as shown in the tables below. The Count Mode is enabled when the CEP, CET, and $\overline{PE}$ inputs are HIGH. When the $\overline{PE}$ is LOW, the counters will synchronously load the data from the parallel inputs into the flip-flops on the LOW to HIGH transition of the clock. Either the CEP or CET can be used to inhibit the count sequence. With the $\overline{PE}$ held HIGH, a LOW on either the CEP or CET inputs at least one set-up time prior to the LOW to HIGH clock transition will cause the existing output states to be retained. The AND feature of the two Count Enable inputs (CET•CEP) allows synchronous cascading without external gating and without delay accumulation over any practical number of bits or digits.

The Terminal Count (TC) output is HIGH when the Count Enable Trickle (CET) input is HIGH while the counter is in its maximum count state (HLLH for the BCD counters, HHHH for the Binary counters). Note that TC is fully decoded and will, therefore, be HIGH only for one count state.

The LS160A and LS162A count modulo 10 following a binary coded decimal (BCD) sequence. They generate a TC output when the CET input is HIGH while the counter is in state 9 (HLLH). From this state they increment to state 0 (LLLL). If loaded with a code in excess of 9 they return to their legitimate sequence within two counts, as explained in the state diagram. States 10 through 15 do *not* generate a TC output.

The LS161A and LS163A count modulo 16 following a binary sequence. They generate a TC when the CET input is HIGH while the counter is in state 15 (HHHH). From this state they increment to state 0 (LLLL).

The Master Reset ($\overline{MR}$) of the LS160A and LS161A is asynchronous. When the $\overline{MR}$ is LOW, it overrides all other input conditions and sets the outputs LOW. The $\overline{MR}$ pin should never be left open. If not used, the $\overline{MR}$ pin should be tied through a resistor to V_{CC}, or to a gate output which is permanently set to a HIGH logic level.

The active LOW Synchronous Reset ($\overline{SR}$) input of the LS162A and LS163A acts as an edge-triggered control input, overriding CET, CEP and $\overline{PE}$, and resetting the four counter flip-flops on the LOW to HIGH transition of the clock. This simplifies the design from race-free logic controlled reset circuits, e.g., to reset the counter synchronously after reaching a predetermined value.

MODE SELECT TABLE

*$\overline{SR}$	$\overline{PE}$	CET	CEP	Action on the Rising Clock Edge (⌐)
L	X	X	X	RESET (Clear)
H	L	X	X	LOAD ($P_n \rightarrow Q_n$)
H	H	H	H	COUNT (Increment)
H	H	L	X	NO CHANGE (Hold)
H	H	X	L	NO CHANGE (Hold)

*For the LS162A and LS163A only.
H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current $\overline{MR}$, Data, CEP, Clock $\overline{PE}$, CET				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	$\overline{MR}$, Data, CEP, Clock $\overline{PE}$, CET				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current $\overline{MR}$, Data, CEP, Clock $\overline{PE}$, CET				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH Total, Output LOW				31 32	mA	V_{CC} = MAX	

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current Data, CEP, Clock $\overline{PE}$, CET, $\overline{SR}$				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Data, CEP, Clock $\overline{PE}$, CET, $\overline{SR}$				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Data, CEP, Clock $\overline{PE}$, CET, $\overline{SR}$				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH Total, Output LOW				31 32	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	32		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay Clock to TC		20 18	35 35	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to Q		13 18	24 27	ns	
t_{PLH} t_{PHL}	Propagation Delay CET to TC		9.0 9.0	14 14	ns	
t_{PHL}	$\overline{MR}$ or $\overline{SR}$ to Q		20	28	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
$t_W CP$	Clock Pulse Width Low	25			ns	$V_{CC} = 5.0$ V
t_W	$\overline{MR}$ or $\overline{SR}$ Pulse Width	20			ns	
t_s	Setup Time, other*	20			ns	
t_s	Setup Time $\overline{PE}$ or $\overline{SR}$	25			ns	
t_h	Hold Time, Any Input	0			ns	

*CEP, CET or DATA

DEFINITION OF TERMS:

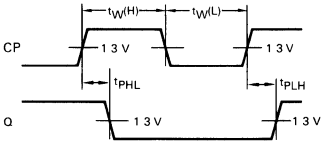
SETUP TIME (t_s) – is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) – is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

RECOVERY TIME (t_{rec}) – is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW to HIGH in order to recognize and transfer HIGH Data to the Q outputs.

AC WAVEFORMS

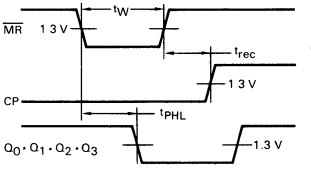
CLOCK TO OUTPUT DELAYS, COUNT FREQUENCY, AND CLOCK PULSE WIDTH.



Other Conditions:
$\overline{PE} = \overline{MR}\ (\overline{SR}) = H$
CEP = CET = H

Fig. 1

MASTER RESET TO OUTPUT DELAY, MASTER RESET PULSE WIDTH, AND MASTER RESET RECOVERY TIME.



Other Conditions:
$\overline{PE} = L$
$P_0 = P_1 = P_2 = P_3 = H$

Fig. 2

AC WAVEFORMS (Cont'd)

COUNT ENABLE TRICKLE INPUT TO TERMINAL COUNT OUTPUT DELAYS

The positive TC pulse occurs when the outputs are in the ($Q_0 \bullet \overline{Q_1} \bullet \overline{Q_2} \bullet Q_3$) state for the LS160 and LS162 and the ($Q_0 \bullet Q_1 \bullet Q_2 \bullet Q_3$) state for the LS161 and LS163.

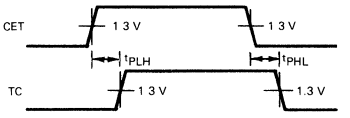


Fig. 3

Other Conditions: CP = $\overline{PE}$ = CEP = $\overline{MR}$ = H

CLOCK TO TERMINAL COUNT DELAYS.

The positive TC pulse is coincident with the output state ($Q_0 \bullet \overline{Q_1} \bullet \overline{Q_2} \bullet Q_3$) for the LS161 and LS163 and ($Q_0 \bullet Q_1 \bullet Q_2 \bullet Q_3$) for the LS161 and LS163.

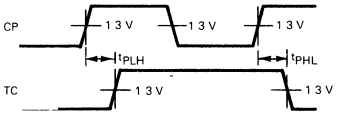


Fig. 4

Other Conditions: $\overline{PE}$ = CEP = CET = $\overline{MR}$ = H

SETUP TIME (t_s) AND HOLD TIME (t_h) FOR PARALLEL DATA INPUTS.

The shaded areas indicate when the input is permitted to change for predictable output performance.

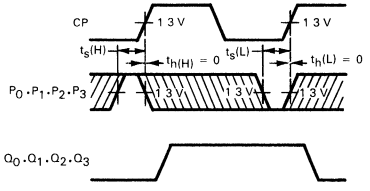


Fig. 5

Other Conditions: $\overline{PE}$ = L, $\overline{MR}$ = H

SETUP TIME (t_s) AND HOLD TIME (t_h) FOR COUNT ENABLE (CEP) AND (CET) AND PARALLEL ENABLE ($\overline{PE}$) INPUTS.

The shaded areas indicate when the input is permitted to change for predictable output performance.

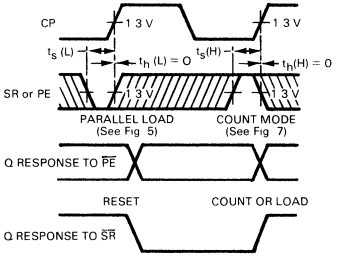
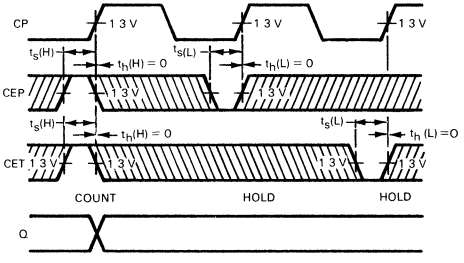


Fig. 6



Other Conditions: $\overline{PE}$ = H, $\overline{MR}$ = H

Fig. 7

MOTOROLA

SN54LS164
SN74LS164

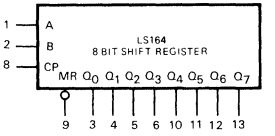
SERIAL-IN PARALLEL-OUT SHIFT REGISTER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS164 is a high speed 8-Bit Serial-In Parallel-Out Shift Register. Serial data is entered through a 2-Input AND gate synchronous with the LOW to HIGH transition of the clock. The device features an asynchronous Master Reset which clears the register setting all outputs LOW independent of the clock. It utilizes the Schottky diode clamped process to achieve high speeds and is fully compatible with all Motorola TTL products.

- **TYPICAL SHIFT FREQUENCY OF 35 MHz**
- **ASYNCHRONOUS MASTER RESET**
- **GATED SERIAL DATA INPUT**
- **FULLY SYNCHRONOUS DATA TRANSFERS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

LOGIC SYMBOL



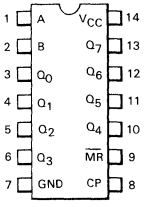
V_{CC} = Pin 14
GND = Pin 7

PIN NAMES

		LOADING (Note a) HIGH	LOW
A, B	Data Inputs	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_7$	Outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

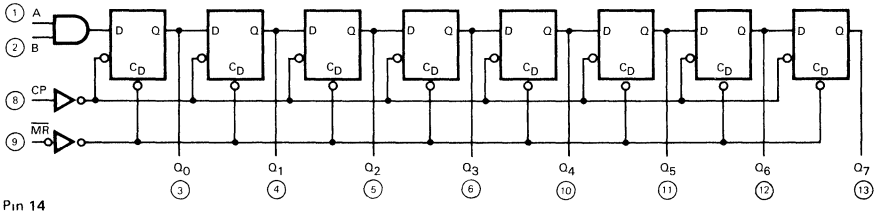
CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAM



V_{CC} = Pin 14
GND = Pin 7
○ = Pin Numbers

4

FUNCTIONAL DESCRIPTION — The LS164 is an edge-triggered 8-bit shift register with serial data entry and an output from each of the eight stages. Data is entered serially through one of two inputs (A or B); either of these inputs can be used as an active HIGH Enable for data entry through the other input. An unused input must be tied HIGH, or both inputs connected together.

Each LOW-to-HIGH transition on the Clock (CP) input shifts data one place to the right and enters into Q_0 the logical AND of the two data inputs (A•B) that existed before the rising clock edge. A LOW level on the Master Reset ($\overline{MR}$) input overrides all other inputs and clears the register asynchronously, forcing all Q outputs LOW.

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS			OUTPUTS	
	$\overline{MR}$	A	B	Q_0	$Q_1 - Q_7$
Reset (Clear)	L	X	X	L	L – L
Shift	H	l	l	L	$q_0 - q_6$
	H	l	h	L	$q_0 - q_6$
	H	h	l	L	$q_0 - q_6$
	H	h	h	H	$q_0 - q_6$

L (l) = LOW Voltage Levels
H (h) = HIGH Voltage Levels
X = Don't Care
q_n = Lower case letters indicate the state of the referenced input or output one set-up time prior to the LOW to HIGH clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	–55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			–0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				27	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	25	36		MHz	V_{CC} = 5 V, C_L = 15 pF
t_{PHL}	Propagation Delay $\overline{MR}$ to Output Q		24	36	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to Output Q		17 21	27 32	ns	

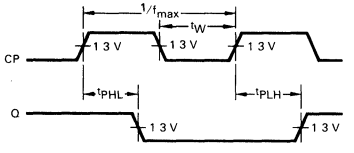
AC SETUP REQUIREMENTS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	CP, $\overline{MR}$ Pulse Width	20			ns	V_{CC} = 5 V
t_s	Data Setup Time	15			ns	
t_h	Data Hold Time	5.0			ns	

AC WAVEFORMS

*The shaded areas indicate when the input is permitted to change for predictable output performance

CLOCK TO OUTPUT DELAYS AND CLOCK PULSE WIDTH



CONDITIONS: $\overline{MR}$ = H

Fig. 1

MASTER RESET PULSE WIDTH, MASTER RESET TO OUTPUT DELAY AND MASTER RESET TO CLOCK RECOVERY TIME

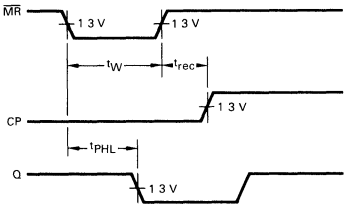


Fig. 2

4

DATA SETUP AND HOLD TIMES

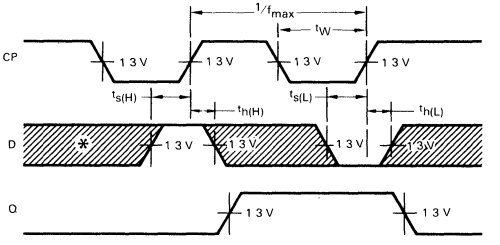


Fig. 3

MOTOROLA

SN54LS165
SN74LS165

8-BIT PARALLEL-TO-SERIAL CONVERTER

LOW POWER SCHOTTKY

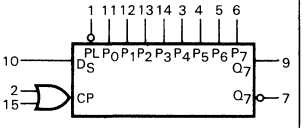
DESCRIPTION — The SN54LS/74LS165 is an 8-bit parallel load or serial-in register with complementary outputs available from the last stage. Parallel inputing occurs asynchronously when the Parallel Load ($\overline{PL}$) input is LOW. With $\overline{PL}$ HIGH, serial shifting occurs on the rising edge of the clock; new data enters via the Serial Data (DS) input. The 2-input OR clock can be used to combine two independent clock sources, or one input can act as an active LOW clock enable.

PIN NAMES

		LOADING (Note a) HIGH	LOW
CP_1, CP_2	Clock (LOW-to-HIGH Going Edge) Inputs	0.5 U.L.	0.25 U.L.
$\overline{DS}$	Serial Data Input	0.5 U.L.	0.25 U.L.
$\overline{PL}$	Asynchronous Parallel Load (Active LOW) Input	1.5 U.L.	0.75 U.L.
P_0-P_7	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
Q_7	Serial Output from Last State (Note b)	10 U.L.	5 (2.5) U.L.
$\overline{Q}_7$	Complementary Output (Note b)	10 U.L.	5 (2.5) U.L.

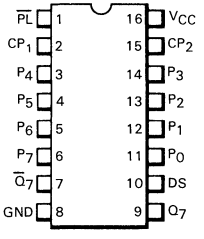
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

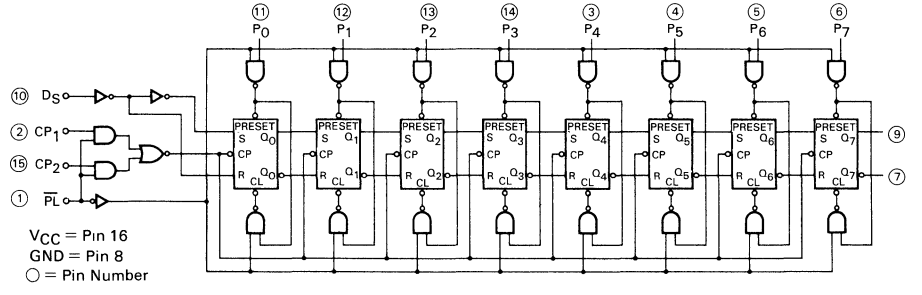
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

TRUTH TABLE

$\overline{PL}$	CP 1	CP 2	CONTENTS Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	$\overline{Q}_7$	RESPONSE
L	X	X	P_0	P_1	P_2	P_3	P_4	P_5	P_6	P_7	Parallel Entry
H	L	↓	D_S	Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	Right Shift
H	H	↓	Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	Q_7	No Change
H	↓	L	D_S	Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	Right Shift
H	↓	H	Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	Q_7	No Change

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Number

FUNCTIONAL DESCRIPTION — The SN54LS/74LS165 contains eight clocked master/slave RS flip-flops connected as a shift register, with auxiliary gating to provide overriding asynchronous parallel entry. Parallel data enters when the $\overline{PL}$ signal is LOW. The parallel data can change while $\overline{PL}$ is LOW, provided that the recommended setup and hold times are observed.

For clock operation, $\overline{PL}$ must be HIGH. The two clock inputs perform identically; one can be used as a clock inhibit by applying a HIGH signal. To avoid double clocking, however, the inhibit signal should only go HIGH while the clock is HIGH. Otherwise, the rising inhibit signal will cause the same response as a rising clock edge. The flip-flops are edge-triggered for serial operations. The serial input data can change at any time, provided only that the recommended setup and hold times are observed, with respect to the rising edge of the clock.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current Other Inputs $\overline{PL}$ Input				20 60	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	Other Inputs $\overline{PL}$ Input				0.1 0.3	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current Other Inputs $\overline{PL}$ Input				−0.4 −1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				36	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Input Clock Frequency	25	35		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay $\overline{PL}$ to Output		22 22	35 35	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to Output		27 28	40 40	ns	
t_{PLH} t_{PHL}	Propagation Delay P_7 to Q_7		14 21	25 30	ns	
t_{PLH} t_{PHL}	Propagation Delay P_7 to $\overline{Q}_7$		21 16	30 25	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	CP Clock Pulse Width	25			ns	$V_{CC} = 5.0$ V
t_W	$\overline{PL}$ Pulse Width	15			ns	
t_S	Parallel Data Setup Time	10			ns	
t_S	Serial Data Setup Time	20			ns	
t_S	CP_1 to CP_2 Setup Time①	30			ns	
t_h	Hold Time	0			ns	
t_{rec}	Recovery Time, $\overline{PL}$ to CP	45			ns	

① The role of CP_1, and CP_2 in an application may be interchanged

DEFINITION OF TERMS

SETUP TIME (t_S) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition A negative hold time indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized

RECOVERY TIME (t_{rec}) — is defined as the minimum time required between the end of the $\overline{PL}$ pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer loaded Data to the Q outputs.

AC WAVEFORMS

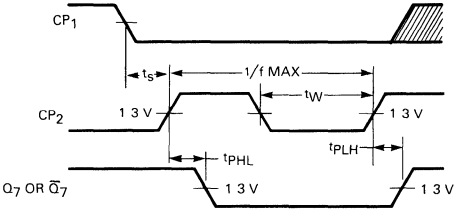


Fig.1

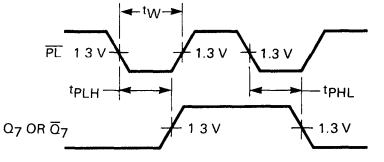


Fig. 2

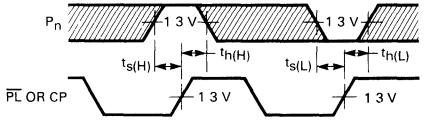


Fig. 3

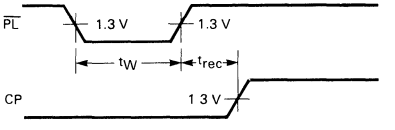


Fig. 4

MOTOROLA

SN54LS166
SN74LS166

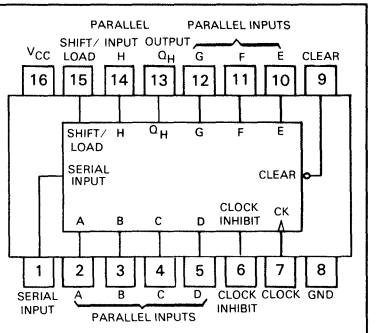
8-BIT SHIFT REGISTERS

LOW POWER SCHOTTKY

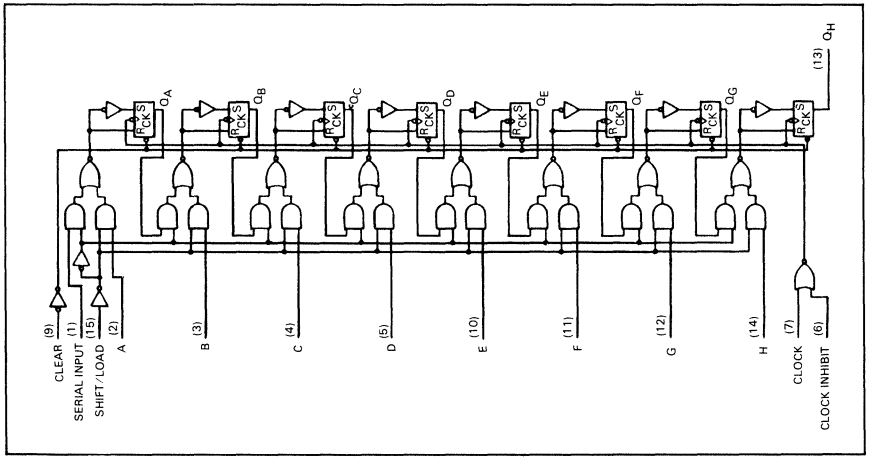
DESCRIPTION — The SN54LS/74LS166 is an 8-Bit Shift Register. Designed with all inputs buffered, the drive requirements are lowered to one 54LS/74LS standard load. By utilizing input clamping diodes, switching transients are minimized and system design simplified.

The LS166 is a parallel-in or serial-in, serial-out shift register and has a complexity of 77 equivalent gates with gated clock inputs and an overriding clear input. The shift/load input establishes the parallel-in or serial-in mode. When high, this input enables the serial data input and couples the eight flip-flops for serial shifting with each clock pulse. Synchronous loading occurs on the next clock pulse when this is low and the parallel data inputs are enabled. Serial data flow is inhibited during parallel loading. Clocking is done on the low-to-high level edge of the clock pulse via a two input positive NOR gate, which permits one input to be used as a clock enable or clock inhibit function. Clocking is inhibited when either of the clock inputs are held high, holding either input low enables the other clock input. This will allow the system clock to be free running and the register stopped on command with the other clock input. A change from low-to-high on the clock inhibit input should only be done when the clock input is high. A buffered direct clear input overrides all other inputs, including the clock, and sets all flip-flops to zero.

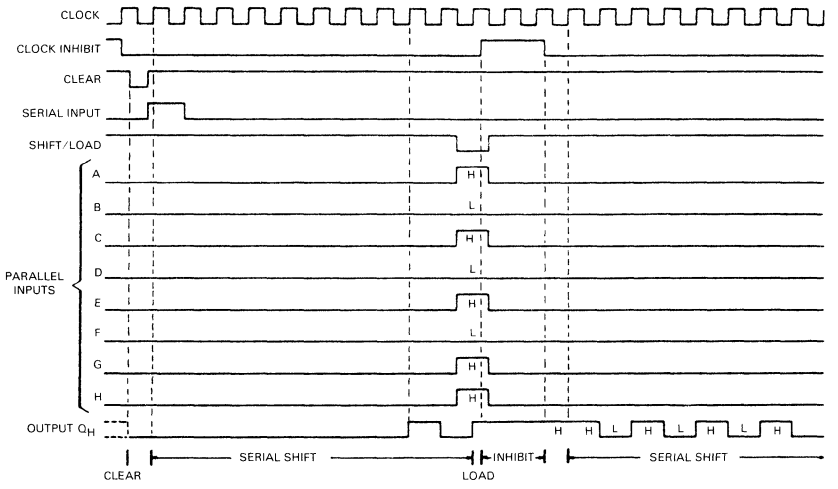
- **SYNCHRONOUS LOAD**
- **DIRECT OVERRIDING CLEAR**
- **PARALLEL TO SERIAL CONVERSION**



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)



Typical Clear, Shift, Load, Inhibit, and Shift Sequences



FUNCTION TABLE

INPUTS						INTERNAL OUTPUTS		OUTPUT
CLEAR	SHIFT/ LOAD	CLOCK INHIBIT	CLOCK	SERIAL	PARALLEL A . . . H	Q_A	Q_B	Q_H
L	X	X	X	X	X	L	L	L
H	X	L	L	X	X	Q_{A0}	Q_{B0}	Q_{H0}
H	L	L	↑	X	a . . . h	a	b	h
H	H	L	↑	H	X	H	Q_{An}	Q_{Gn}
H	H	L	↑	L	X	L	Q_{An}	Q_{Gn}
H	X	H	↑	X	X	Q_{A0}	Q_{B0}	Q_{H0}

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

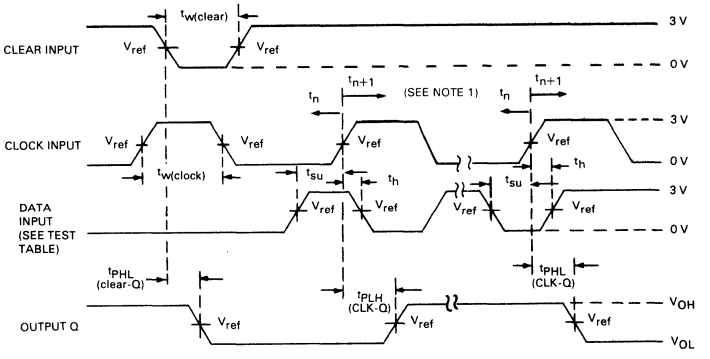
DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				38	mA	V_{CC} = MAX	

AC WAVEFORMS

TEST TABLE FOR SYNCHRONOUS INPUTS

DATA INPUT FOR TEST	SHIFT/LOAD	OUTPUT TESTED
H	0 V	Q_H at t_{n+1}
Serial Input	4.5 V	Q_H at t_{n+8}



Note 1 t_n = bit time before clocking transition
t_{n+1} = bit time after one clocking transition
t_{n+8} = bit time after eight clocking transitions
LS166 V_{ref} = 1.3 V.

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	25	35		MHz	$V_{CC} = 5.0$ V, $C_L = 15$ pF
t_{PHL}	Clear to Output		19	30	ns	
t_{PLH} t_{PHL}	Clock to Output		23 24	35 35	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Clear Pulse Width	30			ns	$V_{CC} = 5.0$ V
t_s	Mode Control Setup Time	30			ns	
t_s	Data Setup Time	20			ns	
t_h	Hold Time, Any Input	15			ns	

MOTOROLA

SN54LS/74LS168A
SN54LS/74LS169A

BCD DECADE/MODULO 16 BINARY SYNCHRONOUS BI-DIRECTIONAL COUNTERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS168A and SN54LS/74LS169A are fully synchronous 4-stage up/down counters featuring a preset capability for programmable operation, carry lookahead for easy cascading and a U/$\overline{D}$ input to control the direction of counting. The SN54LS/74LS168A counts in a BCD decade (8, 4, 2, 1) sequence, while the SN54LS/74LS169A operates in a Modulo 16 binary sequence. All state changes, whether in counting or parallel loading, are initiated by the LOW-to-HIGH transition of the clock.

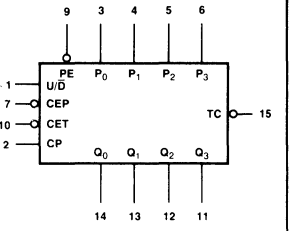
- LOW POWER DISSIPATION 100 mW TYPICAL
- HIGH-SPEED COUNT FREQUENCY 30 MHz TYPICAL
- FULLY SYNCHRONOUS OPERATION
- FULL CARRY LOOKAHEAD FOR EASY CASCADING
- SINGLE UP/DOWN CONTROL INPUT
- POSITIVE EDGE-TRIGGER OPERATION
- INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{CEP}$	Count Enable Parallel (Active LOW) Input	0.5 U.L.	0.25 U.L.
$\overline{CET}$	Count Enable Trickle (Active LOW) Input	1.0 U.L.	0.5 U.L.
$\overline{CP}$	Clock Pulse (Active positive going edge) Input	0.5 U.L.	0.25 U.L.
$\overline{PE}$	Parallel Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
U/$\overline{D}$	Up-Down Count Control Input	0.5 U.L.	0.25 U.L.
P_0-P_3	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
Q_0-Q_3	Flip-Flop Outputs	10 U.L.	5 (2.5) U.L.
$\overline{TC}$	Terminal Count (Active LOW) Output	10 U.L.	5 (2.5) U.L.

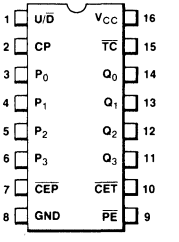
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)

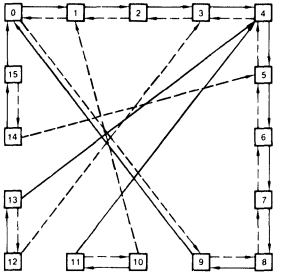


J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

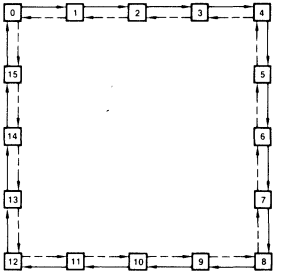
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

STATE DIAGRAMS

SN54LS/74LS168A
UP/DOWN DECADE COUNTER



SN54LS/74LS169A



SN54LS/74LS168A

UP $TC = Q_0 \cdot \overline{Q_3} \cdot (U/\overline{D})$
DOWN $TC = \overline{Q_0} \cdot \overline{Q_1} \cdot \overline{Q_2} \cdot \overline{Q_3} \cdot (U/\overline{D})$

——→ Count Up
— — → Count Down

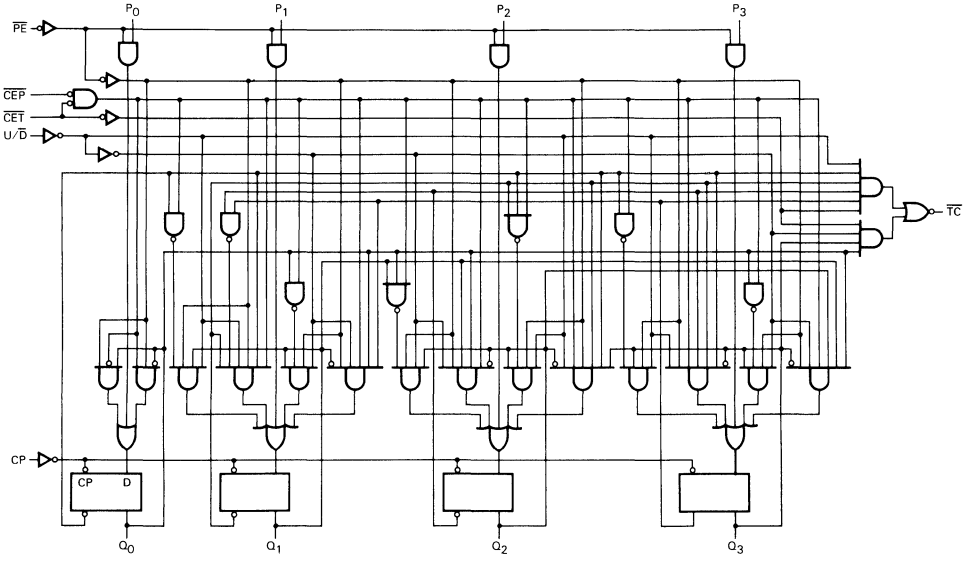
SN54LS/74LS169A

UP $TC = Q_0 \cdot Q_1 \cdot Q_2 \cdot Q_3 \cdot (U/\overline{D})$
DOWN: $TC = \overline{Q_0} \cdot \overline{Q_1} \cdot \overline{Q_2} \cdot \overline{Q_3} \cdot (U/\overline{D})$

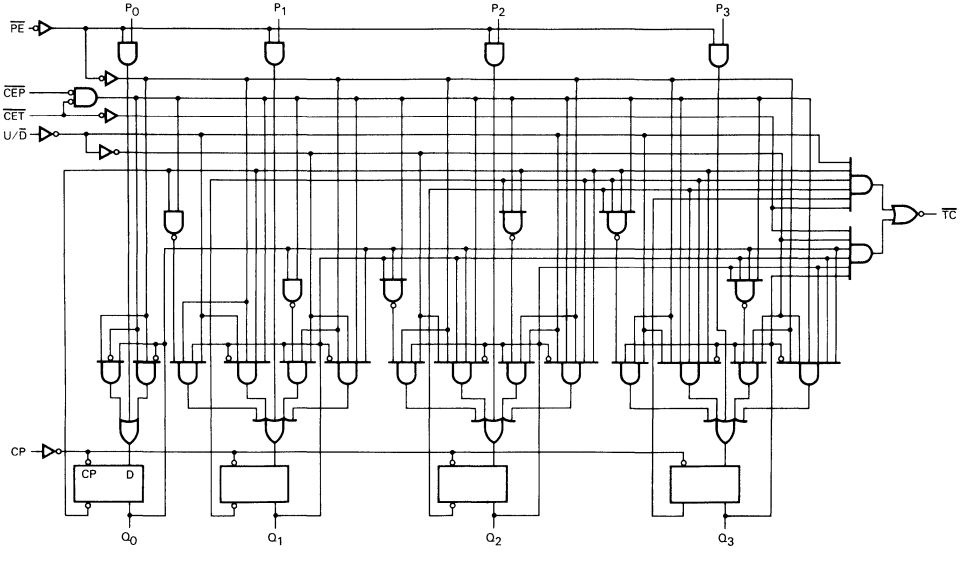
4

LOGIC DIAGRAMS

SN54LS/74LS168A



SN54LS/74LS169A



4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current Other Inputs $\overline{CET}$ Input				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Other Input $\overline{CET}$ Input				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Other Input $\overline{CET}$ Input				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				34	mA	V_{CC} = MAX

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS168A and SN54LS/74LS169A use edge-triggered D-type flip-flops and that have no constraints on changing the control or data input signals in either state of the Clock. The only requirement is that the various inputs attain the desired state at least a set-up time before the rising edge of the clock and remain valid for the recommended hold time thereafter.

The parallel load operation takes precedence over the other operations, as indicated in the Mode Select Table. When $\overline{PE}$ is LOW, the data on the P_0-P_3 inputs enters the flip-flops on the next rising edge of the Clock. In order for counting to occur, both $\overline{CEP}$ and $\overline{CET}$ must be LOW and $\overline{PE}$ must be HIGH. The U/$\overline{D}$ input then determines the direction of counting.

The Terminal Count ($\overline{TC}$) output is normally HIGH and goes LOW, provided that $\overline{CET}$ is LOW, when a counter reaches zero in the COUNT DOWN mode or reaches 15 (9 for the SN54LS/74LS168A) in the COUNT UP mode. The $\overline{TC}$ output state is not a function of the Count Enable Parallel ($\overline{CEP}$) input level. The $\overline{TC}$ output of the SN54LS/74LS168A decade counter can also be LOW in the illegal states 11, 13 and 15, which can occur when power is turned on or via parallel loading. If an illegal state occurs, the SN54LS/74LS168A will return to the legitimate sequence within two counts. Since the $\overline{TC}$ signal is derived by decoding the flip-flop states, there exists the possibility of decoding spikes on $\overline{TC}$. For this reason the use of $\overline{TC}$ as a clock signal is not recommended.

MODE SELECT TABLE

$\overline{PE}$	$\overline{CEP}$	$\overline{CET}$	U/$\overline{D}$	Action on Rising Clock Edge
L	X	X	X	Load (Pn→Qn)
H	L	L	H	Count Up (increment)
H	L	L	L	Count Down (decrement)
H	H	X	X	No Change (Hold)
H	X	H	X	No Change (Hold)

H = HIGH Voltage Level
L = LOW Voltage Level
X = immaterial

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	25	32		MHz	$V_{CC} = 5.0$ V, $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay, Clock to $\overline{TC}$		23 23	35 35	ns	
t_{PLH} t_{PHL}	Propagation Delay, Clock to any Q		13 15	20 23	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CET}$ to $\overline{TC}$		15 15	20 20	ns	
t_{PLH} t_{PHL}	Propagation Delay, U/$\overline{D}$ to $\overline{TC}$		17 19	25 29	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$,

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width	25			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, Data or Enable	20			ns	
t_s	Setup Time $\overline{PE}$	25			ns	
t_s	Setup Time U/$\overline{D}$	30			ns	
t_h	Hold Time Any Input	0			ns	

AC WAVEFORMS

CLOCK TO OUTPUT DELAYS, COUNT FREQUENCY, AND CLOCK PULSE WIDTH.

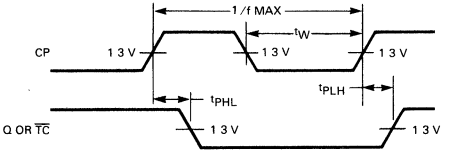


Fig. 1

COUNT ENABLE TRICKLE INPUT TO TERMINAL COUNT OUTPUT DELAYS

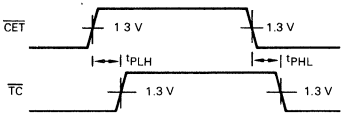


Fig. 2

CLOCK TO TERMINAL DELAYS

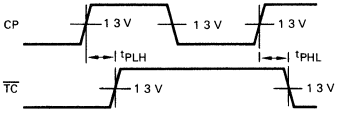


Fig. 3

SETUP TIME (t_s) AND HOLD (t_h) FOR PARALLEL DATA INPUTS.

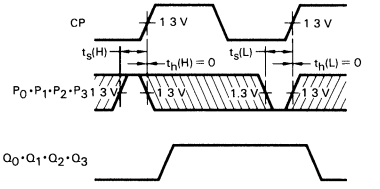
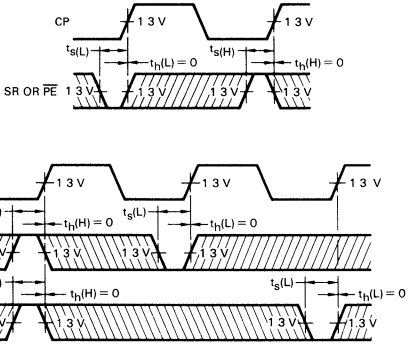


Fig. 4

SETUP TIME AND HOLD TIME FOR COUNT ENABLE AND PARALLEL ENABLE INPUTS, AND UP-DOWN CONTROL INPUTS



The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 5

UP-DOWN INPUT TO TERMINAL COUNT OUTPUT DELAYS

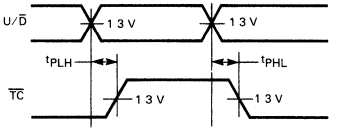


Fig. 6

MOTOROLA

SN54LS170
SN74LS170

4 x 4 REGISTER FILE OPEN-COLLECTOR

LOW POWER SCHOTTKY

DESCRIPTION — The TTL/MSI SN54LS/74LS170 is a high-speed, low-power 4 x 4 Register File organized as four words by four bits. Separate read and write inputs, both address and enable, allow simultaneous read and write operation.

Open-collector outputs make it possible to connect up to 128 outputs in a wired-AND configuration to increase the word capacity up to 512 words. Any number of these devices can be operated in parallel to generate an n-bit length.

The SN54LS/74LS670 provides a similar function to this device but it features 3-state outputs.

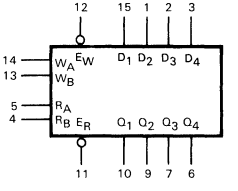
- **SIMULTANEOUS READ/WRITE OPERATION**
- **EXPANDABLE TO 512 WORDS OF n-BITS**
- **TYPICAL ACCESS TIME OF 20 ns**
- **LOW LEAKAGE OPEN-COLLECTOR OUTPUTS FOR EXPANSION**
- **TYPICAL POWER DISSIPATION OF 125 mW**

PIN NAMES

		LOADING (Note a) HIGH	LOW
D_1-D_4	Data Inputs	0.5 U.L.	0.25 U.L.
W_A, W_B	Write Address Inputs	0.5 U.L.	0.25 U.L.
$\bar{E}_W$	Write Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
R_A, R_B	Read Address Inputs	0.5 U.L.	0.25 U.L.
$\bar{E}_R$	Read Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
Q_1-Q_4	Outputs (Note b)	Open-Collector	5(2.5)U.L.

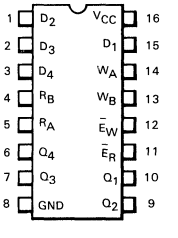
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5.0 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive must be supplied by an external resistor to V_{CC}.

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)

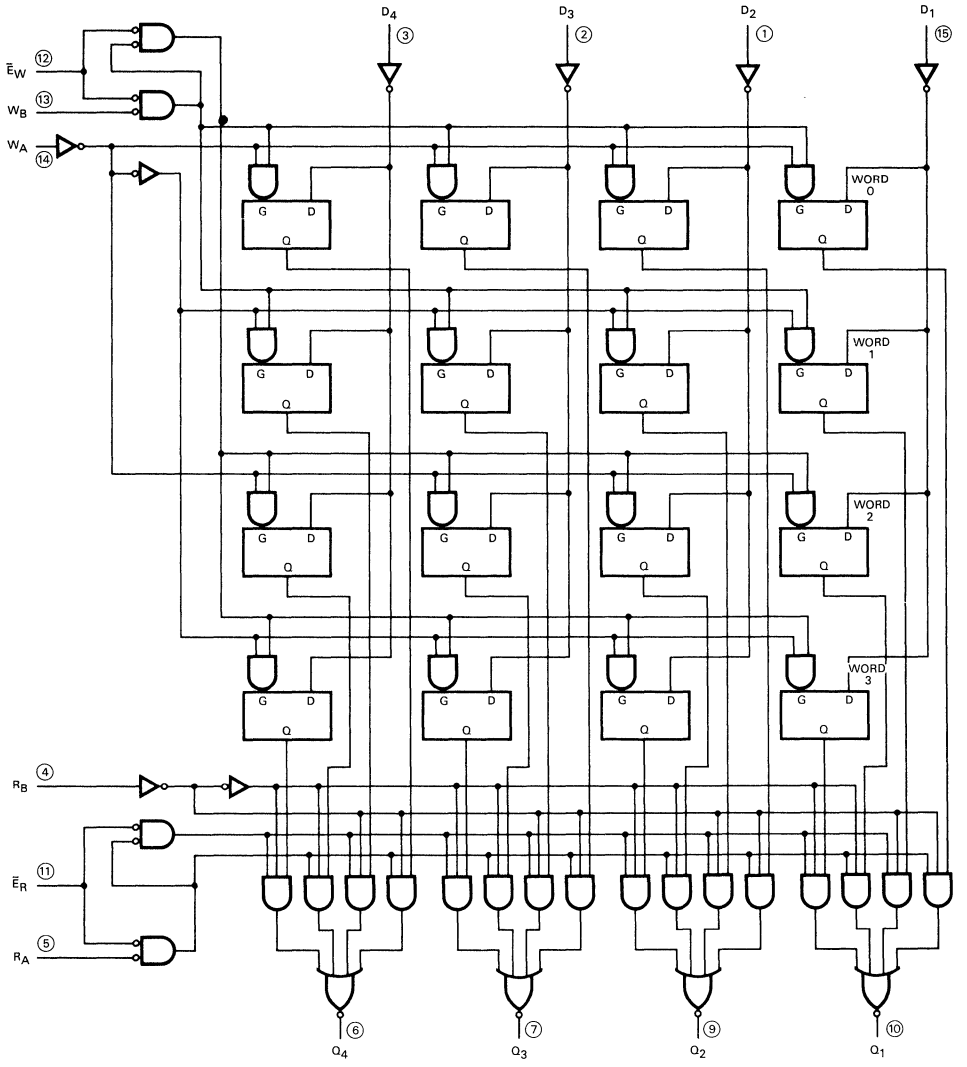


J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯=Pin Numbers

WRITE FUNCTION TABLE (SEE NOTES A, B, AND C)

WRITE INPUTS			WORD			
W_B	W_A	$\overline{E}_W$	0	1	2	3
L	L	L	Q = D	Q_0	Q_0	Q_0
L	H	L	Q_0	Q = D	Q_0	Q_0
H	L	L	Q_0	Q_0	Q = D	Q_0
H	H	L	Q_0	Q_0	Q_0	Q = D
X	X	H	Q_0	Q_0	Q_0	Q_0

READ FUNCTION TABLE (SEE NOTES A AND D)

READ INPUTS			OUTPUTS			
R_B	R_A	$\overline{E}_R$	Q1	Q2	Q3	Q4
L	L	L	W0B1	W0B2	W0B3	W0B4
L	H	L	W1B1	W1B2	W1B3	W1B4
H	L	L	W2B1	W2B2	W2B3	W2B4
H	H	L	W3B1	W3B2	W3B3	W3B4
X	X	H	H	H	H	H

NOTES A H = high level L = low level, X = irreleveant
B (Q = D) = The four selected internal flip-flop outputs will assume the states applied to the four external data inputs
C Q_0 = the level of Q before the indicated input conditions were established
D W0B1 = The first bit of word 0, etc

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4 75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54 , 74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0 65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output High Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0 25	0 4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC}MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0 5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current Any D, R, W $\overline{E}_R$, $\overline{E}_W$				20 40	μA	V_{CC} = MAX, V_{IN} = 2.4 V	
	Any D, R, W $\overline{E}_R$, $\overline{E}_W$				0.1 0 2	mA	V_{CC} = MAX, V_{IN} = 7 0 V	
I_{IL}	Input LOW Current Any D, R, W $\overline{E}_R$, $\overline{E}_W$				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current				40	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
t_{PLH} t_{PHL}	Propagation Delay, Negative-Going $\overline{E}_R$ to Q Outputs		20 20	30 30	ns	Fig. 1	$V_{CC} = 5$ V $C_L = 15$ pF $R_L = 2$ kΩ
t_{PLH} t_{PHL}	Propagation Delay, R_A or R_B to Q Outputs		25 24	40 40	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay, Negative-Going $\overline{E}_W$ to Q Outputs		30 26	45 40	ns	Fig. 1	
t_{PLH} t_{PHL}	Propagation Delay, Data Inputs to Q Outputs		30 22	45 35	ns	Fig. 1	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Pulse Width, $\overline{E}_R$, $\overline{E}_W$	25			ns	$V_{CC} = 5$ V $R_L = 2$ kΩ
t_s	Setup Time, Data to $\overline{E}_W$	10			ns	
t_s	Setup Time, W_A, W_B to $\overline{E}_W$	15			ns	
t_h	Hold Time, Data to $\overline{E}_W$	15			ns	
t_h	Hold Time, W_A, W_B to $\overline{E}_W$	5.0			ns	
t_{LATCH}	Latch Time	25			ns	

4

VOLTAGE WAVEFORMS

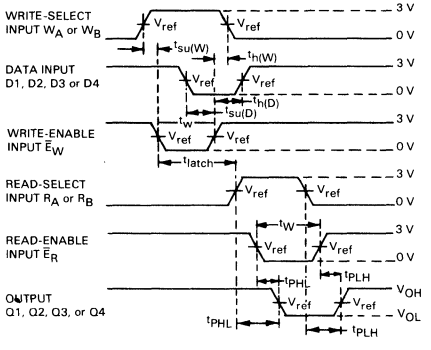


Fig. 1

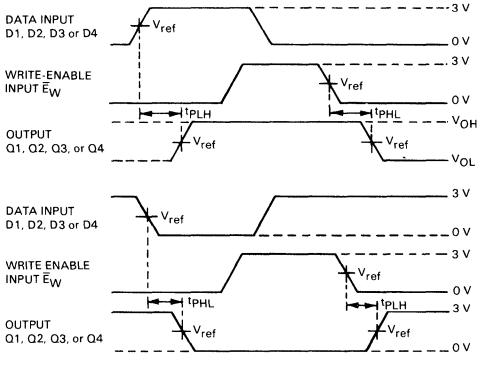


Fig. 2

MOTOROLA

SN54LS173A
SN74LS173A

4-BIT D-TYPE REGISTER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS173A is a high-speed 4-Bit Register featuring 3-state outputs for use in bus-organized systems. The clock is fully edge-triggered allowing either a load from the D inputs or a hold (retain register contents) depending on the state of the Input Enable Lines ($\overline{IE}_1$, $\overline{IE}_2$). A HIGH on either Output Enable line ($\overline{OE}_1$, $\overline{OE}_2$) brings the output to a high impedence state without affecting the actual register contents. A HIGH on the Master Reset (MR) input resets the Register regardless of the state of the Clock (CP), the Output Enable ($\overline{OE}_1$, $\overline{OE}_2$) or the Input Enable ($\overline{IE}_1$, $\overline{IE}_2$) lines.

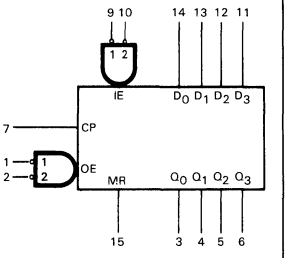
- **FULLY EDGE-TRIGGERED**
- **3-STATE OUTPUTS**
- **GATED INPUT AND OUTPUT ENABLES**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
D_0-D_3	Data Inputs	0.5 U.L.	0.25 U.L.
$\overline{IE}_1$-$\overline{IE}_2$	Input Enable (Active LOW)	0.5 U.L.	0.25 U.L.
$\overline{OE}_1$-$\overline{OE}_2$	Output Enable (Active LOW) Inputs	0.5 U.L.	0.25 U.L.
CP	Clock Pulse (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
MR	Master Reset input (Active HIGH)	0.5 U.L.	0.25 U.L.
Q_0-Q_3	Outputs (Note b)	65(25)U.L.	15(7.5)U.L.

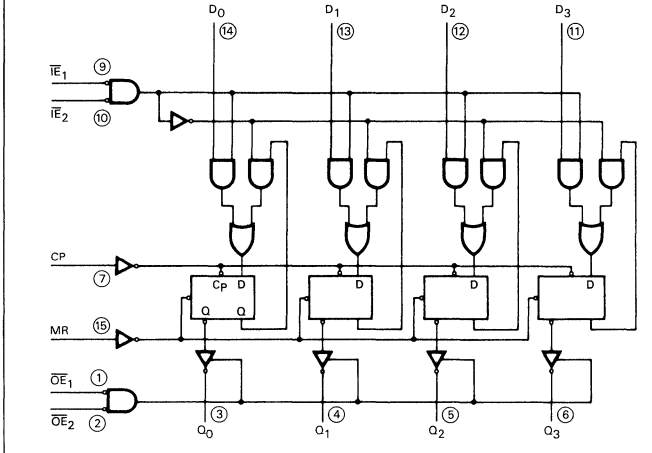
NOTES:
a 1 TTL Unit Load (U L) = 40 μA HIGH/1 6 mA LOW.
b The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U L for Commercial (74) Temperature Ranges

LOGIC SYMBOL



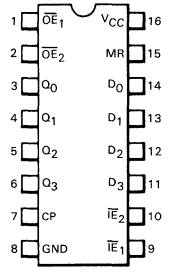
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

TRUTH TABLE

MR	CP	$\overline{E}_1$	$\overline{E}_2$	D_n	Q_n
H	x	x	x	x	L
L	L	x	x	x	Q_n
L	↓	H	x	x	Q_n
L	↓	x	H	x	Q_n
L	↓	L	L	L	L
L	↓	L	L	H	H

When either $\overline{OE}_1$ or $\overline{OE}_2$ are HIGH, the output is in the off state (High Impedence); however this does not affect the contents or sequential operation of the register.

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.4	3.1		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_O = 2.4 V	
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_O = 0.4 V	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				30	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Input Clock Frequency	30	50		MHz	$V_{CC} = 5.0\ V$, $C_L = 45\ pF$, $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		17 22	25 30	ns	
t_{PHL}	Propagation Delay, MR To Output		26	35	ns	
t_{PZH} t_{PZL}	Output Enable Time		15 18	23 27	ns	
t_{PLZ} t_{PHZ}	Output Disable Time		11 11	17 17	ns	$C_L = 5.0\ pF$, $R_L = 667\ \Omega$

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock or MR Pulse Width	20			ns	$V_{CC} = 5.0\ V$
t_s	Data Enable Setup Time,	35			ns	
t_s	Data Setup Time	17			ns	
t_h	Hold Time, Any Input	0			ns	
t_{rec}	Recovery Time	10			ns	

4

AC WAVEFORMS

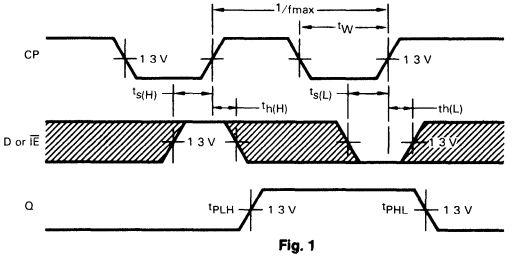


Fig. 1

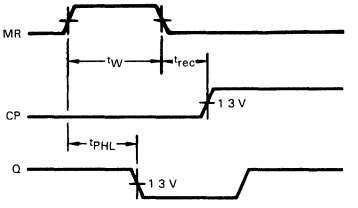


Fig. 2

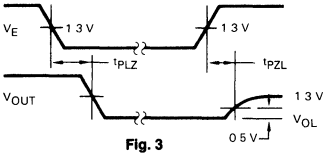


Fig. 3

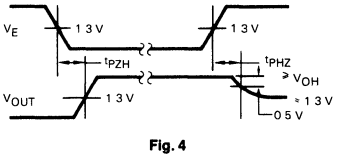
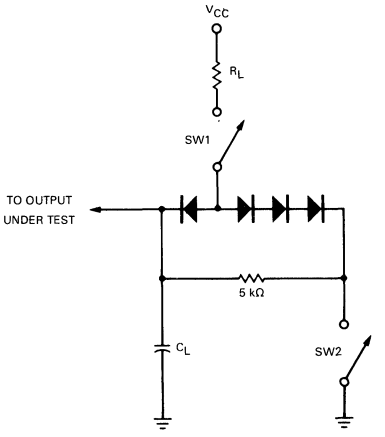


Fig. 4

AC LOAD CIRCUIT



*Includes Jig and Probe Capacitance

Fig. 5

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

4

MOTOROLA

SN54LS174
SN74LS174

HEX D FLIP-FLOP

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS174 is a high speed Hex D Flip-Flop. The device is used primarily as a 6-bit edge-triggered storage register. The information on the D inputs is transferred to storage during the LOW to HIGH clock transition. The device has a Master Reset to simultaneously clear all flip-flops. The LS174 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

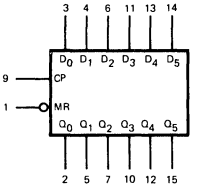
- EDGE-TRIGGERED D-TYPE INPUTS
- BUFFERED-POSITIVE EDGE-TRIGGERED CLOCK
- ASYNCHRONOUS COMMON RESET
- INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS

PIN NAMES

		LOADING (Note a) HIGH	LOW
$D_0 - D_5$	Data Inputs	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_5$	Outputs (Note b)	10 U.L.	5 (2.5) U.L.

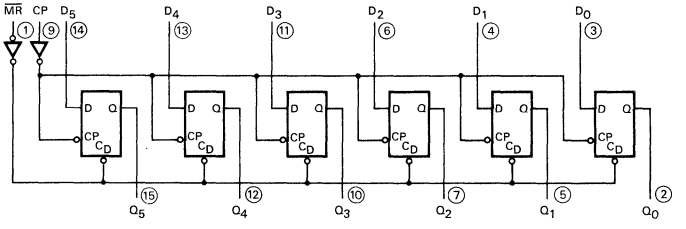
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



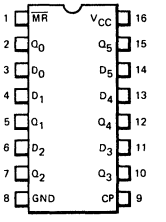
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION – The LS174 consists of six edge-triggered D flip-flops with individual D inputs and Q outputs. The Clock (CP) and Master Reset ($\overline{MR}$) are common to all flip-flops.

Each D input's state is transferred to the corresponding flip-flop's output following the LOW to HIGH Clock (CP) transition.

A LOW input to the Master Reset ($\overline{MR}$) will force all outputs LOW independent of Clock or Data inputs. The LS174 is useful for applications where the true output only is required and the Clock and Master Reset are common to all storage elements.

TRUTH TABLE

Inputs (t = n, $\overline{MR}$ = H)	Outputs (t = n+1) Note 1
D	Q
H	H
L	L

Note 1: t = n + 1 indicates conditions after next clock.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				26	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

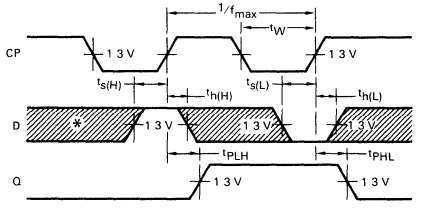
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Input Clock Frequency	30	40		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PHL}	Propagation Delay, $\overline{MR}$ to Output		23	35	ns	
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		20 21	30 30	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock or $\overline{MR}$ Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	5.0			ns	
t_{rec}	Recovery Time	25			ns	

AC WAVEFORMS

CLOCK TO OUTPUT DELAYS, CLOCK PULSE WIDTH, FREQUENCY, SETUP AND HOLD TIMES DATA TO CLOCK



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 1

MASTER RESET TO OUTPUT DELAY, MASTER RESET PULSE WIDTH, AND MASTER RESET RECOVERY TIME

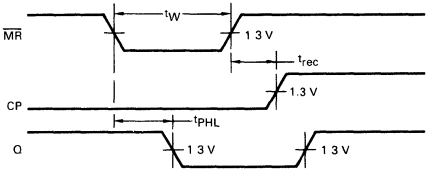


Fig. 2

DEFINITIONS OF TERMS:

SETUP TIME (t_s) – is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) – is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

RECOVERY TIME (t_{rec}) – is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW to HIGH in order to recognize and transfer HIGH Data to the Q outputs.

MOTOROLA

SN54LS175
SN74LS175

QUAD D FLIP-FLOP

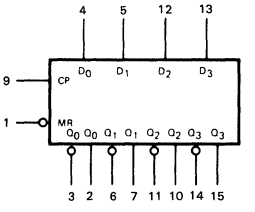
LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS175 is a high speed Quad D Flip-Flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D inputs is stored during the LOW to HIGH clock transition. Both true and complemented outputs of each flip-flop are provided. A Master Reset input resets all flip-flops, independent of the Clock or D inputs, when LOW.

The LS175 is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **EDGE-TRIGGERED D-TYPE INPUTS**
- **BUFFERED-POSITIVE EDGE-TRIGGERED CLOCK**
- **CLOCK TO OUTPUT DELAYS OF 30 ns**
- **ASYNCHRONOUS COMMON RESET**
- **TRUE AND COMPLEMENT OUTPUT**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

LOGIC SYMBOL



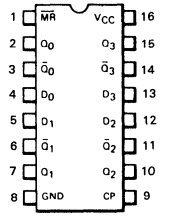
V_{CC} = Pin 16
GND = Pin 8

PIN NAMES

		LOADING (Note a) HIGH	LOW
$D_0 - D_3$	Data Inputs	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_3$	True Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q}_0 - \overline{Q}_3$	Complemented Outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

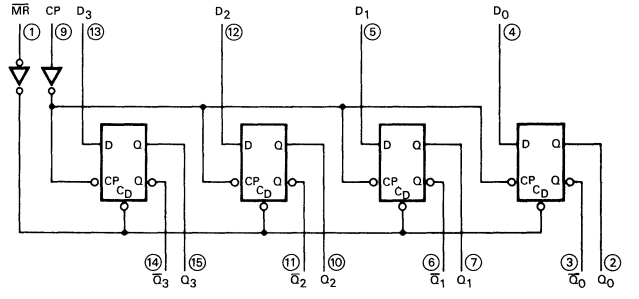
CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

FUNCTIONAL DESCRIPTION – The LS175 consists of four edge-triggered D flip-flops with individual D inputs and Q and $\overline{Q}$ outputs. The Clock and Master Reset are common. The four flip-flops will store the state of their individual D inputs on the LOW to HIGH Clock (CP) transition, causing individual Q and $\overline{Q}$ outputs to follow. A LOW input on the Master Reset ($\overline{MR}$) will force all Q outputs LOW and $\overline{Q}$ outputs HIGH independent of Clock or Data inputs.

The LS175 is useful for general logic applications where a common Master Reset and Clock are acceptable.

TRUTH TABLE

Inputs (t = n, $\overline{MR}$ = H)	Outputs (t = n+1) Note 1	
D	Q	$\overline{Q}$
L	L	H
H	H	L

Note 1 t = n + 1 indicates conditions after next clock.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5 25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0 65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				18	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Input Clock Frequency	30	40		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay, $\overline{MR}$ to Output		20 20	30 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		13 16	25 25	ns	

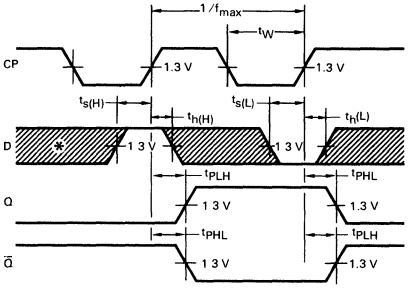
AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock or $\overline{MR}$ Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	5.0			ns	
t_{rec}	Recovery Time	25			ns	

4

AC WAVEFORMS

CLOCK TO OUTPUT DELAYS, CLOCK PULSE WIDTH, FREQUENCY, SETUP AND HOLD TIMES DATA TO CLOCK



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 1

MASTER RESET TO OUTPUT DELAY, MASTER RESET PULSE WIDTH, AND MASTER RESET RECOVERY TIME

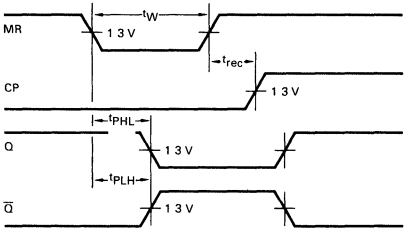


Fig. 2

DEFINITIONS OF TERMS:

SETUP TIME (t_s) – is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) – is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

RECOVERY TIME (t_{rec}) – is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW to HIGH in order to recognize and transfer HIGH Data to the Q outputs.

MOTOROLA

SN54LS181
SN74LS181

4-BIT ARITHMETIC LOGIC UNIT

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS181 is a 4-bit Arithmetic Logic Unit (ALU) which can perform all the possible 16 logic, operations on two variables and a variety of arithmetic operations.

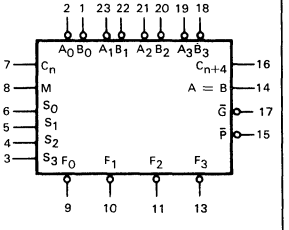
- **PROVIDES 16 ARITHMETIC OPERATIONS**
  ADD, SUBTRACT, COMPARE, DOUBLE, PLUS TWELVE OTHER ARITHMETIC OPERATIONS
- **PROVIDES ALL 16 LOGIC OPERATIONS OF TWO VARIABLES**
  EXCLUSIVE—OR, COMPARE, AND, NAND, OR, NOR, PLUS TEN OTHER LOGIC OPERATIONS
- **FULL LOOKAHEAD FOR HIGH SPEED ARITHMETIC OPERATION ON LONG WORDS**
- **INPUT CLAMP DIODES**

PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{A}_0$–$\overline{A}_3$, $\overline{B}_0$–$\overline{B}_3$	Operand (Active LOW) Inputs	1.5 U.L.	0.75 U.L.
S_0–S_3	Function – Select Inputs	2.0 U.L.	1.0 U.L.
M	Mode Control Input	0.5 U.L.	0.25 U.L.
C_n	Carry Input	2.5 U.L.	1.25 U.L.
$\overline{F}_0$–$\overline{F}_3$	Function (Active LOW) Outputs	10 U.L.	5 (2.5) U.L.
A = B	Comparator Output	Open Collector	5 (2.5) U.L.
$\overline{G}$	Carry Generator (Active LOW) Output	10 U.L.	10 U.L.
$\overline{P}$	Carry Propagate (Active LOW) Output	10 U.L.	5 U.L.
C_{n+4}	Carry Output	10 U.L.	5 (2.5) U.L.

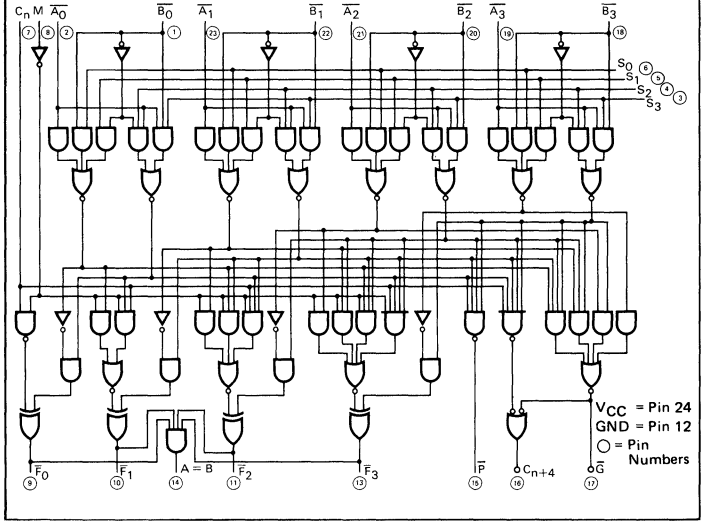
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL

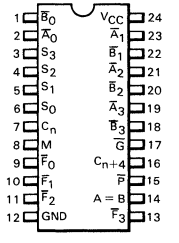


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAMS
DIP (TOP VIEW)



J Suffix — Case 623-05
(Ceramic)
N Suffix — Case 649-03
(Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-line Package.

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS181 is a 4-bit high speed parallel Arithmetic Logic Unit (ALU). Controlled by the four Function Select Inputs (S_0 . S_3) and the Mode Control Input (M), it can perform all the 16 possible logic operations or 16 different arithmetic operations on active HIGH or active LOW operands. The Function Table lists these operations.

When the Mode Control Input (M) is HIGH, all internal carries are inhibited and the device performs logic operations on the individual bits as listed When the Mode Control Input is LOW, the carries are enabled and the device performs arithmetic operations on the two 4-bit words. The device incorporates full internal carry lookahead and provides for either ripple carry between devices using the C_{n+4} output, or for carry lookahead between packages using the signals $\overline{P}$ (Carry Propagate) and $\overline{G}$ (Carry Generate), $\overline{P}$ and $\overline{G}$ are not affected by carry in. When speed requirements are not stringent, the LS181 can be used in a simple ripple carry mode by connecting the Carry Output (C_{n+4}) signal to the Carry Input (C_n) of the next unit. For high speed operation the LS181 is used in conjunction with the 9342 or 93S42 carry lookahead circuit. One carry lookahead package is required for each group of the four LS181 devices. Carry lookahead can be provided at various levels and offers high speed capability over extremely long word lengths.

The A = B output from the LS181 goes HIGH when all four $\overline{F}$ outputs are HIGH and can be used to indicate logic equivalence over four bits when the unit is in the subtract mode. The A = B output is open collector and can be wired-AND with other A = B outputs to give a comparison for more than four bits The A = B signal can also be used with the C_{n+4} signal to indicate A>B and A<B.

The Function Table lists the arithmetic operations that are performed without a carry in. An incoming carry adds a one to each operation Thus, select code LHHL generates A minus B minus 1 (2s complement notation) without a carry in and generates A minus B when a carry is applied. Because subtraction is actually performed by complementary addition (1s complement), a carry out means borrow; thus a carry is generated when there is no underflow and no carry is generated when there is underflow.

4

As indicated, the LS181 can be used with either active LOW inputs producing active LOW outputs or with active HIGH inputs producing active HIGH outputs. For either case the table lists the operations that are performed to the operands labeled inside the logic symbol

FUNCTION TABLE

MODE SELECT INPUTS	ACTIVE LOW INPUTS & OUTPUTS		ACTIVE HIGH INPUTS & OUTPUTS	
S_3 S_2 S_1 S_0	LOGIC (M = H)	ARITHMETIC** (M = L) (C_n = L)	LOGIC (M = H)	ARITHMETIC** (M = L) (C_n = H)
L L L L	$\overline{A}$	A minus 1	$\overline{A}$	A
L L L H	$\overline{AB}$	AB minus 1	$\overline{A+B}$	A + $\overline{B}$
L L H L	$\overline{A+B}$	A$\overline{B}$ minus 1	$\overline{AB}$	A + $\overline{B}$
L L H H	Logical 1	minus 1	Logical 0	minus 1
L H L L	$\overline{A+B}$	A plus (A + $\overline{B}$)	$\overline{AB}$	A plus A$\overline{B}$
L H L H	$\overline{B}$	AB plus (A + $\overline{B}$)	$\overline{B}$	(A + B) plus A$\overline{B}$
L H H L	$\overline{A \oplus B}$	A minus B minus 1	A $\oplus$ B	A minus B minus 1
L H H H	A + $\overline{B}$	A + $\overline{B}$	A$\overline{B}$	AB minus 1
H L L L	$\overline{A}$B	A plus (A + B)	$\overline{A+B}$	A plus AB
H L L H	A $\oplus$ B	A plus B	$\overline{A \oplus B}$	A plus B
H L H L	B	A$\overline{B}$ plus (A + B)	B	(A + $\overline{B}$) plus AB
H L H H	A + B	A + B	AB	AB minus 1
H H L L	Logical 0	A plus A*	Logical 1	A plus A*
H H L H	A$\overline{B}$	AB plus A	A + $\overline{B}$	(A + B) plus A
H H H L	AB	A$\overline{B}$ plus A	A + B	(A + $\overline{B}$) plus A
H H H H	A	A	A	A minus 1

L = LOW Voltage Level

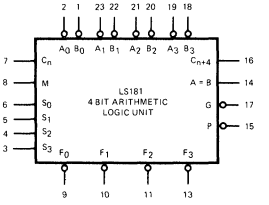
H = HIGH Voltage Level

*Each bit is shifted to the next more significant position

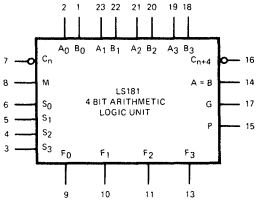
**Arithmetic operations expressed in 2s complement notation

LOGIC SYMBOLS

ACTIVE LOW OPERANDS



ACTIVE HIGH OPERANDS



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5 5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 , 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA
V_{OH}	Output Voltage — High (A=B only)	54,74			5.5	V

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage Except $\overline{G}$ and $\overline{P}$	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
	Output $\overline{G}$	54,74			0.7	V	I_{OL} = 16 mA
	Output $\overline{P}$	54 74			0.6 0.5	V	I_{OL} = 8.0 mA
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
I_{IH}	Input HIGH Current Mode Input Any $\overline{A}$ or $\overline{B}$ Input Any S Input C_n Input				 20 60 80 100	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Mode Input Any $\overline{A}$ or $\overline{B}$ Input Any S Input C_n Input				0.1 0.3 0.4 0.5	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input Low Current Mode Input Any $\overline{A}$ or $\overline{B}$ Input Any S Input C_n Input				 −0.4 −1.2 −1.6 −2.0	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current See Note 1A	54			32	mA	V_{CC} = MAX
		74			34		
	See Note 1B	54			35		
		74			37		

Note 1.
With outputs open, I_{CC} is measured for the following conditions:
A. S0 through S3, M, and A inputs are at 4.5 V, all other inputs are grounded.
B. S0 through S3 and M are at 4.5 V, all other inputs are grounded.

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V, Pin 12 = GND, $C_L = 15$ pF

SYMBOL	PARAMETER	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, (C_n to C_{n+4})	18 13	27 20	ns	M = 0 V, (Sum or Diff Mode) See Fig. 4 and Tables I and II
t_{PLH} t_{PHL}	(C_n to $\overline{F}$ Outputs)	17 13	26 20	ns	M = 0 V, (Sum Mode) See Fig. 4 and Table I
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to $\overline{G}$ Output)	19 15	29 23	ns	$M = S_1 = S_2 = 0$ V, $S_0 = S_3 = 4.5$ V (Sum Mode) See Fig. 4 and Table I
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to $\overline{G}$ Output)	21 21	32 32	ns	$M = S_0 = S_3 = 0$ V, $S_1 = S_2 = 4.5$ V (Diff Mode) See Fig. 5 and Table II
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to $\overline{P}$ Output)	20 20	30 30	ns	$M = S_1 = S_2 = 0$ V, $S_0 = S_3 = 4.5$ V (Sum Mode) See Fig. 4 and Table I
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to $\overline{P}$ Output)	20 22	30 33	ns	$M = S_0 = S_3 = 0$ V, $S_1 = S_2 = 4.5$ V (Diff Mode) See Fig. 5 and Table II
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to any $\overline{F}$ Output)	21 13	32 20	ns	$M = S_1 = S_2 = 0$ V, $S_0 = S_3 = 4.5$ V (Sum Mode) See Fig. 4 and Table I
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to any $\overline{F}$ Output)	21 21	32 32	ns	$M = S_0 = S_3 = 0$ V, $S_1 = S_2 = 4.5$ V (Diff Mode) See Fig. 5 and Table II
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to $\overline{F}$ Outputs)	22 26	33 38	ns	M = 4.5 V (Logic Mode) See Fig. 4 and Table III
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to C_{n+4} Output)	25 25	38 38	ns	$M = 0$ V, $S_0 = S_3 = 4.5$ V, $S_1 = S_2 = 0$ V (Sum Mode) See Fig. 6 and Table I
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to C_{n+4} Output)	27 27	41 41	ns	$M = 0$ V, $S_0 = S_3 = 0$ V, $S_1 = S_2 = 4.5$ V (Diff Mode)
t_{PLH} t_{PHL}	($\overline{A}$ or $\overline{B}$ Inputs to A = B Output)	33 41	50 62	ns	$M = S_0 = S_3 = 0$ V, $S_1 = S_2 = 4.5$ V $R_L = 2$ kΩ (Diff Mode) See Fig. 5 and Table II

AC WAVEFORMS

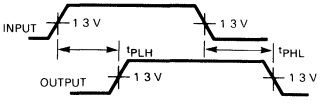


Fig. 4

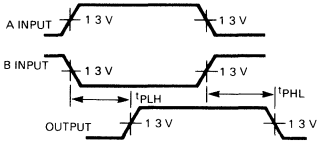


Fig. 5

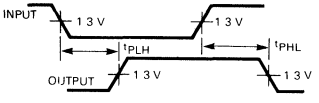


Fig. 6

DIFF MODE TEST TABLE II **FUNCTION INPUTS:** $S_1 = S_2 = 4.5$ V, $S_0 = S_3 = M = 0$ V

PARAMETER	INPUT UNDER TEST	OTHER INPUT SAME BIT		OTHER DATA INPUTS		OUTPUT UNDER TEST
		APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND	
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	Remaining $\overline{A}$	Remaining $\overline{B}$, C_n	$\overline{F}_I$
t_{PLH} t_{PHL}	$\overline{B}$	$\overline{A}$	None	Remaining $\overline{A}$	Remaining $\overline{B}$, C_n	$\overline{F}_I$
t_{PLH} t_{PHL}	$\overline{A}_I$	None	$\overline{B}_I$	Remaining $\overline{B}$, C_n	Remaining $\overline{A}$	$\overline{F}_I + 1$
t_{PLH} t_{PHL}	$\overline{B}_I$	$\overline{A}_I$	None	Remaining $\overline{B}$, C_n	Remaining $\overline{A}$	$\overline{F}_I + 1$
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$\overline{P}$
t_{PLH} t_{PHL}	$\overline{B}$	$\overline{A}$	None	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$\overline{P}$
t_{PLH} t_{PHL}	$\overline{A}$	$\overline{B}$	None	None	Remaining $\overline{A}$ and $\overline{B}_I$, C_n	$\overline{G}$
t_{PLH} t_{PHL}	$\overline{B}$	None	$\overline{A}$	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$\overline{G}$
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	Remaining $\overline{A}$	Remaining $\overline{B}$, C_n	A = B
t_{PLH} t_{PHL}	$\overline{B}$	$\overline{A}$	None	Remaining $\overline{A}$	Remaining $\overline{B}$, C_n	A = B
t_{PLH} t_{PHL}	$\overline{A}$	$\overline{B}$	None	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$C_n + 4$
t_{PLH} t_{PHL}	$\overline{B}$	None	$\overline{A}$	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$C_n + 4$
t_{PLH} t_{PHL}	C_n	None	None	All $\overline{A}$ and $\overline{B}$	None	$C_n + 4$

LOGIC MODE TEST TABLE III

PARAMETER	INPUT UNDER TEST	OTHER INPUT SAME BIT		OTHER DATA INPUTS		OUTPUT UNDER TEST	FUNCTION INPUTS
		APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND		
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	Any $\overline{F}$	$S_1 = S_2 = M = 4.5$ V $S_0 = S_3 = 0$ V
t_{PLH} t_{PHL}	$\overline{B}$	None	$\overline{A}$	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	Any $\overline{F}$	$S_1 = S_2 = M = 4.5$ V $S_0 = S_3 = 0$ V

4

SUM MODE TEST TABLE I **FUNCTION INPUTS:** $S_0 = S_3 = 4.5$ V, $S_1 = S_2 = M = 0$ V

PARAMETER	INPUT UNDER TEST	OTHER INPUT SAME BIT		OTHER DATA INPUTS		OUTPUT UNDER TEST
		APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND	
t_{PLH} t_{PHL}	$\overline{A}_I$	$\overline{B}_I$	None	Remaining $\overline{A}$ and $\overline{B}$	C_n	$\overline{F}_I$
t_{PLH} t_{PHL}	$\overline{B}_I$	$\overline{A}_I$	None	Remaining $\overline{A}$ and $\overline{B}$	C_n	$\overline{F}_I$
t_{PLH} t_{PHL}	$\overline{A}_I$	$\overline{B}_I$	None	C_n	Remaining $\overline{A}$ and $\overline{B}$	$\overline{F}_I + 1$
t_{PLH} t_{PHL}	$\overline{B}_I$	$\overline{A}_I$	None	C_n	Remaining $\overline{A}$ and $\overline{B}$	$\overline{F}_I + 1$
t_{PLH} t_{PHL}	$\overline{A}$	$\overline{B}$	None	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$\overline{P}$
t_{PLH} t_{PHL}	$\overline{B}$	$\overline{A}$	None	None	Remaining $\overline{A}$ and $\overline{B}$, C_n	$\overline{P}$
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	Remaining $\overline{B}$	Remaining $\overline{A}$, C_n	$\overline{G}$
t_{PLH} t_{PHL}	$\overline{B}$	None	$\overline{A}$	Remaining $\overline{B}$	Remaining $\overline{A}$, C_n	$\overline{G}$
t_{PLH} t_{PHL}	$\overline{A}$	None	$\overline{B}$	Remaining $\overline{B}$	Remaining $\overline{A}$, C_n	C_{n+4}
t_{PLH} t_{PHL}	$\overline{B}$	None	$\overline{A}$	Remaining $\overline{B}$	Remaining $\overline{A}$, C_n	C_{n+4}
t_{PLH} t_{PHL}	C_n	None	None	All $\overline{A}$	All $\overline{B}$	Any $\overline{F}$ or C_{n+4}

4

MOTOROLA

SN54LS182
SN74LS182

CARRY LOOKAHEAD GENERATOR

LOW POWER SCHOTTKY

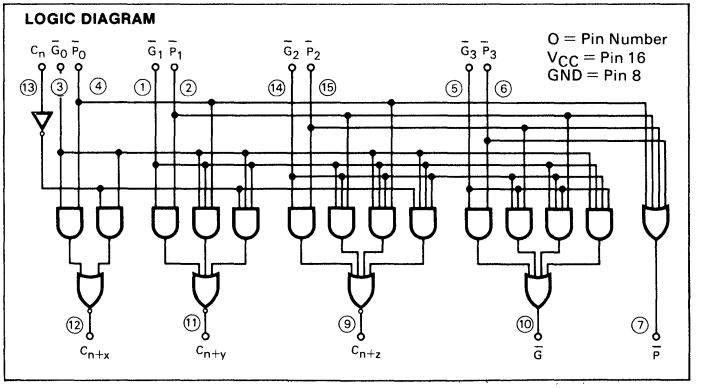
DESCRIPTION — The SN54LS/74LS182 is a high-speed Carry Lookahead Generator. It is generally used with the SN54LS/74LS181 4-Bit Arithmetic Logic Unit to provide high speed lookahead over word lengths of more than four bits. The carry lookahead generator is fully compatible with all members of the Motorola TTL Family.

- PROVIDES CARRY LOOKAHEAD ACROSS A GROUP OF FOUR ALUs
- MULTI-LEVEL LOOKAHEAD FOR HIGH-SPEED ARITHMETIC OPERATION OVER LONG WORD LENGTHS
- INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

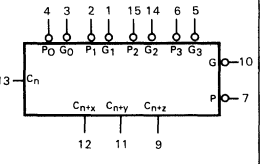
PIN NAMES		LOADING (Note a) HIGH	LOW
C_n	Carry Input	0.5 U.L.	0.25 U.L.
$\overline{G}_0$, $\overline{G}_2$	Carry Generate (Active LOW) Inputs	3.5 U.L.	1.75 U.L.
$\overline{G}_1$	Carry Generate (Active LOW) Input	4.0 U.L.	2.0 U.L.
$\overline{G}_3$	Carry Generate (Active LOW) Input	2.0 U.L.	1.0 U.L.
$\overline{P}_0$, $\overline{P}_1$	Carry Propagate (Active LOW) Inputs	2.0 U.L.	1.0 U.L.
$\overline{P}_2$	Carry Propagate (Active LOW) Input	1.5 U.L.	0.75 U.L.
$\overline{P}_3$	Carry Propagate (Active LOW) Input	1.0 U.L.	0.5 U.L.
C_{n+x}, C_{n+y}, C_{n+z}	Carry Outputs (Note b)	10 U.L.	5 (2.5) U.L.
$\overline{G}$	Carry Generate (Active LOW) Output (Note b)	10 U.L.	5 (2.5) U.L.
$\overline{P}$	Carry Propagate (Active LOW) Output (Note b)	10 U.L.	5 (2.5) U.L.

NOTES:
a 1 Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM

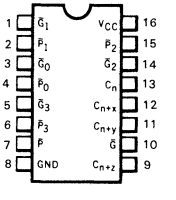


LOGIC SYMBOL



VCC = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS182, carry lookahead generator accepts up to four pairs of active LOW Carry Propagate ($\overline{P}_0$, $\overline{P}_1$, $\overline{P}_2$, $\overline{P}_3$) and Carry Generate ($\overline{G}_0$, $\overline{G}_1$, $\overline{G}_2$, $\overline{G}_3$) signals and an active HIGH Carry Input (C_n) and provides anticipated active HIGH carries (C_{n+x}, C_{n+y}, C_{n+z}) across four groups of binary adders. The SN54LS/74LS182 also has active LOW Carry Propagate ($\overline{P}$) and Carry Generate ($\overline{G}$) outputs which may be used for further levels of lookahead.

The logic equations provided at the outputs are:

$$C_{n+x} = G_0 + P_0C_n$$
$$C_{n+y} = G_1 + P_1G_0 = P_1P_0C_n$$
$$C_{n+z} = \underline{G_2 + P_2G_1 = P_2P_2G_0 + P_2P_1P_0C_n}$$
$$\overline{G} = \overline{G_3 + P_3G_2 + P_3P_2G_1 + P_3P_2P_1G_0}$$
$$\overline{P} = \overline{P_3P_2P_1P_0}$$

Also, the SN54LS/74LS182 can be used with binary ALUs in an active LOW or active HIGH input operand mode. The connections to and from the ALU to the carry lookahead generator are identical in both cases.

TRUTH TABLE

INPUTS									OUTPUTS				
C_n	$\overline{G}_0$	$\overline{P}_0$	$\overline{G}_1$	$\overline{P}_1$	$\overline{G}_2$	$\overline{P}_2$	$\overline{G}_3$	$\overline{P}_3$	C_{n+x}	C_{n+y}	C_{n+z}	$\overline{G}$	$\overline{P}$
X	H	H							L				
L	H	X							L				
X	L	X							H				
H	X	L							H				
X	X	X	H	H						L			
X	H	H	H	X						L			
L	H	X	H	X						L			
X	X	X	L	X						H			
X	L	X	X	L						H			
H	X	L	X	L						H			
X	X	X	X	X	H	H					L		
X	X	X	H	H	H	X					L		
X	H	H	H	X	H	X					L		
L	H	X	H	X	H	X					L		
X	X	X	X	X	L	X					H		
X	X	X	L	X	X	L					H		
X	L	X	X	L	X	L					H		
H	X	L	X	L	X	L					H		
	X		X	X	X	X	H	H				H	
	X		X	X	H	H	H	X				H	
	X		H	H	H	X	H	X				H	
	H		H	X	H	X	H	X				H	
	X		X	X	X	X	L	X				L	
	X		X	X	L	X	X	L				L	
	X		L	X	X	L	X	L				L	
	L		X	L	X	L	X	L				L	
		H		X		X		X					H
		X		H		X		X					H
		X		X		H		X					H
		X		X		X		H					H
		L		L		L		L					L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN	I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = MAX	V_{CC} = MIN, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7					
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = MIN, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74		0.35	0.5		I_{OL} = 8.0 mA	
I_{IH}	C_n $\overline{G}_0$, $\overline{G}_2$ $\overline{G}_3$, $\overline{P}_0$, $\overline{P}_1$ $\overline{P}_2$ $\overline{P}_3$ $\overline{G}_1$				20 140 80 60 40 160	μA	V_{IN} = 2.7 V V_{CC} = MAX	
	C_n $\overline{G}_0$, $\overline{G}_2$ $\overline{G}_3$, $\overline{P}_0$, $\overline{P}_1$ $\overline{P}_2$ $\overline{P}_3$ $\overline{G}_1$				0.1 0.7 0.4 0.3 0.2 0.8	mA	V_{IN} = 7.0 V V_{CC} = MAX	
I_{IL}	C_n $\overline{G}_0$, $\overline{G}_2$ $\overline{G}_3$, $\overline{P}_0$, $\overline{P}_1$ $\overline{P}_2$ $\overline{P}_3$ $\overline{G}_1$				−0.4 −2.8 −1.6 −1.2 −0.8 −3.2	mA	V_{IN} = 0.4 V V_{CC} = MAX	
I_{OS}	Output Short-Circuit Current		−20		−100	mA	V_{CC} = MAX V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				12	mA	V_{CC} = MAX	
	Total, Output LOW				16			

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V, $C_L = 15$ pF

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	(C_n to C_{n+x}, C_{n+y}, C_{n+z})		12 17	25 30	ns	$\bar{P}_0 = \bar{P}_1 = \bar{P}_2 = \bar{G}$nd, $\bar{G}_0 = \bar{G}_1 = \bar{G}_2$ = 4.5 V, Fig. 1
t_{PLH} t_{PHL}	($\bar{P}_0$, $\bar{P}_1$, or $\bar{P}_2$ to C_{n+x}, C_{n+y}, C_{n+z})		9.0 10	21 22	ns	$\bar{P}_x$ = Gnd (if not under test), $C_n = \bar{G}_0 = \bar{G}_1 = \bar{G}_2$ = 4.5 V, Fig. 2
t_{PLH} t_{PHL}	($\bar{G}_0$, $\bar{G}_1$, or $\bar{G}_2$ to C_{n+x}, C_{n+y}, C_{n+z})		9.0 10	21 22	ns	$\bar{G}_x$ = 4.5 V (If not under test), $C_n = \bar{P}_0 = \bar{P}_1 = \bar{P}_2$ = Gnd, Fig. 2
t_{PLH} t_{PHL}	($\bar{P}_1$, $\bar{P}_2$ or $\bar{P}_3$ to $\bar{G}$)		12 8.0	24 20	ns	$\bar{P}_x$ = Gnd (If not under test), $\bar{G}_0 = \bar{G}_1 = \bar{G}_2 = \bar{G}_3 = C_n$ = 0.0 V, Fig. 1
t_{PLH} t_{PHL}	($\bar{G}_0$, $\bar{G}_1$, $\bar{G}_2$ or $\bar{G}_3$ to $\bar{G}$)		13 8.0	25 20	ns	$\bar{G}_x$ = 4.5 V (If not under test), $\bar{P}_1 = \bar{P}_2 = \bar{P}_3$ = Gnd, Fig. 1
t_{PLH} t_{PHL}	($\bar{P}_0$, $\bar{P}_1$, $\bar{P}_2$ or $\bar{P}_3$ to $\bar{P}$)		12 8.0	24 20	ns	$\bar{P}_x$ = Gnd (If not under test), Fig. 1

AC WAVEFORMS

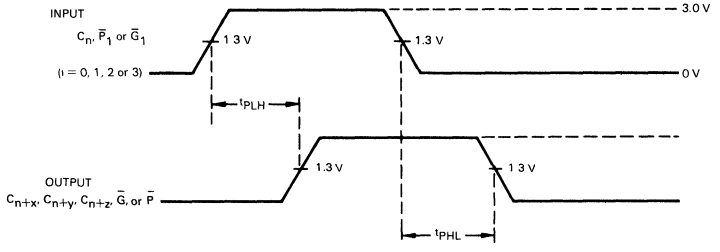


Fig.1

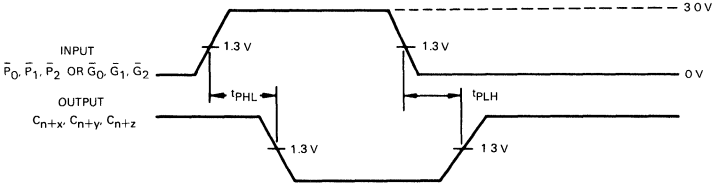


Fig. 2

MOTOROLA

SN54LS183
SN74LS183

DUAL CARRY-SAVE FULL ADDER

LOW POWER SCHOTTKY

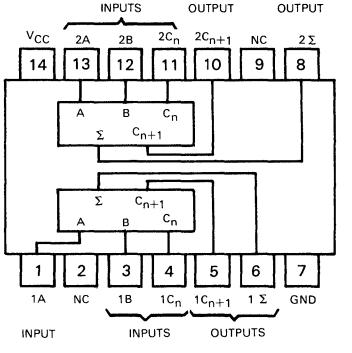
DESCRIPTION—The SN54LS/74LS183 is a Dual Adder. This device features high-speed, high-fan-out Darlington outputs and all inputs are diode clamped for system design simplification. An individual carry output from each bit is featured for use in multiple-input, carry-save techniques to produce true sum and true carry outputs with no more than two gate delays.

- **FOR USE IN HIGH-SPEED WALLACE-TREE SUMMING NETWORKS**
- **HIGH-SPEED, HIGH-FAN-OUT DARLINGTON OUTPUTS**

FUNCTION TABLE

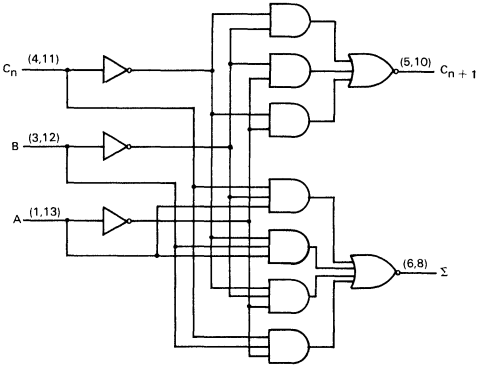
INPUTS			OUTPUTS	
C_n	B	A	Σ	C_{n+1}
L	L	L	L	L
L	L	H	H	L
L	H	L	H	L
L	H	H	L	H
H	L	L	H	L
H	L	H	L	H
H	H	L	L	H
H	H	H	H	H

H = high level, L = low level



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

FUNCTIONAL BLOCK DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				60	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.3	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH Total, Output LOW				14 17	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Propagation Delay Time, Low-to-High Level Output		9.0	15	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PHL}	Propagation Delay Time, High-to-Low Level Output		20	33	ns	

MOTOROLA

SN54LS/74LS190
SN54LS/74LS191

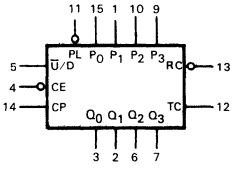
PRESETTABLE BCD/DECADE UP/DOWN COUNTERS
PRESETTABLE 4-BIT BINARY UP/DOWN COUNTERS
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS190 is a synchronous UP/DOWN BCD Decade (8421) Counter and the SN54LS/74LS191 is a synchronous UP/DOWN Modulo-16 Binary Counter. State changes of the counters are synchronous with the LOW-to-HIGH transition of the Clock Pulse input.

An asynchronous Parallel Load ($\overline{PL}$) input overrides counting and loads the data present on the P_n inputs into the flip-flops, which makes it possible to use the circuits as programmable counters. A Count Enable ($\overline{CE}$) input serves as the carry/borrow input in multi-stage counters. An Up/Down Count Control ($\overline{U}$/D) input determines whether a circuit counts up or down. A Terminal Count (TC) output and a Ripple Clock ($\overline{RC}$) output provide overflow/underflow indication and make possible a variety of methods for generating carry/borrow signals in multi-stage counter applications.

- **LOW POWER . . . 90 mW TYPICAL DISSIPATION**
- **HIGH SPEED . . . 25 MHz TYPICAL COUNT FREQUENCY**
- **SYNCHRONOUS COUNTING**
- **ASYNCHRONOUS PARALLEL LOAD**
- **INDIVIDUAL PRESET INPUTS**
- **COUNT ENABLE AND UP/DOWN CONTROL INPUTS**
- **CASCADABLE**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

LOGIC SYMBOL



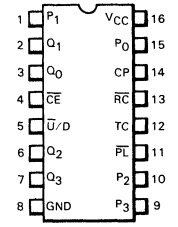
V_{CC} = Pin 16
GND = Pin 8

PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{CE}$	Count Enable (Active LOW) Input	1.5 U.L.	0.7 U.L.
CP	Clock Pulse (Active HIGH going edge) Input	0.5 U.L.	0.25 U.L.
$\overline{U}$/D	Up/Down Count Control Input	0.5 U.L.	0.25 U.L.
$\overline{PL}$	Parallel Load Control (Active LOW) Input	0.5 U.L.	0.25 U.L.
P_n	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
Q_n	Flip-Flop Outputs (Note b)	10 U.L.	5 (2.5) U.L.
$\overline{RC}$	Ripple Clock Output (Note b)	10 U.L.	5 (2.5) U.L.
TC	Terminal Count Output (Note b)	10 U.L.	5 (2.5) U.L.

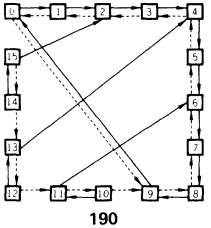
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

STATE DIAGRAMS



190

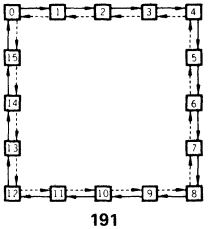
LS190

UP: $TC = Q_0 \cdot Q_3 \cdot (\overline{U/D})$
DOWN: $TC = \overline{Q_0} \cdot \overline{Q_1} \cdot \overline{Q_2} \cdot \overline{Q_3} \cdot (\overline{U/D})$

LS191

UP: $TC = Q_0 \cdot Q_1 \cdot Q_2 \cdot Q_3 \cdot (\overline{U/D})$
DOWN: $TC = \overline{Q_0} \cdot \overline{Q_1} \cdot \overline{Q_2} \cdot \overline{Q_3} \cdot (\overline{U/D})$

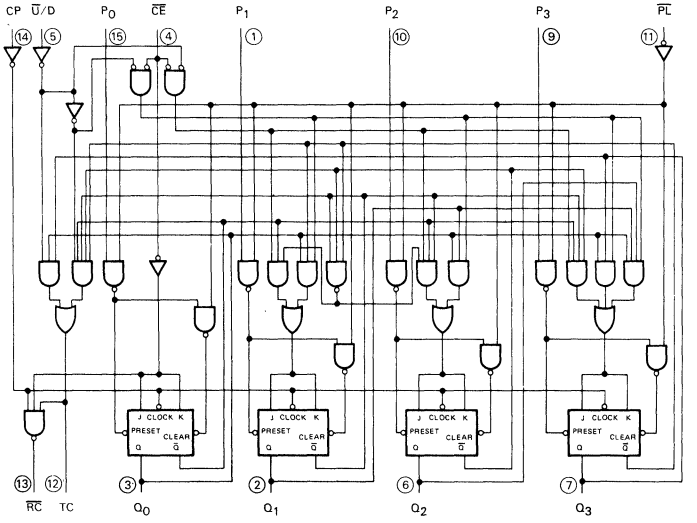
Count Up ——
Count Down ------



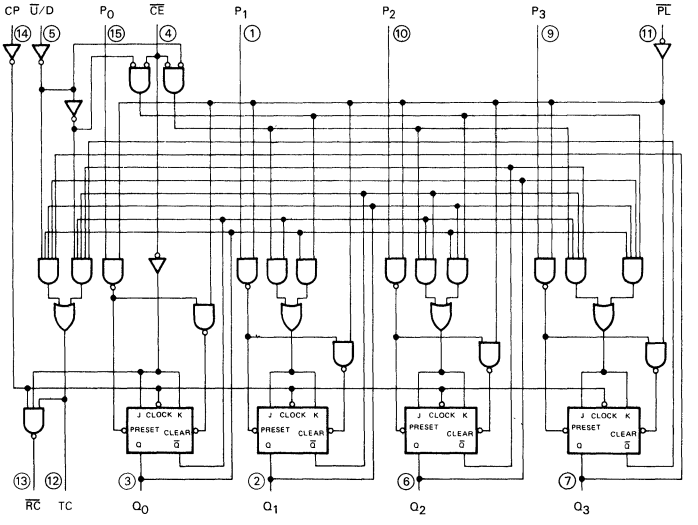
191

4

LOGIC DIAGRAMS



DECADE COUNTER
LS190



BINARY COUNTER
LS191

V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

FUNCTIONAL DESCRIPTION — The LS190 is a synchronous Up/Down BCD Decade Counter and the LS191 is a synchronous Up/Down 4-Bit Binary Counter. The operating modes of the LS190 decade counter and the LS191 binary counter are identical, with the only difference being the count sequences as noted in the state diagrams. Each circuit contains four master/slave flip-flops, with internal gating and steering logic to provide individual preset, count-up and count-down operations.

Each circuit has an asynchronous parallel load capability permitting the counter to be preset to any desired number. When the Parallel Load ($\overline{PL}$) input is LOW, information present on the Parallel Data inputs (P_0–P_3) is loaded into the counter and appears on the Q outputs. This operation overrides the counting functions, as indicated in the Mode Select Table.

A HIGH signal on the $\overline{CE}$ input inhibits counting. When $\overline{CE}$ is LOW, internal state changes are initiated synchronously by the LOW-to-HIGH transition of the clock input. The direction of counting is determined by the $\overline{U}$/D input signal, as indicated in the Mode Select Table. When counting is to be enabled, the $\overline{CE}$ signal can be made LOW when the clock is in either state. However, when counting is to be inhibited, the LOW-to-HIGH $\overline{CE}$ transition must occur only while the clock is HIGH. Similarly, the $\overline{U}$/D signal should only be changed when either $\overline{CE}$ or the clock is HIGH.

Two types of outputs are provided as overflow/underflow indicators. The Terminal Count (TC) output is normally LOW and goes HIGH when a circuit reaches zero in the count-down mode or reaches maximum (9 for the LS190, 15 for the LS191) in the count-up mode. The TC output will then remain HIGH until a state change occurs, whether by counting or presetting or until $\overline{U}$/D is changed. The TC output should not be used as a clock signal because it is subject to decoding spikes.

The TC signal is also used internally to enable the Ripple Clock ($\overline{RC}$) output. The $\overline{RC}$ output is normally HIGH. When $\overline{CE}$ is LOW and TC is HIGH, the $\overline{RC}$ output will go LOW when the clock next goes LOW and will stay LOW until the clock goes HIGH again. This feature simplifies the design of multi-stage counters, as indicated in Figures a and b. In Figure a, each $\overline{RC}$ output is used as the clock input for the next higher stage. This configuration is particularly advantageous when the clock source has a limited drive capability, since it drives only the first stage. To prevent counting in all stages it is only necessary to inhibit the first stage, since a HIGH signal on $\overline{CE}$ inhibits the $\overline{RC}$ output pulse, as indicated in the $\overline{RC}$ Truth Table. A disadvantage of this configuration, in some applications, is the timing skew between state changes in the first and last stages. This represents the cumulative delay of the clock as it ripples through the preceding stages.

A method of causing state changes to occur simultaneously in all stages is shown in Figure b. All clock inputs are driven in parallel and the $\overline{RC}$ outputs propagate the carry/borrow signals in ripple fashion. In this configuration the LOW state duration of the clock must be long enough to allow the negative-going edge of the carry/borrow signal to ripple through to the last stage before the clock goes HIGH. There is no such restriction on the HIGH state duration of the clock, since the $\overline{RC}$ output of any package goes HIGH shortly after its CP input goes HIGH.

The configuration shown in Figure c avoids ripple delays and their associated restrictions. The $\overline{CE}$ input signal for a given stage is formed by combining the TC signals from all the preceding stages. Note that in order to inhibit counting an enable signal must be included in each carry gate. The simple inhibit scheme of Figures a and b doesn't apply, because the TC output of a given stage is not affected by its own $\overline{CE}$.

MODE SELECT TABLE

INPUTS				MODE
$\overline{PL}$	$\overline{CE}$	$\overline{U}$/D	CP	
H	L	L	⎍	Count Up
H	L	H	⎍	Count Down
L	X	X	X	Preset (Asyn.)
H	H	X	X	No Change (Hold)

RC TRUTH TABLE

INPUTS			$\overline{RC}$
$\overline{CE}$	TC*	CP	OUTPUT
L	H	⎍⎍	⎍⎍
H	X	X	H
X	L	X	H

*TC is generated internally

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
⎍ = LOW-to-HIGH Clock Transition
⎍⎍ = LOW Pulse

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current Other Inputs $\overline{CE}$				20 60	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	Other Inputs $\overline{CE}$				0.1 0.3	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current Other Inputs $\overline{CE}$				−0.4 −1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				35	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	20	25		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay, $\overline{PL}$ to Output Q		22 33	33 50	ns	
t_{PLH} t_{PHL}	Data to Output Q		20 27	32 40	ns	
t_{PLH} t_{PHL}	Clock to $\overline{RC}$		13 16	20 24	ns	
t_{PLH} t_{PHL}	Clock to Output Q		16 24	24 36	ns	
t_{PLH} t_{PHL}	Clock to TC		28 37	42 52	ns	
t_{PLH} t_{PHL}	$\overline{U}$/D to $\overline{RC}$		30 30	45 45	ns	
t_{PLH} t_{PHL}	$\overline{U}$/D to TC		21 22	33 33	ns	
t_{PLH} t_{PHL}	$\overline{CE}$ to $\overline{RC}$		21 22	33 33	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	CP Pulse Width	25			ns	$V_{CC} = 5.0$ V
t_W	$\overline{PL}$ Pulse Width	35			ns	
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	5.0			ns	
t_{rec}	Recovery Time	40			ns	

DEFINITIONS OF TERMS:

SETUP TIME (t_s) is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH data to the Q outputs.

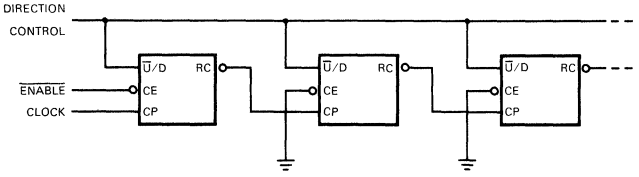


Fig. a) n-stage counter using ripple clock.

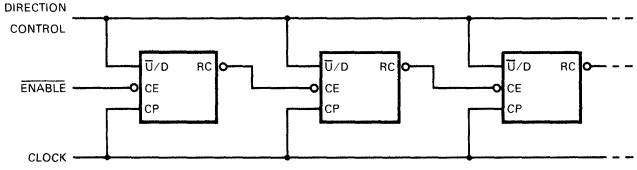


Fig. b) Synchronous n-stage counter using ripple carry/borrow.

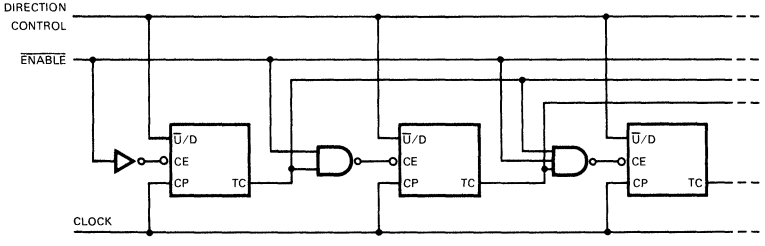


Fig. c) Synchronous n-stage counter with parallel gated carry/borrow.

AC WAVEFORMS

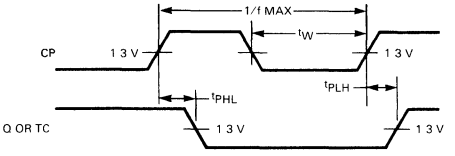


Fig. 1

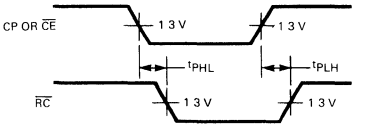
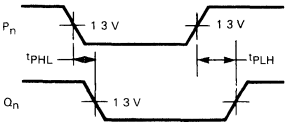


Fig. 2



NOTE: $\overline{PL}$ = LOW

Fig. 3

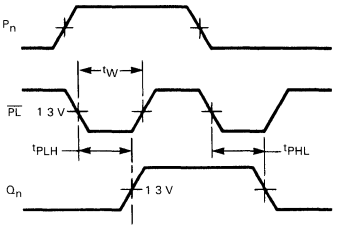


Fig. 4

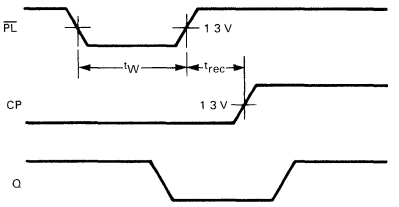
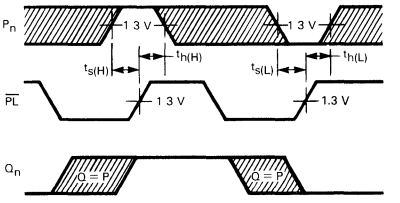


Fig. 5



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 6

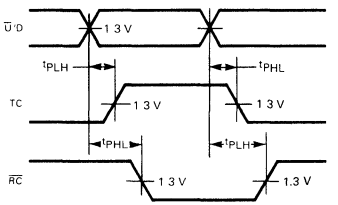


Fig. 7

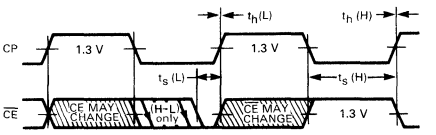


Fig. 8

MOTOROLA

SN54LS/74LS192
SN54LS/74LS193

PRESETTABLE BCD/DECADE UP/DOWN COUNTER
PRESETTABLE 4-BIT BINARY UP/DOWN COUNTER
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS192 is an UP/DOWN BCD Decade (8421) Counter and the SN54LS/74LS193 is an UP/DOWN MODULO-16 Binary Counter. Separate Count Up and Count Down Clocks are used and in either counting mode the circuits operate synchronously. The outputs change state synchronous with the LOW-to-HIGH transitions on the clock inputs.

Separate Terminal Count Up and Terminal Count Down outputs are provided which are used as the clocks for a subsequent stages without extra logic, thus simplifying multistage counter designs. Individual preset inputs allow the circuits to be used as programmable counters. Both the Parallel Load ($\overline{PL}$) and the Master Reset (MR) inputs asynchronously override the clocks.

- **LOW POWER . . . 95 mW TYPICAL DISSIPATION**
- **HIGH SPEED . . . 40 MHz TYPICAL COUNT FREQUENCY**
- **SYNCHRONOUS COUNTING**
- **ASYNCHRONOUS MASTER RESET AND PARALLEL LOAD**
- **INDIVIDUAL PRESET INPUTS**
- **CASCADING CIRCUITRY INTERNALLY PROVIDED**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

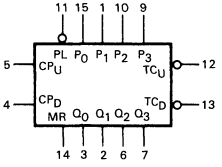
4

PIN NAMES

		LOADING (Note a) HIGH	LOW
CP_U	Count Up Clock Pulse Input	0.5 U.L.	0.25 U.L.
CP_D	Count Down Clock Pulse Input	0.5 U.L.	0.25 U.L.
MR	Asynchronous Master Reset (Clear) Input	0.5 U.L.	0.25 U.L.
$\overline{PL}$	Asynchronous Parallel Load (Active LOW) Input	0.5 U.L.	0.25 U.L.
P_n	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
Q_n	Flip-Flop Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{TC}_D$	Terminal Count Down (Borrow) Output (Note b)	10 U.L.	5(2.5) U.L.
$\overline{TC}_U$	Terminal Count Up (Carry) Output (Note b)	10 U.L.	5(2.5) U.L.

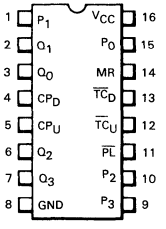
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for MILITARY (54) and 5 U.L. for COMMERCIAL (74) Temperature Ranges.

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

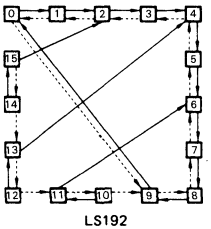
CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

STATE DIAGRAMS



LS192

LS192 LOGIC EQUATIONS FOR TERMINAL COUNT

$\overline{TC}_U = Q_0 \cdot Q_3 \cdot \overline{CP}_U$

$\overline{TC}_D = \overline{Q}_0 \cdot \overline{Q}_1 \cdot \overline{Q}_2 \cdot \overline{Q}_3 \cdot \overline{CP}_D$

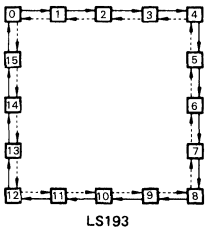
LS193 LOGIC EQUATIONS FOR TERMINAL COUNT

$\overline{TC}_U = Q_0 \cdot Q_1 \cdot Q_2 \cdot Q_3 \cdot \overline{CP}_U$

$\overline{TC}_D = \overline{Q}_0 \cdot \overline{Q}_1 \cdot \overline{Q}_2 \cdot \overline{Q}_3 \cdot \overline{CP}_D$

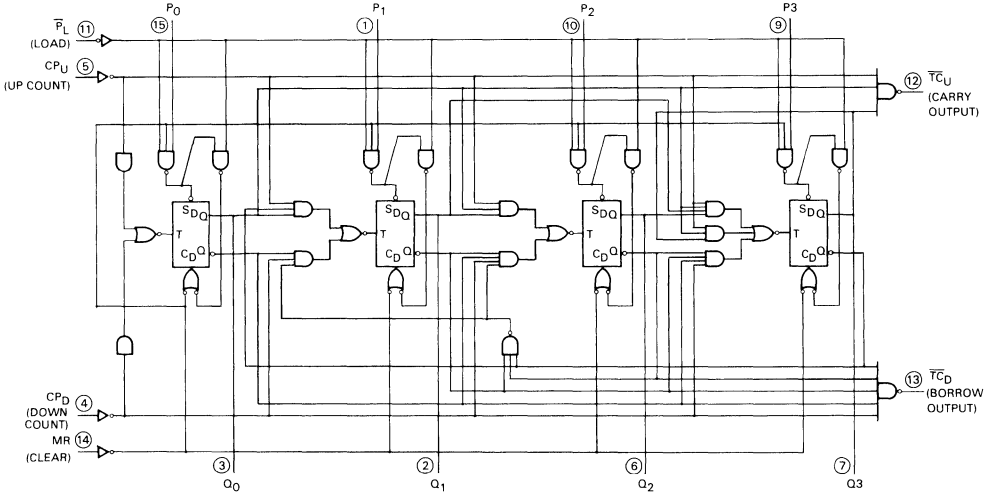
COUNT UP ——

COUNT DOWN ------

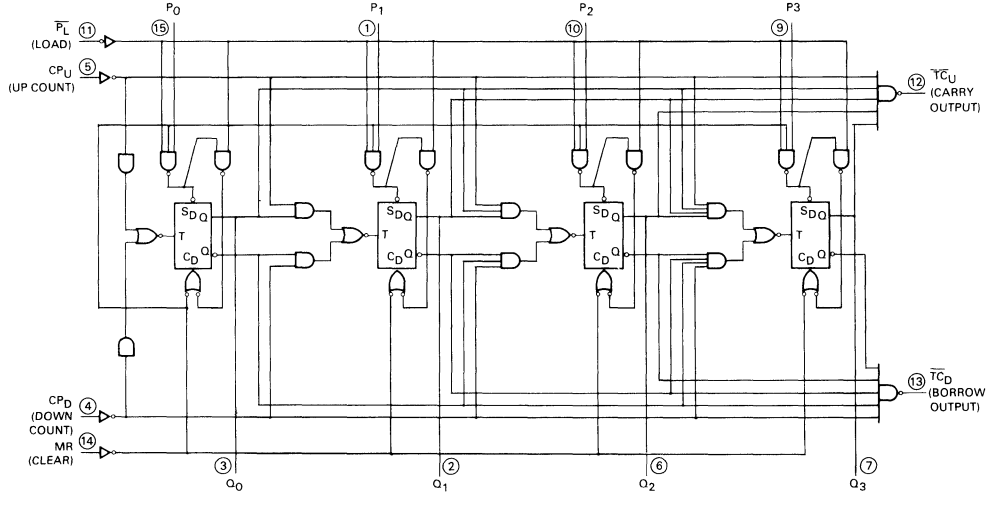


LS193

LOGIC DIAGRAMS



LS192



LS193

V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Number

FUNCTIONAL DESCRIPTION — The LS192 and LS193 are Asynchronously Presettable Decade and 4-Bit Binary Synchronous UP/DOWN (Reversable) Counters. The operating modes of the LS192 decade counter and the LS193 binary counter are identical, with the only difference being the count sequences as noted in the State Diagrams. Each circuit contains four master/slave flip-flops, with internal gating and steering logic to provide master reset, individual preset, count up and count down operations.

Each flip-flop contains JK feedback from slave to master such that a LOW-to-HIGH transition on its T input causes the slave, and thus the Q output to change state. Synchronous switching, as opposed to ripple counting, is achieved by driving the steering gates of all stages from a common Count Up line and a common Count Down line, thereby causing all state changes to be initiated simultaneously. A LOW-to-HIGH transition on the Count Up input will advance the count by one; a similar transition on the Count Down input will decrease the count by one. While counting with one clock input, the other should be held HIGH. Otherwise, the circuit will either count by twos or not at all, depending on the state of the first flip-flop, which cannot toggle as long as either Clock input is LOW.

The Terminal Count Up ($\overline{TC}_U$) and Terminal Count Down ($\overline{TC}_D$) outputs are normally HIGH. When a circuit has reached the maximum count state (9 for the LS192, 15 for the LS193), the next HIGH-to-LOW transition of the Count Up Clock will cause $\overline{TC}_U$ to go LOW. $\overline{TC}_U$ will stay LOW until CP_U goes HIGH again, thus effectively repeating the Count Up Clock, but delayed by two gate delays. Similarly, the $\overline{TC}_D$ output will go LOW when the circuit is in the zero state and the Count Down Clock goes LOW. Since the TC outputs repeat the clock waveforms, they can be used as the clock input signals to the next higher order circuit in a multistage counter.

4

Each circuit has an asynchronous parallel load capability permitting the counter to be preset. When the Parallel Load ($\overline{PL}$) and the Master Reset (MR) inputs are LOW, information present on the Parallel Data inputs (P_0, P_3) is loaded into the counter and appears on the outputs regardless of the conditions of the clock inputs. A HIGH signal on the Master Reset input will disable the preset gates, override both Clock inputs, and latch each Q output in the LOW state. If one of the Clock inputs is LOW during and after a reset or load operation, the next LOW-to-HIGH transition of that Clock will be interpreted as a legitimate signal and will be counted.

MODE SELECT TABLE

MR	$\overline{PL}$	CP_U	CP_D	MODE
H	X	X	X	Reset (Asyn.)
L	L	X	X	Preset (Asyn.)
L	H	H	H	No Change
L	H	⎍	H	Count Up
L	H	H	⎍	Count Down

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
⎍ = LOW-to-HIGH Clock Transition

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				34	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	25	32		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	$\overline{CP_U}$ Input to $\overline{TC_U}$ Output		17 18	26 24	ns	
t_{PLH} t_{PHL}	$\overline{CP_D}$ Input to $\overline{TC_D}$ Output		16 15	24 24	ns	
t_{PLH} t_{PHL}	Clock to Q		27 30	38 47	ns	
t_{PLH} t_{PHL}	$\overline{PL}$ to Q		24 25	40 40	ns	
t_{PHL}	MR Input to Any Output		23	35	ns	

4

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Any Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	5.0			ns	
t_{rec}	Recovery Time	40			ns	

DEFINITIONS OF TERMS:

SETUP TIME (t_s) is defined as the minimum time required for the correct logic level to be present at the logic input prior to the $\overline{PL}$ transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) is defined as the minimum time following the $\overline{PL}$ transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the $\overline{PL}$ transition from LOW-to-HIGH and still be recognized.

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH data to the Q outputs.

4

AC WAVEFORMS

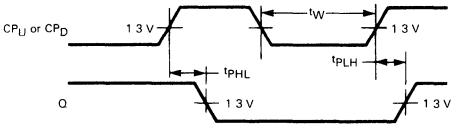


Fig. 1

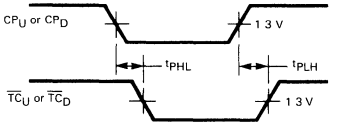
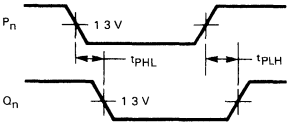


Fig. 2



NOTE: $\overline{PL}$ = LOW

Fig. 3

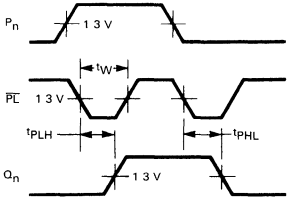


Fig. 4

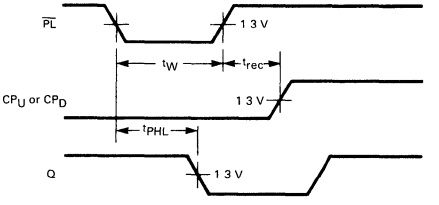
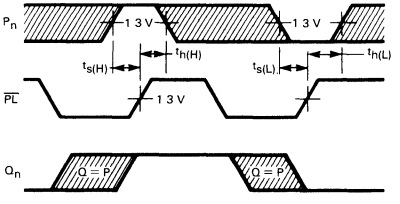


Fig. 5



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 6

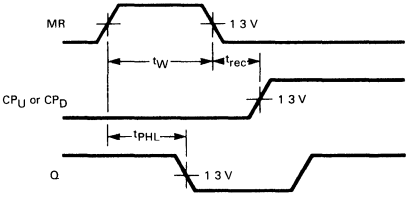


Fig. 7

MOTOROLA

SN54LS194A
SN74LS194A

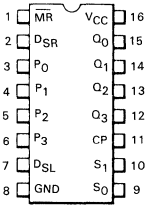
4-BIT BIDIRECTIONAL UNIVERSAL SHIFT REGISTER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS194A is a High Speed 4-Bit Bidirectional Universal Shift Register. As a high speed multifunctional sequential building block, it is useful in a wide variety of applications. It may be used in serial-serial, shift left, shift right, serial-parallel, parallel-serial, and parallel-parallel data register transfers. The LS194A is similar in operation to the LS195A Universal Shift Register, with added features of shift left without external connections and hold (do nothing) modes of operation. It utilizes the Schottky diode clamped process to achieve high speeds and is fully compatible with all Motorola TTL families.

- **TYPICAL SHIFT FREQUENCY OF 36 MHz**
- **ASYNCHRONOUS MASTER RESET**
- **HOLD (DO NOTHING) MODE**
- **FULLY SYNCHRONOUS SERIAL OR PARALLEL DATA TRANSFERS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

CONNECTION DIAGRAM
DIP (TOP VIEW)



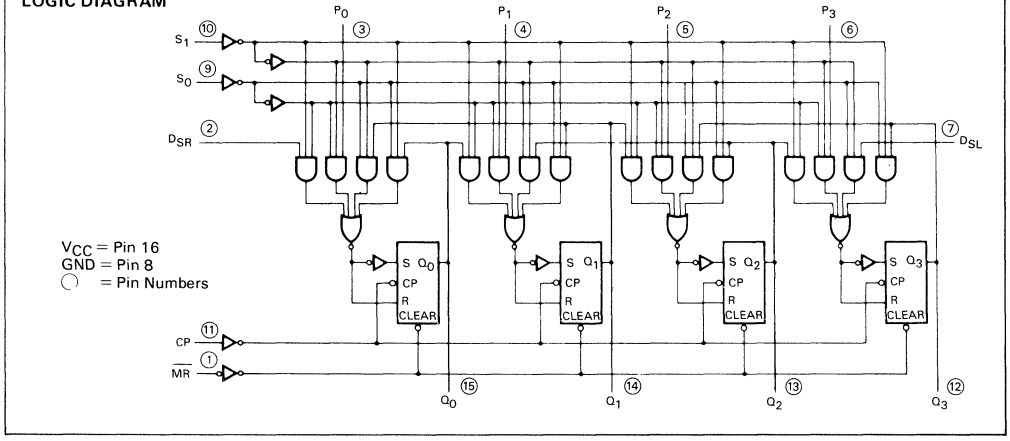
J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

PIN NAMES

		LOADING (Note a) HIGH	LOW
S_0, S_1	Mode Control Inputs	0.5 U.L.	0.25 U.L.
$P_0 - P_3$	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
D_{SR}	Serial (Shift Right) Data Input	0.5 U.L.	0.25 U.L.
D_{SL}	Serial (Shift Left) Data Input	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_3$	Parallel Outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM



FUNCTIONAL DESCRIPTION – The Logic Diagram and Truth Table indicate the functional characteristics of the LS194A 4-Bit Bidirectional Shift Register. The LS194A is similar in operation to the Motorola LS195A Universal Shift Register when used in serial or parallel data register transfers. Some of the common features of the two devices are described below:

1. All data and mode control inputs are edge-triggered, responding only to the LOW to HIGH transition of the Clock (CP). The only timing restriction, therefore, is that the mode control and selected data inputs must be stable one set-up time prior to the positive transition of the clock pulse.

2. The register is fully synchronous, with all operations taking place in less than 15 ns (typical) making the device especially useful for implementing very high speed CPUs, or the memory buffer registers.

3. The four parallel data inputs (P_0, P_1, P_2, P_3) are D-type inputs. When both S_0 and S_1 are HIGH, the data appearing on P_0, P_1, P_2, and P_3 inputs is transferred to the Q_0, Q_1, Q_2, and Q_3 outputs respectively following the next LOW to HIGH transition of the clock.

4. The asynchronous Master Reset ($\overline{MR}$), when LOW, overrides all other input conditions and forces the Q outputs LOW.

Special logic features of the LS194A design which increase the range of application are described below:

1. Two mode control inputs (S_0, S_1) determine the synchronous operation of the device. As shown in the Mode Selection Table, data can be entered and shifted from left to right (shift right, $Q_0 \rightarrow Q_1$, etc.) or right to left (shift left, $Q_3 \rightarrow Q_2$, etc.), or parallel data can be entered loading all four bits of the register simultaneously. When both S_0 and S_1 are LOW, the existing data is retained in a "do nothing" mode without restricting the HIGH to LOW clock transition.

2. D-type serial data inputs (D_{SR}, D_{SL}) are provided on both the first and last stages to allow multistage shift right or shift left data transfers without interfering with parallel load operation.

4

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS						OUTPUTS			
	$\overline{MR}$	S_1	S_0	D_{SR}	D_{SL}	P_n	Q_0	Q_1	Q_2	Q_3
Reset	L	X	X	X	X	X	L	L	L	L
Hold	H	l	l	X	X	X	q_0	q_1	q_2	q_3
Shift Left	H	h	l	X	l	X	q_1	q_2	q_3	L
	H	h	l	X	h	X	q_1	q_2	q_3	H
Shift Right	H	l	h	l	X	X	L	q_0	q_1	q_2
	H	l	h	h	X	X	H	q_0	q_1	q_2
Parallel Load	H	h	h	X	X	p_n	p_0	p_1	p_2	p_3

L = LOW Voltage Level
H= HIGH Voltage Level
X = Don't Care
l = LOW voltage level one set-up time prior to the LOW to HIGH clock transition
h = HIGH voltage level one set-up time prior to the LOW to HIGH clock transition
p_n (q_n) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the LOW to HIGH clock transition.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				23	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	25	36		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		14 17	22 26	ns	
t_{PHL}	Propagation Delay, $\overline{MR}$ to Output		19	30	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock or $\overline{MR}$ Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Mode Control Setup Time	30			ns	
t_s	Data Setup Time	20			ns	
t_h	Hold Time, Any Input	0			ns	
t_{rec}	Recovery Time	25			ns	

DEFINITIONS OF TERMS:

SET UP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

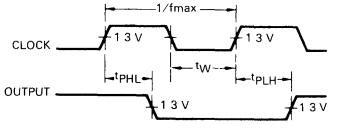
HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

RECOVERY TIME (t_{rec}) — is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW to HIGH in order to recognize and transfer HIGH Data to the Q outputs.

AC WAVEFORMS

The shaded areas indicate when the input is permitted to change for predictable output performance.

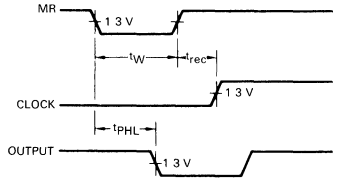
CLOCK TO OUTPUT DELAYS CLOCK PULSE WIDTH AND f_{max}



OTHER CONDITIONS: S_1 = L, $\overline{MR}$ = H, S_0 = H

Fig. 1

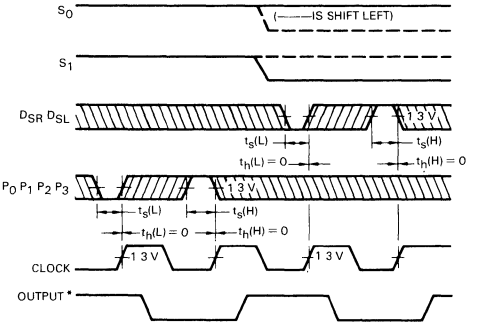
MASTER RESET PULSE WIDTH, MASTER RESET TO OUTPUT DELAY AND MASTER RESET TO CLOCK RECOVERY TIME



OTHER CONDITIONS: S_0, S_1 = H
$P_0 = P_1 = P_2 = P_3$ = H

Fig. 2

SETUP (t_s) AND HOLD (t_h) TIME FOR SERIAL DATA (D_{SR}, D_{SL}) AND PARALLEL DATA (P_0, P_1, P_2, P_3)

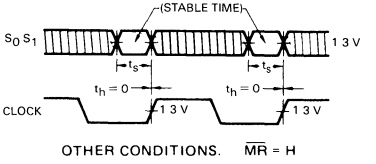


OTHER CONDITIONS. $\overline{MR}$ = H

*D_{SR} set-up time affects Q_0 only
D_{SL} set-up time affects Q_3 only

Fig. 3

SETUP (t_s) AND HOLD (t_h) TIME FOR S INPUT



OTHER CONDITIONS. $\overline{MR}$ = H

Fig. 4

MOTOROLA

SN54LS195A
SN74LS195A

DESCRIPTION — The SN54LS/74LS195A is a high speed 4-Bit Shift Register offering typical shift frequencies of 39 MHz. It is useful for a wide variety of register and counting applications. It utilizes the Schottky diode clamped process to achieve high speeds and is fully compatible with all Motorola TTL products.

- **TYPICAL SHIFT RIGHT FREQUENCY OF 39 MHz**
- **ASYNCHRONOUS MASTER RESET**
- **J, $\overline{K}$ INPUTS TO FIRST STAGE**
- **FULLY SYNCHRONOUS SERIAL OR PARALLEL DATA TRANSFERS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

UNIVERSAL 4-BIT SHIFT REGISTER

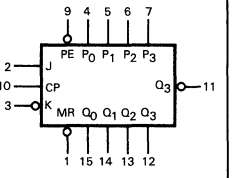
LOW POWER SCHOTTKY

PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{PE}$	Parallel Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
$P_0 - P_3$	Parallel Data Inputs	0.5 U.L.	0.25 U.L.
J	First Stage J (Active HIGH) Input	0.5 U.L.	0.25 U.L.
$\overline{K}$	First Stage K (Active LOW) Input	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$Q_0 - Q_3$	Parallel Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q}_3$	Complementary Last Stage Output (Note b)	10 U.L.	5(2.5) U.L.

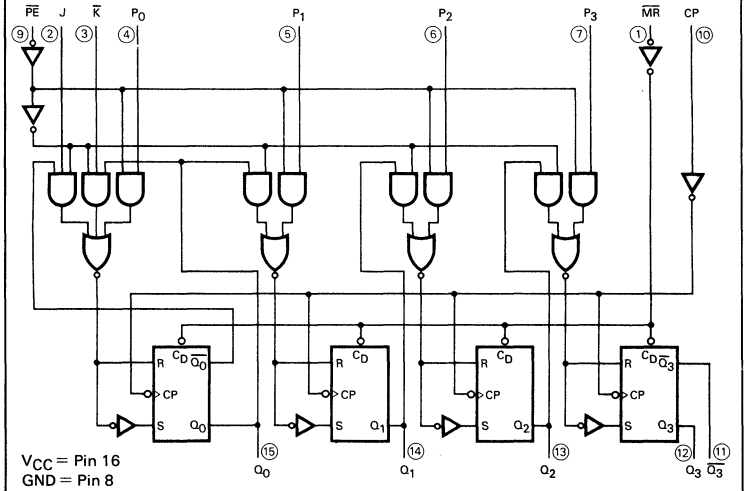
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



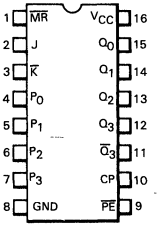
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION – The Logic Diagram and Truth Table indicate the functional characteristics of the LS195A 4-Bit Shift Register. The device is useful in a wide variety of shifting, counting and storage applications. It performs serial, parallel, serial to parallel, or parallel to serial data transfers at very high speeds.

The LS195A has two primary modes of operation, shift right ($Q_0 \rightarrow Q_1$) and parallel load which are controlled by the state of the Parallel Enable ($\overline{PE}$) input. When the PE input is HIGH, serial data enters the first flip-flop Q_0 via the J and $\overline{K}$ inputs and is shifted one bit in the direction $Q_0 \rightarrow Q_1 \rightarrow Q_2 \rightarrow Q_3$ following each LOW to HIGH clock transition. The $\overline{JK}$ inputs provide the flexibility of the JK type input for special applications, and the simple D type input for general applications by tying the two pins together. When the $\overline{PE}$ input is LOW, the LS195A appears as four common clocked D flip-flops. The data on the parallel inputs P_0, P_1, P_2, P_3 is transferred to the respective Q_0, Q_1, Q_2, Q_3 outputs following the LOW to HIGH clock transition. Shift left operations ($Q_3 \rightarrow Q_2$) can be achieved by tying the Q_n outputs to the P_{n-1} inputs and holding the $\overline{PE}$ input LOW.

All serial and parallel data transfers are synchronous, occurring after each LOW to HIGH clock transition. Since the LS195A utilizes edge-triggering, there is no restriction on the activity of the J, $\overline{K}$, P_n and $\overline{PE}$ inputs for logic operation – except for the set-up and release time requirements.

A LOW on the asynchronous Master Reset ($\overline{MR}$) input sets all Q outputs LOW, independent of any other input condition.

MODE SELECT – TRUTH TABLE

OPERATING MODES	INPUTS					OUTPUTS				
	$\overline{MR}$	$\overline{PE}$	J	$\overline{K}$	P_n	Q_0	Q_1	Q_2	Q_3	$\overline{Q}_3$
Asynchronous Reset	L	X	X	X	X	L	L	L	L	H
Shift, Set First Stage	H	h	h	h	X	H	q_0	q_1	q_2	$\overline{q}_2$
Shift, Reset First Stage	H	h	l	l	X	L	q_0	q_1	q_2	$\overline{q}_2$
Shift, Toggle First Stage	H	h	h	l	X	$\overline{q}_0$	q_0	q_1	q_2	$\overline{q}_2$
Shift, Retain First Stage	H	h	l	h	X	q_0	q_0	q_1	q_2	$\overline{q}_2$
Parallel Load	H	l	X	X	p_n	p_0	p_1	p_2	p_3	$\overline{p}_3$

L = LOW voltage levels
H = HIGH voltage levels
X = Don't Care
l = LOW voltage level one set-up time prior to the LOW to HIGH clock transition.
h = HIGH voltage level one set-up time prior to the LOW to HIGH clock transition.
p_n (q_n) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the LOW to HIGH clock transition.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				21	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	39		MHz	V_{CC} = 5.0 V, C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay Clock to Output		14 17	22 26	ns	
t_{PHL}	Propagation Delay $\overline{MR}$ to Output		19	30	ns	

AC SETUP REQUIREMENTS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	CP Clock Pulse Width	16			ns	V_{CC} = 5.0 V
t_W	$\overline{MR}$ Pulse Width	12			ns	
t_s	$\overline{PE}$ Setup Time	25			ns	
t_s	Data Setup Time	15			ns	
t_{rec}	Recovery Time	25			ns	
t_{rel}	$\overline{PE}$ Release Time			10	ns	
t_h	Data Hold Time	0			ns	

SETUP TIME (t_s) is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

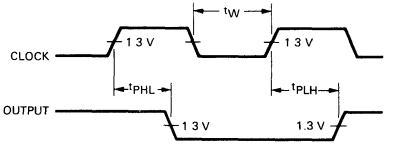
HOLD TIME (t_h) is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW to HIGH in order to recognize and transfer HIGH data to the Q outputs.

AC WAVEFORMS

The shaded areas indicate when the input is permitted to change for predictable output performance.

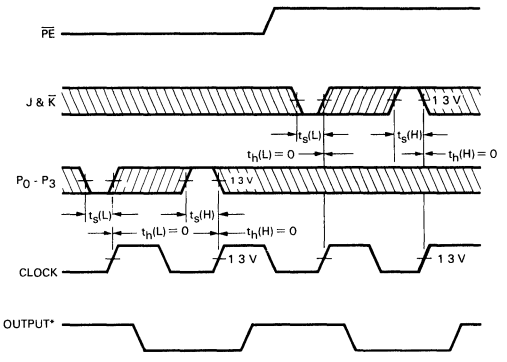
CLOCK TO OUTPUT DELAYS AND CLOCK PULSE WIDTH



CONDITIONS: J = $\overline{PE}$ = $\overline{MR}$ = H
$\overline{K}$ = L

Fig. 1

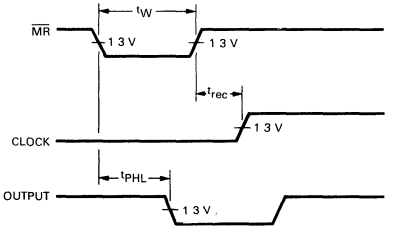
SETUP (t_s) AND HOLD (t_h) TIME FOR SERIAL DATA (J & $\overline{K}$) AND PARALLEL DATA (P_0, P_1, P_2, P_3)



CONDITIONS: $\overline{MR}$ = H
*J and $\overline{K}$ set-up time affects Q_0 only

Fig. 2

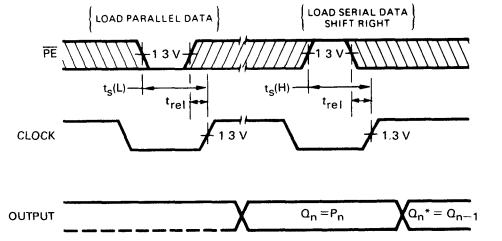
MASTER RESET PULSE WIDTH, MASTER RESET TO OUTPUT DELAY AND MASTER RESET TO CLOCK RECOVERY TIME



CONDITIONS: $\overline{PE}$ = L
$P_0 = P_1 = P_2 = P_3$ = H

Fig. 3

SETUP (t_s) AND HOLD (t_h) TIME FOR $\overline{PE}$ INPUT



CONDITIONS: $\overline{MR}$ = H
*Q_0 state will be determined by J and $\overline{K}$ inputs

Fig. 4

MOTOROLA

SN54LS/74LS196
SN54LS/74LS197

4-STAGE PRESETTABLE RIPPLE COUNTERS

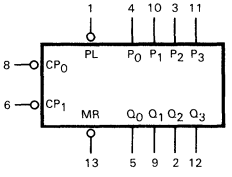
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS196 decade counter is partitioned into divide-by-two and divide-by-five sections which can be combined to count either in BCD (8,4,2,1) sequence or in a bi-quinary mode producing a 50% duty cycle output. The SN54LS/74LS197 contains divide-by-two and divide-by-eight sections which can be combined to form a modulo-16 binary counter. Low Power Schottky technology is used to achieve typical count rates of 70 MHz and power dissipation of only 80 mW.

Both circuit types have a Master Reset ($\overline{MR}$) input which overrides all other inputs and asynchronously forces all outputs LOW. A Parallel Load input ($\overline{PL}$) overrides clocked operations and asynchronously loads the data on the Parallel Data inputs (P_n) into the flip-flops. This preset feature makes the circuits usable as programmable counters. The circuits can also be used as 4-bit latches, loading data from the Parallel Data inputs when $\overline{PL}$ is LOW and storing the data when $\overline{PL}$ is HIGH.

- **LOW POWER CONSUMPTION — TYPICALLY 80 mW**
- **HIGH COUNTING RATES — TYPICALLY 70 MHz**
- **CHOICE OF COUNTING MODES — BCD, BI-QUINARY, BINARY**
- **ASYNCHRONOUS PRESETTABLE**
- **ASYNCHRONOUS MASTER RESET**
- **EASY MULTISTAGE CASCADING**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

LOGIC SYMBOL

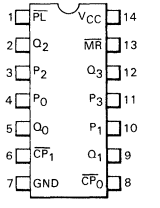


V_{CC} = Pin 14
GND = Pin 7

PIN NAMES		LOADING (Note a) HIGH	LOW
$\overline{CP}_0$	Clock (Active LOW Going Edge) Input to Divide-by-Two Section	1.0 U.L.	1.5 U.L.
$\overline{CP}_1$ (LS196)	Clock (Active LOW Going Edge) Input to Divide-by-Five Section	2.0 U.L.	1.75 U.L.
$\overline{CP}_1$ (LS197)	Clock (Active LOW Going Edge) Input to Divide-by-Eight Section	1.0 U.L.	0.8 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	1.0 U.L.	0.5 U.L.
$\overline{PL}$	Parallel Load (Active LOW) Input	0.5 U.L.	0.25 U.L.
P_0-P_3	Data Inputs	0.5 U.L.	0.25 U.L.
Q_0-Q_3	Outputs (Notes b, c)	10 U.L.	5(2.5) U.L.

NOTES:
a 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.
c In addition to loading shown, Q_0 can also drive $\overline{CP}_1$.

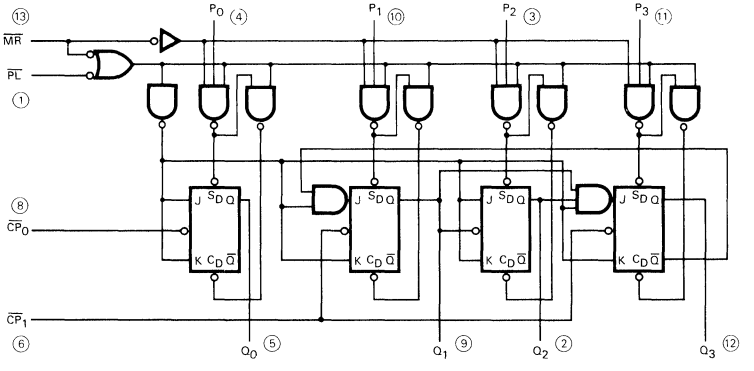
CONNECTION DIAGRAM DIP (TOP VIEW)



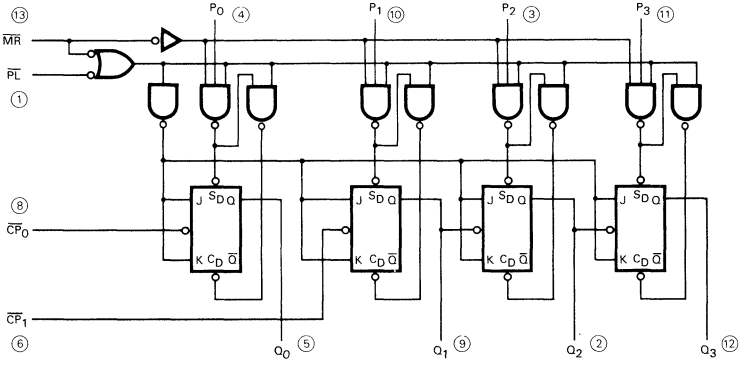
J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAM



LS196



LS197

V_{CC} = Pin 14
GND = Pin 7
◯ = Pin Numbers

FUNCTIONAL DESCRIPTION — The LS196 and LS197 are asynchronously presettable decade and binary ripple counters. The LS196 Decade Counter is partitioned into divide-by-two and divide-by-five sections while the LS197 is partitioned into divide-by-two and divide-by-eight sections, with all sections having a separate Clock input. In the counting modes, state changes are initiated by the HIGH to LOW transition of the clock signals. State changes of the Q outputs, however, do not occur simultaneously because of the internal ripple delays. When using external logic to decode the Q outputs, designers should bear in mind that the unequal delays can lead to decoding spikes and thus a decoded signal should not be used as a clock or strobe. The $\overline{CP_0}$ input serves the Q_0 flip-flop in both circuit types while the $\overline{CP_1}$ input serves the divide-by-five or divide-by-eight section. The Q_0 output is designed and specified to drive the rated fan-out plus the $\overline{CP_1}$ input. With the input frequency connected to $\overline{CP_0}$ and Q_0 driving $\overline{CP_1}$, the LS197 forms a straightforward module-16 counter, with Q_0 the least significant output and Q_3 the most significant output.

The LS196 Decade Counter can be connected up to operate in two different count sequences, as indicated in the tables of Figure 2. With the input frequency connected to $\overline{CP_0}$ and with Q_0 driving $\overline{CP_1}$, the circuit counts in the BCD (8, 4, 2, 1) sequence. With the input frequency connected to $\overline{CP_1}$ and Q_3 driving $\overline{CP_0}$, Q_0 becomes the low frequency output and has a 50% duty cycle waveform. Note that the maximum counting rate is reduced in the latter (bi-quinary) configuration because of the interstage gating delay within the divide-by-five section.

The LS196 and LS197 have an asynchronous active LOW Master Reset input (MR) which overrides all other inputs and forces all outputs LOW. The counters are also asynchronously presettable. A LOW on the Parallel Load input (PL) overrides the clock inputs and loads the data from Parallel Data (P_0—P_3) inputs into the flip-flops. While PL is LOW, the counters act as transparent latches and any change in the P_n inputs will be reflected in the outputs.

4

Figure 2: LS196 COUNT SEQUENCES

DECADE (NOTE 1)					BI-QUINARY (NOTE 2)				
COUNT	Q_3	Q_2	Q_1	Q_0	COUNT	Q_0	Q_3	Q_2	Q_1
0	L	L	L	L	0	L	L	L	L
1	L	L	L	H	1	L	L	L	H
2	L	L	H	L	2	L	L	H	L
3	L	L	H	H	3	L	L	H	H
4	L	H	L	L	4	L	H	L	L
5	L	H	L	H	5	H	L	L	L
6	L	H	H	L	6	H	L	L	H
7	L	H	H	H	7	H	L	H	L
8	H	L	L	L	8	H	L	H	H
9	H	L	L	H	9	H	H	L	L

NOTES:
1. Signal applied to CP_0, Q_0 connected to CP_1.
2. Signal applied to CP_1, Q_3 connected to CP_0.

MODE SELECT TABLE

INPUTS			RESPONSE
$\overline{MR}$	$\overline{PL}$	$\overline{CP}$	
L	X	X	Reset (Clear)
H	L	X	Parallel Load
H	H	⌐	Count

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
⌐ = HIGH to Low Clock Transition

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current Data, $\overline{PL}$ $\overline{MR}$, $\overline{CP_0}$ (LS196) $\overline{MR}$, $\overline{CP_0}$, $\overline{CP_1}$ (LS197) $\overline{CP_1}$ (LS196)				20 40 40 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Data, $\overline{PL}$ $\overline{MR}$, $\overline{CP_0}$ (LS196) $\overline{MR}$, $\overline{CP_0}$, $\overline{CP_1}$ (LS197) $\overline{CP_1}$ (LS196)				0.1 0.2 0.2 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Data, $\overline{PL}$ $\overline{MR}$ $\overline{CP_0}$ $\overline{CP_1}$ (LS196) $\overline{CP_1}$ (LS197)				−0.4 −0.8 −2.4 −2.8 −1.3	mA	V_{CC} = MAX = V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				27	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS						UNITS	TEST CONDITIONS
		LS196			LS197				
		MIN	TYP	MAX	MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	30	40		30	40		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	$\overline{CP_0}$ Input to Q_0 Output		8.0 13	15 20		8.0 14	15 21	ns	
t_{PLH} t_{PHL}	$\overline{CP_1}$ Input to Q_1 Output		16 22	24 33		12 23	19 35	ns	
t_{PLH} t_{PHL}	$\overline{CP_1}$ Input to Q_2 Output		38 41	57 62		34 42	51 63	ns	
t_{PLH} t_{PHL}	$\overline{CP_1}$ Input to Q_3 Output		12 30	18 45		55 63	78 95	ns	
t_{PLH} t_{PHL}	Data to Output		20 29	30 44		18 29	27 44	ns	
t_{PLH} t_{PHL}	$\overline{PL}$ Input to Any Output		27 30	41 45		26 30	39 45	ns	
t_{PHL}	$\overline{MR}$ Input to Any Output		34	51		34	51	ns	

4

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS						UNITS	TEST CONDITIONS
		LS196			LS197				
		MIN	TYP	MAX	MIN	TYP	MAX		
t_W	$\overline{CP_0}$ Pulse Width	20			20			ns	$V_{CC} = 5.0$ V
t_W	$\overline{CP_1}$ Pulse Width	30			30			ns	
t_W	$\overline{PL}$ Pulse Width	20			20			ns	
t_W	$\overline{MR}$ Pulse Width	15			15			ns	
t_s	Data Input Setup Time — HIGH	10			10			ns	
t_s	Data Input Setup Time — LOW	15			15			ns	
t_h	Data Hold Time — HIGH	$t_W(\overline{PL})$			$t_W(\overline{PL})$			ns	
t_h	Data Hold Time — LOW	$t_W(\overline{PL})$			$t_W(\overline{PL})$			ns	
t_{rec}	Recovery Time	30			30			ns	

DEFINITIONS OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from HIGH to LOW in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from HIGH to LOW that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from HIGH to LOW and still be recognized.

RECOVERY TIME (t_{rec}) — is defined as the minimum time required between the end of the reset pulse and the clock transition from HIGH to LOW in order to recognize and transfer LOW Data to the Q outputs.

AC WAVEFORMS

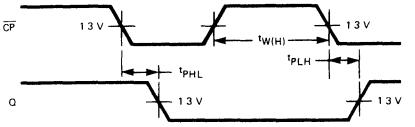
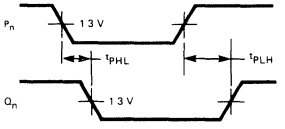


Fig. 1



NOTE: $\overline{PL}$ = LOW

Fig. 2

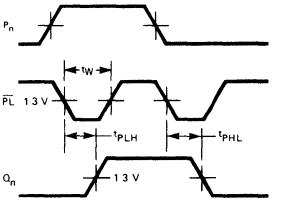


Fig. 3

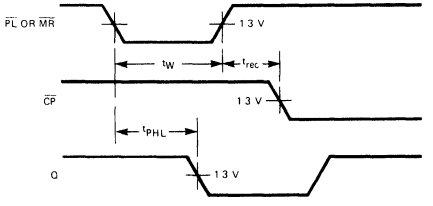
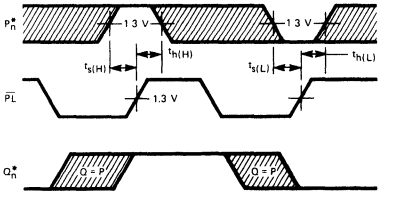


Fig. 4



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 5

MOTOROLA

SN54LS221
SN74LS221

DUAL MONOSTABLE MULTIVIBRATORS WITH SCHMITT-TRIGGER INPUTS

LOW POWER SCHOTTKY

DESCRIPTION — Each multivibrator of the LS221 features a negative-transition-triggered input and a positive-transition-triggered input either of which can be used as an inhibit input.

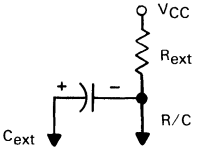
Pulse triggering occurs at a voltage level and is not related to the transition time of the input pulse. Schmitt-trigger input circuitry for B input allows jitter-free triggering for inputs as slow as 1 volt/second, providing the circuit with excellent noise immunity. A high immunity to V_{CC} noise is also provided by internal latching circuitry.

Once triggered, the outputs are independent of further transitions of the inputs and are a function of the timing components. The output pulses can be terminated by the overriding clear. Input pulse width may be of any duration relative to the output pulse width. Output pulse width may be varied from 35 nanoseconds to a maximum of 70 s by choosing appropriate timing components. With R_{ext} = 2 kΩ and C_{ext} = 0, a typical output pulse of 30 nanoseconds is achieved. Output rise and fall times are independent of pulse length.

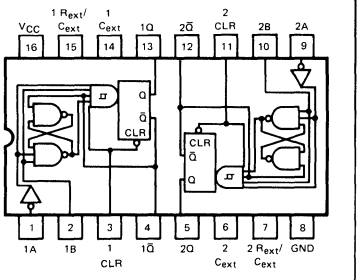
Pulse width stability is achieved through internal compensation and is virtually independent of V_{CC} and temperature. In most applications, pulse stability will only be limited by the accuracy of external timing components.

Jitter-free operation is maintained over the full temperature and V_{CC} ranges for greater than six decades of timing capacitance (10pF to 10 μF), and greater than one decade of timing resistance (2 to 70 kΩ for the SN54LS221, and 2 to 100 kΩ for the SN74LS221). Pulse width is defined by the relationship: $t_{W(out)} = C_{ext}R_{ext} \ln 2 \approx 0.7\, C_{ext}R_{ext}$. If pulse cutoff is not critical, capacitance up to 1000 μF and resistance as low as 1.4 kΩ may be used. The range of jitter-free pulse widths is extended if V_{CC} is 5 V and 25°C temperature.

- **SN54LS221 and SN74LS221 IS A DUAL HIGHLY STABLE ONE-SHOT**
- **OVERRIDING CLEAR TERMINATES OUTPUT PULSE**
- **PIN OUT IS IDENTICAL TO SN54LS/74LS123**



(TOP VIEW)



positive logic Low input to clear resets Q low and Q̄ high regardless of d-c levels at A or B inputs.

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

FUNCTION TABLE

(EACH MONOSTABLE)

INPUTS			OUTPUTS	
CLEAR	A	B	Q	Q̄
L	X	X	L	H
X	H	X	L	H
X	X	L	L	H
H	L	↑	⎍	⎎
H	↓	H	⎍	⎎
↑	L	H	⎍	⎎

TYPE	TYPICAL POWER DISSIPATION	MAXIMUM OUTPUT PULSE LENGTH
SN54LS221	23 mW	49 s
SN74LS221	23 mW	70 s

Once in the pulse trigger mode, the output pulse width is determined by $t_W = R_{ext}C_{ext}\ln 2$, as long as R_{ext} and C_{ext} are within their minimum and maximum valves and the duty cycle is less than 50%. This pulse width is essentially independent of V_{CC} and temperature variations. Output pulse widths varies typically no more than ±0.5% from device to device.

If the duty cycle, defined as being $100 \bullet \frac{t_W}{T}$ where T is the period of the input pulse, rises above 50%, the output pulse width will become shorter. If the duty cycle varies between low and high valves, this causes the output pulse width to vary in length, or jitter. To reduce jitter to a minimum, R_{ext} should be as large as possible. (Jitter is independent of C_{ext}). With $R_{ext} = 100K$, jitter is not appreciable until the duty cycle approaches 90%.

Although the LS221 is pin-for-pin compatible with the LS123, it should be remembered that they are not functionally identical. The LS123 is retriggerable so that the output is dependent upon the input transitions once it is high. This is not the case for the LS221. Also note that it is recommended to externally ground the LS123 C_{ext} pin. However, this cannot be done on the LS221.

The SN54LS/74LS221 is a dual, monolithic, non-retriggerable, high-stability one shot. The output pulse width, t_W can be varied over 9 decades of timing by proper selection of the external timing components, R_{ext} and C_{ext}.

Pulse triggering occurs at a voltage level and is, therefore, independent of the input slew rate. Although all three inputs have this Schmitt-trigger effect, only the B input should be used for very long transition triggers ($\geqslant 1.0\,\mu V/s$). High immunity to V_{CC} noise (typically 1.5 V) is achieved by internal latching circuitry. However, standard V_{CC} bypassing is strongly recommended.

The LS221 has four basic modes of operation.

Clear Mode: If the clear input is held low, irregardless of the previous output state and other input states, the Q output is low.

Inhibit Mode: If either the A input is high or the B input is low, once the Q output goes low, it cannot be retriggered by other inputs.

Pulse Trigger Mode: This occurs when none of the other modes are in effect and the Q output is low. A proper transition by either the CLR, A or B input, as shown in the truth table, will cause the Q output to go high and remain high for the pulse time t_W.

Once triggered, as long as the output remains high, all input transitions (except for Clear, see Note 4) are ignored.

Overriding Clear Mode: If the Q output is high, it may be forced low by bringing the clear input low.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{T+}	Positive-Going Threshold Voltage at A Input			1.0	2.0	V	V_{CC} = MIN
V_{T-}	Negative-Going Threshold Voltage at A Input	54	0.7	1.0		V	V_{CC} = MIN
		74	0.8	1.0		V	
V_{T+}	Positive-Going Threshold Voltage at B Input			1.0	2.0	V	V_{CC} = MIN
V_{T-}	Negative-Going Threshold Voltage at B Input	54	0 7	0.9		V	V_{CC} = MIN
		74	0.8	0.9		V	
V_{IK}	Input Clamp Voltage				−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = MAX
		74	2.7	3.4		V	
V_{OL}	Output LOW Voltage	54		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = MIN
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0 1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Input A Input B Clear				 −0.4 −0.8 −0.8	 mA	V_{CC} = MAX, V_{IN} = 0 4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Quiescent			4.7	11	mA	V_{CC} = MAX
	Triggered			19	27		

AC CHARACTERISTICS: V_{CC} = 5.0 V, T_A = 25°C

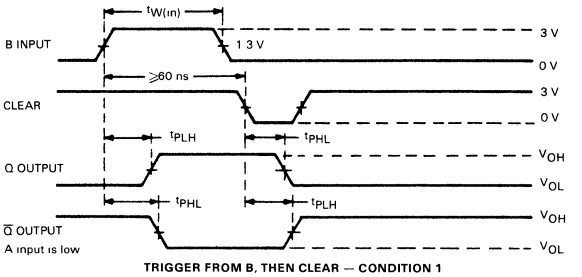
SYMBOL	FROM (INPUT)	TO (OUTPUT)	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNIT	TEST CONDITIONS	
t_{PLH}	A	Q		45	70	ns	C_L=15 pF, See Figure 1	C_{ext} = 80 pF, R_{ext} = 2 kΩ
	B	Q		35	55			
t_{PHL}	A	$\overline{Q}$		50	80	ns		
	B	$\overline{Q}$		40	65			
t_{PHL}	Clear	Q		35	55	ns		
t_{PLH}	Clear	$\overline{Q}$		44	65	ns		
$t_{W(out)}$	A or B	Q or $\overline{Q}$	70	120	150	ns		C_{ext} = 80 pF, R_{ext} = 2 Ω
			20	47	70			C_{ext} = 0, R_{ext} = 2 kΩ
			600	670	750			C_{ext} = 100 pF, R_{ext} = 10 kΩ
			6	6.9	7.5	ms		C_{ext} = 1 μF, R_{ext} = 10 kΩ

AC SETUP REQUIREMENTS V_{CC} = 5.0 V, T_A = 25°C

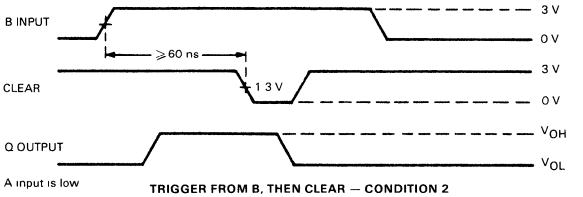
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS
dv/dt	Rate of Rise or Fall of Input Pulse — Schmitt, B		1.0			V/s
	Rate of Rise or Fall of Input Pulse — Logic Input, A		1.0			V/μs
t_W	Input Pulse Width — A or B, $t_{W(in)}$		40			ns
	Input Pulse Width — Clear, t_W (clear)		40			
t_s	Clear-Inactive-State Setup Time		15			ns
R_{ext}	External Timing Resistance	54	1.4		70	kΩ
		74	1.4		100	
C_{ext}	External Timing Capacitance		0		1000	μF
	Output Duty Cycle — RT = 2.0 kΩ				50	%
	Output Duty Cycle — R_T = MAX R_{ext}				90	

4

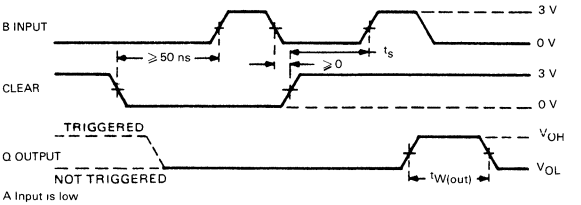
AC WAVEFORMS



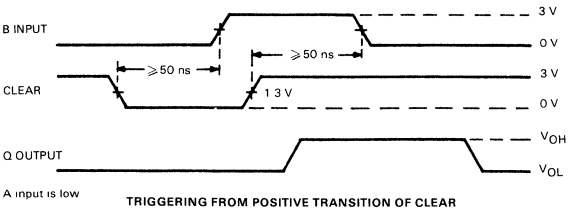
TRIGGER FROM B, THEN CLEAR — CONDITION 1



TRIGGER FROM B, THEN CLEAR — CONDITION 2



CLEAR OVERRIDING B, THEN TRIGGER FROM B



TRIGGERING FROM POSITIVE TRANSITION OF CLEAR

Fig. 1

MOTOROLA

SN54LS/74LS240
SN54LS/74LS241
SN54LS/74LS244

DESCRIPTION — The SN54LS/74LS240, 241 and 244 are Octal Buffers and Line Drivers designed to be employed as memory address drivers, clock drivers and bus-oriented transmitters/receivers which provide improved PC board density

- HYSTERESIS AT INPUTS TO IMPROVE NOISE MARGINS
- 3-STATE OUTPUTS DRIVE BUS LINES OR BUFFER MEMORY ADDRESS REGISTERS
- INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

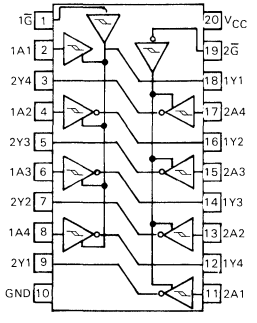
OCTAL BUFFER/LINE DRIVER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

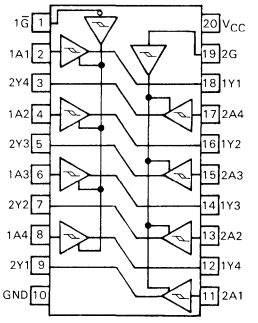
4

LOGIC AND CONNECTION DIAGRAMS DIP (TOP VIEW)

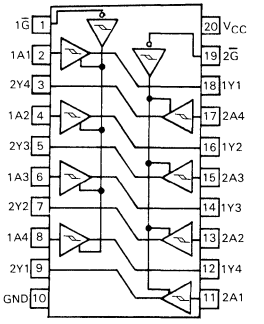
SN54LS/74LS240



SN54LS/74LS241



SN54LS/74LS244



TRUTH TABLES

SN54LS/74LS240

INPUTS		OUTPUT
$1\bar{G},2\bar{G}$	D	
L	L	H
L	H	L
H	X	(Z)

SN54LS/74LS244

INPUTS		OUTPUT
$1\bar{G},2\bar{G}$	D	
L	L	L
L	H	H
H	X	(Z)

SN54LS/74LS241

INPUTS		OUTPUT	INPUTS		OUTPUT
$1\bar{G}$	D		2G	D	
L	L	L	H	L	L
L	H	H	H	H	H
H	X	(Z)	L	X	(Z)

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = HIGH Impedance

J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−3.0	mA
		54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
$V_{T+} - V_{T-}$	Hysteresis		0.2	0.4		V	V_{CC} = MIN
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN, I_{OH} = −3.0 mA
		54,74	2.0			V	V_{CC} = MIN, I_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				27	mA	V_{CC} = MAX
	Total, Output LOW	LS240			44		
		LS241/244			46		
	Total at HIGH Z	LS240			50		
		LS241/244			54		

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0\ V$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, Data to Output LS240		9.0 12	14 18	ns	$C_L = 45\ pF$, $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Data to Output LS241/244		12 12	18 18	ns	
t_{PZH}	Output Enable Time to HIGH Level		15	23	ns	
t_{PZL}	Output Enable Time to LOW Level		20	30	ns	
t_{PLZ}	Output Disable Time from LOW Level		15	25	ns	$C_L = 5.0\ pF$ $R_L = 667\ \Omega$
t_{PHZ}	Output Disable Time from HIGH Level		10	18	ns	

AC WAVEFORMS

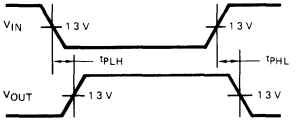


Fig.1

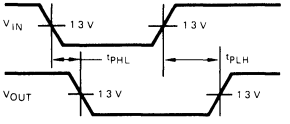


Fig. 2

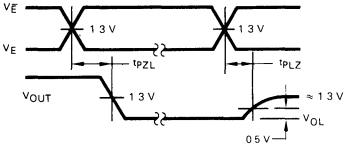


Fig. 3

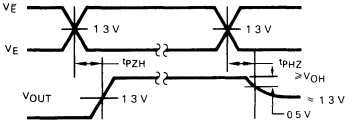
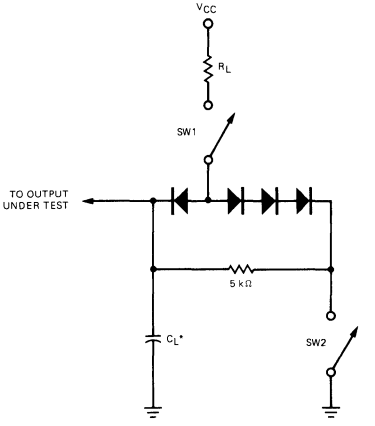


Fig. 4



SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 5

MOTOROLA

SN54LS/74LS242
SN54LS/74LS243

QUAD BUS TRANSCEIVER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS242 and SN54LS/74LS243 are Quad Bus Transmitters/Receivers designed for 4-line asynchronous 2-way data communications between data buses.

- HYSTERISIS AT INPUTS TO IMPROVE NOISE IMMUNITY
- 2-WAY ASYNCHRONOUS DATA BUS COMMUNICATION
- INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

TRUTH TABLES

SN54LS/74LS242

INPUTS		OUTPUT	INPUTS		OUTPUT
$\overline{G}$AB	D		GAB	D	
L	L	H	L	X	(Z)
L	H	L	H	L	H
H	X	(Z)	H	H	L

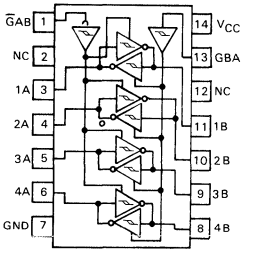
H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = HIGH Impedence

SN54LS/74LS243

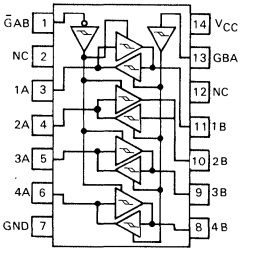
INPUTS		OUTPUT	INPUTS		OUTPUT
$\overline{G}$AB	D		GAB	D	
L	L	L	L	X	(Z)
L	H	H	H	L	L
H	X	(Z)	H	H	H

LOGIC AND CONNECTION DIAGRAMS
DIP (TOP VIEW)

SN54LS/74LS242



SN54LS/74LS243



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−3.0	mA
		54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
$V_{T+} - V_{T-}$	Hysteresis		0.2	0.4		V	V_{CC} = MIN
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN I_{OH} = −3.0 mA
		54,74	2.0			V	V_{CC} = MIN, I_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				40	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−200	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current	D, $\overline{E}_1$, E_2			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		$\overline{E}_1$, E_2			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		D Input			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V
I_{IL}	Input LOW Current				−0.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				38	mA	V_{CC} = MAX
	Total, Output LOW				50		
	Total at HIGH Z	LS242			50		
		LS243			54		

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS						UNITS	TEST CONDITIONS
		LS242			LS243				
		MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		9.0 12	14 18		12 12	18 18	ns	$C_L = 45$ pF $R_L = 667\ \Omega$
t_{PZH}	Output Enable Time to HIGH Level		15	23		15	23	ns	
t_{PZL}	Output Enable Time to LOW Level		20	30		20	30	ns	
t_{PLZ}	Output Disable Time from LOW Level		15	25		15	25	ns	$C_L = 5.0$ pF $R_L = 667\ \Omega$
t_{PHZ}	Output Disable Time from HIGH Level		10	18		10	18	ns	

AC WAVEFORMS

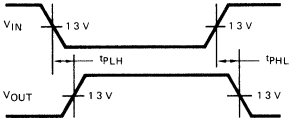


Fig.1

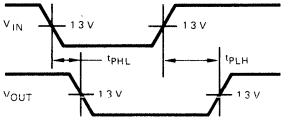


Fig. 2

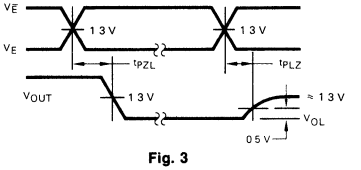


Fig. 3

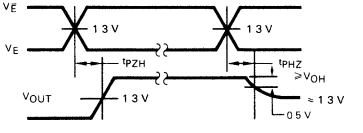
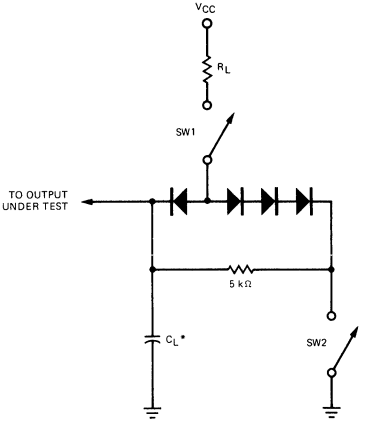


Fig. 4



SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 5

MOTOROLA

SN54LS245
SN74LS245

OCTAL BUS TRANSCEIVER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS245 is an Octal Bus Transmitter/Receiver designed for 8-line asynchronous 2-way data communication between data buses. Direction Input (DR) controls transmission of Data from bus A to bus B or bus B to bus A depending upon its logic level. The Enable input ($\overline{E}$) can be used to isolate the buses.

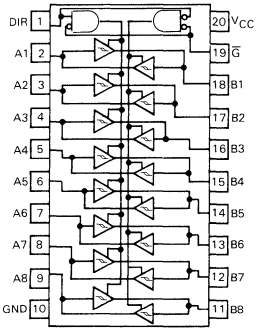
- HYSTERESIS INPUTS TO IMPROVE NOISE IMMUNITY
- 2-WAY ASYNCHRONOUS DATA BUS COMMUNICATION
- INPUT DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

TRUTH TABLE

INPUTS		OUTPUT
$\overline{G}$	DIR	
L	L	Bus B Data to Bus A
L	H	Bus A Data to Bus B
H	X	Isolation

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

LOGIC AND CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−3.0	mA
		54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
$V_{T+}-V_{T-}$	Hysteresis		0.2	0.4		V	V_{CC} = MIN	
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN, I_{OH} = −3.0 mA	
		54,74	2.0			V	V_{CC} = MIN, I_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW				−200	μA	V_{CC} = MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current	A or B, DR or $\overline{E}$			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
		DR or $\overline{E}$			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
		A or B			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V	
I_{IL}	Input LOW Current				−0.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Output Short Circuit Current		−40		−225	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				70	mA	V_{CC} = MAX	
	Total, Output LOW				90			
	Total at HIGH Z				95			

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		8.0 8.0	12 12	ns	C_L = 45 pF R_L = 667 Ω
t_{PZH}	Output Enable Time to HIGH Level		25	40	ns	
t_{PZL}	Output Enable Time to LOW Level		27	40	ns	
t_{PLZ}	Output Disable Time from LOW Level		15	25	ns	C_L = 5.0 pF R_L = 667 Ω
t_{PHZ}	Output Disable Time from HIGH Level		15	25	ns	

MOTOROLA

SN54LS/74LS247
SN54LS/74LS248
SN54LS/74LS249

BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS247 thru SN54LS/74LS249 are BCD-to-Seven-Segment Decoder/Drivers.

The LS247 and LS248 are functionally and electrically identical to the LS47 and LS48 with the same pinout configuration. The LS249 is a 16-pin version of the 14-pin LS49 and includes full functional capability for lamp test and ripple blanking which was not available in the LS49.

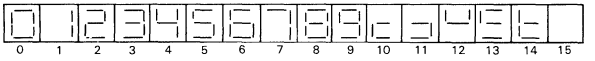
The composition of all characters, except the 6 and 9 are identical between the LS247, 248, 249 and the LS47, 48 and 49. The LS47 thru 49 compose the 6 and 9 without tails, the LS247 thru 249 compose the 6 and 9 with the tails. The LS247 has active-low outputs for direct drive of indicators. The LS248 and 249 have active-high outputs for driving lamp buffers.

All types feature a lamp test input and have full ripple-blanking input/output controls. On all types an automatic leading and/or trailing-edge zero-blanking control (RBI and RBO) is incorporated and an overriding blanking input (BI) is contained which may be used to control the lamp intensity by pulsing or to inhibit the output's lamp test may be performed at any time when the BI/RBO node is at high level. Segment identification and resultant displays are shown below. Display pattern for BCD input counts above 9 are unique symbols to authenticate input conditions.

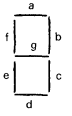
LS247
- **OPEN-COLLECTOR OUTPUTS DRIVE INDICATORS DIRECTLY**
- **LAMP-TEST PROVISION**
- **LEADING/TRAILING ZERO SUPPRESSION**

LS248
- **INTERNAL PULL-UPS ELIMINATE NEED FOR EXTERNAL RESISTORS**
- **LAMP-TEST PROVISION**
- **LEADING/TRAILING ZERO SUPPRESSION**

LS249
- **OPEN-COLLECTOR OUTPUTS**
- **LAMP-TEST PROVISION**
- **LEADING/TRAILING ZERO SUPPRESSION**

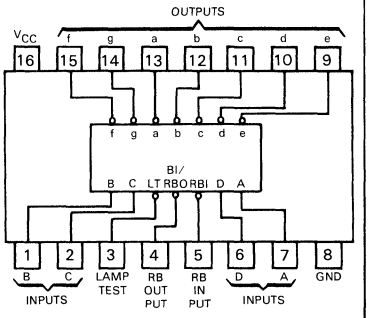


NUMERICAL DESIGNATIONS AND RESULTANT DISPLAYS

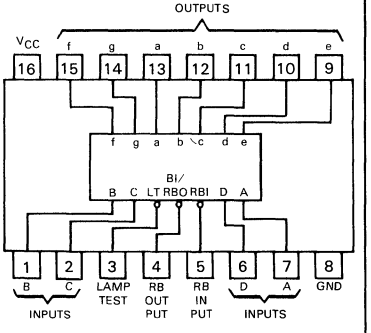


SEGMENT IDENTIFICATION

SN54LS/74LS247
(TOP VIEW)



SN54LS/74LS248
SN54LS/74LS249
(TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

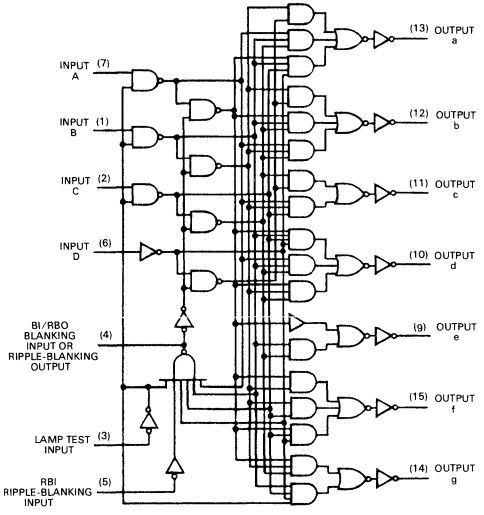
4

ALL CIRCUIT TYPES FEATURE LAMP INTENSITY MODULATION CAPABILITY

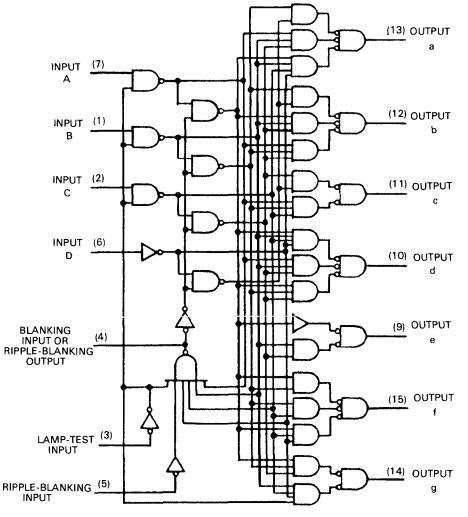
TYPE	DRIVER OUTPUTS				TYPICAL POWER DISSIPATION
	ACTIVE LEVEL	OUTPUT CONFIGURATION	SINK CURRENT	MAX VOLTAGE	
SN54LS247	low	open-collector	12 mA	15 V	35 mW
SN54LS248	high	2-kΩ pull-up	2.0 mA	5.5 V	125 mW
SN54LS249	high	open-collector	4.0 mA	5.5 V	40 mW
SN74LS247	low	open-collector	24 mA	15 V	35 mW
SN74LS248	high	2-kΩ pull-up	6.0 mA	5.5 V	125 mW
SN74LS249	high	open-collector	8.0 mA	5.5 V	40 mW

LOGIC DIAGRAM

LS247



LS248, LS249



LS247
FUNCTION TABLE

DECIMAL OR FUNCTION	INPUTS						BI/RBO†	OUTPUTS							NOTE
	LT	RBI	D	C	B	A		a	b	c	d	e	f	g	
0	H	H	L	L	L	L	H	ON	ON	ON	ON	ON	ON	OFF	
1	H	X	L	L	L	H	H	OFF	ON	ON	OFF	OFF	OFF	OFF	
2	H	X	L	L	H	L	H	ON	ON	OFF	ON	ON	OFF	ON	
3	H	X	L	L	H	H	H	ON	ON	ON	ON	OFF	OFF	ON	
4	H	X	L	H	L	L	H	OFF	ON	ON	OFF	OFF	ON	ON	
5	H	X	L	H	L	H	H	ON	OFF	ON	ON	OFF	ON	ON	
6	H	X	L	H	H	L	H	ON	OFF	ON	ON	ON	ON	ON	
7	H	X	L	H	H	H	H	ON	ON	ON	OFF	OFF	OFF	OFF	1
8	H	X	H	L	L	L	H	ON	ON	ON	ON	ON	ON	ON	
9	H	X	H	L	L	H	H	ON	ON	ON	ON	OFF	ON	ON	
10	H	X	H	L	H	L	H	OFF	OFF	OFF	ON	ON	OFF	ON	
11	H	X	H	L	H	H	H	OFF	OFF	ON	ON	OFF	OFF	ON	
12	H	X	H	H	L	L	H	OFF	ON	OFF	OFF	OFF	ON	ON	
13	H	X	H	H	L	H	H	ON	OFF	OFF	ON	OFF	ON	ON	
14	H	X	H	H	H	L	H	OFF	OFF	OFF	ON	ON	ON	ON	
15	H	X	H	H	H	H	H	OFF	OFF	OFF	OFF	OFF	OFF	OFF	
BI	X	X	X	X	X	X	L	OFF	OFF	OFF	OFF	OFF	OFF	OFF	2
RBI	H	L	L	L	L	L	L	OFF	OFF	OFF	OFF	OFF	OFF	OFF	3
LT	L	X	X	X	X	X	H	ON	ON	ON	ON	ON	ON	ON	4

LS248, LS249
FUNCTION TABLE

DECIMAL OR FUNCTION	INPUTS						BI/RBO†	OUTPUTS							NOTE
	LT	RBI	D	C	B	A		a	b	c	d	e	f	g	
0	H	H	L	L	L	L	H	H	H	H	H	H	H	L	1
1	H	X	L	L	L	H	H	L	H	H	L	L	L	L	1
2	H	X	L	L	H	L	H	H	H	L	H	H	L	H	
3	H	X	L	L	H	H	H	H	H	H	H	L	L	H	
4	H	X	L	H	L	L	H	L	H	H	L	L	H	H	
5	H	X	L	H	L	H	H	H	L	H	H	L	H	H	
6	H	X	L	H	H	L	H	H	L	H	H	H	H	H	
7	H	X	L	H	H	H	H	H	H	H	L	L	L	L	1
8	H	X	H	L	L	L	H	H	H	H	H	H	H	H	
9	H	X	H	L	L	H	H	H	H	H	H	L	H	H	
10	H	X	H	L	H	L	H	L	L	L	H	H	L	H	
11	H	X	H	L	H	H	H	L	L	H	H	L	L	H	
12	H	X	H	H	L	L	H	L	H	L	L	L	H	H	
13	H	X	H	H	L	H	H	H	L	L	H	L	H	H	
14	H	X	H	H	H	L	H	L	L	L	H	H	H	H	
15	H	X	H	H	H	H	H	L	L	L	L	L	L	L	
BI	X	X	X	X	X	X	L	L	L	L	L	L	L	L	2
RBI	H	L	L	L	L	L	L	L	L	L	L	L	L	L	3
LT	L	X	X	X	X	X	H	H	H	H	H	H	H	H	4

H = high level, L = low level, X = irrelevant

NOTES: 1. The blanking input (BI) must be open or held at a high logic level when output functions 0 through 15 are desired. The ripple-blanking input (RBI) must be open or high if blanking of a decimal zero is not desired.
2. When a low logic level is applied directly to the blanking input (BI), all segment outputs are off regardless of the level of any other input.
3. When ripple-blanking input (RBI) and inputs A, B, C, and D are at a low level with the lamp test input high, all segment outputs go off and the ripple-blanking output (RBO) goes to a low level (response condition).
4. When the blanking input/ripple blanking output (BI/RBO) is open or held high and a low is applied to the lamp-test input, all segment outputs are on.

†BI/RBO is wire-AND logic serving as blanking input (BI) and/or ripple-blanking output (RBO).

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High BI/RBO	54,74			−50	μA
I_{OL}	Output Current — Low BI/RBO	54 74			1.6 3.2	mA
$V_{O(off)}$	Off-State Output Voltage a—g	54,74			15	V
$I_{O(on)}$	On-State Output Current a—g a—g	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	4.2		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
	BI/RBO	74	2.4	4.2		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 1.6 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
	BI/RBO	74		0.35	0.5	V	I_{OL} = 3.2 mA
$I_{O(off)}$	Off-State Output Current a—g	54,74			250	μA	V_{CC} = MAX, V_{IH} = 2.0 V, $V_{O(off)}$ = 15 V, V_{IL} = MAX
$V_{O(on)}$	On-State Output Voltage	54,74		0.25	0.4	V	$I_{O(on)}$ = 12 mA; V_{CC} = MIN, V_{IH} = 2.0 V, V_{IL} per Truth Table
	a—g	74		0.35	0.5	V	$I_{O(on)}$ = 24 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Any Input, except BI/RBO				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	BI/RBO				−1.2		
I_{OS}	Short Circuit Current BI/RBO		−0.3		−2.0	mA	V_{CC} = MAX
I_{CC}	Power Supply Current			7.0	13	mA	V_{CC} = MAX

AC CHARACTERISTICS: V_{CC} = 5.0 V, T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Turn-Off Time from A Input Turn-On Time from A Input			100 100	ns	C_L = 15 pF, R_L = 665 Ω
t_{PHL} t_{PLH}	Turn-Off Time from RBI Input Turn-On Time from RBI Input			100 100	ns	

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High BI/RBO	54,74			−50	μA
	a—g	54,74			−100	
I_{OL}	Output Current — Low BI/RBO BI/RBO	54 74			1.6 3.2	mA
	a—g a—g	54 74			2.0 6.0	

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.4	4.2		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
	a—g and BI/RBO	74	2.4	4.2		V		
I_O	Output Current a—g	54,74	−1.3	−2.0		mA	V_{CC} = MIN, V_O = 0.85 V, Input Conditions as for V_{OH}	
V_{OL}	Output LOW Voltage a—g	54,74		0.25	0.4	V	I_{OL} = 2.0 mA	V_{CC} = MIN, V_{IH} = 2.0 V, V_{IL} = per Truth Table
		74		0.35	0.5		I_{OL} = 6.0 mA	
	BI/RBO	54,74		0.25	0.4	V	I_{OL} = 1.6 mA	
		74		0.35	0.5		I_{OL} = 3.2 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
	Any Input, except BI/RBO				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current Any Input, except BI/RBO				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
	BI/RBO				−1.2			
I_{OS}	Short Circuit Current BI/RBO		−0.3		−2.0	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current			25	38	mA	V_{CC} = MAX	

AC CHARACTERISTICS: V_{CC} = 5.0 V, T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL} t_{PLH}	Propagation Delay Time, High-to-Low-Level Output from A Input Propagation Delay Time, Low-to-High-Level Output from A Input			100 100	ns	C_L = 15 pF, R_L = 4.0 kΩ
t_{PHL} t_{PLH}	Propagation Delay Time, High-to-Low-Level Output from RBI Input Propagation Delay Time, Low-to-High-Level Output from RBI Input			100 100	ns	C_L = 15 pF, R_L = 6.0 kΩ

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER			MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage		54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range		54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	BI/RBO	54,74			−50	μA
I_{OL}	Output Current — Low	BI/RBO BI/RBO	54 74			1.6 3.2	mA
V_{OH}	Output Voltage — High	a—g	54,74			5.5	V
I_{OL}	Output Current — Low	a—g a—g	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	4.2		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
	BI/RBO	74	2.4	4.2		V	
I_{OH}	Output HIGH Current a—g	54,74			250	μA	V_{CC} = MIN, V_{IH} = 2.0 V, V_{OH} = 5.5 V, V_{IL} = MAX
V_{OL}	Output LOW Voltage						
	BI/RBO	54,74		0.25	0.4	V	I_{OL} = 1.6 mA; V_{CC} = MIN, V_{IH} = 2.0 V, V_{IL} = per Truth Table
		74		0.35	0.5		I_{OL} = 3.2 mA
	a—g	54,74		0.25	0.4	V	I_{OL} = 4.0 mA
		74		0.35	0.5		I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Any Input, except BI/RBO				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Any Input, except BI/RBO				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	BI/RBO				−1.2		
I_{OS}	Short Circuit Current BI/RBO		−0.3		−2.0	mA	V_{CC} = MAX
I_{CC}	Power Supply Current			8.0	15	mA	V_{CC} = MAX

AC CHARACTERISTICS: V_{CC} = 5.0 V, T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PHL} t_{PLH}	Propagation Delay Time, High-to-Low-Level Output from A Input Propagation Delay Time, Low-to-High-Level Output from A Input			100 100	ns	C_L = 15 pF, R_L = 2.0 kΩ
t_{PHL} t_{PLH}	Propagation Delay Time, High-to-Low-Level Output from RBI Input Propagation Delay Time, Low-to-High-Level Output from RBI Input			100 100	ns	C_L = 15 pF, R_L = 6.0 kΩ

MOTOROLA

SN54LS251
SN74LS251

8-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The TTL/MSI SN54LS/74LS251 is a high speed 8-Input Digital Multiplexer. It provides, in one package, the ability to select one bit of data from up to eight sources. The LS251 can be used as a universal function generator to generate any logic function of four variables. Both assertion and negation outputs are provided.

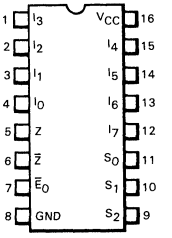
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **ON-CHIP SELECT LOGIC DECODING**
- **INVERTING AND NON-INVERTING 3-STATE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
$S_0 — S_2$	Select Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}_0$	Output Enable (Active LOW) Inputs	0.5 U.L.	0.25 U.L.
$I_0 — I_7$	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
Z	Multiplexer Output (Note b)	65 (25) U.L.	15 (7.5) U.L.
$\overline{Z}$	Complementary Multiplexer Output (Note b)	65 (25) U.L.	15 (7.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1 6 mA LOW.
b. The Output LOW drive factor is 7.5 U L. for Military (54) and 15 U L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L for Military (54) and 65 U.L. for Commercial (74) Temperature Ranges.

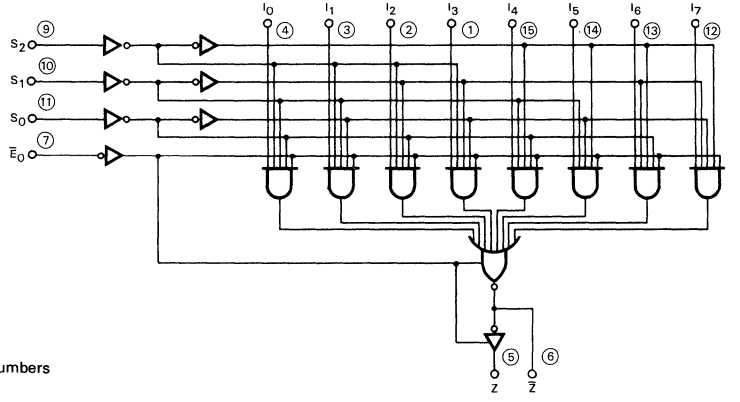
CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

4

FUNCTIONAL DESCRIPTION — The LS251 is a logical implementation of a single pole, 8-position switch with the switch position controlled by the state of three Select inputs, S_0, S_1, S_2. Both assertion and negation outputs are provided. The Output Enable input ($\overline{E}_O$) is active LOW. When it is activated, the logic function provided at the output is:

$$Z = \overline{E}_O \cdot (I_0 \cdot \overline{S}_0 \cdot \overline{S}_1 \cdot \overline{S}_2 + I_1 \cdot S_0 \cdot \overline{S}_1 \cdot \overline{S}_2 + I_2 \cdot \overline{S}_0 \cdot S_1 \cdot \overline{S}_2 + I_3 \cdot S_0 \cdot S_1 \cdot \overline{S}_2 + I_4 \cdot \overline{S}_0 \cdot \overline{S}_1 \cdot S_2 + I_5 \cdot S_0 \cdot \overline{S}_1 \cdot S_2 + I_6 \cdot \overline{S}_0 \cdot S_1 \cdot S_2 + I_7 \cdot S_0 \cdot S_1 \cdot S_2).$$

When the Output Enable is HIGH, both outputs are in the high impedance (high Z) state. This feature allows multiplexer expansion by tying the outputs of up to 128 devices together. When the outputs of the 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. The Output Enable signals should be designed to ensure there is no overlap in the active LOW portion of the enable voltages.

TRUTH TABLE

$\overline{E}_0$	S_2	S_1	S_0	I_0	I_1	I_2	I_3	I_4	I_5	I_6	I_7	$\overline{Z}$	Z
H	X	X	X	X	X	X	X	X	X	X	X	(Z)	(Z)
L	L	L	L	L	X	X	X	X	X	X	X	H	L
L	L	L	L	H	X	X	X	X	X	X	X	L	H
L	L	L	H	X	L	X	X	X	X	X	X	H	L
L	L	L	H	X	H	X	X	X	X	X	X	L	H
L	L	H	L	X	X	L	X	X	X	X	X	H	L
L	L	H	L	X	X	H	X	X	X	X	X	L	H
L	L	H	H	X	X	X	L	X	X	X	X	H	L
L	L	H	H	X	X	X	H	X	X	X	X	L	H
L	H	L	L	X	X	X	X	L	X	X	X	H	L
L	H	L	L	X	X	X	X	H	X	X	X	L	H
L	H	L	H	X	X	X	X	X	L	X	X	H	L
L	H	L	H	X	X	X	X	X	H	X	X	L	H
L	H	H	L	X	X	X	X	X	X	L	X	H	L
L	H	H	L	X	X	X	X	X	X	H	X	L	H
L	H	H	H	X	X	X	X	X	X	X	L	H	L
L	H	H	H	X	X	X	X	X	X	X	H	L	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
(Z) = High Impedance (Off)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX, $V_{\overline{E}}$ = 0.0 V
					12	mA	V_{CC} = MAX, $V_{\overline{E}}$ = 4.5 V

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay, Select to $\overline{Z}$ Output		20 21	33 33	ns	Fig. 1	C_L = 15 pF, R_L = 2K Ω
t_{PLH} t_{PHL}	Propagation Delay, Select to Z Output		29 28	45 45	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay, Data to $\overline{Z}$ Output		10 9.0	15 15	ns	Fig. 1	
t_{PLH} t_{PHL}	Propagation Delay, Data to Z Output		17 18	28 28	ns	Fig. 2	
t_{PZH} t_{PZL}	Output Enable Time to $\overline{Z}$ Output		17 24	27 40	ns	Figs. 4, 5	
t_{PZH} t_{PZL}	Output Enable Time to Z Output		30 26	45 40	ns	Figs. 3, 5	
t_{PHZ} t_{PLZ}	Output Disable Time to $\overline{Z}$ Output		37 15	55 25	ns	Figs. 3, 5	C_L = 5 pF, R_L = 667 Ω
t_{PHZ} t_{PLZ}	Output Disable Time to Z Output		30 15	45 25	ns	Figs. 4, 5	

4

3-STATE AC WAVEFORMS

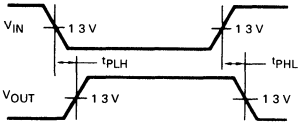


Fig. 1

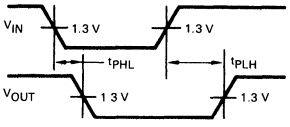


Fig. 2

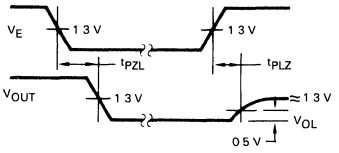


Fig. 3

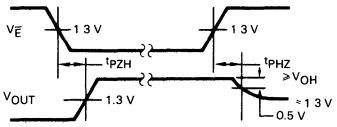
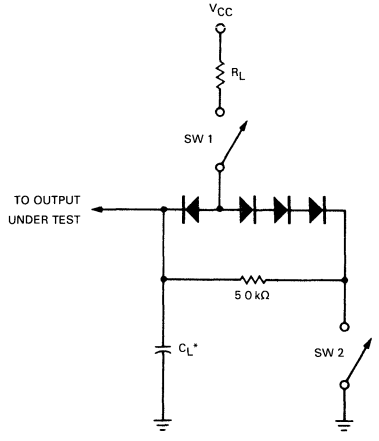


Fig. 4

4

AC LOAD CIRCUIT



*Includes Jig and Probe Capacitance

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 5

MOTOROLA

SN54LS253
SN74LS253

DUAL 4-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS253 is a Dual 4-Input Multiplexer with 3-state outputs. It can select two bits of data from four sources using common select inputs. The outputs may be individually switched to a high impedance state with a HIGH on the respective Output Enable ($\overline{E}_O$) inputs, allowing the outputs to interface directly with bus oriented systems. It is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

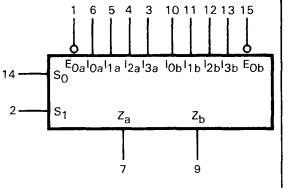
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **NON-INVERTING 3-STATE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S_0, S_1	Common Select Inputs	0.5 U.L.	0.25 U.L.
Multiplexer A			
$\overline{E}_{0a}$	Output Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_{0a} — I_{3a}	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
Z_a	Multiplexer Output (Note b)	65(25) U.L.	15(7.5) U.L.
Multiplexer B			
$\overline{E}_{0b}$	Output Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_{0b} — I_{3b}	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
Z_b	Mutiplexer Output (Note b)	65(25) U.L.	15(7.5) U.L.

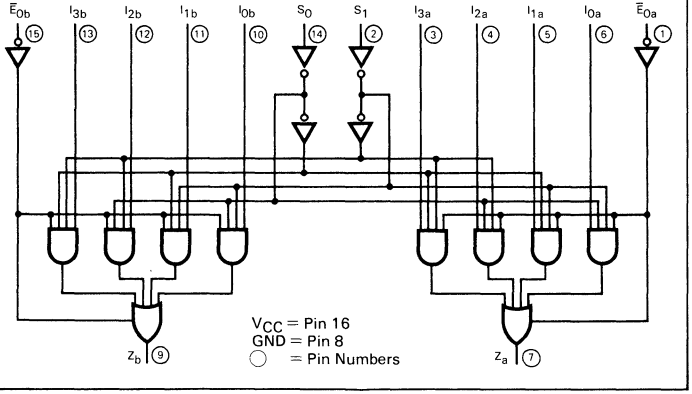
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L. for Military (54) and 65 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



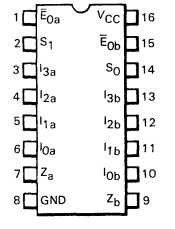
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION – The LS253 contains two identical 4-Input Multiplexers with 3-state outputs. They select two bits from four sources selected by common select inputs (S_0, S_1). The 4-input multiplexers have individual Output Enable ($\overline{E}_{0a}$, $\overline{E}_{0b}$) inputs which when HIGH, forces the outputs to a high impedance (high Z) state.

The LS253 is the logic implementation of a 2-pole, 4-position switch, where the position of the switch is determined by the logic levels supplied to the two select inputs. The logic equations for the outputs are shown below:

$$Z_a = \overline{E}_{0a} \cdot (I_{0a} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1a} \cdot \overline{S}_1 \cdot S_0 + I_{2a} \cdot S_1 \cdot \overline{S}_0 + I_{3a} \cdot S_1 \cdot S_0)$$
$$Z_b = \overline{E}_{0b} \cdot (I_{0b} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1b} \cdot \overline{S}_1 \cdot S_0 + I_{2b} \cdot S_1 \cdot \overline{S}_0 + I_{3b} \cdot S_1 \cdot S_0)$$

If the outputs of 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so that there is no overlap.

TRUTH TABLE

SELECT INPUTS		DATA INPUTS				OUTPUT ENABLE	OUTPUT
S_0	S_1	I_0	I_1	I_2	I_3	$\overline{E}_0$	Z
X	X	X	X	X	X	H	(Z)
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
H	L	X	L	X	X	L	L
H	L	X	H	X	X	L	H
L	H	X	X	L	X	L	L
L	H	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

H = HIGH Level
L = LOW Level
X = Irrelevant
(Z) = High Impedance (off)
Address inputs S_0 and S_1 are common to both sections.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				12	mA	V_{CC} = MAX, $V_{\overline{E}}$ = 0.0 V
					14	mA	V_{CC} = MAX, $V_{\overline{E}}$ = 4.5 V

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V (See SN54LS251 for Waveforms)

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		17 13	25 20	ns	Fig. 1	C_L = 45 pF, R_L = 667 Ω
t_{PLH} t_{PHL}	Propagation Delay, Select to Output		30 21	45 32	ns	Fig. 1	
t_{PZH} t_{PZL}	Output Enable Time		15 15	28 23	ns	Figs. 4, 5	
t_{PHZ} t_{PLZ}	Output Disable Time		27 18	41 27	ns	Figs. 3, 5	C_L = 5.0 pF, R_L = 667 Ω

4

MOTOROLA

SN54LS256
SN74LS256

DUAL 4-BIT ADDRESSABLE LATCH

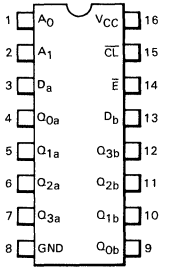
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS256 is a Dual 4-Bit Addressable Latch with common control inputs; these include two Address inputs (A_0, A_1), an active LOW Enable input (E) and an active LOW Clear input (CL). Each latch has a Data input (D) and four outputs (Q_0-Q_3).

When the Enable ($\overline{E}$) is HIGH and the Clear input ($\overline{CL}$) is LOW, all outputs (Q_0-Q_3) are LOW. Dual 4-channel demultiplexing occurs when the ($\overline{CL}$) and $\overline{E}$ are both LOW. When $\overline{CL}$ is HIGH and $\overline{E}$ is LOW, the selected output (Q_0-Q_3), determined by the Address inputs, follows D. When the $\overline{E}$ goes HIGH, the contents of the latch are stored. When operating in the addressable latch mode ($\overline{E}$=LOW, $\overline{CL}$=HIGH), changing more than one bit of the Address (A_0, A_1) could impose a transient wrong address. Therefore, this should be done only while in the memory mode ($\overline{E}$=$\overline{CL}$=HIGH).

- **SERIAL-TO-PARALLEL CAPABILITY**
- **OUTPUT FROM EACH STORAGE BIT AVAILABLE**
- **RANDOM (ADDRESSABLE) DATA ENTRY**
- **EASILY EXPANDABLE**
- **ACTIVE LOW COMMON CLEAR**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

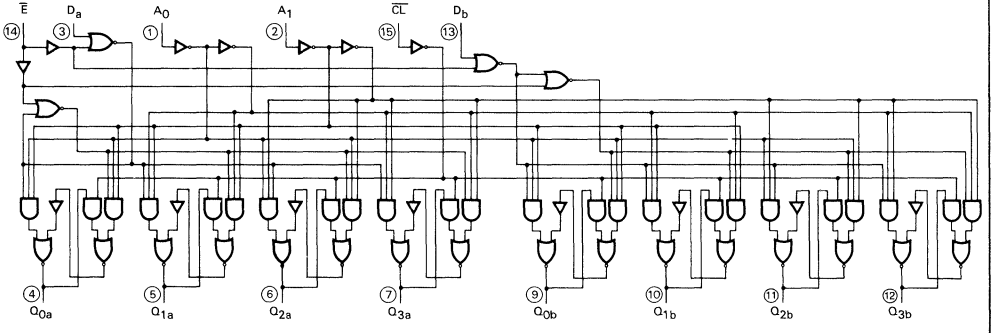
NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

PIN NAMES

		LOADING (Note a) HIGH	LOW
A_0, A_1	Address Inputs	0.5 U.L.	0.25 U.L.
D_a, D_b	Data Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable Input (Active LOW)	1.0 U.L.	0.5 U.L.
$\overline{CL}$	Clear Input (Active LOW)	0.5 U.L.	0.25 U.L.
Q_{0a}-Q_{3a}, Q_{0b}-Q_{3b}	Parallel Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.

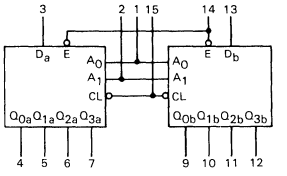
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

TRUTH TABLE

$\overline{CL}$	$\overline{E}$	D	A_0	A_1	Q_0	Q_1	Q_2	Q_3	MODE
L	H	X	X	X	L	L	L	L	Clear
L	L	L	L	L	L	L	L	L	Demultiplex
L	L	H	L	L	H	L	L	L	
L	L	L	H	L	L	L	L	L	
L	L	H	H	L	L	H	L	L	
L	L	L	L	H	L	L	L	L	
L	L	H	L	H	L	L	H	L	
L	L	L	H	H	L	L	L	L	
L	L	H	H	H	L	L	L	H	
H	H	X	X	X	Q_{N-1}	Q_{N-1}	Q_{N-1}	Q_{N-1}	Memory
H	L	L	L	L	L	Q_{N-1}	Q_{N-1}	Q_{N-1}	Addressable Latch
H	L	H	L	L	H	Q_{N-1}	Q_{N-1}	Q_{N-1}	
H	L	L	H	L	Q_{N-1}	L	Q_{N-1}	Q_{N-1}	
H	L	H	H	L	Q_{N-1}	H	Q_{N-1}	Q_{N-1}	
H	L	L	L	H	Q_{N-1}	Q_{N-1}	L	Q_{N-1}	
H	L	H	L	H	Q_{N-1}	Q_{N-1}	H	Q_{N-1}	
H	L	L	H	H	Q_{N-1}	Q_{N-1}	Q_{N-1}	L	
H	L	H	H	H	Q_{N-1}	Q_{N-1}	Q_{N-1}	H	

H = High Voltage Level
L = LOW Voltage Level
X = Immaterial

MODE SELECTION

$\overline{E}$	$\overline{CL}$	MODE
L	H	Addressable Latch
H	H	Memory
L	L	Dual 4-Channel Demultiplexer
H	L	Clear

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current Others $\overline{E}$ Input				20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Others $\overline{E}$ Input				0.1 0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Others $\overline{E}$ Input				−0.4 −0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				25	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Turn-Off Delay, Enable to Output Turn-On Delay, Enable to Output		20 16	27 24	ns ns	V_{CC} = 5.0 V, C_L = 15 pF Fig. 1
t_{PLH} t_{PHL}	Turn-Off Delay, Data to Output Turn-On Delay, Data to Output		20 13	30 20	ns ns	V_{CC} = 5.0 V, C_L = 15 pF Fig. 2
t_{PLH} t_{PHL}	Turn-Off Delay, Address to Output Turn-On Delay, Address to Output		20 14	30 24	ns ns	V_{CC} = 5.0 V, C_L = 15 pF Fig. 3
t_{PHL}	Turn-On Delay, Clear to Output		12	23	ns	V_{CC} = 5.0 V, C_L = 15 pF Fig. 5

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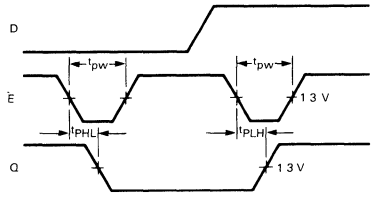
AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_s	Data Setup Time	20			ns	$V_{CC} = 5.0$ V Fig 4
t_s	Address Setup Time	0			ns	Fig. 6
t_h	Data Hold Time	0			ns	$V_{CC} = 5.0$ V Fig. 4
t_h	Address Hold Time	15			ns	V_{CC} = 5V Fig. 6
t_W	Enable Pulse Width	15			ns	$V_{CC} = 5.0$ V Fig. 1

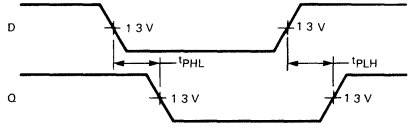
AC WAVEFORMS

Fig. 1 TURN-ON AND TURN-OFF DELAYS, ENABLE TO OUTPUT AND ENABLE PULSE WIDTH



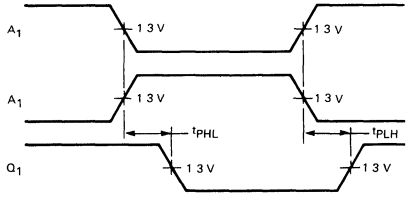
OTHER CONDITIONS: $\overline{CL}$ = H, A = STABLE

Fig. 2 TURN-ON AND TURN-OFF DELAYS, DATA TO OUTPUT



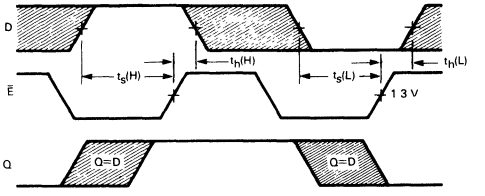
OTHER CONDITIONS: $\overline{E}$ = L, $\overline{CL}$ = H, A = STABLE

Fig. 3 TURN-ON AND TURN-OFF DELAYS, ADDRESS TO OUTPUT



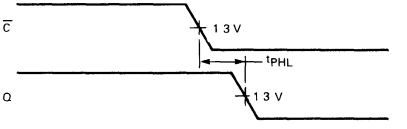
OTHER CONDITIONS: $\overline{E}$ = L, $\overline{CL}$ = L, D = H

Fig. 4 SETUP AND HOLD TIME, DATA TO ENABLE



OTHER CONDITIONS: $\overline{C}$ = H, A = STABLE

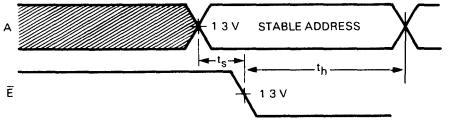
Fig. 5 TURN-ON DELAY, CLEAR TO OUTPUT



OTHER CONDITIONS: $\overline{E}$ = H

Fig. 6 SETUP TIME, ADDRESS TO ENABLE

(SEE NOTES 1 AND 2)



OTHER CONDITIONS: $\overline{CL}$ = H

NOTES:
1. The Address to Enable Setup Time is the time before the HIGH-to-LOW Enable transition that the Address must be stable so that the correct latch is addressed and the other latches are not affected.
2. The shaded areas indicate when the inputs are permitted to change for predictable output performance.

MOTOROLA

SN54LS/74LS257A
SN54LS/74LS258A

QUAD 2-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

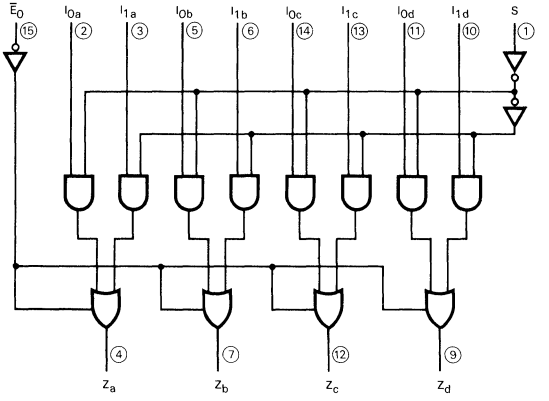
DESCRIPTION — The LSTTL/MSI SN54LS/74LS257A and the SN54LS/74LS258A are Quad 2-Input Multiplexers with 3-state outputs. Four bits of data from two sources can be selected using a Common Data Select input. The four outputs present the selected data in true (non-inverted) form. The outputs may be switched to a high impedance state with a HIGH on the common Output Enable ($\overline{E}_O$) Input, allowing the outputs to interface directly with bus oriented systems. It is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIPLEXER EXPANSION BY TYING OUTPUTS TOGETHER**
- **NON-INVERTING 3-STATE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

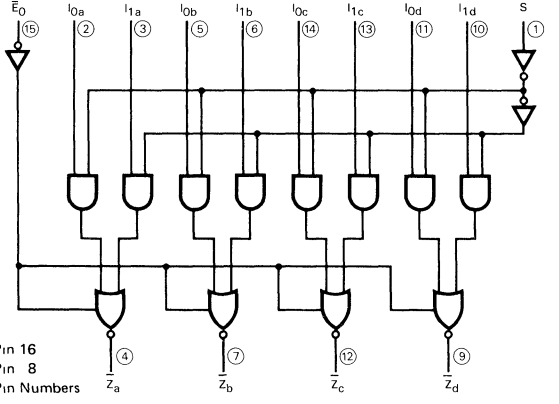
4

LOGIC DIAGRAMS

SN54LS/74LS257A



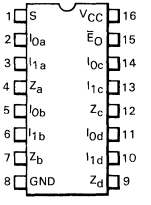
SN54LS/74LS258A



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

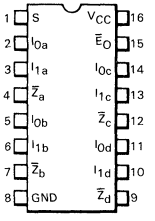
CONNECTION DIAGRAM DIP (TOP VIEW)

SN54LS/74LS257A



V_{CC} = Pin 16
GND = Pin 8

SN54LS/74LS258A



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

FUNCTIONAL DESCRIPTION — The LS257A and LS258A are Quad 2-Input Multiplexers with 3-state outputs. They select four bits of data from two sources each under control of a Common Data Select Input. When the Select Input is LOW, the I_0 inputs are selected and when Select is HIGH, the I_1 inputs are selected. The data on the selected inputs appears at the outputs in true (non-inverted) form for the LS257A and in the inverted form for the LS258A.

The LS257A and LS258A are the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select Input. The logic equations for the outputs are shown below:

LS257A

$$Z_a = \overline{E}_O \bullet (I_{1a} \bullet S + I_{0a} \bullet \overline{S}) \qquad Z_b = \overline{E}_O \bullet (I_{1b} \bullet S + I_{0b} \bullet \overline{S})$$
$$Z_c = \overline{E}_O \bullet (I_{1c} \bullet S + I_{0c} \bullet \overline{S}) \qquad Z_d = \overline{E}_O \bullet (I_{1d} \bullet S + I_{0d} \bullet \overline{S})$$

LS258A

$$\overline{Z}_a = \overline{E}_O \bullet (I_{1a} \bullet S + I_{0a} \bullet \overline{S}) \qquad \overline{Z}_b = \overline{E}_O \bullet (I_{1b} \bullet S + I_{0b} \bullet \overline{S})$$
$$\overline{Z}_c = \overline{E}_O \bullet (I_{1c} \bullet S + I_{0c} \bullet \overline{S}) \qquad \overline{Z}_d = \overline{E}_O \bullet (I_{1d} \bullet S + I_{0d} \bullet \overline{S})$$

When the Output Enable Input ($\overline{E}_O$) is HIGH, the outputs are forced to a high impedance "off" state. If the outputs are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so there is no overlap.

TRUTH TABLE

OUTPUT ENABLE	SELECT INPUT	DATA INPUTS		OUTPUTS LS257A	OUTPUTS LS258A
$\overline{E}_O$	S	I_0	I_1	Z	$\overline{Z}$
H	X	X	X	(Z)	(Z)
L	H	X	L	L	H
L	H	X	H	H	L
L	L	L	X	L	H
L	L	H	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
(Z) = High impedance (off)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
I_{OZH}	Output Off Current — HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current — LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current	Other Inputs			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		S Inputs			40	μA	
		Other Inputs			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		S Inputs			0.2	mA	
I_{IL}	Input LOW Current	Other Inputs			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		S Inputs			−0.8	mA	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH	LS257A			10	mA	V_{CC} = MAX
		LS258A			7.0	mA	
	Total, Output LOW	LS257A			16	mA	
		LS258A			14	mA	
	Total, Output 3-State				19	mA	

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V (See SN54LS251 for Waveforms)

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		12 12	18 18	ns	Fig. 1, 2	C_L = 45 pF
t_{PLH} t_{PHL}	Propagation Delay, Select to Output		14 14	21 21	ns	Fig. 1, 2	C_L = 45 pF
t_{PZH}	Output Enable Time to HIGH Level		20	30	ns	Figs. 4, 5	C_L = 45 pF
t_{PZL}	Output Enable Time to LOW Level		20	30	ns	Figs. 3, 5	R_L = 667 Ω
t_{PLZ}	Output Disable Time to LOW Level		16	25	ns	Figs. 3, 5	C_L = 5.0 pF
t_{PHZ}	Output Disable Time from HIGH Level		18	30	ns	Figs. 4, 5	R_L = 667 Ω

MOTOROLA

SN54LS259
SN74LS259

8-BIT ADDRESSABLE LATCH

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS259 is a high-speed 8-Bit Addressable Latch designed for general purpose storage applications in digital systems. It is a multifunctional device capable of storing single line data in eight addressable latches, and also a 1-of-8 decoder and demultiplexer with active HIGH outputs. The device also incorporates an active LOW common Clear for resetting all latches, as well as, an active LOW Enable.

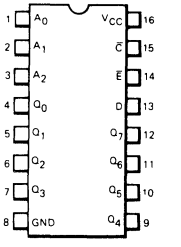
- **SERIAL-TO-PARALLEL CONVERSION**
- **EIGHT BITS OF STORAGE WITH OUTPUT OF EACH BIT AVAILABLE**
- **RANDOM (ADDRESSABLE) DATA ENTRY**
- **ACTIVE HIGH DEMULTIPLEXING OR DECODING CAPABILITY**
- **EASILY EXPANDABLE**
- **COMMON CLEAR**

PIN NAMES

		LOADING (Note a)	
		HIGH	LOW
A_0, A_1, A_2	Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{D}$	Data Input	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
$\overline{C}$	Clear (Active LOW) Input	0.5 U.L.	0.25 U.L.
Q_0 to Q_7	Parallel Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.

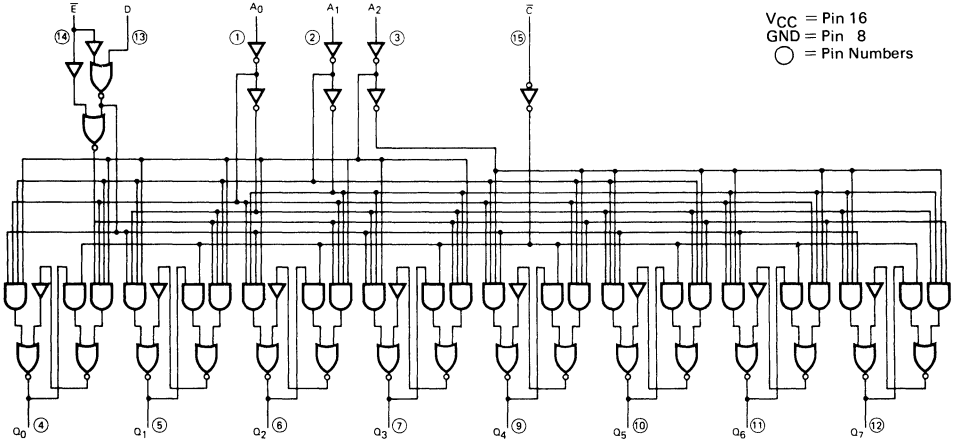
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LOGIC DIAGRAM



4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS259 has four modes of operation as shown in the mode selection table. In the addressable latch mode, data on the Data line (D) is written into the addressed latch. The addressed latch will follow the data input with all non-addressed latches remaining in their previous states. In the memory mode, all latches remain in their previous state and are unaffected by the Data or Address inputs.

In the one-of-eight decoding or demultiplexing mode, the addressed output will follow the state of the D input with all other inputs in the LOW state. In the clear mode all outputs are LOW and unaffected by the address and data inputs.

When operating the SN54LS/74LS259 as an addressable latch, changing more than one bit of the address could impose a transient wrong address. Therefore, this should only be done while in the memory mode.

The truth table below summarizes the operations.

MODE SELECTION

$\overline{E}$	$\overline{C}$	MODE
L	H	Addressable Latch
H	H	Memory
L	L	Active HIGH Eight-Channel Demultiplexer
H	L	Clear

TRUTH TABLE

						PRESENT OUTPUT STATES								
$\overline{C}$	$\overline{E}$	D	A_0	A_1	A_2	Q_0	Q_1	Q_2	Q_3	Q_4	Q_5	Q_6	Q_7	MODE
L	H	X	X	X	X	L	L	L	L	L	L	L	L	Clear
L	L	L	L	L	L	L	L	L	L	L	L	L	L	Demultiplex
L	L	H	L	L	L	H	L	L	L	L	L	L	L	
L	L	L	H	L	L	L	L	L	L	L	L	L	L	
L	L	H	H	L	L	L	H	L	L	L	L	L	L	
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
L	L	H	H	H	H	L	L	L	L	L	L	L	H	
H	H	X	X	X	X	Q_{N-1} →								Memory
H	I	I	L	L	L	L	Q_{N-1}	Q_{N-1}	Q_{N-1} →					Addressable
H	L	H	L	L	L	H	Q_{N-1}	Q_{N-1} →						Latch
H	L	L	H	L	L	Q_{N-1}	L	Q_{N-1} →						
H	L	H	H	L	L	Q_{N-1}	H	Q_{N-1} →						
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
•	•	•		•					•					
H	L	L	H	H	H	Q_{N-1} →						Q_{N-1}	L	
H	L	H	H	H	H	Q_{N-1} →						Q_{N-1}	H	

X = Don't Care Condition
L = LOW Voltage Level
H = HIGH Voltage Level
Q_{N-1} = Previous Output State

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				36	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_{PLH}	Turn-Off Delay, Enable to Output		22	35	ns	C_L = 15 pF
t_{PHL}	Turn-On Delay, Enable to Output		15	24	ns	
t_{PLH}	Turn-Off Delay, Data to Output		20	32	ns	
t_{PHL}	Turn-On Delay, Data to Output		13	21	ns	
t_{PLH}	Turn-Off Delay, Address to Output		24	38	ns	
t_{PHL}	Turn-On Delay, Address to Output		18	29	ns	
t_{PHL}	Turn-On Delay, Clear to Output		17	27	ns	

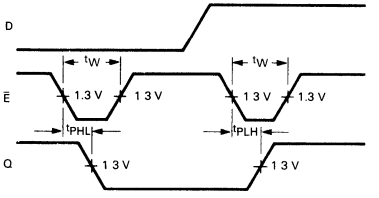
4

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0\ V$

SYMBOL	PARAMETER	LIMITS			UNITS
		MIN	TYP	MAX	
t_s	Input Setup Time	20			ns
t_W	Pulse Width, Clear or Enable	15			ns
t_h	Hold Time, Data	5.0			ns
t_h	Hold Time, Address	20			ns

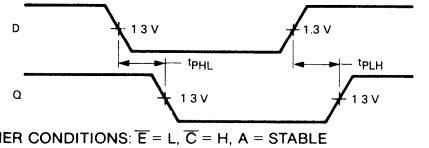
AC WAVEFORMS

Fig. 1 TURN-ON AND TURN-OFF DELAYS, ENABLE TO OUTPUT AND ENABLE PULSE WIDTH



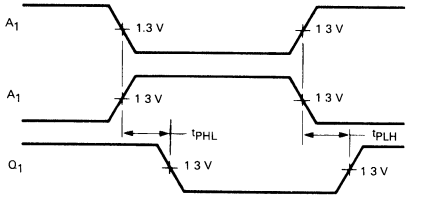
OTHER CONDITIONS: $\overline{C}$ = H, A = STABLE

Fig. 2 TURN-ON AND TURN-OFF DELAYS, DATA TO OUTPUT



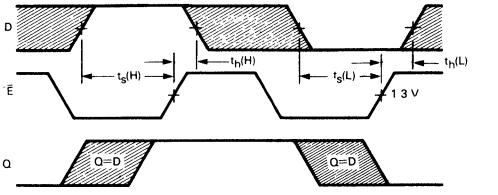
OTHER CONDITIONS: $\overline{E}$ = L, $\overline{C}$ = H, A = STABLE

Fig. 3 TURN-ON AND TURN-OFF DELAYS, ADDRESS TO OUTPUT



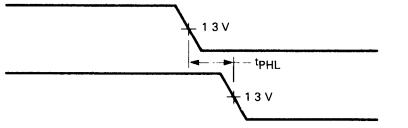
OTHER CONDITIONS: $\overline{E}$ = L, $\overline{C}$ = L, D = H

Fig. 4 SETUP AND HOLD TIME, DATA TO ENABLE



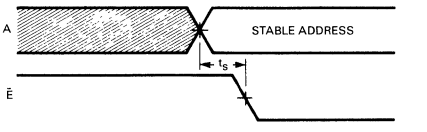
OTHER CONDITIONS: $\overline{C}$ = H, A = STABLE

Fig. 5 TURN-ON DELAY, CLEAR TO OUTPUT



OTHER CONDITIONS: $\overline{E}$ = H

Fig. 6 SETUP TIME, ADDRESS TO ENABLE (SEE NOTES 1 AND 2)



OTHER CONDITIONS: $\overline{C}$ = H

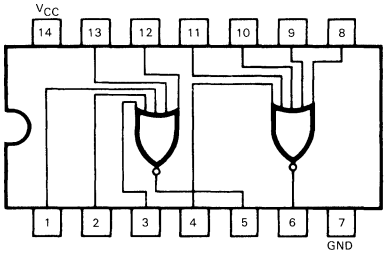
NOTES:
1. The Address to Enable Setup Time is the time before the HIGH-to-LOW Enable transition that the Address must be stable so that the correct latch is addressed and the other latches are not affected.
2. The shaded areas indicate when the inputs are permitted to change for predictable output performance.

MOTOROLA

SN54LS260
SN74LS260

DUAL 5-INPUT NOR GATE

LOW POWER SCHOTTKY



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				4.0	mA	V_{CC} = MAX	
	Total, Output LOW				5.5			

AC CHARACTERISTICS: T_A = 25°C

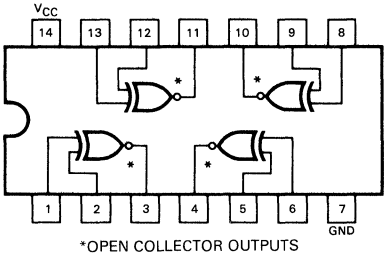
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Turn Off Delay, Input to Output		5.0	15	ns	V_{CC} = 5.0 V
t_{PHL}	Turn On Delay, Input to Output		6.0	15	ns	C_L = 15 pF

MOTOROLA

SN54LS266
SN74LS266

QUAD 2-INPUT EXCLUSIVE NOR GATE

LOW POWER SCHOTTKY



*OPEN COLLECTOR OUTPUTS

TRUTH TABLE

IN		OUT
A	B	Z
L	L	H
L	H	L
H	L	L
H	H	H

J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54,74			5.5	V
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current				13	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Other Input LOW		18 18	30 30	ns	V_{CC} = 5.0 V C_L = 15 pF, R_L = 2.0 kΩ
t_{PLH} t_{PHL}	Propagation Delay, Other Input HIGH		18 18	30 30	ns	

MOTOROLA

SN54LS273
SN74LS273

8-BIT REGISTER WITH CLEAR

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS273 is a high-speed 8-Bit Register. The register consists of eight D-Type Flip-Flops with a Common Clock and an asynchronous active LOW Master Reset. This device is supplied in a 20-pin package featuring 0.3 inch lead spacing.

- **8-BIT HIGH SPEED REGISTER**
- **PARALLEL REGISTER**
- **COMMON CLOCK AND MASTER RESET**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
D_0-D_7	Data Inputs	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
Q_0-Q_7	Register Outputs (Note b)	10 U.L.	5(2.5) U.L.

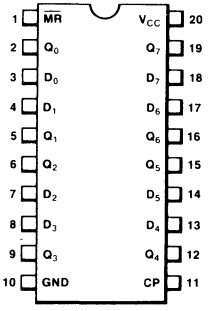
NOTES.
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

TRUTH TABLE

$\overline{MR}$	CP	D_X	Q_X
L	X	X	L
H	↑	H	H
H	↑	L	L

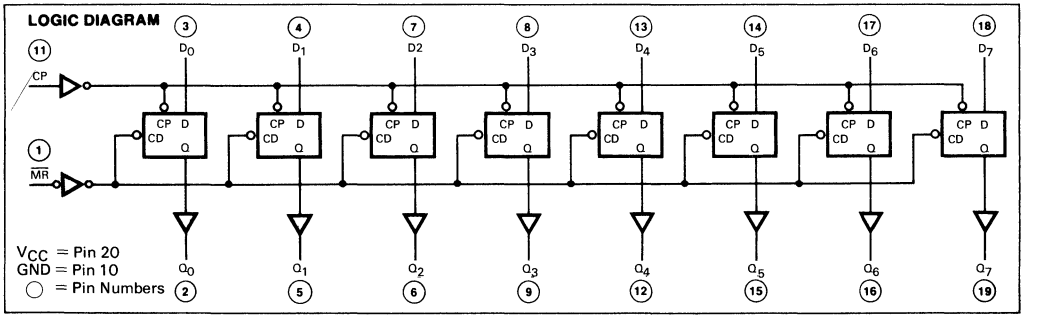
H = High Logic Level
L = Low Logic Level
X = Immaterial

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

LOGIC DIAGRAM



4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS273 is an 8-Bit Parallel Register with a common Clock and common Master Reset.

When the $\overline{MR}$ input is LOW, the Q outputs are LOW, independent of the other inputs. Information meeting the setup and hold time requirements of the D inputs is transferred to the Q outputs on the LOW-to-HIGH transition of the clock input.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				27	mA	V_{CC} = MAX

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

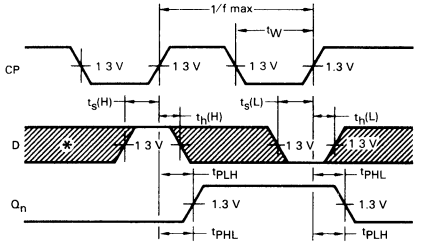
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Input Clock Frequency	30	40		MHz	Fig. 1
t_{PHL}	Propagation Delay, $\overline{MR}$ to Q Output		18	27	ns	Fig. 2
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		17 18	27 27	ns	Fig. 1

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_w	Pulse Width, Clock or Clear	20			ns	Fig. 1
t_s	Data Setup Time	20			ns	Fig. 1
t_h	Hold Time	5.0			ns	Fig. 1
t_{rec}	Recovery Time	25			ns	Fig. 2

AC WAVEFORMS

CLOCK TO OUTPUT DELAYS, CLOCK PULSE WIDTH, FREQUENCY, SETUP AND HOLD TIMES DATA TO CLOCK



*The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 1

MASTER RESET TO OUTPUT DELAY, MASTER RESET PULSE WIDTH, AND MASTER RESET RECOVERY TIME

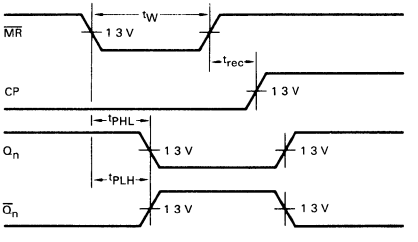


Fig. 2

DEFINITION OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

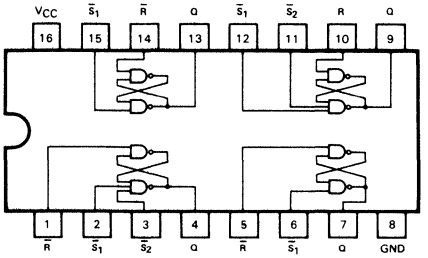
RECOVERY TIME (t_{rec}) — is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH data to the Q outputs.

MOTOROLA

SN54LS279
SN74LS279

QUAD SET-RESET LATCH

LOW POWER SCHOTTKY



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

TRUTH TABLE

INPUTS			OUTPUT
$\bar{S}_1$	$\bar{S}_2$	$\bar{R}$	(Q)
L	L	L	h
L	X	H	H
X	L	H	H
H	H	L	L
H	H	H	No Change

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
h = The output is HIGH as long as S_1 or S_2 is LOW. If all inputs go HIGH simultaneously, the output state is indeterminate, otherwise, it follows the Truth Table

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				7.0	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, $\bar{S}$ to Output		12 13	22 21	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PHL}	Propagation Delay, $\bar{R}$ to Output		15	27	ns	

MOTOROLA

SN54LS280
SN74LS280

9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS280 is a Universal 9-Bit Parity Generator/Checker. It features odd/even outputs to facilitate either odd or even parity. By cascading, the word length is easily expanded.

The LS280 is designed without the expander input implementation, but the corresponding function is provided by an input at Pin 4 and the absence of any connection at Pin 3. This design permits the LS280 to be substituted for the LS180 which results in improved performance. The LS280 has buffered inputs to lower the drive requirements to one LS unit load.

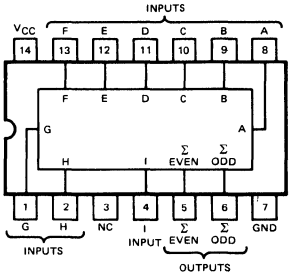
- GENERATES EITHER ODD OF EVEN PARITY FOR NINE DATA LINES
- TYPICAL DATA-TO-OUTPUT DELAY OF ONLY 33 ns
- CASCADABLE FOR n-BITS
- CAN BE USED TO UPGRADE SYSTEMS USING MSI PARITY CIRCUITS
- TYPICAL POWER DISSIPATION = 80 mW

FUNCTON TABLE

NUMBER OF INPUTS A THRU 1 THAT ARE HIGH	OUTPUTS ΣEVEN	OUTPUTS ΣODD
0, 2, 4, 6, 8	H	L
1, 3, 5, 7, 9	L	H

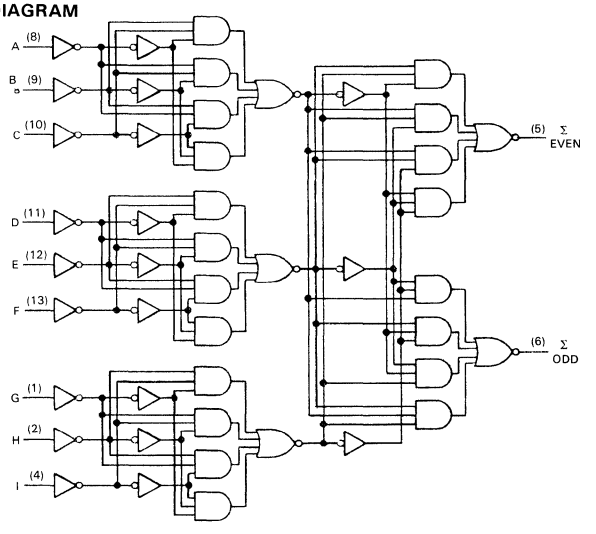
H = high level, L = low level

(TOP VIEW)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

FUNCTIONAL BLOCK DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				27	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Data to Output ΣEVEN		33 29	50 45	ns	C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Data to Output ΣODD		23 31	35 50	ns	

MOTOROLA

SN54LS283
SN74LS283

4-BIT BINARY FULL ADDER WITH FAST CARRY

LOW POWER SCHOTTKY

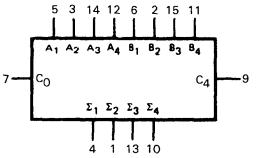
DESCRIPTION — The SN54LS/74LS283 is a high-speed 4-Bit Binary Full Adder with internal carry lookahead. It accepts two 4-bit binary words (A_1 — A_4, B_1 — B_4) and a Carry Input (C_0). It generates the binary Sum outputs (Σ_1 — Σ_4) and the Carry Output (C_4) from the most significant bit. The LS283 operates with either active HIGH or active LOW operands (positive or negative logic).

PIN NAMES

		LOADING (Note a) HIGH	LOW
A_1 — A_4	Operand A Inputs	1.0 U.L.	0.5 U.L.
B_1 — B_4	Operand B Inputs	1.0 U.L.	0.5 U.L.
C_0	Carry Input	0.5 U.L.	0.25 U.L.
Σ_1 — Σ_4	Sum Outputs (Note b)	10 U.L.	5(2.5) U.L.
C_4	Carry Output (Note b)	10 U.L.	5(2.5) U.L.

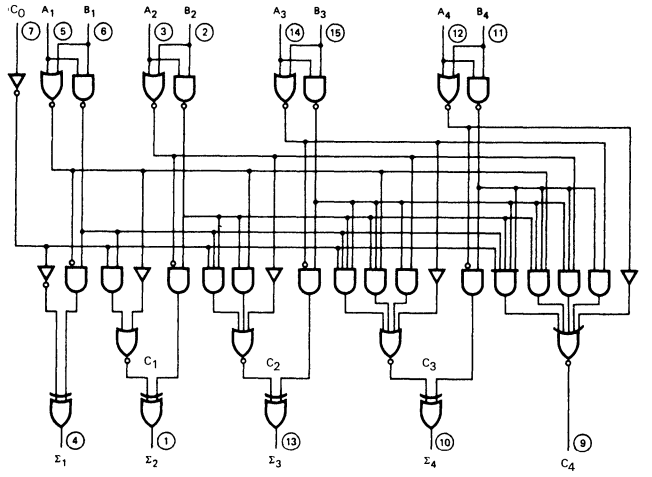
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges

LOGIC SYMBOL



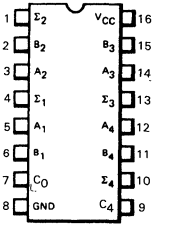
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTES:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

4

FUNCTIONAL DESCRIPTION — The LS283 adds two 4-bit binary words (A plus B) plus the incoming carry. The binary sum appears on the sum outputs (Σ_1 — Σ_4) and outgoing carry (C_4) outputs.

$C_0 + (A_1+B_1)+2(A_2+B_2)+4(A_3+B_3)+8(A_4+B_4) = \Sigma_1+2\,\Sigma_2+4\,\Sigma_3+8\,\Sigma_4+16C_4$
Where: (+) = plus

Due to the symmetry of the binary add function the LS283 can be used with either all inputs and outputs active HIGH (positive logic) or with all inputs and outputs active LOW (negative logic). Note that with active HIGH inputs, Carry Input can not be left open, but must be held LOW when no carry in is intended.

Example:

	C_0	A_1	A_2	A_3	A_4	B_1	B_2	B_3	B_4	Σ_1	Σ_2	Σ_3	Σ_4	C_4	
logic levels	L	L	H	L	H	H	L	L	H	H	H	L	L	H	
Active HIGH	0	0	1	0	1	1	0	0	1	1	1	0	0	1	(10+9=19)
Active LOW	1	1	0	1	0	0	1	1	0	0	0	1	1	0	(carry+5+6=12)

Interchanging inputs of equal weight does not affect the operation, thus C_0, A_1, B_1, can be arbitrarily assigned to pins 7, 5 or 3.

4

FUNCTIONAL TRUTH TABLE

C (n−1)	A_n	B_n	Σ_n	C_n
L	L	L	L	L
L	L	H	H	L
L	H	L	H	L
L	H	H	L	H
H	L	L	H	L
H	L	H	L	H
H	H	L	L	H
H	H	H	H	H

C_1 — C_3 are generated internally
C_0 is an external input
C_4 is an output generated internally

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	C_0			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		Any A or B			40	μA	
		C_0			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		Any A or B			0.2	mA	
I_{IL}	Input LOW Current	C_0			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Any A or B			−0.8	mA	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				34	mA	V_{CC} = MAX
	Total, Output LOW				39		

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, C_0 Input to Any Σ Output		16 15	24 24	ns	C_L = 15 pF Figures 1 and 2
t_{PLH} t_{PHL}	Propagation Delay, Any A or B Input to Σ Outputs		15 15	24 24	ns	
t_{PLH} t_{PHL}	Propagation Delay, C_0 Input to C_4 Output		11 11	17 22	ns	
t_{PLH} t_{PHL}	Propagation Delay, Any A or B Input to C_4 Output		11 12	17 17	ns	

AC WAVEFORMS

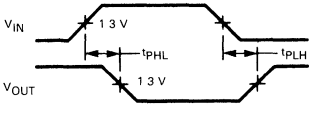


Fig. 1

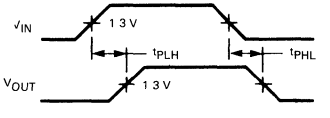


Fig. 2

MOTOROLA

SN54LS/74LS290
SN54LS/74LS293

DECADE COUNTER; 4-BIT BINARY COUNTER

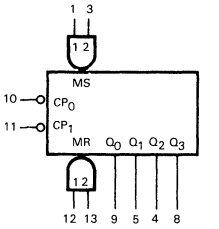
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS290 and SN54LS/74LS293 are high-speed 4-bit ripple type counters partitioned into two sections. Each counter has a divide-by-two section and either a divide-by-five (LS290) or divide-by-eight (LS293) section which are triggered by a HIGH-to-LOW transition on the clock inputs. Each section can be used separately or tied together (Q to $\overline{CP}$) to form BCD, Bi-quinary, or Modulo-16 counters. Both of the counters have a 2-input gated Master Reset (Clear), and the LS290 also has a 2-input gated Master Set (Preset 9).

- **CORNER POWER PIN VERSIONS OF THE LS90 and LS93**
- **LOW POWER CONSUMPTION . . . TYPICALLY 45 mW**
- **HIGH COUNT RATES . . . TYPICALLY 42 MHz**
- **CHOICE OF COUNTING MODES . . . BCD, BI-QUINARY, BINARY**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

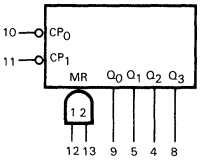
LOGIC SYMBOL

LS290



V_{CC} = Pin 14
GND = Pin 7
NC = Pins 2, 6

LS293



V_{CC} = Pin 14
GND = Pin 7
NC = Pins 1, 2, 3, 6

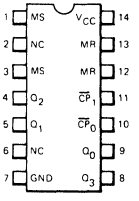
PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{CP}_0$	Clock (Active LOW going edge) Input to ÷2 Section.	0.05 U.L.	1.5 U.L.
$\overline{CP}_1$	Clock (Active LOW going edge) Input to ÷5 Section (LS290).	0.05 U.L.	2.0 U.L.
$\overline{CP}_1$	Clock (Active LOW going edge) Input to ÷8 Section (LS293).	0.05 U.L.	1.0 U.L.
MR_1, MR_2	Master Reset (Clear) Inputs	0.5 U.L.	0.25 U.L.
MS_1, MS_2	Master Set (Preset-9, LS290) Inputs	0.5 U.L.	0.25 U.L.
Q_0	Output from ÷2 Section (Notes b & c)	10 U.L.	5(2.5) U.L.
Q_1, Q_2, Q_3	Outputs from ÷5 & ÷8 Sections (Note b)	10 U.L.	5(2.5) U.L.

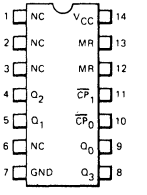
NOTES:
a 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.
c The Q_0 Outputs are guaranteed to drive the full fan-out plus the $\overline{CP}_1$ Input of the device.

CONNECTION DIAGRAM
DIP (TOP VIEW)

LS290



LS293



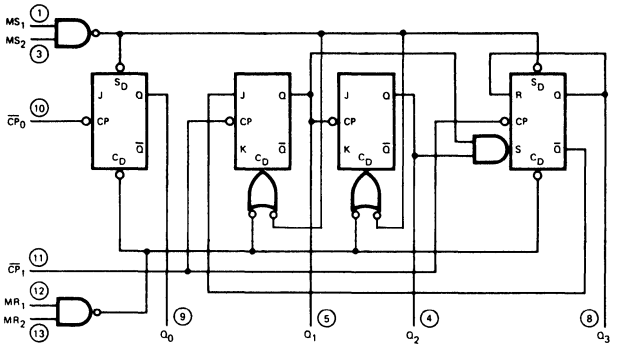
J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

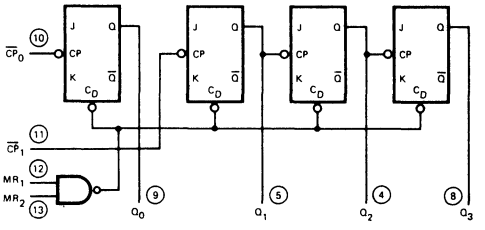
LOGIC DIAGRAMS

LS290



○ = Pin Numbers
V_{CC} = Pin 14
GND = 7

LS293



○ = Pin Numbers
V_{CC} = Pin 14
GND = 7

4

FUNCTIONAL DESCRIPTION — The LS290 and LS293 are 4-bit ripple type Decade, and 4-Bit Binary counters respectively. Each device consists of four master/slave flip-flops which are internally connected to provide a divide-by-two section and a divide-by-five (LS290) or divide-by-eight (LS293) section. Each section has a separate clock input which initiates state changes of the counter on the HIGH-to-LOW clock transition. State changes of the Q outputs do not occur simultaneously because of internal ripple delays. Therefore, decoded output signals are subject to decoding spikes and should not be used for clocks or strobes. The Q_0 output of each device is designed and specified to drive the rated fan-out plus the $\overline{CP}_1$ input of the device.

A gated AND asynchronous Master Reset ($MR_1 \cdot MR_2$) is provided on both counters which overrides the clocks and resets (clears) all the flip-flops. A gated AND asynchronous Master Set ($MS_1 \cdot MS_2$) is provided on the LS290 which overrides the clocks and the MR inputs and sets the outputs to nine (HLLH).

Since the output from the divide-by-two section is not internally connected to the succeeding stages, the devices may be operated in various counting modes:

LS290

A. BCD Decade (8421) Counter — the $\overline{CP}_1$ input must be externally connected to the Q_0 output. The $\overline{CP}_0$ input receives the incoming count and a BCD count sequence is produced.

B. Symmetrical Bi-quinary Divide-By-Ten Counter — The Q_3 output must be externally connected to the $\overline{CP}_0$ input. The input count is then applied to the $\overline{CP}_1$ input and a divide-by-ten square wave is obtained at output Q_0.

C. Divide-By-Two and Divide-By-Five Counter — No external interconnections are required. The first flip-flop is used as a binary element for the divide-by-two function ($\overline{CP}_0$ as the input and Q_0 as the output). The $\overline{CP}_1$ input is used to obtain binary divide-by-five operation at the Q_3 output.

LS293

A. 4-Bit Ripple Counter — The output Q_0 must be externally connected to input $\overline{CP}_1$. The input count pulses are applied to input $\overline{CP}_0$. Simultaneous division of 2, 4, 8, and 16 are performed at the Q_0, Q_1, Q_2, and Q_3 outputs as shown in the truth table.

B. 3-Bit Ripple Counter — The input count pulses are applied to input $\overline{CP}_1$. Simultaneous frequency divisions of 2, 4, and 8 are available at the Q_1, Q_2, and Q_3 outputs. Independent use of the first flip-flop is available if the reset function coincides with reset of the 3-bit ripple-through counter.

LS290 MODE SELECTION

RESET/SET INPUTS				OUTPUTS			
MR_1	MR_2	MS_1	MS_2	Q_0	Q_1	Q_2	Q_3
H	H	L	X	L	L	L	L
H	H	X	L	L	L	L	L
X	X	H	H	H	L	L	H
L	X	L	X	Count			
X	L	X	L	Count			
L	X	X	L	Count			
X	L	L	X	Count			

LS293 MODE SELECTION

RESET INPUTS		OUTPUTS			
MR_1	MR_2	Q_0	Q_1	Q_2	Q_3
H	H	L	L	L	L
L	H	Count			
H	L	Count			
L	L	Count			

4

LS290
BCD COUNT SEQUENCE

COUNT	OUTPUT			
	Q_0	Q_1	Q_2	Q_3
0	L	L	L	L
1	H	L	L	L
2	L	H	L	L
3	H	H	L	L
4	L	L	H	L
5	H	L	H	L
6	L	H	H	L
7	H	H	H	L
8	L	L	L	H
9	H	L	L	H

NOTE: Output Q_0 is connected to Input CP_1 for BCD count.

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

TRUTH TABLE

COUNT	OUTPUT			
	Q_0	Q_1	Q_2	Q_3
0	L	L	L	L
1	H	L	L	L
2	L	H	L	L
3	H	H	L	L
4	L	L	H	L
5	H	L	H	L
6	L	H	H	L
7	H	H	H	L
8	L	L	L	H
9	H	L	L	H
10	L	H	L	H
11	H	H	L	H
12	L	L	H	H
13	H	L	H	H
14	L	H	H	H
15	H	H	H	H

Note: Output Q_0 connected to input CP_1.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.7	3.5		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current MS, MR $\overline{CP}_0$ $\overline{CP}_1$ (LS290) $\overline{CP}_1$ (LS293)				 −0.4 −2.4 −3.2 −1.6	 mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				15	mA	V_{CC} = MAX	

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V, $C_L = 15$ pF

SYMBOL	PARAMETER	LIMITS						UNITS
		LS290			LS293			
		MIN	TYP	MAX	MIN	TYP	MAX	
f_{MAX}	$\overline{CP}_0$ Input Clock Frequency	32			32			MHz
f_{MAX}	$\overline{CP}_1$ Input Clock Frequency	16			16			MHz
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}_0$ Input to Q_0 Output		10 12	16 18		10 12	16 18	ns
t_{PLH} t_{PHL}	$\overline{CP}_0$ Input to Q_3 Output		32 34	48 50		46 46	70 70	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_1 Output		10 14	16 21		10 14	16 21	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_2 Output		21 23	32 35		21 23	32 35	ns
t_{PLH} t_{PHL}	$\overline{CP}_1$ Input to Q_3 Output		21 23	32 35		34 34	51 51	ns
t_{PHL}	MS Input to Q_0 and Q_3 Outputs		20	30				ns
t_{PHL}	MS Input to Q_1 and Q_2 Outputs		26	40				ns
t_{PHL}	MR Input to Any Output		26	40		26	40	ns

4

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS				UNITS
		LS290		LS293		
		MIN	MAX	MIN	MAX	
t_W	$\overline{CP}_0$ Pulse Width	15		15		ns
t_W	$\overline{CP}_1$ Pulse Width	30		30		ns
t_W	MS Pulse Width	15				ns
t_W	MR Pulse Width	15		15		ns
t_{rec}	Recovery Time MR to $\overline{CP}$	25		25		ns

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from HIGH-to-LOW in order to recognize and transfer HIGH data to the Q outputs.

AC WAVE FORMS

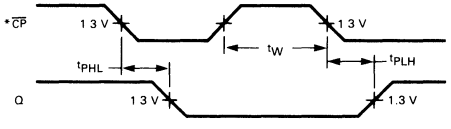


Fig. 1

*The number of Clock Pulses required between the t_{PHL} and t_{PLH} measurements can be determined from the appropriate Truth Tables.

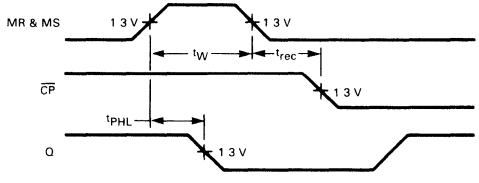


Fig. 2

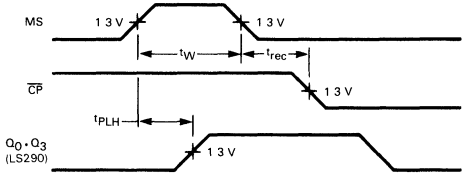


Fig. 3

MOTOROLA

SN54LS295A
SN74LS295A

4-BIT SHIFT REGISTERS WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

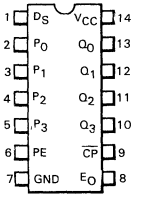
DESCRIPTION — The SN54LS/74LS295A is a 4-Bit Shift Register with serial and parallel synchronous operating modes, and independent 3-state output buffers. The Parallel Enable input (PE) controls the shift-right or parallel load operation. All data transfers and shifting occur synchronous with the HIGH to LOW clock transition.

The 3-State output buffers are controlled by an active HIGH Output Enable input (EO). Disabling the output buffers does not affect the shifting or loading of input data, but it does inhibit serial expansion.

The LS295A is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all Motorola TTL families.

- **FULLY SYNCHRONOUS SERIAL OR PARALLEL DATA TRANSFERS**
- **NEGATIVE EDGE-TRIGGERED CLOCK INPUT**
- **PARALLEL ENABLE MODE CONTROL INPUT**
- **3-STATE BUSSABLE OUTPUT BUFFERS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

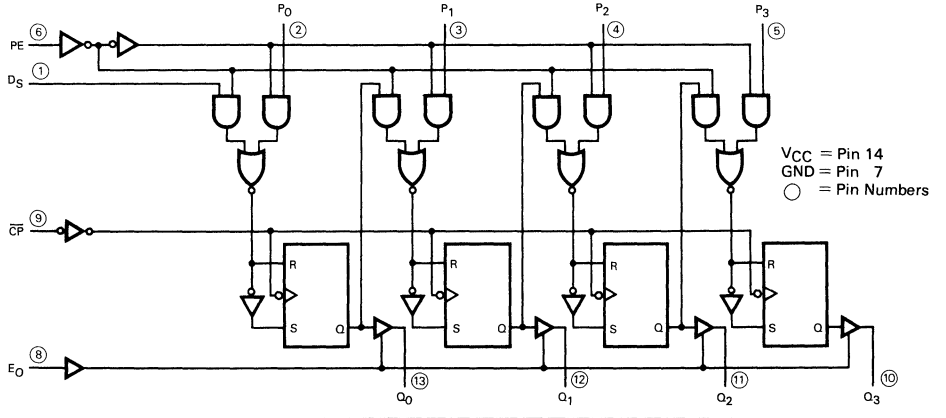
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

PIN NAMES

		LOADING (Note a) HIGH	LOW
PE	Parallel Enable Input	0.5 U.L.	0.25 U.L.
D_S	Serial Data Input	0.5 U.L.	0.25 U.L.
P_0—P_3	Parallel Data Input	0.5 U.L.	0.25 U.L.
$\overline{E_O}$	Output Enable Input	0.5 U.L.	0.25 U.L.
$\overline{CP}$	Clock Pulse (Active LOW Going Edge) Input	0.5 U.L.	0.25 U.L.
Q_0—Q_3	3-State Outputs (Note b)	10(25) U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L. for Military (54) and 65 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM



4

FUNCTIONAL DESCRIPTION — The LS295A is a 4-Bit Shift Register with serial and parallel synchronous operating modes. It has a Serial Data (D_S) and four Parallel Data (P_0–P_3) inputs and four parallel 3-State output buffers (Q_0–Q_3). When the Parallel Enable (PE) input is HIGH, data is transferred from the Parallel Data Inputs (P_0—P_3) into the register synchronous with the HIGH to LOW transition of the Clock ($\overline{CP}$). When the PE is LOW, a HIGH to LOW transition on the clock transfers the serial data on the D_S input to register Q_0, and shifts data from Q_0 to Q_1, Q_1 to Q_2 and Q_2 to Q_3. The input data and parallel enable are fully edge-triggered and must be stable only one set-up time before the HIGH to LOW clock transition.

The 3-State output buffers are controlled by an active HIGH Output Enable input (E_O). When the E_O is HIGH, the four register outputs appear at the Q_0—Q_3 outputs. When E_O is LOW, the outputs are forced to a high impedance "off" state. The 3-State output buffers are completely independent of the register operation,i.e., the input transitions on the E_O input do not affect the serial or parallel data transfers of the register. If the outputs are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-State devices whose outputs are tied together are designed so there is no overlap.

4

MODE SELECT – TRUTH TABLE

OPERATING MODE	INPUTS				OUTPUTS*			
	PE	$\overline{CP}$	D_S	P_n	Q_0	Q_1	Q_2	Q_3
Shift Right	l	⌐	l	X	L	q_0	q_1	q_2
	l	⌐	h	X	H	q_0	q_1	q_2
Parallel Load	h	⌐	X	p_n	p_0	p_1	p_2	p_3

*The indicated data appears at the Q outputs when E_O is HIGH. When E_O is LOW, the indicated data is loaded into the register, but the outputs are all forced to the high impedance "off" state.

L = LOW Voltage Levels
H = HIGH Voltage Levels
X = Don't Care
$p_n(q_n)$ = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.
l = LOW Voltage Level one set-up time prior to the HIGH to LOW clock transition.
h = HIGH Voltage Level one set-up time prior to the HIGH to LOW clock transition.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0 7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2 5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current					mA	V_{CC} = MAX, E_O = 4 5 V, $\overline{CP}$ momentary 3.0 V, then GND
	Total, Output HIGH				29		V_{CC} = MAX, E_O = GND, $\overline{CP}$ = GND
	Total, Output LOW				33		

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	45		MHz	C_L = 15 pF, V_{CC} = 5.0 V
t_{PLH} t_{PHL}	Propagation Delay Clock to Output		14 19	20 30	ns	
t_{PZH}	Output Enable Time to HIGH LEVEL		18	26	ns	
t_{PZL}	Output Enable Time to LOW Level		20	30	ns	
t_{PLZ}	Output Disable Time from LOW Level		13	20	ns	C_L = 5.0 pF
t_{PHZ}	Output Disable Time from HIGH Level		13	20	ns	

4

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	16			ns	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_s	Data Setup Time	20			ns	
t_h	Data Hold Time	0			ns	

DEFINITION OF TERMS:

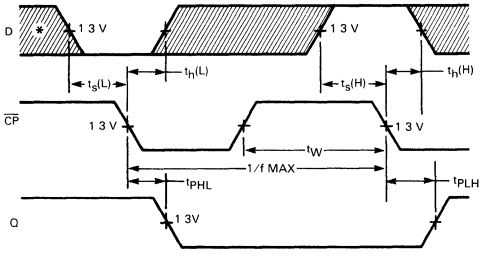
SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from HIGH to LOW in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from HIGH to LOW that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from HIGH to LOW and still be recognized.

4

AC WAVEFORMS

The shaded areas indicate when the input is permitted to change for predictable output performance.



*The Data Input is D_S for PE = LOW and P_n for PE = HIGH.

Fig. 1

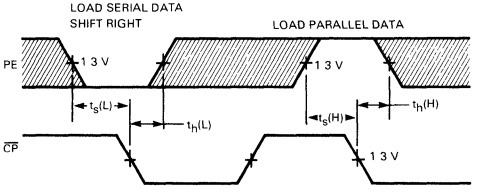


Fig. 2

MOTOROLA

SN54LS298
SN74LS298

QUAD 2-INPUT MULTIPLEXER WITH STORAGE

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS298 is a Quad 2-Port Register. It is the logical equivalent of a quad 2-input multiplexer followed by a quad 4-bit edge-triggered register. A Common Select input selects between two 4-bit input ports (data sources.) The selected data is transferred to the output register synchronous with the HIGH to LOW transition of the Clock input.

The LS298 is fabricated with the Schottky barrier process for high speed and is completely compatible with all Motorola TTL families.

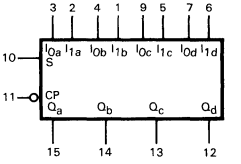
- **SELECT FROM TWO DATA SOURCES**
- **FULLY EDGE-TRIGGERED OPERATION**
- **TYPICAL POWER DISSIPATION OF 65 mW**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{S}$	Common Select Input	0.5 U.L.	0.25 U.L.
$\overline{CP}$	Clock (Active LOW Going Edge) Input	0.5 U.L.	0.25 U.L.
I_{0a}—I_{0d}	Data Inputs From Source 0	0.5 U.L.	0.25 U.L.
I_{1a}—I_{1d}	Data Inputs From Source 1	0.5 U.L.	0.25 U.L.
Q_a—Q_d	Register Outputs (Note b)	10 U.L.	5(2.5) U.L.

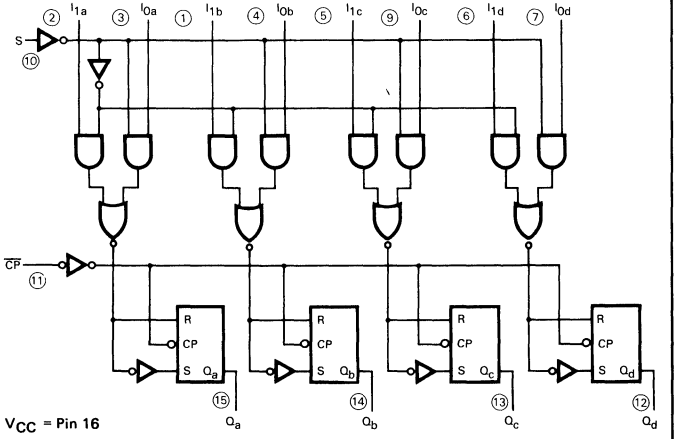
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC SYMBOL



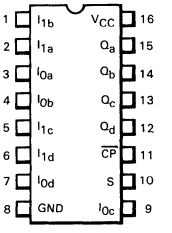
V_{CC} = Pin 16
GND = Pin 8

LOGIC OR BLOCK DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The LS298 is a high speed Quad 2-Port Register. It selects four bits of data from two sources (ports) under the control of a Common Select Input (S). The selected data is transferred to the 4-bit output register synchronous with the HIGH to LOW transition of the Clock input ($\overline{CP}$). The 4-bit output register is fully edge-triggered. The Data inputs (I) and Select input (S) must be stable only one setup time prior to the HIGH to LOW transition of the clock for predictable operation.

TRUTH TABLE

INPUTS			OUTPUT
S	I_0	I_1	Q
l	l	X	L
l	h	X	H
h	X	l	L
h	X	h	H

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care
l = LOW Voltage Level one setup time prior to the HIGH to LOW clock transition.
h = HIGH Voltage Level one setup time prior to the HIGH to LOW clock transition.

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				21	mA	V_{CC} = MAX

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH}	Propagation Delay,		18	27	ns	$V_{CC} = 5.0$ V
t_{PHL}	Clock to Output		21	32	ns	$C_L = 15$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	15			ns	
t_s	Select Setup Time	25			ns	
t_h	Data Hold Time	5.0			ns	
t_h	Select Hold Time	0				

DEFINITIONS OF TERMS:

SETUP TIME (t_s) – is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW to HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) – is defined as the minimum time following the clock transition from LOW to HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW to HIGH and still be recognized.

4

AC WAVEFORMS

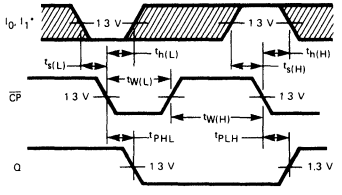


Fig. 1

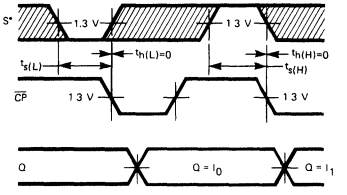


Fig. 2

*The shaded areas indicate when the input is permitted to change for predictable output performance.

MOTOROLA

SN54LS299
SN74LS299

8-BIT SHIFT/STORAGE REGISTER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS299 is an 8-Bit Universal Shift/Storage Register with 3-state outputs. Four modes of operation are possible: hold (store), shift left, shift right and load data.

The parallel load inputs and flip-flop outputs are multiplexed to reduce the total number of package pins. Separate outputs are provided for flip-flops Q_0 and Q_7 to allow easy cascading. A separate active LOW Master Reset is used to reset the register.

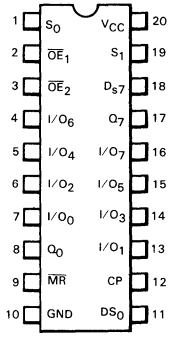
- **COMMON I/O FOR REDUCED PIN COUNT**
- **FOUR OPERATION MODES: SHIFT LEFT, SHIFT RIGHT, LOAD AND STORE**
- **SEPARATE SHIFT RIGHT SERIAL INPUT AND SHIFT LEFT SERIAL INPUT FOR EASY CASCADING**
- **3-STATE OUTPUTS FOR BUS ORIENTED APPLICATIONS**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
CP	Clock Pulse (active positive-going edge) Input	0.5 U.L.	0.25 U.L.
DS_0	Serial Data Input for Right Shift	0.5 U.L.	0.25 U.L.
DS_7	Serial Data Input for Left Shift	0.5 U.L.	0.25 U.L.
I/O_n	Parallel Data Input or Parallel Output (3-State) (Note c)	0.5 U.L. 65(25) U.L.	0.25 U.L. 15(7.5) U.L.
$\overline{OE}_1$, $\overline{OE}_2$	3-State Output Enable (active LOW) Inputs	0.5 U.L.	0.25 U.L.
Q_0, Q_7	Serial Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{MR}$	Asynchronous Master Reset (active LOW) Input	0.5 U.L.	0.25 U.L.
S_0, S_1	Mode Select Inputs	1 U.L.	0.5 U.L.

NOTES
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.
c. The Output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial (74), The Output HIGH drive factor is 25 U.L. for Military (54) and 65 U.L. for Commercial (74) Temperature Ranges.

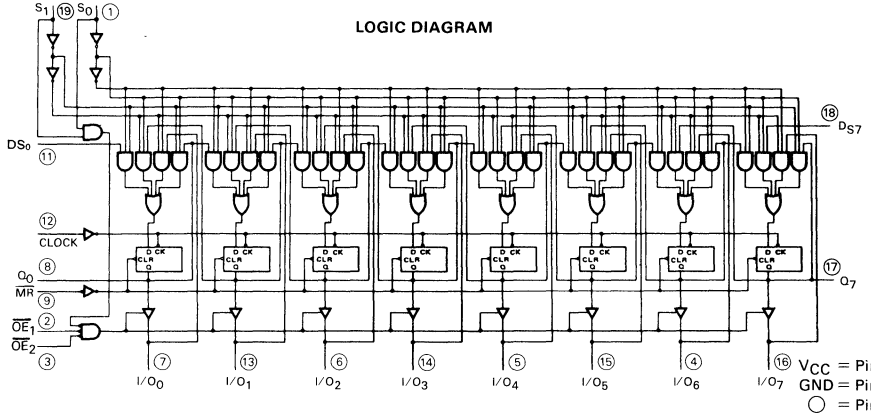
CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

NOTE.
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER			MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage		54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range		54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	Q_0, Q_7	54,74			−0.4	mA
I_{OL}	Output Current — Low	Q_0, Q_7 Q_0, Q_7	54 74			4.0 8.0	mA
I_{OH}	Output Current — High	I/O_0—I/O_7 I/O_0—I/O_7	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	I/O_0—I/O_7 I/O_0—I/O_7	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage I/O_0—I/O_7	54	2.4	3.2		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.4	3.1		V		
V_{OH}	Output HIGH Voltage Q_0, Q_7	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.7	3.4		V		
V_{OL}	Output LOW Voltage I/O_0—I/O_7	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
V_{OL}	Output LOW Voltage Q_0—Q_7	54,74			0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74			0.5	V	I_{OL} = 8.0 mA	
I_{OZH}	Output Off Current HIGH I/O_0—I/O_7				40	μA	V_{CC}= MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW I/O_0—I/O_7				−400	μA	V_{CC}= MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current	Others			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
		S_0, S_1, I/O_0—I/O_7			40	μA		
		Others			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
		S_0, S_1			0.2	mA		
		I/O_0—I/O_7			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V	
I_{IL}	Input LOW Current	Others			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
		S_0, S_1			−0.8	mA		
I_{OS}	Short Circuit Current	Q_0, Q_7	−20		−100	mA	V_{CC} = MAX	
		I/O_0—I/O_7	−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				53	mA	V_{CC} = MAX	

FUNCTION TABLE

INPUTS								RESPONSE
$\overline{MR}$	S_1	S_0	$\overline{OE}_1$	$\overline{OE}_2$	CP	DS_0	DS_7	
L	X	X	H	X	X	X	X	Asynchronous Reset; $Q_0 = Q_7$ = LOW
L	X	X	X	H	X	X	X	I/O Voltage Undetermined
L	H	H	X	X	X	X	X	
L	L	X	L	L	X	X	X	Asynchronous Reset; $Q_0 = Q_7$ = LOW
L	X	L	L	L	X	X	X	I/O Voltage LOW
X	L	H	X	X	↓	D	X	Shift Right; D→Q_0; Q_0→Q_1; etc.
H	L	H	L	L	↓	D	X	Shift Right; D→Q_0 & I/O_0; Q_0→Q_1 & I/O_1; etc.
H	H	L	X	X	↓	X	D	Shift Left; D→Q_7; Q_7→Q_6; etc.
H	H	L	L	L	↓	X	D	Shift Left; D→Q_7 & I/O_7; Q_7→Q_6 & I/O_6; etc.
H	H	H	X	X	↓	X	X	Parallel Load; I/O_n→Q_n
H	L	L	H	X	X	X	X	Hold: I/O Voltage undetermined
H	L	L	X	H	X	X	X	
H	L	L	L	L	X	X	X	Hold: $I/O_n = Q_n$

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	35		MHz	$C_L = 15$ pF
t_{PHL} t_{PLH}	Propagation Delay, Clock to Q_0 or Q_7		26 22	39 33	ns	
t_{PHL}	Propagation Delay, Clear to Q_0 or Q_7		27	40	ns	
t_{PHL} t_{PLH}	Propagation Delay, Clock to $I/O_0 - I/O_7$		26 17	39 25	ns	$C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PHL}	Propagation Delay, Clear to $I/O_0 - I/O_7$		26	40	ns	
t_{PZH} t_{PZL}	Output Enable Time		13 19	21 30	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		10 10	15 15	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width HIGH	30			ns	$V_{CC} = 5.0$ V
t_W	Clock Pulse Width LOW	10			ns	
t_W	Clock Pulse Width LOW	20			ns	
t_s	Data Setup Time	20			ns	
t_s	Select Setup Time	35			ns	
t_h	Data Hold Time	0			ns	
t_h	Select Hold Time	10			ns	
t_{rec}	Recovery Time	20			ns	

DEFINITION OF TERMS:

SETUP TIME (t_s) is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

RECOVERY TIME (t_{rec}) is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH Data to the Q outputs.

MOTOROLA

SN54LS322A
SN74LS322A

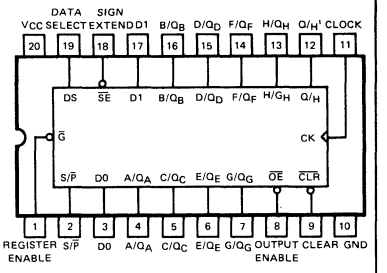
8-BIT SHIFT REGISTERS WITH SIGN EXTEND

LOW POWER SCHOTTKY

DESCRIPTION — These 8-bit shift registers have multiplexed input/output data ports to accomplish full 8-bit data handling in a single 20-pin package. Serial data may enter the shift-right register through either D0 or D1 inputs as selected by the data select pin. A serial output is also provided. Synchronous parallel loading is achieved by taking the register enable and the S/$\overline{P}$ inputs low. This places the three-state input/output ports in the data input mode. Data is entered on the low-to-high clock transition. The data extend function repeats the sign in the Q_A flip-flop during shifting. An overriding clear input clears the internal registers when taken low whether the outputs are enabled or off. The output enable does not affect synchronous operation of the register.

- MULTIPLEXED INPUTS/OUTPUTS PROVIDE IMPROVED BIT DENSITY
- SIGN EXTEND FUNCTION
- DIRECT OVERRIDING CLEAR
- 3-STATE OUTPUTS DRIVE BUS LINES DIRECTLY

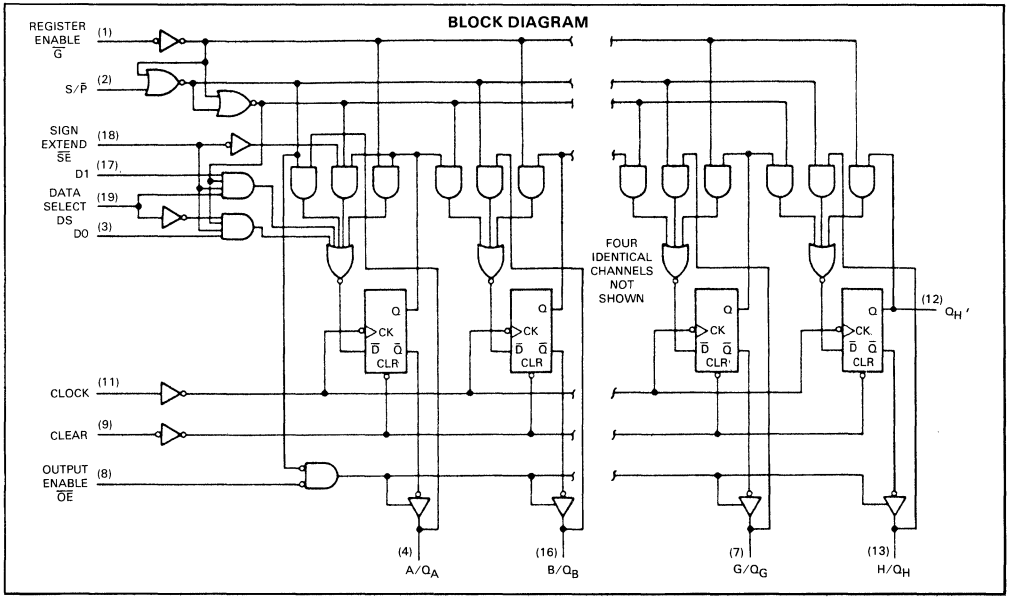
(TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

4

BLOCK DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER			MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage		54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range		54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	Q_H'	54,74			−0.4	mA
I_{OL}	Output Current — Low	Q_H' Q_H'	54 74			4.0 8.0	mA
I_{OH}	Output Current — High	Q_A—Q_H Q_A—Q_H	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	Q_A—Q_H Q_A—Q_H	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage Q_A-Q_H	54	2.4	3.2		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.4	3.2		V		
V_{OH}	Output HIGH Voltage Q_H'	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.7	3.4		V		
V_{OL}	Output LOW Voltage Q_A-Q_H	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
V_{OL}	Output LOW Voltage Q_H'	54,74			0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74			0.5	V	I_{OL} = 8.0 mA	
I_{OZH}	Output Off Current HIGH Q_A-Q_H				40	μA	V_{CC} = MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW Q_A-Q_H				−400	μA	V_{CC}= MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current	Other			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
		A-H, Data Select			40	μA		
		Sign Extend			60	μA		
		Other			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
		Data Select			0.2	mA		
		Sign Extend			0.3	mA		
		A-H			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V	
I_{IL}	Input LOW Current	Other			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
		Data Select			−0.8	mA		
		Sign Extend			−1.2	mA		
I_{OS}	Short Circuit Current	Q_H'	−20		−100	mA	V_{CC} = MAX	
		Q_A-Q_H	−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				60	mA	V_{CC} = MAX	

FUNCTION TABLE

OPERATION	INPUTS							INPUTS/OUTPUTS				OUTPUT
	CLEAR	REGISTER ENABLE	S/$\overline{P}$	SIGN EXTEND	DATA SELECT	OUTPUT ENABLE	CLOCK	A/Q_A	B/Q_B	C/Q_C ... H/Q_H		Q_H'
Clear	L	H	X	X	X	L	X	L	L	L	L	L
	L	X	H	X	X	L	X	L	L	L	L	L
Hold	H	H	X	X	X	L	X	Q_{A0}	Q_{B0}	Q_{C0}	Q_{H0}	Q_{H0}
Shift Right	H	L	H	H	L	L	↑	D0	Q_{An}	Q_{Bn}	Q_{Gn}	Q_{Gn}
	H	L	H	H	H	L	↑	D1	Q_{An}	Q_{Bn}	Q_{Gn}	Q_{Gn}
Sign Extend	H	L	H	L	X	L	↑	Q_{An}	Q_{An}	Q_{Bn}	Q_{Gn}	Q_{Gn}
Load	H	L	L	X	X	X	↑	a	b	c	h	h

When the output enable is high, the eight input/output terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected. If both the register enable input and the S/$\overline{P}$ input are low while the clear input is low, the register is cleared while the eight input/output terminals are disabled to the high-impedance state.

H = high level (steady state)
L = low level (steady state)
X = irrelevant (any input, including transitions)
↑ = transition from low to high level
Q_{A0} . . . Q_{H0} = the level of Q_A through Q_H, respectively, before the indicated steady-state conditions were established
Q_{An} . . . Q_{Hn} = the level of Q_A through Q_H, respectively, before the most recent ↑ transition of the clock
D0, D1 = the level of steady-state inputs at inputs D0 and D1 respectively
a . . . h = the level of steady-state inputs at inputs A through H respectively

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	35		MHz	$C_L = 15$ pF
t_{PHL} t_{PLH}	Propagation Delay, Clock to Q_H'		26 22	35 33	ns	
t_{PHL}	Propagation Delay, Clear to Q_H'		27	35	ns	
t_{PHL} t_{PLH}	Propagation Delay, Clock to Q_A-Q_H		22 16	33 25	ns	$C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PHL}	Propagation Delay, Clear to Q_A-Q_H		22	35	ns	
t_{PZH} t_{PZL}	Output Enable Time		15 15	35 35	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		15 15	25 25	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width HIGH	30			ns	$V_{CC} = 5.0$ V
t_W	Clock Pulse Width LOW	10			ns	
t_W	Clear Pulse Width LOW	20			ns	
t_s	Data Setup Time	20			ns	
t_s	Select Setup Time	10			ns	
t_h	Data Hold Time	0			ns	
t_h	Select Hold Time	10			ns	
t_{rec}	Recovery Time	20			ns	

DEFINITION OF TERMS:

SETUP TIME t_s is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME t_h is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

RECOVERY TIME t_{rec} is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH Data to the Q outputs.

MOTOROLA

SN54LS323
SN74LS323

8-BIT SHIFT/STORAGE REGISTER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS323 is an 8-Bit Universal Shift/Storage Register with 3-state outputs. Its function is similar to the SN54LS/74LS299 with the exception of Synchronous Reset. Parallel load inputs and flip-flop outputs are multiplexed to minimize pin count. Separate inputs and outputs are provided for flip-flops Q_0 and Q_7 to allow easy cascading.

Four operation modes are possible: hold (store), shift left, shift right, and parallel load. All modes are activated on the LOW-to-HIGH transition of the Clock.

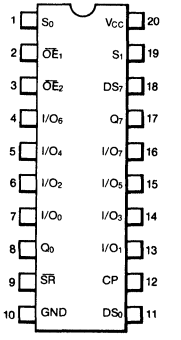
- **COMMON I/O FOR REDUCED PIN COUNT**
- **FOUR OPERATION MODES: SHIFT LEFT, SHIFT RIGHT, PARALLEL LOAD AND STORE**
- **SEPARATE CONTINUOUS INPUTS AND OUTPUTS FROM Q_0 AND Q_7 ALLOW EASY CASCADING**
- **FULLY SYNCHRONOUS RESET**
- **3-STATE OUTPUTS FOR BUS ORIENTED APPLICATIONS**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
CP	Clock Pulse (active positive-going edge) Input	0.5 U.L.	0.25 U.L.
DS_0	Serial Data Input For Right Shift	0.5 U.L.	0.25 U.L.
DS_7	Serial Data Input For Left Shift	0.5 U.L.	0.25 U.L.
I/O_n	Parallel Data Input or Parallel Output (3-State) (Note c)	1.0 U.L. 65(25) U.L.	0.5 U.L. 15(7.5) U.L.
$\overline{OE}_1$, $\overline{OE}_2$	3-State Output Enable (active LOW) Inputs	0.5 U.L.	0.25 U.L.
Q_0, Q_7	Serial Outputs (Note b)	10 U.L.	5(2.5) U.L.
S_0, S_1	Mode Select Inputs	1 U.L.	
$\overline{SR}$	Synchronous Reset (active LOW) Input	0.5 U.L.	0.25 U.L.

NOTES:
a. 1 TTL LOAD = .40 μA HIGH/1.6 mA LOW.
b. The output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial Temperature Ranges.
c. The output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial Temperature Ranges.
The output HIGH drive factor is 25 U.L. for Military (54) and 65 U.L. for Commercial Temperature Ranges.

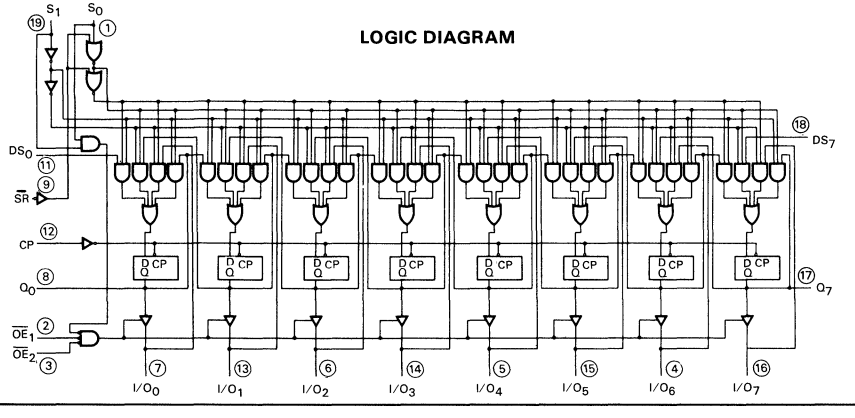
CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAM



FUNCTIONAL DESCRIPTION The logic diagram and truth table indicate the functional characteristics of the SN54LS/74LS323 Universal Shift/Storage Register. This device is similar in operation to the SN54LS/74LS299 except for synchronous reset. A partial list of the common features are described below:

1. They use eight D-type edge-triggered flip-flops that respond only to the LOW-to-HIGH transition of the Clock (CP). The only timing restriction, therefore, is that the mode control (S_0, S_1) and data inputs (DS_0, DS_7, I/O_0-I/O_7) may be stable at least a setup time prior to the positive transition of the Clock Pulse.

2. When $S_0 = S_1 = 1$, I/O_0-I/O_7 are parallel inputs to flip-flops Q_0-Q_7 respectively, and the outputs of Q_0-Q_7 are in the high impedance state regardless of the state of $\overline{OE}_1$ or $\overline{OE}_2$.

An important unique feature of the SN54LS/74LS323 is a fully Synchronous Reset that requires only to be stable at least one setup time prior to the positive transition of the Clock Pulse.

TRUTH TABLE

INPUTS								RESPONSE
$\overline{SR}$	S_1	S_0	$\overline{OE}_1$	$\overline{OE}_2$	CP	DS_0	DS_7	
L	X	X	H	X	⎍	X	X	Synchronous Reset, $Q_0 = Q_7$ = LOW
L	X	X	X	H	⎍	X	X	I/O voltage undetermined
L	H	H	X	X	⎍	X	X	
L	L	X	L	L	⎍	X	X	Synchronous Reset, $Q_0 = Q_7$ = LOW
L	X	L	L	L	⎍	X	X	I/O voltage LOW
H	L	H	X	X	⎍	D	X	Shift Right; $D \rightarrow Q_0$, $Q_0 \rightarrow Q_1$, etc
H	L	H	L	L	⎍	D	X	Shift Right, $D \rightarrow Q_0$ & I/O_0, $Q_0 \rightarrow Q_1$ & I/O_1, etc
H	H	L	X	X	⎍	X	D	Shift Left; $D \rightarrow Q_7$, $Q_7 \rightarrow Q_6$, etc
H	H	L	L	L	⎍	X	D	Shift Left, $D \rightarrow Q_7$ & I/O_7, $Q_7 \rightarrow Q_6$ & I/O_6, etc
H	H	H	X	X	⎍	X	X	Parallel Load $I/O_n \rightarrow Q_n$
H	L	L	H	X	X	X	X	Hold, I/O Voltage Undetermined
H	L	L	X	H	X	X	X	
H	L	L	L	L	X	X	X	Hold, $I/O_n = Q_n$

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER			MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage		54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range		54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	Q_0, Q_7	54,74			−0.4	mA
I_{OL}	Output Current — Low	Q_0, Q_7 Q_0, Q_7	54 74			4.0 8.0	mA
I_{OH}	Output Current — High	I/O_0—I/O_7 I/O_0—I/O_7	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	I/O_0—I/O_7 I/O_0—I/O_7	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage I/O_0—I/O_7	54	2.4	3.2		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.4	3.1		V		
V_{OH}	Output HIGH Voltage Q_0,Q_7	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = MAX	
		74	2.7	3.4		V		
V_{OL}	Output LOW Voltage I/O_0-I/O_7	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
V_{OL}	Output LOW Voltage Q_0-Q_7	54,74			0.4	V	I_{OL} = 4.0 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74			0.5	V	I_{OL} = 8.0 mA	
I_{OZH}	Output Off Current HIGH I/O_0-I/O_7				40	μA	V_{CC}= MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW I/O_0-I/O_7				−400	μA	V_{CC}= MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current	Others			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
		S_0, S_1, I/O_0-I/O_7			40	μA		
		Others			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
		S_0, S_1			0.2	mA		
		I/O_0-I/O_7			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V	
I_{IL}	Input LOW Current	Others			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
		S_0, S_1			−0.8	mA		
I_{OS}	Short Circuit Current	Q_0, Q_7	−20		−100	mA	V_{CC} = MAX	
		I/O_0-I/O_7	−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				53	mA	V_{CC} = MAX	

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	35		MHz	$C_L = 15$ pF
t_{PHL} t_{PLH}	Propagation Delay, Clock to Q_0 or Q_7		26 22	39 33	ns	
t_{PHL} t_{PLH}	Propagation Delay, Clock to I/O_0-I/O_7		25 17	39 25	ns	$C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PZH} t_{PZL}	Output Enable Time		14 20	21 30	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		10 10	15 15	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width HIGH	30			ns	$V_{CC} = 5.0$ V
t_W	Clock Pulse Width LOW	10			ns	
t_W	Clock Pulse Width LOW	20			ns	
t_s	Data Setup Time	20			ns	
t_s	Select Setup Time	35			ns	
t_h	Data Hold Time	0			ns	
t_h	Select Hold Time	10			ns	
t_{rec}	Recovery Time	20			ns	

DEFINITION OF TERMS:

SETUP TIME t_s is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME t_h is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

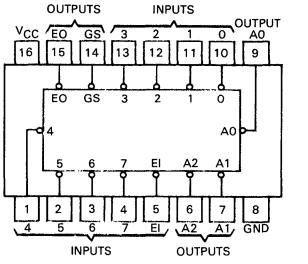
RECOVERY TIME t_{rec} is defined as the minimum time required between the end of the reset pulse and the clock transition from LOW-to-HIGH in order to recognize and transfer HIGH Data to the Q outputs.

MOTOROLA

SN54LS/74LS348
SN54LS/74LS848

8-INPUT PRIORITY ENCODER

LOW POWER SCHOTTKY



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

DESCRIPTION — 1The SN54LS/74LS348 and the SN54LS/74LS848 are eight input priority encoders which provide the 8-line to 3-line function.

The outputs(A0–A2) and inputs (0–7) are active low. The active low input which has the highest priority (input 7 has the highest) is represented on the outputs (output A0 is the lowest bit). An example would be if inputs 1, 2 and 4 were low, then a binary 4 would be represented on the outputs.

The GS (Group Signal) output is active low when any of the inputs are low. It serves to indicate when any of the inputs are active.

A0, A1 and A2 are three-state outputs. This allows for up to 64 line expansion without the need for special external circuitry.

A logical one on the Enable Input (EI) forces A0, A1 and A2 to the disabled state and outputs GS and EO to the high state. A high on all data inputs (0–7) together with a low on the EI input disables outputs A0, A1, and A2 and forces output GS to the high state and output EO to the low state.

Use of the EI input in conjunction with the EO output provides for the capability of having priority encoding of n input signals.

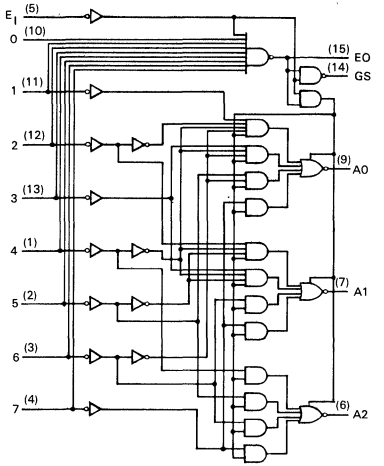
The LS848 has special internal circuitry providing for a greatly reduced negative going glitch on the GS (Group Signal) output and on a reduced tendency for the A0, A1 and A2 outputs to become momentarily enabled. Both of these occurrences happen when the EI input goes from a logical one to a logical zero and all data inputs (0–7) are held at logical ones. The internal glitch reduction circuitry does add an additional fan-in of one on all data inputs (compared to that of the LS348).

FUNCTION TABLE

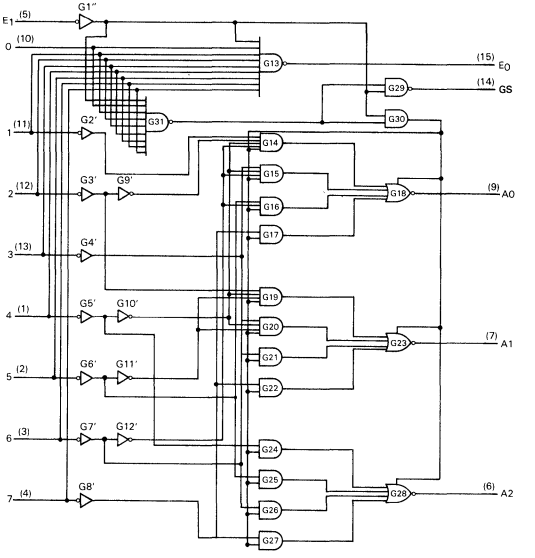
INPUTS									OUTPUTS				
EI	0	1	2	3	4	5	6	7	A2	A1	A0	GS	EO
H	X	X	X	X	X	X	X	X	Z	Z	Z	H	H
L	H	H	H	H	H	H	H	H	Z	Z	Z	H	L
L	X	X	X	X	X	X	X	L	L	L	L	L	H
L	X	X	X	X	X	X	L	H	L	L	H	L	H
L	X	X	X	X	X	L	H	H	L	H	L	L	H
L	X	X	X	X	L	H	H	H	L	H	H	L	H
L	X	X	X	L	H	H	H	H	H	L	L	L	H
L	X	X	L	H	H	H	H	H	H	L	H	L	H
L	X	L	H	H	H	H	H	H	H	H	L	L	H
L	L	H	H	H	H	H	H	H	H	H	H	L	H

H = high logic level
L = low logic level
X = irrelevant
Z = high impedance state

BLOCK DIAGRAMS



SN54LS/74LS348



SN54LS/74LS848

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High EO, GS	54,74			−0.4	mA
I_{OH}	Output Current — High A0, A1, A2 A0, A1, A2	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low EO, GS	54 74			4.0 8.0	mA
I_{OL}	Output Current — Low A0, A1, A2 A0, A1, A2	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage A0, A1, A2	54,74	2.4	3.1		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
	EO, GS	54	2.5	3.5		V	
	EO, GS	74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current Input 0, EI — LS348				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Input 0 — LS848				40	μA	
	Other — LS348 Other — LS848				40 60	μA μA	
	Input 0, EI — LS348				0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
	Input 0 — LS848				0.2	mA	
	Other — LS348 Other — LS848				0.2 0.3	mA mA	
I_{IL}	Input LOW Current Input 0, EI — LS348				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	Input 0 — LS848				−0.8	mA	
	Other — LS348 Other — LS848				−0.8 −1.2	mA mA	
I_{OS}	Short Circuit Current	EO, GS	−20		−120	mA	V_{CC} = MAX
		A0,A1,A2	−30		−130	mA	
I_{CC}	Power Supply Current Total, Output HIGH			12	23	mA	V_{CC} = MAX, All Inputs and Outputs Open
	Total, Output LOW			13	25		V_{CC} = MAX, Inputs 7, E1 = GND All Others Open

4

AC CHARACTERISTICS: $V_{CC} = 5.0$ V, $T_A = 25°C$

SYMBOL	FROM (INPUT)	TO (OUTPUT)	WAVEFORM	LS348 LIMITS			LS848 LIMITS			UNIT	TEST CONDITIONS
				MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH}	1 thru 7	A0, A1, or A2	In-Phase		11	17		12	18	ns	$C_L = 45$ pF
t_{PHL}			output		20	30		20	30		
t_{PLH}	1 thru 7	A0, A1, or A2	Out-of-Phase		23	35		23	35	ns	$R_L = 667\ \Omega$
t_{PHL}			output		23	35		23	35		
t_{PZH}	EI	A0, A1, or A2			25	39		25	39	ns	
t_{PZL}					24	41		24	41		
t_{PLH}	0 thru 7	EO	Out-of-Phase		11	18		11	18	ns	
t_{PHL}			output		26	40		26	40		
t_{PLH}	0 thru 7	GS	In-Phase		38	55		38	55	ns	$C_L = 15$ pF
t_{PHL}			output		9.0	21		9.0	21		
t_{PLH}	EI	GS	In-Phase		11	17		11	17	ns	$R_L = 2.0\ k\Omega$
t_{PHL}			output		14	36		14	36		
t_{PLH}	EI	EO	In-Phase		17	21		17	21	ns	
t_{PHL}			output		25	40		30	45		
t_{PHZ}	EI	A0, A1 or A2			18	27		18	27	ns	$C_L = 5.0$ pF
t_{PLZ}					23	35		23	35		$R_L = 667\ \Omega$

4

MOTOROLA

SN54LS352
SN74LS352

DUAL 4-INPUT MULTIPLEXER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS352 is a very high-speed Dual 4-Input Multiplexer with Common Select inputs and individual Enable inputs for each section. It can select two bits of data from four sources. The two buffered outputs present data in the inverted (complementary) form. The SN54LS/74LS352 is the functional equivalent of the SN54LS/74LS153 except with inverted outputs.

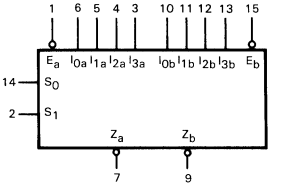
- **INVERTED VERSION OF THE SN54LS/74LS153**
- **SEPARATE ENABLES FOR EACH MULTIPLEXER**
- **INPUT CLAMP DIODE LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S_0, S_1	Common Select Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}$	Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_0—I_1	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
$\overline{Z}$	Multiplexer Outputs (note b)	10 U.L.	5(2.5) U.L.

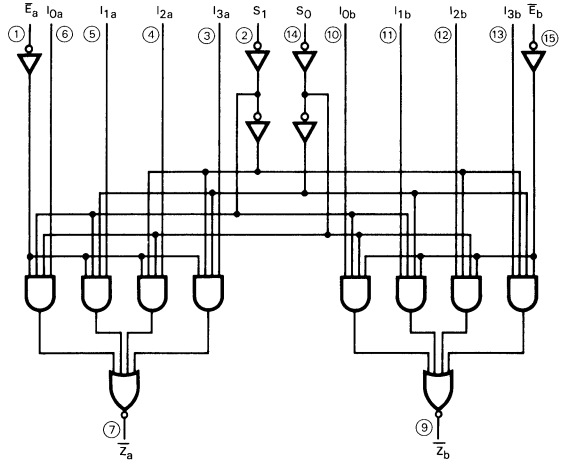
NOTES:
a 1 TTL Unit Load (U L) = 40 μA HIGH/1 6 mA LOW.
b. The Output LOW drive factor is 2 5 U L for Military (54) and 5 U L for Commercial (74) Temperature Ranges

LOGIC SYMBOL



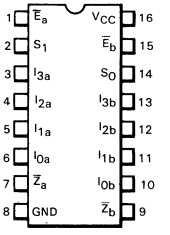
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS352 is a Dual 4-Input Multiplexer. It selects two bits of data from up to four sources under the control of the common Select Inputs (S_0, S_1). The two 4-input multiplexer circuits have individual active LOW Enables ($\overline{E}_a$, $\overline{E}_b$) which can be used to strobe the outputs independently. When the Enables ($\overline{E}_a$, $\overline{E}_b$) are HIGH, the corresponding outputs ($\overline{Z}_a$, $\overline{Z}_b$) are forced HIGH.

The logic equations for the outputs are shown below.

$$\overline{Z}_a = \overline{E}_a \bullet \overline{(I_{0a} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1a} \bullet \overline{S}_1 \bullet S_0 + I_{2a} \bullet S_1 \bullet \overline{S}_0 + I_{3a} \bullet S_1 \bullet S_0)}$$

$$\overline{Z}_b = \overline{E}_b \bullet (I_{0b} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1b} \bullet \overline{S}_1 \bullet S_0 + I_{2b} \bullet S_1 \bullet \overline{S}_0 + I_{3b} \bullet S_1 \bullet S_0)$$

The SN54LS/74LS352 can be used to move data from a group of registers to a common output bus. The particular register from which the data came would be determined by the state of the Select Inputs. A less obvious application is a function generator. The SN54LS/74LS352 can generate two functions of three variables. This is useful for implementing highly irregular random logic.

TRUTH TABLE

SELECT INPUTS		INPUTS (a or b)					OUTPUT
S_0	S_1	$\overline{E}$	I_0	I_1	I_2	I_3	$\overline{Z}$
X	X	H	X	X	X	X	H
L	L	L	L	X	X	X	H
L	L	L	H	X	X	X	L
H	L	L	X	L	X	X	H
H	L	L	X	H	X	X	L
L	H	L	X	X	L	X	H
L	H	L	X	X	H	X	L
H	H	L	X	X	X	L	H
H	H	L	X	X	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay, Select to Output		19 25	29 38	ns	Fig. 1 or 2	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Enable to Output		16 21	24 32	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		13 17	20 26	ns	Fig. 1	

AC WAVEFORMS

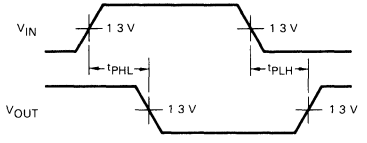


Fig. 1

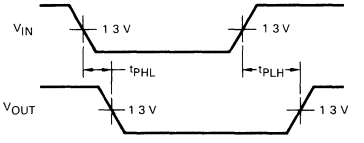


Fig. 2

MOTOROLA

SN54LS353
SN74LS353

DUAL 4-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The LSTTL/MSI SN54LS/74LS353 is a Dual 4-Input Multiplexer with 3-state outputs. It can select two bits of data from four sources using common select inputs. The outputs may be individually switched to a high impedance state with a HIGH on the respective Output Enable (E_0) inputs, allowing the outputs to interface directly with bus oriented systems. It is fabricated with the Schottky barrier diode process for high speed and is completely compatible with all TTL families.

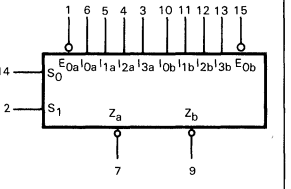
- **INVERTED VERSION OF SN54LS/74LS253**
- **SCHOTTKY PROCESS FOR HIGH SPEED**
- **MULTIFUNCTION CAPABILITY**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S_0, S_1	Common Select Inputs	0.5 U.L.	0.25 U.L.
Multiplexer A			
$\overline{E}_{0a}$	Output Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_{0a}—I_{3a}	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
$\overline{Z}_a$	Multiplexer Output (Note b)	65(25)U.L.	15(7.5) U.L.
Multiplexer B			
$\overline{E}_{0b}$	Output Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
I_{0b}—I_{3b}	Multiplexer Inputs	0.5 U.L.	0.25 U.L.
$\overline{Z}_b$	Multiplexer Output (Note b)	65(25)U.L.	15(7.5) U.L.

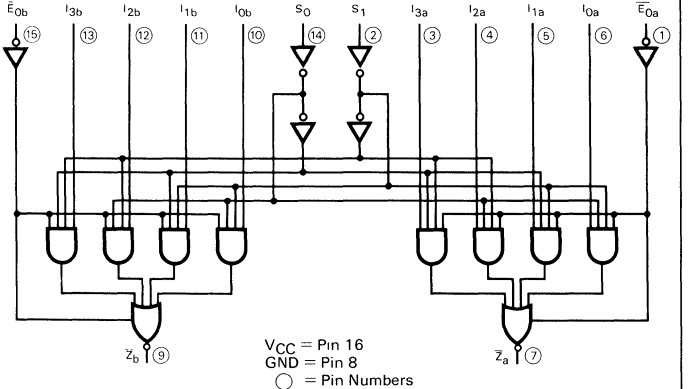
NOTES
a 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b The Output LOW drive factor is 7.5 U.L. for Military (54) and 15 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L. for Military and 65 U.L. for Commercial Temperature Ranges.

LOGIC SYMBOL



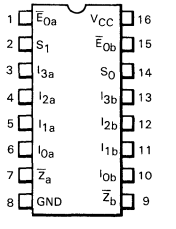
V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
◯ = Pin Numbers

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS353 contains two identical 4-input Multiplexers with 3-state outputs. They select two bits from four sources selected by common select inputs (S_0, S_1). The 4-input multiplexers have individual Output Enable (E_{0a}, E_{0b}) inputs which when HIGH, forces the outputs to a high impedance (high Z) state.

The logic equations for the outputs are shown below:

$$\overline{Z_a} = \overline{\bar{E}_{0a} \bullet (I_{0a} \bullet \bar{S}_1 \bullet \bar{S}_0 + I_{1a} \bullet \bar{S}_1 \bullet S_0 + I_{2a} \bullet S_1 \bullet \bar{S}_0 + I_{3a} \bullet S_1 \bullet S_0)}$$

$$\overline{Z_b} = \overline{\bar{E}_{0b} \bullet (I_{0b} \bullet \bar{S}_1 \bullet \bar{S}_0 + I_{1b} \bullet \bar{S}_1 \bullet S_0 + I_{2b} \bullet S_1 \bullet \bar{S}_0 + I_{3b} \bullet S_1 \bullet S_0)}$$

If the outputs of 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so that there is no overlap.

TRUTH TABLE

SELECT INPUTS		DATA INPUTS				OUTPUT ENABLE	OUTPUT
S_0	S_1	I_0	I_1	I_2	I_3	$\bar{E}_0$	Z
X	X	X	X	X	X	H	(Z)
L	L	L	X	X	X	L	H
L	L	H	X	X	X	L	L
H	L	X	L	X	X	L	H
H	L	X	H	X	X	L	L
L	H	X	X	L	X	L	H
L	H	X	X	H	X	L	L
H	H	X	X	X	L	L	H
H	H	X	X	X	H	L	L

H = HIGH Level
L = LOW Level
X = Immaterial
(Z) = High Impedance (off)
Address inputs S_0 and S_1 are common to both sections.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage $Q_A - Q_H$	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.7 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output 3-State				14	mA	V_{CC} = MAX
	Total, Output LOW				12		

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		11 13	25 20	ns	Fig. 1	C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Select to Output		20 21	45 32	ns	Fig. 1 or 2	
t_{PZH}	Output Enable Time to HIGH Level		11	23	ns	Figs. 4, 5	
t_{PZL}	Output Enable Time to LOW Level		15	23	ns	Figs. 3, 5	
t_{PLZ}	Output Disable Time from LOW Level		12	27	ns	Figs. 3, 5	C_L = 5.0 pF
t_{PHZ}	Output Disable Time from HIGH Level		27	41	ns	Figs. 4, 5	

3-STATE WAVEFORMS

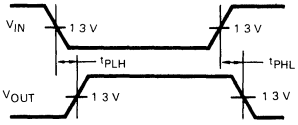


Fig. 1

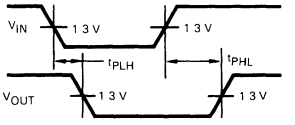


Fig. 2

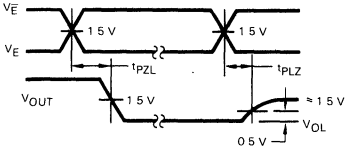


Fig. 3

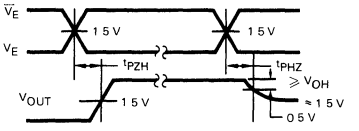
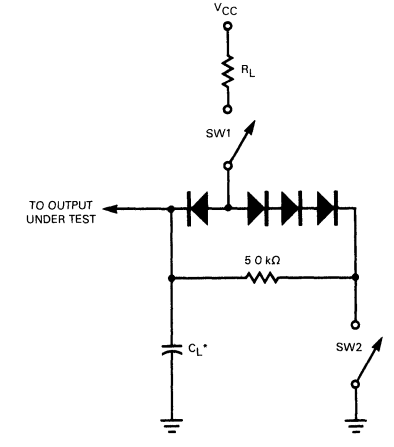


Fig. 4

4

AC LOAD CIRCUIT



*Includes Jig and Probe Capacitance

Fig. 5

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

MOTOROLA

SN54LS/74LS365A
SN54LS/74LS366A
SN54LS/74LS367A
SN54LS/74LS368A

3-STATE HEX BUFFERS

LOW POWER SCHOTTKY

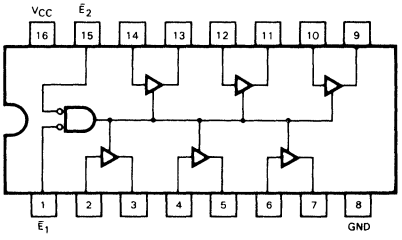
DESCRIPTION — These devices are high speed hex buffers with 3-state outputs. They are organized as single 6-bit or 2-bit/4-bit, with inverting or non-inverting data (D) paths. The outputs are designed to drive 15 TTL Unit Loads or 60 Low Power Schottky loads when the Enable (E) is LOW.

When the Output Enable (E) is HIGH, the outputs are forced to a high impedance "off" state. If the outputs of the 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so there is no overlap.

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

4

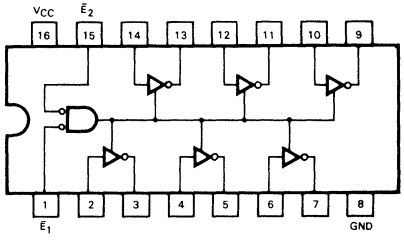
SN54LS/74LS365A
HEX 3-STATE BUFFER WITH COMMON 2-INPUT NOR ENABLE



TRUTH TABLE

INPUTS			OUTPUT
$\bar{E}_1$	$\bar{E}_2$	D	
L	L	L	L
L	L	H	H
H	X	X	(Z)
X	H	X	(Z)

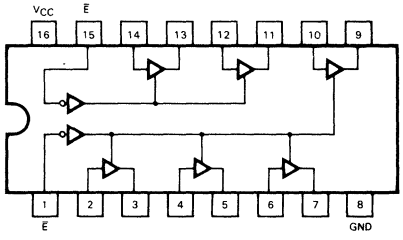
SN54LS/74LS366A
HEX 3-STATE INVERTER BUFFER WITH COMMON 2-INPUT NOR ENABLE



TRUTH TABLE

INPUTS			OUTPUT
$\bar{E}_1$	$\bar{E}_2$	D	
L	L	L	H
L	L	H	L
H	X	X	(Z)
X	H	X	(Z)

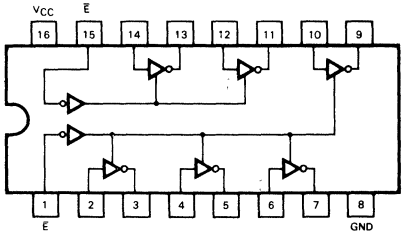
SN54LS/74LS367A
HEX 3-STATE BUFFER SEPARATE 2-BIT AND 4-BIT SECTIONS



TRUTH TABLE

INPUTS		OUTPUT
$\bar{E}$	D	
L	L	L
L	H	H
H	X	(Z)

SN54LS/74LS368A
HEX 3-STATE INVERTER BUFFER SEPARATE 2-BIT AND 4-BIT SECTIONS



TRUTH TABLE

INPUTS		OUTPUT
$\bar{E}$	D	
L	L	H
L	H	L
H	X	(Z)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current $\overline{E}$ Inputs				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	D Inputs				−20	μA	V_{CC} = MAX, V_{IN} = 0.5 V Either, $\overline{E}$ Input at 2 V
					−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V Both $\overline{E}$ Inputs at 0.4 V
I_{OS}	Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current LS365A, 367A				24	mA	V_{CC} = MAX
	LS366A, 368A				21		

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LS365A/LS367A MIN	LS365A/LS367A TYP	LS365A/LS367A MAX	LS366A/LS368A MIN	LS366A/LS368A TYP	LS366A/LS368A MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay		10 9.0	16 22		7.0 12	15 18	ns	C_L = 45 pF, R_L = 667 Ω
t_{PZH} t_{PZL}	Output Enable Time		19 24	35 40		18 28	35 45	ns	
t_{PHZ} t_{PLZ}	Output Disable Time			30 35			32 35	ns	C_L = 5.0 pF

MOTOROLA

SN54LS/74LS373
SN54LS/74LS374

OCTAL TRANSPARENT LATCH WITH 3-STATE OUTPUTS;

OCTAL D-TYPE FLIP-FLOP WITH 3-STATE OUTPUT

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS373 consists of eight latches with 3-state outputs for bus organized system applications. The flip-flops appear transparent to the data (data changes asynchronously) when Latch Enable (LE) is HIGH. When LE is LOW, the data that meets the setup times is latched. Data appears on the bus when the Output Enable ($\overline{OE}$) is LOW. When $\overline{OE}$ is HIGH the bus output is in the high impedence state.

The SN54LS/74LS374 is a high-speed, low-power Octal D-type Flip-Flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus oriented applications. A buffered Clock (CP) and Output Enable (OE) is common to all flip-flops. The SN54LS/74LS374 is manufactured using advanced Low Power Schottky technology and is compatible with all Motorola TTL families.

- **EIGHT LATCHES IN A SINGLE PACKAGE**
- **3-STATE OUTPUTS FOR BUS INTERFACING**
- **HYSTERESIS ON LATCH ENABLE**
- **EDGE-TRIGGERED D-TYPE INPUTS**
- **BUFFERED POSITIVE EDGE-TRIGGERED CLOCK**
- **HYSTERESIS ON CLOCK INPUT TO IMPROVE NOISE MARGIN**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

4

PIN NAMES

		LOADING (Note a)	
		HIGH	LOW
D_0-D_7	Data Inputs	0.5 U.L.	0.25 U.L.
LE	Latch Enable (Active HIGH) Input	0.5 U.L.	0.25 U.L.
$\overline{CP}$	Clock (Active HIGH going edge) Input	0.5 U.L.	0.25 U.L.
$\overline{OE}$	Output Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
O_0—O_7	Outputs (Note b)	65(25)U.L.	15(7.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 7.5 U.L. for Military and 25 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L. for Military (54) and 65 U.L. for Commercial (74) Temperature Ranges.

TRUTH TABLE

LS373

Dn	LE	$\overline{OE}$	On
H	H	L	H
L	H	L	L
X	X	H	Z*

LS374

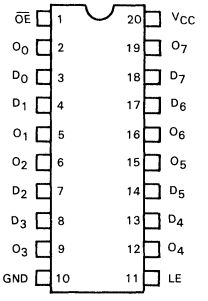
Dn	CP	$\overline{OE}$	On
H	⎍	L	H
L	⎍	L	L
X	X	H	Z*

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedence

*Note. Contents of flip-flops unaffected by the state of the Output Enable input ($\overline{OE}$)

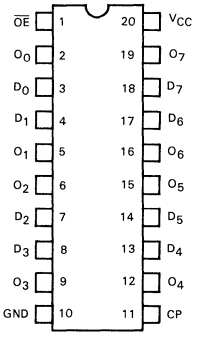
CONNECTION DIAGRAM
DIP (TOP VIEW)

SN54LS/74LS373



CONNECTION DIAGRAM
DIP (TOP VIEW)

SN54LS/74LS374

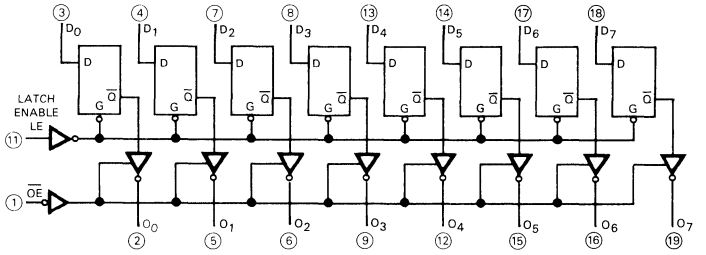


J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

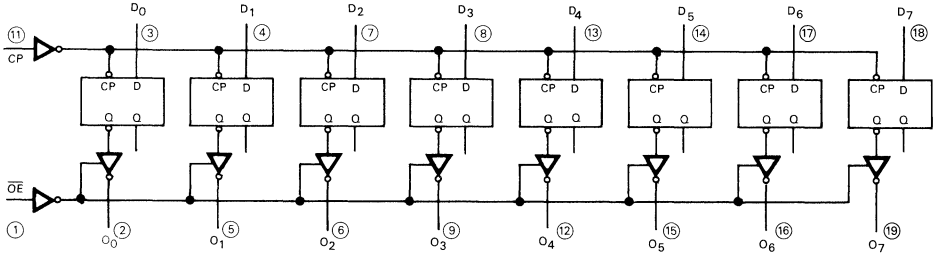
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAMS

SN54LS/74LS373



SN54LS/74LS374



V_{CC} = Pin 20
GND = Pin 10
◯ = Pin Numbers

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.4	3.1		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V	
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				40	mA	V_{CC} = MAX	

4

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LS373 MIN	LS373 TYP	LS373 MAX	LS374 MIN	LS374 TYP	LS374 MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency				35	50		MHz	C_L = 45 pF, R_L = 667 Ω
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		12 12	18 18				ns	
t_{PLH} t_{PHL}	Clock or Enable to Output		20 18	30 30		15 19	28 28	ns	
t_{PZH} t_{PZL}	Output Enable Time		15 25	28 36		20 21	28 28	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		12 15	20 25		12 15	20 25	ns	C_L = 5.0 pF

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LS373 MIN	LS373 MAX	LS374 MIN	LS374 MAX	UNITS
t_W	Clock Pulse Width	15		15		ns
t_s	Setup Time	5.0		20		ns
t_h	Hold Time	20		0		ns

DEFINITION OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to LE transition from HIGH-to-LOW in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the LE transition from HIGH-to-LOW that the logic level must be maintained at the input in order to ensure continued recognition.

AC WAVEFORMS

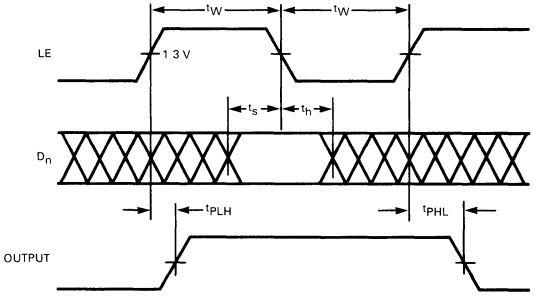


Fig. 1

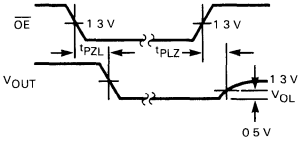


Fig. 2

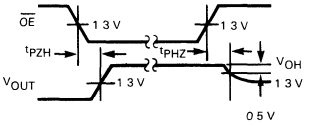
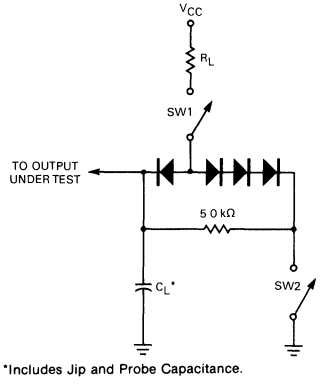


Fig. 3

AC LOAD CIRCUIT



*Includes Jip and Probe Capacitance.

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 4

4

AC WAVEFORMS

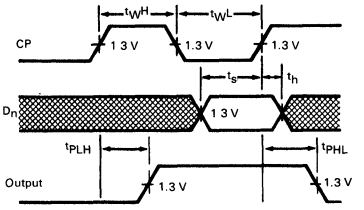


Fig. 5

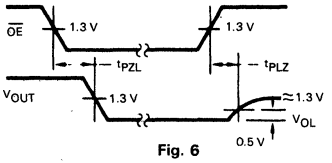


Fig. 6

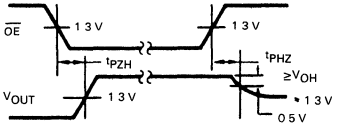
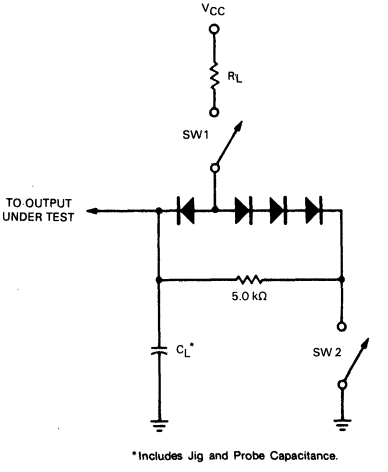


Fig. 7

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

AC LOAD CIRCUIT



*Includes Jig and Probe Capacitance.

Fig. 8

MOTOROLA

SN54LS375
SN74LS375

4-BIT D LATCH

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS375 is a 4-Bit D-Type Latch for use as temporary storage for binary information between processing limits and input/output or indicator units. When the Enable (E) is HIGH, information present at the D input will be transferred to the Q output and, if E is HIGH, the Q output will follow the input. When E goes LOW, the information present at the D input prior to its setup time will be retained at the Q outputs.

TRUTH TABLE
(Each latch)

t_n	t_{n+1}
D	Q
H	H
L	L

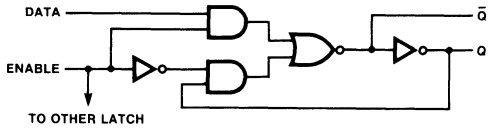
NOTES:
t_n = bit time before enable negative-going transition
t_{n+1} = bit time after enable negative-going transition

PIN NAMES

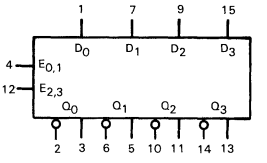
		LOADING (Note a) HIGH	LOW
D_1—D_4	Data Inputs	0.5 U.L.	0.25 U.L.
$E_{0—1}$	Enable Input Latches 0, 1	2.0 U.L.	1.0 U.L.
$E_{2—3}$	Enable Input Latches 2, 3	2.0 U.L.	1.0 U.L.
Q_1—Q_4	Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q_1}$—$\overline{Q_4}$	Complimentary Latch Outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a 1 Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM

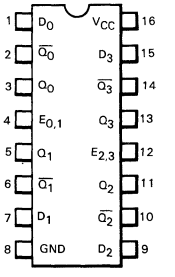


LOGIC SYMBOL



V_{CC} = 16
GND = Pin 8

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

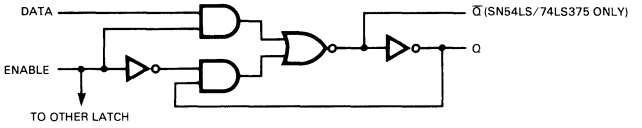
SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	D Input E Input			20 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		D Input E Input			0.1 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	D Input E Input			−0.4 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				12	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Data to Q		15 9.0	27 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Data to $\overline{Q}$		12 7.0	20 15	ns	
t_{PLH} t_{PHL}	Propagation Delay, Enable to Q		15 14	27 25	ns	
t_{PLH} t_{PHL}	Propagation Delay, Enable to $\overline{Q}$		16 7.0	30 15	ns	

LOGIC DIAGRAM



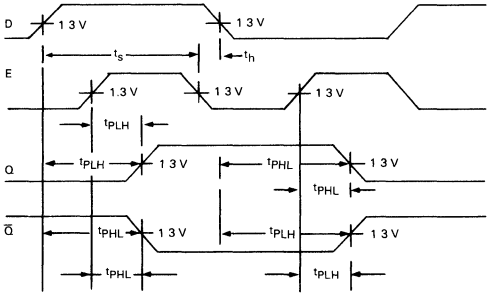
GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Enable Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

AC WAVEFORMS



DEFINITION OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

MOTOROLA

SN54LS/74LS377
SN54LS/74LS378
SN54LS/74LS379

OCTAL D FLIP-FLOP WITH ENABLE;
HEX D FLIP-FLOP WITH ENABLE;
4-BIT D FLIP-FLOP WITH ENABLE

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS377 is an 8-bit register built using advanced Low Power Schottky technology. This register consists of eight D-type flip-flops with a buffered common clock and a buffered common clock enable.

The SN54LS/74LS378 is a 6-Bit Register with a buffered common enable. This device is similar to the SN54LS/74LS174, but with common Enable rather than common Master Reset.

The SN54LS/74LS379 is a 4-Bit Register with buffered common Enable. This device is similar to the SN54LS/74LS175 but features the common Enable rather than common Master Reset.

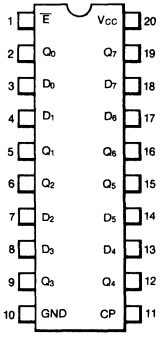
- **8-BIT HIGH SPEED PARALLEL REGISTERS**
- **POSITIVE EDGE-TRIGGERED D-TYPE FLIP FLOPS**
- **FULLY BUFFERED COMMON CLOCK AND ENABLE INPUTS**
- **TRUE AND COMPLEMENT OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS**

4

PIN NAMES		LOADING (Note a)	
		HIGH	LOW
$\overline{E}$	Enable (Active LOW) Input	0.5 U.L.	0.25 U.L.
D_0—D_3	Data Inputs	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
Q_0—Q_3	True Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q}_0$—$\overline{Q}_3$	Complemented Outputs (Note b)	10 U.L	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

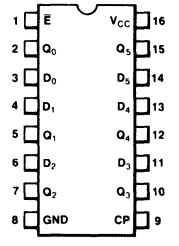
CONNECTION DIAGRAM
DIP (TOP VIEW)
SN54LS/74LS377



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

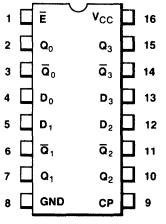
CONNECTION DIAGRAM
DIP (TOP VIEW)
SN54LS/74LS378



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

CONNECTION DIAGRAM
DIP (TOP VIEW)
SN54LS/74LS379

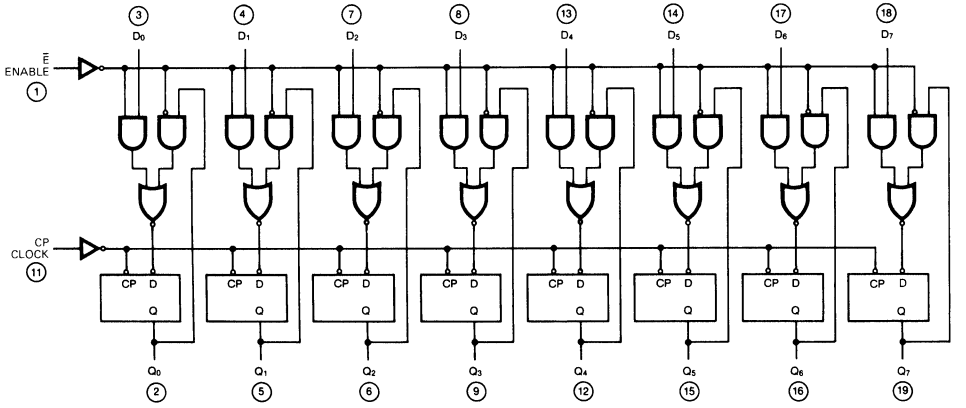


J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

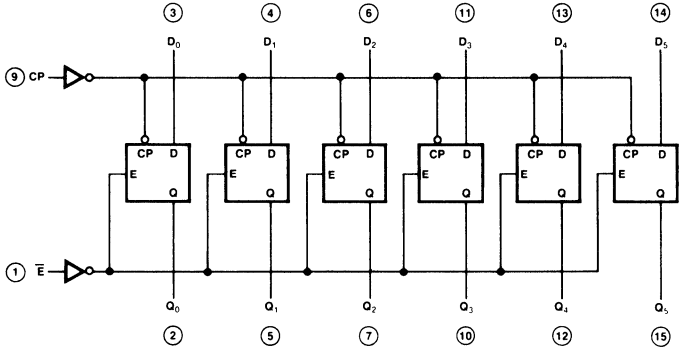
NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

LOGIC DIAGRAMS

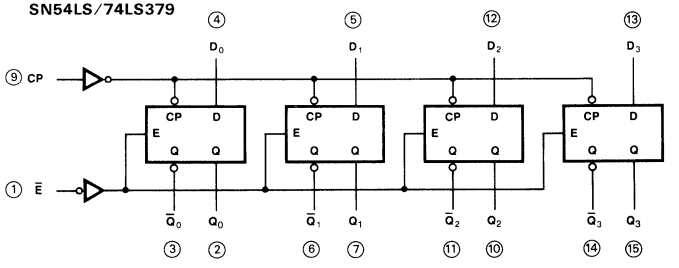
SN54LS/74LS377



SN54LS/74LS378



SN54LS/74LS379



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA V_{CC} = V_{CC} MIN,
		74		0.35	0.5	V	I_{OL} = 8.0 mA V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current	LS377 LS378 LS379			28 22 15	mA	V_{CC} = MAX, NOTE 1

Note: With all inputs open and GND applied to all data and enable inputs, I_{CC} is measured after a momentary GND, then 4.5 V is applied to clock.

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	40		MHz	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output		17 18	27 27	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Any Pulse Width		20			ns	V_{CC} = 5.0 V
t_s	Data Setup Time		20			ns	
t_s	Enable Setup Time	Inactive — State	10			ns	
		Active — State	25			ns	
t_h	Any Hold Time		5.0			ns	

DEFINITION OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative HOLD TIME indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

TRUTH TABLE

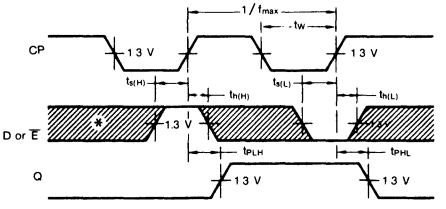
$\overline{E}$	CP	D_n	Q_n	$\overline{Q}_n$
H	⎍	X	No Change	No Change
L	⎍	H	H	L
L	⎍	L	L	H

L = LOW Voltage Level
H = HIGH Voltage Level
X = Immaterial

AC WAVEFORMS

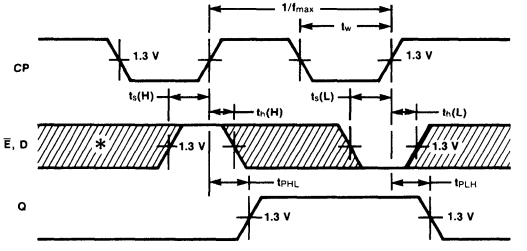
SN54LS/74LS377

**CLOCK TO OUTPUT DELAYS
CLOCK PULSE WIDTH, FREQUENCY,
SETUP AND HOLD TIMES DATA OR ENABLE TO CLOCK**



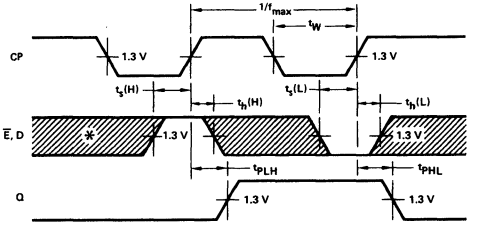
SN54LS/74LS378

**CLOCK TO OUTPUT DELAYS
CLOCK PULSE WIDTH, FREQUENCY,
SETUP AND HOLD TIMES DATA OR ENABLE TO CLOCK**



SN54LS/74LS379

**CLOCK TO OUTPUT DELAYS
CLOCK PULSE WIDTH, FREQUENCY,
SETUP AND HOLD TIMES DATA, ENABLE TO CLOCK**



*The shaded areas indicate when the input is permitted to change for predictable output performance

MOTOROLA

SN54LS385
SN74LS385

QUADRUPLE SERIAL ADDERS/SUBTRACTORS

LOW POWER SCHOTTKY

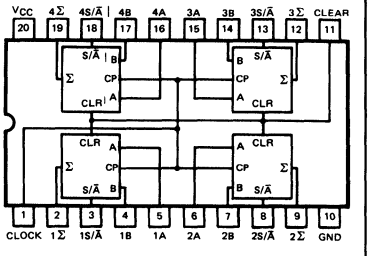
DESCRIPTION — The SN54LS/74LS385 is a general-purpose adder/subtractor which is useful as a companion part to the SN54LS/74LS384 two's-complement multiplier. The LS385 contains four independent adder/subtractor elements with common clock and clear.

Each of four independent sum (Σ) outputs reflects the respective A and B input and is controlled by the $S/\overline{A}$ pin.

When low, the clear input asynchronously resets the sum flip-flop low and the carry flip-flop either high in the subtract mode or low in the add mode. The clock is positive-edge triggered and controls the sum and carry flip-flops.

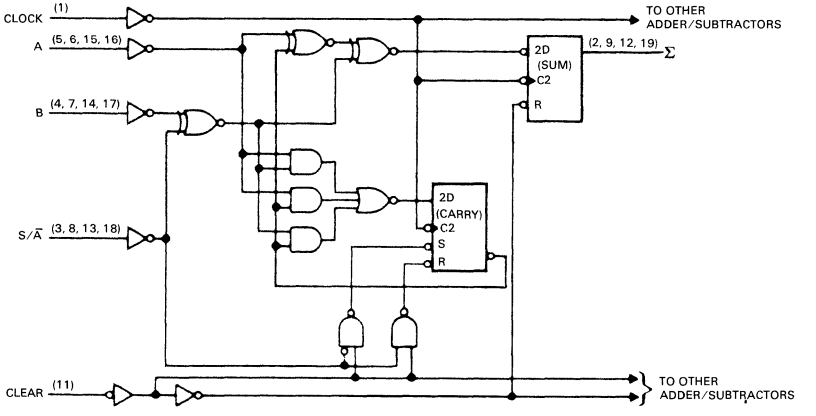
- **FOUR SYNCHRONOUS ELEMENTS IN A SINGLE 20-PIN PACKAGE**
- **INDEPENDENT TWO'S-COMPLEMENT ADDITION/SUBTRACTION**
- **BUFFERED CLOCK AND DIRECT CLEAR INPUTS**

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

BLOCK DIAGRAM



FUNCTION TABLE

SELECTED	INPUTS					INTERNAL CARRY D INPUT		OUTPUT
FUNCTION	CLEAR	S/$\overline{A}$	A	B	CLOCK	BEFORE ↑	AFTER ↑	AFTER ↑
Clear	L	L	X	X	X	L	L	L
	L	H	X	X	X	H	H	L
Add	H	L	L	L	↑	L	L	L
	H	L	L	L	↑	H	L	H
	H	L	L	H	↑	L	L	H
	H	L	L	H	↑	H	H	L
	H	L	H	L	↑	L	L	H
	H	L	H	L	↑	H	H	L
	H	L	H	H	↑	L	H	L
	H	L	H	H	↑	H	H	H
Subtract	H	H	L	L	↑	L	L	H
	H	H	L	L	↑	H	H	L
	H	H	L	H	↑	L	L	L
	H	H	L	H	↑	H	L	H
	H	H	H	L	↑	L	H	L
	H	H	H	L	↑	H	H	H
	H	H	H	H	↑	L	L	H
	H	H	H	H	↑	H	H	L

H = high level, L = low level, X = irrelevant,
↑ = transition from low to high level at the clock input

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				75	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

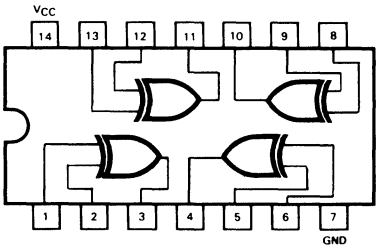
SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency	30	40		MHz	V_{CC} = 5.0 V, C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Clock to Σ		14 18	22 27	ns	
t_{PHL}	Propagation Delay Clear to Σ		18	30	ns	

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width	16			ns	V_{CC} = 5.0 V
t_s	Setup Time	10			ns	
t_h	Hold Time	0			ns	

MOTOROLA

SN54LS386
SN74LS386



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT EXCLUSIVE-OR GATE

LOW POWER SCHOTTKY

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.2	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.8	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				10	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, Other Input LOW		12 10	23 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PLH} t_{PHL}	Propagation Delay, Other Input HIGH		20 13	30 22	ns	

MOTOROLA

SN54LS/74LS390
SN54LS/74LS393

DUAL DECADE COUNTER; DUAL 4-STAGE BINARY COUNTER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS390 and SN54LS/74LS393 each contain a pair of high-speed 4-stage ripple counters. Each half of the LS390 is partitioned into a divide-by-two section and a divide-by-five section, with a separate clock input for each section. The two sections can be connected to count in the 8.4.2.1 BCD code or they can count in a biquinary sequence to provide a square wave (50% duty cycle) at the final output.

Each half of the LS393 operates as a Modulo-16 binary divider, with the last three stages triggered in a ripple fashion. In both the 'LS390 and the LS393, the flip-flops are triggered by a HIGH-to-LOW transition of their CP inputs. Each half of each circuit type has a Master Reset input which responds to a HIGH signal by forcing all four outputs to the LOW state.

- **DUAL VERSIONS OF LS290 AND LS293**
- **LS390 HAS SEPARATE CLOCKS ALLOWING ÷2, ÷2.5, ÷5**
- **INDIVIDUAL ASYNCHRONOUS CLEAR FOR EACH COUNTER**
- **TYPICAL MAX COUNT FREQUENCY OF 50 MHZ**
- **INPUT CLAMP DIODES MINIMIZE HIGH SPEED TERMINATION EFFECTS**

4

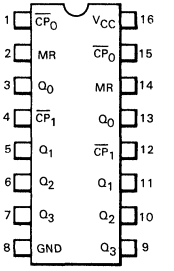
PIN NAMES

		LOADING (Note a) HIGH	LOW
$\overline{CP}$	Clock (Active LOW going edge) Input to +16 (LS393)	0.5 U.L.	1.0 U.L.
$\overline{CP}_0$	Clock (Active LOW going edge) Input to ÷2 (LS390)	0.5 U.L.	1.0 U.L.
$\overline{CP}_1$	Clock (Active LOW going edge) Input to ÷5 (LS390)	0.5 U.L.	1.5 U.L.
MR	Master Reset (Active HIGH) Input	0.5 U.L.	0.25 U.L.
Q_0—Q_3	Flip-Flop outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

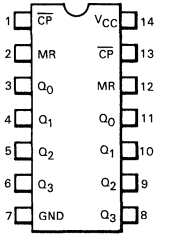
CONNECTION DIAGRAMS
DIP (TOP VIEW)

SN54LS/74LS390



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

SN54LS/74LS393



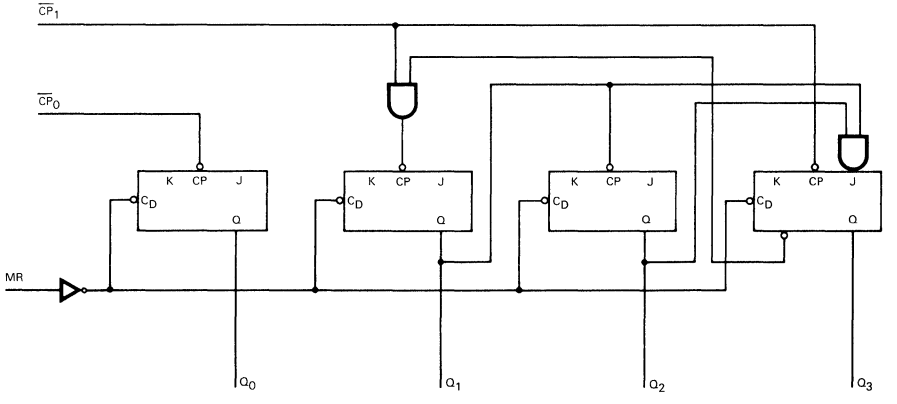
J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

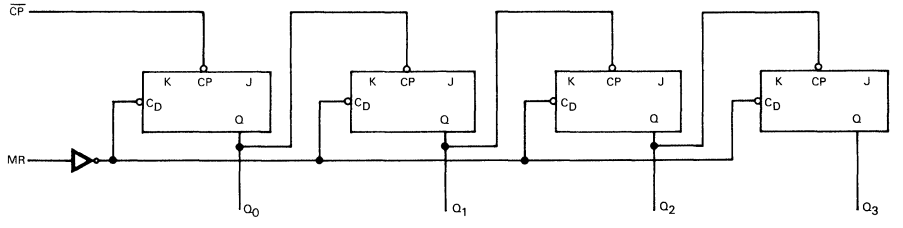
FUNCTIONAL DESCRIPTION—Each half of the SN54LS/74LS393 Operates in the Modulo 16 binary sequence, as indicated in the ÷16 Truth Table. The first flip-flop is triggered by HIGH-to-LOW transitions of the CP input signal. Each of the other flip-flops is triggered by a HIGH-to-LOW transition of the Q output of the preceding flip-flop. Thus state changes of the Q outputs do not occur simultaneously. This means that logic signals derived from combinations of these outputs will be subject to decoding spikes and, therefore, should not be used as clocks for other counters, registers or flip-flops. A HIGH signal on MR forces all outputs to the LOW state and prevents counting.

Each half of the 'LS390 contains a ÷5 section that is independent except for the common MR function. The ÷5 section operates in 4.2.1 binary sequence, as shown in the ÷5 Truth Table, with the third stage output exhibiting a 20% duty cycle when the input frequency is constant. To obtain a ÷10 function having a 50% duty cycle output, connect the input signal to $\overline{CP}_1$ and connect the Q_3 output to the $\overline{CP}_0$ input; the Q_0 output provides the desired 50% duty cycle output. If the input frequency is connected to $\overline{CP}_0$ and the Q_0 output is connected to $\overline{CP}_1$, a decade divider operating in the 8.4.2.1 BCD code is obtained, as shown in the BCD Truth Table. Since the flip-flops change state asynchronously, logic signals derived from combinations of 'LS390 outputs are also subject to decoding spikes. A HIGH signal on MR forces all outputs LOW and prevents counting.

SN54LS/74LS390 LOGIC DIAGRAM (one half shown)



SN54LS/74LS393 LOGIC DIAGRAM (one half shown)



SN54LS/74LS390 BCD TRUTH TABLE (Input on $\overline{CP}_0$; Q_0 $\overline{CP}_1$)

COUNT	OUTPUTS			
	Q_3	Q_2	Q_1	Q_0
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H

SN54LS/74LS390 ÷ 5 TRUTH TABLE (Input on $\overline{CP}_1$)

COUNT	OUTPUTS		
	Q_3	Q_2	Q_1
0	L	L	L
1	L	L	H
2	L	H	L
3	L	H	H
4	H	L	L

SN54LS/74LS393 TRUTH TABLE

COUNT	OUTPUTS			
	Q_3	Q_2	Q_1	Q_0
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H
10	H	L	H	L
11	H	L	H	H
12	H	H	L	L
13	H	H	L	H
14	H	H	H	L
15	H	H	H	H

H = HIGH Voltage Level
L = LOW Voltage Level

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	MR			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		$\overline{CP}$, $\overline{CP}_0$			−1.6	mA	
		$\overline{CP}_1$			−2.4	mA	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				26	mA	V_{CC} = MAX

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0\ V$

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
f_{MAX}	Maximum Clock Frequency $\overline{CP}_0$ to Q_0		25	35		MHz	$C_L = 15\ pF$
f_{MAX}	Maximum Clock Frequency $\overline{CP}_1$ to Q_1		12.5	20		MHz	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}$ to Q_0	LS393		12 13	20 20	ns	
t_{PLH} t_{PHL}	$\overline{CP}_0$ to Q_0	LS390		12 13	20 20	ns	
t_{PLH} t_{PHL}	$\overline{CP}$ to Q_3	LS393		40 40	60 60	ns	
t_{PLH} t_{PHL}	$\overline{CP}_0$ to Q_2	LS390		37 39	60 60	ns	
t_{PLH} t_{PHL}	$\overline{CP}_1$ to Q_1	LS390		13 14	21 21	ns	
t_{PLH} t_{PHL}	$\overline{CP}_1$ to Q_2	LS390		24 26	39 39	ns	
t_{PLH} t_{PHL}	$\overline{CP}_1$ to Q_3	LS390		13 14	21 21	ns	
t_{PHL}	MR to Any Input	LS390/393		24	39	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0\ V$

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Clock Pulse Width	LS393	20			ns	$V_{CC} = 5.0\ V$
t_W	$\overline{CP}_0$ Pulse Width	LS390	20			ns	
t_W	$\overline{CP}_1$ Pulse Width	LS390	40			ns	
t_W	MR Pulse Width	LS390/393	20			ns	
t_{rec}	Recovery Time	LS390/393	25			ns	

4

AC WAVEFORMS

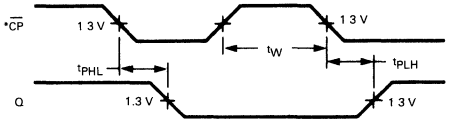


Fig. 1

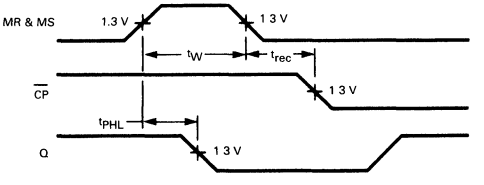


Fig. 2

*The number of Clock Pulses required between the t_{PHL} and t_{PLH} measurements can be determined from the appropriate Truth Table

MOTOROLA

SN54LS395
SN74LS395

4-BIT SHIFT REGISTER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS395 is a 4-Bit Register with 3-state outputs and can operate in either a synchronous parallel load or a serial shift-right mode, as determined by the Select input. An asynchronous active LOW Master Reset (MR) input overrides the synchronous operations and clears the register. An active HIGH Output Enable (OE) input controls the 3-state output buffers, but does not interfere with the other operations. The fourth stage also has a conventional output for linking purposes in multi-stage serial operations.

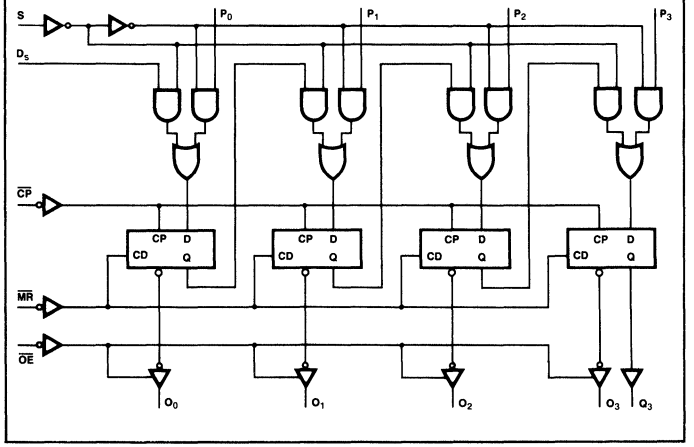
- **SHIFT LEFT OR PARALLEL 4-BIT REGISTER**
- **3-STATE OUTPUTS**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

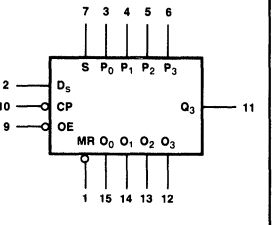
		LOADING (Note a) HIGH	LOW
P_0-P_3	Parallel Inputs	0.5 U.L.	0.25 U.L.
D_S	Serial Data Input	0.5 U.L.	0.25 U.L.
$\overline{S}$	Mode Select Input	0.5 U.L.	0.25 U.L.
$\overline{CP}$	Clock (Active LOW) Input	0.5 U.L.	0.25 U.L.
$\overline{MR}$	Master Reset (Active LOW) Input	0.5 U.L.	0.25 U.L.
$\overline{OE}$	Output Enable (Active HIGH) Input	0.5 U.L.	0.25 U.L.
O_0—O_3	3-State Register Outputs	65(25) U.L.	15(7.5) U.L.
Q_3	Register Output	10 U.L.	5 (2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

LOGIC DIAGRAM

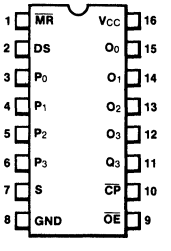


LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS395 contains four D-type edge-triggered flip-flops and auxiliary gating to select a D input either from a Parallel (Pn) input or from the preceding stage. When the Select input is HIGH, the Pn inputs are enabled. A LOW signal on the S input enables the serial inputs for shift-right operations, as indicated in the Truth Table.

State changes are initiated by HIGH-to-LOW transitions on the Clock Pulse (CP) input. Signals on the P_n, D_S and S inputs can change when the Clock is in either state, provided that the recommended set-up and hold times are observed. When the S input is LOW, a CP HIGH-LOW transition transfers data in Q_0 to Q_1, Q_1 to Q_2, and Q_2 to Q_3. A left-shift is accomplished by connecting the outputs back to the P_n inputs, but offset one place to the left, i.e., O_3 to P_2, O_2 to P_1 and O_1 to P_0, with P_3 acting as the linking input from another package

When the $\overline{OE}$ input is HIGH, the output buffers are disabled and the Q_0—Q_3 outputs are in a high impedance condition. The shifting, parallel loading or resetting operations can still be accomplished, however.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_O = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_O = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					−0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				31	mA	V_{CC} = MAX, $\overline{OE}$ = GND, $\overline{CP}$ = GND
	Total, Output LOW				34	mA	V_{CC} = MAX, $\overline{OE}$ = 4.5 V, $\overline{CP}$ momentary 3.0 V then GND

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Input Clock Frequency	30	45		MHz	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PHL}	Propagation Delay, Clear to Output		22	35	ns	
t_{PLH} t_{PHL}	Propagation Delay, Low to High Propagation Delay, High to Low		15 25	30 30	ns	
t_{PZH} t_{PZL}	Output Enable Time		15 17	25 25	ns	
t_{PLZ} t_{PHZ}	Output Disable Time		12 11	20 17	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	16			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, Mode Select	40			ns	
t_s	Setup Time, All Others	20			ns	
t_h	Data Hold Time	10			ns	

4

MODE SELECT — TRUTH TABLE

Operating Mode	Inputs @ t_n					Outputs @ t_{n+1}			
	$\overline{MR}$	$\overline{CP}$	S	D_S	P_n	O_0	O_1	O_2	O_3
Asynchronous Reset	L	X	X	X	X	L	L	L	L
Shift, SET First Stage	H	↘	L	H	X	H	O_{0n}	O_{1n}	O_{2n}
Shift, RESET First Stage	H	↘	L	L	X	L	O_{0n}	O_{1n}	O_{2n}
Parallel Load	H	↘	H	X	P_n	P_0	P_1	P_2	P_3

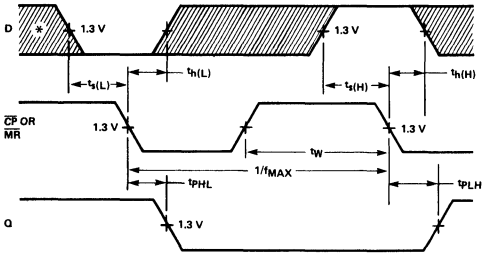
H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

$t_{n, n+1}$ = time before and after CP HIGH-to-LOW transition

NOTE
When $\overline{OE}$ is HIGH, outputs O_0—O_3 are in the high impedance state; however, this does not affect other operations or the Q_3 output.

AC WAVEFORMS

The shaded areas indicate when the input is permitted to change for predictable output performance.



*The Data Input is D_S for S = LOW and P_n for S = HIGH

Fig. 1

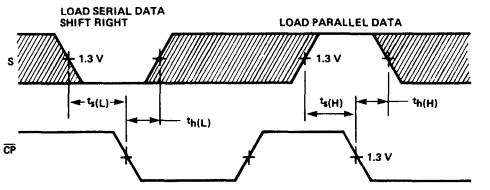


Fig. 2

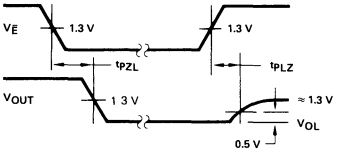


Fig. 3

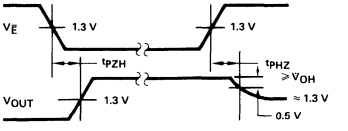
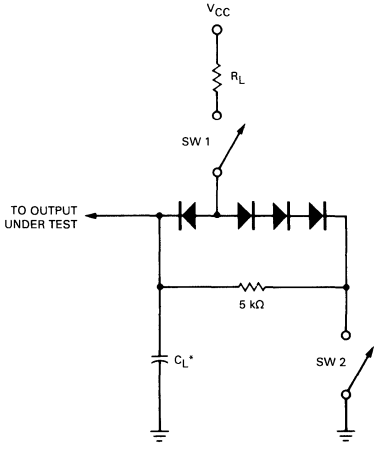


Fig. 4

AC LOAD CIRCUIT



*Includes Jig and Probe Capacitance.

SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 5

MOTOROLA

SN54LS/74LS398
SN54LS/74LS399

QUAD 2-PORT REGISTER

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS398 and SN54LS/74LS399 are Quad 2-Port Registers. They are the logical equivalent of a quad 2-input multiplexer followed by a quad 4-bit edge-triggered register. A Common Select input selects between two 4-bit input ports (data sources). The selected data is transferred to the output register on the LOW-to-HIGH transition of the Clock input. The SN54LS/74LS398 features both Q and $\overline{Q}$ inputs, while the SN54LS/74LS399 has only Q outputs.

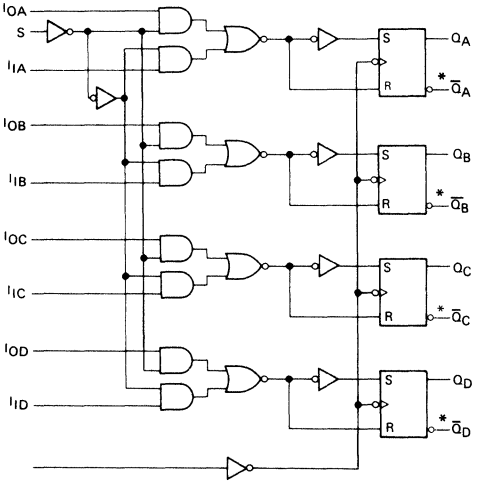
- **SELECT FROM TWO DATA SOURCES**
- **FULLY POSITIVE EDGE-TRIGGERED OPERATION**
- **BOTH TRUE AND COMPLEMENTED OUTPUTS ON SN54LS/74LS398**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

PIN NAMES

		LOADING (Note a) HIGH	LOW
S	Common Select Input	0.5 U.L.	0.25 U.L.
CP	Clock (Active HIGH Going Edge) Input	0.5 U.L.	0.25 U.L.
I_{0a}—I_{0d}	Data Inputs From Source 0	0.5 U.L.	0.25 U.L.
I_{1a}—I_{0d}	Data Inputs From Source 1	0.5 U.L.	0.25 U.L.
Q_a—Q_d	Register True Outputs (Note b)	10 U.L.	5(2.5) U.L.
$\overline{Q}_a$—$\overline{Q}_d$	Register Complementary Outputs (Note b)	10 U.L.	5(2.5) U.L.

NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

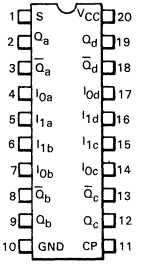
FUNCTIONAL BLOCK DIAGRAM



* SN54LS/74LS398 only

CONNECTION DIAGRAM
DIP (TOP VIEW)

SN54LS/74LS398

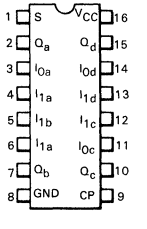


V_{CC} = Pin 20
GND = Pin 10

J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

CONNECTION DIAGRAM
DIP (TOP VIEW)

SN54LS/74LS399



V_{CC} = 16
GND = 8

J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

4

FUNCTIONAL DESCRIPTION — The SN54LS/74LS398 and SN54LS/74LS399 are high-speed Quad 2-Port Registers. They select four bits of data from two sources (Ports) under the control of a common Select Input (S). The selected data is transferred to a 4-Bit Output Register synchronous with the LOW-to-HIGH transition of the Clock input (CP). The 4-Bit RS type output register is fully edge-triggered. The Data inputs (I) and Select inputs (S) must be stable only a setup time prior to and hold time after the LOW-to-HIGH transition of the Clock input for predictable operation. The SN54LS/74LS398 has both Q and $\overline{Q}$ Outputs available.

FUNCTION TABLE

INPUTS			OUTPUTS	
S	I_0	I_1	Q	$\overline{Q}$*
l	l	X	L	H
l	h	X	H	L
h	X	l	L	H
h	X	h	H	L

***SN54LS/74LS398 only**

l = LOW Voltage Level one setup time prior to the LOW-to-HIGH clock transition
h = HIGH Voltage Level one setup time prior to the LOW-to-HIGH clock transition
L = LOW Voltage Level
H = HIGH Voltage Level
X = Immaterial

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				13	mA	V_{CC} = MAX

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, Clock to Output Q		18 21	27 32	ns	$V_{CC} = 5.0$ V $C_L = 15$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	25			ns	
t_s	Select Setup Time	45			ns	
t_h	Hold Time, Any Input	0			ns	

DEFINITIONS OF TERMS:

SETUP TIME (t_s) — is defined as the minimum time required for the correct logic level to be present at the logic input prior to the clock transition from LOW-to-HIGH in order to be recognized and transferred to the outputs.

HOLD TIME (t_h) — is defined as the minimum time following the clock transition from LOW-to-HIGH that the logic level must be maintained at the input in order to ensure continued recognition. A negative Hold Time indicates that the correct logic level may be released prior to the clock transition from LOW-to-HIGH and still be recognized.

4

AC WAVEFORMS

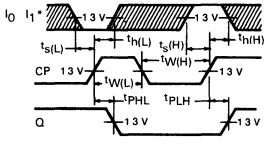


Fig. 1

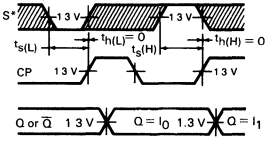


Fig. 2

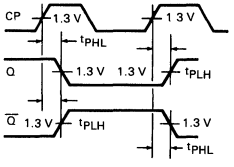


Fig. 3

*The shaded areas indicate when the input is permitted to change for predictable output performance.

MOTOROLA

SN54LS490
SN74LS490

DESCRIPTION — The SN54LS/74LS490 contains a pair of high-speed 4-stage ripple counters. Each half of the SN54LS/74LS490 has individual Clock, Master Reset and Master Set (Preset 9) inputs. Each section counts in the 8, 4, 2, 1 BCD code.

- **DUAL VERSION OF SN54LS/74LS90**
- **INDIVIDUAL ASYNCHRONOUS CLEAR AND PRESET TO 9 FOR EACH COUNTER**
- **COUNT FREQUENCY — TYPICALLY 65 MHz**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

DUAL DECADE COUNTER

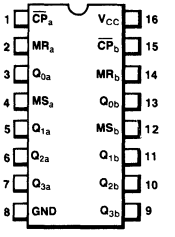
LOW POWER SCHOTTKY

PIN NAMES

		LOADING (Note a) HIGH	LOW
MS	Master Set (Set to 9) Input	0.5 U.L.	0.25 U.L.
MR	Master Reset	0.5 U.L.	0.25 U.L.
$\overline{CP}$	Clock Input (Active LOW Going Edge)	1.5 U.L.	1.5 U.L.
Q_0—Q_3	Counter Outputs (Note b)	10 U.L.	5(2.5) U.L.

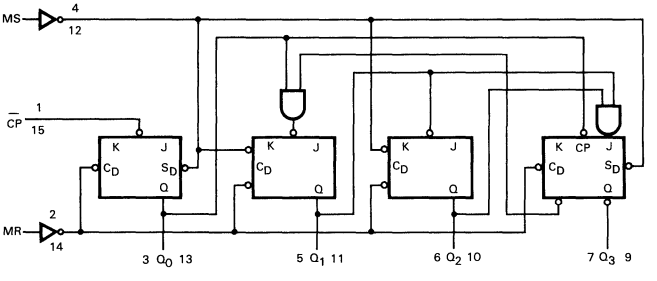
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5 U.L. for Commercial (74) Temperature Ranges.

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LOGIC DIAGRAM (ONE HALF SHOWN)



TRUTH TABLE

COUNT	OUTPUTS Q_3	Q_2	Q_1	Q_0
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	MS, MR			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Clock			−1.6	mA	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				26	mA	V_{CC} = MAX

AC SETUP REQUIREMENTS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_W	Any Pulse Width	20			ns	V_{CC} = 5.0 V
t_s	MR or MS to Setup Time	25			ns	

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS	
		MIN	TYP	MAX			
f_{MAX}	Maximum Clock Frequency	25	35		MHz	Fig. 1	$V_{CC} = 5.0$ V $C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}$ to Q_0		12 13	20 20	ns	Fig. 1	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}$ to Q_1 or Q_3		24 26	39 39	ns	Fig. 3	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{CP}$ to Q_2		32 36	54 54	ns	Fig. 2	
t_{PHL}	Propagation Delay, MR to Output		24	39	ns	Fig. 2	
t_{PLH} t_{PHL}	Propagation Delay, MS to Output		24 20	39 36	ns	Fig. 2	

AC WAVEFORMS

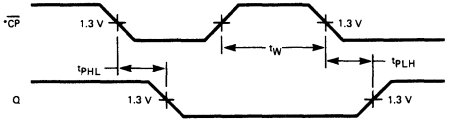


Fig. 1

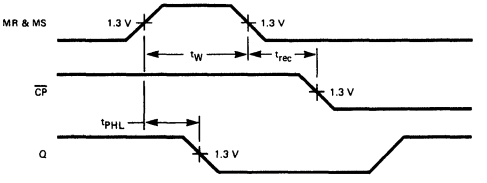


Fig. 2

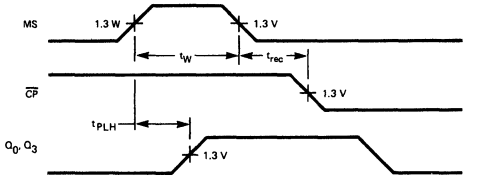


Fig. 3

*The number of Clock Pulses required between the t_{PHL} and t_{PLH} measurements can be determined from the Truth Table.

MOTOROLA

SN54LS/74LS540
SN54LS/74LS541

OCTAL BUFFER/LINE DRIVER WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS540 and SN54LS/74LS541 are octal buffers and line drivers with the same functions as the LS240 and LS241, but with pinouts on the opposite side of the package.

These device types are designed to be used as memory address drivers, clockdrivers and bus-oriented transmitters/receivers. These devices are especially useful as output ports for the microprocessors, allowing ease of layout and greater PC board density.

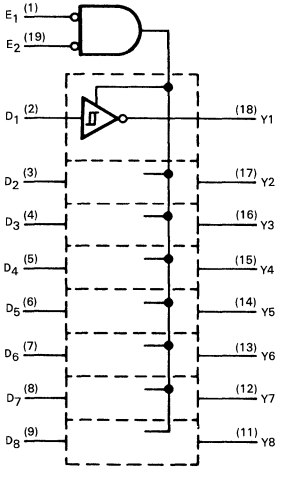
- **HYSTERESIS AT INPUTS TO IMPROVE NOISE MARGIN**
- **PNP INPUTS REDUCE LOADING**
- **3-STATE OUTPUTS DRIVE BUS LINES**
- **INPUTS AND OUTPUTS OPPOSITE SIDE OF PACKAGE, ALLOWING EASIER INTERFACE TO MICROPROCESSORS**
- **INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS**

INPUTS			OUTPUTS	
E_1	E_2	D	LS540	LS541
L	L	H	L	H
H	X	X	Z	Z
X	H	X	Z	Z
L	L	L	H	L

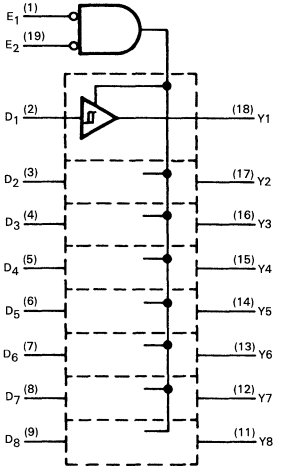
L = LOW Voltage Level
H = HIGH Voltage Level
X = Immaterial
Z = High Impedance

BLOCK DIAGRAM

LS540

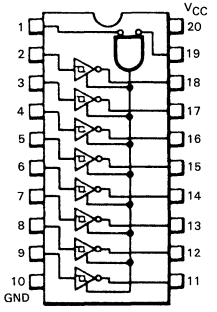


LS541

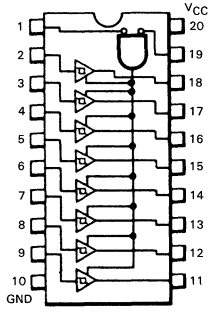


LOGIC DIAGRAMS AND CONNECTION DIAGRAMS
DIP (TOP VIEW)

SN54LS/74LS540



SN54LS/74LS541



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN, I_{OH} = −3.0 mA
		54,74	2.0			V	V_{CC} =MIN, I_{OH} =MAX, V_{IL} =0.5 V
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
V_{T+}, V_{T-}	Hysteresis		0.2	0.4		V	V_{CC} =MIN
I_{OZH}	Output Off Current High				20	μA	V_{CC} = MAX, V_{OUT} =2.4 V
I_{OZL}	Output Off Current Low				−20	μA	V_{CC} = MAX, V_{OUT} =0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} =MAX, V_{IN} =2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH	LS540			25	mA	V_{CC} =MAX
		LS541			32	mA	
	Total, Output LOW	LS540			45	mA	
		LS541			52	mA	
	Total Output 3-State	LS540			52	mA	
		LS541			55	mA	

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AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH}	Propagation Delay, Data to Output	LS540		9.0	15	ns	$V_{CC} = 5.0$ V, $C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PLH}		LS541		12	15		
t_{PHL}		LS540		12	15		
t_{PHL}		LS541		12	18		
t_{PZH}	Output Enable Time to HIGH Level	LS540		15	25	ns	
		LS541		15	32		
t_{PZL}	Output Enable Time to LOW Level	LS540		20	38	ns	
		LS541		20	38		
t_{PHZ}	Output Disable Time from HIGH Level	LS540		10	18	ns	$C_L = 5.0$ pF
		LS541		10	18		
t_{PLZ}	Output Disable Time from LOW Level	LS540		15	25	ns	
		LS541		15	29		

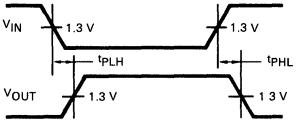


Fig. 1

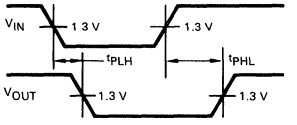


Fig. 2

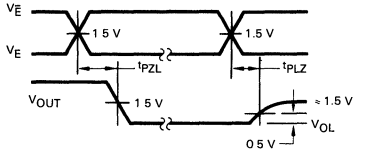


Fig. 3

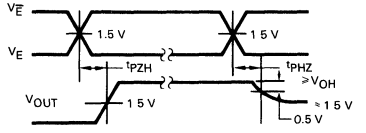
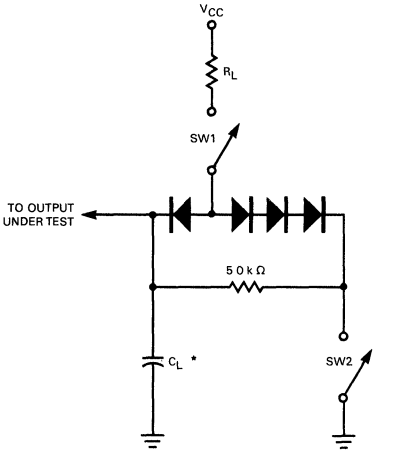


Fig. 4



SWITCH POSITIONS

SYMBOL	SW1	SW2
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PLZ}	Closed	Closed
t_{PHZ}	Closed	Closed

Fig. 5

MOTOROLA

SN54LS/74LS568
SN54LS/74LS569

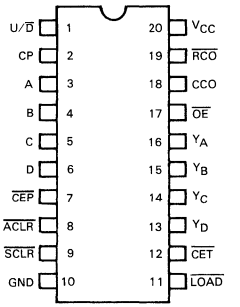
FOUR-BIT UP/DOWN COUNTERS WITH THREE-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION —The SN54LS/74LS568 and SN54LS/74LS569 are designed as programmable up/down BCD and Binary counters respectively. These devices have 3-state outputs for use in bus organized systems. With the exception of output enable ($\overline{OE}$) and asynchronous clear ($\overline{ACLR}$), all functions occur on the positive edge of the clock pulse (CP).

When the $\overline{LOAD}$ input is LOW, the outputs will be programmed by the parallel data inputs (A, B, C, D) on the next clock edge. Enabling of the counters occurs only when $\overline{CEP}$ and $\overline{CET}$ are LOW and LOAD is HIGH. Direction of the count is controlled by the up-down input ($U/\overline{D}$), HIGH counts up and LOW counts down. High-speed counting and cascading is implemented by internal look-ahead carry logic and an active LOW ripple carry output ($\overline{RCO}$). On the LS568, the $\overline{RCO}$ is LOW at binary 9 during up-count and during down-count it is LOW at binary 0. On the LS569, the $\overline{RCO}$ is LOW at binary 15 during up-count and during down-count it is also LOW at binary 0. During normal cascading operation $\overline{RCO}$ connected to the succeeding block at $\overline{CET}$ is the only requisite. When counting and when $\overline{RCO}$ is LOW, the clocked carry output (CCO) provides a HIGH-LOW-HIGH pulse for a duration equal to the LOW time of the clock pulse. Two active LOW reset lines are provided, a master reset asynchronous clear ($\overline{ACLR}$) and a synchronous clear ($\overline{SCLR}$). When in a HIGH state, the output control ($\overline{OE}$) input forces the counter output into a HIGH impedance state and when LOW, the counter outputs are enabled.

CONNECTION DIAGRAM
(TOP VIEW)



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)
V_{CC} = Pin 20
GND = Pin 10
Note: Pin 1 is marked for orientation.

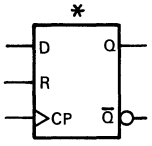
4

FUNCTION TABLE

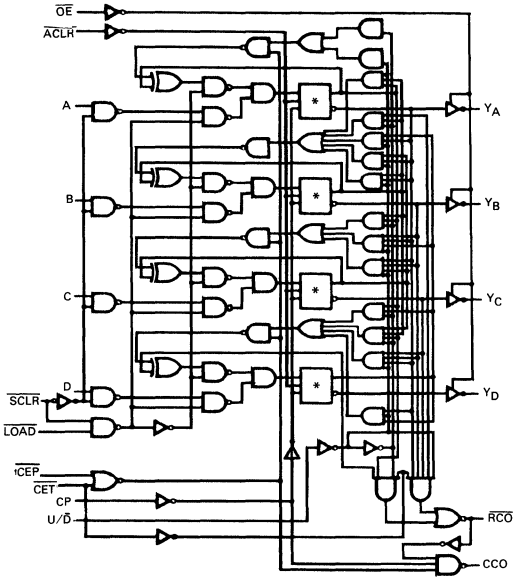
INPUTS											OUTPUTS						
CP	D	C	B	A	$\overline{LOAD}$	$\overline{CET}$	$\overline{CEP}$	$U/\overline{D}$	$\overline{ACLR}$	$\overline{SCLR}$	$\overline{OE}$	$\overline{RCO}$	CCO	Y_D	Y_C	Y_B	Y_A	
↑	X	X	X	X	H	L	L	H	H	H	L	A/R	A/R	(Q_T — CP) + 1				Count Up
↑	X	X	X	X	H	L	L	L	H	H	L	A/R	A/R	(Q_T — CP) − 1				Count Down
↑	X	X	X	X	H	H	X	X	H	H	L	H	H	NC	NC	NC	NC	Count Inhibit
↑	X	X	X	X	H	L	H	X	H	H	L	A/R	H	NC	NC	NC	NC	Count Inhibit
⊓	X	X	X	X	X	L	L	H	H	H	L	L	⊓	H	H	H	H	Overflow (LS569)
↑	X	X	X	X	X	L	H	H	H	H	L	L	H	H	H	H	H	Overflow (LS569)
⊓	X	X	X	X	X	L	L	H	H	H	L	L	⊓	H	L	L	H	Overflow (LS568)
↑	X	X	X	X	X	L	H	H	H	H	L	L	H	H	L	L	H	Overflow (LS568)
↑	X	X	X	X	X	H	X	H	H	H	L	H	H	H	H	H	H	Overflow Inhibit (LS569)
↑	X	X	X	X	X	H	X	H	H	H	L	H	H	H	L	L	H	Overflow Inhibit (LS568)
⊓	X	X	X	X	X	L	L	L	H	H	L	L	⊓	L	L	L	L	Underflow
↑	X	X	X	X	X	L	H	L	H	H	L	L	H	L	L	L	L	Underflow
↑	X	X	X	X	X	H	X	L	H	H	L	H	H	L	L	L	L	Underflow Inhibit
↑	L	H	L	H	L	X	X	X	H	H	L	H	H	L	H	L	H	Load Example
↑	X	X	X	X	X	H	X	H	H	L	L	H	H	L	L	L	L	Clear (Synchronous)
⊓	X	X	X	X	X	L	L	L	H	L	L	L	⊓	L	L	L	L	Clear (Synchronous)
↑	X	X	X	X	X	L	H	L	H	L	L	L	H	L	L	L	L	Clear (Synchronous)
↑	X	X	X	X	X	H	X	L	H	L	L	H	H	L	L	L	L	Clear (Synchronous)
X	X	X	X	X	X	X	X	H	L	X	L	H	H	L	L	L	L	Asynchronous Clear
⊓	X	X	X	X	X	L	L	L	L	X	L	L	⊓	L	L	L	L	Asynchronous Clear
X	X	X	X	X	X	L	H	L	L	X	L	L	H	L	L	L	L	Asynchronous Clear
X	X	X	X	X	X	H	X	L	L	X	L	H	H	L	L	L	L	Asynchronous Clear
X	X	X	X	X	X	X	X	X	X	X	H	X	X	Hi-Z				Output Disabled

(Q_T — CP) = Output state prior to clock edge
NC = No change
A/R = Assumes required output state; High except during Overflow and Underflow
X = Don't care

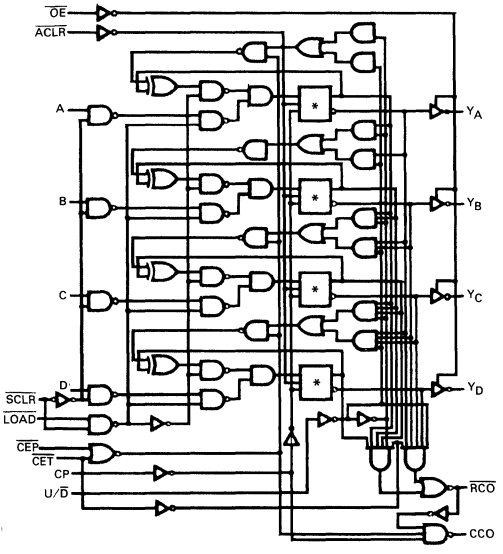
LOGIC DIAGRAMS



SN54LS/74LS568



SN54LS/74LS569



DEFINITION OF FUNCTIONAL TERMS

A, B, C, D The four programmable data inputs.

$\overline{CEP}$ Count Enable Parallel. Can be used to enable and inhibit counting in high speed cascaded operation. $\overline{CEP}$ must be LOW to count.

$\overline{CET}$ Count Enable Trickle. Enables the ripple carry output for cascaded operation. Must be LOW to count.

CP Clock Pulse. All synchronous functions occur on the LOW-to-HIGH transition of the clock.

$\overline{LOAD}$ Enables parallel load of counter outputs from data inputs on the next clock edge. Must be HIGH to count.

U/$\overline{D}$ Up/Down Count Control. HIGH counts up and LOW counts down.

$\overline{ACLR}$ Asynchronous Clear. Master reset of counters to zero when $\overline{ACLR}$ is LOW, independent of the clock.

$\overline{SCLR}$ Synchronous clear of counters to zero on the next clock edge when $\overline{SCLR}$ is LOW.

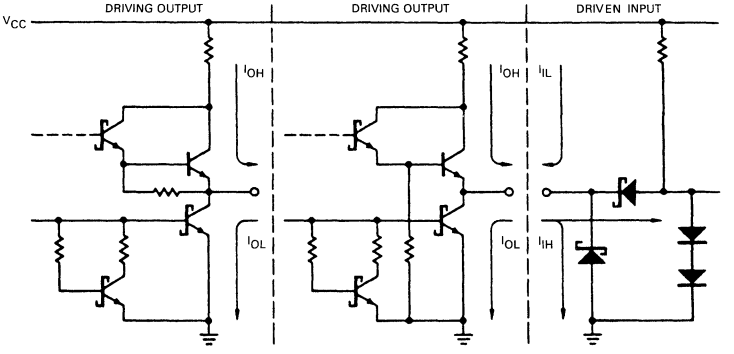
$\overline{OE}$ A HIGH on the output control sets the four counter outputs in the high impedance, and a LOW, enables the output.

Y_A, Y_B, Y_C, Y_D The four counter outputs.

$\overline{RCO}$ Ripple Carry Output. Output will be LOW on the maximum count on up-count. Upon down-count, $\overline{RCO}$ is LOW at 0000.

CCO Clock Carry Output. While counting and $\overline{RCO}$ is LOW, CCO will follow the clock HIGH-LOW-HIGH transition.

LOW-POWER SCHOTTKY INPUT/OUTPUT CURRENT INTERFACE CONDITIONS



Note: Actual current flow direction shown

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High Except $\overline{RCO}$, CCO	54 74			−1.0 −2.6	mA
I_{OH}	Output Current — High $\overline{RCO}$, CCO	54,74			−0.44	mA
I_{OL}	Output Current — Low Except $\overline{RCO}$, CCO	54 74			12 24	mA
I_{OL}	Output Current — Low, RCO, CCO	54 74			4 8	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage $\overline{RCO}$, CCO	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
		54	2.5	3.5		V	
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = I_{OL} MAX; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	
I_{OZH}	Output Off Current—High				20	μA	V_{CC} = MAX, V_O = 2.4 V
I_{OZL}	Output Off Current—Low				−20	μA	V_{CC} = MAX, V_O = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	Others			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		$\overline{CET}$			−0.8	mA	
I_{OS}	Short Circuit Current	$\overline{RCO}$,CCO	−20		−100	mA	V_{CC} = MAX
		Others	−30		−130	mA	
I_{CC}	Power Supply Current, 3-State				43	mA	V_{CC} = MAX

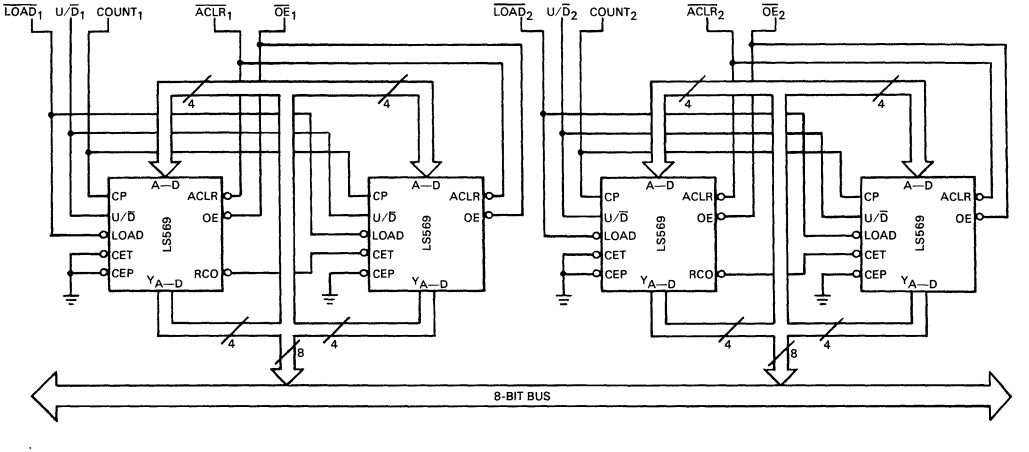
AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Toggle Frequency	25			MHz	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay Clock to Q		15 23	24 35	ns	
t_{PLH} t_{PHL}	Propagation Delay $\overline{CET}$ to $\overline{RCO}$		14 14	24 24	ns	
t_{PLH} t_{PHL}	Propagation Delay U/D to $\overline{RCO}$		20 15	30 24	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to $\overline{RCO}$		25 26	40 40	ns	
t_{PLH} t_{PHL}	Propagation Delay $\overline{CET}$ or $\overline{CEP}$ to CCO		12 20	20 30	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to CCO		17 26	27 40	ns	
t_{PLH} t_{PHL}	Propagation Delay $\overline{ACLR}$ to Q		21 21	32 32	ns	
t_{PZH} t_{PZL}	Output Enable Time		10 17	16 24	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		20 17	25 27	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	30			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, A, B, C, D	20			ns	
t_s	Setup Time, $\overline{SCLR}$	20			ns	
t_s	Setup Time, $\overline{LOAD}$	30			ns	
t_s	Setup Time, U/$\overline{D}$	50			ns	
t_s	Setup Time, $\overline{CET}$, $\overline{CEP}$	32			ns	
t_h	Hold Time, Any Inputs	0			ns	

MICROPROGRAMMABLE DUAL-EVENT 8-BIT COUNTERS



MOTOROLA

SN54LS/74LS604
SN54LS/74LS605
SN54LS/74LS606
SN54LS/74LS607

OCTAL 2-INPUT MULTIPLEXED LATCHES

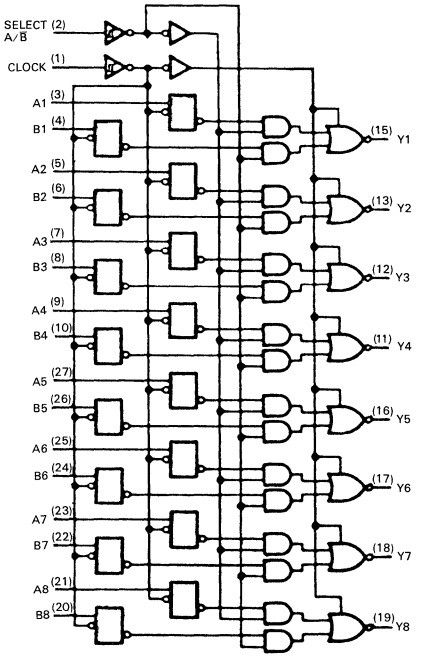
LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS604 thru SN54LS/74LS607 are multiplexed latches designed for storing data from two input buses, A and B, and providing the stored data from either the A or B register to the output bus.

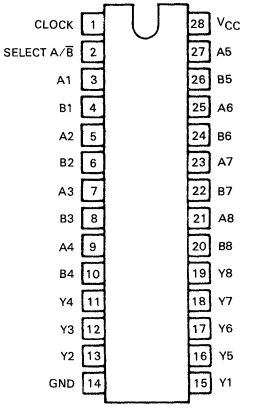
Data is loaded by the clock on the positive going transition (low-level to high-level). Control of the active and high impedance states of the outputs is also on the clock pin. The outputs are in the HIGH impedance or OFF state when the clock pin is LOW and the outputs are enabled when the clock pin is HIGH.

The SN54LS/74LS604 and 605 are designed for high speed operation and the SN54LS/74LS606 and 607 are designed to eliminate decoding voltage spikes. The SN54LS/74LS 604 and 606 have 3-state outputs while the SN54LS/74LS605 and 607 are open collector.

BLOCK DIAGRAM



CONNECTION DIAGRAM
(TOP VIEW)



J Suffix — Case 733-02 (Ceramic)
N Suffix — Case 710-02 (Plastic)

FUNCTION TABLE

INPUTS				OUTPUTS
A1-A8	B1-B8	SELECT A/B	CLOCK	Y1-Y8
A data	B data	L	↑	B data
A data	B data	H	↑	A data
X	X	X	L	Z or Off
X	X	L	H	B register stored data
X	X	H	H	A register stored data

H = high level (steady state)
X = irrelevant
Off = H if pull-up resistor is connected to open-collector output
↑ = transition from low to high level
L = low level (steady state)
Z = high-impedance state

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table	
		74	2.4	3.1		V		
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_O = 2.4 V	
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_O = 0.4 V	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					−0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current	A,B			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
		CK, Select			−0.2	mA		
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX	
I_{CC}	Power Supply Current				70	mA	V_{CC} = MAX	

4

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LS604 LIMITS			LS606 LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH} t_{PHL}	Select A/$\overline{B}$, Data: A = H, B = L		15 23	25 35		36 16	50 30	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Select A/$\overline{B}$, Data: A = L, B = H		31 19	45 30		22 22	35 35	ns	
t_{PZH} t_{PZL}	Clock to Output		19 27	30 40		27 35	40 50	ns	
t_{PLZ} t_{PHZ}	Clock to Output		20 15	30 25		20 15	30 25	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54,74			5.5	V
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.8			
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			250	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current	A,B			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
		CK, Select			−0.2	mA		
I_{CC}	Power Supply Current				60	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LS605 LIMITS MIN	LS605 LIMITS TYP	LS605 LIMITS MAX	LS607 LIMITS MIN	LS607 LIMITS TYP	LS607 LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Select A/$\overline{B}$, Data: A = H, B = L		28 28	40 40		51 21	70 30	ns	V_{CC} = 5.0 V C_L = 45 pF, R_L = 667 Ω
t_{PLH} t_{PHL}	Select A/$\overline{B}$, Data: A = L, B = H		39 25	60 40		28 28	40 40	ns	
t_{PLH} t_{PHL}	Clock to Output		27 25	40 40		30 32	45 45	ns	

AC SETUP REQUIREMENTS: T_A = 25°C

SYMBOL	PARAMETER	LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	CONDITIONS
t_W	Clock Pulse Width	20			ns	V_{CC} = 5.0 V
t_s	Setup Time	20			ns	
t_h	Hold Time	0			ns	

MOTOROLA

SN54LS/74LS620
SN54LS/74LS621
SN54LS/74LS622
SN54LS/74LS623

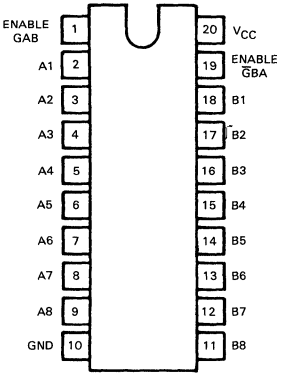
OCTAL BUS TRANSCEIVERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS620 thru SN54LS/74LS623 series are octal bus transceivers designed for asynchronous two-way communication between data buses. Control function implementation allows maximum timing flexibility. Enable inputs may be used to disable the device so that buses are effectively isolated. Depending on the Logic Levels at the enable inputs, Data transmission is allowed from the A bus to the B bus or from the B bus to the A bus. The dual-enable configuration gives the LS620 thru LS623 the capability to store data by simultaneous enabling of $\overline{G}BA$ and GAB. Each output reinforces its input in this transceiver configuration. Thus, when both control inputs are enabled all other data sources to the two sets of bus lines (16 in all) will remain at their last states. The 8-bit codes appearing on the two sets of buses will be identical for the LS621 and LS623 devices or complementary for the LS620 and LS622.

CONNECTION DIAGRAM

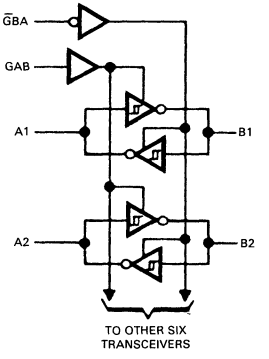
(TOP VIEW)



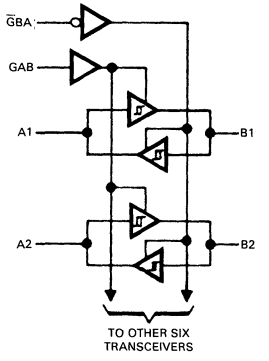
J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

BLOCK DIAGRAMS

$^1/_4$ LS620, $^1/_4$ LS622



$^1/_4$ LS621, $^1/_4$ LS623



FUNCTION TABLE

ENABLE INPUTS		OPERATION	
$\overline{G}BA$	GAB	LS620, LS622	LS621, LS623
L	L	$\overline{B}$ data to A bus	B data to A bus
H	H	$\overline{A}$ data to B bus	A data to B bus
H	L	Isolation	Isolation
L	H	$\overline{B}$ data to A bus, $\overline{A}$ data to B bus	B data to A bus, A data to B bus

H = high level, L = low level, X = irrelevant

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−3.0	mA
		54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.5	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.6		
$V_{T+}-V_{T-}$	Hysteresis		0.2	0.4		V	V_{CC} = MIN
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN, I_{OH} = −3.0 mA
		54,74	2.0			V	V_{CC} = MIN, I_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−400	μA	V_{CC} = MAX, V_{OUT} = 4.0 V
I_{IH}	Input HIGH Current	A or B, $\overline{G}$BA or GAB			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		$\overline{G}$BA or GAB			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		A or B			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total Output HIGH				70	mA	V_{CC} = MAX
	Total Output LOW				90		
	Total at HIGH Z				95		

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0\ V$

SYMBOL	PARAMETER	LS620 LIMITS			LS623 LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay A to B		6.0 8.0	10 15		8.0 11	15 15	ns	$C_L = 45\ pF$, $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay B to A		6.0 8.0	10 15		8.0 11	15 15	ns	
t_{PZL} t_{PZH}	Output Enable Time $\overline{G}$BA to A		31 23	40 40		31 26	40 40	ns	
t_{PZL} t_{PZH}	Output Enable Time GAB to B		31 23	40 40		31 26	40 40	ns	
t_{PLZ} t_{PHZ}	Output Disable Time $\overline{G}$BA to A		15 15	25 25		15 15	25 25	ns	$C_L = 5.0\ pF$
t_{PLZ} t_{PHZ}	Output Disable Time GAB to B		15 15	25 25		15 15	25 25	ns	

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 '5	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54,74			5.5	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs	
V_{IL}	Input LOW Voltage	54			0.5	V	Guaranteed Input LOW Voltage for All Inputs	
		74			0.6			
$V_{T+}-V_{T-}$	A or B Input		0.2	0.4		V	V_{CC} = MIN	
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA	
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA	V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA	
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					−0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V	
I_{CC}	Power Supply Current Total, Output HIGH				70	mA	V_{CC} = MAX	
	Total, Output LOW				90	mA	V_{CC} = MAX	

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LS621 LIMITS MIN	LS621 LIMITS TYP	LS621 LIMITS MAX	LS622 LIMITS MIN	LS622 LIMITS TYP	LS622 LIMITS MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay A to B		17 16	25 25		19 14	25 25	ns	C_L = 45 pF, R_L = 667 Ω
t_{PLH} t_{PHL}	Propagation Delay B to A		17 16	25 25		19 14	25 25	ns	
t_{PLH} t_{PHL}	Output Disable Time $\overline{G}$BA to A		23 34	40 50		26 43	40 60	ns	
t_{PLH} t_{PHL}	Output Disable Time $\overline{G}$AB to B		25 37	40 50		28 39	40 60	ns	

MOTOROLA

SN54LS/74LS640 thru SN54LS/74LS645

OCTAL BUS TRANSCEIVERS

LOW POWER SCHOTTKY

DESCRIPTION — These octal bus transceivers are designed for asynchronous two-way communication between data buses. Control function implementation minimizes external timing requirements. These circuits allow data transmission from the A bus to B or from the B bus to A bus depending upon the logic level of the direction control (DIR) input. Enable input ($\overline{G}$) can disable the device so that the buses are effectively isolated.

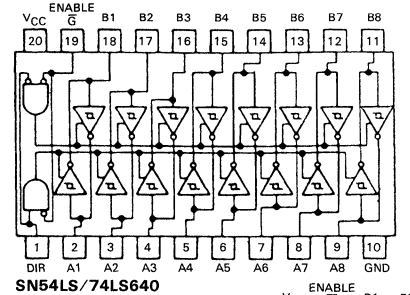
DEVICE	OUTPUT	LOGIC
LS640	3-State	Inverting
LS641	Open-Collector	True
LS642	Open-Collector	Inverting
LS643	3-State	True and Inverting
LS644	Open-Collector	True and Inverting
LS645	3-State	True

FUNCTION TABLE

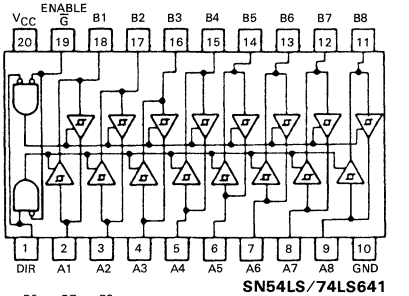
CONTROL INPUTS		OPERATION		
$\overline{G}$	DIR	LS640 LS642	LS641 LS645	LS643 LS644
L	L	$\overline{B}$ data to A bus	B data to A bus	B data to A bus
L	H	$\overline{A}$ data to B bus	A data to B bus	$\overline{A}$ data to B bus
H	X	Isolation	Isolation	Isolation

H = High level, L = low level, X = irrelevant

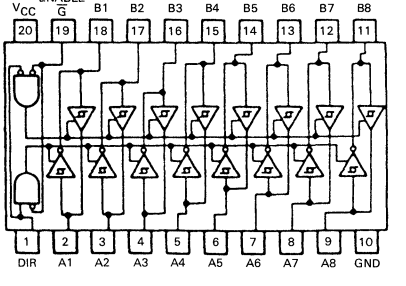
CONNECTION DIAGRAMS
(TOP VIEW)



SN54LS/74LS640
SN54LS/74LS642



SN54LS/74LS641
SN54LS/74LS645



SN54LS/74LS643
SN54LS/74LS644

J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−3.0	mA
		54 74			−12 −15	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.5	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.6		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54,74	2.4	3.4		V	V_{CC} = MIN, I_{OH} = −3.0 mA
		54,74	2.0			V	V_{CC} = MIN, I_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−400	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current	A or B, DIR or $\overline{G}$			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		DIR or $\overline{G}$			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		A or B			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Output Short Circuit Current		−40		−225	mA	V_{CC} = MAX
I_{CC}	Power Supply Current Total Output HIGH				70	mA	V_{CC} = MAX
	Total Output LOW				90		
	Total at HIGH Z				95		

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

SYMBOL	PARAMETER	LIMITS									UNITS	TEST CONDITIONS
		LS640			LS643			LS645				
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, A to B		6.0 8.0	10 15		6.0 9.0	10 15		8.0 11	15 15	ns	$C_L = 45$ pF, $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, B to A		6.0 8.0	10 15		8.0 11	15 15		8.0 11	15 15	ns	
t_{PZL} t_{PZH}	Output Enable Time $\overline{G}$, DIR to A		31 23	40 40		32 27	45 40		31 26	40 40	ns	
t_{PZL} t_{PZH}	Output Enable Time $\overline{G}$, DIR to B		31 23	40 40		32 23	45 40		31 26	40 40	ns	
t_{PLZ} t_{PHZ}	Output Disable Time $\overline{G}$, DIR to A		15 15	25 25		15 15	25 25		15 15	25 25	ns	$C_L = 5.0$ pF
t_{PLZ} t_{PHZ}	Output Disable Time $\overline{G}$, DIR to B		15 15	25 25		15 15	25 25		15 15	25 25	ns	

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54,74			5.5	V
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.5	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.6		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54,74			100	μA	V_{CC} = MIN, V_{OH} = MAX
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					−0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{CC}	Power Supply Current Total, Output HIGH				70	mA	V_{CC} = MAX
	Total, Output LOW				90	mA	V_{CC} = MAX
	Total at HIGH Z				95	mA	V_{CC} = MAX

AC CHARACTERISTICS: T_A = 25°C, V_{CC} = 5.0 V

SYMBOL	PARAMETER	LIMITS LS641 MIN	LS641 TYP	LS641 MAX	LS642 MIN	LS642 TYP	LS642 MAX	LS644 MIN	LS644 TYP	LS644 MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay, A to B		17 16	25 25		19 14	25 25		17 14	25 25	ns	C_L = 45 pF, R_L = 667 Ω
t_{PLH} t_{PHL}	Propagation Delay, B to A		17 16	25 25		19 14	25 25		19 16	25 25	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, DIR to A		23 34	40 50		26 43	40 60		26 43	40 60	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, DIR to B		25 37	40 50		28 39	40 60		25 37	40 50	ns	

4

MOTOROLA

SN54LS/74LS668
SN54LS/74LS669

SYNCHRONOUS 4-BIT UP/DOWN COUNTERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS668 and SN54LS/74LS669 are synchronous 4-bit up/down counters. The LS668 is a decade counter and the LS669 is a 4-bit binary counter. For high speed counting applications, these presettable counters feature an internal carry look-ahead for cascading purposes. By clocking all flip-flops simultaneously so the outputs change coincident with each other (when instructed to do so by the count enable inputs and internal gating) synchronous operation is provided. This helps to eliminate output counting spikes, normally associated with asynchronous (ripple-clock) counters. The four master-slave flip-flops are triggered on the rising (positive-going) edge of the clock waveform by a buffered clock input.

Circuitry of the load inputs allows loading with the carry-enable output of the cascaded counters. Because loading is synchronous, disabling of the counter by setting up a low level on the load input will cause the outputs to agree with the data inputs after the next clock pulse.

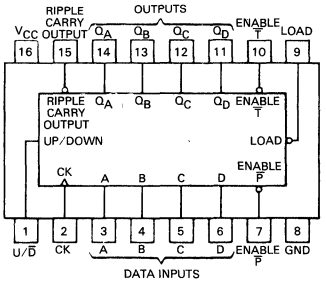
Cascading counters for N-bit synchronous applications are provided by the carry look-ahead circuitry, without additional gating. Two count-enable inputs and a carry output help accomplish this function. Count-enable inputs ($\overline{P}$ and $\overline{T}$) must both be low to count. The level of the up-down input determines the direction of the count. When the input level is low, the counter counts down, and when the input is high, the count is up. Input $\overline{T}$ is fed forward to enable the carry output. The carry output will now produce a low level output pulse with a duration ≈ equal to the high portion of the Q_A output when counting up and when counting down ≈ equal to the low portion of the Q_A output. This low level carry pulse may be utilized to enable successive cascaded stages. Regardless of the level of the clock input, transitions at the $\overline{P}$ or $\overline{T}$ inputs are allowed. By diode-clamping all inputs, transmission line effects are minimized which allows simplification of system design.

Any changes at control inputs (ENABLE $\overline{P}$, ENABLE $\overline{T}$, LOAD, UP/DOWN) will have no effect on the operating mode until clocking occurs because of the fully independant clock circuits. Whether enabled, disabled, loading or counting, the function of the counter is dictated entirely by the conditions meeting the stable setup and hold times.

PROGRAMMABLE LOOK-AHEAD UP/DOWN BINARY/DECADE COUNTERS

- **FULLY SYNCHRONOUS OPERATION FOR COUNTING AND PROGRAMMING**
- **INTERNAL LOOK-AHEAD FOR FAST COUNTING**
- **CARRY OUTPUT FOR n-BIT CASCADING**
- **FULLY INDEPENDENT CLOCK CIRCUIT**
- **BUFFERED OUTPUTS**

CONNECTION DIAGRAM
(TOP VIEW)

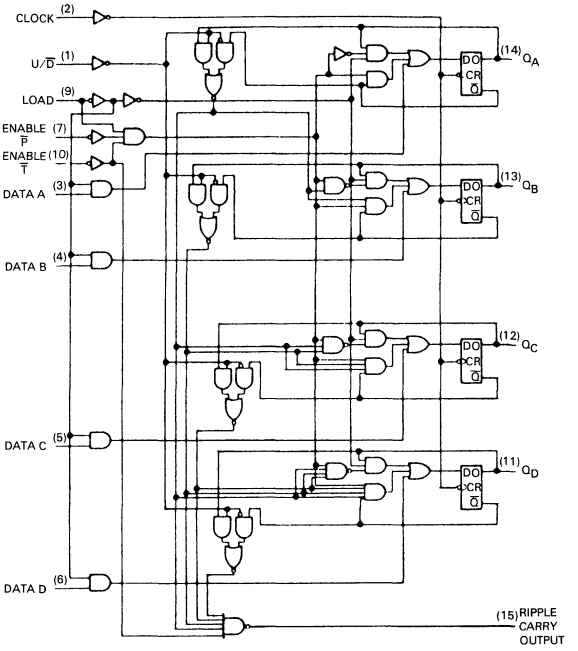


J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

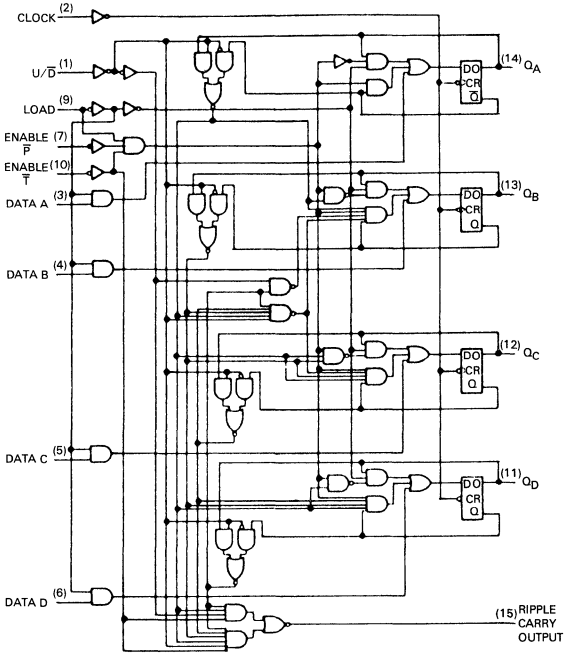
4

BLOCK DIAGRAMS

SN54LS/74LS669



SN54LS/74LS668



4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 4.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 8.0 mA
I_{IH}	Input HIGH Current	Others			20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		Load			40	μA	
		Others			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
		Load			0.2	mA	
I_{IL}	Input LOW Current	Others			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Load			−0.8	mA	
I_{OS}	Short Circuit Current		−20		−100	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				34	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: $T_A = 25°C$, $V_{CC} = 5.0$ V

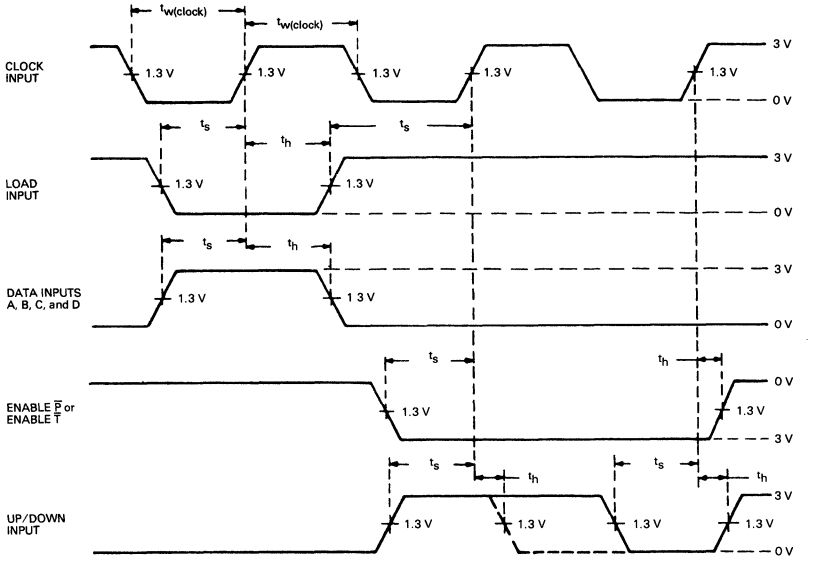
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	25	32		MHz	$C_L = 15$ pF
t_{PLH} t_{PHL}	Propagation Delay, Clock to $\overline{RCO}$		26 40	40 60	ns	
t_{PLH} t_{PHL}	Propagation Delay Clock to Any Q		18 18	27 27	ns	
t_{PLH} t_{PHL}	Enable to $\overline{RCO}$		11 29	17 45	ns	
t_{PLH} t_{PHL}	$U/\overline{D}$ to $\overline{RCO}$		22 26	35 40	ns	

AC SETUP REQUIREMENTS: $T_A = 25°C$, $V_{CC} = 5.0$ V

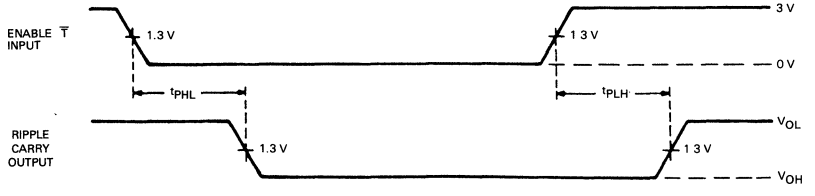
SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Data Setup Time	20			ns	
t_s	Enable Setup Time	35			ns	
t_s	$\overline{Load}$ Setup Time	25			ns	
t_s	$U/\overline{D}$ Setup Time	30			ns	
t_h	Hold Time, Any Input	0			ns	

4

PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS



MOTOROLA

SN54LS670
SN74LS670

4 x 4 REGISTER FILE WITH 3-STATE OUTPUTS

LOW POWER SCHOTTKY

DESCRIPTION — The TTL/MSI SN54LS/74LS670 is a high-speed, low-power 4 x 4 Register File organized as four words by four bits. Separate read and write inputs, both address and enable, allow simultaneous read and write operation.

The 3-state outputs make it possible to connect up to 128 outputs to increase the word capacity up to 512 words. Any number of these devices can be operated in parallel to generate an n-bit length.

The SN54LS/74LS170 provides a similar function to this device but it features open-collector outputs.

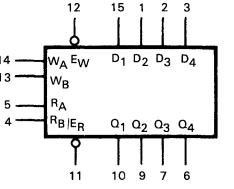
- **SIMULTANEOUS READ/WRITE OPERATION**
- **EXPANDABLE TO 512 WORDS BY n-BITS**
- **TYPICAL ACCESS TIME OF 20 ns**
- **3-STATE OUTPUTS FOR EXPANSION**
- **TYPICAL POWER DISSIPATION OF 125 mW**

PIN NAMES

		LOADING (Note a)	
		HIGH	LOW
D_1-D_4	Data Inputs	0.5 U.L.	0.25 U.L.
W_A, W_B	Write Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}_W$	Write Enable (Active LOW) Input	1.0 U.L.	0.5 U.L.
R_A, R_B	Read Address Inputs	0.5 U.L.	0.25 U.L.
$\overline{E}_R$	Read Enable (Active LOW) Input	1.5 U.L.	0.75 U.L.
Q_1-Q_4	Outputs (Note b)	65(25) U.L.	15(7.5) U.L.

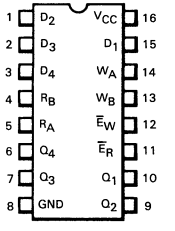
NOTES:
a. 1 TTL Unit Load (U.L.) = 40 μA HIGH/1.6 mA LOW.
b. The Output LOW drive factor is 2.5 U.L. for Military (54) and 5.0 U.L. for Commercial (74) Temperature Ranges. The Output HIGH drive factor is 25 U.L. for Military and 65 U.L. for Commercial Temperature Ranges.

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM DIP (TOP VIEW)

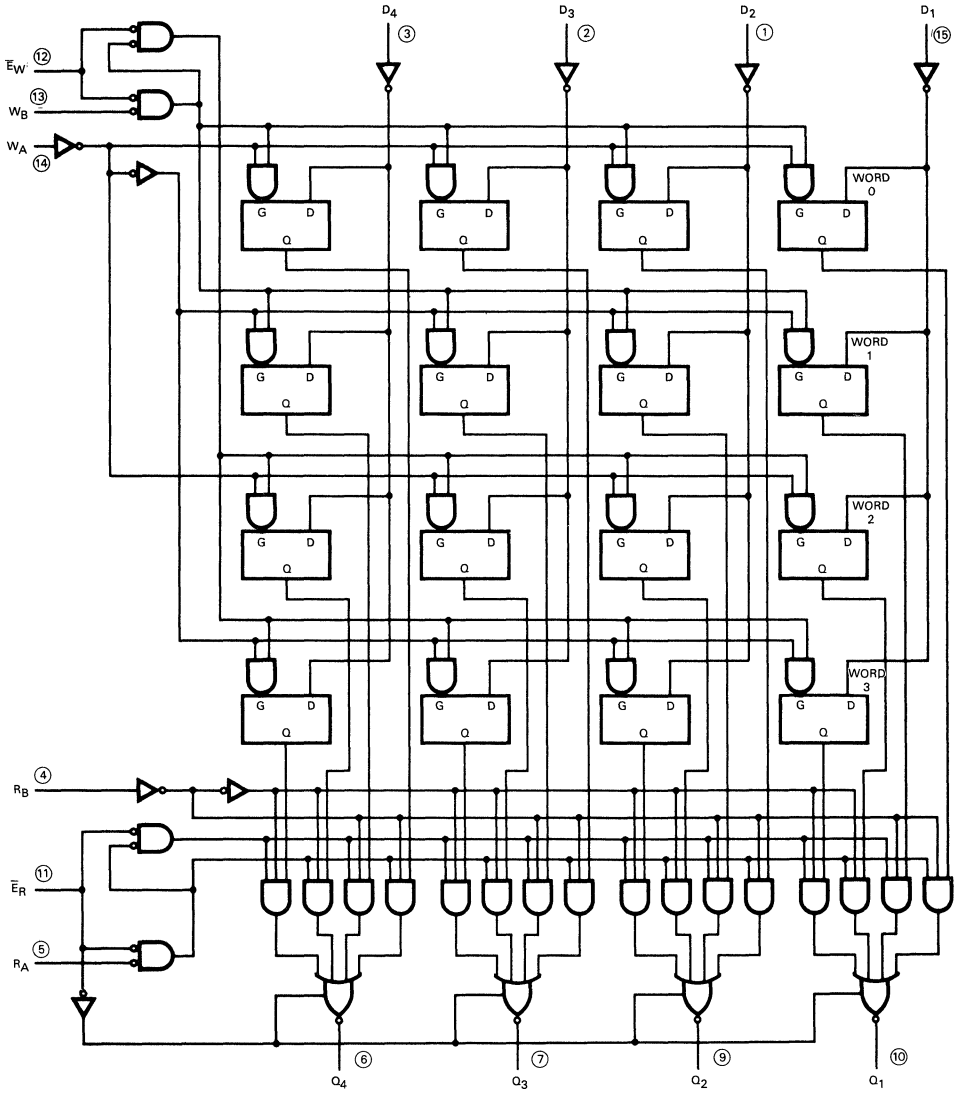


J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

4

LOGIC DIAGRAM



◯ = Pin Numbers
V_{CC} = Pin 16
GND = Pin 8

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.4		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.1		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current HIGH				20	μA	V_{CC} = MAX, V_O = 2.4 V
I_{OZL}	Output Off Current LOW				−20	μA	V_{CC} = MAX, V_O = 0.4 V
I_{IH}	Input HIGH Current D, R, W $\bar{E}_W$ $\bar{E}_R$				20 40 60	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	D, R, W $\bar{E}_W$ $\bar{E}_R$				0.1 0.2 0.3	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current D, R, W $\bar{E}_W$ $\bar{E}_R$				−0.4 −0.8 −1.2	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current				50	mA	V_{CC} = MAX

4

AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, R_A or R_B to Output		23 25	40 45	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF
t_{PLH} t_{PHL}	Propagation Delay, $\overline{E}_W$ to Output		26 28	45 50	ns	
t_{PLH} t_{PHL}	Propagation Delay, Data to Output		25 23	45 40	ns	
t_{PZH} t_{PZL}	Output Enable Time		15 22	35 40	ns	
t_{PLZ} t_{PHZ}	Output Disable Time		16 30	35 50	ns	$C_L = 5.0$ pF

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Pulse Width	25			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, (D)	10			ns	
t_s	Setup Time, (W)	15			ns	
t_h	Hold Time (D)	15			ns	
t_h	Hold Time (W)	5.0			ns	
t_{rec}	Recovery Time	25			ns	

4

AC WAVEFORMS

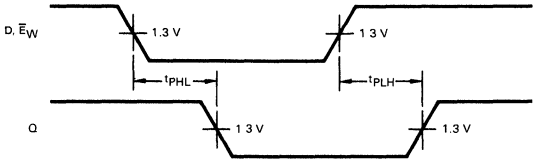


Fig. 1

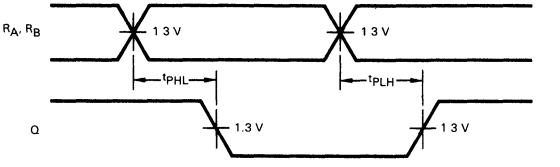


Fig. 2

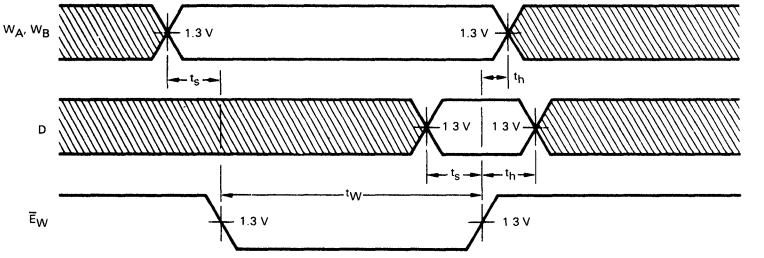


Fig. 3

MOTOROLA

SN54LS/74LS673
SN54LS/74LS674

16-BIT SHIFT REGISTERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS673 and SN54LS/74LS674 are 3-state 16-bit shift registers.

The LS673 is a 16-bit shift register and a 16-bit storage register in a single package. Serial entry and/or data reading is accomplished via a 3-state input/output (SER/Q15) port to the shift register.

Since the storage register is connected in a parallel data loop with the shift register, it may be asynchronously cleared by taking the store-clear input to a low state. The storage register may be parallel loaded with data from the shift register to provide status of the shift register via the parallel outputs. Upon command, the shift register may be parallel loaded with storage register data.

When a high logic level exists at the chip-select ($\overline{CS}$) input, both the shift register and storage register clocks are disabled, and the SER/Q15 is placed in a high impedance state. The store-clear function is not disabled by the chip-select.

CAUTION! To prevent false clocking of either the shift register or storage register via the chip-select input, the shift clock should be low during low-to-high transistion and the store clock should be low during the high-to-low transistion of chip-select.

The LS674 is a 16-bit parallel-in, serial-out shift register. Access for serial data entry or reading the shift register word in a recirculating loop is provided by a 3-state input/output (SER/Q15) port.

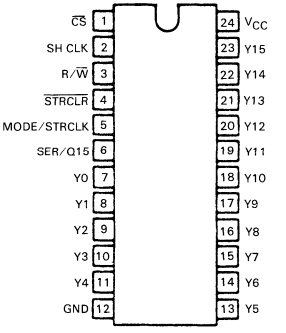
The LS674 has four basic modes of operation:

1. Hold
2. Write
3. Read
4. Load

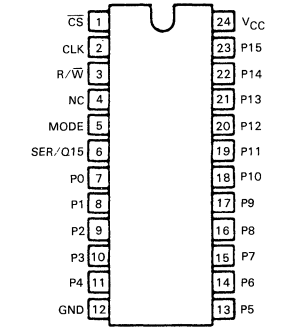
CAUTION! Transistion from low-to-high level at the chip-select input should be made only when the clock input is low to avoid false clocking.

CONNECTION DIAGRAMS
(TOP VIEW)

SN54LS/74LS673



SN54LS/74LS674



NC — No internal connection

J Suffix — Case 623-05 (Ceramic)
N Suffix — Case 649-03 (Plastic)

4

FUNCTION TABLES

SN54LS/74LS673

INPUTS					SER/ Q15	SHIFT REGISTER FUNCTIONS				STORAGE REGISTER FUNCTIONS	
$\overline{CS}$	R/$\overline{W}$	SH CLK	$\overline{STRCLR}$	MODE/ STRCLK		SHIFT	READ FROM SERIAL OUTPUT	WRITE INTO SERIAL OUTPUT	PARALLEL LOAD	CLEAR	LOAD
H	X	X	X	X	Z	NO	NO	NO	NO		NO
X	X	X	L	X						YES	
L	L	↓	X	X	Z	YES	NO	YES	NO		
L	H	X	X	X	Q15		YES	NO			NO
L	H	↓	X	L	Q14n	YES	YES	NO	NO		NO
L	H	↓	L	H	L	NO	YES		YES	YES	NO
L	H	↓	H	H	Y15n	NO	YES		YES	NO	NO
L	L	X	H	↑	Z		NO		NO	NO	YES

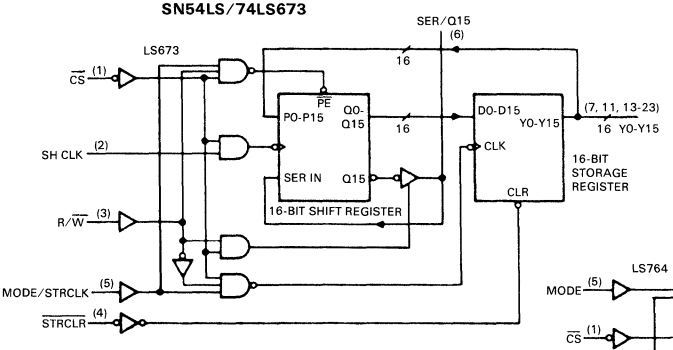
SN54LS/74LS674

INPUTS				SER/ Q15	OPERATION
$\overline{CS}$	R/$\overline{W}$	MODE	CLK		
H	X	X	X	Z	Do nothing
L	L	X	↓	Z	Shift and write (serial load)
L	H	L	↓	Q14n	Shift and read
L	H	H	↓	P15	Parallel load

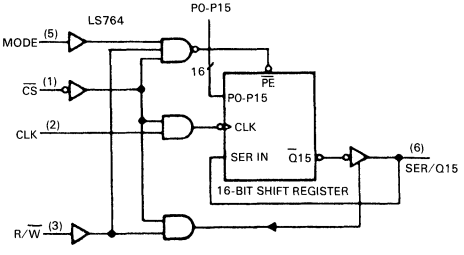
H = high level (steady state)
L = low level (steady state)
↑ = transition from low to high level
↓ = transition from high to low level
X = irrelevant (any input including transitions)
Z = high impedance, input mode
Q14n = content of 14th bit of the shift register before the most recent ↓ transition of the clock.
Q15 = present content of 15th bit of the shift register
Y15n = content of the 15th bit of the storage register before the most recent ↓ transition of the clock.
P15 = level of input P15

BLOCK DIAGRAMS

SN54LS/74LS673



SN54LS/74LS674



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER			MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage		54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range		54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	SER/Q15 SER/Q15	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	SER/Q15 SER/Q15	54 74			12 24	mA
I_{OH}	Output Current — High	Y0-Y15	54,74			−0.4	mA
I_{OL}	Output Current — Low	Y0-Y15 Y0-Y15	54 74			4.0 8.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage SER/Q15	54	2.4	3.2		V	V_{CC} = MIN, I_{OH} = MAX
		74	2.4	3.2		V	
V_{OH}	Output HIGH Voltage Y0-Y15	54	2.5	3.4		V	V_{CC} = MIN, I_{OH} = MAX
		74	2.7	3.4		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA
I_{OZH}	Output Off Current HIGH				40	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current LOW				−400	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current	Others SER/Q15			20 40	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		Others SER/Q15			0.1 0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V V_{CC} = MAX, V_{IN} = 5.5 V
I_{IL}	Input LOW Current				−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current	Y0-Y15 LS673	−20		−100	mA	V_{CC} = MAX
		SER/Q15	−30		−130	mA	
I_{CC}	Power Supply Current	LS674			40	mA	V_{CC} = MAX
		LS673			80		

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AC CHARACTERISTICS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS						UNITS	TEST CONDITIONS
		LS673			LS674				
		MIN	TYP	MAX	MIN	TYP	MAX		
f_{MAX}	Maximum Clock Frequency	20	28		20	28		MHz	$V_{CC} = 5.0$ V, $C_L = 45$ pF, $R_L = 667\Omega$
t_{PLH} t_{PHL}	Propagation Delay, MODE/STRCLK to Y0-Y15		28 30	45 45				ns	
t_{PHL}	Propagation Delay, $\overline{STRCLR}$ to Y0-Y15		25	40				ns	
t_{PLH} t_{PHL}	Propagation Delay, SH CLK to SER/Q15		21 26	33 40					
t_{PLH} t_{PHL}	Propagation Delay, CLK to SER/Q15					21 26	33 40	ns	
t_{PZH} t_{PZL}	Output Enable Time, $\overline{CS}$, R/$\overline{W}$ to SER/Q15		30 30	45 45		30 30	45 45	ns	
t_{PLZ} t_{PHZ}	Output Disable Time, $\overline{CS}$, R/$\overline{W}$ to SER/Q15		25 25	40 40		25 25	40 40	ns	$C_L = 5.0$ pF

4

AC SETUP REQUIREMENTS: $T_A = 25°C$

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_W	Clock Clear Pulse Width	20			ns	$V_{CC} = 5.0$ V
t_s	Setup Time, SER/Q15, P0-P15	20			ns	
t_s	Setup Time, MODE, R/$\overline{W}$, $\overline{CS}$	35			ns	
t_h	Hold Time, Any Input	0			ns	

MOTOROLA

SN54LS/74LS682 thru SN54LS/74LS689

8-BIT MAGNITUDE COMPARATORS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS682 thru SN54LS/74LS689 are 8-bit magnitude comparators. These device types are designed to perform comparisons between two eight-bit binary or BCD words. All device types provide $\overline{P=Q}$ outputs and the LS682 thru LS687 have $\overline{P>Q}$ outputs also.

The LS682, LS684, LS686 and LS688 are totem pole devices. The LS683, LS685, LS687 and LS689 are open-collector devices.

The LS682 and LS683 have a 20 kΩ pullup resistor on the Q inputs for analog or switch data.

TYPE	$\overline{P=Q}$	$\overline{P>Q}$	OUTPUT ENABLE	OUTPUT CONFIGURATION	PULLUP
LS682	yes	yes	no	totem-pole	yes
LS683	yes	yes	no	open-collector	yes
LS684	yes	yes	no	totem-pole	no
LS685	yes	yes	no	open-collector	no
LS686	yes	yes	yes	totem-pole	no
LS687	yes	yes	yes	open-collector	no
LS688	yes	no	yes	totem-pole	no
LS689	yes	no	yes	open-collector	no

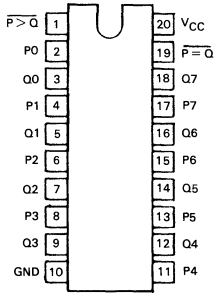
FUNCTION TABLE

INPUTS			OUTPUTS	
DATA	ENABLES			
P, Q	$\overline{G}$, $\overline{G1}$	$\overline{G2}$	$\overline{P=Q}$	$\overline{P>Q}$
P = Q	L	L	L	H
P > Q	L	L	H	L
P < Q	L	L	H	H
X	H	H	H	H

H = high level, L = low level, X = irrelevant

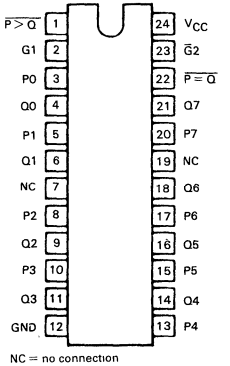
CONNECTION DIAGRAMS
(TOP VIEW)

SN54LS/74LS682 THRU SN54LS/74LS685



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

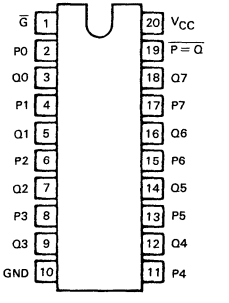
SN54LS/74LS686 SN54LS/74LS687



NC = no connection

J Suffix — Case 758-01 (Ceramic)
N Suffix — Case 724-02 (Plastic)

SN54LS/74LS688 SN54LS/74LS689



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

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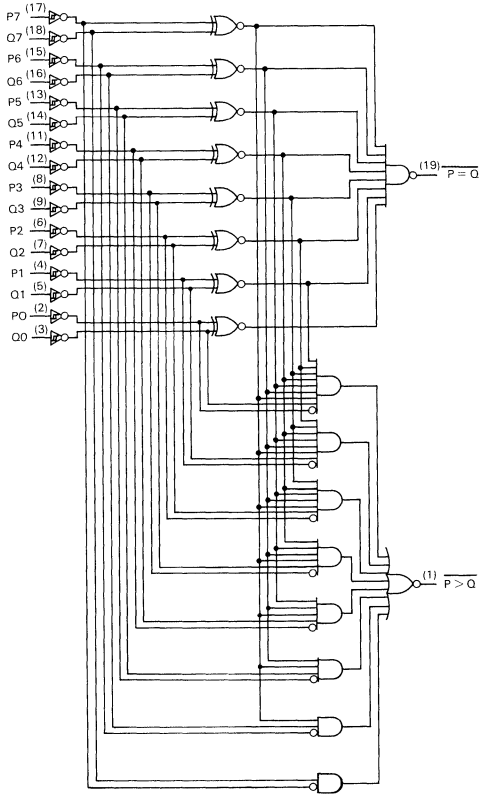
GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54,74			−0.4	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

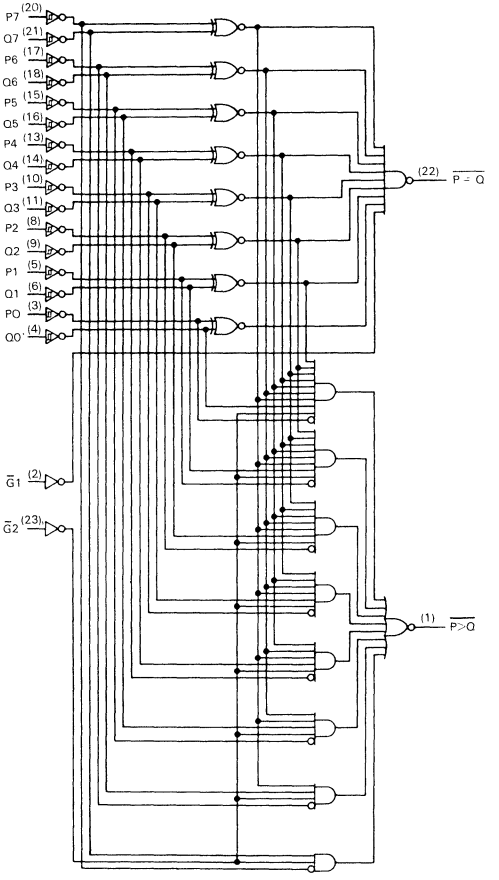
DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		LS682-Q Inputs			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V
		Others			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	LS682-Q Inputs			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Others			−0.2	mA	
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current	LS682			70	mA	V_{CC} = MAX
		LS684			65	mA	
		LS686			75	mA	
		LS688			65	mA	

BLOCK DIAGRAMS



SN54LS/74LS682 thru LS685



SN54LS/74LS686, LS687

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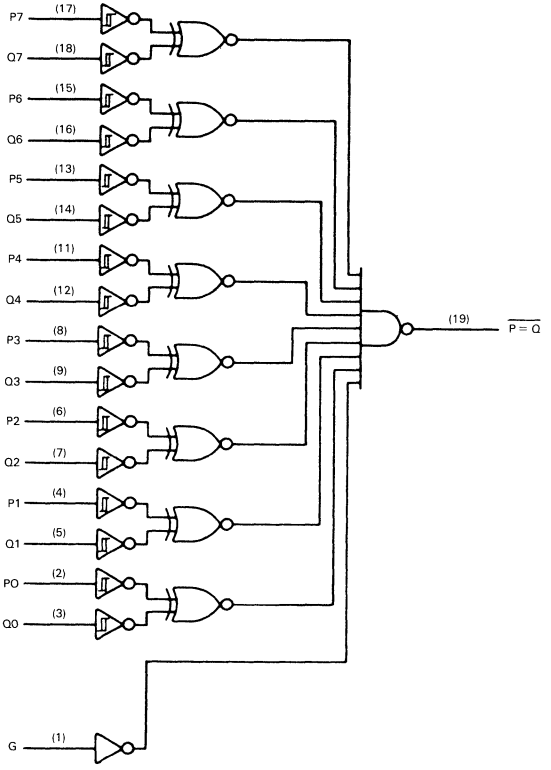
BLOCK DIAGRAM



SN54LS/74LS688, LS689

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
V_{OH}	Output Voltage — High	54,74			5.5	V
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
I_{OH}	Output HIGH Current	54			250	μA	V_{CC} = MIN, V_{OH} = MAX
		74			100	μA	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
		LS683-Q Inputs			0.1	mA	V_{CC} = MAX, V_{IN} = 5.5 V
		Others			0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current	LS683-Q Inputs			−0.4	mA	V_{CC} = MAX, V_{IN} = 0.4 V
		Others			−0.2	mA	
I_{CC}	Power Supply Current	LS683			70	mA	V_{CC} = MAX
		LS685			65	mA	
		LS687			75	mA	
		LS689			65	mA	

4

AC CHARACTERISTICS: $T_A = 25°C$

SN54LS/74LS682

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		13 15	25 25	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		14 15	25 25	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		20 15	30 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		21 19	30 30	ns	

SN54LS/74LS683

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		30 20	45 30	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		24 23	35 35	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		31 17	45 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		30 21	45 30	ns	

SN54LS/74LS684

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		15 17	25 25	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		16 15	25 25	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		22 17	30 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		24 20	30 30	ns	

SN54LS/74LS685

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		30 19	45 35	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		24 23	45 35	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		32 16	45 35	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		30 20	45 35	ns	

AC CHARACTERISTICS: $T_A = 25°C$

SN54LS/74LS686

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		13 20	25 30	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		13 21	25 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, $\overline{G1}$ to $\overline{P = Q}$		11 19	20 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		19 15	30 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		18 19	30 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G2}$ to $\overline{P > Q}$		21 16	30 25	ns	

SN54LS/74LS687

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		24 20	35 30	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		24 20	35 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, $\overline{G1}$ to $\overline{P = Q}$		21 18	35 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P > Q}$		24 16	35 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P > Q}$		24 16	35 30	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G2}$ to $\overline{P > Q}$		24 15	35 30	ns	

SN54LS/74LS688

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		12 17	18 23	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		12 17	18 23	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, $\overline{G1}$ to $\overline{P = Q}$		12 13	18 20	ns	

SN54LS/74LS689

SYMBOL	PARAMETER	LIMITS			UNITS	TEST CONDITIONS
		MIN	TYP	MAX		
t_{PLH} t_{PHL}	Propagation Delay, P to $\overline{P = Q}$		24 22	40 35	ns	$V_{CC} = 5.0$ V $C_L = 45$ pF $R_L = 667\ \Omega$
t_{PLH} t_{PHL}	Propagation Delay, Q to $\overline{P = Q}$		24 22	40 35	ns	
t_{PLH} t_{PHL}	Propagation Delay, $\overline{G}$, $\overline{G1}$ to $\overline{P = Q}$		22 19	35 30	ns	

4

MOTOROLA

SN54LS/74LS716
SN54LS/74LS718

PROGRAMMABLE MODULO-N COUNTERS

LOW POWER SCHOTTKY

DESCRIPTION — These monolithic devices are programmable, cascadable, modulo-N-counters. The SN54LS/74LS716 can be programmed to divide by any number (N) from 0 thru 9, the SN54LS/74LS718 from 0 thru 15.

The parallel enable ($\overline{PE}$) input enables the parallel data inputs D0 thru D3. All zeros are entered into the counter by applying a logic "0" level to the master reset ($\overline{MR}$) and $\overline{PE}$ inputs. This causes the counter to stop counting (count = 0). All data inputs are independent of the logic level of the Clock.

Modulo-N counters are useful in frequency synthesizers, in phase-locked loops, and in other applications where a simple method for frequency division is needed.

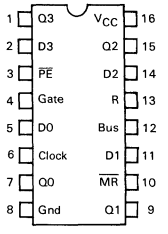
All Types:

Input Loading Factor:
Clock, $\overline{PE}$ = 2
D0, D1, D2, D3, Gate = 1
$\overline{MR}$ = 4
Output Loading Factor = 8

Total Power Dissipation = 85 mW typ/pkg
Propagation Delay Time:
Clock to Q3 = 50 ns typ
Clock to Bus = 35 ns typ

CONNECTION DIAGRAM
DIP (TOP VIEW)

V_{CC} = Pin 16
Gnd = Pin 8



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

SN54LS/74LS716

COUNT	OUTPUT			
	Q3	Q2	Q1	Q0
9	1	0	0	1
8	1	0	0	0
7	0	1	1	1
6	0	1	1	0
5	0	1	0	1
4	0	1	0	0
3	0	0	1	1
2	0	0	1	0
1	0	0	0	1
0	0	0	0	0

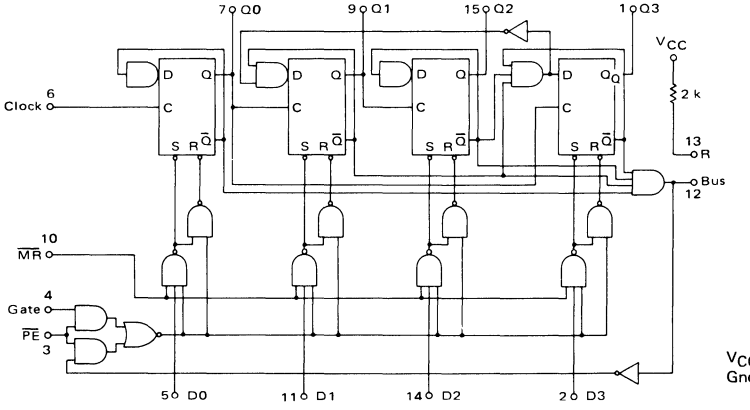
SN54LS/74LS718

COUNT	OUTPUT			
	Q3	Q2	Q1	Q0
15	1	1	1	1
14	1	1	1	0
13	1	1	0	1
12	1	1	0	0
11	1	0	1	1
10	1	0	1	0
9	1	0	0	1
8	1	0	0	0
7	0	1	1	1
6	0	1	1	0
5	0	1	0	1
4	0	1	0	0
3	0	0	1	1
2	0	0	1	0
1	0	0	0	1
0	0	0	0	0

4

LOGIC DIAGRAMS

SN54LS/74LS716



VCC = Pin 16
Gnd = Pin 8

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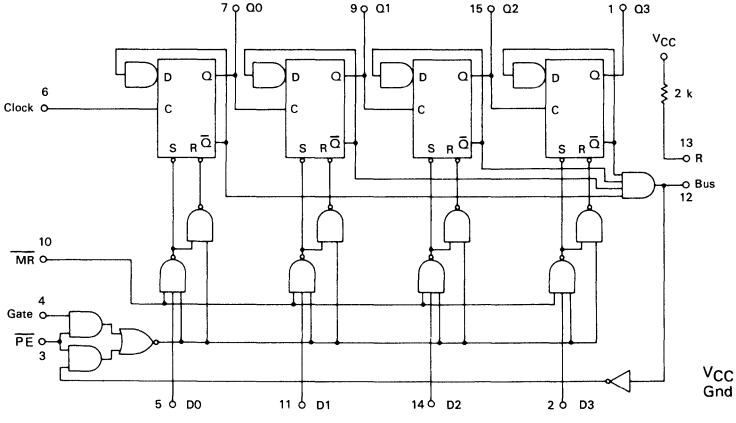
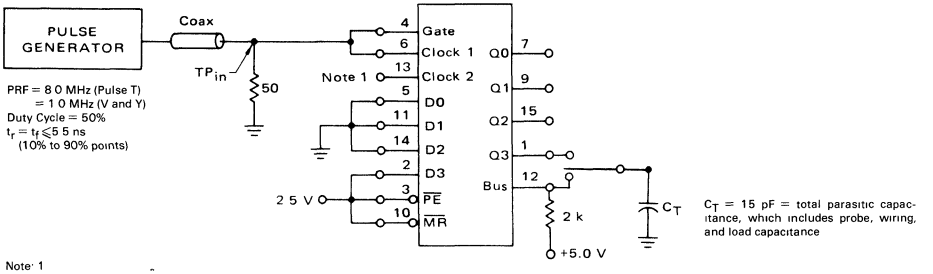
SN54LS/74LS718

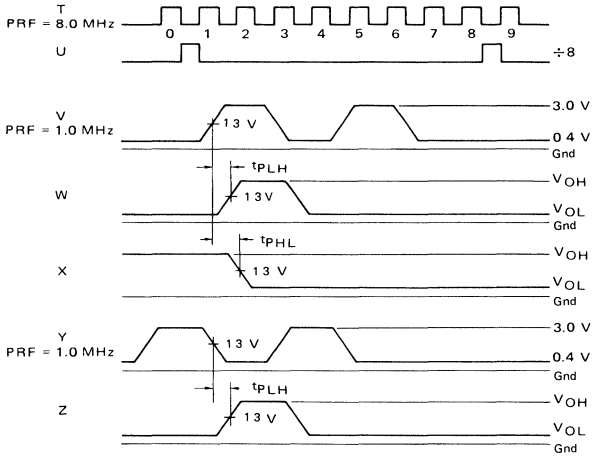


VCC = Pin 16
Gnd = Pin 8

SWITCHING TIME TEST CIRCUIT AND VOLTAGE WAVEFORMS



Note: 1
Counter programmed for ÷8 operation, Pin 13 is the resistor pin, and left open



SWITCHING TIME TEST PROCEDURES (T_A = 25°C)

(Letters shown in test columns refer to waveforms.)

TEST	SYMBOL	INPUT				OUTPUT		LIMITS		
		Clock Pin 6	Gate Pin 4	D0, D1, D2 Pins 5, 11, 14	D3, $\overline{PE}$, $\overline{MR}$ Pins 2, 3, 10	Bus Pin 12	Q3 Pin 1	Min	Max	Unit
Toggle Frequency (Check before measuring propagation delay.)	f_{tog}	T	T	Gnd	2.5 V	—	U	8.0	—	MHz
Propagation Delay Clock to Bus	t_{PLH}	V	V	Gnd	2.5 V	W	—	—	65	ns
Propagation Delay Gate to Q3	t_{PLH}	Y	Y	Gnd	2.5 V	—	Z	—	35	ns
Propagation Delay Clock 1 to Q3	t_{PHL}	V	V	Gnd	2.5 V		X			
SN54LS/74LS716								—	45	ns
SN54LS/74LS718								—	78	ns

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−1.0 −2.6	mA
I_{OL}	Output Current — Low	54 74			12 24	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.4	3.5		V	V_{CC} = MIN, I_{OH} = MAX, V_{IN} = V_{IH} or V_{IL} per Truth Table
		74	2.4	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 12 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 24 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{IH}	Input HIGH Current Data, Clock, Gate Enable $\overline{MR}$				20 40 80	μA	V_{CC} = MAX, V_{IN} = 2.7 V
	Data, Clock, Gate Enable $\overline{MR}$				0.1 0.2 0.4	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current Data, Clock, Gate Enable $\overline{MR}$				−0.4 −0.8 −1.6	mA	V_{CC} = MAX, V_{IN} = 0.4 V
I_{OS}	Short Circuit Current	Others	−30		−130	mA	V_{CC} = MAX
		R Output	−1.8		−3.8	mA	
I_{CC}	Power Supply Current			17	32	mA	V_{CC} = MAX

4

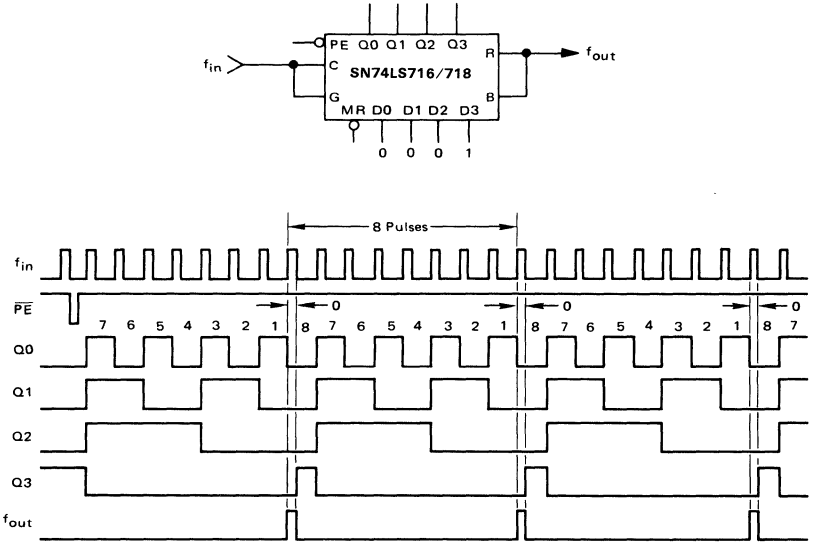


Fig. 1 — SINGLE-STAGE OPERATION

4

OPERATING CHARACTERISTICS

Operation of both counters is essentially the same. The SN54LS/74LS716 has a maximum modulus of ten while the SN54LS/74LS718 is capable of dividing by up to sixteen. Minor differences in the programming procedure will be covered in the discussion of cascaded stages.

Suitable connections for operating a single stage are shown in Figure 1, as well as appropriate waveforms. The desired modulus is applied to the data inputs D0, D1, D2, and D3 in binary SN74LS718 or binary coded decimal SN74LS716 positive logic format. If a number greater than nine (BCD 1001) is applied to the SN74LS716 it treats the most significant bit position as a zero; if for example, binary fourteen (1110) were applied to an SN74LS716 the counter would divide by six. BCD eight is programmed in Figure 1. As $\overline{PE}$ is taken low the states on the parallel inputs are transferred to their respective outputs. Subsequent positive transitions of the input clock will decrement the counter until the all zero state is detected by the bus gate. The resulting positive transition of the bus line is internally inverted and fed back to the preset gating circuitry but does not yet preset the counter since the gate-clock input is still high. As the clock returns to the low state the counter is set to the programmed state, taking the bus line low. The net result is one positive pulse on the bus line for every N clock pulses. The output pulse width is approximately equal to one clock pulse high time.

Operation will continue in this fashion until the data on the programmable inputs is changed. Since the preset circuitry is inhibited except when the counter is in the zero state, preset data may be changed while clocking is occurring. If it is necessary to enter a new number before the counter has reached zero this can be done by momentarily taking $\overline{PE}$ low. Countdown will continue from the new number on the next positive clock transition.

The counters can be made to divide by 10 (SN74LS716) or 16 (SN74LS718) by inhibiting the preset logic. This may be done by either holding the gate input high or by holding the bus line low.

The normal connections for cascading stages are indicated in Figure 2, with the appropriate waveforms. Note that the gate input of each stage is connected to the clock; all bus outputs are tied to one of the internal pullup resistors, R. The total modulus for cascaded SN74LS716's is determined from $N_T = N_0 + 10N_1 + 100N_2 + \ldots$; N_T for SN74LS718's is given by $N_T = N_0 + 16N_1 + 256N_2 + \ldots$ Stated another way, the BCD equivalent of each decimal digit is applied to respective SN74LS716 stages while the data inputs of the SN74LS718 stages are treated as part of one long binary number. The difference in programming is illustrated in Figure 2 where $N_T = 245$ is coded for both counter types.

Cascaded operation can be further clarified by referring to the timing diagram of Figure 2. For the SN74LS716 counting begins with the first positive clock transition after the data has been set in. After the five clock pulses, the least-significant stage has been counted down to zero. The bus line does not go high at this time since the three bus terminals are wire-ORed and the other two stages are not in the zero state. Since no reset occurs, the next positive clock edge advances the least significant stage to the nine (1001) state, causing the second stage to be decremented. The process continues in this manner with the least significant stage now dividing by ten. The second stage eventually counts down to zero and also reverts to dividing by ten. Each pulse out of the second stage decrements the third until it reaches zero. At this time the bus line goes high; it remains high until the clock goes low, causing all three stages to be reset to the programmed count again.

Maximum operating frequency of the basic SN74LS716/718 counter is limited by the time required for reprogramming at the end of each count down cycle. Operation can be extended to approximately 25 MHz by adding an "early decode" feature as shown in Figure 3. The appropriate connections for three stages are shown; however up to eight stages can be satisfactorily cascaded. Note the following differences between this and the non-extended method: the counter gate inputs are not connected to the input clock; all Parallel Enables are connected to the $\overline{Q}$ output of a type D flip-flop formed by gates G1 through G6; the bus terminal of the least significant stage is grounded; all other bus terminals and one internal resistor, R, are connected together and serve as a data input to the flip-flop. Four additional data inputs are provided for decoding the "two" state of the least significant stage. Circuit operation is illustrated in the waveforms of Figure 3 where the timing for the end of a count-down cycle is shown in expanded form. The counter parallel inputs are assumed to have N = 245 applied. Timing is now shown for the third stage since it has already been counted down to the all zero state. As the next-to-least significant stage reaches zero, the common bus line goes high. Count down of the least significant stage continues until the "two" state is reached. This condition causes the remaining D inputs to the flip-flop to be high. The next-to-last clock pulse of the cycle then triggers the flip-flop Q output high. $\overline{Q}$ simultaneously takes the parallel enable of all stages low, resetting the programmed data to the outputs. The next input pulse clocks Q (f_{out}) back to the zero stage, since the data inputs to the flip-flop are no longer all high. The positive output pulse is one input clock period in duration. Note that division by N equal to 1 or 2 is not available using this method.

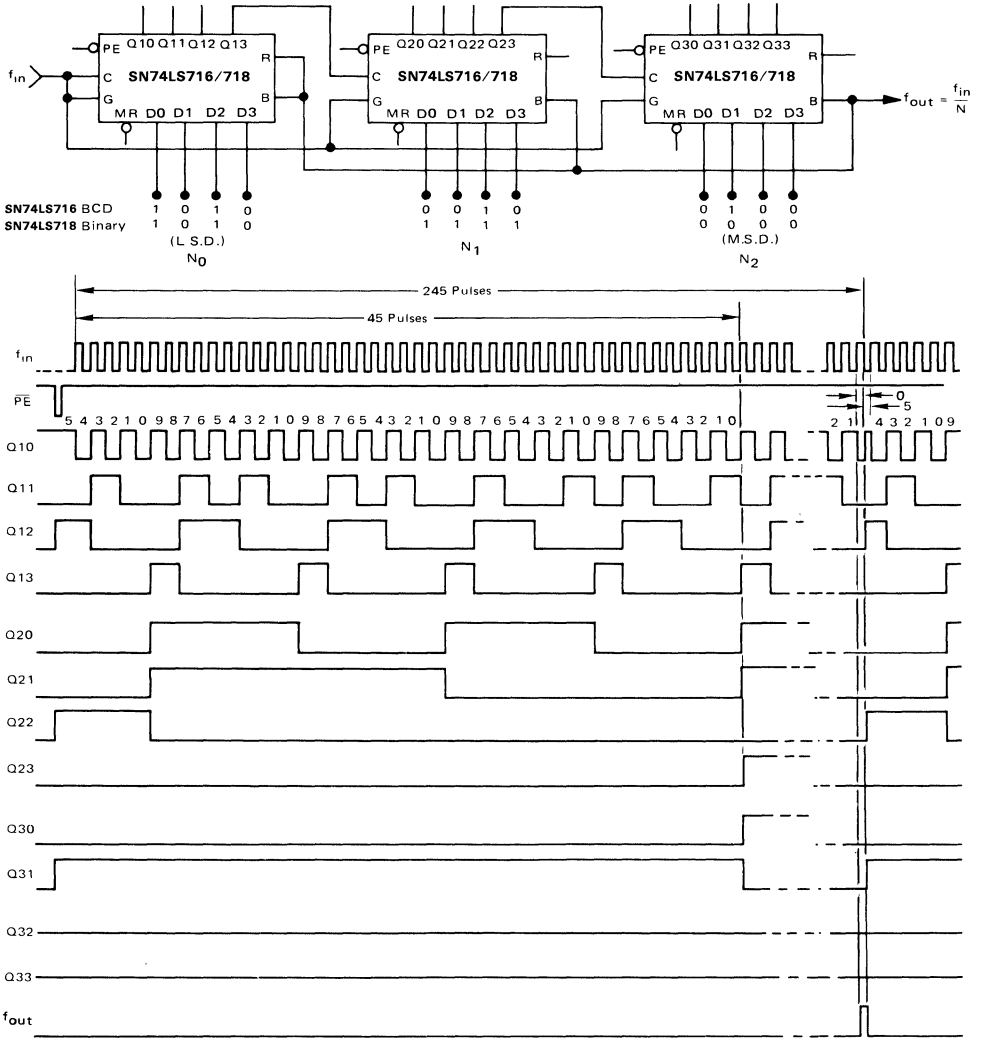
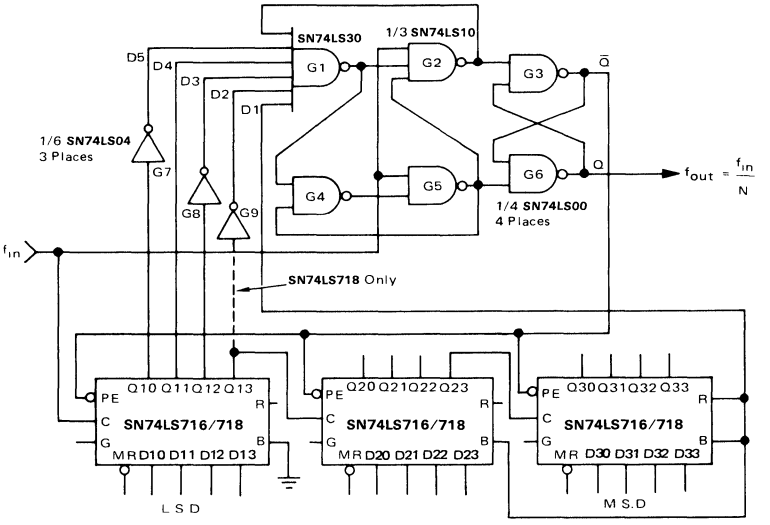


Fig. 2 — CASCADED OPERATION



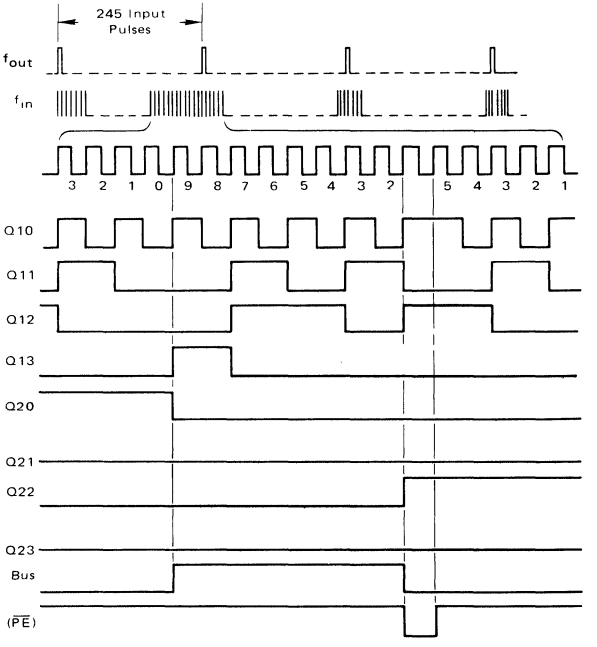


Fig. 3 — INCREASING OPERATING RANGE

APPLICATIONS INFORMATION

A typical system application for programmable counters is illustrated in the frequency synthesizer shown in Figure 4. There the counter provides a means of digitally selecting some integral multiple of a stable reference frequency. The circuit phase locks the output, f_{VCO}, of a voltage controlled oscillator to a reference frequency, f_{ref}.[1] Circuit operation is such that $f_{VCO} = Nf_{ref}$, where N is the divider ratio of the feedback counter.

In many synthesizer applications the VCO is operated at VHF frequencies too high for direct division by TTL counters. In these cases the VCO output is usually prescaled by using a suitable fixed divided-by-M ECL circuit as shown in Figure 5. For this configuration, $f_{VCO} = NMf_{ref}$, where N is variable (programmable) and M is fixed. Design of the optimum loop filter requires that the input reference frequency be as high as possible where the upper limit is established by the required channel spacing. Since $f_{VCO} = Nf_{ref}$ in the non-prescaled case, if N is changed by one, the VCO output changes by f_{ref}, or the synthesizer channel spacing is just equal to f_{ref}. When the prescaler is used as in Figure 5, $f_{VCO} = NMf_{ref}$, and a change of one in N results in the VCO changing by Mf_{ref}, i.e., if f_{ref} is set equal to the minimum permissible channel spacing as is desirable, then only every M channels in a given band can be selected. One solution is to set f_{ref} = channel spacing/M but this leads to more stringent loop filter requirements.

An alternate approach that avoids this problem is provided by the counter configuration shown in Figure 6.[2]. It too uses a prescaler ahead of a programmable counter, however the modulus of the prescaler is now controlled by a third counter, causing it to alternate between M and M + 1. Operation is best explained by assuming that all three counters have been set for the beginning of a cycle: the prescaler for division by (M + 1), the modulus control counter for division by N_{mc}, and the

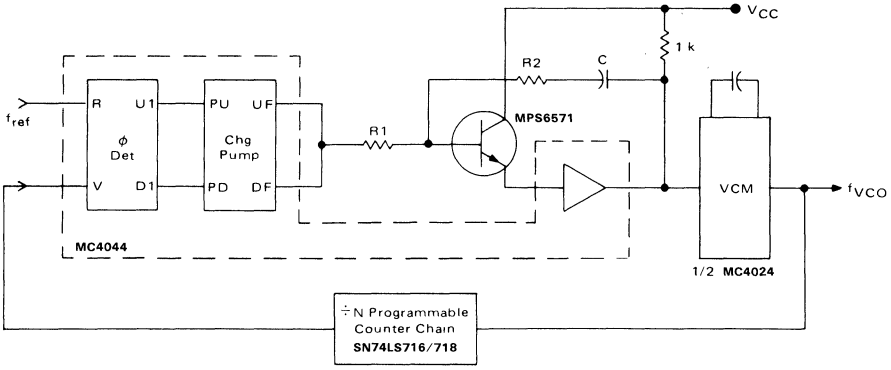


Fig. 4 — MTTL PHASE-LOCKED LOOP

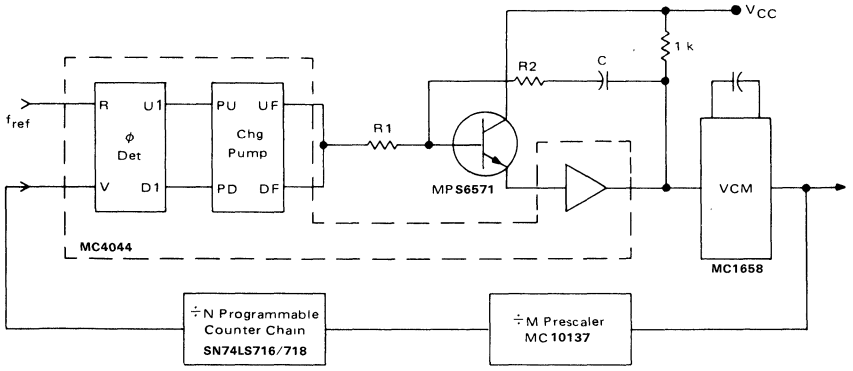


Fig. 5 — MTTL-MECL PHASE-LOCKED LOOP

1 See Motorola Application Note AN-535 and the MC4344/4044 Data Sheet for detailed explanation of overall circuit operation

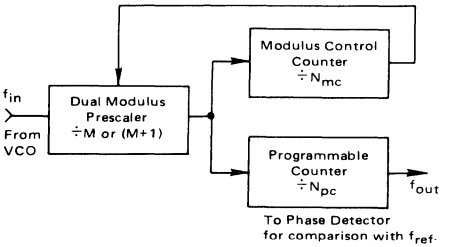


Fig. 6 — FEEDBACK COUNTERS WITH DUAL MODULUS PRESCALER

programmable counter for division by N_{pc}. The prescaler will divide by (M + 1) until the modulus control counter has counted down to zero; at this time, the all zero state is detected and causes the prescaler to divide by M until the programmable counter has also counted down to zero. When this occurs, a cycle is complete and each counter is reset to its original modulus in readiness for the next cycle. For this configuration,

$$f_{out} = \frac{f_{in}}{MN_{pc}+N_{mc}}$$

In terms of the synthesizer application, $f_{VCO} = (MN_{pc} + N_{mc})\, f_{ref}$ and channels can be selected every f_{ref} by letting N_{pc} and N_{mc} take on suitable integer values, including zero.

A simplified example of this technique is shown in Figure 7. The MC12013 Dual Modulus Prescaler divides by either 10 or 11 as shown in Figure 7. If the E3 and E4 Enable inputs are high at the start of a prescaler cycle, division by 10 results; if the Enable inputs are low at the beginning of the cycle, division by 11 results. The zero detection circuitry of the MC12014 Counter Control Logic is connected to monitor the outputs of the modulus control counter; this provides a suitable enable signal at EO as the modulus control counter reaches its terminal (zero) count. The remainder of the MC12014 is connected to extend the operating frequency of the programmable counter chain.

A specific example of this technique is shown in Figure 8. There the feedback divider circuitry required for generating frequencies between the 144 MHz and 178 MHz with 30 kHz channel spacing is shown.[2]

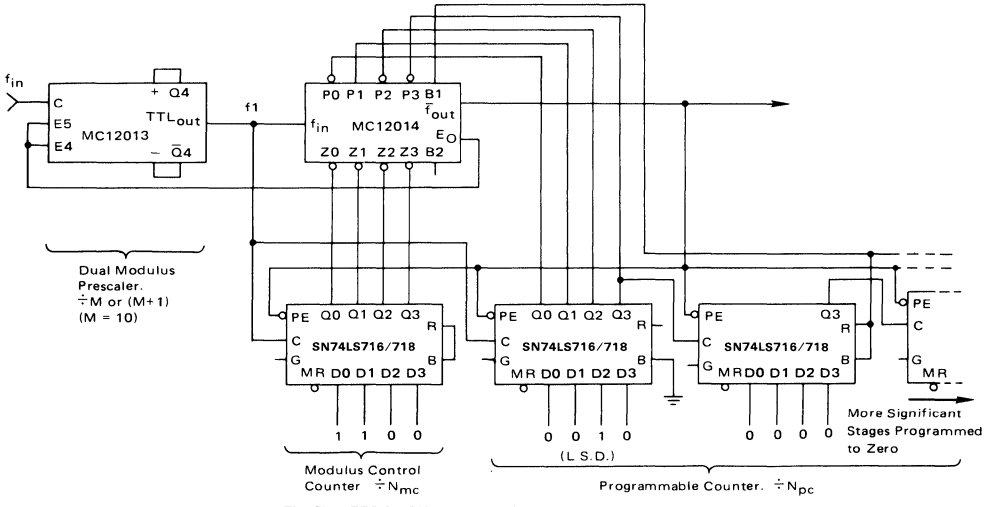


Fig. 7 — FREQUENCY DIVISION: $f_O = f_{in}/MN_{pc} = N_{mc}$

2. This application is discussed in greater detail in the MC 12014 Counter Control Logic data sheet.

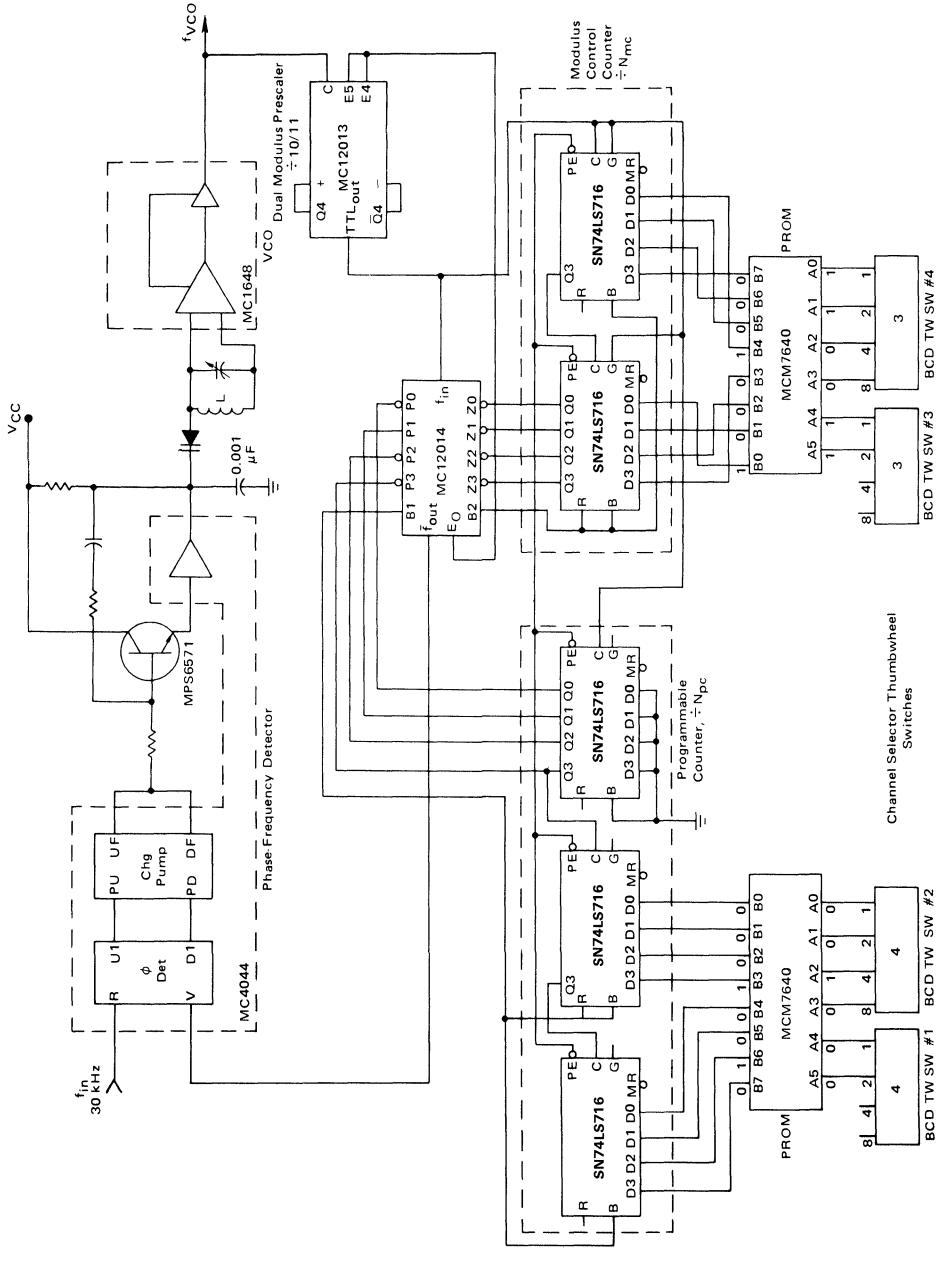


Fig. 8 — 144 to 178 MHz FREQUENCY SYNTHESIZER WITH 30 kHz CHANNEL SPACING

MOTOROLA

SN74LS724

Advance Information

VOLTAGE CONTROLLED OSCILLATOR

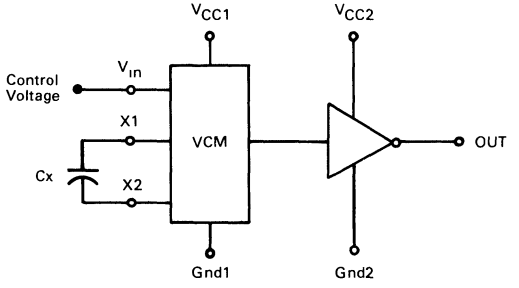
DESCRIPTION — The SN74LS724 is a low power Voltage Controlled Oscillator. With an external capacitor connected across Pins 1 and 8, the output frequency can be varied over a 3.5 to 1 range by adjusting the control voltage input (V_{in}) from 1.0 to 5.0 volts.

The LS724 is ideal for video game and microcomputer applications. It can be used to generate sound IF, a colorburst reference, and/or a microprocessor clock. Also, the output rise and fall times are slow compared to standard LS logic so the generation of electromagnetic interference is reduced.

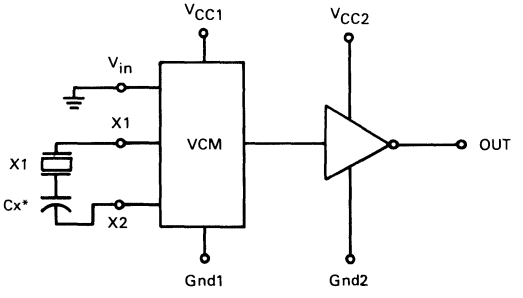
FEATURES:

- **CAN BE USED AS A VOLTAGE CONTROLLED OR CRYSTAL CONTROLLED OSCILLATOR**
- **8-PIN DIP REQUIRES MINIMAL PC BOARD SPACE**
- **REDUCED RISE AND FALL TIMES FOR LESS EMI**
- **LOW POWER — 45 mW MAX**

VOLTAGE CONTROLLED MULTIVIBRATOR



CRYSTAL OSCILLATOR



*Cx is optional

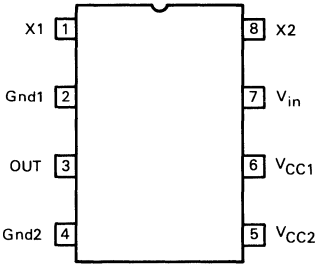
(Cx may be necessary to trim oscillator frequency or improve performance.)

This document contains information on a new product. Specifications and information herein are subject to change without notice.

VOLTAGE-CONTROLLED OSCILLATOR

LOW POWER SCHOTTKY

CONNECTION DIAGRAM DIP
(TOP VIEW)



Case 626-04 (Plastic)
Case 693-02 (Ceramic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	4.75	5.0	5.25	V
T_A	Operating Ambient Temperature Range	0	25	70	°C
I_{OH}	Output Current — High			-0.4	mA
I_{OL}	Output Current — Low			4.0	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER	LIMITS			CONDITIONS
		MIN	MAX	UNITS	
V_{OH}	Output HIGH Voltage	2.7		V	I_{OH} = -0.4 mA, V_{CC} = MIN
V_{OL}	Output LOW Voltage		0.5	V	I_{OL} = 4.0 mA, V_{CC} = MIN
I_{IN}	Input HIGH Current		100	μA	V_{IN} = 5.0 V, V_{CC} = MAX
I_{OS}	Short Circuit Current	-8.0	-25	mA	V_O = 0 V, V_{CC} = MAX
I_{CC}	Supply Current		8.5	mA	V_{CC} = MAX

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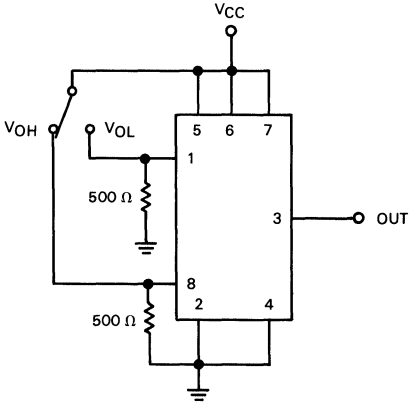
AC CHARACTERISTICS: V_{CC} = 5.0 V, T_A = 25°C, C_L = 15 pF

SYMBOL	TEST	CONDITIONS	VALUE			UNITS
			MIN	TYP	MAX	
f_{max}*	Maximum Operating Frequency	Cx = 10 pF, V_{IN} = 5.0 Vdc V_{CC} = 5.0 Vdc Load = 15 pF	11	16		MHz
f_{HIGH} f_{LOW}	Ratio of Frequency of Oscillation Over Specified Input Voltage Range	Cx = 100 pF V_{IN} HIGH = 5.0 Vdc V_{IN} LOW = 1.0 Vdc	3.5 to 1.0	4.0 to 1.0		—

*Due to the low power nature of this device, some degradation of output swing can be expected as output frequency exceeds 9.0 MHz. With V_{CC} = 5.0 V, the guaranteed V_{OH} level drops from 2.7 volts at 9.0 MHz to 2.0 volts at 16 MHz.



For dc test purposes the LS724 output can be forced into a HIGH (V_{OH}) or LOW (V_{OL}) logic state as shown.

APPLICATIONS INFORMATION

In order to improve frequency stability, separate V_{CC} and ground pins are provided to allow the oscillator to be isolated from the logic power supply. However, both ground lines must be connected externally to ensure proper operation. It is also recommended that the oscillator V_{CC} be bypassed with a good RF type capacitor of 500 to 1000 pF.

When used as a voltage controlled oscillator, the center frequency can be approximated by:

$$f_c\,(\text{MHz}) \simeq \frac{130}{Cx\,(\text{pF})} : V_{in} \simeq 4.25\ \text{V}$$

The relationship between control input voltage, external capacitance and output frequency can be found in Figure 1 which is valid for values of capacitance in excess of 100 pF. For values of capacitance less than 100 pF, Figure 2 should be used.

FREQUENCY STABILITY

Oscillator output frequency is somewhat dependent on temperature and power supply voltage. Typical frequency variation at V_{in} = 5.0 V is approximately ±10% over the V_{CC} range and approximately ±7% over the 0°C to 70°C temperature range. As with any oscillator, internal noise will also cause the output frequency to drift slightly.

FIGURE 1 — FREQUENCY CAPACITANCE PRODUCT

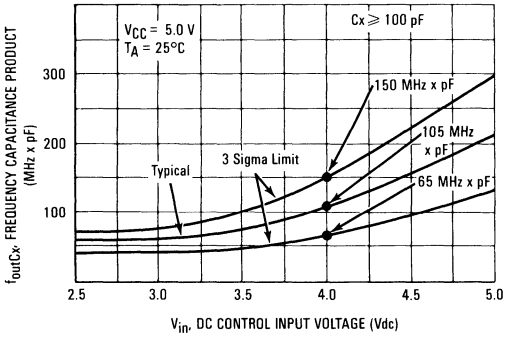
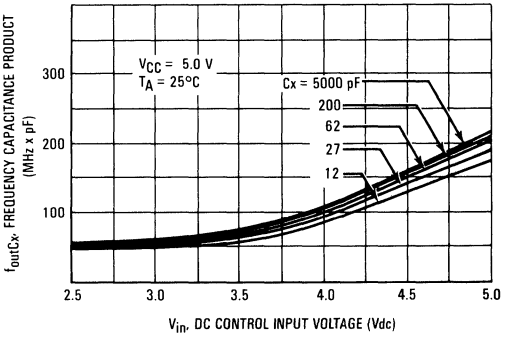


FIGURE 2 — FREQUENCY CAPACITANCE PRODUCT TYPICAL CURVES



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SN74LS783
MC6883

SYNCHRONOUS ADDRESS MULTIPLEXER

LOW POWER SCHOTTKY

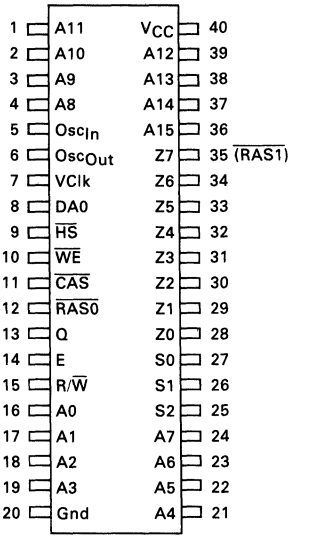
SYNCHRONOUS ADDRESS MULTIPLEXER

The SN74LS783/MC6883 brings together the MC6809E (MPU), the MC6847 (Color Video Display Generator) and dynamic RAM to form a highly effective, compact and cost effective computer and display system.

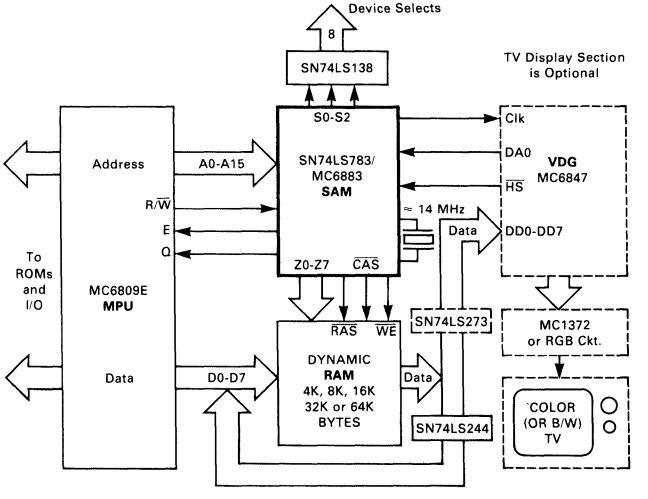
- MC6809E, MC6800, MC6801E, MC68000 and MC6847 (VDG) Compatible
- Transparent MPU/VDG/Refresh
- RAM size — 4K, 8K, 16K, 32K or 64K Bytes (Dynamic or Static)
- Addressing Range — 96K Bytes
- Single Crystal Provides All Timing
- Register Programmable:
  - VDG Addressing Modes
  - VDG Offset (0 to 64K)
  - RAM Size
  - Page Switch
  - MPU Rate (Crystal ÷ 16 or ÷ 8)
  - MPU Rate (Address Dependent or Independent)
- System "Device Selects" Decoded 'On Chip'
- Timing is Optimized for Standard Dynamic RAMs
- +5.0 V Only Operation
- Easy Synchronization of Multiple SAM Systems
- DMA Mode

4

PIN ASSIGNMENT



SYSTEM BLOCK DIAGRAM



MAXIMUM RATINGS (T_A = 25°C unless otherwise noted.)

Rating	Symbol	Value	Unit
Power Supply Voltage	V_{CC}	−0.5 to +7.0	Vdc
Input Voltage (Except Osc_{In})	V_I	−0.5 to 10	Vdc
Input Current (Except Osc_{In})	I_I	−30 to +5.0	mA
Output Voltage	V_O	−0.5 to +7.0	Vdc
Operating Ambient Temperature Range	T_A	0 to +70	°C
Storage Temperature Range	T_{stg}	−65 to +150	°C
Input Voltage Osc_{In}	$V_{IOsc_{In}}$	−0.5 to V_{CC}	Vdc
Input Current Osc_{In}	$I_{IOsc_{In}}$	−0.5 to +5.0	mA

GUARANTEED OPERATING RANGES

Parameter	Symbol	Min	Typ	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	V
Operating Ambient Temperature Range	T_A	0	25	75	°C
Output Current High	I_{OH}				mA
$\overline{RAS0}$, $\overline{RAS1}$, $\overline{CAS}$, $\overline{WE}$		—	—	−1.0	
All Other Outputs		—	—	−0.2	
Output Current Low	I_{OL}				mA
$\overline{RAS0}$, $\overline{RAS1}$, $\overline{CAS}$, $\overline{WE}$		—	—	8.0	
VClk		—	—	0.8	
All Other Outputs		—	—	4.0	

DC CHARACTERISTICS (Unless otherwise noted specifications apply over recommended power supply and temperature ranges.)

Characteristic	Symbol	Min	Typ	Max	Units
Input Voltage — High Logic State	V_{IH}	2.0	—	—	V
Input Voltage — Low Logic State	V_{IL}	—	—	0.8	V
Input Clamp Voltage (V_{CC} = Min, I_{in} = −18 mA) All Inputs Except Osc_{In}	V_{IK}	—	—	−1.5	V
Input Current — High Logic State at Max Input Voltage	I_I				µA
(V_{CC} = Max, V_{in} = 5.25 V) VClk Input		—	—	200	
(V_{CC} = Max, V_{in} = 5.25 V) DA0 Input		—	—	100	
(V_{CC} = Max, V_{in} = 5.25 V Osc_{In} = Gnd) Osc_{Out} Input		—	—	250	
(V_{CC} = Max, V_{in} = 7.0 V) All Other Inputs Except Osc_{In}		—	—	100	
Input Current High Logic State All Inputs Except VClk,	I_{IH}				µA
(V_{CC} = Max, V_{in} = 2.7 V) DA0 Osc_{In}, Osc_{Out}		—	—	20	
Input Current — Low Logic State	I_{IL}				mA
(V_{CC} = Max, V_{in} = 0.4 V) DA0 Input		—	—	−1.2	
(V_{CC} = Max, V_{in} = 0.4 V) VClk Input		—	−30	−60	
(V_{CC} = Max, V_{in} = 0.4 V, Osc_{In} = Gnd) Osc_{Out} Input		—	—	−8	
(V_{CC} = Max, V_{in} = 0.4 V) All Other Inputs Except Osc_{In}		—	—	−.4	
Output Voltage — High Logic State					V
(V_{CC} = Min, I_{OH} = −1.0 mA) $\overline{RAS0}$, $\overline{RAS1}$, $\overline{CAS}$, $\overline{WE}$	$V_{OH(C)}$	3.0	—	—	
(V_{CC} = Min, I_{OH} = −0.2 mA) E, Q	$V_{OH(E)}$	V_{CC} − 0.75	—	—	
(V_{CC} = Min, I_{OH} = −0.2 mA) All Other Outputs	V_{OH}	2.7	—	—	
Output Voltage — Low Logic State					V
(V_{CC} = Min, I_{OL} = 8.0 mA) $\overline{RAS0}$, $\overline{RAS1}$, $\overline{CAS}$, $\overline{WE}$	$V_{OL(C)}$	—	—	0.5	
(V_{CC} = Min, I_{OL} = 4.0 mA) E, Q Outputs	$V_{OL(E)}$	—	—	0.5	
(V_{CC} = Min, I_{OL} = 0.8 mA) VClk Output	$V_{OL(V)}$	—	—	0.6	
(V_{CC} = Min, I_{OL} = 4.0 mA) All Other Outputs	V_{OL}	—	—	0.5	
Power Supply Current	I_{CC}	—	180	230	mA
Output Short-Circuit Current	I_{OS}	30	—	225	mA

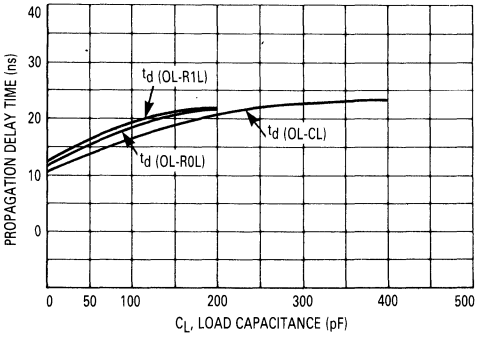
4

AC CHARACTERISTICS (4.75 V≤V_{CC}≤5.25 V and 0≤T_A≤70°C, unless otherwise noted).

Characteristic	Symbol	Min	Typ	Max	Units
Propagation Delay Times					ns
(See Circuit in Figure 9) Oscillator-In ↘ to Oscillator-Out ↗	$t_{d(OL-OH)}$	—	3.0	—	
Oscillator-In ↗ to Oscillator-Out ↘	$t_{d(OH-OL)}$	—	20	—	
(C_L = 195 pF) A0 thru A15 to Z0, Z1, Z2 thru Z7	$t_{d(A-Z)}$	—	28	—	
(C_L = 30 pF) A0 thru A15, R/W to S0, S1, S3	$t_{d(A-S)}$	—	18	—	
(C_L = 95 pF) Oscillator-Out ↘ to $\overline{RAS0}$ ↗	$t_{d(OL-R0H)}$	—	20	—	
(C_L = 95 pF) Oscillator-Out ↘ to $\overline{RAS0}$ ↘	$t_{d(OL-R0L)}$	—	18	—	
(C_L = 95 pF) Oscillator-Out ↘ to $\overline{RAS1}$ ↗	$t_{d(OL-R1H)}$	—	22	—	
(C_L = 95 pF) Oscillator-Out ↘ to $\overline{RAS1}$ ↘	$t_{d(OL-R1L)}$	—	20	—	
(C_L = 195 pF) Oscillator-Out ↘ to $\overline{CAS}$ ↗	$t_{d(OL-CH)}$	—	20	—	
(C_L = 195 pF) Oscillator-Out ↘ to $\overline{CAS}$ ↘	$t_{d(OL-CL)}$	—	20	—	
(C_L = 195 pF) Oscillator-Out ↘ to $\overline{WE}$ ↗	$t_{d(OL-WH)}$	—	22	—	
(C_L = 195 pF) Oscillator-Out ↘ to $\overline{WE}$ ↘	$t_{d(OL-WL)}$	—	40	—	
(C_L = 100 pF) Oscillator-Out ↘ to E ↗	$t_{d(OL-EH)}$	—	55	—	
(C_L = 100 pF) Oscillator-Out ↘ to E ↘	$t_{d(OL-EL)}$	—	25	—	
(C_L = 100 pF) Oscillator-Out ↘ to Q ↗	$t_{d(OL-QH)}$	—	55	—	
(C_L = 100 pF) Oscillator-Out ↘ to Q ↘	$t_{d(OL-QL)}$	—	25	—	
(C_L = 30 pF) Oscillator-Out ↗ to VClk ↗	$t_{d(OH-VH)}$	—	50	—	
(C_L = 30 pF) Oscillator-Out ↗ to VClk ↘	$t_{d(OH-VL)}$	—	65	—	
(C_L = 195 pF) Oscillator-Out ↘ to Row Address	$t_{d(OL-AR)}$	—	36	—	
(C_L = 195 pF) Oscillator-Out ↘ to Column Address	$t_{d(OL-AC)}$	—	33	—	
(C_L = 15 pF) Oscillator-Out ↘ to DA0 ↗ Earliest(1)	$t_{d(OL-DH)}$	—	−15	—	
(C_L = 15 pF) Oscillator-Out ↘ to DA0 ↗ Latest(1)	$t_{d(OL-DH)}$	—	+15	—	
(C_L = 95 pF on $\overline{RAS}$, C_L = 195 pF on $\overline{CAS}$) $\overline{CAS}$ ↘ to $\overline{RAS}$ ↗	$t_{d(CL-RH)}$	—	208	—	
Setup Time for A0 thru A15, R/$\overline{W}$ Rate = ÷16	$t_{su(A)}$	—	28	—	ns
Rate = ÷ 8		—	28		
Hold Time for A0 thru A15, R/$\overline{W}$ Rate = ÷16	$t_{h(A)}$	—	30	—	ns
Rate = ÷ 8		—	30	—	
Width of $\overline{HS}$ Low 2	$t_{WL(HS)}$	2.0	5.0	6.0	µs

Notes: 1. When using the SAM with an MC6847, the rising edge of DA0 is confined within the range shown in the timing diagrams (unless the synchronizing process is incomplete.) The synchronization process requires a maximum of 32 cycles of Osc_{Out} for completion.
2. $t_{WL(HS)}$ wider than 6.0 µs may yield more than 8 sequential refresh addresses.

FIGURE 1 — PROPAGATION DELAY TIMES VERSUS LOAD CAPACITANCE



PIN DESCRIPTION TABLE

		Name	No.	Function
Input Pins	Power	V_{CC}	40	Apply + 5 volts ± 5%. SAM draws less than 230 mA.
		Gnd	20	Return Ground for +5 volts.
	MPU Address and Control	A15	36	Most Significant Bit.
		A14	37	
		A13	38	MPU address bits A0-A15. These 16 signals come directly from the MPU and are used to directly address up to 64K memory locations or to indirectly address up to 96K memory locations. (See pages 17 and 18 for memory maps). Each input is approximately equivalent to one low power Schottky load.
		A12	39	
		A11	1	
		A10	2	
		A9	3	
		A8	4	
		A7	24	
		A6	23	
		A5	22	
		A4	21	
		A3	19	
		A2	18	
		A1	17	
		A0	16	Least Significant Bit.
		R/$\overline{W}$	15	MPU READ or $\overline{WRITE}$. This signal comes directly from the MPU and is used to enable writing to the SAM control register, dynamic RAM (via $\overline{WE}$), and to enable device select #0.
	VDG Control	Osc_{In}	5	Apply 14.31818* MHz crystal and 2.5–30 pF trimmer to ground. See page 12.
		DA0	8	Display Address DA0. The primary function of this pin is to input the least significant bit of a 16-bit video display address. The more significant 15-bits are outputs from an internal 15-bit counter which is clocked by DA0. The secondary function of this pin is to indirectly input the logic level of the VDG "$\overline{FS}$" (field synchronization pulse) for vertical video address updating.
		$\overline{HS}$	9	Horizontal Synchronization. The primary function of this pin is to detect the falling edge of VDG "$\overline{HS}$" pulse in order to initiate eight dynamic RAM refresh cycles. The secondary function is to reset up to 4 least significant bits of the internal video address counter.
		VClk	7	VDG Clock. The primary function of this pin is to **output** a 3.579545 MHz square wave** to the VDG "Clk" pin. The secondary function resets the SAM when this VClk pin is pulled to logic "0" level, acting as an **input.**
Output Pins		Osc_{Out}	6	Apply 1.5 kΩ resistor to 14.31818* MHz crystal and 33 pF capacitor to ground. See page 12.
	Device Selects	S2	25	Most Significant Bit (Device Select Bits). The binary value of S2, S1, S0 selects one of eight "chunks" of MPU address space (numbers 0 through 7). Varying in length, these "chunks" provide efficient memory mapping for ROMs, RAMs, Input/Output devices, and MPU Vectors. (Requires 74LS 138-type demultiplexer).
		S1	26	
		S0	27	Least Significant Bit.
	MPU Clocks	E	14	E (Enable Clock) "E" and "Q" are 90° out of phase and are both used as MPU clocks for the MC6809E. For the MC6800 and MC6801E, only "E" is used. "E" is also used for many MC6800 peripheral chips.
		Q	13	Q (Quadrature Clock).
	RAM Address	Z7†	35	Most Significant Bit
		Z6†	34	First, the least significant address bits from the MPU or "VDG" are presented to Z0–Z5 (4K x 1 RAMs) or Z0–Z6 (16K x 1 RAMs) or Z0–Z7 (64K x 1 RAMs). Next, the most significant address bits from the MPU or "VDG" are presented to Z0–Z5 (4K x 1 RAMs) or Z0–Z6 (16K x 1 RAMs) or Z0–Z7 (64K x 1 RAMs). Note that for 4K x 1 and 16K x 1 RAMs, Z7 (Pin 35) is not needed for address information. Therefore, Pin 35 is used for a second row address select which is labeled ($\overline{RAS1}$).
		Z5†	33	
		Z4†	32	
		Z3†	31	
		Z2†	30	
		Z1†	29	
		Z0†	28	Least Significant Bit.
	RAM Control	$\overline{RAS1}$†	35	Row Address Strobe One. This pulse strobes the least significant 6,7 or 8 address bits into dynamic RAMs in Bank #1.
		$\overline{RAS0}$†	12	Row Address Strobe Zero. This pulse strobes the least significant 6,7 or 8 address bits into dynamic RAMs in Bank #0.
		$\overline{CAS}$†	11	Column Address Strobe. This pulse strobes the most significant 6,7 or 8 address bits into dynamic RAMs.
		$\overline{WE}$†	10	Write Enable. When low, this pulse enables the MPU to write into dynamic RAM.

*14.31818 MHz is 4 times 3.579545 MHz television color subcarrier. Other frequencies may be used. (See page 12.)
**When VDG and SAM are not yet synchronized the "square wave" will stretch (see page 10.)
† Due to fast transitions, ferrite beads in series with these outputs may be necessary to avoid high frequency (≈ 60 MHz) resonances.

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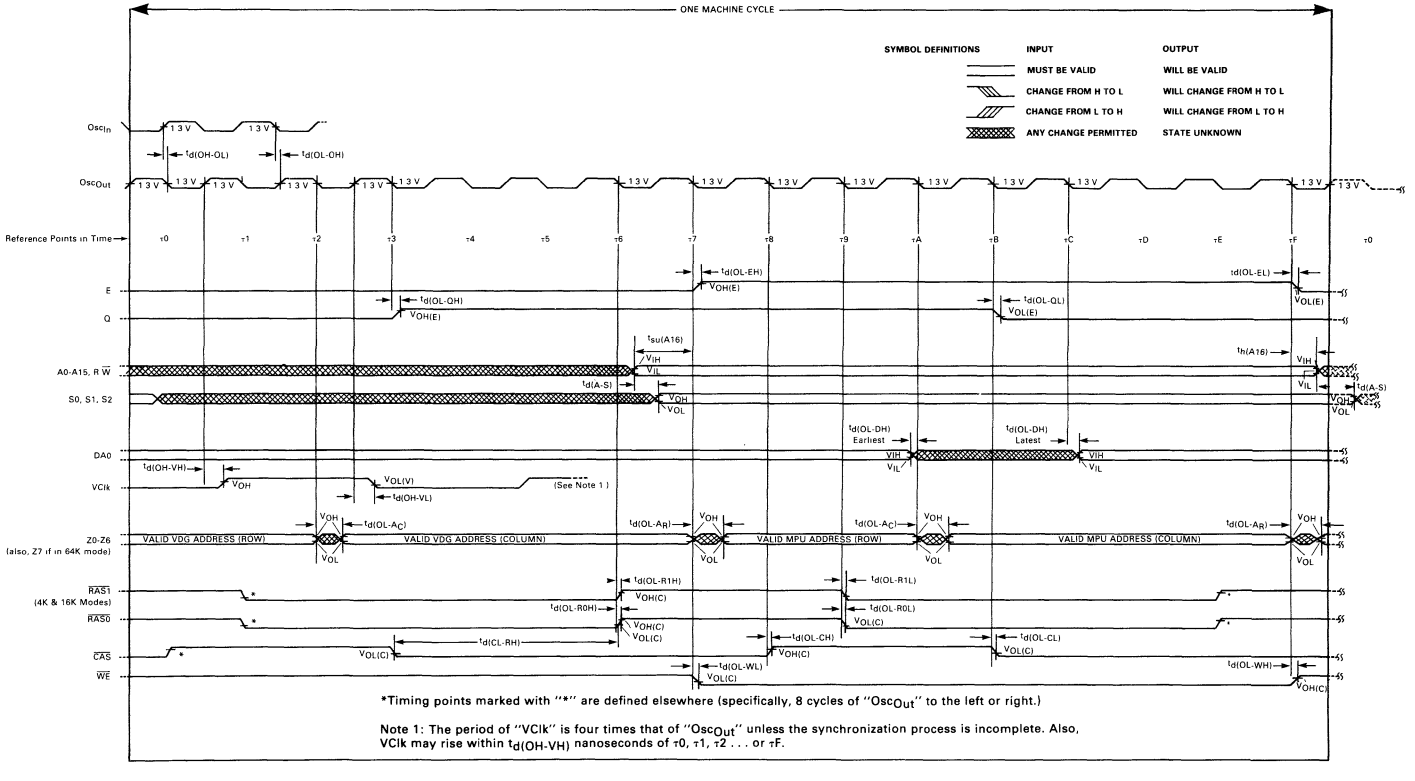
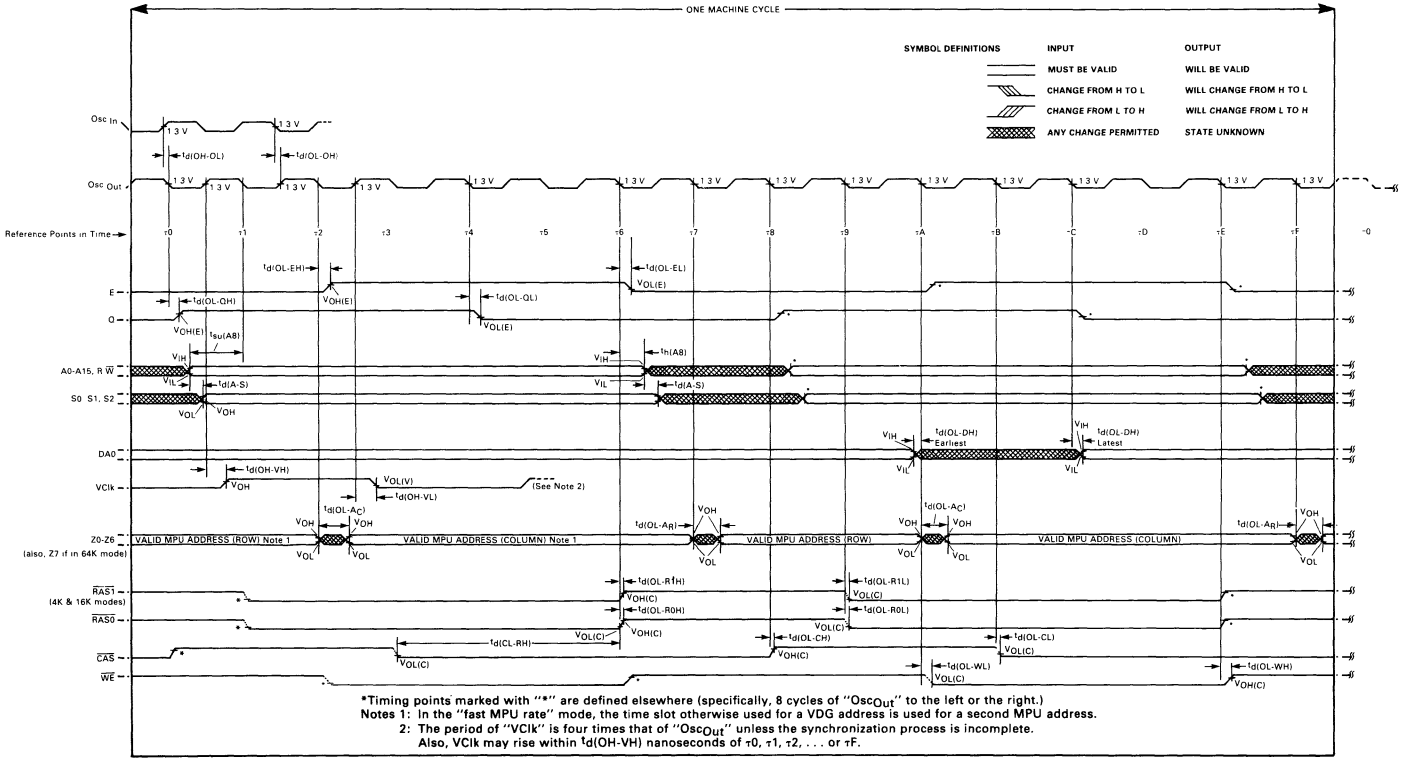
FIGURE 2 — TIMING WAVEFORMS for MPU RATE = SLOW



Timing points marked with "" are defined elsewhere (specifically, 8 cycles of "Osc_{Out}" to the left or right.)

Note 1: The period of "VClk" is four times that of "Osc_{Out}" unless the synchronization process is incomplete. Also, VClk may rise within $t_{d(OH-VH)}$ nanoseconds of τ0, τ1, τ2 . . . or τF.

FIGURE 3— TIMING WAVEFORMS for MPU RATE = FAST



Timing points marked with "" are defined elsewhere (specifically, 8 cycles of "Osc_{Out}" to the left or the right.)

Notes 1: In the "fast MPU rate" mode, the time slot otherwise used for a VDG address is used for a second MPU address.

2: The period of "VClk" is four times that of "Osc_{Out}" unless the synchronization process is incomplete. Also, VClk may rise within $t_{d(OH-VH)}$ nanoseconds of τ0, τ1, τ2, . . . or τF.

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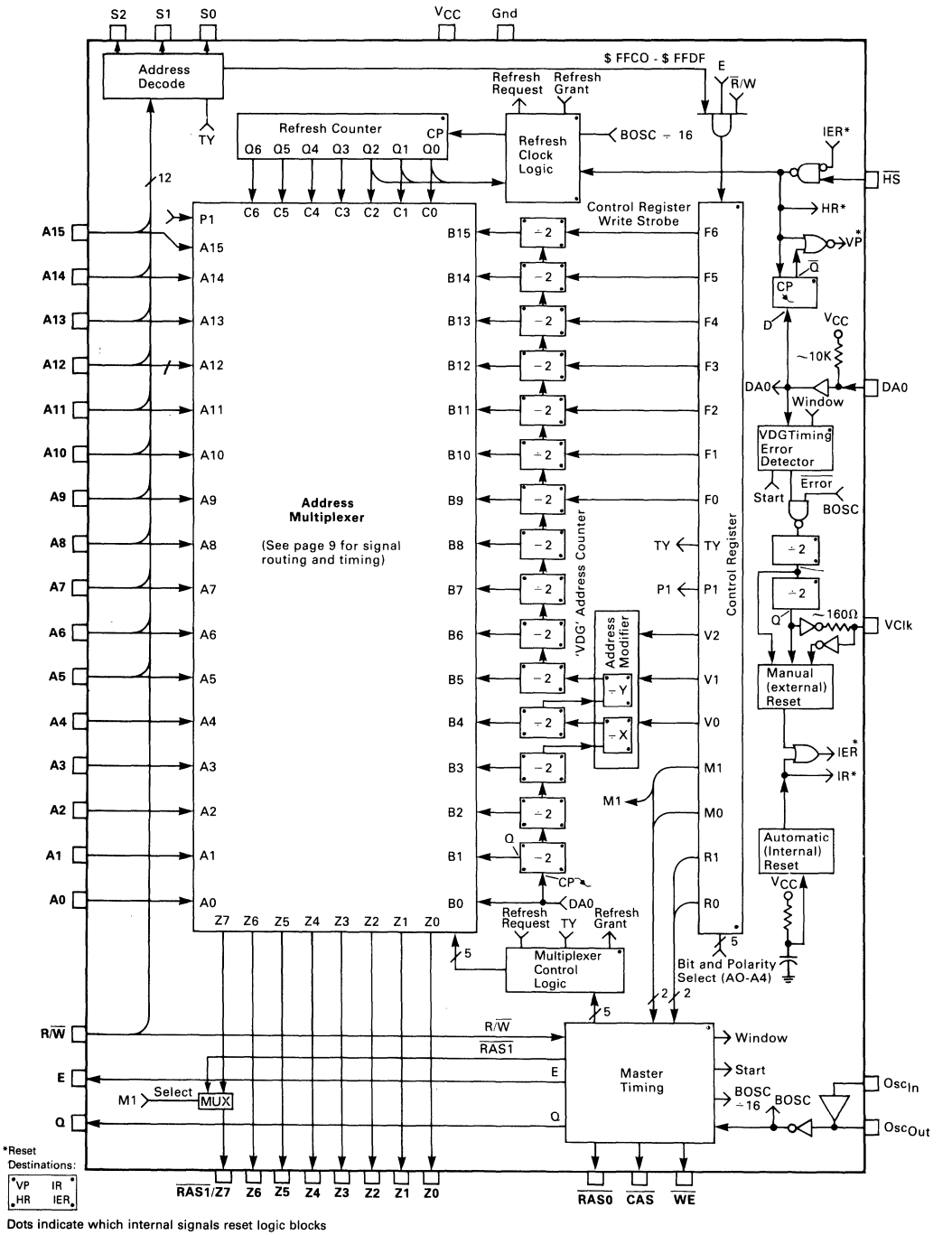
FIGURE 4 — SAM BLOCK DIAGRAM



Dots indicate which internal signals reset logic blocks

SAM BLOCK DIAGRAM DESCRIPTION

MPU Addresses (A0 – A15):

These 16 signals come directly from the MPU and are used to directly address up to 64K memory locations (K = 1024) or to indirectly address up to 96K memory locations, by using a paging bit "P" (see pages 17 and 18 for memory maps.) Each input is approximately equivalent to one low power Schottky load.

VDG Address Counter (B0 – B15):

These 16 signals are derived from one input (DA0) which is the least significant bit of the VDG address. Most of the counter is simply binary. However, to duplicate the various addressing modes of the MC6847 VDG, ADDRESS MODIFIER logic is used. Selected by three VDG mode bits (V2, V1, and V0) from the SAM CONTROL REGISTER, eight address modifications are obtained as shown in Figure 5.

Also, notice that bits B9-B15 may be loaded from bits F0-F6 from the CONTROL REGISTER. This allows the starting address of the VDG display to be offset (in ½K increments) from $0000 to $FFFF†. B9-B15 are loaded when a VERTICAL PRE-LOAD(VP) pulse is generated. VP goes active (high) when $\overline{HS}$ from the VDG rises if DA0 is high (or a high impedance.) This condition should occur only while the TV electron beam is in vertical blanking and is simply implemented by connecting $\overline{FS}$ and $\overline{MS}$ together on the MC6847. The VP pulse also **clears** bits B1 – B8.

Finally, a HORIZONTAL RESET (HR) pulse may also affect the counter by clearing bits B1 – B3 or B1 – B4 when $\overline{HS}$ from the VDG is LOW (see Figure 5.) The HR pulse should occur only while the TV electron beam is in horizontal blanking.

In summary, DA0 clocks the VDG ADDRESS COUNTER; HR initializes the horizontal portion and VP initializes the vertical portion of the VDG ADDRESS COUNTER.

REFresh Address Counter (C0 – C6):

A seven bit binary counter with outputs labeled C0 – C6 supplies bursts of eight* sequential addresses triggered by a $\overline{HS}$ high to low transition. Thus, while the TV electron beam is in horizontal blanking, eight sequential addresses are accessed. Likewise, the next eight addresses are accessed during the next horizontal blanking period, etc. In this manner, all 128 addresses are refreshed in less than 1.1 milliseconds.

Address Multiplexer:

Occupying a large portion of the block diagram in Figure 4, is the address multiplexer which outputs bits Z0-Z7 (as addresses to dynamic RAM's.) Inputs to the address multiplexer include the VDG address (B0 – B15) the REFresh address (C0- C6) and the MPU address (A0 – A15) or (A0 – A14 plus one paging bit "P".) The paging bit "P" is one bit in the SAM CONTROL REGISTER that is used in place of A15 when memory map TYpe #0 is selected (via the SAM CONTROL REGISTER "TY" bit.)

Figure 6 shows which inputs are routed to Z0 – Z7 and **when** the routing occurs relative to one SAM machine cycle. Notice that Z7 and $\overline{RAS1}$ share the same pin. Z7 is selected if "M1" in the SAM CONTROL REGISTER IS HIGH (Memory size = 64K.)

Address Decode:

At the top left of Figure 4, is the Address Decode block. Outputs S2, S1, and S0 form a three bit encoded binary word(S). Thus S may be one of eight values (0 through 7) with each value representing a different range of MPU addresses. (To enable peripheral ROM's or I/O, decode the S2, S1, and S0 bits into eight seperate signals by using a 74LS138, 74LS155 or 74LS156. Notice that S2, S1, and S0 are **not** gated with any timing signals such as E or Q.)

Along with the A5 – A15 inputs is the MEMORY MAP TYpe bit (TY.) This bit is soft-programmable (as are **all** 16 bits in the SAM CONTROL REGISTER,) and selects one of two memory maps. Memory map #0 is intended to be used in systems that are primarily **ROM** based. Whereas, memory map #1 is intended for a primarily **RAM** based system with 64K contiguous RAM locations (minus 256 locations.) The various meanings of S2, S1, S0 are tabulated in Figure 16 (page 19) and again on pages 17 and 18.

In addition to S2, S1, and S0 outputs is a decode of $FFC0 through $FFDF which, when gated with E and $\overline{R/W}$, results in the write strobe for the SAM CONTROL REGISTER.

SAM Control Register

As shown in Figure 4, the CONTROL REGISTER has 16 "outputs":

VDG Addressing Modes:	V2, V1, V0	MPU Rate:	R1, R0
VDG Address OFFset:	F6, F5, F4, F3, F2, F1, F0	Memory Size (RAM):	M1, M0
32K Page Switch:	P	Memory Map TYpe:	TY

When the SAM is reset (see page 10,) all 16 bits are cleared. To **set** any one of these 16 bits, the MPU simply **writes** to a unique** **odd** address (within $FFC1 through $FFDF.) To **clear** any one of these 16 bits, the MPU

* If $\overline{HS}$ is held low longer than 8 μs, then the number of sequential addresses in one refresh "BURST" is proportional to the time interval during which $\overline{HS}$ is low.

** See pages 17 or 18 for specific addresses.

† In this document, the "$" symbol always preceeds hexidecimal characters.

simply writes to a unique** **even** address (within $FFCO through $FFDE.) Note that the **data** on the MPU data bus is irrelevant.

Inputs to the control register include A4, A3, A2, A1 (which are used to select **which one** of 16 bits is to be cleared or set), A0 (which determines the polarity . . . clear or set,) and R/W, E and $FFCO – $FFDF (which restrict the method, timing and addresses for changing one of the 16 bits.) For more detailed descriptions of the purposes of the 16 control bits, refer to related sections in the BLOCK DIAGRAM DESCRIPTION (pages 8 through 12) and the PROGRAMMING GUIDE (pages 14 through 18).

** See pages 17 or 18 for specific addresses.

FIGURE 5 — VDG ADDRESS MODIFIER

Mode			Division Variables		Bits Cleared by $\overline{HS}$ (low)
V2	V1	V0	X	Y	
0	0	0	1	12	B1–B4
0	0	1	3	1	B1–B3
0	1	0	1	3	B1–B4
0	1	1	2	1	B1–B3
1	0	0	1	2	B1–B4
1	0	1	1	1	B1–B3
1	1	0	1	1	B1–B4
1	1	1	1	1	None (DMA MODE)

FIGURE 6 — SIGNAL ROUTING for ADDRESS MULTIPLEXER

Memory Size		Signal	Row/Column	Signals Routed to Z0–Z7								Timing
M1	M0	Source		Z7	Z6	Z5	Z4	Z3	Z2	Z1	Z0	(Figure 2)
4K	**0** **0**	MPU	ROW	*	A6	A5	A4	A3	A2	A1	A0	T7-TA
			COL	*	L	A11	A10	A9	A8	A7	A6	TA-TF
		VDG	ROW	*	B6	B5	B4	B3	B2	B1	B0	TF-T2
			COL	*	L	B11	B10	B9	B8	B7	B6	T2-T7
		REF	ROW	*	C6	C5	C4	C3	C2	C1	C0	TF-T2
			COL	*	L	L	L	L	L	L	L	T2-T7
16K	**0** **1**	MPU	ROW	*	A6	A5	A4	A3	A2	A1	A0	T7-TA
			COL	*	A13	A12	A11	A10	A9	A8	A7	TA-TF
		VDG	ROW	*	B6	B5	B4	B3	B2	B1	B0	TF-T2
			COL	*	B13	B12	B11	B10	B9	B8	B7	T2-T7
		REF	ROW	*	C6	C5	C4	C3	C2	C1	C0	TF-T2
			COL	*	L	L	L	L	L	L	L	T2-T7
64K (dynamic)	**1** **0**	MPU	ROW	A7	A6	A5	A4	A3	A2	A1	A0	T7-TA
			COL	P/A15***	A14	A13	A12	A11	A10	A9	A8	TA-TF
		VDG	ROW	B7	B6	B5	B4	B3	B2	B1	B0	TF-T2
			COL	B15	B14	B13	B12	B11	B10	B9	B8	T2-T7
		REF	ROW	L	C6	C5	C4	C3	C2	C1	C0	TF-T2
			COL	L	L	L	L	L	L	L	L	T2-T7
64K (static)	**1** **1**	MPU	ROW	A7	A6	A5	A4	A3	A2	A1	A0	T7-**T9**
			COL	P/A15***	A14	A13	A12	A11	A10	A9	A8	**T9**-TF
		VDG	ROW	B7	B6	B5	B4	B3	B2	B1	B0	TF-**T1**
			COL	B15	B14	B13	B12	B11	B10	B9	B8	**T1**-T7
		REF	ROW	L	C6	C5	C4	C3	C2	C1	C0	TF-**T1**
			COL	L	L	L	L	L	L	L	L	**T1**-T7

Notes: "L" implies logical LOW level.
*Z7 functions as RAS1 and its level is address dependent. For example, when using two banks of 16K x 1 RAMs, $\overline{RAS0}$ is active for addresses $0000 to $3FFF and $\overline{RAS1}$ is active for addresses $4000 to $7FFF.
***If Map TYpe = 0, then page bit "P" is the output (otherwise A15).

Internal Reset

By lowering V_{CC} below 0.6 volts for at least one millisecond, a **complete** SAM reset is initiated and is completed within 500 nanoseconds after V_{CC} rises above 4.25 volts.

NOTE: In some applications, (for example, multiple "VDG-RAM" systems controlled by a single MPU) **multiple** SAM ICs can be synchronized as follows:

- Drive all SAM's from one external oscillator.
- Stop external oscillator.
- Lower V_{CC} below 0.6 volts for at least 1.0 millisecond.
- Raise V_{CC} to 5.0 volts.
- Start external oscillator.
- Wait at least 500 nanoseconds.

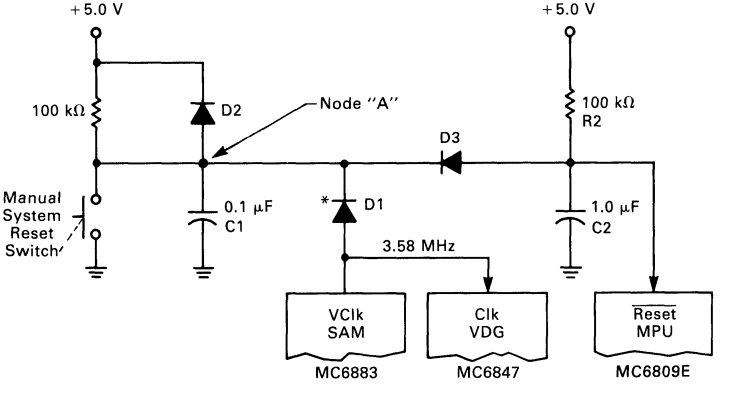
Now, the "E" clocks from all SAM's should be in-phase.

External Reset

When the VClk pin on SAM is forced below 0.8 volts for at least eight cycles of "oscillator-out", the SAM becomes **partially** reset. That is, all bits in the SAM control register are cleared. However, signals such as $\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, E or Q are **not** stopped (as they are with an **internal** reset), since the SAM must maintain dynamic RAM refresh even during this external reset period.

Figure 7 shows how VClk can be pulled low through diode D1 when node "A" is low.* When node "A" is high, only the backbiased capacitance of diode D1 loads the 3.58 MHz on VClk. Diode D2 helps discharge C1 (Power-on-Reset capacitor) when power is turned off. Diode D3 allows the MPU reset time constant R2C2 to be greater than the SAM reset time constant. Thereby, ensuring **release** of the SAM reset **prior to** attempting to program the SAM control register.

FIGURE 7 — EXTERNAL RESET CIRCUITRY



VDG Synchronization

In order for the VDG and MPU to share the same dynamic RAM (see page 13,) the **VDG clock must be stopped** until the VDG data fetch and MPU data fetch are synchronized as shown in Figure 12. Once synchronized, the VDG clock resumes its 3.579545 MHz rate and is not stopped again unless an extreme temperature change (or SAM reset) occurs. When stopped, the VDG clock remains stopped for **no more than** 32 Osc_{Out} cycles (approximately 2 microseconds.)

In the block diagram in Figure 4, DA0 enters a block labeled VDG Timing Error Detector. If DA0 rises **between** time reference points** τ_A and τ_C, then $\overline{Error}$ is high and VClk is the result of dividing BOSC (Buffered Osc_{Out} ≈ 14 MHz) by four. However, if DA0 rises **outside** the time Window τ_A to τ_C, then $\overline{Error}$ goes LOW and the VDG stops. A START pulse at time reference point τ_B (center of Window) restarts the VDG . . . properly synchronized.

*Use a diode with sufficiently low forward voltage drop to meet V_{IL} requirement at VClk.

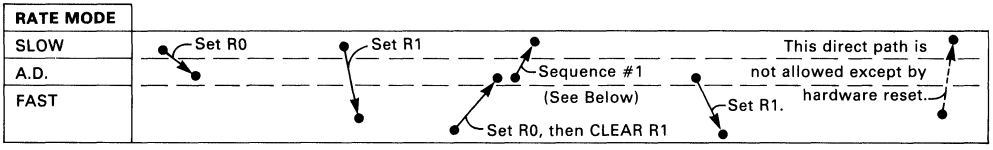
**See timing diagrams on page 5 and 6.

Changing the MPU Rate (by changing SAM control register bits R0, R1).

Two bits in the SAM control register determine the period of both "E" and "Q" MPU clocks. Three rate modes are implemented as follows:

RATE MODE	R1	R0	
SLOW	0	0	The frequency of "E" (and "Q") is f crystal ÷ 16. This rate mode is automatically selected when the SAM is reset. Note that system timing is least critical in this "SLOW" rate mode.
A.D. (Address Dependent)	0	1	The frequency of "E" (and "Q") is either f crystal ÷ 16 or f crystal ÷ 8, depending on the address the MPU is presenting.
FAST	1	X	The frequency of "E" (and "Q") is f crystal ÷ 8. This is accomplished by stealing the time that is normally used for VDG/REFRESH, and using this time for the MPU. Note: Neither VDG display nor dynamic RAM refresh are available in the "FAST" rate mode. (Both are available in SLOW and A.D. rate modes).

When changing between any two of the three rate modes, the following procedures must be followed to ensure that MPU timing specifications are met:



May be ANY address from $0000 to $7FFF.

SEQUENCE #1:

```
7D 00 00  TST #$0000 . . . Synchronizes STA instruction to write during T2-TG (See Figure #8).*
21 00     BRN 00
B7 FF D6  STA #$FFD6 . . . Clears bit R0
```

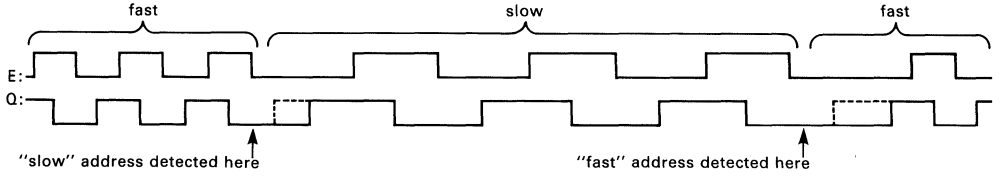
*Note: "TST" instruction affects MC6809E condition code register.

Changing the MPU Rate (In Address Dependent Mode)

When the SAM control register bits "R1", and "R0" are programmed to "0" and "1", respectively, the Address Dependent Rate Mode is selected. In this mode, the ÷ 16 MPU rate is automatically used when addressing within $0000 to $7FFF* or $FF00 to $FF1F ranges. Otherwise the ÷ 8 MPU rate is automatically used. (Refer to Figure 8 for sample "E" and "Q" waveforms yielding ÷ 8 to ÷ 16 and ÷ 16 to ÷ 8 rate changes). This mode often nearly doubles the MPU throughput while still providing transparent VDG and dynamic, RAM refresh functions. For example, since much of the MPU's time may be spent performing internal MPU functions (address = $FFFF)**, accessing ROM (address = $8000 to $FEFF) or accessing I/O (address = $FF20 — $FF5F), the faster f crystal ÷ 8 MPU rate may be used much of the time.

Note: The VDG operates normally when using the SLOW or A.D. rate modes. However, in the FAST rate mode, the VDG is not allowed access to the dynamic RAM.

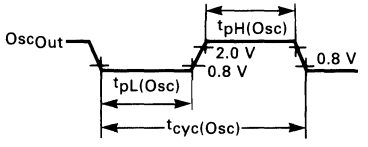
FIGURE 8 — RATE CHANGE E AND Q WAVEFORMS



*When using Memory Map 0, addresses $0000 to $7FFF may access Dynamic RAM.
**The MC6809 outputs $FFFF on A0–A15 when no other valid addresses are being presented.

Oscillator

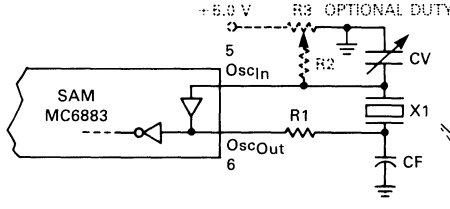
In Figure 4, an amplifier between Osc_{In} and Osc_{Out} provides the gain for oscillation (using a crystal as shown in Figure 9.) Alternately, Pin 5 (Osc_{In}) may be grounded while Pin 6 (Osc_{Out}) may be driven at low-power Schottky levels as shown in Figure 10. Also, see V_{IH}, V_{IL} on page 2.



AC Specifications*

	Max	Typ	Min	Units
$t_{pH(Osc)}$	—	30	22	ns
$t_{pL(Osc)}$	—	30	22	ns
$t_{cyc(Osc)}$	—	70	62.4	ns

FIGURE 9 — CRYSTAL OSCILLATOR



Suggested Component Values

Freq. MHz	CV*	CF*	R1*	R2*	R3*	X1
14.31818	2.5–30 pF	33 pF	1.5 kΩ	~ 100K	10K	*
16.0000	2.5–30 pF	33 pF	1.5 kΩ	~ 100K	10K	*

Recommended Crystal Parameters

	14.31818 MHz**	16.0000 MHz**
R_S	10 Ω ± 2.0 Ω	10 Ω ± 2.0 Ω
CO	5.0 pF ± 1.5 pF	6.0 pF ± 1.0 pF
C1	0.0245 pF ± 15%	0.0319 pF ± 15%
L1	5.05 mH	3.1 mH
Q	50K ± 10K	40K ± 10K

Calibration Tolerance: 0.002% at 26°C
Temperature Tolerance: 0.001% 0°C to 70°C

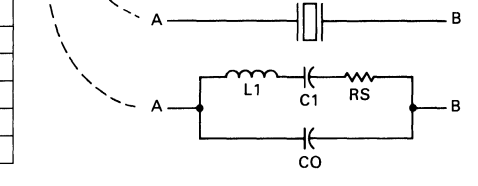
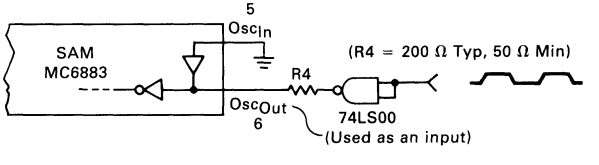


FIGURE 10 — TTL CLOCK INPUT



Typical input capacitances are 3.0 pF for Pin 5 and 5.5 pF for Pin 6.

*Optimum values depend on characteristics of the crystal (X1). For many applications, VClk must be 3.579545 MHz ± 50 Hz! Hence, Osc_{Out} must be made similarly "drift resistant" (by balancing temperature coefficients of X1, CV, CF, R1, R2 and R3).

**Specifically cut for MC6883 are International Crystal Manufacturing, Inc. Crystals (#167568 for 14.31818 MHz or #167569 for 16.0 MHz). However, other crystals may be used.

THEORY OF OPERATION

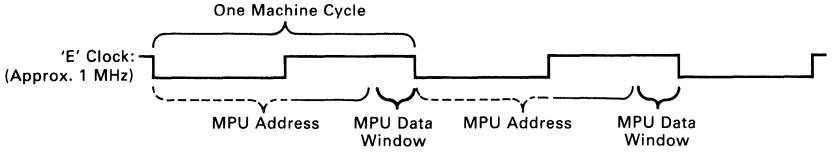
Video or No Video

Although the MC6883 may be used as a dynamic RAM controller **without** a video display*, most applications are likely to include a MC6847 video display generator (VDG). Therefore, this document emphasizes MC6883 with MC6847 systems.

Shared RAM (with interleaved DMA)

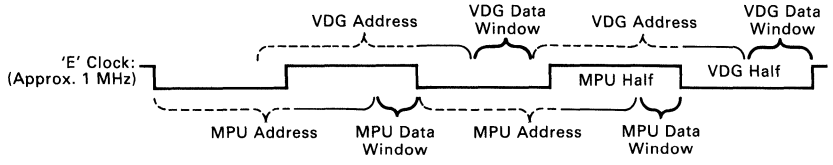
To minimize the number of RAM and interface chips, both the MPU and VDG share common dynamic RAM. Yet, the use of common RAM creates an apparent difficulty. That is, the MPU and VDG must both access the RAM without contention. This difficulty is overcome by taking advantage of the timing and architecture of Motorola MPU's (MC6800, MC6801E, MC6809E, MC68000). Specifically, **all** MPU accesses of external memory **always** occur in the **latter half** of the machine cycle, as shown below:

FIGURE 11 — MOTOROLA MPU TIMING



Similarly, the MC6847 (non-interlaced) VDG transfers a data byte in a half machine cycle (E or Φ2). Thus, when properly positioned, VDG and MPU RAM accesses interleave without contention as shown below:

FIGURE 12 — MOTOROLA MPU WITH VDG TIMING



This Interleaved Direct Memory Access (IDMA) is synchronized via the MC6883 by centering the VDG data window half-way between MPU data windows.**

The result is a shared RAM system without MPU/VDG RAM access contention, with both MPU and VDG running uninterrupted at normal operating speed, each transparent to the other.

RAM Refresh

Dynamic RAM refresh is accomplished by accessing eight*** sequential addresses every 64*** microseconds until 128 consecutive addresses have been accessed. To avoid RAM access contention between REFRESH and MPU, each of the 128 refresh accesses occupies the "VDG half" of the interleaved DMA (IDMA). Furthermore, refresh accesses occur only during the television retrace period (at which time the VDG doesn't need to access RAM).

In summary, the VDG, MPU and MC6883's Refresh Counter all transparently access the common dynamic RAM without contention or interruption.

Why IDMA?

Use of the interleaved direct memory access results in fast modification to variable portions of display RAM, by the MPU, without any distracting flashes on the screen (due to RAM access contention.) In addition, the MPU is not slowed down nor stopped by the MC6883; thereby, assuring accurate software timing loops without costly additional hardware timers. Furthermore, additional hardware and software to give "access permission" to the MPU is eliminated since the MPU may access RAM at **any** time.

* Only 1 pin, (DA0) out of 40 pins is dedicated to the video display.
** See VDG synchronization (page 10) for more detail.
*** When not using a MC6847, $\overline{HS}$ may be wired low for continuous transparent refresh.

"Systems On Silicon" Concept

Total Timing

For most applications, the SAM can supply complete system timing from its on-chip precision 14.31818 MHz oscillator. This includes buffered MPU clocks (E and Q), VDG clock, color subcarrier (3.58 MHz), row address select ($\overline{RAS}$), column address select ($\overline{CAS}$) and write enable ($\overline{WE}$).

Total Address Decode

For most applications, the SAM plus a "1 of 8 decoder" chip completely decodes I/O, ROM and RAM chip selects without wasting memory address space and without needlessly chopping-up contiguous address space. Chip selects are positioned in address space to allow three types of memory (RAM, local ROM and cartridge ROM) independent room for growth. For example, RAM may grow from address $0000-up, cartridge ROM may grow from address $FEFF-down and local ROM may grow from $FBFF-down. Alternately, if the application requires minimum ROM and maximum contiguous RAM, a second choice of two memory maps places RAM from $0000 to $FEFF. (See pages 17 and 18.)

In both memory maps all I/O, MPU vectors, SAM control registers, and some reserved address spaces are efficiently contained between addresses $FF00 and $FFFF.

How Much RAM?

Using nine SAM pins (Z0 – Z7 and $\overline{RAS0}$) the following combinations require no additional address logic.

FIGURE 13 — RAM CONFIGURATIONS

Address: MSB LSB	Chip Select:	
Z5Z4Z3Z2Z1Z0	$\overline{RAS0}$	One or two banks of 4K x 8 (like MCM4027's)
Z5Z4Z3Z2Z1Z0	$\overline{RAS1}$ (=Z7)	
Z6Z5Z4Z3Z2Z1Z0	$\overline{RAS0}$	One or two banks of 16K x 8 (like MCM4116's)
Z6Z5Z4Z3Z2Z1Z0	$\overline{RAS1}$ (=Z7)	
Z7Z6Z5Z4Z3Z2Z1Z0	$\overline{RAS0}$	One bank of 64K x 8 (like MCM6665's)

4

PROGRAMMING GUIDE

SAM — Programmability

The SAM contains a 16-bit control register which allows the MC6809E to program the SAM for the following options:

VDG Addressing Mode	3-bits
VDG Address Offset	7-bits
32K Page Switch	1-bit
MPU Rate	2-bits
Memory Size	2-bits
Map Type	1-bit

Note that when the SAM is **reset** by first applying power or by manual hardware reset,† all control register bits are **cleared** (to a logic "0").

VDG Addressing Mode

Three bits (V2, V1, V0) control the sequence of DISPLAY ADDRESSES generated by the SAM (which are used to scan dynamic RAM for video information). For example, if you wish to display Dynamic RAM data as INTERNAL ALPHANUMERICS VIDEO, you should program‡ the MC6847 for the INTERNAL ALPHANUMERICS MODE **and** CLEAR BITS V2, V1 and V0 in the SAM. The table on the following page summarizes the available modes:

† See Figure 7 for manual reset circuit.
‡ Typically, part of a PIA (MC6821) at location $FF22 is used to control MC6847 modes. (See MC6847 Data Sheet.)

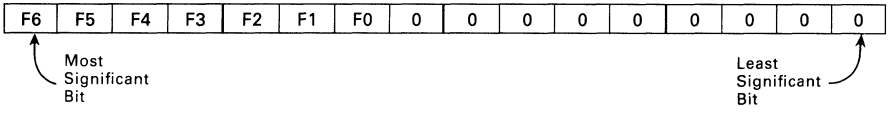
Mode Type	MC6847 Mode					SAM Mode		
	G/$\overline{A}$	GM2	GM1	GM0 EXT/$\overline{I}$	CSS	V2	V1	V0
Internal Alphanumerics	0	X	X	0	X	0	0	0
External Alphanumerics	0	X	X	1	X	0	0	0
OSemigraphics — 4	0	X	X	0	X	0	0	0
Semigraphics — 6	0	X	X	1	X	0	0	0
Semigraphics — 8*	0	X	X	0	X	0	1	0
Semigraphics — 12*	0	X	X	0	X	1	0	0
Semigraphics — 24*	0	X	X	0	X	1	1	0
Full Graphics — 1C	1	0	0	0	X	0	0	1
Full Graphics — 1R	1	0	0	1	X	0	0	1
Full Graphics — 2C	1	0	1	0	X	0	1	0
Full Graphics — 2R	1	0	1	1	X	0	1	1
Full Graphics — 3C	1	1	0	0	X	1	0	0
Full Graphics — 3R	1	1	0	1	X	1	0	1
Full Graphics — 6C	1	1	1	0	X	1	1	0
Full Graphics — 6R	1	1	1	1	X	1	1	0
Direct Memory Access†	X	X	X	X	X	1	1	1

*S8, S12, & S24 modes are **not** described in the MC6847 Data Sheet. See appendix "A".
†DMA is identical to 6R except as shown in Figure 5 on page 9.

4

VDG Address Offset

Seven bits (F6, F5, F4, F3, F2, F1 and F0) determine the **Starting Address** for the video display. The "Starting Address" is defined as "the address corresponding to data displayed in the **Upper Left** corner of the TV screen". The "Starting Address" is shown below in binary:



Note that the "Starting Address" may be placed anywhere within the 64K address space with a resolution of ½K (the size of one alphanumeric page).
The F6–F0 bits take effect during the TV vertical synchronization pulse (i.e., when $\overline{FS}$ from MC6847 is low).

Page Switch

One bit (P1) is used "in place of" A15 from the MC6809E in order to refer access within $0000-$7FFF to one of two 32K byte **pages** of RAM. If the system does **not** use more than 32K bytes of RAM, P1 can be ignored.**

**When using 4K x 1 RAMS, two banks of eight IC's are allowed. This accounts for Addresses $0000-1FFF. Also, this same RAM can be addressed at $2000-$3FFF, $4000-$5FFF and $6000-$7FFF.

MPU Rate

Two bits (R1, R0) control the clock rate to the MC6809E MPU. The options are:

RATE (FREQUENCY OF "E" CLOCK)	R1	R0
0.9 MHz (Crystal Frequency ÷ 16) Slow	0	0
0.9/1.8 MHz (Address Dependent Rate)	0	1
1.8 MHz (Crystal Frequency ÷ 8) Fast	1	X
(Typical Crystal Frequency = 14.31818 MHz)		

In the "address dependent rate" mode, accesses to $0000-$7FFF and $FF00-$FF1F are slowed to 0.9 MHz (crystal frequency ÷ 16) and all other addresses are accessed at 1.8 MHz (crystal frequency ÷ 8.)
Note: "Slow" (0.9 MHz) operation can be accomplished using 1.0 MHz MC6809E and MC6821 devices. For "Fast" (1.8 MHz) operation, 2.0 MHz MC68B09E and MC68B21 devices must be used.

Memory Size

Two bits (M1 and M0) determine RAM memory size. The options are:

SIZE	M1	M0
One or two banks of 4K × 1 dynamic RAMs	0	0
One or two banks of 16K × 1 dynamic RAMs	0	1
One bank of 64K × 1 dynamic RAMs	1	0
Up to 64K static RAM*	1	1

*Requires a latch for demultiplexing the RAM address.

IMPORTANT!

Note: Be sure to program the SAM for the correct memory size **before** using RAM (i.e., for a subroutine stack).

Map Type

One bit (TY) is used to select between two memory map configurations.
Refer to pages 17, 18 and 19 for details. Early versions of the SAM did not allow the "Fast" MPU rate to be used in conjunction with Map Type "TY = 1". Devices manufactured after January 1, 1983 allow both "Fast" and "Slow" MPU rates to be used with Map Type "TY = 1." (Date of manufacture is marked on devices as YYWW where YY is the year and WW is the week of manufacture.)

Writing To The SAM Control Register

Any bit in the control register (CR) may be set by writing to a specific unique address. Each bit has two unique addresses . . . writing to the **even** # address **clears** the bit and writing to the **odd** # address **sets** the bit. (Data on the data bus is irrelevant in this procedure.) The specific addresses are tabulated on pages 17 and 18.
If desired, a short routine may be written to program the SAM CR "a word at a time". For example, the following routine copies "B" bits from "A" register to SAM CR addresses beginning with address "X".

SAM1	46		ROR	A
	24	06	BCC	SAM2
	30	01	INX	(LEAX1,X)
	A7	80	STA	O,X+
	20	02	BRA	SAM3
SAM2	A7	81	STA	O,X++
SAM3	5A		DEC	B
	26	F2	BNE	SAM1
	39		RTS	

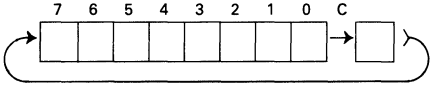
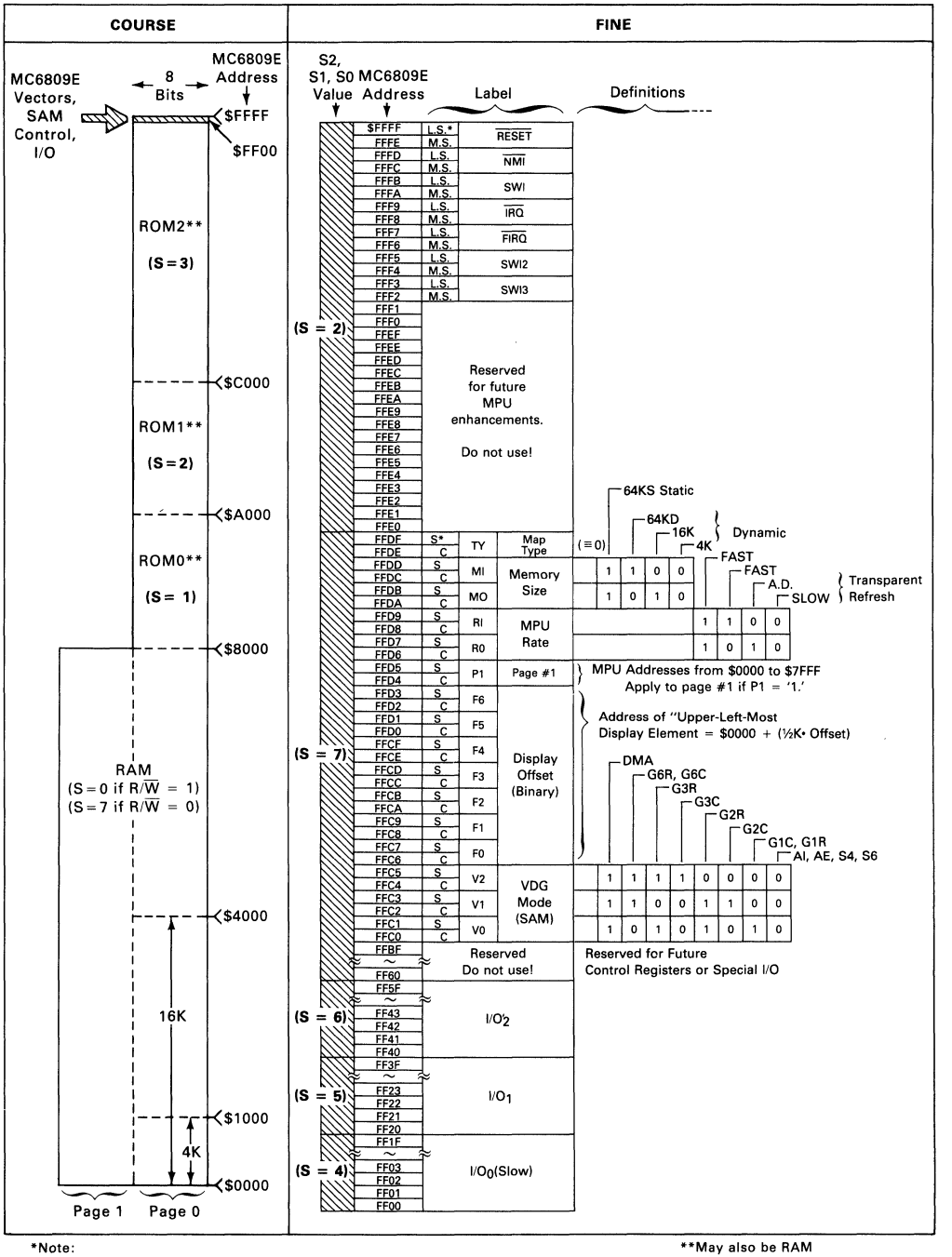


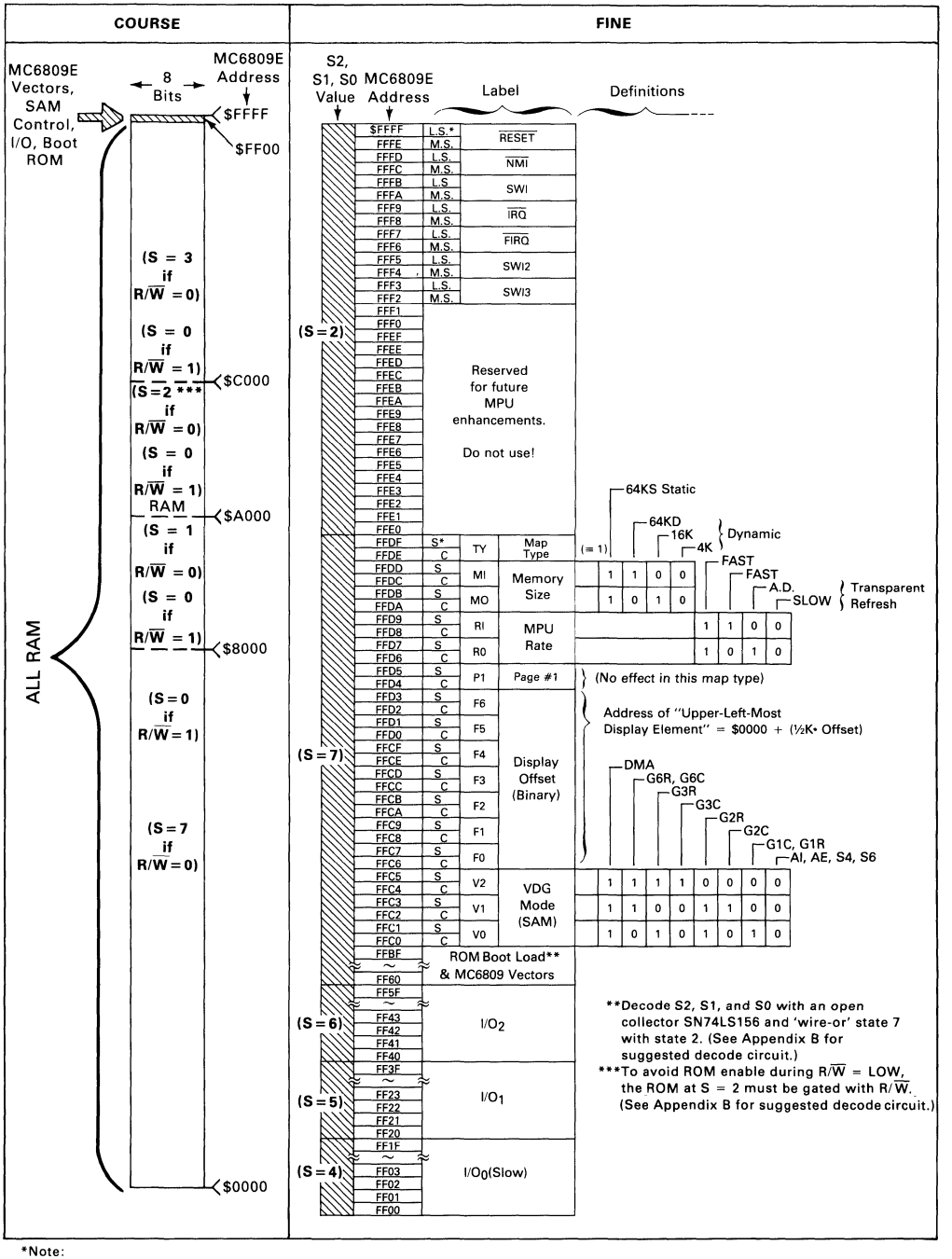
FIGURE 14 — MEMORY MAP (TYPE #0)



*Note:
M.S. = Most Significant
L.S. = Least Significant
S = Set Bit
C = Clear Bit
(All bits are cleared when SAM is reset.)
S = Device Select value = 4 x S2 + 2 x S1 + 1 x S0

**May also be RAM

FIGURE 15 — MEMORY MAP (TYPE #1)



*Note:
M.S. = Most Significant
L.S. = Least Significant
S = Set Bit
C = Clear Bit
(All bits are cleared when SAM is reset.)
S = Device Select value = 4 x S2 + 2 x S1 + 1 x S0

FIGURE 16 — MEMORY ALLOCATION TABLE
(Also, see the memory MAPs on pages 17 and 18.)

Type # 0: (Primarily for ROM based systems)

Address Range	S=4(S2)+2 (S1)+S0 S Value	Intended Use
$FFF2 to FFFF	2	MC6809E Vectors: $\overline{\text{Reset}}$, $\overline{\text{NMI}}$, SWI, $\overline{\text{IRQ}}$, $\overline{\text{FIRQ}}$, SWI2, SWI3.
FFE0 to FFF1	2	Reserved for future MPU enhancements.
FFC0 to FFDF	7	SAM Control Register: V0, – V2, F0 – F6, P, R0, R1, M0, M1, TY.
FF60 to FFBF	7	Reserved for future control register enhancements.
FF40 to FF5F	6	I/O_2: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A0 – A4.
FF20 to FF3F	5	I/O_1: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A0 – A4.
FF00 to FF1F	4	I/O_0: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A0 – A4.
C000 to FEFF	3	ROM2: 16K addresses. External cartridge ROM*.
A000 to BFFF	2	ROM1: 8K addresses. Internal ROM*. Note that MC6809E vector addresses select this ROM*.
8000 to 9FFF	1	ROM0: 8K addresses. Internal ROM*.
0000 to 7FFF	0 if R/$\overline{\text{W}}$ = 1 7 if R/$\overline{\text{W}}$ = 0	RAM: 32K addresses. RAM shared by MPU and VDG.

*Not restricted to ROM. For example, RAM or I/O may be used here.

Type # 1: (Primarily for RAM based systems)

Address Range	S=4(S2)+2 (S1)+S0 S Value	Intended Use
$FFF2 to FFFF	2	MC6809E Vectors: $\overline{\text{Reset}}$, $\overline{\text{NMI}}$, SWI, $\overline{\text{IRQ}}$, $\overline{\text{FIRQ}}$, SWI2, SWI3.
FFE0 to FFF1	2	Reserved for future MPU enhancements.
FFC0 to FFDF	7	SAM Control Register: V0 – V2, F0 – F_6, P, R0, R1, M0, M1, TY.
FF60 to FFBF	7	Small ROM: Boot load program and initial MC6809 vectors.
FF40 to FF5F	6	I/O_2: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A0-A4.
FF20 to FF3F	5	I/O_1: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A0 – A4.
FF00 to FF1F	4	I/O_0: Input/Output (PIAs, ACIAs, etc.) To subdivide, use A2 – A4.
0000 to FEFF	0 if R/$\overline{\text{W}}$ = 1	RAM: 64K(–256) addresses, shared by MPU and VDG. (If R/$\overline{\text{W}}$ = 0 then S = 3 for $C000–$FEFF; S = 2 for $A000–$BFFF; S = 1 for $8000–$9FFF and S = 7 for $0000–$7FFF.)

APPENDIX A

VDG/SAM Video Display System Offers 3 New Modes

by

Paul Fletcher

There are three new modes created when the VDG and SAM are used together in a video display system. These modes offer alphanumeric compatibility with 8 color low-to-high resolution graphics, 64Hx64V, 64Hx96V, 64Hx192V. The new modes S8, S12, and S24 are created by placing the VDG in the Alpha Internal mode and having the SAM in a 2K, 3K or 6K full color graphics mode. In all modes the VDG's S/$\overline{A}$ and Inv. pins are connected to data bits DD7 and DD6 to allow switching on the fly between Alpha and Semigraphics and between inverted and non-inverted alpha. This method is used in most VDG systems to obtain maximum flexibility.

The three modes divide the standard 8*12 dot box used by the VDG for the standard alpha and semigraphics modes into eight 4*3 dot boxes for the S8 mode, twelve 4*2 dot boxes for the S12 mode, and twenty-four 4*1 dot boxes for the S24 mode. Figure 17 shows the arrangement of these boxes. One byte is needed to control two horizontally consecutive boxes. It therefore takes four bytes for the S8, six bytes for the S12, and 12 bytes for the S24 mode to control the entire 8*12 dot box. These two horizontally consecutive boxes have four combinations of luminance controlled by bits B0 – B3. For convenience B2 should be made equal to B0 and B3 should be made equal to B1. This eliminates a screen placement problem which would cause other codes to change patterns when moved vertically on the screen. The illuminated boxes can be one of eight colors which are controlled by B4 – B6 (see Figure 18). The bytes needed to control all the boxes in the 8*12 dot box must be spaced 32 address spaces apart in the display RAM because of the addressing scheme orginally used in the VDG and duplicated by the SAM. This means to place an alphanumeric character on the TV screen it requires 4, 6, or 12 bytes depending on the mode used. These bytes are placed 32 memory locations apart in the display RAM (see Figure 18). This multiple byte format allows the mixing of character rows of different characters in the same 8*12 dot box creating new characters and symbols. It also allows overlining and underlining in eight colors by switching to semigraphics at the correct time.

These new modes optimize the memory versus screen density tradeoffs for RF performance on color TVs. This could make them the most versatile of all the modes depending on the users creativity and the software sophistication.

4

APPENDIX B
Memory Decode for "MAP TYPE = 1"

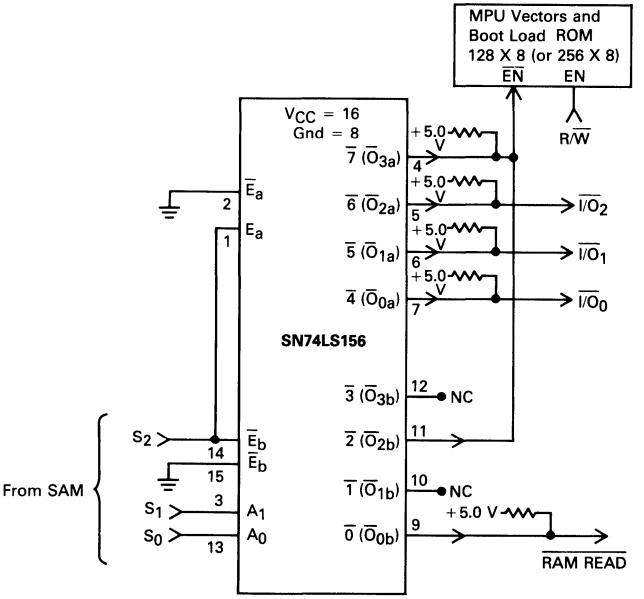
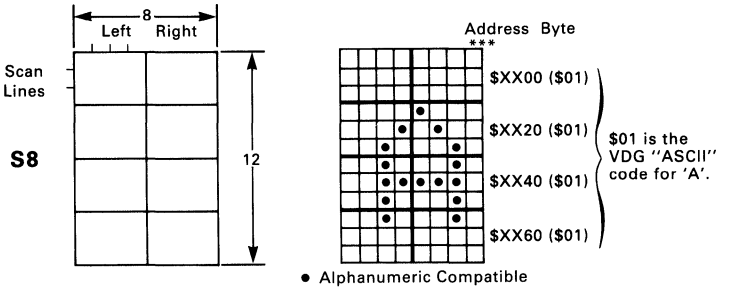
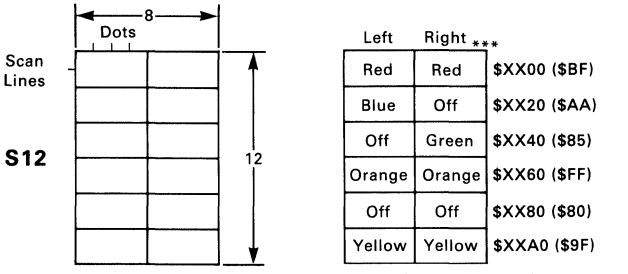


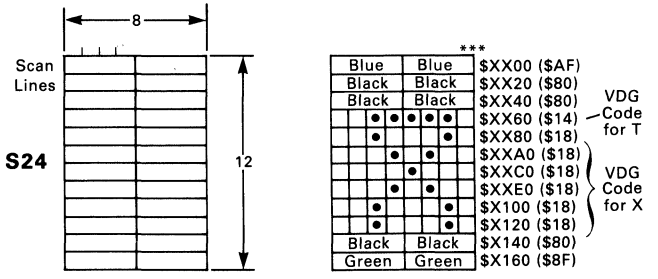
FIGURE 17 — DISPLAY MODES S8, S12, S24
Bit/Visible Dot Correlation



• Alphanumeric Compatible



• Options: One of 8 colors for L or R or both. Off = Black

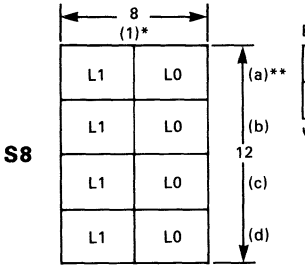


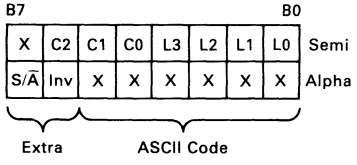
• Underline, Overline

• Mix Character Dot Rows

*** Characters will always remain in standard VDG positions.

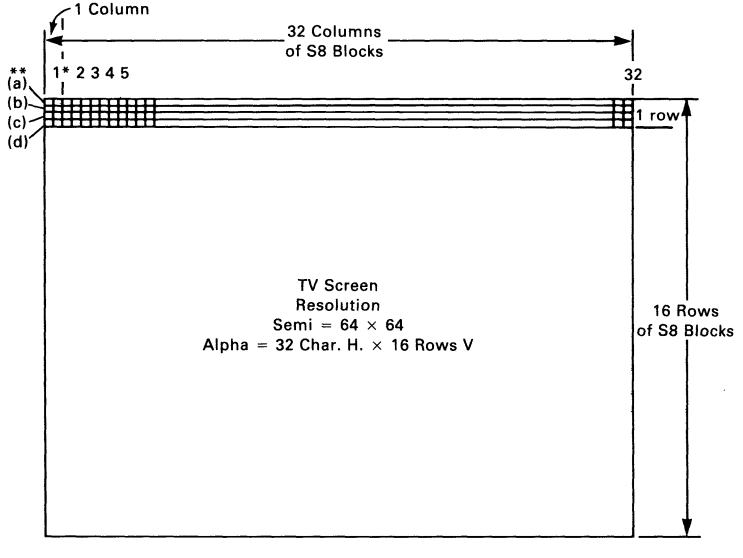
FIGURE 18 — S8 DISPLAY FORMAT EXAMPLES





LX	C2	C1	C0	Color
0	X	X	X	Black
1	0	0	0	Green
1	0	0	1	Yellow
1	0	1	0	Blue
1	0	1	1	Red
1	1	0	0	Buff
1	1	0	1	Cyan
1	1	1	0	Magenta
1	1	1	1	Orange

B3,B1	B2,B0		4	
0	0	=	Off	Off
0	1	=	Off	Color
1	0	=	Color	Off
1	1	=	Color	



S8 Screen Memory Map

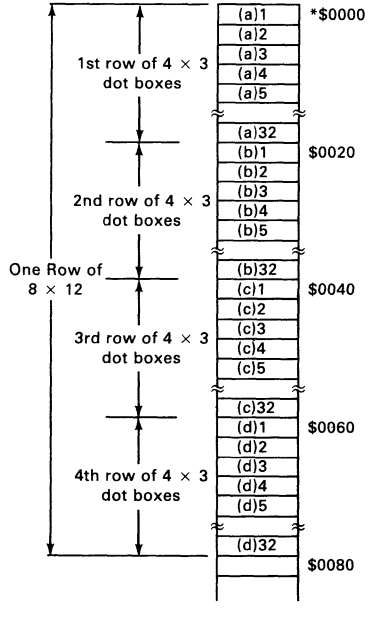
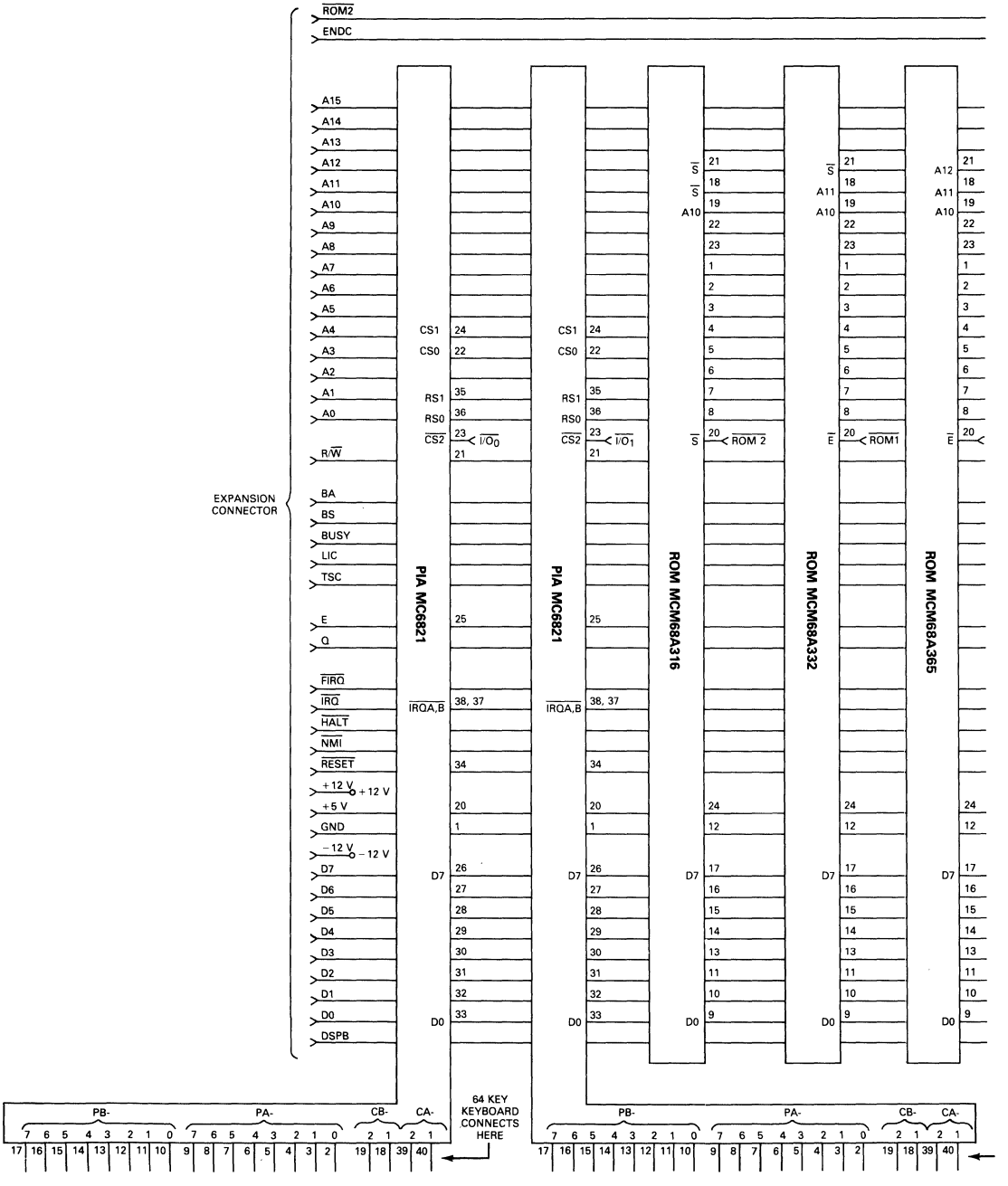
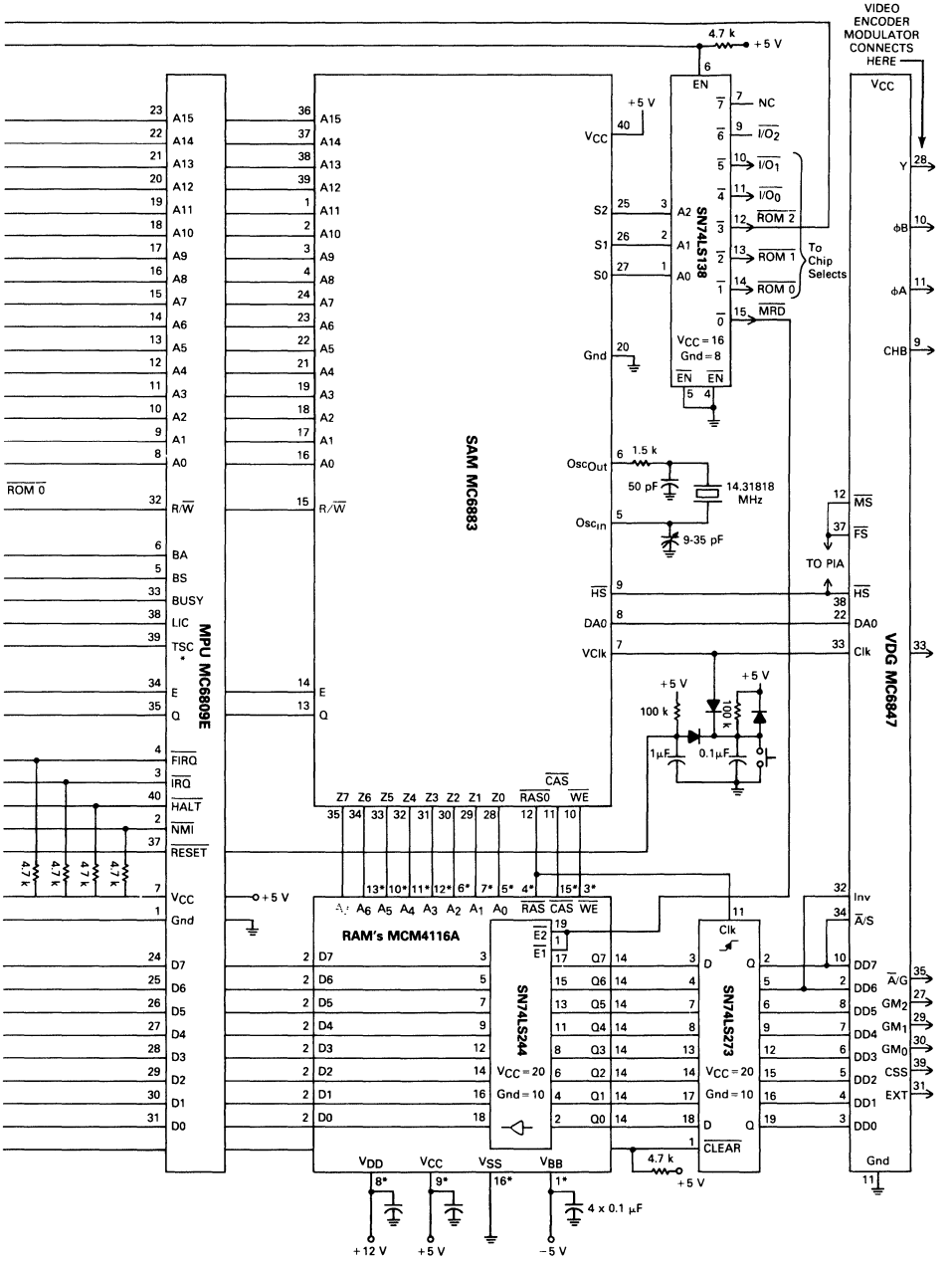


FIGURE 19 — EXAMPLE of MC6809E, MC6883 and MC6847 COMPUTER





MC6847 Mode Control & Misc I/O connects here.

*This pin number on 8 different RAM chips is connected to this point.

FIGURE 20 — EQUIVALENT OF OSCILLATOR INPUT AND OUTPUT

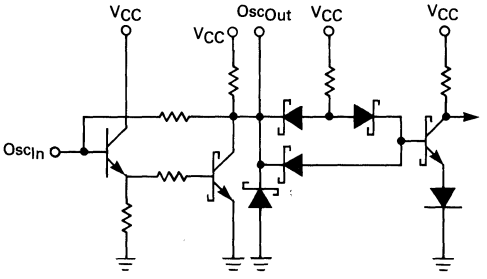


FIGURE 21 — DA0 INPUT

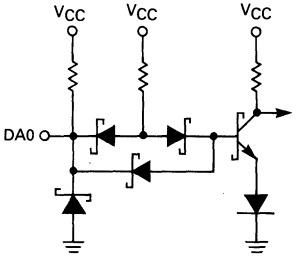


FIGURE 22 — VCIk INPUT/OUTPUT

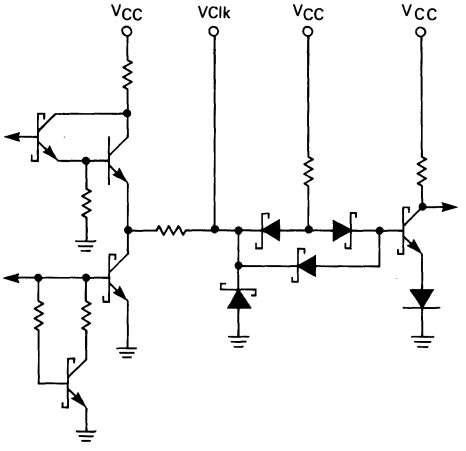


FIGURE 23 — E AND Q OUTPUTS

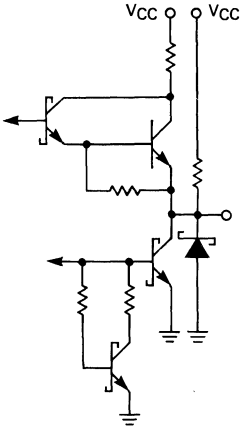


FIGURE 24 — TYPICAL INPUT

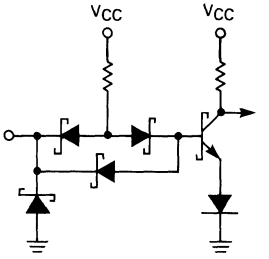
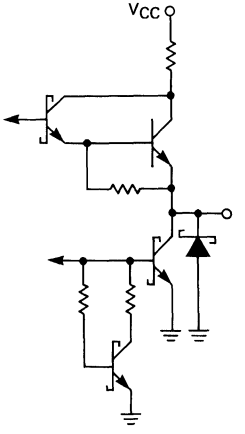


FIGURE 25 — TYPICAL OUTPUT



4

MOTOROLA

SN54LS/74LS795
SN54LS/74LS796
SN54LS/74LS797
SN54LS/74LS798

TRI-STATE OCTAL BUFFERS

LOW POWER SCHOTTKY

DESCRIPTION — The SN54LS/74LS795 thru SN54LS/74LS798 device types provide a second source for the 71/81LS95 thru 71/81LS98 series. These devices are octal low power Schottky versions of the 70/8095 thru 70/8098 3-STATE Hex Buffers. The LS795 and LS797 are noninverting and the LS796 and LS798 are inverting functions. On each buffer, one of the two inputs is used as a control line to gate the output into the high impedance state, while the other input passes the data through the buffer. On the LS795 and LS796 access is through a 2-input NOR gate, with all eight 3-STATE enable lines common. On the LS797 and LS798, four buffers are enabled from one common line and the other four buffers from another common line. On all device types the 3-STATE condition is achieved by applying a high logic level to the enable pins.

TRUTH TABLES

LS795

INPUTS			OUTPUT
$\overline{G}1$	$\overline{G}2$	A	Y
H	X	X	Z
X	H	X	Z
L	L	H	H
L	L	L	L

LS796

INPUTS			OUTPUT
$\overline{G}1$	$\overline{G}2$	A	Y
H	X	X	Z
X	H	X	Z
L	L	H	L
L	L	L	H

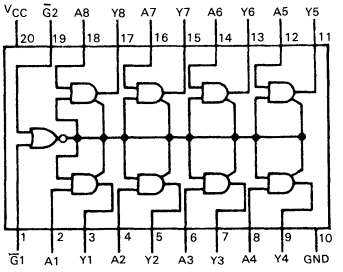
LS797

INPUTS		OUTPUT
$\overline{G}$	A	Y
H	X	Z
L	H	H
L	L	L

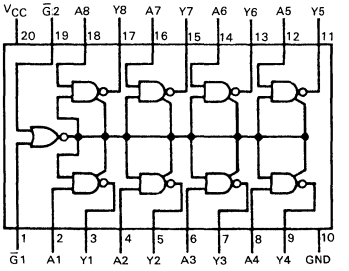
LS798

INPUTS		OUTPUT
$\overline{G}$	A	Y
H	X	Z
L	H	L
L	L	H

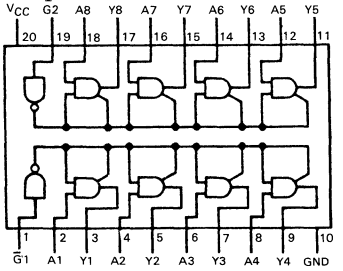
LOGIC DIAGRAMS



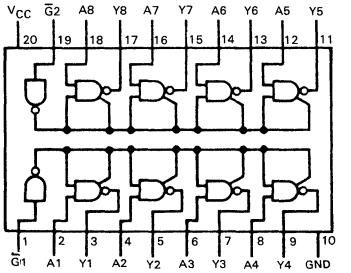
SN54LS/74LS795



SN54LS/74LS796



SN54LS/74LS797



SN54LS/74LS798

J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

4

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54 74			−2.6 −5.0	mA
I_{OL}	Output Current — Low	54 74			8.0 16	mA

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage for All Inputs
V_{IL}	Input LOW Voltage	54			0.7	V	Guaranteed Input LOW Voltage for All Inputs
		74			0.8		
V_{IK}	Input Clamp Diode Voltage			−0.65	−1.5	V	V_{CC} = MIN, I_{IN} = −18 mA
V_{OH}	Output HIGH Voltage	54	2.5	3.5		V	V_{CC} = MIN, I_{OH} = MAX
		74	2.7	3.5		V	
V_{OL}	Output LOW Voltage	54,74		0.25	0.4	V	I_{OL} = 8.0 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
		74		0.35	0.5	V	I_{OL} = 16 mA; V_{CC} = V_{CC} MIN, V_{IN} = V_{IL} or V_{IH} per Truth Table
I_{OZH}	Output Off Current—High				20	μA	V_{CC} = MAX, V_{OUT} = 2.4 V
I_{OZL}	Output Off Current—Low				−20	μA	V_{CC} = MAX, V_{OUT} = 0.4 V
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V
					−0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V
I_{IL}	Input LOW Current A Input, Both $\overline{G}$ at 0.4 V $\overline{G}$ Input				−0.36 −0.36	mA	V_{CC} = MAX, V_{IN} = 0.4 V
	A Input, Both $\overline{G}$ at 2.0 V				−20	μA	V_{CC} = MAX, V_{IN} = 0.5 V
I_{OS}	Short Circuit Current		−30		−130	mA	V_{CC} = MAX
I_{CC}	Power Supply Current	LS795/LS797			26	mA	V_{CC} = MAX
		LS796/LS798			21	mA	

AC CHARACTERISTICS: T_A = 25°C

SYMBOL	PARAMETER	LS795/LS797 MIN	LS795/LS797 TYP	LS795/LS797 MAX	LS796/LS798 MIN	LS796/LS798 TYP	LS796/LS798 MAX	UNITS	TEST CONDITIONS
t_{PLH} t_{PHL}	Propagation Delay		11 15	16 22		6.0 13	10 17	ns	V_{CC} = 5.0 V C_L = 15 pF
t_{PZH} t_{PZL}	Output Enable Time		16 13	25 20		17 16	27 25	ns	
t_{PHZ} t_{PLZ}	Output Disable Time		13 19	20 27		13 18	20 27	ns	C_L = 5.0 pF

SCHOTTKY TTL

ALS Data Sheets

5

description

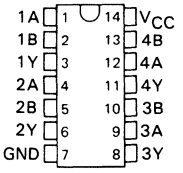
These devices contain four independent 2-input NAND gates. They perform the boolean functions $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

The SN54ALS00 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS00 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

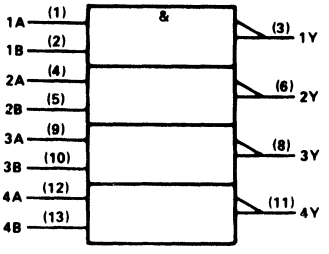
INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

(TOP VIEW)



J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS00 . . . . . −55 °C to 125 °C
SN74ALS00 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS00			SN74ALS00			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS00			SN74ALS00			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC} −2						V
		I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.80			0.80	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			2.2			2.2	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS00	SN54ALS00		SN74ALS00	
			TYP	MIN	MAX	MIN	MAX
t_{PLH}	A or B	Y	4	3	14	3	13	ns
t_{PHL}	A or B	Y	3	2	11	2	9	ns

5

description

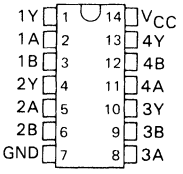
These devices contain four independent 2-input NOR gates. They perform the boolean functions $Y = \overline{A+B}$ or $Y = \overline{A} \cdot \overline{B}$ in positive logic.

The SN54ALS02 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS02 is characterized for operation from 0 °C to 70 °C.

FUNCTION TABLE (each gate)

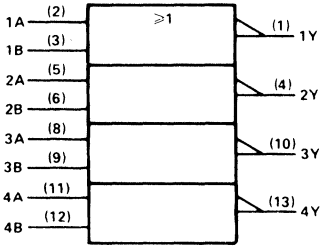
INPUTS		OUTPUT
A	B	Y
H	X	L
X	H	L
L	L	H

(TOP VIEW)



J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS02 . . . . . −55 °C to 125 °C
SN74ALS02 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS02			SN74ALS02			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS02			SN74ALS02			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC}−2						V
		I_{OH} = −0.4 mA				V_{CC}−2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			1.6			1.6	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			2.7			2.7	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS02	SN54ALS02		SN74ALS02	
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	6	3	16	3	15	ns
t_{PHL}	A or B	Y	5	3	14	3	11	ns

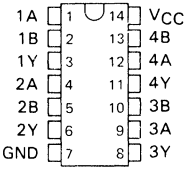
5

description

These devices contain four independent 2-input NAND gates. They perform the boolean functions $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS03 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS03 is characterized for operation from 0°C to 70°C.

(TOP VIEW)



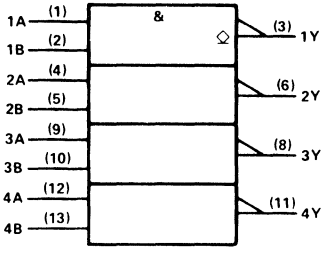
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS03 . . . . . −55 °C to 125 °C
SN74ALS03 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS03			SN74ALS03			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS03			SN74ALS03			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.8			0.8	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			2.2			2.2	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS03	SN54ALS03		SN74ALS03		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	8	3	20	3	15	ns
t_{PHL}	A or B	Y	12	5	26	5	22	ns

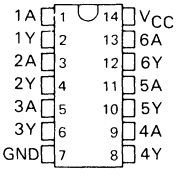
5

description

These devices contain six independent inverters. They perform the boolean function $Y = \overline{A}$.

The SN54ALS04 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS04 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)

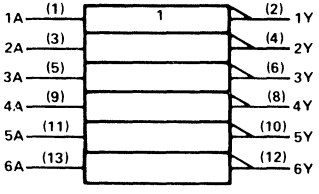


J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE
(each inverter)

INPUT A	OUTPUT Y
H	L
L	H

logic symbol



Pin numbers shown are for J and N packages

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS04 . . . . . −55 °C to 125 °C
SN74ALS04 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS04			SN74ALS04			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS04			SN74ALS04			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC}−2						V
		I_{OH} = −0.4 mA				V_{CC}−2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			1.2			1.2	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			3.3			3.3	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS04	SN54ALS04		SN74ALS04	
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	4	3	15	3	14	ns
t_{PHL}	A	Y	3	2	10	2	10	ns

5

description

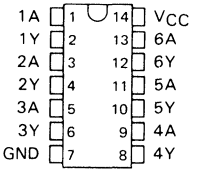
These devices contain six independent inverters. They perform the boolean function $Y = \overline{A}$. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS05 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS05 is characterized for operation from 0 °C to 70 °C.

FUNCTION TABLE (each inverter)

INPUT A	OUTPUT Y
H	L
L	H

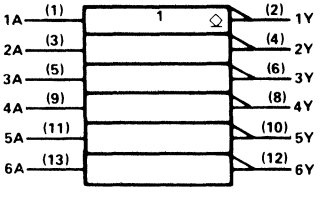
(TOP VIEW)



J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS05 . . . . . −55 °C to 125 °C
SN74ALS05 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS05			SN74ALS05			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS05			SN74ALS05			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			1.2			1.2	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			3.3			3.3	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS05	SN54ALS05		SN74ALS05		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	13	5	26	5	22	ns
t_{PHL}	A	Y	8	4	23	4	19	ns

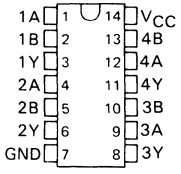
5

description

These devices contain four independent 2-input AND gates. They perform the boolean functions $Y = A \cdot B$ or $Y = \overline{\overline{A} + \overline{B}}$ in positive logic.

The SN54ALS08 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS08 is characterized for operation from 0°C to 70°C.

(TOP VIEW)



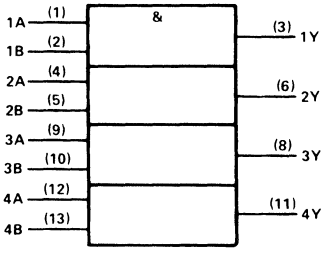
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	H
L	X	L
X	L	L

5

logic symbol



Pin numbers shown are for J and N packages

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS08 . . . . . −55°C to 125°C
SN74ALS08 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

		SN54ALS08			SN74ALS08			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS08			SN74ALS08			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC} −2						V
		I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 4.5 V			2.4			2.4	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 0 V			4.4			4.4	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25°C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

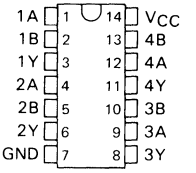
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25°C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS08	SN54ALS08		SN74ALS08	
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	8	4	17	4	17	ns
t_{PHL}	A or B	Y	5	3	14	3	13	ns

description

These devices contain four independent 2-input AND gates. They perform the boolean functions $Y = A \cdot B$ or $Y = \overline{\overline{A} + \overline{B}}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS09 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS09 is characterized for operation from 0°C to 70°C.

(TOP VIEW)



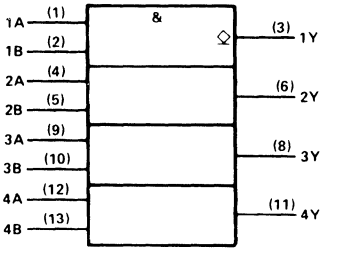
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS		OUTPUT
A	B	Y
H	H	H
L	X	L
X	L	L

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS09 . . . . . −55 °C to 125 °C
SN74ALS09 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS09			SN74ALS09			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS09			SN74ALS09			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 4.5 V			2.4			2.4	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 0 V			4.4			4.4	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS09	SN54ALS09		SN74ALS09		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	15	9	35	9	30	ns
t_{PHL}	A or B	Y	13	7	25	7	20	ns

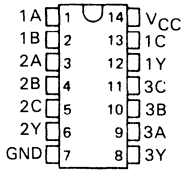
5

description

These devices contain three independent 3-input NAND gates. They perform the boolean functions $Y = \overline{A \cdot B \cdot C}$ or $Y = \overline{A} + \overline{B} + \overline{C}$ in positive logic.

The SN54ALS10 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS10 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



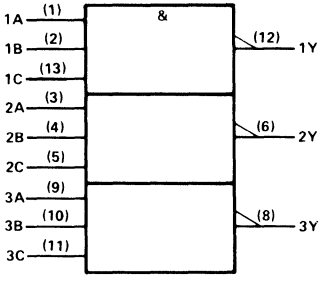
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS			OUTPUT
A	B	C	Y
H	H	H	L
L	X	X	H
X	L	X	H
X	X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS10 . . . . . −55 °C to 125 °C
SN74ALS10 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS10			SN74ALS10			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS10			SN74ALS10			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC}−2						V
		I_{OH} = −0.4 mA				V_{CC}−2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.6			0.6	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.65			1.65	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS10	SN54ALS10		SN74ALS10	
			TYP	MIN	MAX	MIN	MAX
t_{PLH}	Any	Y	4	3	17	3	15	ns
t_{PHL}	Any	Y	10	4	18	4	18	ns

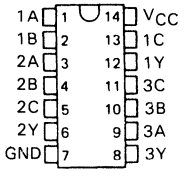
5

description

These devices contain three independent 3-input AND gates. They perform the boolean functions $Y = A \cdot B \cdot C$ or $Y = \overline{\overline{A} + \overline{B} + \overline{C}}$ in positive logic.

The SN54ALS11 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS11 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



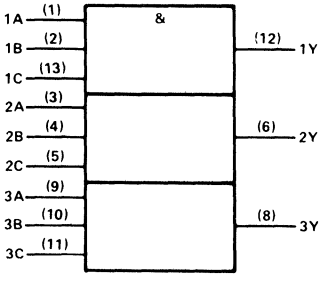
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS			OUTPUT
A	B	C	Y
H	H	H	H
L	X	X	L
X	L	X	L
X	X	L	L

5

logic symbol



Pin numbers shown are for J and N packages

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS11 . . . . . −55°C to 125°C
SN74ALS11 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

		SN54ALS11			SN74ALS11			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS11			SN74ALS11			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC}-2						V
		I_{OH} = −0.4 mA				V_{CC}-2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.8			1.8	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 0 V			3.3			3.3	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25°C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25°C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			'ALS11	SN54ALS11		SN74ALS11		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	12	5	23	5	20	ns
t_{PHL}	Any	Y	6	3	13	3	13	ns

5

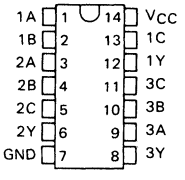
TYPES SN54ALS12, SN74ALS12
TRIPLE 3-INPUT POSITIVE-NAND GATES
WITH OPEN-COLLECTOR OUTPUTS

description

These devices contain three independent 3-input NAND gates with open-collector outputs. These gates perform the boolean functions $Y = \overline{A \cdot B \cdot C}$ or $Y = \overline{A} + \overline{B} + \overline{C}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS12 is characterized for operation over the full military range of −55 °C to 125 °C. The SN74ALS12 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



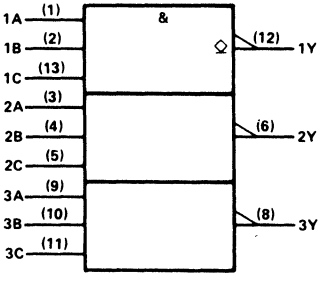
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS			OUTPUT
A	B	C	Y
H	H	H	L
L	X	X	H
X	L	X	H
X	X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS12 . . . . . −55 °C to 125 °C
SN74ALS12 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS12			SN74ALS12			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS12			SN74ALS12			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.7			0.7	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.65			1.65	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS12	SN54ALS12		SN74ALS12		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	14	8	35	8	35	ns
t_{PHL}	Any	Y	14	6	35	6	30	ns

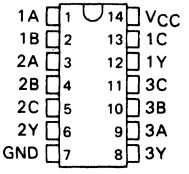
5

description

These devices contain three independent 3-input AND gates with open-collector outputs. These gates perform the boolean functions $Y = A \cdot B \cdot C$ or $Y = \overline{\overline{A}+\overline{B}+\overline{C}}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS15 is characterized for operation over the full military range of −55 °C to 125 °C. The SN74ALS15 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



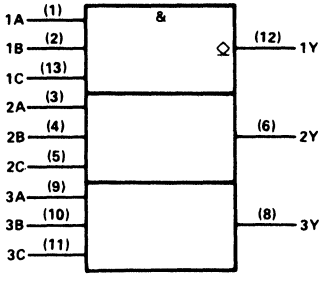
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS			OUTPUT
A	B	C	Y
H	H	H	H
L	X	X	L
X	L	X	L
X	X	L	L

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS15 . . . . . −55 °C to 125 °C
SN74ALS15 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS15			SN74ALS15			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS15			SN74ALS15			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.8			1.8	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 0 V			3.3			3.3	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS15	SN54ALS15		SN74ALS15		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	15	6	30	6	30	ns
t_{PHL}	Any	Y	15	6	35	6	35	ns

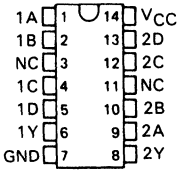
5

description

These devices contain two independent 4-input NAND gates. They perform the boolean functions $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ in positive logic.

The SN54ALS20 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS20 is characterized for operation from 0°C to 70°C.

(TOP VIEW)



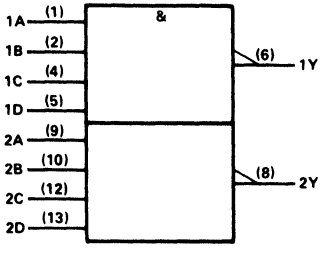
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS20 . . . . . −55 °C to 125 °C
SN74ALS20 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS20			SN74ALS20			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS20			SN74ALS20			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC} −2						V
		I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.4			0.4	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.1			1.1	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

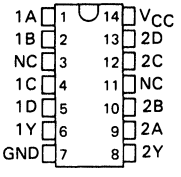
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS20	SN54ALS20		SN74ALS20	
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	4	3	16	3	15	ns
t_{PHL}	Any	Y	4	3	17	3	16	ns

description

These devices contain two independent 4-input AND gates. They perform the boolean functions $Y = A \cdot B \cdot C \cdot D$ or $Y = \overline{\overline{A} + \overline{B} + \overline{C} + \overline{D}}$ in positive logic.

The SN54ALS21 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS21 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



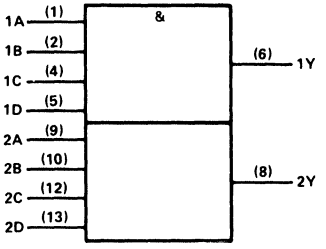
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	H
L	X	X	X	L
X	L	X	X	L
X	X	L	X	L
X	X	X	L	L

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS21 . . . . . −55 °C to 125 °C
SN74ALS21 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS21			SN74ALS21			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS21			SN74ALS21			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC} -2						V
		I_{OH} = −0.4 mA				V_{CC} -2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.2			1.2	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 0 V			2.2			2.2	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2 25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			'ALS21	SN54ALS21		SN74ALS21		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	12	6	24	6	24	ns
t_{PHL}	Any	Y	5	3	15	3	15	ns

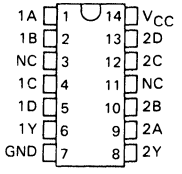
5

description

These devices contain two independent 4-input NAND gates. These gates perform the boolean functions $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS22 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS22 is characterized for operation from 0°C to 70°C.

(TOP VIEW)



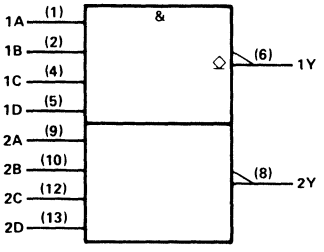
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS22 . . . . . −55 °C to 125 °C
SN74ALS22 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS22			SN74ALS22			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS22			SN74ALS22			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			0.4			0.4	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			1.1			1.1	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 2 kΩ, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 2 kΩ, T_A = MIN to MAX				UNIT
			'ALS22	SN54ALS22		SN74ALS22		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	14	6	35	6	25	ns
t_{PHL}	Any	Y	11	4	25	4	20	ns

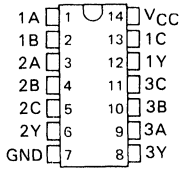
5

description

These devices contain three independent 3-input NOR gates. They perform the boolean functions $Y = \overline{A+B+C}$ or $Y = \overline{A} \cdot \overline{B} \cdot \overline{C}$ in positive logic.

The SN54ALS27 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS27 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



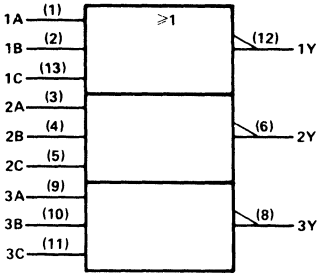
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS			OUTPUT
A	B	C	Y
H	X	X	L
X	H	X	L
X	X	H	L
L	L	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS27 . . . . . −55 °C to 125 °C
SN74ALS27 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS27			SN74ALS27			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS27			SN74ALS27			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		I_{OH} = −0.4 mA	V_{CC} -2						V
		I_{OH} = −0.4 mA				V_{CC} -2			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			2.0			2.0	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			3.4			3.4	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25 °C	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX			UNIT
			'ALS27	SN54ALS27		SN74ALS27	
			TYP	MIN	MAX	MIN	MAX
t_{PLH}	Any	Y	9	4	27	4	27	ns
t_{PHL}	Any	Y	3	3	11	3	11	ns

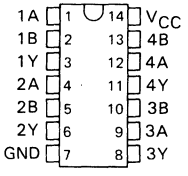
5

description

These devices contain four independent 2-input NAND buffer gates. They perform the boolean functions $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

The SN54ALS37 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS37 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)

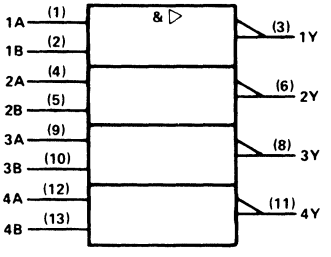


J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

logic symbol



Pin numbers shown are for J and N packages

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS37 . . . . . −55 °C to 125 °C
SN74ALS37 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS37			SN74ALS37			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−1				mA
							−2.6	
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS37			SN74ALS37			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}	V_{CC} = 4.5 V,	I_{OH} = −1 mA	2.4	3.3					V
	V_{CC} = 4.5 V,	I_{OH} = −2.6 mA				2.4	3.2		
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			1.0			1.0	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			6.0			6.0	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS37		SN74ALS37		
			MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	2	10	2	9	ns
t_{PHL}	A or B	Y	3	13	3	11	ns

5

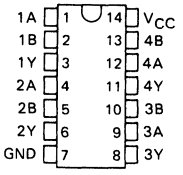
TYPES SN54ALS38, SN74ALS38
QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS WITH OPEN-COLLECTOR OUTPUTS

description

These devices contain four independent 2-input NAND buffer gates with open-collector outputs. These NAND buffers perform the boolean functions $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS38 is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS38 is characterized for operation from 0 °C to 70 °C.

(TOP VIEW)



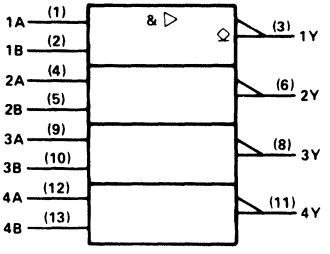
J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

FUNCTION TABLE (each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

5

logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Off-state output voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS38 . . . . . −55°C to 125°C
SN74ALS38 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

		SN54ALS38			SN74ALS38			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS38			SN74ALS38			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
I_{OH}	V_{CC} = 4.5 V,	V_{OH} = 5.5 V			0.1			0.1	mA
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_{IL} = 0.4 V			−0.1			−0.1	mA
I_{CCH}	V_{CC} = 5.5 V,	V_I = 0 V			1.0			1.0	mA
I_{CCL}	V_{CC} = 5.5 V,	V_I = 4.5 V			6.0			6.0	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25°C.

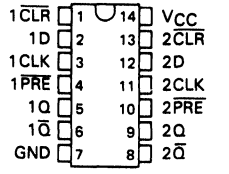
switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 680 Ω, T_A = MIN to MAX				UNIT
			SN54ALS38		SN74ALS38		
			MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	6	28	6	23	ns
t_{PHL}	A or B	Y	6	21	6	18	ns

5

TYPES SN54ALS74, SN74ALS74 DUAL D-TYPE POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH CLEAR AND PRESET

(TOP VIEW)



J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

description

These devices contain two independent D-type positive-edge-triggered flip-flops. A low level at the Preset or Clear inputs sets or resets the outputs regardless of the levels of the other inputs. When Preset and Clear are inactive (high), data at the D input meeting the setup time requirements are transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold time interval, data at the D input may be changed without affecting the levels at the outputs.

The SN54ALS74 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS74 is characterized for operation from 0°C to 70°C.

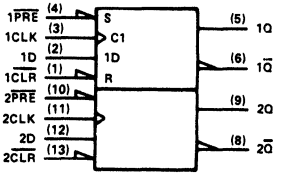
5

FUNCTION TABLE

INPUTS				OUTPUTS	
PRESET	CLEAR	CLOCK	D	Q	$\overline{Q}$
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H*	H*
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q_0	$\overline{Q}_0$

*The output levels in this configuration are not guaranteed to meet the minimum levels for V_{OH} if the lows at Preset and Clear are near V_{IL} maximum. Furthermore, this configuration is nonstable; that is, it will not persist when either Preset or Clear returns to its inactive (high) level.

logic symbol



Pin numbers shown are for J and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS74 . . . . . −55°C to 125°C
SN74ALS74 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

			SN54ALS74			SN74ALS74			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
I_{OH}	High-level output current				−0.4			−0.4	mA
I_{OL}	Low-level output current				4				mA
								8	
f_{clock}	Clock frequency		0		30	0		34	MHz
t_w	Pulse duration	$\overline{PRE}$ or $\overline{CLR}$ low	15			15			ns
		CLK high	14			12			
		CLK low	19			17			
t_{su}	Setup time before CLK↑	Data	15			15			ns
		$\overline{PRE}$ or $\overline{CLR}$ inactive	10			10			
t_h	Hold time, data after CLK↑		0			0			ns
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS74			SN74ALS74			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}			I_{OH} = −0.4 mA	V_{CC} −2						V
			I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V	I_{OL} = 8 mA					0.35	0.5	
I_I	CLK or D	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	$\overline{PRE}$ or $\overline{CLR}$					0.1			0.1	
I_{IH}	CLK or D	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	$\overline{PRE}$ or $\overline{CLR}$					20			20	
I_{IL}	CLK or D	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.2			−0.2	mA
	$\overline{PRE}$ or $\overline{CLR}$					−0.4			−0.4	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}		V_{CC} = 5.5 V,	See Note 1		2.4	4		2.4	4	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25°C.

*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

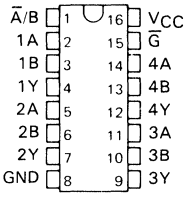
NOTE 1: I_{CC} is measured with D, CLK, and $\overline{PRE}$ grounded, then with D, CLK, and $\overline{CLR}$ grounded.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 15 pF, R_L = 500 Ω, T_A = 25°C			V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			'ALS74			SN54ALS74		SN74ALS74		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}			40	50		30		34		MHz
t_{PLH}	$\overline{PRE}$ or $\overline{CLR}$	Q or $\overline{Q}$		6		3	15	3	13	ns
t_{PHL}				10		5	17	5	15	
t_{PLH}	CLK	Q or $\overline{Q}$		8		5	18	5	16	ns
t_{PHL}				12		7	20	7	18	

5

(TOP VIEW)



J Suffix—Case 620-08 (Ceramic)
N Suffix—Case 648-05 (Plastic)

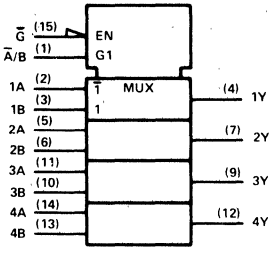
description

These monolithic data selectors/multiplexers contain inverters and drivers to supply full data selection to the four output gates. A separate strobe input ($\overline{G}$) is provided. A 4-bit word is selected from one of two sources and is routed to the four outputs. The 'ALS157 presents true data whereas the 'ALS158 presents inverted data to minimize propagation delay time.

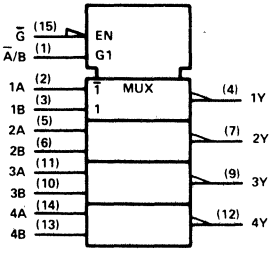
The SN54ALS157 and SN54ALS158 are characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS157 and SN74ALS158 are characterized for operation from 0 °C to 70 °C.

logic symbols

'ALS157



'ALS158



Pin numbers shown are for J and N packages

FUNCTION TABLE

INPUTS				OUTPUT Y	
STROBE $\overline{G}$	SELECT $\overline{A}$/B	DATA A	DATA B	'ALS157	'ALS158
H	X	X	X	L	H
L	L	L	X	L	H
L	L	H	X	H	L
L	H	X	L	L	H
L	H	X	H	H	L

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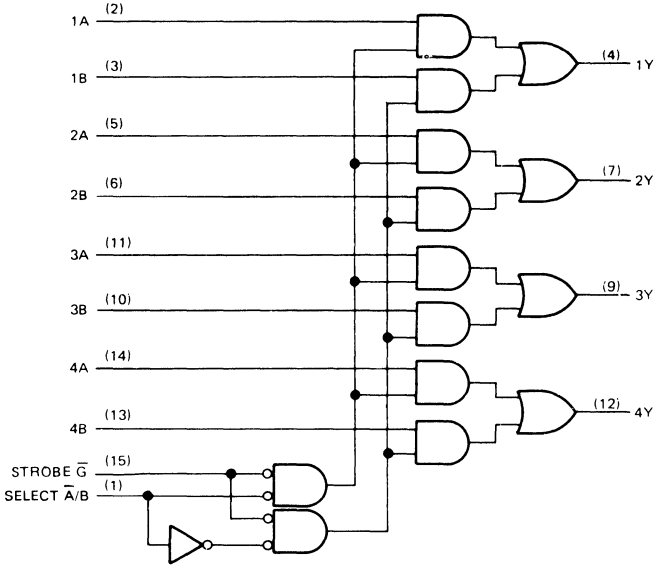
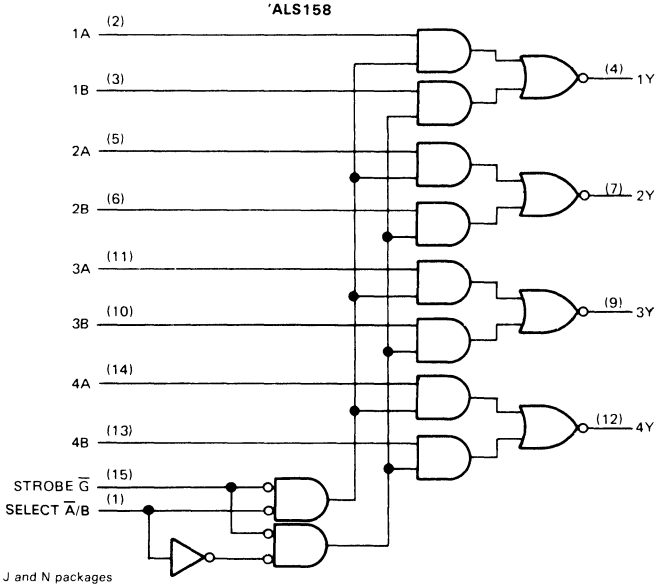
logic diagrams (positive logic)

'ALS157



'ALS158



Pin numbers shown are for J and N packages

5

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS157, SN54ALS158 . . . . . −55 °C to 125 °C
SN74ALS157, SN74ALS158 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS157 SN54ALS158			SN74ALS157 SN74ALS158			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−0.4				mA
							−0.4	
I_{OL}	Low-level output current			4				mA
							8	
T_A	Operating free-air temperature	−55		125	0		70	°C

5

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS157 SN54ALS158			SN74ALS157 SN74ALS158			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}			I_{OH} = −0.4 mA	V_{CC}−2						V
			I_{OH} = −0.4 mA				V_{CC}−2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	A or B	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	$\overline{A}$/B or $\overline{G}$					0.2			0.2	
I_{IH}	A or B	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	$\overline{A}$/B or $\overline{G}$					40			40	
I_{IL}	A or B	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
	$\overline{A}$/B or $\overline{G}$					−0.2			−0.2	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}	'ALS157	V_{CC} = 5.5 V				8.0			8.0	mA
	'ALS158					4.0			4.0	

‡All typical values are at V_{CC} = 5 V, T_A = 25°C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

'ALS157 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX						UNIT
			SN54ALS157			SN74ALS157			
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
t_{PLH}	A or B	Y	3	7	14	3	7	13	ns
t_{PHL}			3	6	14	3	6	13	
t_{PLH}	$\overline{A}$/B	Y	6	18	32	6	18	30	ns
t_{PHL}			5	11	22	5	11	20	
t_{PLH}	$\overline{G}$	Y	6	14	27	6	14	25	ns
t_{PHL}			4	9	17	4	9	15	

'ALS158 switching characteristics

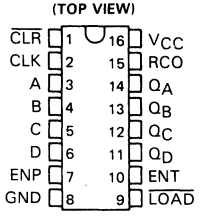
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX						UNIT
			SN54ALS158			SN74ALS158			
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
t_{PLH}	A or B	Y	3	7	17	3	7	14	ns
t_{PHL}			3	6	12	3	6	11	
t_{PLH}	$\overline{A}$/B 1	Y	5	12	25	5	12	23	ns
t_{PHL}			5	18	35	5	18	30	
t_{PLH}	$\overline{G}$ 15	Y	4	8	17	4	8	16	ns
t_{PHL}			4	13	25	4	13	23	

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.

5

TYPES SN54ALS160 THRU SN54ALS163
SN74ALS160 THRU SN74ALS163
SYNCHRONOUS 4-BIT DECADE AND BINARY COUNTERS

- **Internal Look-Ahead for Fast Counting**
- **Carry Output for n-Bit Cascading**
- **Synchronous Counting**
- **Synchronously Programmable**



J Suffix—Case 620-08 (Ceramic)
N Suffix—Case 648-05 (Plastic)

description

These synchronous, presettable counters feature an internal carry look-ahead for application in high-speed counting designs. The 'ALS160 and 'ALS162 are decade counters, and the 'ALS161 and 'ALS163 are 4-bit binary counters. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when so instructed by the count-enable inputs and internal gating. This mode of operation eliminates the output counting spikes that are normally associated with asynchronous (ripple clock) counters. A buffered clock input triggers the four flip-flops on the rising (positive-going) edge of the clock input waveform.

These counters are fully programmable; that is, the outputs may be preset to either level. As presetting is synchronous, setting up a low level at the load input disables the counter and causes the outputs to agree with the setup data after the next clock pulse regardless of the levels of the enable inputs.

The clear function for the 'ALS160 and 'ALS161 is asynchronous and a low level at the clear input sets both of the flip-flop outputs low regardless of the levels of the clock, load, or enable inputs.

The clear function for the 'ALS162 and 'ALS163 is synchronous and a low level at the clear input sets both of the flip-flop outputs low after the next clock pulse, regardless of the levels of the enable inputs. This synchronous clear allows the count length to be modified easily as decoding the maximum count desired can be accomplished with one external NAND gate. The gate output is connected to the clear input to synchronously clear the counter to 0000 (LLLL).

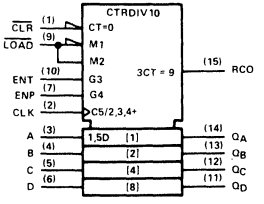
The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a ripple carry output. Both count-enable inputs (ENP and ENT) must be high to count, and ENT is fed forward to enable the ripple carry output. The ripple carry output (RCO) thus enabled will produce a high-level pulse while the count is maximum (9 or 15 with Q_A high). This high-level overflow ripple carry pulse can be used to enable successive cascaded stages. Transitions at the ENP or ENT are allowed regardless of the level of the clock input.

These counters feature a fully independent clock circuit. Changes at control inputs (ENP, ENT, or $\overline{\text{LOAD}}$) that will modify the operating mode have no effect on the contents of the counter until clocking occurs. The function of the counter (whether enabled, disabled, loading, or counting) will be dictated solely by the conditions meeting the stable setup and hold times.

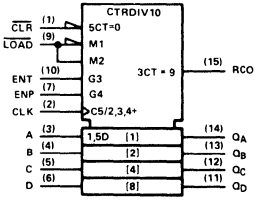
The SN54ALS160 through SN54ALS163 are characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS160 through SN74ALS163 are characterized for operation from 0°C to 70°C.

logic symbols

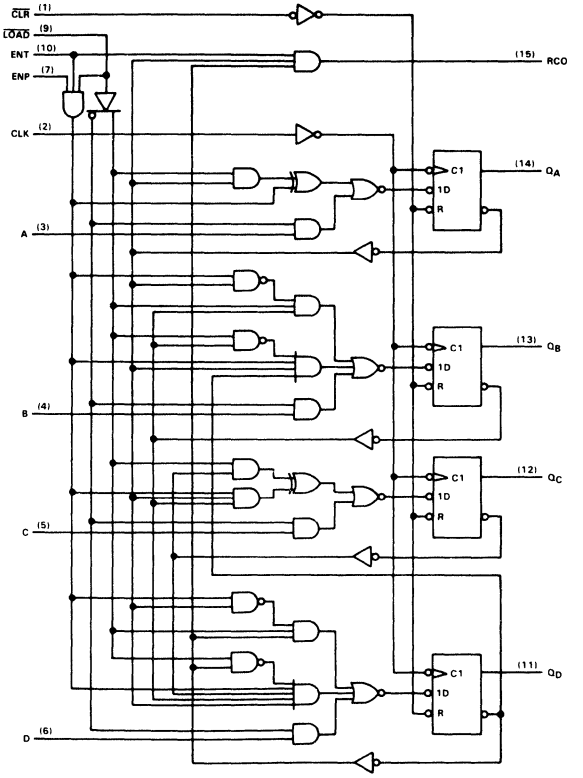
'ALS160 DECADE
COUNTER WITH DIRECT CLEAR



'ALS162 DECADE
COUNTER WITH SYNCHRONOUS CLEAR



'ALS160 logic diagram (positive logic)



'ALS162 decade counter is similar; however the clear is synchronous as shown for the 'ALS163 binary counter on the following page.

Pin numbers shown are for J and N packages.

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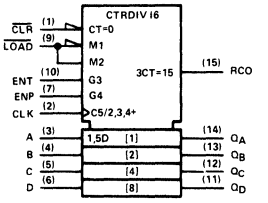
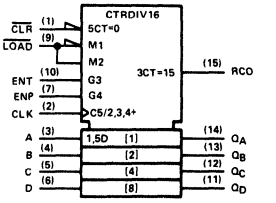
logic symbols

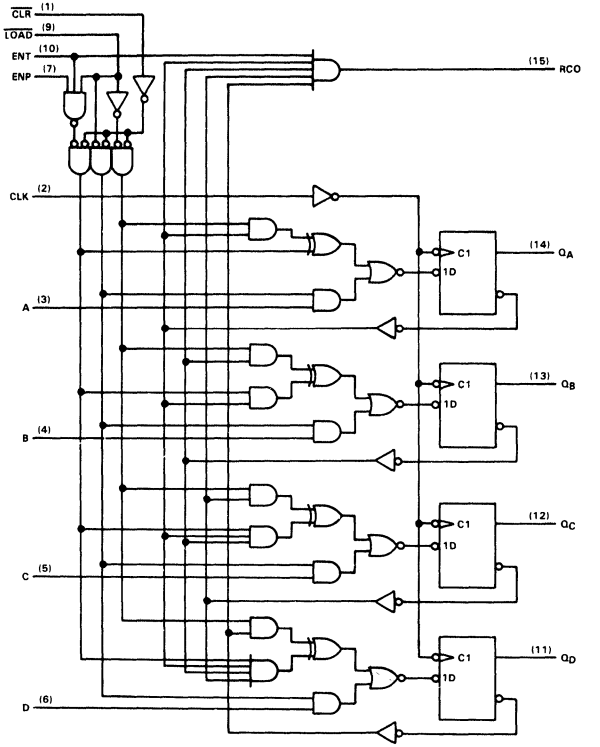
'ALS161 BINARY COUNTER WITH DIRECT CLEAR



'ALS163 BINARY COUNTER WITH SYNCHRONOUS CLEAR



'ALS163 logic diagram (positive logic)



'ALS161 synchronous binary counter is similar; however the clear is asynchronous as shown for the 'ALS160 decade counter on the preceding page.

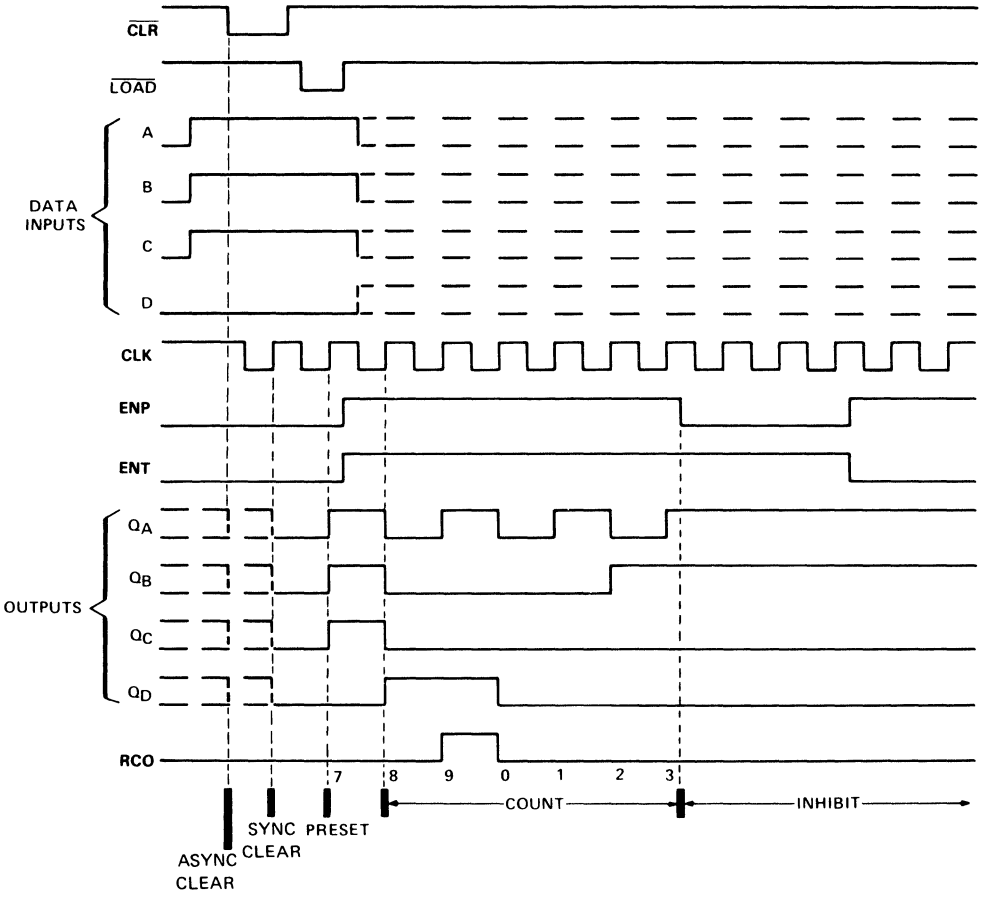
Pin numbers shown are for J and N packages.

typical clear, preset, count, and inhibit sequences

'ALS160, 'ALS162

Illustrated below is the following sequence:

1. Clear outputs to zero ('ALS160 is asynchronous, 'ALS162 is synchronous)
2. Preset to BCD seven
3. Count to eight, nine, zero, one, two, and three
4. Inhibit



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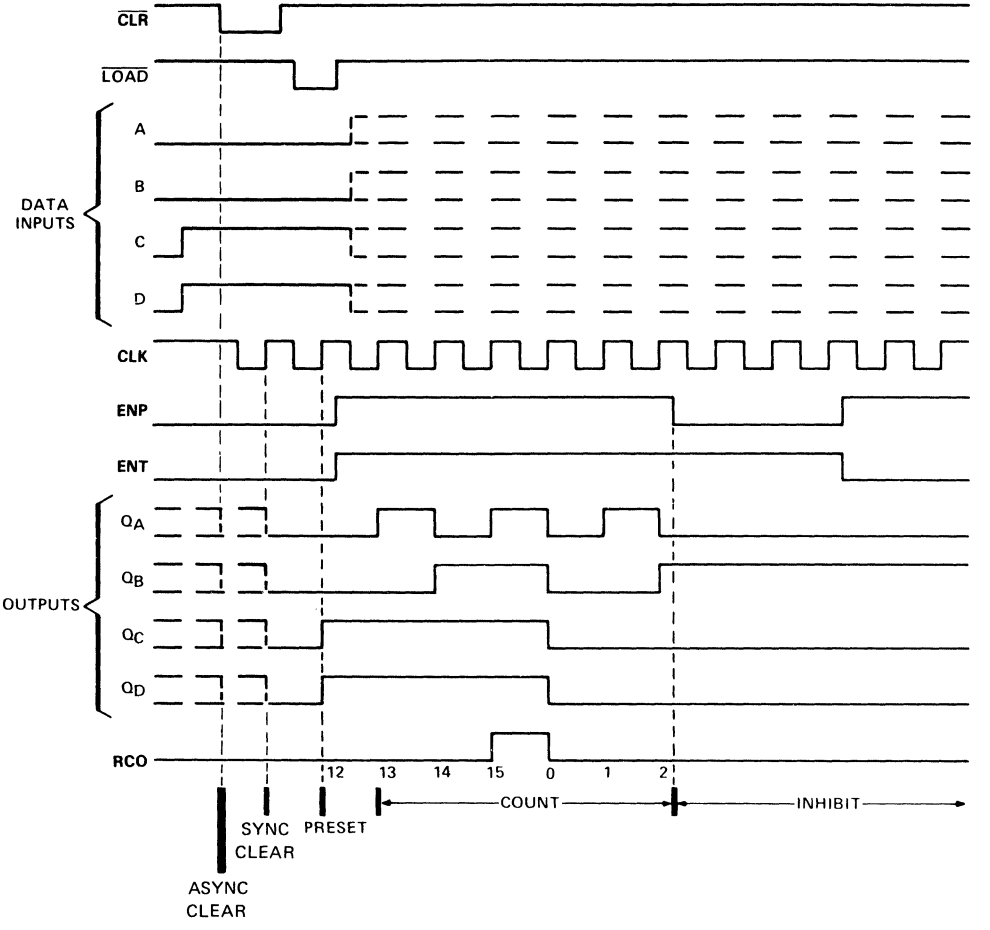
typical clear, preset, count, and inhibit sequences

'ALS161, 'ALS163

Illustrated below is the following sequence:

1. Clear outputs to zero ('ALS161 is asynchronous, 'ALS163 is synchronous)
2. Preset to binary twelve
3. Count to thirteen, fourteen, fifteen, zero, one, and two
4. Inhibit



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS160 thru SN54ALS163 . . . . . −55 °C to 125 °C
SN74ALS160 thru SN74ALS163 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

				SN54ALS160 THRU SN54ALS163			SN74ALS160 THRU SN74ALS163			UNIT
				MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage			4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage			2			2			V
V_{IL}	Low-level input voltage					0.8			0.8	V
I_{OH}	High-level output voltage					−0.4			−0.4	mA
I_{OL}	Low-level output current					4			8	mA
f_{clock}	Clock frequency	'ALS160, 'ALS162		0		30	0		30	MHz
		'ALS161, 'ALS163		0		30	0		30	
t_w	Pulse duration	CLK High		18			15			ns
		CLK Low		15			15			
		'ALS160, 'ALS161 $\overline{CLR}$ low		18			16			
t_{su}	Setup time before CLK↑	A, B, C, D		15			15			ns
		ENP, ENT	'ALS160, 'ALS161	20			20			
			'ALS162, 'ALS163	20			20			
		'ALS160, 'ALS161 $\overline{CLR}$ inactive		15			15			
		'ALS162, 'ALS163	$\overline{CLR}$ Low	25			25			
			$\overline{CLR}$ high (inactive)	15			15			
t_h	Hold time, all synchronous inputs after CLK↑			0			0			ns
T_A	Operating free-air temperature			−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS160 THRU SN54ALS163			SN74ALS160 THRU SN74ALS163			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}			I_{OH} = −0.4 mA	V_{CC}−2						V
			I_{OH} = −0.4 mA				V_{CC}−2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 4 mA		0 25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	$\overline{LOAD}$, CLK or ENT	V_{CC} = 5.5 V,	V_I = 7 V			0.2			0.2	mA
	All other					0.1			0.1	
I_{IH}	$\overline{LOAD}$, CLK or ENT	V_{CC} = 5.5 V,	V_I = 0.4 V			40			40	μA
	All other					20			20	
I_{IL}		V_{CC} = 5.5 V,	V_I = 0.4 V			−0.2			−0.2	mA
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CCL}		V_{CC} = 5.5 V				16			16	mA
I_{CCH}		V_{CC} = 5.5 V				15.5			15.5	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

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'ALS160 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS160 SN54ALS161		SN74ALS160 SN74ALS161		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS160		30		30		MHz
	'ALS161		30		30		
t_{PLH}	CLK	RCO	8	25	8	23	ns
t_{PHL}			7	20	7	20	
t_{PLH}	CLK	Any Q	4	22	4	22	ns
t_{PHL}			6	28	6	28	
t_{PLH}	ENT	RCO	5	20	5	20	ns
t_{PHL}			4	16	4	16	
t_{PHL}	$\overline{CLR}$	Any Q	8	28	8	28	ns
t_{PHL}	$\overline{CLR}$	RCO	11	35	11	30	ns

'ALS162 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS162 SN54ALS163		SN74ALS162 SN74ALS163		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS162		30		30		MHz
	'ALS163		30		30		
t_{PLH}	CLK	RCO	8	25	8	23	ns
t_{PHL}			7	20	7	20	
t_{PLH}	CLK	Any Q	4	22	4	22	ns
t_{PHL}			6	28	6	28	
t_{PLH}	ENT	RCO	5	20	5	20	ns
t_{PHL}			4	16	4	16	

See next page for 161 and 163.

'ALS161 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS160 SN54ALS161		SN74ALS160 SN74ALS161		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS160		30		30		MHz
	'ALS161		30		30		
t_{PLH}	CLK	RCO	8	25	8	23	ns
t_{PHL}			7	20	7	20	
t_{PLH}	CLK	Any Q	4	22	4	22	ns
t_{PHL}			6	26	6	26	
t_{PLH}	ENT	RCO	5	20	5	20	ns
t_{PHL}			4	16	4	16	
t_{PHL}	$\overline{CLR}$	Any Q	8	28	8	28	ns
t_{PHL}	$\overline{CLR}$	RCO	11	31	11	28	ns

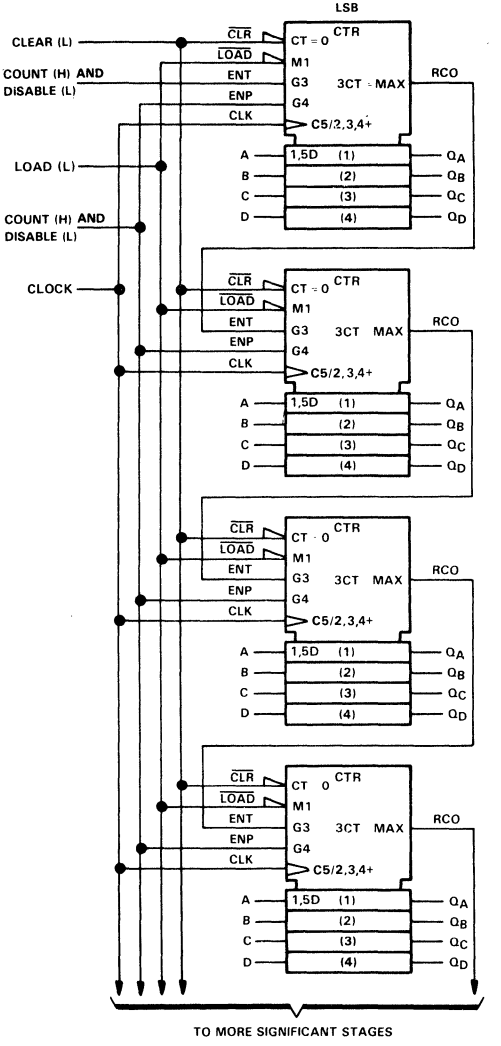
'ALS163 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS162 SN54ALS163		SN74ALS162 SN74ALS163		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS162		30		30		MHz
	'ALS163		30		30		
t_{PLH}	CLK	RCO	8	25	8	23	ns
t_{PHL}			7	20	7	20	
t_{PLH}	CLK	Any Q	4	22	4	22	ns
t_{PHL}			6	28	6	28	
t_{PLH}	ENT	RCO	5	20	5	20	ns
t_{PHL}			4	16	4	16	

TYPICAL APPLICATION DATA

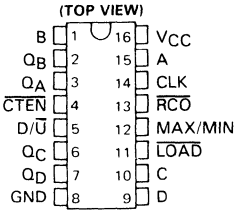
N-BIT SYNCHRONOUS COUNTERS

This application demonstrates how the look-ahead carry circuit can be used to implement a high-speed n-bit counter. The 'ALS160 and 'ALS162 will count in BCD and the 'ALS161 and 'ALS163 will count in binary. Virtually any count mode (modulo-N, N_1-to-N_2, N_1-to-maximum) can be used with this fast look-ahead circuit.



TYPES SN54ALS190, SN54ALS191, SN74ALS190, SN74ALS191
SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

- **Single Down/Up Count Control Line**
- **Look-Ahead Circuitry Enhances Speed of Cascaded Counters**
- **Fully Synchronous in Count Modes**
- **Asynchronously Presettable with Load Control**



J Suffix—Case 620-08 (Ceramic)
N Suffix—Case 648-05 (Plastic)

descriptions

The 'ALS190 and 'ALS191 are synchronous, reversible up/down counters. The 'ALS190 is a 4-bit decade counter and the 'ALS191 is a 4-bit binary counter. Synchronous counting operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when so instructed by the steering logic. This mode of operation eliminates the output counting spikes normally associated with asynchronous (ripple clock) counters.

The outputs of the four flip-flops are triggered on a low-to-high-level transition of the clock input if the enable input ($\overline{CTEN}$) is low. A high at $\overline{CTEN}$ inhibits counting. The direction of the count is determined by the level of the down/up (D/$\overline{U}$) input. When D/$\overline{U}$ is low, the counter counts up and when D/$\overline{U}$ is high, it counts down.

These counters feature a fully independent clock circuit. Changes at the control inputs ($\overline{CTEN}$ and D/$\overline{U}$) that will modify the operating mode have no effect on the contents of the counter until clocking occurs. The function of the counter will be dictated solely by the condition meeting the stable setup and hold times.

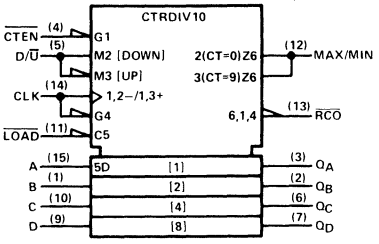
These counters are fully programmable; that is, the outputs may each be preset to either level by placing a low on the load input and entering the desired data at the data inputs. The output will change to agree with the data inputs independently of the level of the clock input. This feature allows the counters to be used as modulo-N dividers by simply modifying the count length with the preset inputs.

The CLK, D/$\overline{U}$, and LOAD inputs are buffered to lower the drive requirement, which significantly reduces the loading on, or current required by, clock drivers, etc., for long parallel words.

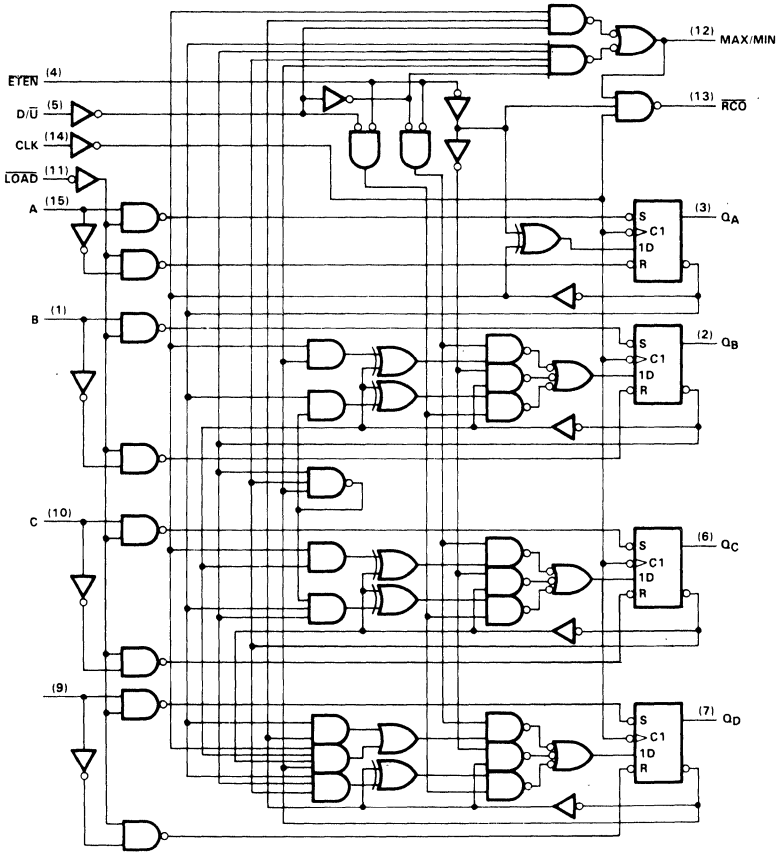
Two outputs have been made available to perform the cascading function: ripple clock and maximum/minimum count. The latter output produces a high-level output pulse with a duration approximately equal to one complete cycle of the clock while the count is zero (all outputs low) counting down or maximum (9 or 15) counting up. The ripple clock output produces a low-level output pulse under those same conditions but only while the clock input is low. The counters can be easily cascaded by feeding the ripple clock output to the enable input of the succeeding counter if parallel clocking is used, or to the clock input if parallel enabling is used. The maximum/minimum count output can be used to accomplish look-ahead for high-speed operation.

The SN54ALS190 and SN54ALS191 are characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS190 and SN74ALS191 are characterized for operation from 0 °C to 70 °C.

'ALS190 logic symbol



'ALS190 logic diagram (positive logic)



Pin numbers shown are for J and N packages.

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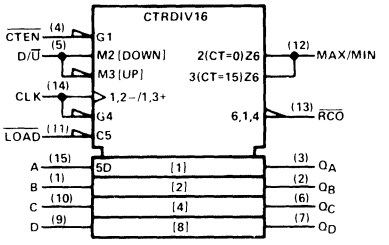
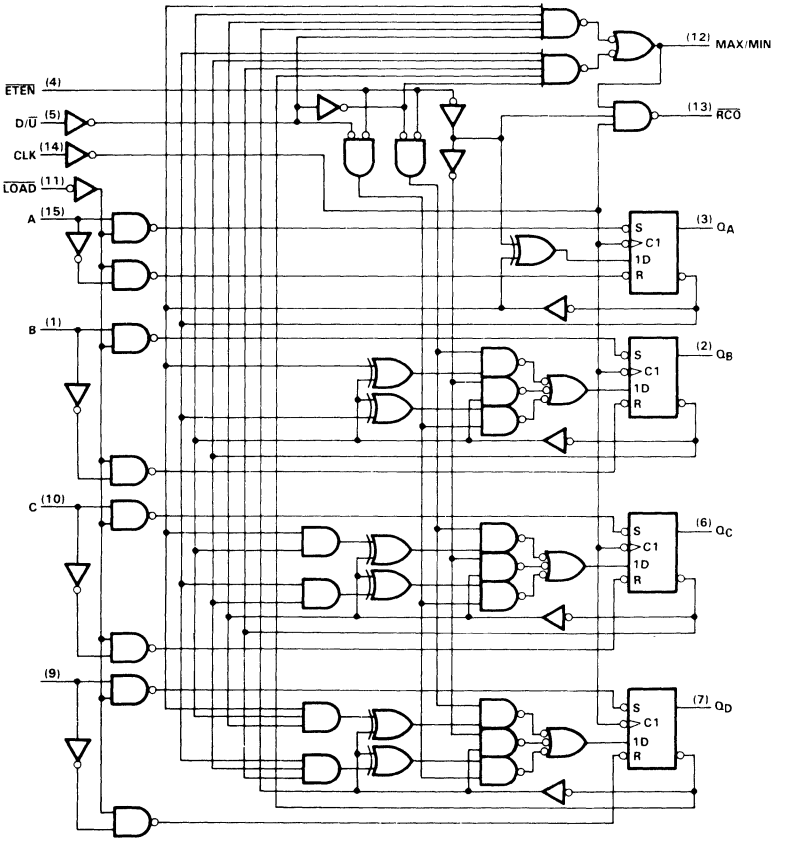
'ALS191 logic symbol



'ALS191 logic diagram (positive logic)



Pin numbers shown are for J and N packages

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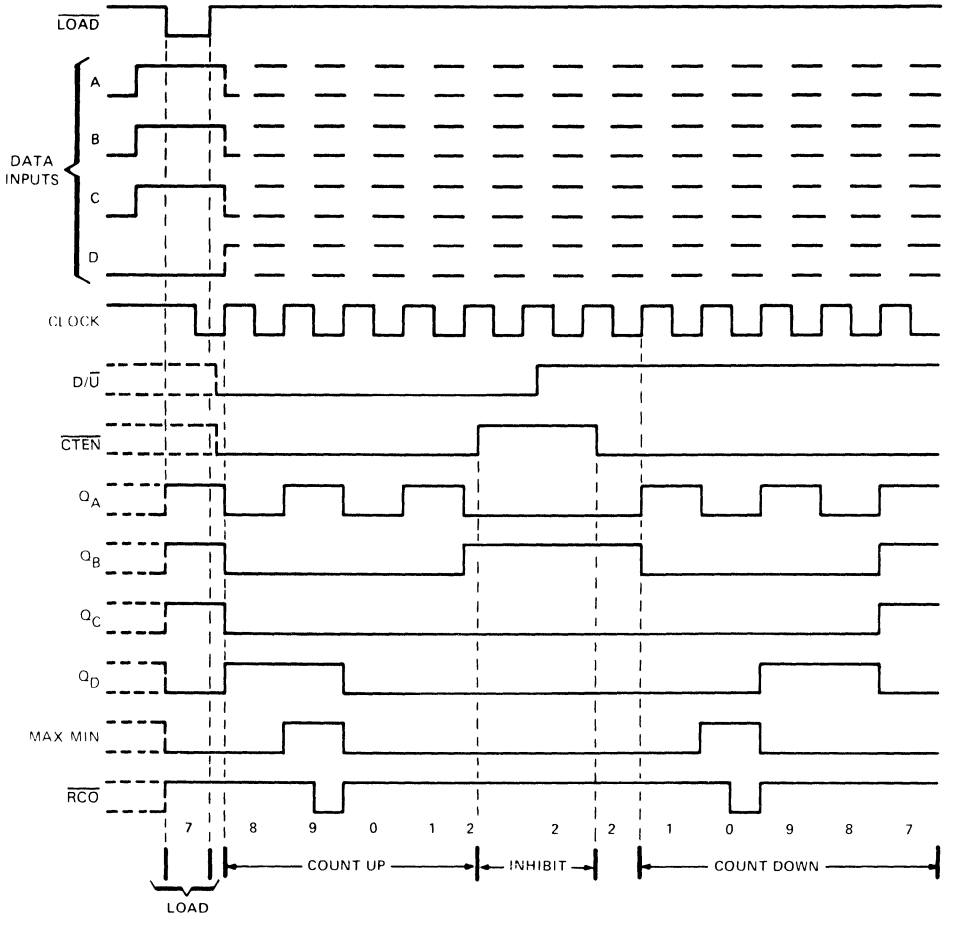
typical load, count, and inhibit sequences

'ALS190

Illustrated below is the following sequence:

1. Load (preset) to BCD seven.
2. Count up to eight, nine (maximum), zero, one, and two.
3. Inhibit.
4. Count down to one, zero (minimum), nine, eight, and seven.

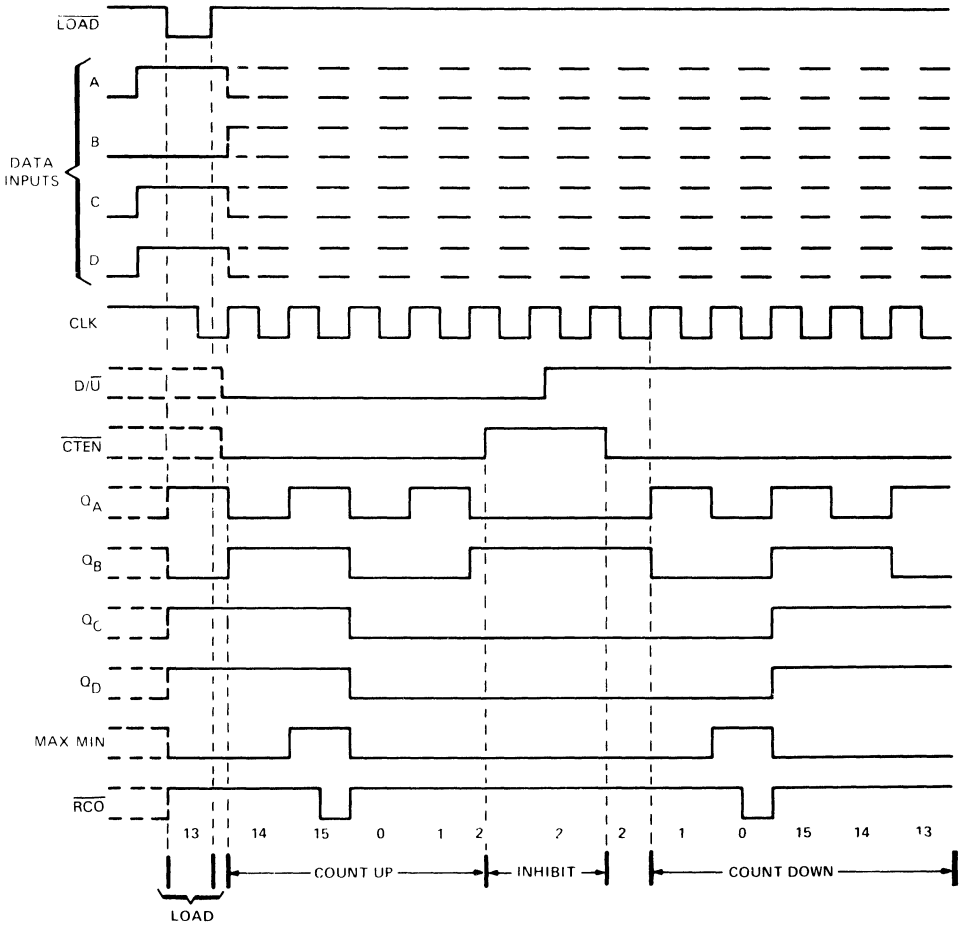


typical load, count, and inhibit sequences

'ALS191

Illustrated below is the following sequence:

1. Load (preset) to binary thirteen.
2. Count up to fourteen, fifteen (maximum), zero, one, and two.
3. Inhibit.
4. Count down to one, zero (minimum), fifteen, fourteen, and thirteen.



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS190, SN54ALS191 . . . . . −55 °C to 125 °C
SN74ALS190, SN74ALS191 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

			SN54ALS190 SN54ALS191			SN74ALS190 SN74ALS191			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
I_{OH}	High-level output current				−0.4			−0.4	mA
I_{OL}	Low-level output current				4				mA
								8	
f_{clock}	Clock frequency	'ALS190	0		25	0		25	MHz
		'ALS191	0		25	0		25	
t_w	Pulse duration	CLK high	20			20			ns
		CLK low	20			20			
		$\overline{LOAD}$ low	25			25			
t_{su}	Setup time	Data before $\overline{LOAD}$↑	20			20			ns
		$\overline{CTEN}$ before CLK↑	20			20			
		D/$\overline{U}$ before CLK↑	20			20			
		$\overline{LOAD}$ inactive before CLK↑	20			20			
t_h	Hold time	Data after $\overline{LOAD}$↑	0			0			ns
		$\overline{CTEN}$ after CLK↑	0			0			
		D/$\overline{U}$ after CLK↑	0			0			
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS190 SN54ALS191			SN74ALS190 SN74ALS191			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}			I_{OH} = −0.4 mA	V_{CC} −2						V
			I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	$\overline{CTEN}$	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	All others					0.1			0.1	
I_{IH}	$\overline{CTEN}$	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	All others					20			20	
I_{IL}	$\overline{CTEN}$	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.2			−0.2	mA
	All others					−0.1			−0.1	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}		V_{CC} = 5.5 V,	All inputs at 0 V			17.5			17.5	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS190 SN54ALS191		SN74ALS190 SN74ALS191		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS190		25		25		MHz
	'ALS191		25		25		
t_{PLH}	$\overline{LOAD}$	Any Q	8	45	8	45	ns
t_{PHL}			8	35	8	35	
t_{PLH}	A, B, C, D	Any Q	4	28	4	26	ns
t_{PHL}			4	37	4	35	
t_{PLH}	CLK	$\overline{RCO}$	5	17	5	16	ns
t_{PHL}			5	15	5	14	
t_{PLH}	CLK	Any Q	3	25	3	25	ns
t_{PHL}			3	28	3	28	
t_{PLH}	CLK	MAX/MIN	8	35	8	35	ns
t_{PHL}			8	25	8	20	
t_{PLH}	D/$\overline{U}$	$\overline{RCO}$	15	44	15	40	ns
t_{PHL}			10	34	10	32	
t_{PLH}	D/$\overline{U}$	MAX/MIN	8	28	8	26	ns
t_{PHL}			8	28	8	26	
t_{PLH}	$\overline{CTEN}$	$\overline{RCO}$	4	17	4	17	ns
t_{PHL}			4	16	4	16	

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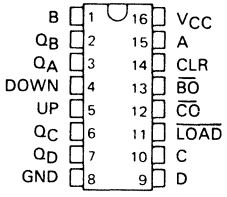
TYPES SN54ALS192, SN54ALS193, SN74ALS192, SN74ALS193
SYNCHRONOUS 4-BIT UP/DOWN COUNTERS (DUAL CLOCK WITH CLEAR)

- **Look-Ahead Circuitry Enhances Cascaded Counters**
- **Fully Synchronous in Count Modes**
- **Parallel Asynchronous Load for Modulo-N Count Lengths**
- **Asynchronous Clear**

(TOP VIEW)



J Suffix—Case 620-08 (Ceramic)
N Suffix—Case 648-05 (Plastic)

description

The 'ALS192 and 'ALS193 are synchronous, reversible up/down counters. The 'ALS192 is a 4-bit decade counter and the 'ALS193 is a 4-bit binary counter. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincidently with each other when so instructed by the steering logic. This mode of operation eliminates the output counting spikes normally associated with asynchronous (ripple clock) counters.

The outputs of the four flip-flops are triggered by a low-to-high-level transition of either count (clock) input (Up or Down). The direction of counting is determined by which count input is pulsed while the other count input is high.

All four counters are fully programmable; that is, each output may be preset to either level by placing a low on the load input and entering the desired data at the data inputs. The output will change to agree with the data inputs independently of the count pulses. This feature allows the counters to be used as modulo-N dividers by simply modifying the count length with the preset inputs.

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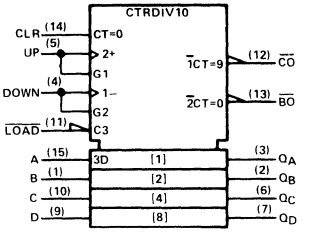
A clear input has been provided that forces all outputs to the low level when a high level is applied. The clear function is independent of the count and the load inputs. The clock, count, and load inputs are buffered to lower the drive requirements. This significantly reduces the loading on clock drivers, etc., for long parallel words.

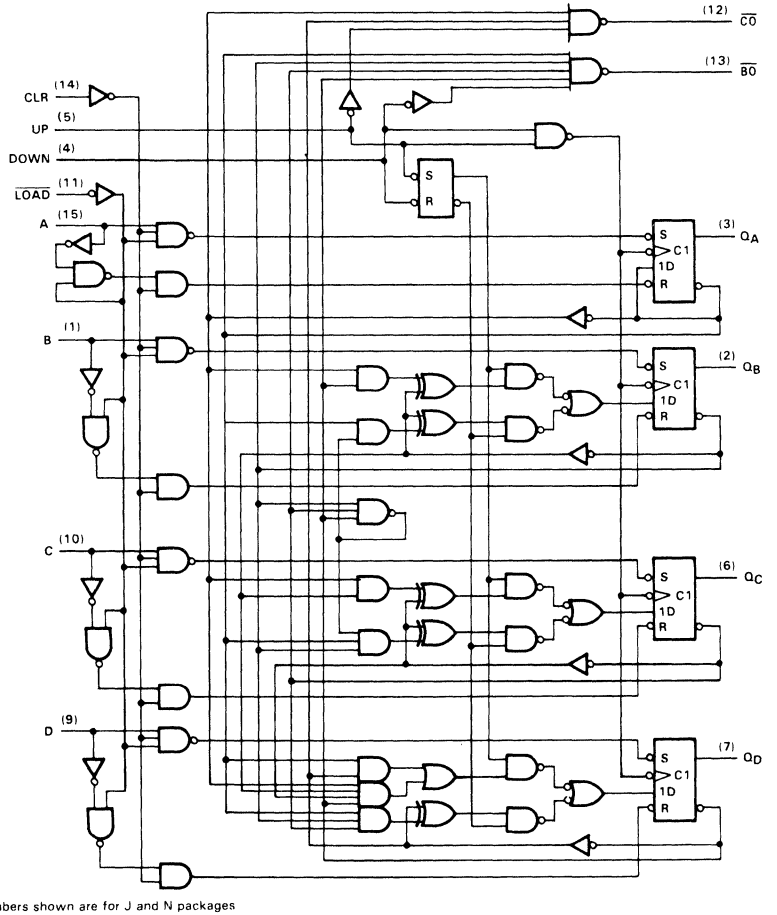
These counters were designed to be cascaded without the need for external circuitry. The borrow output (BO) produces a low-level pulse while the count is zero (all outputs low) and the count-down input is low. Similarly, the carry output ($\overline{CO}$) produces a low-level pulse while the count is maximum (9 or 15) and the count-up input is low. The counters can then be easily cascaded by feeding the borrow and carry outputs to the count-down and count-up inputs, respectively, of the succeeding counter.

The SN54ALS192 and SN54ALS193 are characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74ALS192 and SN74ALS193 are characterized for operation from 0 °C to 70 °C.

'ALS192 logic symbol



'ALS192 logic diagram (positive logic)



Pin numbers shown are for J and N packages

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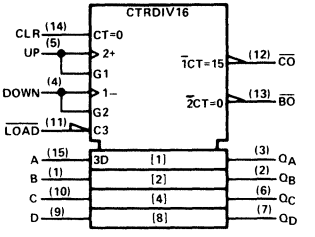
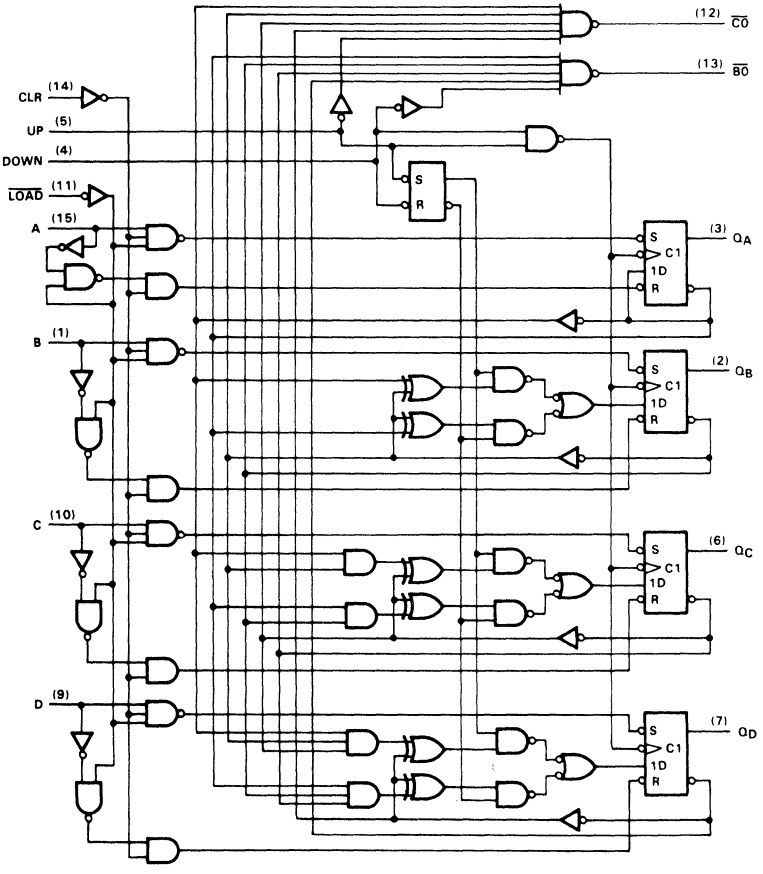
'ALS193 logic symbol



'ALS193 logic diagrams (positive logic)



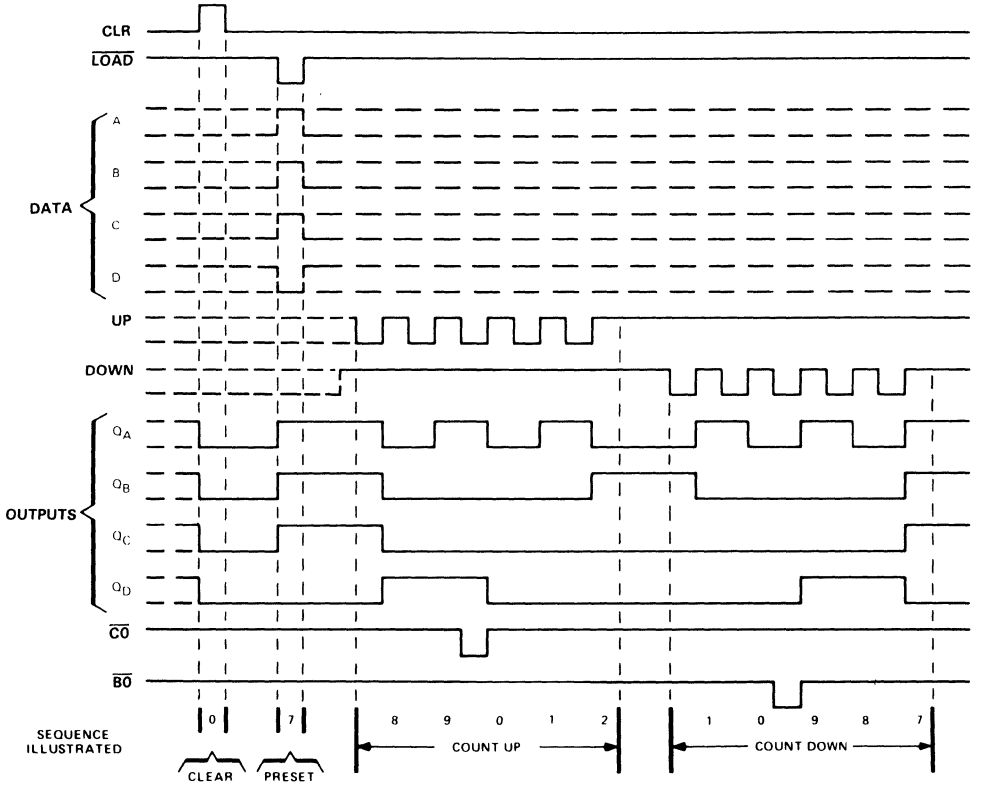
Pin numbers shown are for J and N packages

typical clear, load, and count sequence

'ALS192

Illustrated below is the following sequence:

1. Clear outputs to zero.
2. Load (preset) to BCD seven.
3. Count up to eight, nine, carry, zero, one, and two.
4. Count down to one, zero, borrow, nine, eight, and seven.



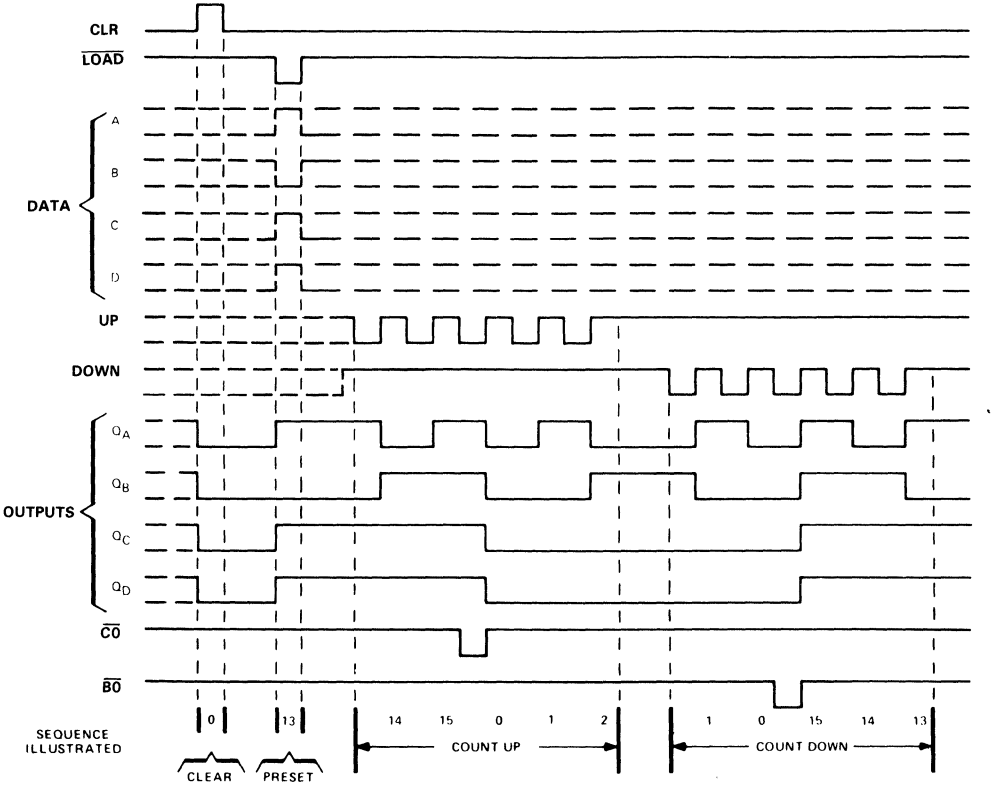
NOTES. A. Clear overrides load, data, and count inputs.
B. When counting up, count-down input must be high; when counting down, count-up input must be high.

typical clear, load, and count sequences

'ALS193

Illustrated below is the following sequence:

1. Clear outputs to zero.
2. Load (preset) to binary thirteen.
3. Count up to fourteen, fifteen, carry, zero, one, and two.
4. Count down to one, zero, borrow, fifteen, fourteen, and thirteen.



NOTES: A. Clear overrides load, data, and count inputs.
B. When counting up, count-down input must be high, when counting down, count-up input must be high.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54ALS192, SN54ALS193 . . . . . −55 °C to 125 °C
SN74ALS192, SN74ALS193 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

			SN54ALS192 SN54ALS193			SN74ALS192 SN74ALS193			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
I_{OH}	High-level output current				−0.4			−0.4	mA
I_{OL}	Low-level output current				4			8	mA
f_{clock}	Clock frequency	'ALS192	0		25	0		25	MHz
		'ALS193	0		25	0		25	
t_w	Pulse duration	CLR high	20			20			ns
		$\overline{LOAD}$ low	25			25			
		Up or Down high	20			20			
		Up or Down low	20			20			
t_{su}	Setup time	Data before $\overline{LOAD}$↑	20			20			ns
		CLR inactive before Up↑ or Down↑	5			5			
		$\overline{LOAD}$ inactive before Up↑ or Down↑	15			15			
t_h	Hold time	Data after $\overline{LOAD}$↑	0			0			ns
		Up high after Down↑	0			0			
		Down high after Up↑	0			0			
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS192 SN54ALS193			SN74ALS192 SN74ALS193			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}			I_{OH} = −0.4 mA	V_{CC} −2						V
			I_{OH} = −0.4 mA				V_{CC} −2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 8 mA					0.35	0.5	
I_I	Up, Down	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	All others					0.1			0.1	
I_{IH}	Up, Down	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	All others					20			20	
I_{IL}	Up, Down	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
	All others					−0.1			−0.1	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}		V_{CC} = 5.5 V,	See Note 1			17			17	mA

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.
NOTE 1. I_{CC} is measured with the clear and load inputs gounded, and all other inputs at 4.5 V.

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switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS192 SN54ALS193		SN74ALS192 SN74ALS193		
			MIN	MAX	MIN	MAX	
f_{max}	'ALS192		25		25		MHz
	'ALS193		25		25		
t_{PLH}	Up	CO	4	18	4	18	ns
t_{PHL}			5	18	5	18	
t_{PLH}	Down	BO	4	18	4	18	ns
t_{PHL}			5	18	5	18	
t_{PLH}	Up or Down	Any Q	4	35	4	33	ns
t_{PHL}			4	35	4	33	
t_{PLH}	$\overline{LOAD}$	Any Q	8	48	8	45	ns
t_{PHL}			8	35	8	35	
t_{PHL}	CLR	Any Q	5	30	5	30	ns

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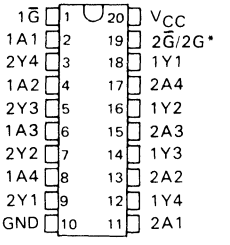
TYPES SN54ALS240, SN54ALS241
SN74ALS240, SN74ALS241
OCTAL BUFFERS AND LINE DRIVERS WITH 3-STATE OUTPUTS

- **3-State Outputs Drive Bus Lines or Buffer Memory Address Registers**
- **P-N-P Inputs Reduce DC Loading**

(TOP VIEW)



*2G̅ for 'ALS240 or 2G for 'ALS241

J Suffix—Case 732-03 (Ceramic)
N Suffix—Case 738-01 (Plastic)

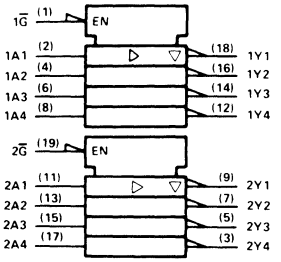
description

These octal buffers and line drivers are designed specifically to improve both the performance and density of three-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The designer has a choice of selected combinations of inverting and noninverting outputs, symmetrical G̅ (active-low output control) inputs, and complementary G and G̅ inputs. These devices feature high fan-out and improved fan-in.

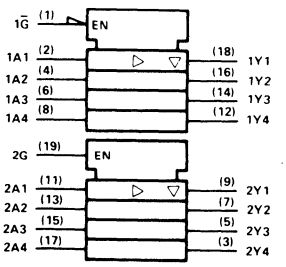
The SN54' family is characterized for operation over the full military temperature range of −55 °C to 125 °C. The SN74' family is characterized for operation from 0 °C to 70 °C.

logic symbols

'ALS240



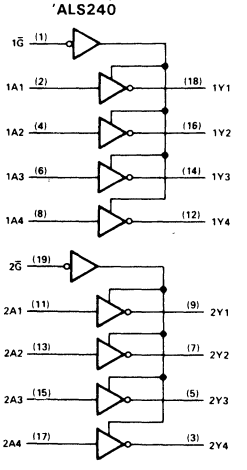
'ALS241



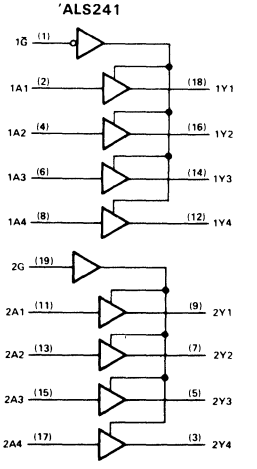
Pin numbers shown are for J and N packages

logic diagrams (positive logic)

'ALS240



'ALS241



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Voltage applied to a disabled 3-state output . . . . . 5.5 V
Operating free-air temperature range: SN54ALS240, SN54ALS241 . . . . . −55 °C to 125 °C
SN74ALS240, SN74ALS241 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS240 SN54ALS241			SN74ALS240 SN74ALS241			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−12				mA
							−15	
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS240 SN54ALS241			SN74ALS240 SN74ALS241			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		V_{CC} = 4.5 V,	I_{OH} = −3 mA	2.4	3.2		2.4	3.2		V
		V_{CC} = 4.5 V,	I_{OH} = −12 mA	2						
		V_{CC} = 4.5 V,	I_{OH} = −15 mA				2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_{OZH}		V_{CC} = 5.5 V,	V_O = 2.7 V			20			20	μA
I_{OZL}		V_{CC} = 5.5 V,	V_O = 0.4 V			−20			−20	μA
I_I		V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}		V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}		V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}	'ALS240	V_{CC} = 5.5 V	Outputs high			11.5			11.5	mA
			Outputs low			22			22	
			Outputs disabled			25			25	
	'ALS241		Outputs high			11.5			11.5	
			Outputs low			23			23	
			Outputs disabled			27			27	

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

'ALS240 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS240		SN74ALS240		
			MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	3	12	3	10	ns
t_{PHL}			2	11	2	9	
t_{PZH}	$\overline{G}$	Y	5	22	5	20	ns
t_{PZL}			5	30	5	28	
t_{PHZ}	$\overline{G}$	Y	2	15	2	13	ns
t_{PLZ}			3	21	3	17	

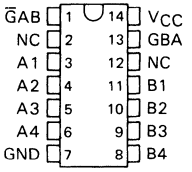
'ALS241 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS241		SN74ALS241		
			MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	3	14	3	12	ns
t_{PHL}			3	13	3	10	
t_{PZH}	$1\overline{G}$	Y	7	25	7	21	ns
t_{PZL}			7	25	7	21	
t_{PHZ}	$1\overline{G}$	Y	2	18	2	16	ns
t_{PLZ}			3	26	3	20	
t_{PZH}	2G	Y	7	25	7	21	ns
t_{PZL}			7	25	7	21	
t_{PHZ}	2G	Y	2	18	2	16	ns
t_{PLZ}			3	26	3	20	

TYPES SN54ALS242, SN54ALS243, SN74ALS242, SN74ALS243, QUADRUPLE BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

- 2-Way Asynchronous Communication Between Data Buses
- P-N-P Inputs Reduce Loading

(TOP VIEW)



J Suffix—Case 632-07 (Ceramic)
N Suffix—Case 646-05 (Plastic)

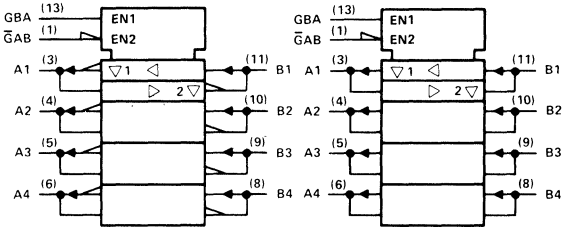
description

These four-data-line transceivers are designed for asynchronous two-way communications between data buses. The SN74' devices can be used to drive terminated lines down to 100 ohms.

The SN54' family is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74' family is characterized for operation from 0°C to 70°C.

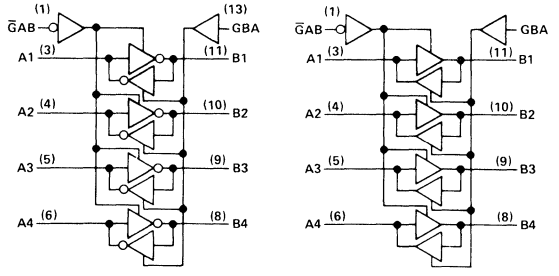
logic symbol

'ALS242 'ALS243



logic diagrams (positive logic)

'ALS242 'ALS243



Pin numbers shown are for J and N packages.

FUNCTION TABLE

INPUTS		'ALS242	'ALS243
$\overline{G}AB$	GBA		
L	L	$\overline{A}$ to B	A to B
H	H	$\overline{B}$ to A	B to A
H	L	Isolation	Isolation
L	H	Latch A and B ($A = \overline{B}$)	Latch A and B ($A = B$)

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage: All inputs . . . . . 7 V
I/O ports . . . . . 5.5 V
Operating free-air temperature range: SN54ALS242, SN54ALS243 . . . . . −55°C to 125°C
SN74ALS242, SN74ALS243 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

		SN54ALS242 SN54ALS243			SN74ALS242 SN74ALS243			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−12				mA
							−15	
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS242 SN54ALS243			SN74ALS242 SN74ALS243			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		V_{CC} = 4.5 V,	I_{OH} = −3 mA	2.4	3.2		2.4	3.2		V
		V_{CC} = 4.5 V,	I_{OH} = −12 mA	2						
		V_{CC} = 4.5 V,	I_{OH} = −15 mA				2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_I	Control inputs	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	A or B ports	V_{CC} = 5.5 V,	V_I = 5.5 V			0.1			0.1	
I_{IH}	Control inputs	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	A or B ports▲					20			20	
I_{IL}	Control inputs	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
	A or B ports▲					−0.1			−0.1	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}	'ALS242	V_{CC} = 5.5 V	Outputs high			19			19	mA
			Outputs low			25			25	
			Outputs disabled			25			25	
	'ALS243		Outputs high			19			19	
			Outputs low			25			25	
			Outputs disabled			27			27	

‡All typical values are at V_{CC} = 5 V, T_A = 25°C.

*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

▲For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

5

'ALS242 switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_1 = 500 Ω, R_2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS242		SN74ALS242		
			MIN	MAX	MIN	MAX	
t_{PLH}	A or B	B or A	3	15	3	11	ns
t_{PHL}			2	14	2	10	
t_{PZH}	$\overline{G}$AB	B	4	24	4	22	ns
t_{PZL}			7	32	7	30	
t_{PHZ}	$\overline{G}$AB	B	2	18	2	16	ns
t_{PLZ}			4	28	4	25	
t_{PZH}	GBA	A	4	24	4	22	ns
t_{PZL}			7	32	7	30	
t_{PHZ}	GBA	A	2	18	2	16	ns
t_{PLZ}			4	28	4	25	

'ALS243 switching characteristics

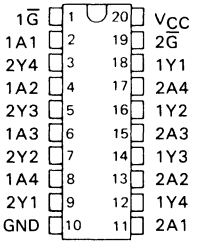
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_1 = 500 Ω, R_2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS243		SN74ALS243		
			MIN	MAX	MIN	MAX	
t_{PLH}	A or B	B or A	4	15	4	11	ns
t_{PHL}			4	15	4	11	
t_{PZH}	$\overline{G}$AB	B	7	25	7	23	ns
t_{PZL}			7	26	7	24	
t_{PHZ}	$\overline{G}$AB	B	2	20	2	18	ns
t_{PLZ}			4	30	4	25	
t_{PZH}	GBA	A	7	25	7	23	ns
t_{PZL}			7	26	7	24	
t_{PHZ}	GBA	A	2	20	2	18	ns
t_{PLZ}			4	30	4	25	

5

TYPES SN54ALS244, SN74ALS244
OCTAL BUFFERS AND LINE DRIVERS WITH 3-STATE OUTPUTS

- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- P-N-P Inputs Reduce DC Loading

(TOP VIEW)



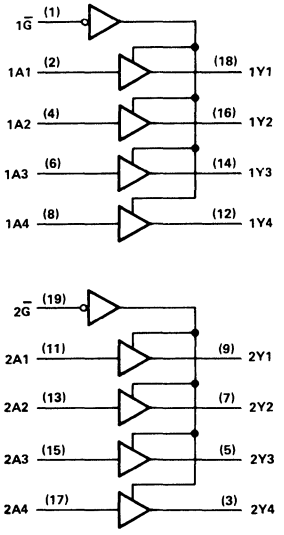
J Suffix—Case 732-03 (Ceramic)
N Suffix—Case 738-01 (Plastic)

description

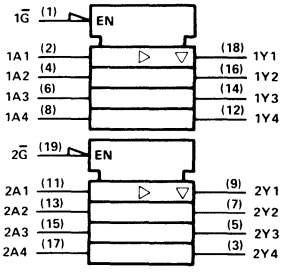
These octal buffers and line drivers are designed specifically to improve both the performance and density of three-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Taken together with the 'ALS240, and 'ALS241, these devices provide the choice of selected combinations of inverting outputs, symmetrical $\overline{G}$ (active-low input control) inputs, and complementary G and $\overline{G}$ inputs.

The SN54ALS244 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS244 is characterized for operation from 0°C to 70°C.

logic diagram (positive logic)



logic symbol



Pin numbers shown are for J and N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage . . . . . 7 V
Voltage applied to a disabled 3-state output . . . . . 5.5 V
Operating free-air temperature range: SN54ALS244 . . . . . −55 °C to 125 °C
SN74ALS244 . . . . . 0 °C to 70 °C
Storage temperature range . . . . . −65 °C to 150 °C

recommended operating conditions

		SN54ALS244			SN74ALS244			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−12				mA
							−15	
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS244			SN74ALS244			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}	V_{CC} = 4.5 V,	I_{OH} = −3 mA	2.4	3.2		2.4	3.2		V
	V_{CC} = 4.5 V,	I_{OH} = −12 mA	2						
	V_{CC} = 4.5 V,	I_{OH} = −15 mA				2			
V_{OL}	V_{CC} = 4.5 V	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
	V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_{OZH}	V_{CC} = 5.5 V,	V_O = 2.7 V			20			20	μA
I_{OZL}	V_{CC} = 5.5 V,	V_O = 0.4 V			−20			−20	μA
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
I_O*	V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}	V_{CC} = 5.5 V	Outputs high			11.5			11.5	mA
		Outputs low			23			23	
		Outputs disabled			27			27	

‡All typical values are at V_{CC} = 5 V, T_A = 25 °C.
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.

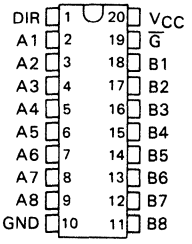
switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS244		SN74ALS244		
			MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	3	14	3	11	ns
t_{PHL}			3	13	3	10	
t_{PZH}	$\overline{G}$	Y	7	25	7	21	ns
t_{PZL}			7	25	7	21	
t_{PHZ}	$\overline{G}$	Y	2	15	2	14	ns
t_{PLZ}			3	22	3	17	

5

- **3-State Outputs Drive Bus Lines Directly**
- **P-N-P Inputs Reduce DC Loading**

(TOP VIEW)



J Suffix—Case 732-03 (Ceramic)
N Suffix—Case 738-01 (Plastic)

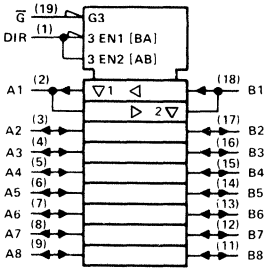
description

These octal bus transceivers are designed for synchronous two-way communication between data buses. The control function implementation minimizes external timing requirements.

The devices allow data transmission from the A bus to the B bus or from the B bus to the A bus depending upon the logic level at the direction control (DIR) input. The enable input ($\overline{G}$) can be used to disable the device so that the buses are effectively isolated.

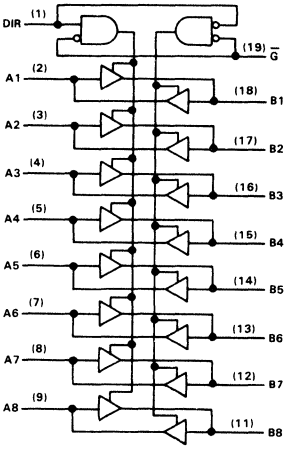
The SN54ALS245 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74ALS245 is characterized for operation from 0°C to 70°C.

logic symbol



Pin numbers shown are for J and N packages

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage: All inputs . . . . . 7 V
I/O ports . . . . . 5.5 V
Operating free-air temperature range: SN54ALS245 . . . . . −55°C to 125°C
SN74ALS245 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

		SN54ALS245			SN74ALS245			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−12				mA
							−15	
I_{OL}	Low-level output current			12				mA
							24	
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS245			SN74ALS245			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}		V_{CC} = 4.5 V,	I_{OH} = −3 mA	2.4	3.2		2.4	3.2		V
		V_{CC} = 4.5 V,	I_{OH} = −12 mA	2						
		V_{CC} = 4.5 V,	I_{OH} = −15 mA				2			
V_{OL}		V_{CC} = 4.5 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
		V_{CC} = 4.5 V,	I_{OL} = 24 mA					0.35	0.5	
I_I	Control inputs	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
	A or B ports	V_{CC} = 5.5 V,	V_I = 5.5 V			0.1			0.1	
I_{IH}	Control inputs	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	μA
	A or B ports▲					20			20	
I_{IL}	Control inputs	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.1			−0.1	mA
	A or B ports▲					−0.1			−0.1	
I_O*		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	−30		−112	mA
I_{CC}		V_{CC} = 5.5 V	Outputs high			35			35	mA
			Outputs low			45			45	
			Outputs disabled			47.5			47.5	

‡All typical values are at V_{CC} = 5 V, T_A = 25°C
*The current produced by grounding the outputs is approximately twice that produced with 2.25 V on the outputs.
▲For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current

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switching characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX				UNIT
			SN54ALS245		SN74ALS245		
			MIN	MAX	MIN	MAX	
t_{PLH}	A or B	B or A	3	16	3	12	ns
t_{PHL}			3	14	3	12	
t_{PZH}	$\overline{G}$	A or B	7	20	8	17	ns
t_{PZL}			10	22	10	20	
t_{PHZ}	$\overline{G}$	A or B	3	16	3	14	ns
t_{PLZ}			4	23	4	20	

5

SCHOTTKY TTL

FAST Data Sheets

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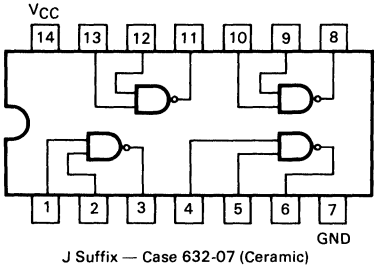
MOTOROLA

MC54F00
MC74F00

Advance Information

QUAD 2-INPUT NAND GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NAND GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				2.8	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				10.2	mA	V_{CC} = MAX, V_{IN} = Open	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.4	5.0	2.0	7.0	2.4	6.0	ns
t_{PHL}	Propagation Delay	2.0	4.3	1.5	6.5	2.0	5.3	ns

AC TEST CIRCUIT

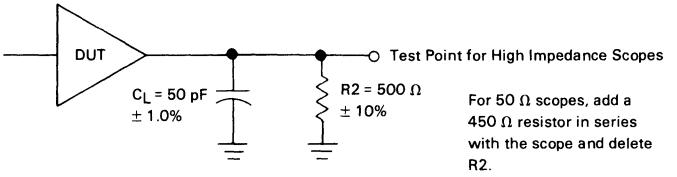


Fig. 1

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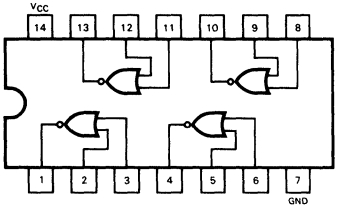
MOTOROLA

MC54F02
MC74F02

Advance Information

QUAD 2-INPUT NOR GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT NOR GATE
FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				5.6	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				13	mA	V_{CC} = MAX, V_{IN} = Note 3	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.
3. Measured with one input high, one input low for each gate.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.5	5.5	2.5	7.5	2.5	6.5	ns
t_{PHL}	Propagation Delay	2.0	4.3	1.5	6.5	2.0	5.3	ns

AC TEST CIRCUIT

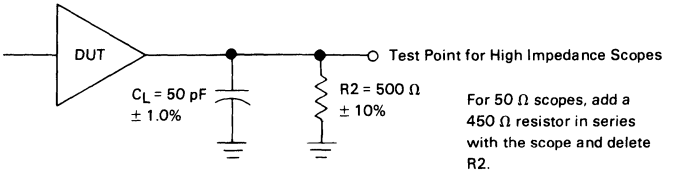

Fig. 1

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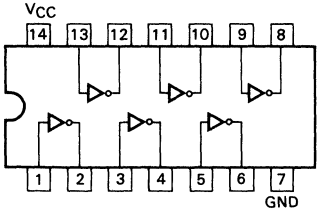
MOTOROLA

MC54F04
MC74F04

Advance Information

HEX INVERTER



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

HEX INVERTER

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				4.2	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				15.3	mA	V_{CC} = MAX, V_{IN} = Open	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = −55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.4	5.0	2.0	7.0	2.4	6.0	ns
t_{PHL}	Propagation Delay	2.0	4.3	1.5	6.5	2.0	5.3	ns

AC TEST CIRCUIT

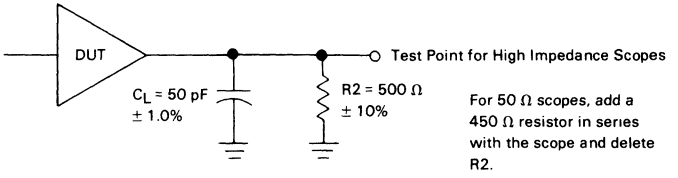


Fig. 1

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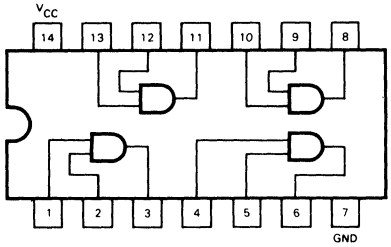
MOTOROLA

MC54F08
MC74F08

Advance Information

QUAD 2-INPUT AND GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT AND GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				8.3	mA	V_{CC} = MAX, V_{IN} = Open	
	Total, Output LOW				12.9	mA	V_{CC} = MAX, V_{IN} = GND	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	3.0	5.6	2.5	7.5	3.0	6.6	ns
t_{PHL}	Propagation Delay	2.5	5.3	2.0	7.5	2.5	6.3	ns

AC TEST CIRCUIT

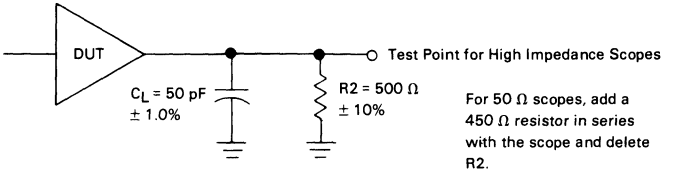


Fig. 1

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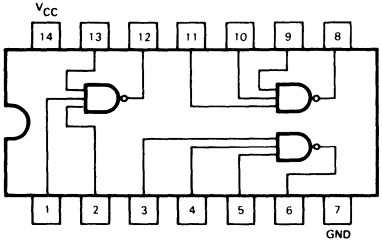
MOTOROLA

MC54F10
MC74F10

Advance Information

TRIPLE 3-INPUT NAND GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

TRIPLE 3-INPUT NAND GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				2.1	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				7.7	mA	V_{CC} = MAX, V_{IN} = Open	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.4	5.0	2.0	7.0	2.4	6.0	ns
t_{PHL}	Propagation Delay	2.0	4.3	1.5	6.5	2.0	5.3	ns

AC TEST CIRCUIT

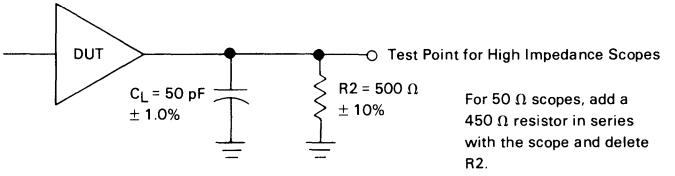


Fig. 1

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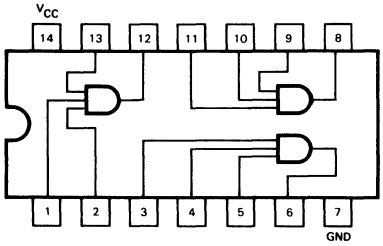
MOTOROLA

MC54F11
MC74F11

Advance Information

TRIPLE 3-INPUT AND GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

TRIPLE 3-INPUT AND GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				6.2	mA	V_{CC} = MAX, V_{IN} = Open	
	Total, Output LOW				9.7	mA	V_{CC} = MAX, V_{IN} = GND	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = −55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	3.0	5.6	2.5	7.5	3.0	6.6	ns
t_{PHL}	Propagation Delay	2.5	5.5	2.0	7.5	2.5	6.5	ns

AC TEST CIRCUIT

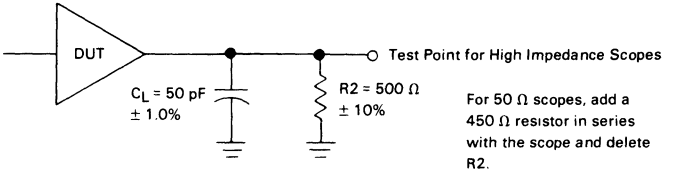

Fig. 1

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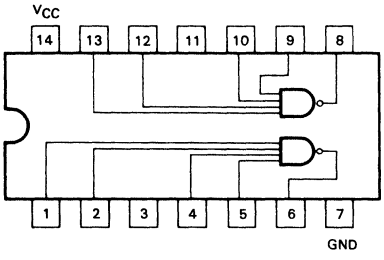
MOTOROLA

MC54F20
MC74F20

Advance Information

DUAL 4-INPUT NAND GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

DUAL 4-INPUT NAND GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				1.4	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				5.1	mA	V_{CC} = MAX, V_{IN} = Open	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.4	5.0	2.0	7.0	2.4	6.0	ns
t_{PHL}	Propagation Delay	2.0	4.3	1.5	6.5	2.0	5.3	ns

AC TEST CIRCUIT

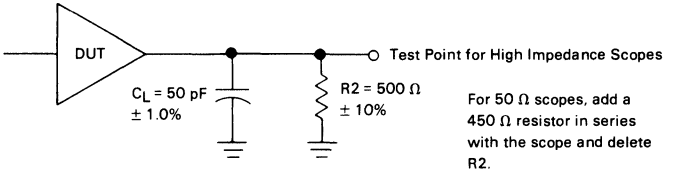


Fig. 1

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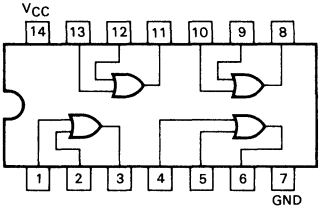
MOTOROLA

MC54F32
MC74F32

Advance Information

QUAD 2-INPUT OR GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

QUAD 2-INPUT OR GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range and will meet the specifications of 54ALS devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54, 74	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH CUrrent				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current Total, Output HIGH				9.2	mA	V_{CC} = MAX, V_{IN} = GND	
	Total, Output LOW				15.5	mA	V_{CC} = MAX, V_{IN} = Open	

NOTES:
1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time.

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6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$ $V_{CC} = +5.0$ V $C_L = 50$ pF		54F $T_A = -55°C$ to $+125°C$ $V_{CC} = 5.0$ V ± 10% $C_L = 50$ pF		74F $T_A = 0°C$ to $70°C$ $V_{CC} = 5.0$ V ± 5% $C_L = 50$ pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	3.0	5.6	3.0	7.5	3.0	6.6	ns
t_{PHL}	Propagation Delay	3.0	5.3	2.5	7.5	3.0	6.3	ns

AC TEST CIRCUIT

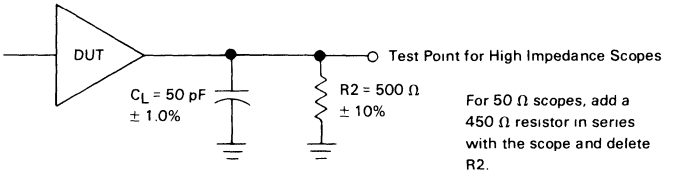

Fig. 1

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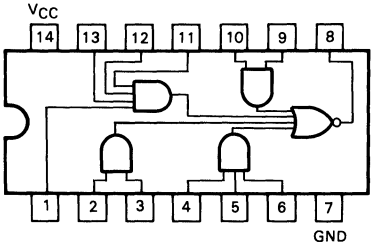
MC54F64
MC74F64

Advance Information

4-2-3-2-INPUT AND-OR-INVERT GATE



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

4-2-3-2-INPUT AND-OR-INVERT GATE

FAST™ SCHOTTKY TTL

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			−1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				−1.2	V	I_{IN} = −18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = −1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = −1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					0.1	mA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				−0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		−60		−150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current Total, Output HIGH				2.8	mA	V_{IN} = GND	V_{CC} = MAX
	Total, Output LOW				4.7	mA	V_{IN} = *	

NOTES:
1. For conditions shown as MIN or MAX, use the appropiate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.
* I_{CCL} is measured with all inputs of one gate open and remaining inputs grounded.

FAST is a trademark of Fairchild Camera and Instrument Corporation.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF		54F T_A = -55°C to +125°C V_{CC} = 5.0 V ± 10% C_L = 50 pF		74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.5	6.0	2.5	8.0	2.5	7.0	ns
t_{PHL}	Propagation Delay	2.0	4.5	1.5	6.5	2.0	5.5	ns

AC TEST CIRCUIT

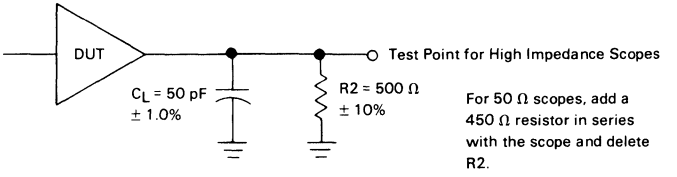

Fig. 1

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MOTOROLA

MC54F74
MC74F74

Advance Information

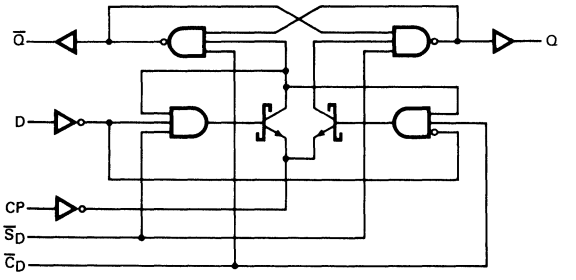
DUAL D-TYPE POSITIVE EDGE-TRIGGERED FLIP-FLOP

DESCRIPTION — The MC54F/74F74 is a dual D-type flip-flop with Direct Clear and Set inputs and complementary (Q, $\overline{Q}$) outputs. Information at the input is transferred to the outputs on the positive edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. After the Clock Pulse input threshold voltage has been passed, the Data input is locked out and information present will not be transferred to the outputs until the next rising edge of the Clock Pulse input.

DUAL D-TYPE POSITIVE EDGE-TRIGGERED FLIP-FLOP

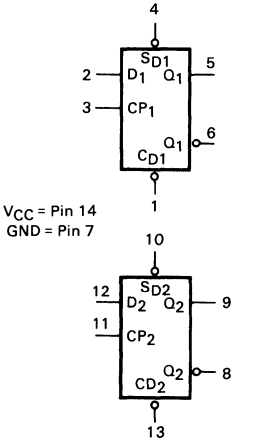
FAST™ SCHOTTKY TTL

LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

LOGIC SYMBOL



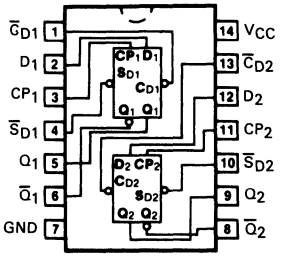
TRUTH TABLE
(Each Half)

INPUT	OUTPUTS	
@ t_n	@ $t_n + 1$	
D	Q	$\overline{Q}$
L	L	H
H	H	L

Asynchronous Inputs:
LOW Input to $\overline{S}_D$ sets Q to HIGH level
LOW Input to $\overline{C}_D$ sets Q to LOW level
Clear and Set are indepedent of clock
Simultaneous LOW on $\overline{C}_D$ and $\overline{S}_D$ makes both Q and $\overline{Q}$ HIGH

H = HIGH Voltage Level
L = LOW Voltage Level
t_n = Bit time before clock pulse
$t_n + 1$ = Bit time after clock pulse

CONNECTION DIAGRAM



J Suffix — Case 632-07
(Ceramic)
N Suffix — Case 646-05
(Plastic)

FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

* 74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current (CP and D Inputs)				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	($\overline{C}_D$ and $\overline{S}_D$ Inputs)				-1.8	mA		
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			10.5	16	mA	V_{CP} = 0 V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
f_{max}	Maximum Clock Frequency	100	125		100		100		MHz
t_{PLH}	Propagation Delay	3.8	5.3	6.8	3.8	8.5	3.8	7.8	ns
t_{PHL}	CP_n to Q_n or $\overline{Q}_n$	4.4	6.2	8.0	4.4	10.5	4.4	9.2	
t_{PLH}	Propagation Delay	3.2	4.6	6.1	3.2	8.0	3.2	7.1	ns
t_{PHL}	$\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to Q_n or $\overline{Q}_n$	3.5	7.0	9.0	3.5	11.5	3.5	10.5	

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Set up Time, HIGH or LOW D_n to CP_n	2.0 3.0			3.0 4.0		2.0 3.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW D_n to CP_n	1.0 1.0			2.0 2.0		1.0 1.0		
t_w (H) t_w (L)	CP_n Pulse Width, HIGH or LOW	4.0 5.0			4.0 6.0		4.0 5.0		ns
t_w (L)	$\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ Pulse Width LOW	4.0			4.0		4.0		ns
t_{rec}	Recovery Time $\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to CP	2.0			3.0		2.0		ns

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MOTOROLA

MC54F86
MC74F86

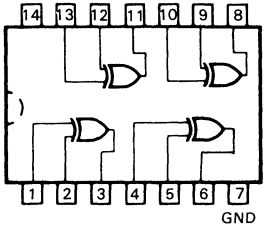
Advance Information

QUAD 2-INPUT EXCLUSIVE-OR GATE

QUAD 2-INPUT EXCLUSIVE-OR GATE

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



J Suffix — Case 632-07 (Ceramic)
N Suffix — Case 646-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

* 74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN,
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			15	23	mA	Inputs LOW	V_{CC} = MAX
				18	28		Inputs HIGH	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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This document contains information on a new product. Specifications and information herein are subject to change without notice.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	3.0	4.0	5.5	3.0	7.0	3.0	6.5	ns
t_{PHL}	(Other Input LOW)	3.0	4.2	5.5	3.0	7.0	3.0	6.5	
t_{PLH}	Propagation Delay	3.5	5.3	7.0	3.5	8.5	3.5	8.0	ns
t_{PHL}	(Other Input HIGH)	3.0	4.7	6.5	3.0	8.0	3.0	7.5	

6

MOTOROLA

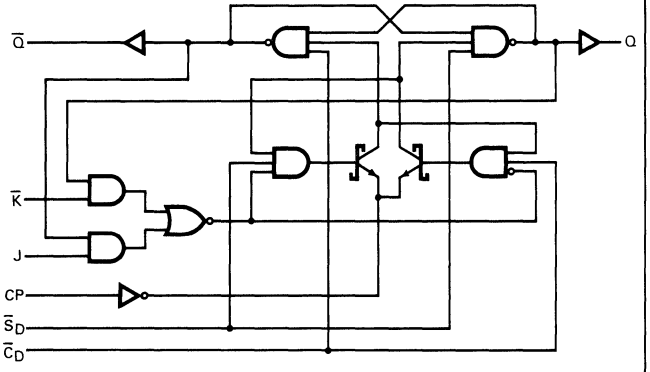
MC54F109
MC74F109

Advance Information

DUAL J$\overline{K}$ POSITIVE EDGE-TRIGGERED FLIP-FLOP

DESCRIPTION — The MC54F/74F109 consists of two high-speed, completely independent transition clocked J$\overline{K}$ flip-flops. The clocking operation is independent of rise and fall times of the clock waveform. The J$\overline{K}$ design allows operation as a D flip-flop (refer to 'F74 data sheet) by connecting the J and $\overline{K}$ inputs together.

LOGIC DIAGRAM (one half shown)



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

TRUTH TABLE

INPUTS		OUTPUTS	
@ t_n		@ t_{n+1}	
J	$\overline{K}$	Q	$\overline{Q}$
L	H	No Change	
L	L	L	H
H	H	H	L
H	L	Toggles	

Asynchronous Inputs:
LOW Input to $\overline{S}_D$ sets Q to HIGH level
LOW Input to $\overline{C}_D$ sets Q to LOW level
Clear and Set are indepedent of clock
Simultaneous LOW on $\overline{C}_D$ and $\overline{S}_D$ makes both Q and $\overline{Q}$ HIGH

t_n = Bit time before clock pulse
$t_n + 1$ = Bit time after clock pulse
H = HIGH Voltage Level
L = LOW Voltage Level

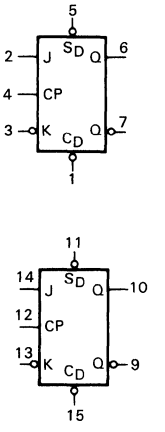
FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product Specifications and information herein are subject to change without notice

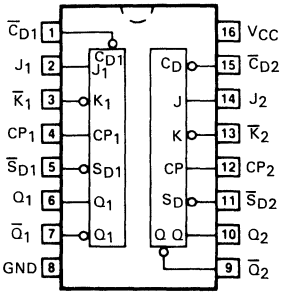
DUAL J$\overline{K}$ POSITIVE EDGE-TRIGGERED FLIP-FLOP

FAST™ SCHOTTKY TTL

LOGIC SYMBOL



CONNECTION DIAGRAM



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.50 4.75	5.0 5.0	5.50 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current (J, $\overline{K}$ and CP Inputs)				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	($\overline{C}_D$ and $\overline{S}_D$ Inputs)				-1.8	mA		
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			11.7	17	mA	V_{CP} = 0 V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
f_{max}	Maximum Clock Frequency	90	125		90		90		MHz
t_{PLH} t_{PHL}	Propagation Delay CP_n to Q_n or $\overline{Q}_n$	3.8 4.4	5.3 6.2	7.0 8.0	3.8 4.4	9.0 10.5	3.8 4.4	8.0 9.2	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to Q_n or $\overline{Q}_n$	3.2 3.5	5.2 7.0	7.0 9.0	3.2 3.5	9.0 11.5	3.2 3.5	8.0 10.5	ns

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Set up Time, HIGH or LOW J_n or $\overline{K}_n$ to CP_n	3.0 3.0			3.0 3.0		3.0 3.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW J_n or $\overline{K}_n$ to CP_n	1.0 1.0			1.0 1.0		1.0 1.0		
t_w (H) t_w (L)	CP_n Pulse Width, HIGH or LOW	4.0 5.0			4.0 5.0		4.0 5.0		ns
t_w (L)	$\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ Pulse Width LOW	4.0			4.0		4.0		ns
t_{rec}	Recovery Time $\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to CP	2.0			2.0		2.0		ns

6

MOTOROLA

MC54F138
MC74F138

Advance Information

1-OF-8 DECODER/DEMULTIPLEXER

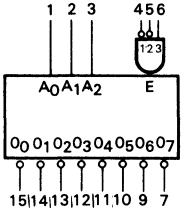
1-OF-8 DECODER/ DEMULTIPLEXER

FAST™ SCHOTTKY TTL

DESCRIPTION — The MC54F/74F138 is a high speed 1-of-8 Decoder/Demultiplexer. This device is ideally suited for high speed bipolar memory chip select address decoding. The multiple input enables allow parallel expansion to a 1-of-24 decoder using just three F138 devices or to a 1-of-32 decoder using four F138s and one inverter.

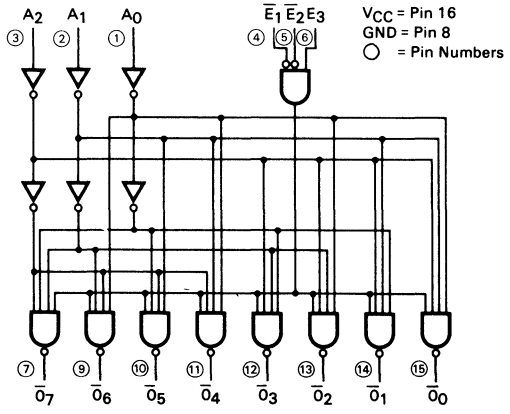
- DEMULTIPLEXING CAPABILITY
- MULTIPLE INPUT ENABLE FOR EASY EXPANSION
- ACTIVE LOW MUTUALLY EXCLUSIVE OUTPUTS
- INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS

LOGIC SYMBOL

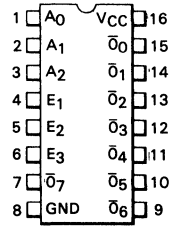


V_{CC} = Pin 16
GND = Pin 8

LOGIC DIAGRAM



CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package.

FAST is a trademark of Fairchild Camera and Instrument Corporation.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

* 74F devices may be operated over the 4 5 to 5 5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current				20	mA	V_{CC} = MAX	

AC CHARACTERISTICS

SYMBOL	PARAMETER	LEVELS OF DELAY	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	54/74F MAX	54F T_A = -55°C to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	54F MAX	74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF MIN	74F MAX	UNITS
t_{PLH}	Propagation Delay,	3	3.5	7.0	3.5	12	3.5	8.0	ns
t_{PHL}	Address to Output		4.0	8.0	4.0	9.5	4.0	9.0	ns
t_{PLH}	Enable to Output	2	3.5	7.0	3.5	11	3.5	8.0	ns
t_{PHL}	$\overline{E}_1$ or $\overline{E}_2$		3.0	7.0	3.0	8.0	3.0	7.5	ns
t_{PLH}	Enable to Output	3	4.0	8.0	4.0	12.5	4.0	9.0	ns
t_{PHL}	E3		3.5	7.5	3.5	8.5	3.5	8.5	ns

NOTES
1 For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type
2 Not more than one output should be shorted at a time, nor for more than 1 second.

6

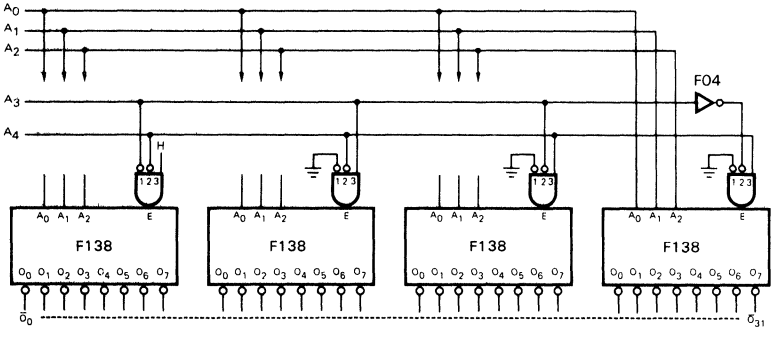
FUNCTIONAL DESCRIPTION — The decoder accepts three binary weighted inputs (A_0, A_1, A_2) and when enabled provides eight mutually exclusive active LOW outputs ($\overline{O}_0$–$\overline{O}_7$). The F138 features three Enable inputs, two active LOW ($\overline{E}_1$, $\overline{E}_2$) and one active HIGH (E_3). All outputs will be HIGH unless $\overline{E}_1$ and $\overline{E}_2$ are LOW and E_3 is HIGH. This multiple enable function allows easy parallel expansion of the device to a 1-of-32 (5 lines to 32 lines) decoder with just four F138s and one inverter.

The F138 can be used as an 8-output demultiplexer by using one of the active LOW Enable inputs as the data input and the other Enable inputs as strobes. The Enable inputs which are not used must be permanently tied to their appropriate active HIGH or active LOW state.

TRUTH TABLE

INPUTS						OUTPUTS							
$\overline{E}_1$	$\overline{E}_2$	E_3	A_0	A_1	A_2	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$	$\overline{O}_4$	$\overline{O}_5$	$\overline{O}_6$	$\overline{O}_7$
H	X	X	X	X	X	H	H	H	H	H	H	H	H
X	H	X	X	X	X	H	H	H	H	H	H	H	H
X	X	L	X	X	X	H	H	H	H	H	H	H	H
L	L	H	L	L	L	L	H	H	H	H	H	H	H
L	L	H	H	L	L	H	L	H	H	H	H	H	H
L	L	H	L	H	L	H	H	L	H	H	H	H	H
L	L	H	H	H	L	H	H	H	L	H	H	H	H
L	L	H	L	L	H	H	H	H	H	L	H	H	H
L	L	H	H	L	H	H	H	H	H	H	L	H	H
L	L	H	L	H	H	H	H	H	H	H	H	L	H
L	L	H	H	H	H	H	H	H	H	H	H	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care



6

AC TEST CIRCUIT

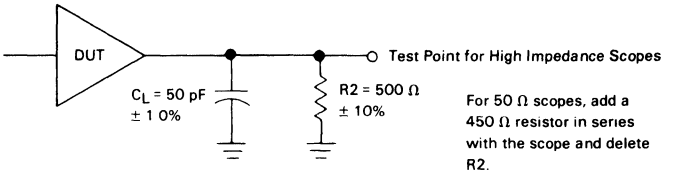


Fig. 1

AC WAVEFORMS

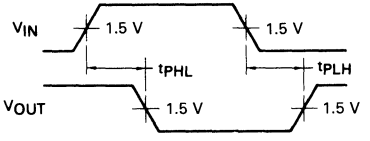


Fig. 2

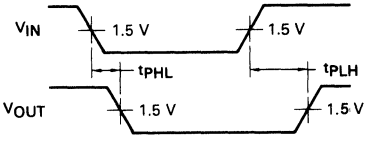


Fig. 3

6

MOTOROLA

MC54F139
MC74F139

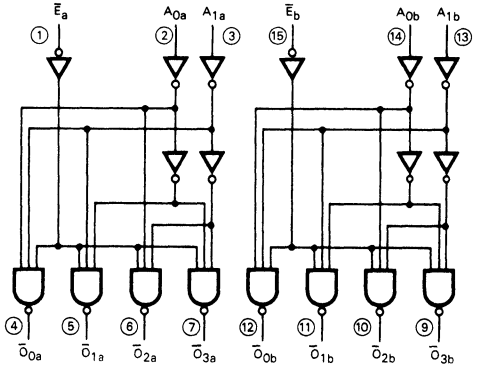
Advance Information

DUAL 1-OF-4 DECODER

DESCRIPTION — The MC54F/74F139 is a high speed Dual 1-of-4 Decoder/Demultiplexer. The device has two independent decoders, each accepting two inputs and providing four mutually exclusive active LOW Outputs. Each decoder has an active LOW Enable input which can be used as a data input for a 4-output demultiplexer. Each half of the F139 can be used as a function generator providing all four minterms of two variables.

- MULTIFUNCTION CAPABILITY
- TWO COMPLETELY INDEPENDENT 1-OF-4 DECODERS
- ACTIVE LOW MUTUALLY EXCLUSIVE OUTPUTS
- INPUT CLAMP DIODES LIMIT HIGH SPEED TERMINATION EFFECTS

LOGIC DIAGRAM



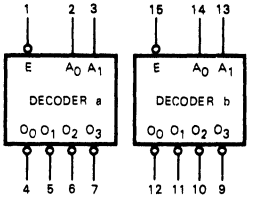
V_{CC} = Pin 16
GND = Pin 8
○ = Pin Numbers

FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product Specifications and information herein are subject to change without notice

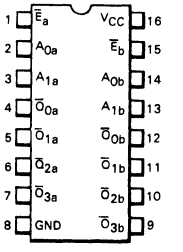
DUAL 1-OF-4 DECODER
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM
DIP (TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

NOTE:
The Flatpak version has the same pinouts (Connection Diagram) as the Dual In-Line Package

6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	-55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	V_{CC} = MIN, I_{IN} = -18 mA	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{CC} = MAX, V_{IN} = 2.7 V	
					0.1	mA	V_{CC} = MAX, V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{CC} = MAX, V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{CC} = MAX, V_{OUT} = 0 V	
I_{CC}	Power Supply Current				20	mA	V_{CC} = MAX	

AC CHARACTERISTICS:

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	54/74F MAX	54F T_A = -55°C to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	54F MAX	74F T_A = 0°C to 70°C V_{CC} = 5.0 V ± 5% C_L = 50 pF MIN	74F MAX	UNITS
t_{PLH}	Propagation Delay,	3.5	7.0	2.5	9.5	3.0	8.0	ns
t_{PHL}	Address to Output	4.0	8.0	3.5	9.5	4.0	9.0	ns
t_{PLH}	Enable to Output	3.5	7.0	3.0	9.0	3.5	8.0	ns
t_{PHL}		3.0	6.5	2.5	8.0	3.0	7.5	ns

NOTES:
1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

6

FUNCTIONAL DESCRIPTION — The F139 is a high speed dual 1-of-4 decoder/demultiplexer fabricated with the Schottky barrier diode process. The device has two independent decoders, each of which accept two binary weighted inputs (A_0, A_1) and provide four mutually exclusive active LOW outputs ($\overline{O}_0$–$\overline{O}_3$). Each decoder has an active LOW Enable ($\overline{E}$). When $\overline{E}$ is HIGH all outputs are forced HIGH. The enable can be used as the data input for a 4-output demultiplexer application.

Each half of the F139 generates all four miniterms of two variables. These four miniterms are useful in some applications, replacing multiple gate functions as shown in Fig. a, and thereby reducing the number of packages required in a logic network.

TRUTH TABLE

INPUTS			OUTPUTS			
$\overline{E}$	A_0	A_1	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$
H	X	X	H	H	H	H
L	L	L	L	H	H	H
L	H	L	H	L	H	H
L	L	H	H	H	L	H
L	H	H	H	H	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

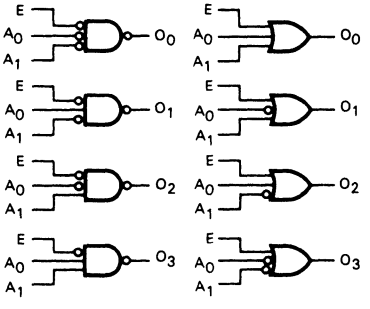


Fig. a

AC WAVEFORMS

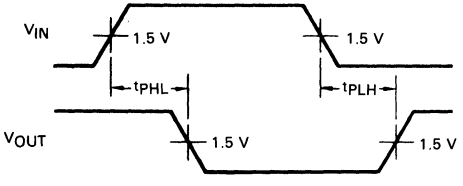


Fig. 1

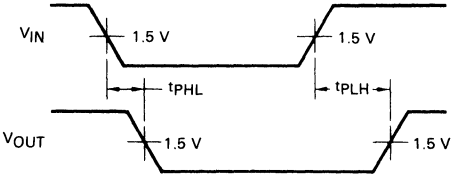


Fig. 2

AC TEST CIRCUIT

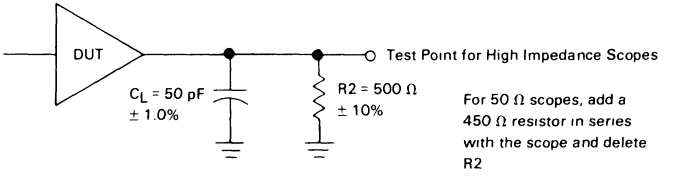


Fig. 3

MOTOROLA

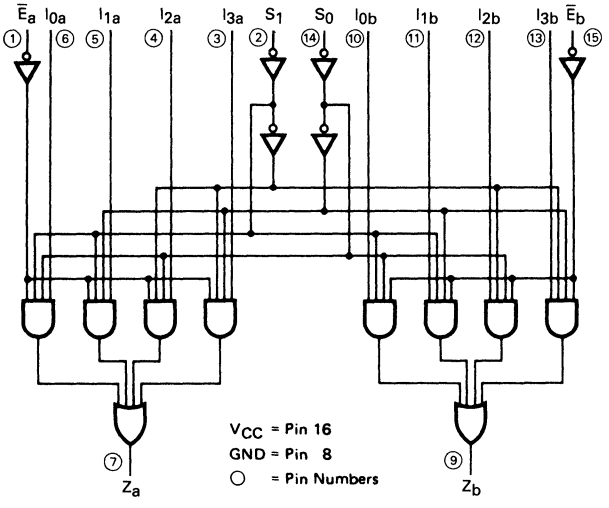
MC54F153
MC74F153

Advance Information

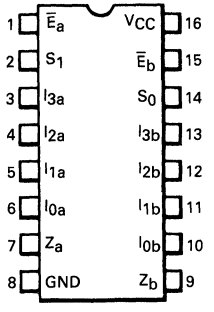
DESCRIPTION — The MC54F/74F153 is a high-speed Dual 4-Input Multiplexer with common select inputs and individual enable inputs for each section. It can select two lines of data from four sources. The two buffered outputs present data in the true (non-inverted) form. In addition to multiplexer operation, the F153 can generate any two functions of three variables.

DUAL 4-INPUT MULTIPLEXER
FAST™ SCHOTTKY TTL

LOGIC DIAGRAM



CONNECTION DIAGRAM DIP
(TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74	—	—	−1.0	mA
I_{OL}	Output Current — Low	54, 74	—	—	20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0°C to 70°C temperature range.

FUNCTIONAL DESCRIPTION

The F153 is a Dual 4-Input Multiplexer. It can select two bits of data from up to four sources under the control of the common Select Inputs (S_0, S_1). The two 4-input multiplexer circuits have individual active LOW Enables ($\overline{E}_a$, $\overline{E}_b$) which can be used to strobe the outputs independently. When the Enables ($\overline{E}_a$, $\overline{E}_b$) are HIGH, the corresponding outputs (Z_a, Z_b) are forced LOW.

The F153 is the logic implementation of a 2-pole, 4-position switch, where the position of the switch is determined by the logic levels supplied to the two Select Inputs. The logic equations for the outputs are shown below:

$$Z_a = \overline{E}_a \cdot (I_{0a} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1a} \cdot \overline{S}_1 \cdot S_0 + I_{2a} \cdot S_1 \cdot \overline{S}_0 + I_{3a} \cdot S_1 \cdot S_0)$$
$$Z_b = \overline{E}_b \cdot (I_{0b} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1b} \cdot \overline{S}_1 \cdot S_0 + I_{2b} \cdot S_1 \cdot \overline{S}_0 + I_{3b} \cdot S_1 \cdot S_0)$$

The F153 can be used to move data from a group of registers to a common output bus. The particular register from which the data came would be determined by the state of the Select Inputs. A less obvious application is a function generator. The F153 can generate two functions of three variables. This is useful for implementing highly irregular random logic.

TRUTH TABLE

SELECT INPUTS		INPUTS (a or b)					OUTPUT
S_0	S_1	$\overline{E}$	I_0	I_1	I_2	I_3	Z
X	X	H	X	X	X	X	L
L	L	L	L	X	X	X	L
L	L	L	H	X	X	X	H
H	L	L	X	L	X	X	L
H	L	L	X	H	X	X	H
L	H	L	X	X	L	X	L
L	H	L	X	X	H	X	H
H	H	L	X	X	X	L	L
H	H	L	X	X	X	H	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				−1.2	V	I_{IN} = −18 mA, V_{CC} = MIN	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OL} = −1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OL} = −1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V, V_{CC} = MAX	
					0.1	mA	V_{IN} = 7.0 V, V_{CC} = MAX	
I_{IL}	Input LOW Current				−0.6	mA	V_{IN} = 0.5 V, V_{CC} = MAX	
I_{OS}	Output Short Circuit Current (Note 2)		−60		−150	mA	V_{OUT} = 0 V, V_{CC} = MAX	
I_{CC}	Power Supply Current				20	mA	V_{IN} = GND, V_{CC} = MAX	

NOTES:
1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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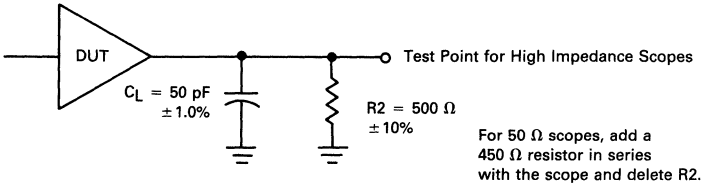
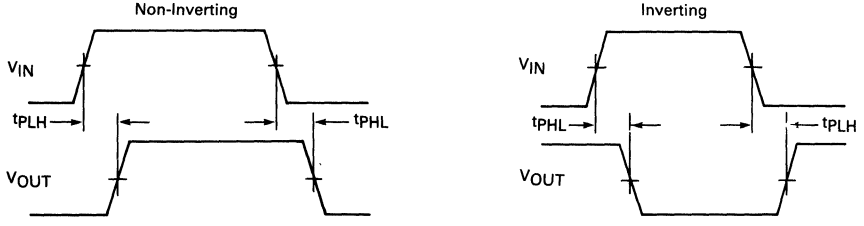
AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$ $V_{CC} = +5.0\ V$ $C_L = 50\ pF$		54F $T_A = -55°C$ to $+125°C$ $V_{CC} = 5.0\ V \pm 10\%$ $C_L = 50\ pF$		74F $T_A = 0°C$ to $+70°C$ $V_{CC} = 5.0\ V \pm 5.0\%$ $C_L = 50\ pF$		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay S_n to Z_n	5.5 4.0	10.5 9.0	5.0 3.5	14 11	5.5 4.0	12 10.5	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{E}_n$ to Z_n	5.0 4.0	9.0 7.0	4.5 3.5	11.5 9.0	5.0 4.0	10.5 8.0	ns
t_{PLH} t_{PHL}	Propagation Delay I_n to Z_n	4.0 3.0	7.0 6.5	3.5 2.5	9.0 8.0	4.0 3.0	8.0 7.5	ns

AC TEST CIRCUIT



PROPAGATION DELAY MEASUREMENTS



NOTES:
1. All input waveforms have the following characteristics:
   Low Level = 0 V
   High Level = 3.0 V
   Rise and Fall Times (10% to 90%) = 2.5 ns

2. All timing is measured at 1.5 V unless otherwise indicated.

MOTOROLA

MC54F157
MC74F157

Advance Information

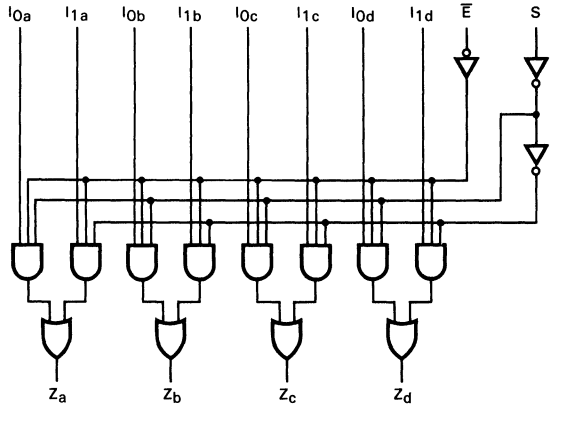
QUAD 2-INPUT MULTIPLEXER

DESCRIPTION — The MC54F/74F157 is a high-speed quad 2-input multiplexer. Four bits of data from two sources can be selected using the common Select and Enable inputs. The four buffered outputs present the selected data in the true (non-inverted) form. The 'F157 can also be used to generate any four of the 16 different functions to two variables.

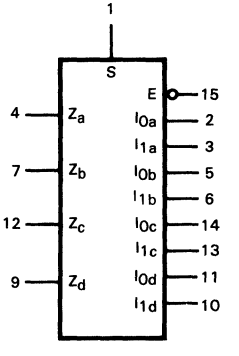
QUAD 2-INPUT MULTIPLEXER

FAST™ SCHOTTKY TTL

LOGIC DIAGRAM



LOGIC SYMBOL



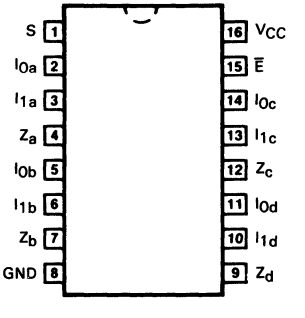
V_{CC} = Pin 16
GND = Pin 8

TRUTH TABLE

INPUTS				OUTPUT
$\overline{E}$	S	I_0	I_1	Z
H	X	X	X	L
L	H	X	L	L
L	H	X	H	H
L	L	L	X	L
L	L	H	X	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

FAST is a trademark of Fairchild Camera and Instrument Corporation.
This document contains information on a new product. Specifications and information herein are subject to change without notice.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN,
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			15	23	mA	All Inputs = 4.5 V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

6

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	4.5	10.1	13	3.5	17	4.5	15	ns
t_{PHL}	S to Z_n	3.5	6.3	8.0	3.5	11.5	3.5	9.0	
t_{PLH}	Propagation Delay	5.0	7.6	10	5.0	15	5.0	11.5	ns
t_{PHL}	$\overline{E}$ to Z_n	3.8	5.3	7.0	3.8	8.5	3.8	8.0	
t_{PLH}	Propagation Delay	3.8	5.5	7.0	3.5	10	3.8	8.0	ns
t_{PHL}	I_n to Z_n	2.5	4.6	5.5	2.5	7.5	2.5	7.0	

FUNCTIONAL DESCRIPTION — The F157 is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S). The Enable input ($\overline{E}$) is active LOW. When $\overline{E}$ is HIGH, all of the outputs (Z) are forced LOW regardless of all other inputs. The F157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$Z_a = \overline{E} \cdot (I_{1a} \cdot S + I_{0a} \cdot \overline{S}) \qquad Z_b = \overline{E} \cdot (I_{1b} \cdot S + I_{0b} \cdot \overline{S})$$
$$Z_c = \overline{E} \cdot (I_{1c} \cdot S + I_{0c} \cdot \overline{S}) \qquad Z_d = \overline{E} \cdot (I_{1d} \cdot S + I_{0d} \cdot \overline{S})$$

A common use of the F157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The F157 can generate any four of the 16 different functions of two variables with one variable common. This is useful for implementing highly irregular logic.

MOTOROLA

MC54F158
MC74F158

Advance Information

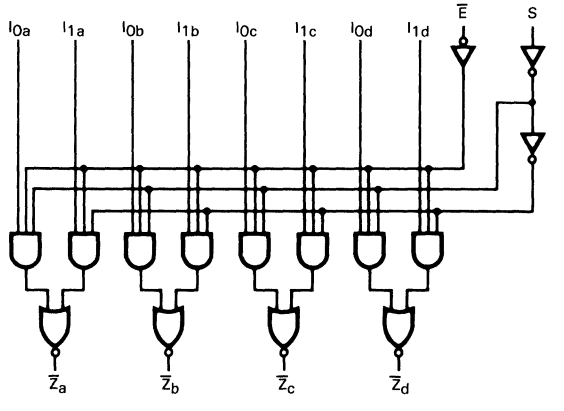
QUAD 2-INPUT MULTIPLEXER

DESCRIPTION — The MC54F/74F158 is a high-speed quad 2-input multiplexer. It selects four bits of data from two sources using the common Select and Enable inputs. The four buffered outputs present the selected data in the inverted form. The 'F158 can also generate any four of the 16 different functions of two variables.

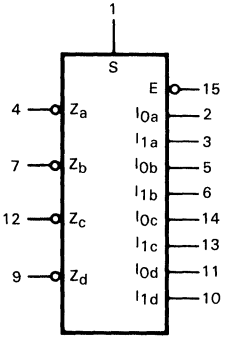
QUAD 2-INPUT MULTIPLEXER

FAST™ SCHOTTKY TTL

LOGIC DIAGRAM



LOGIC SYMBOL



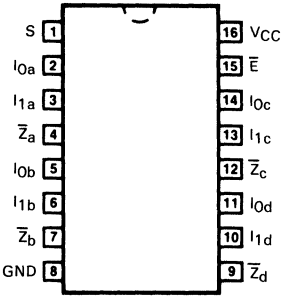
V_{CC} = Pin 16
GND = Pin 8

TRUTH TABLE

INPUTS				OUTPUTS
$\overline{E}$	S	I_0	I_1	$\overline{Z}$
H	X	X	X	H
L	L	L	X	H
L	L	H	X	L
L	H	X	L	H
L	H	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

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6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN,
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current*			10	15	mA	V_{CC} = MAX	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	4.0	6.4	8.5	4.0	10.5	4.0	9.5	ns
t_{PHL}	S to $\overline{Z}$	4.0	6.9	9.0	4.0	10.5	4.0	10.5	
t_{PLH}	Propagation Delay	4.5	6.2	8.0	4.5	9.5	4.5	9.0	ns
t_{PHL}	$\overline{E}$ to $\overline{Z}_n$	3.5	6.4	8.5	3.5	9.5	3.5	9.5	
t_{PLH}	Propagation Delay	3.0	4.4	5.9	2.5	8.5	3.0	7.0	ns
t_{PHL}	I_n to $\overline{Z}$	2.0	3.3	4.5	2.0	6.0	2.0	5.5	

*I_{CC} measured with outputs open and 4.5 V applied to all inputs.

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FUNCTIONAL DESCRIPTION — The F158 quad 2-input multiplexer selects four bits of data from two sources under the control of a common Select input (S) and presents the data in inverted form at the four outputs. The Enable input ($\overline{E}$) is active LOW. When $\overline{E}$ is HIGH, all of the outputs ($\overline{Z}$) are forced HIGH regardless of all other inputs. The F158 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input.

A common use of the F158 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The F158 can generate four functions of two variables with one variable n common. This is useful for implementing gating functions.

MOTOROLA

MC54F175
MC74F175

Advance Information

QUAD D FLIP-FLOP

DESCRIPTION — The MC54F/74F175 is a high-speed quad D flip-flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D inputs is stored during the LOW-to-HIGH clock transition. Both true and complemented outputs of each flip-flop are provided. A Master Reset input resets all flip-flops, independent of the Clock or D inputs when LOW.

- **EDGE-TRIGGERED D-TYPE INPUTS**
- **BUFFERED POSITIVE EDGE-TRIGGERED CLOCK**
- **ASYNCHRONOUS COMMON RESET**
- **TRUE AND COMPLEMENT OUTPUT**

FUNCTIONAL DESCRIPTION — The F175 consists of four edge-triggered D flip-flops with individual D inputs and Q and Q outputs. The Clock and Master Reset are common. The four flip-flops will store the state of their individual D inputs on the LOW-to-HIGH clock (CP) transition, causing individual Q and Q outputs to follow. A LOW input on the Master Reset (MR) will force all Q outputs LOW and Q outputs HIGH independent of Clock or Data inputs. The F175 is useful for general logic applications where a common Master Reset and Clock are acceptable.

TRUTH TABLE

INPUTS	OUTPUTS	
@ t_n, $\overline{MR}$ = H	@ t_{n+1}	
D_n	Q_n	$\bar{Q}_n$
L	L	H
H	H	L

t_n = Bit time before clock positive-going transition
t_{n+1} = Bit time after clock positive-going transition
H = HIGH Voltage Level
L = LOW Voltage Level

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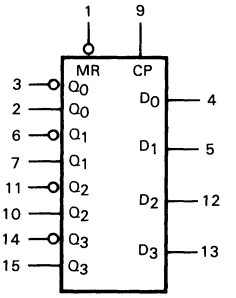
This document contains information on a new product. Specifications and information herein are subject to change without notice.

QUAD D FLIP-FLOP

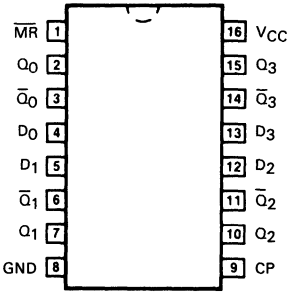
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

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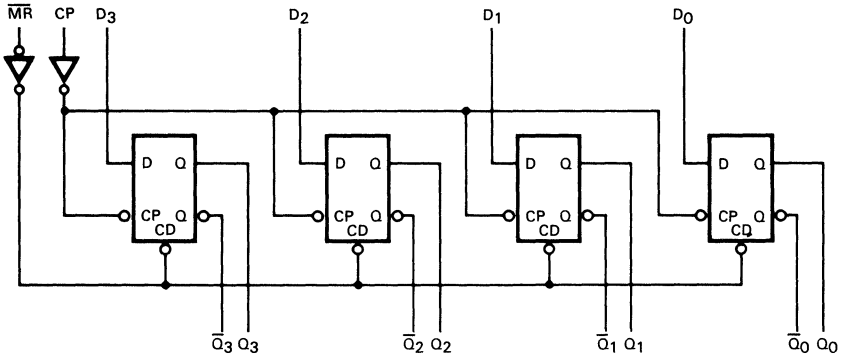
LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

* 74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	V_{CC} = MAX
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			22.5	34	mA	D_n = $\overline{MR}$ = 4.5 V, CP = ⎍	V_{CC} = Max

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$ $V_{CC} = +5.0\ V$ $C_L = 50\ pF$			54F $T_A = -55$ to $+125°C$ $V_{CC} = 5.0\ V \pm 10\%$ $C_L = 50\ pF$		74F $T_A = 0$ to $+70°C$ $V_{CC} = 5.0\ V \pm 5\%$ $C_L = 50\ pF$		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	Maximum Clock Frequency	100	140		100		100		MHz
t_{PLH} t_{PHL}	Propagation Delay CP to Q_n or $\overline{Q}_n$	4.0 4.0	5.0 6.5	6.5 8.5	3.5 4.0	8.5 10.5	4.0 4.0	7.5 9.5	ns
t_{PHL}	Propagation Delay $\overline{MR}$ to Q_n	4.5	9.0	11.5	4.5	15	4.5	13	ns
t_{PLH}	Propagation Delay $\overline{MR}$ to $\overline{Q}_n$	4.0	6.5	8.0	4.0	10	4.0	9.0	ns

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$ $V_{CC} = +5.0\ V$			54F $T_A = -55$ to $+125°C$ $V_{CC} = 5.0\ V \pm 10\%$		74F $T_A = 0$ to $+70°C$ $V_{CC} = 5.0\ V \pm 5\%$		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Set up Time, HIGH or LOW D_n to CP	3.0 3.0			3.0 3.0		3.0 3.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW D_n to CP	1.0 1.0			1.0 1.0		1.0 1.0		
t_w (H) t_w (L)	CP Pulse Width, HIGH or LOW	4.0 5.0			4.0 5.0		4.0 5.0		ns
t_w (L)	$\overline{MR}$ Pulse Width LOW	5.0			5.0		5.0		ns
t_{rec}	Recovery Time $\overline{MR}$ to CP	5.0			5.0		5.0		ns

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MOTOROLA

MC54F181
MC74F181

Advance Information

4-BIT ARITHMETIC LOGIC UNIT

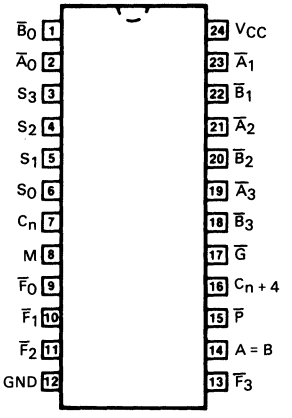
DESCRIPTION — The MC54F/74F181 is a 4-bit Arithmetic Logic Unit (ALU) which can perform all the possible 16 logic operations on two variables and a variety of arithmetic operations. It is 40% faster than the Schottky ALU and only consumes 30% as much power.

- **PROVIDES 16 ARITHMETIC OPERATIONS ADD, SUBTRACT, COMPARE, DOUBLE, PLUS TWELVE OTHER ARITHMETIC OPERATIONS**
- **PROVIDES ALL 16 LOGIC OPERATIONS OF TWO VARIABLES EXCLUSIVE-OR, COMPARE, AND, NAND, OR, NOR, PLUS TEN OTHER LOGIC OPERATIONS**
- **FULL LOOKAHEAD FOR HIGH-SPEED ARITHMETIC OPERATION ON LONG WORDS**
- **600 OR 300 MIL WIDE DIP PACKAGES**

4-BIT ARITHMETIC LOGIC UNIT

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



J Suffix — Case 623-05
(Ceramic)
N Suffix — Case 649-03
(Plastic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
V_{OH}	Output Voltage — High A = B output	54, 74			5.5	V
I_{OL}	Output Current — Low	54, 74			20	mA

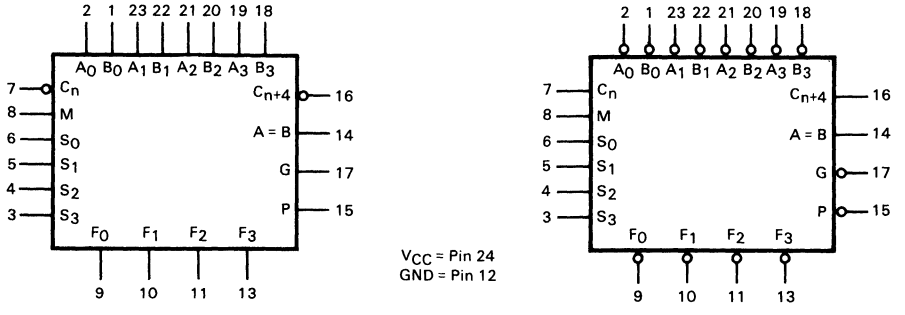
*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FAST is a trademark of Fairchild Camera and Instrument Corporation

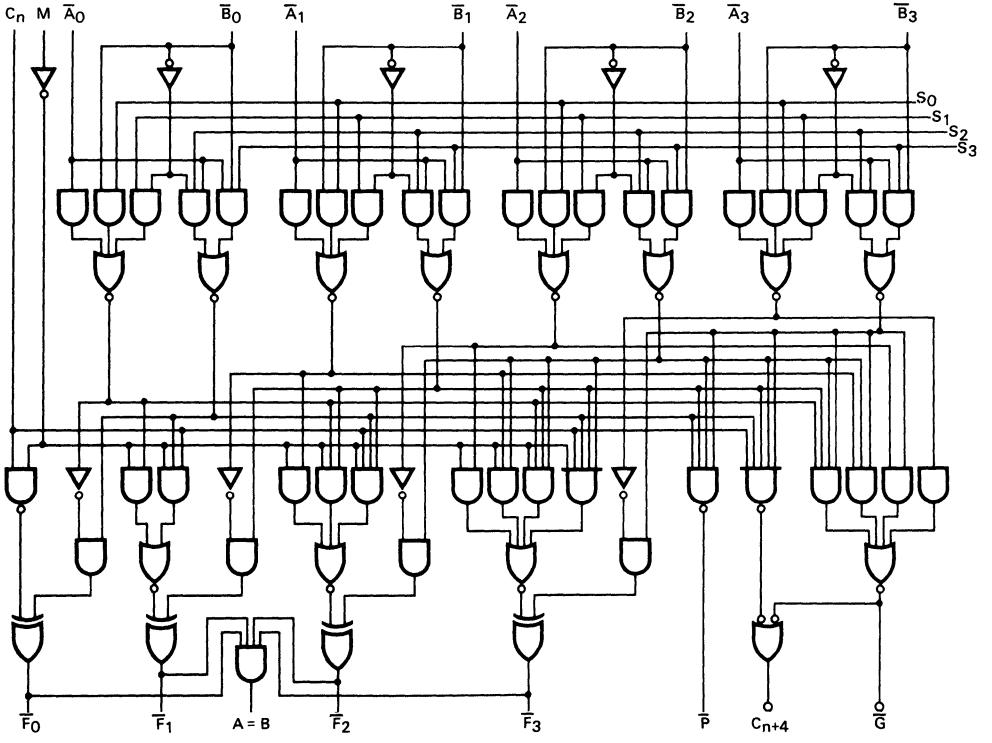
This document contains information on a new product. Specifications and information herein are subject to change without notice.

LOGIC SYMBOLS

ACTIVE-HIGH OPERANDS



LOGIC DIAGRAM



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
I_{OH}	Output Current — HIGH				250	μA	V_{OH} = 5.5 V	V_{CC} = MIN, A=B
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current	M Input			-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
		A and B Inputs			-1.8	mA		
		S_{0-3} Inputs			-2.4	mA		
		C_n Input			-3.0	mA		
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			43	65	mA	V_{CC} = MAX	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

FUNCTIONAL DESCRIPTION — The F181 is a 4-bit high-speed parallel Arithmetic Logic Unit (ALU). Controlled by the four Function Select inputs (S_0-S_3) and the Mode Control input (M), it can perform all the 16 possible logic operations or 16 different arithmetic operations on active-HIGH or active—LOW operands. The Function Table lists these operations.

When the Mode Control input (M) is HIGH, all internal carries are inhibited and the device performs logic operations on the individual bits as listed. When the Mode Control input is LOW, the carries are enabled and the device performs arithmetic operations on the two 4-bit words. The device incorporates full internal carry lookahead and provides for either ripple carry between devices using the C_{n+4} output, or for carry lookahead between packages using the signals $\overline{P}$ (Carry Propagate) and $\overline{G}$ (Carry Generate). In the Add mode, $\overline{P}$ indicates that $\overline{F}$ is 15 or more, while $\overline{G}$ indicates that $\overline{F}$ is 16 or more. In the Subtract mode, $\overline{P}$ indicates that $\overline{F}$ is zero or less, while $\overline{G}$ indicates that $\overline{F}$ is less than zero. $\overline{P}$ and $\overline{G}$ are not affected by carry in. When speed requirements are not stringent, it can be used in a simple Ripple Carry mode by connecting the Carry output (C_{n+4}) signal to the Carry input (C_n) of the next unit. For high-speed operation the device is used in conjunction with a carry lookahead circuit. One carry lookahead package is required for each group of four F181 devices. Carry lookahead can be provided at various levels and offers high-speed capability over extremely long word lengths.

The A = B output from the device goes HIGH when all four $\overline{F}$ outputs are HIGH and can be used to indicate logic equivalence over four bits when the unit is in the Subtract mode. The A = B output is open collector and can be wired-AND with other A = B outputs to give a comparison for more than four bits. The A = B signal can be used with the C_{n+4} signal to indicate $A > B$ and $A < B$.

The Function Table lists the arithmetic operations that are performed without a carry in. An incoming carry adds a one to each operation. Thus, select code LHHL generates A minus B minus 1 (2s complement notation) without a carry in and generates A minus B when a carry is applied. Because subtraction is actually performed by complementary addition (1s complement), a carry out means borrow; thus a carry is generated when there is no underflow and no carry is generated when there is underflow. As indicated, this device can be used with either active-LOW inputs producing active-LOW outputs or with active-HIGH inputs producing active-HIGH outputs. For either case the table lists the operations that are performed to the operands labeled inside the logic symbol.

AC CHARACTERISTICS

SYMBOL	PARAMETER		54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
	PATH	MODE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	C_n to C_{n+4}		3.0 3.0	6.4 6.1	8.5 8.0	3.0 3.0	12 11.5	3.0 3.0	9.5 9.0	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to C_{n+4}	Sum	5.0 5.0	10 9.4	13 12	5.0 5.0	18 17	5.0 5.0	14 13	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to C_{n+4}	Dif	5.0 5.0	10.8 10	14 13	5.0 5.0	19.5 18	5.0 5.0	15 14	ns
t_{PLH} t_{PHL}	C_n to $\overline{F}$	Any	3.0 3.0	6.7 6.5	8.5 8.5	3.0 3.0	12 12	3.0 3.0	9.5 9.5	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to $\overline{G}$	Sum	3.0 3.0	5.7 5.8	7.5 7.5	3.0 3.0	10.5 10.5	3.0 3.0	8.5 8.5	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to $\overline{G}$	Dif	3.0 3.0	6.5 7.3	8.5 9.5	3.0 3.0	12 13.5	3.0 3.0	9.5 10.5	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to $\overline{P}$	Sum	3.0 3.0	5.0 5.5	7.0 7.5	3.0 3.0	10 10.5	3.0 3.0	8.0 8.5	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to $\overline{P}$	Dif	4.0 4.0	5.8 6.5	7.5 8.5	4.0 4.0	10.5 12	4.0 4.0	8.5 9.5	ns
t_{PLH} t_{PHL}	$\overline{A}_i$ or $\overline{B}_i$ to $\overline{F}_i$	Sum	3.0 3.0	7.0 7.2	9.0 10	3.0 3.0	12.5 14	3.0 3.0	10 10	ns
t_{PLH} t_{PHL}	$\overline{A}_i$ or $\overline{B}_i$ to $\overline{F}_i$	Dif	3.0 3.0	8.2 5.0	11 11	3.0 3.0	15.5 15.5	3.0 3.0	12 12	ns
t_{PLH} t_{PHL}	Any $\overline{A}$ or $\overline{B}$ to Any $\overline{F}$	Sum	4.0 4.0	8.0 7.8	10.5 10	4.0 4.0	15.5 14	4.0 4.0	11.5 11	ns
t_{PLH} t_{PHL}	Any $\overline{A}$ or $\overline{B}$ to Any $\overline{F}$	Dif	4.5 4.5	9.4 9.4	12 12	4.5 4.5	17 17	4.5 4.5	13 13	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to $\overline{F}$	Logic	4.0 4.0	6.0 6.0	9.0 10	4.0 4.0	12.5 14	4.0 4.0	10 11	ns
t_{PLH} t_{PHL}	$\overline{A}$ or $\overline{B}$ to A = B	Dif	11 7.0	18.5 9.8	27 12.5	11 7.0	35 17.5	11 7.0	29 13.5	ns

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FUNCTION TABLE

MODE SELECT INPUTS				ACTIVE-LOW OPERANDS & F_n OUTPUTS		ACTIVE-HIGH OPERANDS & F_n OUTPUTS	
				LOGIC	ARITHMETIC**	LOGIC	ARITHMETIC**
S_3	S_2	S_1	S_0	(M = H)	(M = L) (C_n = L)	(M = H)	(M = L) (C_n = H)
L	L	L	L	$\overline{A}$	A minus 1	$\overline{A}$	A
L	L	L	H	$\overline{AB}$	AB minus 1	$\overline{A+B}$	A + B
L	L	H	L	$\overline{A}+B$	$A\overline{B}$ minus 1	$\overline{A}B$	A + $\overline{B}$
L	L	H	H	Logic 1	minus 1	Logic 0	minus 1
L	H	L	L	$\overline{A+B}$	A plus (A + $\overline{B}$)	$\overline{A}\overline{B}$	A plus $A\overline{B}$
L	H	L	H	$\overline{B}$	AB plus (A + $\overline{B}$)	$\overline{B}$	(A + B) plus $A\overline{B}$
L	H	H	L	$\overline{A \oplus B}$	A minus B minus 1	$A \oplus B$	A minus B minus 1
L	H	H	H	A + $\overline{B}$	A + $\overline{B}$	$A\overline{B}$	$A\overline{B}$ minus 1
H	L	L	L	$\overline{A}B$	A plus (A + B)	$\overline{A+B}$	A plus AB
H	L	L	H	$A \oplus B$	A plus B	$\overline{A \oplus B}$	A plus B
H	L	H	L	B	$A\overline{B}$ plus (A + B)	B	(A + $\overline{B}$) plus AB
H	L	H	H	A + B	A + B	AB	AB minus 1
H	H	L	L	Logic 0	A plus A*	Logic 1	A plus A*
H	H	L	H	$A\overline{B}$	AB plus A	A + $\overline{B}$	(A + B) plus A
H	H	H	L	AB	$A\overline{B}$ minus A	A + B	(A + $\overline{B}$) plus A
H	H	H	H	A	A	A	A minus 1

*Each bit is shifted to the next more significant position. H = HIGH Voltage Level
**Arithmetic operations expressed in 2s complement notation. L = LOW Voltage Level

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MOTOROLA

MC54F182
MC74F182

Advance Information

CARRY LOOKAHEAD GENERATOR

DESCRIPTION — The MC54F/74F182 is a high-speed carry lookahead generator. It is generally used with the F181, F381 or 29F01 4-bit arithmetic logic unit to provide high-speed lookahead over word lengths of more than four bits.

- **PROVIDES LOOKAHEAD CARRIES ACROSS A GROUP OF FOUR ALUs**
- **MULTI-LEVEL LOOKAHEAD HIGH-SPEED ARITHMETIC OPERATION OVER LONG WORD LENGTHS**

TRUTH TABLE

INPUTS									OUTPUTS				
C_n	$\overline{G}_0$	$\overline{P}_0$	$\overline{G}_1$	$\overline{P}_1$	$\overline{G}_2$	$\overline{P}_2$	$\overline{G}_3$	$\overline{P}_3$	C_{n+x}	C_{n+y}	C_{n+z}	$\overline{G}$	$\overline{P}$
X	H	H							L				
L	H	X							L				
X	L	X							H				
H	X	L							H				
X	X	X	H	H						L			
X	H	H	H	X						L			
L	H	X	H	X						L			
X	X	X	L	X						H			
X	L	X	X	L						H			
H	X	L	X	L						H			
X	X	X	X	X	H	H					L		
X	X	X	H	H	H	X					L		
X	H	H	H	X	H	X					L		
L	H	X	H	X	H	X					L		
X	X	X	X	X	L	X					H		
X	X	X	L	X	X	L					H		
X	L	X	X	L	X	L					H		
H	X	L	X	L	X	L					H		
	X		X	X	X	X	H	H				H	
	X		X	X	H	H	H	X				H	
	X		H	H	H	X	H	X				H	
	H		H	X	H	X	H	X				H	
	X		X	X	X	X	L	X				L	
	X		X	X	L	X	X	L				L	
	X		L	X	X	L	X	L				L	
	L		X	L	X	L	X	L				L	
		H		X		X		X					H
		X		H		X		X					H
		X		X		H		X					H
		X		X		X		H					H
		L		L		L		L					L

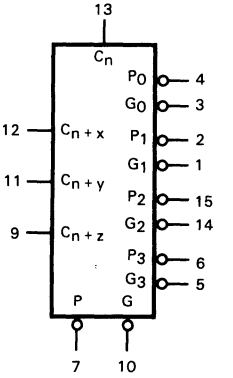
H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

FAST is a trademark of Fairchild Camera and Instrument Corporation.
This document contains information on a new product. Specifications and information herein are subject to change without notice.

CARRY LOOKAHEAD GENERATOR

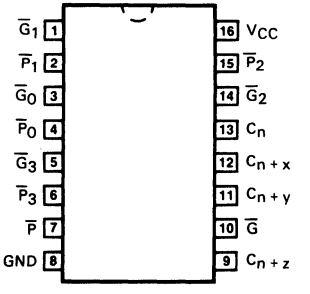
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

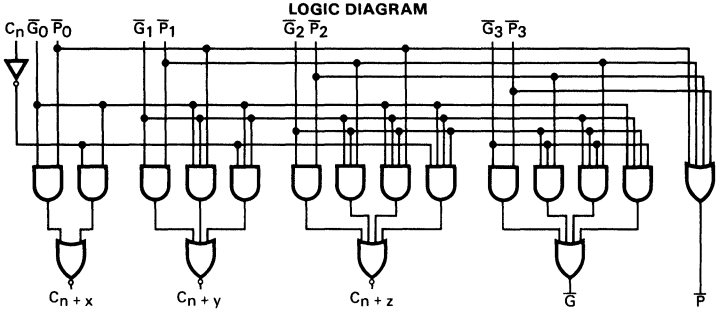
CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

6

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	V_{CC} = MAX
I_{IL}	Input LOW Current	C_n Input			-1.2	mA	V_{IN} = 0.5 V	V_{CC} = MAX
		$\overline{P}_3$ Input			-2.4			
		$\overline{P}_2$ Input			-3.6			
		$\overline{G}_3$, $\overline{P}_0$, $\overline{P}_1$ Inputs			-4.8			
		$\overline{G}_0$, $\overline{G}_2$ Inputs			-8.4			
		$\overline{G}_1$ Input			-9.6			
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current (All Outputs HIGH)			18.4	28	mA	$\overline{P}_3$, $\overline{G}_3$ = 4.5 V All Other Inputs = GND	V_{CC} = MAX
I_{CCL}	Power Supply Current (All Outputs LOW)			23.5	36	mA	$\overline{G}_0$, $\overline{G}_1$, $\overline{G}_2$ = 4.5 V All Other Inputs = GND	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

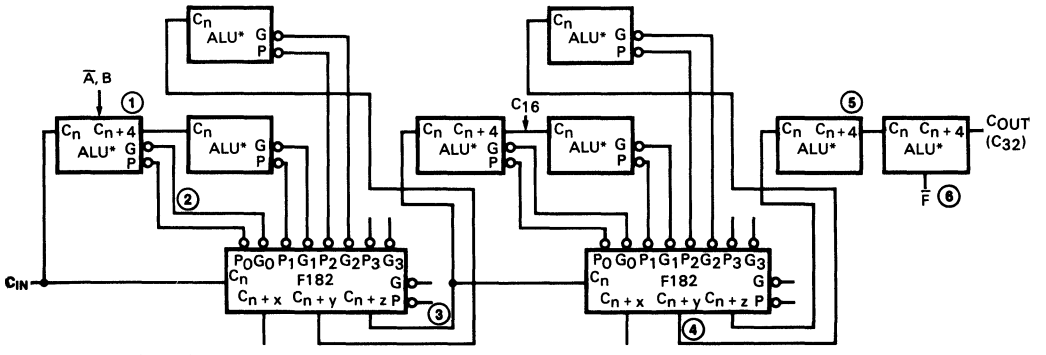
SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay C_n to C_{n+x}, C_{n+y}, C_{n+z}	3.0 3.0	6.6 6.8	8.5 9.0	3.0 3.0	10.5 11	3.0 3.0	9.5 10	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{P}_0$, $\overline{P}_1$ or $\overline{P}_2$ to C_{n+x}, C_{n+y}, C_{n+z}	2.5 2.0	6.2 3.7	8.0 5.0	2.5 2.0	10.7 6.5	2.5 2.0	9.0 6.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{G}_0$, $\overline{G}_1$ or $\overline{G}_2$ to C_{n+x}, C_{n+y}, C_{n+z}	2.5 2.0	6.5 3.9	8.5 5.2	2.5 2.0	10.5 6.5	2.5 2.0	9.5 6.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{P}_1$, $\overline{P}_2$ or $\overline{P}_3$ to $\overline{G}$	3.0 3.0	7.9 6.0	10 8.0	3.0 3.0	12.5 9.5	3.0 3.0	11 9.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{G}_n$ to $\overline{G}$	3.0 3.0	8.3 5.7	10.5 7.5	3.0 3.0	12.5 9.5	3.0 3.0	11.5 8.5	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{P}_n$ to $\overline{P}$	3.0 2.5	5.7 4.1	7.5 5.5	3.0 2.5	11 7.5	3.0 2.5	8.5 6.5	ns

FUNCTIONAL DESCRIPTION — The F182 carry lookahead generator accepts up to four pairs of active-LOW Carry Propagate ($\overline{P}_0$-$\overline{P}_3$) and Carry Generate ($\overline{G}_0$-$\overline{G}_3$) signals and an active-HIGH Carry input (C_n) and provides anticipated active-HIGH carries (C_{n+x}, C_{n+y}, C_{n+z}) across four groups of binary adders. The F182 also has active-LOW Carry Propagate ($\overline{P}$) and Carry Generate ($\overline{G}$) outputs which may be used for further levels of lookahead. The logic equations provided at the output are:

$$C_{n+x} = G_0 + P_0C_n$$
$$C_{n+y} = G_1 + P_1G_0 + P_1P_0C_n$$
$$C_{n+z} = G_2 + P_2G_1 + P_2P_1G_0 + P_2P_1P_0C_n$$
$$\overline{G} = \overline{G_3 + P_3G_2 + P_3P_2G_1 + P_3P_2P_1G_0}$$
$$P = \overline{P_3P_2P_1P_0}$$

Also, the F182 can be used with binary ALUs in an active-LOW or active-HIGH input operand mode. The connections (Figure A) to and from the ALU to the carry lookahead generator are identical in both cases. Carries are rippled between lookahead blocks. The critical speed path follows the circled numbers. There are several possible arrangements for the carry interconnects, but all achieve about the same speed. A 28-bit ALU is formed by dropping the last F181 or F381.

FIGURE A — 32-Bit ALU with Ripple Carry between 16-Bit Lookahead ALUs



*ALUs may be either F181, F381 or 2901A.

MOTOROLA

MC54F190
MC74F190

Advance Information

UP/DOWN DECADE COUNTER
(With Preset and Ripple Clock)

DESCRIPTION — The MC54F/74F190 is a reversible BCD (8421) decade counter featuring synchronous counting and asynchronous presetting. The preset feature allows the F190 to be used in programmable dividers. The Count Enable input, the Terminal Count output and the Ripple Clock output make possible a variety of methods of implementing multistage counters. In the counting modes, state changes are initiated by the rising edge of the clock.

- HIGH-SPEED — 110 MHz TYPICAL COUNT FREQUENCY
- SYNCHRONOUS COUNTING
- ASYNCHRONOUS PARALLEL LOAD
- CASCADABLE

$\overline{RC}$ TRUTH TABLE

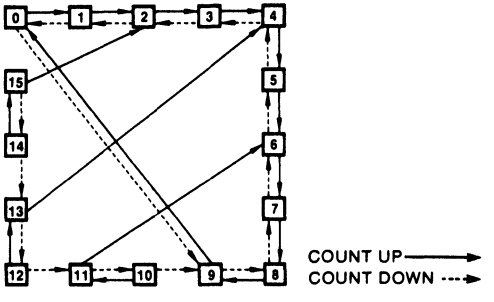
INPUTS			OUTPUT
$\overline{CE}$	TC*	CP	$\overline{RC}$
L	H	⊓	⊓
H	X	X	H
X	L	X	H

MODE SELECT TABLE

INPUTS				MODE
$\overline{PL}$	$\overline{CE}$	$\overline{U}$/D	CP	
H	L	L	⌐	Count Up
H	L	H	⌐	Count Down
L	X	X	X	Preset (Asyn.)
H	H	X	X	No Change (Hold)

*TC is generated internally
H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

STATE DIAGRAM



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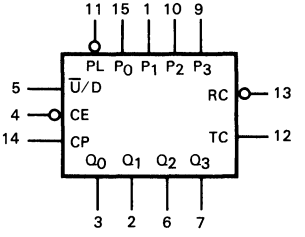
This document contains information on a new product. Specifications and information herein are subject to change without notice.

UP/DOWN DECADE COUNTER
(With Preset and Ripple Clock)

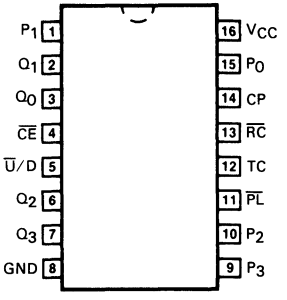
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

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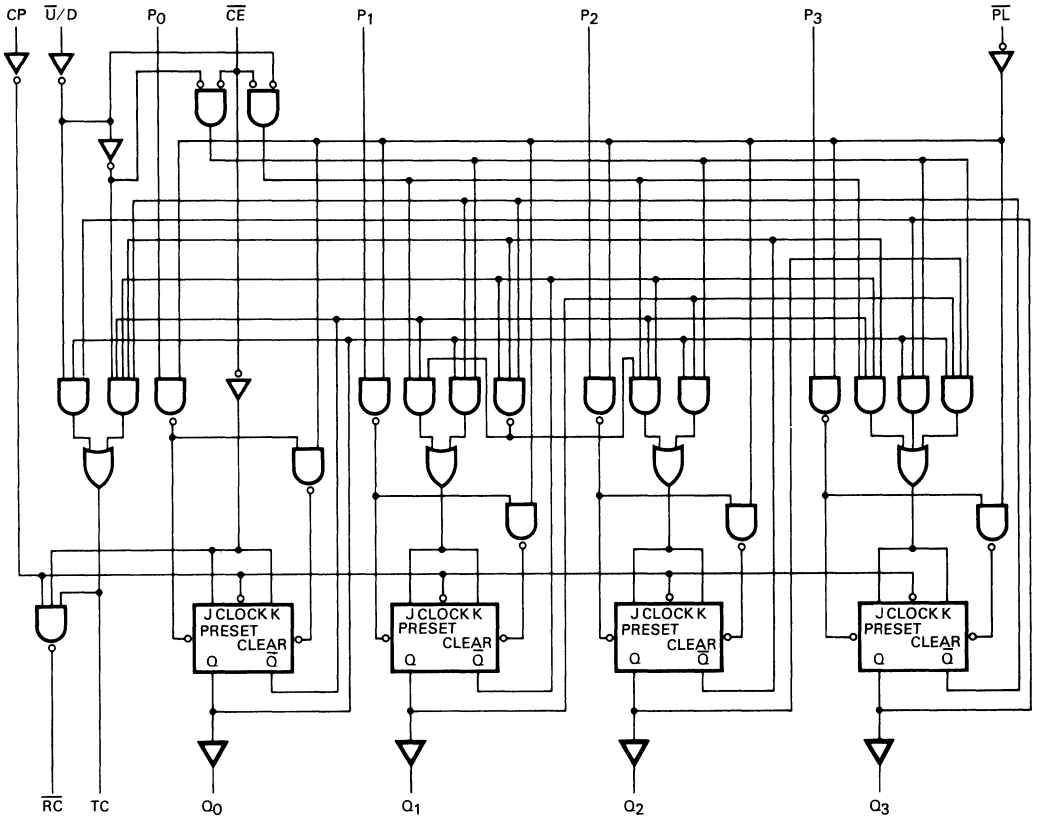
LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

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GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FUNCTIONAL DESCRIPTION — The F190 is a synchronous up/down BCD decade counter containing four edge-triggered flip-flops, with internal gating and steering logic to provide individual preset, count-up and count-down operations. It has an asynchronous parallel load capability permitting the counter to be preset to any desired number. When the Parallel Load ($\overline{PL}$) input is LOW, information present on the Parallel Data inputs (P_0–P_3) is loaded into the counter and appears on the Q outputs. This operation overrides the counting functions, as indicated in the Mode Select Table. A HIGH signal on the $\overline{CE}$ input inhibits counting. When $\overline{CE}$ is LOW, internal state changes are initiated synchronously by the LOW-to-HIGH transition of the clock input. The direction of counting is determined by the $\overline{U}/D$ input signal, as indicated in the Mode Select Table. $\overline{CE}$ and $\overline{U}/D$ can be changed with the clock in either state, provided only that the recommended setup and hold times are observed.

Two types of outputs are provided as overflow/underflow indicators. The Terminal Count (TC) output is normally LOW and goes HIGH when a circuit reaches zero in the count-down mode or reaches 9 in the count-up mode. The TC output will then remain HIGH until a state change occurs, whether by counting or presetting or until $\overline{U}/D$ is changed. The TC output should not be used as a clock signal because it is subject to decoding spikes. The TC signal is also used internally to enable the Ripple Clock ($\overline{RC}$) output. The $\overline{RC}$ output is normally HIGH. When $\overline{CE}$ is LOW and TC is HIGH, the $\overline{RC}$ output will go LOW when the clock next goes LOW and will stay LOW until the clock goes HIGH again. This feature simplifies the design of multistage counters. For a discussion and illustrations of the various methods of implementing multistage counters, please see the F191 data sheet.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	V_{CC} = MAX
I_{IL}	Input LOW Current Other Inputs				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	$\overline{CE}$ Input				-1.8			
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			38	55	mA	V_{CC} = MAX	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	Maximum Count Frequency	80	110		80		80		MHz
t_{PLH} t_{PHL}	Propagation Delay CP to Q_n	3.0 3.0	5.5 6.5	9.0 10	3.0 3.0	12.5 14	3.0 3.0	10 11	ns
t_{PLH} t_{PHL}	Propagation Delay CP to TC	8.0 5.0	12.5 9.5	16 13	8.0 5.0	22.5 18	8.0 5.0	17 14	ns
t_{PLH} t_{PHL}	Propagation Delay CP to $\overline{RC}$	4.0 3.0	7.0 5.0	9.5 8.0	4.0 3.0	13.5 11	4.0 3.0	10.5 9.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{CE}$ to $\overline{RC}$	3.0 3.0	4.6 4.5	7.0 7.0	3.0 3.0	10 10	3.0 3.0	8.0 8.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{U}$/D to $\overline{RC}$	7.0 5.0	11 9.0	18 12	7.0 5.0	25.5 17	7.0 5.0	19 13	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{U}$/D to TC	3.0 3.0	6.0 6.5	11 11	3.0 3.0	15.5 15.5	3.0 3.0	12 12	ns
t_{PLH} t_{PHL}	Propagation Delay P_n to Q_n	3.0 8.0	4.6 13.4	7.0 17	3.0 8.0	10 24	3.0 8.0	8.0 18	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{PL}$ to Q_n	3.0 4.0	6.7 7.2	11 15	3.0 4.0	15.5 21	3.0 4.0	12 16	ns

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Set up Time, HIGH or LOW P_n to $\overline{PL}$	5.0 8.0			5.0 8.0		5.0 8.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW P_n to $\overline{PL}$	3.0 3.0			3.0 3.0		3.0 3.0		
t_s (L)	Set up Time LOW $\overline{CE}$ to CP	10			10		10		ns
t_h (L)	Hold Time LOW $\overline{CE}$ to CP	0			0		0		
t_w (L)	$\overline{PL}$ Pulse Width, LOW	6.0			6.0		6.0		ns
t_w (L)	CP Pulse Width LOW	6.0			6.0		6.0		ns
t_{rec}	Recovery Time $\overline{PL}$ to CP	7.0			7.0		7.0		ns

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MOTOROLA

MC54F191
MC74F191

Advance Information

UP/DOWN BINARY COUNTER
(With Preset and Ripple Clock)

DESCRIPTION — The MC54F/74F191 is a reversible modulo-16 binary counter featuring synchronous counting and asynchronous presetting. The preset feature allows the F191 to be used in programmable dividers. The Count Enable input, the Terminal Count output and the Ripple Clock output make possible a variety of methods of implementing multistage counters. In the counting modes, state changes are initiated by the rising edge of the clock.

- **HIGH-SPEED — 110 MHz TYPICAL COUNT FREQUENCY**
- **SYNCHRONOUS COUNTING**
- **ASYNCHRONOUS PARALLEL LOAD**
- **CASCADABLE**

FUNCTIONAL DESCRIPTION — The F191 is a synchronous up/down 4-bit binary counter. It contains four edge-triggered flip-flops, with internal gating and steering logic to provide individual preset, count-up and count-down operations.

Each circuit has an asynchronous parallel load capability permitting the counter to be preset to any desired number. When the Parallel Load ($\overline{PL}$) input is LOW, information present on the Parallel Data inputs (P_0–P_3) is loaded into the counter and appears on the Q outputs. This operation overrides the counting functions, as indicated in the Mode Select Table.

A HIGH signal on the $\overline{CE}$ input inhibits counting. When $\overline{CE}$ is LOW, internal state changes are initiated synchronously by the LOW-to-HIGH transition of the clock input. The direction of counting is determined by the $\overline{U}/D$ input signal, as indicated in the Mode Select Table. $\overline{CE}$ and $\overline{U}/D$ can be changed with the clock in either state, provided only that the recommended setup and hold times are observed.

MODE SELECT TABLE

INPUTS				MODE
$\overline{PL}$	$\overline{CE}$	$\overline{U}/D$	CP	
H	L	L	⎍	Count Up
H	L	H	⎍	Count Down
L	X	X	X	Preset (Asyn.)
H	H	X	X	No Change (Hold)

RC TRUTH TABLE

INPUTS			OUTPUT
$\overline{CE}$	TC*	CP	$\overline{RC}$
L	H	⎎	⎎
H	X	X	H
X	L	X	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

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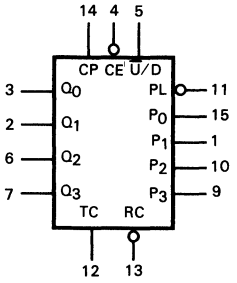
This document contains information on a new product. Specifications and information herein are subject to change without notice.

UP/DOWN BINARY COUNTER
(With Preset and Ripple Clock)

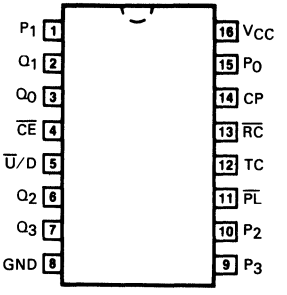
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

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FUNCTIONAL DESCRIPTION (continued)

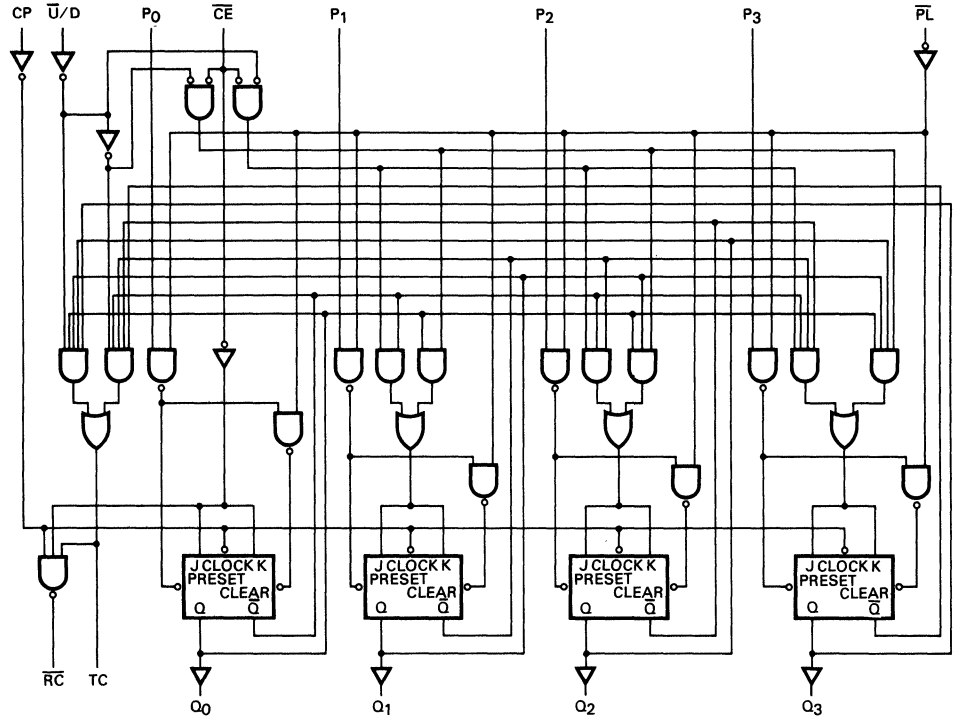
Two types of outputs are provided as overflow/underflow indicators. The Terminal Count (TC) output is normally LOW and goes HIGH when a circuit reaches zero in the count-down mode or reaches 15 in the count-up mode. The TC output will then remain HIGH until a state change occurs, whether by counting or presetting or until $\overline{U}$/D is changed. The TC output should not be used as a clock signal because it is subject to decoding spikes.

The TC signal is also used internally to enable the Ripple Clock ($\overline{RC}$) output. The $\overline{RC}$ output is normally HIGH. When $\overline{CE}$ is LOW and TC is HIGH, the $\overline{RC}$ output will go LOW when the clock next goes LOW and will stay LOW until the clock goes HIGH again. This feature simplifies the design of multistage counters, as indicated in Figures A and B. In Figure A, each $\overline{RC}$ output is used as the clock input for the next higher stage. This configuration is particularly advantageous when the clock source has a limited drive capability, since it drives only the first stage. To prevent counting in all stages it is only necessary to inhibit the first stage, since a HIGH signal on $\overline{CE}$ inhibits the $\overline{RC}$ output pulse, as indicated in the $\overline{RC}$ Truth Table. A disadvantage of this configuration, in some applications, is the timing skew between state changes in the first and last stages. This represents the cumulative delay of the clock as it ripples through the preceding stages.

A method of causing state changes to occur simultaneously in all stages is shown in Figure B. All clock inputs are driven in parallel and the $\overline{RC}$ outputs propagate the carry/borrow signals in ripple fashion. In this configuration the LOW state duration of the clock must be long enough to allow the negative-going edge of the carry/borrow signal to ripple through to the last stage before the clock goes HIGH. There is no such restriction on the HIGH state duration of the clock, since the $\overline{RC}$ output of any device goes HIGH shortly after its CP input goes HIGH.

The configuration shown in Figure C avoids ripple delays and their associated restrictions. The $\overline{CE}$ input for a given stage is formed by combining the TC signals from all the preceding stages. Note that in order to inhibit counting an enable signal must be included in each carry gate. The simple inhibit scheme of Figures A and B doesn't apply, because the TC output of a given stage is not affected by its own $\overline{CE}$.

LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FIGURE A — N-Stage Counter Using Ripple Clock

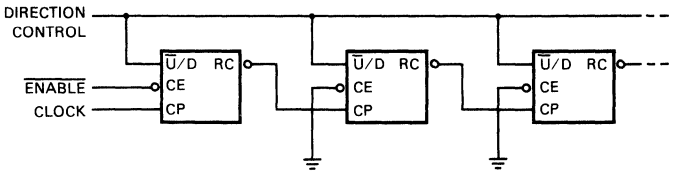


FIGURE B — Synchronous N-Stage Counter Using Ripple Carry/Borrow

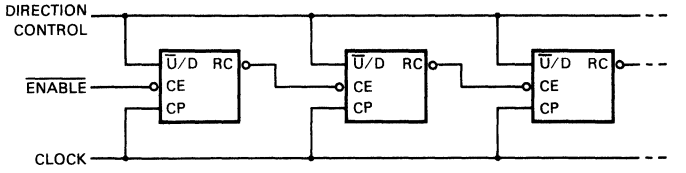
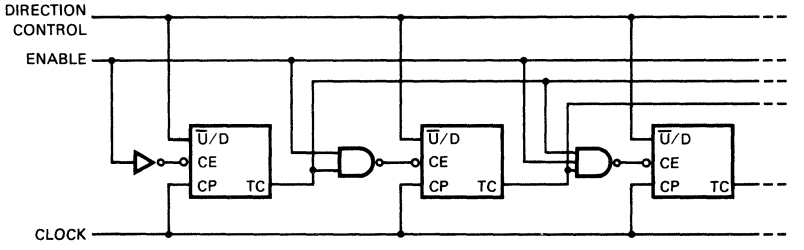


FIGURE C — Synchronous N-Stage Counter with Parallel Gated Carry/Borrow



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DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current Other Inputs				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	$\overline{CE}$ Input				-1.8			
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			38	55	mA	V_{CC} = MAX	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
f_{max}	Maximum Count Frequency	80	110		80		80		MHz
t_{PLH} t_{PHL}	Propagation Delay CP to Q_n	3.0 3.0	5.5 6.5	9.0 10	3.0 3.0	12.5 14	3.0 3.0	10 11	ns
t_{PLH} t_{PHL}	Propagation Delay CP to TC	8.0 5.0	12.5 9.5	16 13	8.0 5.0	22.5 18	8.0 5.0	17 14	ns
t_{PLH} t_{PHL}	Propagation Delay CP to $\overline{RC}$	4.0 3.0	7.0 5.0	9.5 8.0	4.0 3.0	13.5 11	4.0 3.0	10.5 9.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{CE}$ to $\overline{RC}$	3.0 3.0	4.6 4.5	7.0 7.0	3.0 3.0	10 10	3.0 3.0	8.0 8.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{U}/D$ to $\overline{RC}$	7.0 5.0	11 9.0	18 12	7.0 5.0	25.5 17	7.0 5.0	19 13	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{U}/D$ to TC	3.0 3.0	6.0 6.5	11 11	3.0 3.0	15.5 15.5	3.0 3.0	12 12	ns
t_{PLH} t_{PHL}	Propagation Delay P_n to Q_n	3.0 8.0	4.6 13.4	7.0 17	3.0 8.0	10 24	3.0 8.0	8.0 18	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{PL}$ to Q_n	3.0 4.0	6.7 7.2	11 15	3.0 4.0	15.5 21	3.0 4.0	12 16	ns

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AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Set up Time, HIGH or LOW P_n to $\overline{PL}$	5.0 8.0			5.0 8.0		5.0 8.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW P_n to $\overline{PL}$	3.0 3.0			3.0 3.0		3.0 3.0		
t_s (L)	Set up Time LOW $\overline{CE}$ to CP	10			10		10		ns
t_h (L)	Hold Time LOW $\overline{CE}$ to CP	0			0		0		
t_w (L)	$\overline{PL}$ Pulse Width, LOW	6.0			6.0		6.0		ns
t_w (L)	CP Pulse Width LOW	6.0			6.0		6.0		ns
t_{rec}	Recovery Time $\overline{PL}$ to CP	7.0			7.0		7.0		ns

MOTOROLA

MC54F194
MC74F194

Advance Information

4-BIT BIDIRECTIONAL UNIVERSAL SHIFT REGISTER

DESCRIPTION — The MC54F/74F194 is a high-speed 4-bit bidirectional universal shift register. As a high-speed multifunctional, sequential building block, it is useful in a wide variety of applications. It may be used in serial-serial, shift left, shift right, serial-parallel, parallel-serial, and parallel-parallel data register transfers. The F194 is similar in operation to the S195 universal shift register, with added features of shift left without external connections and hold (do nothing) modes of operation.

- **TYPICAL SHIFT FREQUENCY OF 150 MHz**
- **ASYNCHRONOUS MASTER RESET**
- **HOLD (DO NOTHING) MODE**
- **FULLY SYNCHRONOUS SERIAL OR PARALLEL DATA TRANSFERS**

FUNCTIONAL DESCRIPTION — The F194 contains four edge-triggered D flip-flops and the necessary interstage logic to synchronously perform shift right, shift left, parallel load and hold operations. Signals applied to the Select (S_0, S_1) inputs determine the type of operation, as shown in the Mode Select Table. Signals on the Select, Parallel data (P_0–P_3) and Serial data (D_{SR}, D_{SL}) inputs can change when the clock is in either state, provided only that the recommended setup and hold times, with respect to the clock rising edge, are observed. A LOW signal on Master Reset ($\overline{MR}$) overrides all other inputs and forces the outputs LOW.

MODE SELECT TABLE

OPERATING MODE	INPUTS						OUTPUTS			
	$\overline{MR}$	S_1	S_0	D_{SR}	D_{SL}	P_n	Q_0	Q_1	Q_2	Q_3
Reset	L	X	X	X	X	X	L	L	L	L
Hold	H	l	l	X	X	X	q_0	q_1	q_2	q_3
Shift Left	H	h	l	X	l	X	q_1	q_2	q_3	L
	H	h	l	X	h	X	q_1	q_2	q_3	H
Shift Right	H	l	h	l	X	X	L	q_0	q_1	q_2
	H	l	h	h	X	X	H	q_0	q_1	q_2
Parallel Load	H	h	h	X	X	p_n	p_0	p_1	p_2	p_3

l = LOW voltage level one setup time prior to the LOW-to-HIGH clock transition.
h = HIGH voltage level one setup time prior to the LOW-to-HIGH clock transition.
p_n (q_n) = Lower case letters indicate the state of the referenced input (or output) one setup time prior to the LOW-to-HIGH clock transition.
H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

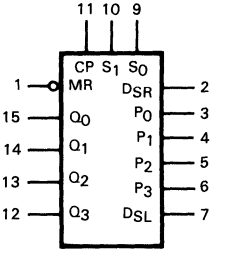
FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

4-BIT BIDIRECTIONAL UNIVERSAL SHIFT REGISTER

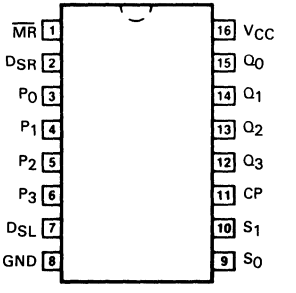
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

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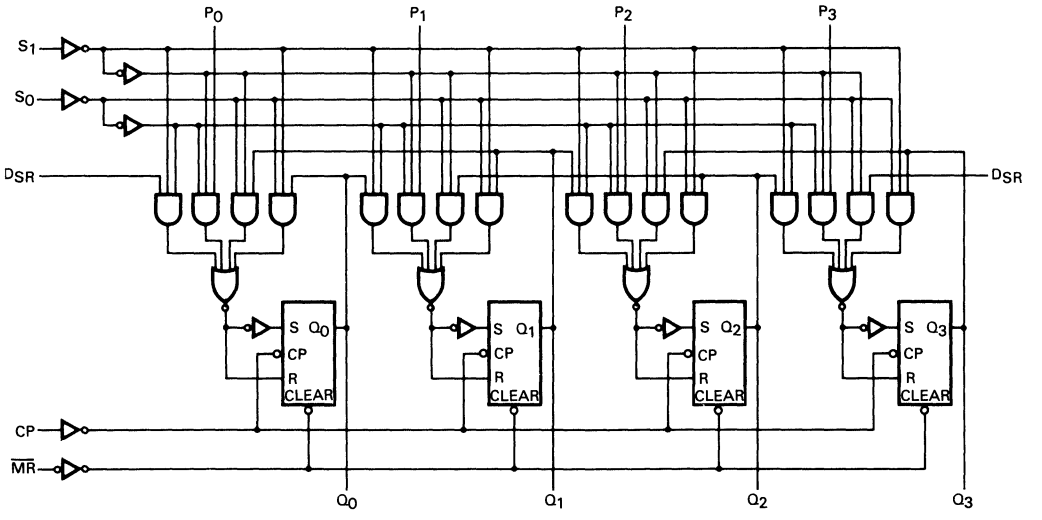
LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF			54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF		74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	Maximum Shift Frequency	105	150		90		90		MHz
t_{PLH}	Propagation Delay CP to Q_n	3.5	5.2	7.0	3.0	8.5	3.5	8.0	ns
t_{PHL}		3.5	5.5	7.0	3.0	8.5	3.5	8.0	
t_{PHL}	Propagation Delay $\overline{MR}$ to Q_n	4.5	8.6	12	4.5	14.5	4.5	14	ns

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DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			33	46	mA	S_n, $\overline{MR}$, D_{SR}, D_{SL} = 4.5 V, P_n = Gnd, CP = ⌐¬	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% MIN	MAX	UNITS
t_s (H)	Set up Time, HIGH or LOW	4.0			4.0		4.0		ns
t_s (L)	P_n or D_{SR} or D_{SL} to CP	4.0			4.0		4.0		
t_h (H)	Hold Time, HIGH or LOW	0			1.0		1.0		
t_h (L)	P_n or D_{SR} or D_{SL} to CP	0			1.0		1.0		
t_s (H)	Set up Time, HIGH or LOW	8.0			8.0		8.0		ns
t_s (L)	S_n to CP	8.0			8.0		8.0		
t_h (H)	Hold Time, HIGH or LOW	0			0		0		
t_h (L)	S_n to CP	0			0		0		
t_w (H)	CP Pulse Width HIGH	5.0			5.5		5.5		ns
t_w (L)	$\overline{MR}$ Pulse Width LOW	5.0			5.0		5.0		ns
t_{rec}	Recovery Time $\overline{MR}$ to CP	7.0			9.0		8.0		ns

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MOTOROLA

MC54F251
MC74F251

Advance Information

8-INPUT MULTIPLEXER
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F251 is a high-speed 8-input digital multiplexer. It provides, in one package, the ability to select one bit of data from up to eight sources. It can be used as universal function generator to generate any logic function of four variables. Both assertion and negation outputs are provided.

- **MULTIFUNCTIONAL CAPACITY**
- **ON-CHIP SELECT LOGIC DECODING**
- **INVERTING AND NON-INVERTING 3-STATE OUTPUTS**

FUNCTIONAL DESCRIPTION — This device is a logical implementation of a single-pole, 8-position switch with the switch position controlled by the state of three Select inputs, S_0, S_1, S_2. Both assertion and negation outputs are provided. The Output Enable input ($\overline{OE}$) is active LOW. When it is activated, the logic function provided at the output is:

$$Z = \overline{OE} \cdot (I_0 \cdot \overline{S_0} \cdot \overline{S_1} \cdot \overline{S_2} + I_1 \cdot S_0 \cdot \overline{S_1} \cdot \overline{S_2} + I_2 \cdot \overline{S_0} \cdot S_1 \cdot \overline{S_2} + I_3 \cdot S_0 \cdot S_1 \cdot \overline{S_2} + I_4 \cdot \overline{S_0} \cdot \overline{S_1} \cdot S_2 + I_5 \cdot S_0 \cdot \overline{S_1} \cdot S_2 + I_6 \cdot \overline{S_0} \cdot S_1 \cdot S_2 + I_7 \cdot S_0 \cdot S_1 \cdot S_2 +$$

When the Output Enable is HIGH, both outputs are in the high impedance (high Z) state. This feature allows multiplexer expansion by typing the outputs of up to 128 devices together. When the outputs of the 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. The Output Enable signals should be designed to ensure there is no overlap in the active LOW portion of the enable voltages.

TRUTH TABLE

INPUTS				OUTPUTS	
$\overline{OE}$	S_2	S_1	S_0	$\overline{Z}$	Z
H	X	X	X	$\overline{Z}$	Z
L	L	L	L	$\overline{I_0}$	I_0
L	L	L	H	$\overline{I_1}$	I_1
L	L	H	L	$\overline{I_2}$	I_2
L	L	H	H	$\overline{I_3}$	I_3
L	H	L	L	$\overline{I_4}$	I_4
L	H	L	H	$\overline{I_5}$	I_5
L	H	H	L	$\overline{I_6}$	I_6
L	H	H	H	$\overline{I_7}$	I_7

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance

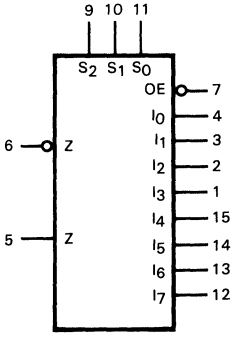
FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

8-INPUT MULTIPLEXER
(With 3-State Outputs)

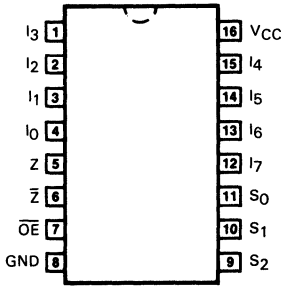
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

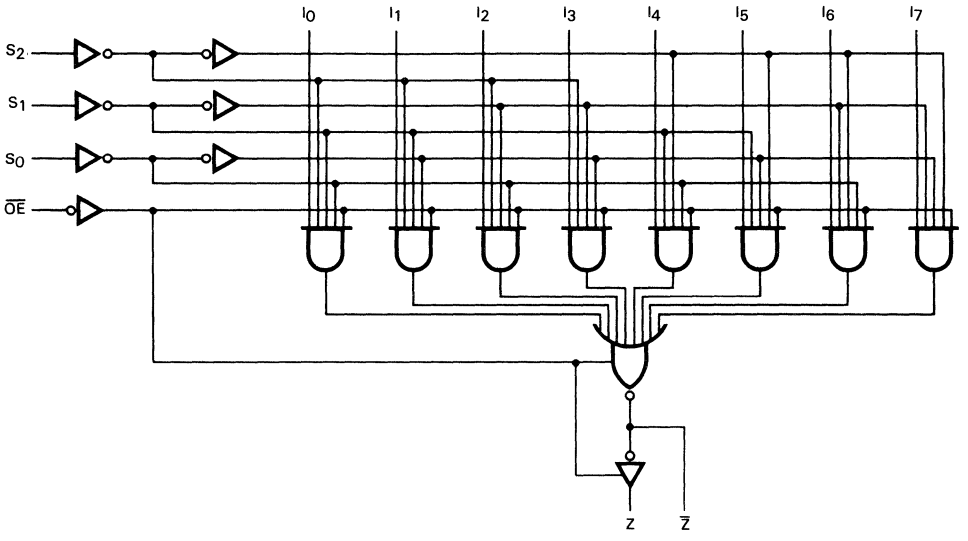
CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

6

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current	ON		15	22	mA	I_n, S_n = 4.5 V, $\overline{OE}$ = Gnd	V_{CC} = MAX
		OFF		16	24		$\overline{OE}$, I_n = 4.5 V	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	4.0	5.9	8.0	3.5	9.5	4.0	9.0	ns
t_{PHL}	S_n to $\overline{Z}_n$	3.2	5.7	7.5	3.2	9.5	3.2	8.5	
t_{PLH}	Propagation Delay	4.5	9.6	13	3.5	16.5	4.5	14	ns
t_{PHL}	S_n to Z_n	5.0	6.9	9.0	3.0	10.5	4.0	10	
t_{PLH}	Propagation Delay	3.0	4.1	5.7	2.5	8.0	3.0	7.0	ns
t_{PHL}	I_n to $\overline{Z}$	2.0	3.0	4.0	2.0	6.0	2.0	5.0	
t_{PLH}	Propagation Delay	5.5	7.2	9.5	3.5	11.5	5.5	10.5	ns
t_{PHL}	I_n to Z	3.7	5.1	6.5	3.7	7.5	3.7	7.5	
t_{PZH}	Output Enable Time	3.0	5.4	7.0	3.0	9.5	3.0	8.0	ns
t_{PZL}	$\overline{OE}$ to $\overline{Z}$	3.5	6.4	8.5	3.5	10.5	3.5	9.5	
t_{PHZ}	Output Disable Time	3.0	5.0	6.5	3.0	8.5	3.0	7.5	ns
t_{PLZ}	$\overline{OE}$ to $\overline{Z}$	2.0	3.2	4.5	2.0	7.5	2.0	5.5	
t_{PZH}	Output Enable Time	4.0	6.9	9.0	4.0	10	4.0	10	ns
t_{PZL}	$\overline{OE}$ to Z	3.5	6.0	8.0	3.5	10	3.5	9.0	
t_{PHZ}	Output Disable Time	3.0	4.7	6.0	3.0	7.0	3.0	7.0	ns
t_{PLZ}	$\overline{OE}$ to Z	2.0	3.5	4.5	2.0	5.5	2.0	5.5	

MOTOROLA

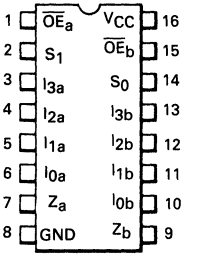
MC54F253
MC74F253

Advance Information

DESCRIPTION — The MC54F/74F253 is a Dual 4-Input Multiplexer with 3-State Outputs. It can select two bits of data from four sources using common select inputs. The outputs may be individually switched to a high-impedance state with a HIGH on the respective Output Enable $\overline{OE}$ inputs, allowing the outputs to interface directly with bus oriented systems.

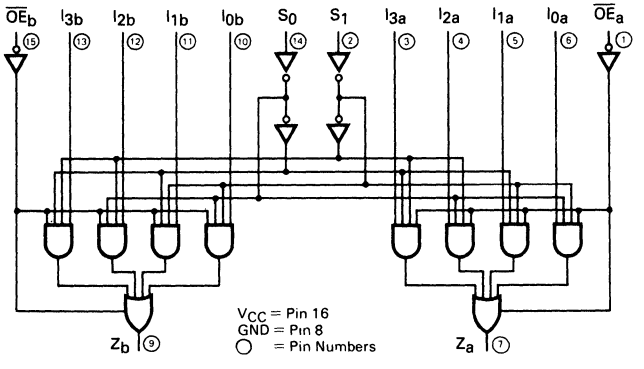
DUAL 4-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS
FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM DIP
(TOP VIEW)



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

LOGIC DIAGRAM



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GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54 74	4.5 4.75	5.0 5.0	5.5 5.25	V
T_A	Operating Ambient Temperature Range	54 74	−55 0	25 25	125 70	°C
I_{OH}	Output Current — High	54, 74	—	—	−1.0	mA
I_{OL}	Output Current — Low	54, 74	—	—	20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0°C to 70°C temperature range.

FUNCTIONAL DESCRIPTION

The F253 contains two identical 4-Input Multiplexers with 3-State Outputs. They select two bits from four sources selected by common Select Inputs (S_0, S_1). The 4-input multiplexers have individual Output Enable ($\overline{OE}_a$, $\overline{OE}_b$) inputs which when HIGH, force the outputs to a high impedance (high Z) state.

The F253 is the logic implementation of a 2-pole, 4-position switch, where the position of the switch is determined by the logic levels supplied to the two select inputs. The logic equations for the outputs are shown below:

$$Z_a = \overline{OE}_a \cdot (I_{0a} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1a} \cdot \overline{S}_1 \cdot S_0 + I_{2a} \cdot S_1 \cdot \overline{S}_0 + I_{3a} \cdot S_1 \cdot S_0)$$
$$Z_b = \overline{OE}_b \cdot (I_{0b} \cdot \overline{S}_1 \cdot \overline{S}_0 + I_{1b} \cdot \overline{S}_1 \cdot S_0 + I_{2b} \cdot S_1 \cdot \overline{S}_0 + I_{3b} \cdot S_1 \cdot S_0)$$

If the outputs of 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so that there is no overlap.

TRUTH TABLE

SELECT INPUTS		DATA INPUTS				OUTPUT ENABLE	OUTPUT
S_0	S_1	I_0	I_1	I_2	I_3	$\overline{OE}$	Z
X	X	X	X	X	X	H	(Z)
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
H	L	X	L	X	X	L	L
H	L	X	H	X	X	L	H
L	H	X	X	L	X	L	L
L	H	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

H = HIGH Level
L = LOW Level
X = Immaterial
(Z) = High Impedance (off)
Address inputs S_0 and S_1 are common to both sections.

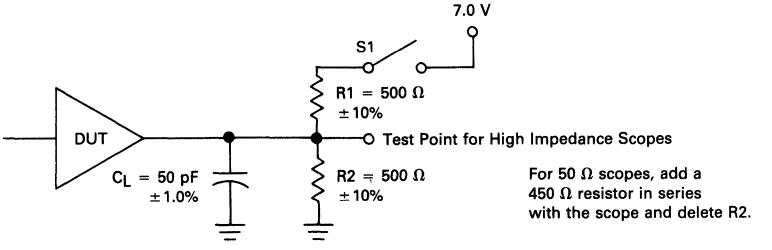
DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				−1.2	V	I_{IN} = −18 mA, V_{CC} = MIN	
V_{OH}	Output HIGH Voltage	54	2.5			V	I_{OL} = −1.0 mA	V_{CC} = MIN
		74	2.7			V	I_{OL} = −1.0 mA	
V_{OL}	Output LOW Voltage				0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V, V_{CC} = MAX	
					0.1	mA	V_{IN} = 7.0 V, V_{CC} = MAX	
I_{IL}	Input LOW Current				−0.6	mA	V_{IN} = 0.5 V, V_{CC} = MAX	
I_{OS}	Output Short Circuit Current (Note 2)		−60		−150	mA	V_{OUT} = 0 V, V_{CC} = MAX	
I_{CC}	Power Supply Current Total, Output HIGH				16	mA	$\overline{OE}_n$ = GND, V_{CC} = MAX; I_0, S_n = 4.5 V; I_1–I_3 = GND	
	Total, Output LOW				23		I_n, S_n, $\overline{OE}_n$ = GND; V_{CC} = MAX	
	Total at HIGH-Z				23		$\overline{OE}_n$ = 4.5 V, V_{CC} = MAX; I_n, S_n = GND	

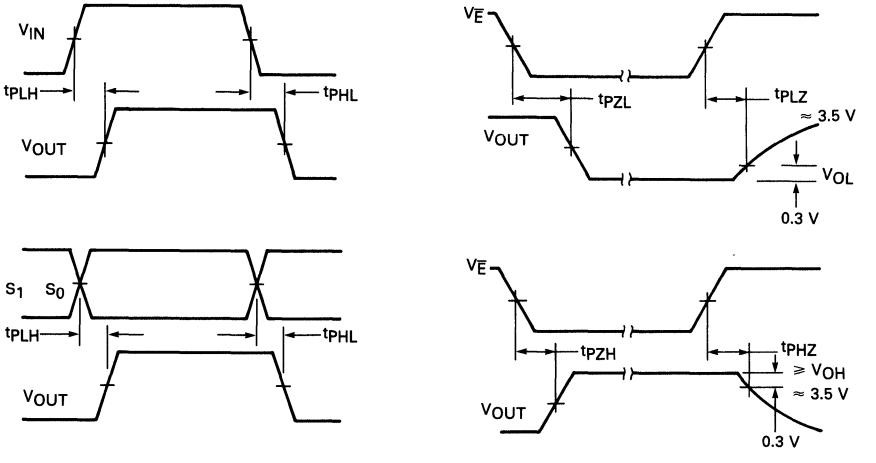
AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$ $V_{CC} = +5.0\ V$ $C_L = 50\ pF$		54F $T_A = -55°C$ to $+125°C$ $V_{CC} = 5.0\ V \pm 10\%$ $C_L = 50\ pF$		74F $T_A = 0°C$ to $+70°C$ $V_{CC} = 5.0\ V \pm 5.0\%$ $C_L = 50\ pF$		UNITS	S1 POSITION
		MIN	MAX	MIN	MAX	MIN	MAX		
t_{PLH} t_{PHL}	Propagation Delay S_n to Z_n	5.5 4.5	12.5 11	3.5 2.5	15 12	4.5 3.5	13.5 12	ns	OPEN
t_{PLH} t_{PHL}	Propagation Delay I_n to Z_n	3.0 3.0	7.0 7.0	2.5 2.5	9.0 8.0	3.0 3.0	8.0 8.0	ns	
t_{PZH} t_{PZL}	Output Enable Time	3.0 3.0	9.0 9.5	2.5 2.5	10.5 11	3.0 3.0	10 10.5	ns	CLOSED
t_{PHZ} t_{PLZ}	Output Disable Time	2.0 2.0	5.0 6.0	2.0 2.0	6.5 9.0	2.0 2.0	6.0 7.0	ns	OPEN CLOSED

AC TEST CIRCUIT



PROPAGATION DELAY MEASUREMENTS



NOTES:
1. All input waveforms have the following characteristics:
   Low Level = 0V
   High Level = 3.0 V
   Rise and Fall Times (10% to 90%) = 2.5 ns
2. All timing is measured at 1.5 V unless otherwise indicated.

MOTOROLA

MC54F257
MC74F257

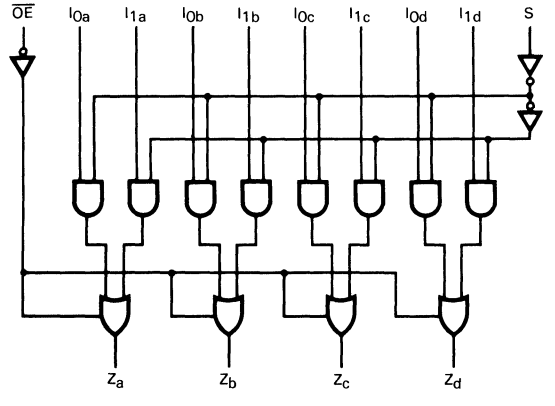
Advance Information

QUAD 3-INPUT MULTIPLEXER
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F257 is a quad 2-input multiplexer with 3-state outputs. Four bits of data from two sources can be selected using a Common Data Select input. The four outputs present the selected data in true (non-inverted) form. The outputs may be switched to a high impedance state with a HIGH on the common Output Enable ($\overline{OE}$) input, allowing the outputs to interface directly with bus oriented systems.

- MULTIPLEXER EXPANSION BY TYING OUTPUTS TOGETHER
- NON-INVERTING 3-STATE OUTPUTS
- INPUT CLAMP DIODES LIMIT HIGH-SPEED TERMINATION EFFECTS

LOGIC DIAGRAM



TRUTH TABLE

OUTPUT ENABLE	SELECT INPUT	DATA INPUTS		OUTPUTS
$\overline{OE}$	S	I_0	I_1	Z
H	X	X	X	(Z)
L	H	X	L	L
L	H	X	H	H
L	L	L	X	L
L	L	H	X	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
(Z) = High Impedance

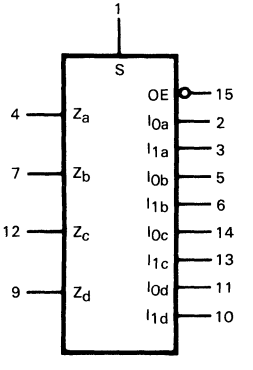
FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

QUAD 3-INPUT MULTIPLEXER
(With 3-State Outputs)

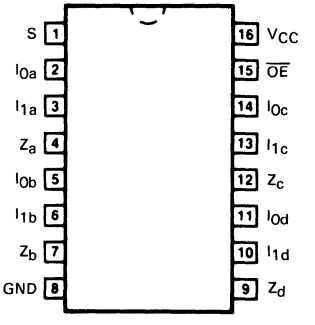
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			9.0	15	mA	$\overline{S}$, I_{1x} = 4.5 V, $\overline{OE}$, I_{0x} = Gnd	V_{CC} = MAX
I_{CCL}				14.5	22		I_{1x} = 4.5 V, $\overline{OE}$, I_{0x}, S = Gnd	
I_{CCZ}				15	23		$\overline{S}$, I_{0x} = Gnd, $\overline{OE}$, I_{1x} = 4.5 V	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

6

FUNCTIONAL DESCRIPTION — The F257 is a quad 2-input multiplexer with 3-state outputs. It selects four bits of data from two sources under control of a Common Data Select input. When the Select input is LOW, the I_{0x} inputs are selected and when Select is HIGH, the I_{1x} inputs are selected. The data on the selected inputs appears at the outputs in true (non-inverted) form. The device is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$Z_a = \overline{OE} \cdot (I_{1a} \cdot S + I_{0a} \cdot \overline{S}) \qquad Z_b = \overline{OE} \cdot (I_{1b} \cdot S + I_{0b} \cdot \overline{S})$$
$$Z_c = \overline{OE} \cdot (I_{1c} \cdot S + I_{0c} \cdot \overline{S}) \qquad Z_d = \overline{OE} \cdot (I_{1d} \cdot S + I_{0d} \cdot \overline{S})$$

When the Output Enable input ($\overline{OE}$) is HIGH, the outputs are forced to a high impedance OFF state. If the outputs are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure the Output Enable signals to 3-state devices whose outputs are tied together are designed so there is no overlap.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$, $V_{CC} = +5.0$ V, $C_L = 50$ pF			54F $T_A = -55$ to $+125°C$, $V_{CC} = 5.0$ V $\pm 10\%$, $C_L = 50$ pF		74F $T_A = 0$ to $+70°C$, $V_{CC} = 5.0$ V $\pm 5\%$, $C_L = 50$ pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay I_n to Z_n	3.0 2.5	4.5 4.2	6.0 5.5	3.0 2.5	8.0 8.0	3.0 2.5	7.0 6.5	ns
t_{PLH} t_{PHL}	Propagation Delay S to Z_n	4.5 3.5	10.1 6.5	13 8.5	4.5 3.5	15.5 10.5	4.5 3.5	15 9.5	ns
t_{PZH} t_{PZL}	Output Enable Time	3.0 3.0	5.9 5.5	7.5 7.5	3.0 3.0	9.5 10	3.0 3.0	8.5 8.5	ns
t_{PZH} t_{PZL}	Output Disable Time	2.0 2.0	4.3 4.5	6.0 6.0	2.0 2.0	7.0 9.5	2.0 2.0	7.0 7.0	ns

6

MOTOROLA

MC54F258
MC74F258

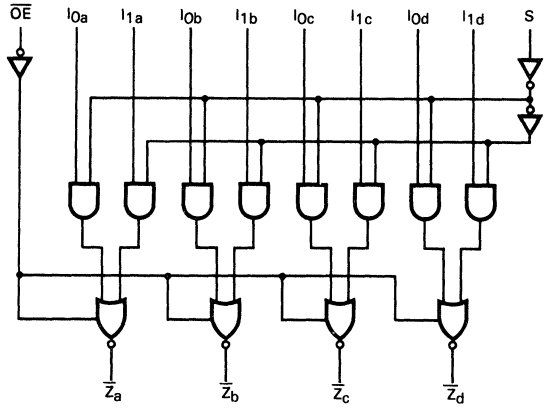
Advance Information

QUAD 2-INPUT MULTIPLEXER
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F258 is a quad 2-input multiplexer with 3-state outputs. Four bits of data from two sources can be selected using a Common Data Select input. The four outputs present the selected data in the complement (inverted) form. The outputs may be switched to a high impedance state with a HIGH on the common Output Enable ($\overline{OE}$) input, allowing the outputs to interface directly with bus oriented systems.

- **MULTIPLEXER EXPANSION BY TYING OUTPUTS TOGETHER**
- **INVERTING 3-STATE OUTPUTS**

LOGIC DIAGRAM



TRUTH TABLE

OUTPUT ENABLE	SELECT INPUT	DATA INPUTS		OUTPUTS
$\overline{OE}$	S	I_0	I_1	$\overline{Z}$
H	X	X	X	Z
L	H	X	L	H
L	H	X	H	L
L	L	L	X	H
L	L	H	X	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance

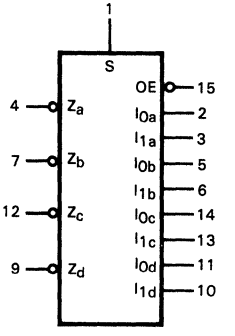
FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

QUAD 2-INPUT MULTIPLEXER
(With 3-State Outputs)

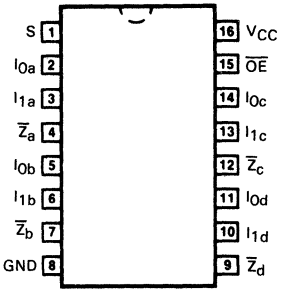
FAST™ SCHOTTKY TTL

LOGIC SYMBOLS



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

6

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

* 74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	µA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	µA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	µA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			6.2	9.5	mA	S, I_{1x} = 4.5 V $\overline{OE}$, I_{0x} = Gnd	V_{CC} = MAX
I_{CCL}				15.1	23		I_{1x} = 4.5 V $\overline{OE}$, I_{0x}, S = Gnd	
I_{CCZ}				11.3	17		S, I_{0x} = Gnd $\overline{OE}$, I_{1x} = 4.5 V	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

6

FUNCTIONAL DESCRIPTION — The F258 is a quad 2-input multiplexer with 3-state outputs. It selects four bits of data from two sources under control of a common Select input (S). When the Select input is LOW, the I_{0x} inputs are selected and when Select is HIGH, the I_{1x} inputs are selected. The data on the selected inputs appears at the outputs in inverted form. The F258 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$\overline{Z}_a = \overline{OE} \cdot (I_{1a} \cdot S + I_{0a} \cdot \overline{S}) \quad \overline{Z}_b = \overline{OE} \cdot (I_{1b} \cdot S + I_{0b} \cdot \overline{S})$$
$$\overline{Z}_c = \overline{OE} \cdot (I_{1c} \cdot S + I_{0c} \cdot \overline{S}) \quad \overline{Z}_d = \overline{OE} \cdot (I_{1d} \cdot S + I_{0d} \cdot \overline{S})$$

When the Output Enable input ($\overline{OE}$) is HIGH, the outputs are forced to a high impedance OFF state. If the outputs of the 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so there is no overlap.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay I_n to $\overline{Z}_n$	2.5 2.0	4.0 3.5	5.3 4.7	2.0 1.5	7.5 6.0	2.5 2.0	6.0 5.5	ns
t_{PLH} t_{PHL}	Propagation Delay S to $\overline{Z}_n$	4.0 4.0	6.5 7.3	8.5 9.5	4.0 4.0	12 11.5	4.0 4.0	9.5 11	ns
t_{PZH} t_{PZL}	Output Enable Time	3.0 3.0	5.9 5.5	7.5 7.5	3.0 3.0	11 9.5	3.0 3.0	8.5 8.5	ns
t_{PZH} t_{PZL}	Output Disable Time	2.0 2.0	4.3 4.5	6.0 6.0	1.5 2.0	7.0 9.0	2.0 2.0	7.0 7.0	ns

6

MOTOROLA

MC54F283
MC74F283

Advance Information

4-BIT BINARY FULL ADDER
(With Fast Carry)

DESCRIPTION — MC54F/74F283 high-speed 4-bit binary full adder with internal carry lookahead accepts two 4-bit binary words (A_0-A_3, B_0-B_3) and a Carry input (C_0). It generates the binary Sum outputs (S_0-S_3) and the Carry output (C_4) from the most significant bit. The 'F283 will operate with either active-HIGH or active-LOW operands (positive or negative logic).

FUNCTIONAL DESCRIPTION — The 'F283 adds two 4-bit binary words (A plus B) plus the incoming carry C_0. The binary sum appears on the Sum (S_0-S_3) and outgoing carry (C_4) outputs. The binary weight of the various inputs and outputs is indicated by the subscript numbers, representing powers of two.

$2^0(A_0+B_0+C_0)+2^1(A_1+B_1)$
$+2^2(A_2+B_2)+2^3(A_3+B_3)$
$= S_0 + 2S_1 + 4S_2 + 8S_3 + 16C_4$
Where (+) = plus

Interchanging inputs of equal weight does not affect the operation. Thus C_0, A_0, B_0 can be arbitrarily assigned to pins 5, 6 and 7. Due to the symmetry of the binary add function, the 'F283 can be used either with all inputs and outputs active HIGH (positive logic) or with all inputs and outputs active LOW (negative logic). See Figure A. Note that if C_0 is not used it must be tied LOW for active-HIGH logic or tied HIGH for active-LOW logic.

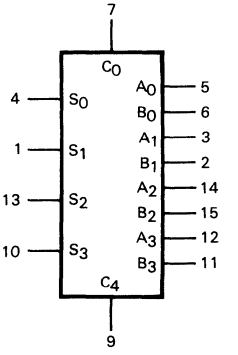
Due to pin limitations, the intermediate carries of the 'F283 are not brought out for use as inputs or outputs. However, other means can be used to effectively insert a carry into, or bring a carry out from, an intermediate stage. Figure B shows how to make a 3-bit adder. Tying the operand inputs of the fourth adder (A_3, B_3) LOW makes S_3 dependent only on, and equal to, the carry from the third adder. Using somewhat the same principle, Figure C shows a way of dividing the 'F283 into a 2-bit and a 1-bit adder. The third stage adder (A_2, B_2, S_2) is used merely as a means of getting a carry (C_{10}) signal into the fourth stage (via A_2 and B_2) and bringing out the carry from the second stage on S_2. Note that as long as A_2 and B_2 are the same, whether HIGH or LOW, they do not influence S_2. Similarly, when A_2 and B_2 are the same the carry into the third stage does not influence the carry out of the third stage. Figure D shows a method of implementing a 5-input encoder, where the inputs are equally weighted. The outputs S_0, S_1 and S_2 present a binary number equal to the number of inputs I_1 -I_5 that are true. Figure E shows one method of implementing a 5-input majority gate. When three or more of the inputs I_1 -I_5 are true, the output M_5 is true.

FAST is a trademark of Fairchild Camera and Instrument Corporation

4-BIT BINARY FULL ADDER
(With Fast Carry)

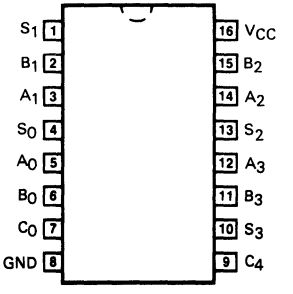
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

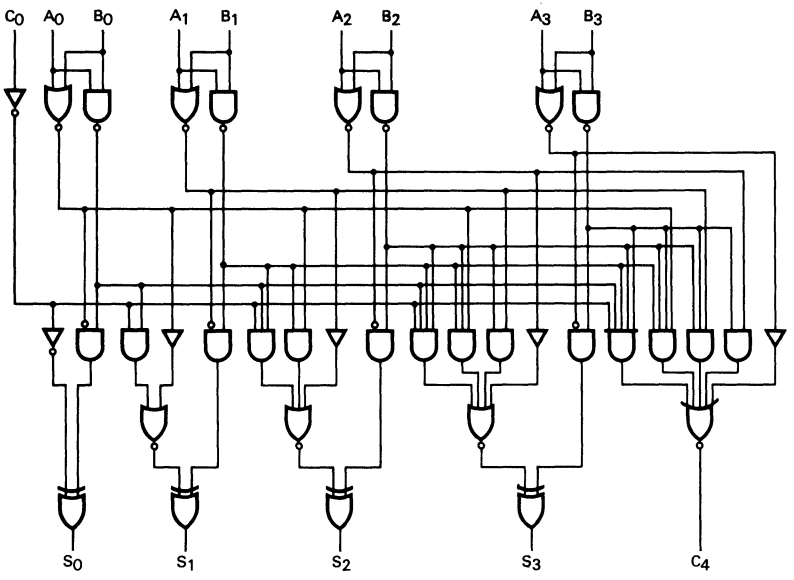
CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

6

LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74	—	—	-1.0	mA
I_{OL}	Output Current — Low	54, 74	—	—	20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FIGURE A — Active-HIGH versus Active-LOW Interpretation

	C_0	A_0	A_1	A_2	A_3	B_0	B_1	B_2	B_3	S_0	S_1	S_2	S_3	C_4
Logic Levels	L	L	H	L	H	H	L	L	H	H	H	L	L	H
Active HIGH	0	0	1	0	1	1	0	0	1	1	1	0	0	1
Active LOW	1	1	0	1	0	0	1	1	0	0	0	1	1	0

Active HIGH: 0 + 10 + 9 = 3 + 16 Active LOW: 1 + 5 + 6 = 12 + 0

FIGURE B — 3-Bit Adder

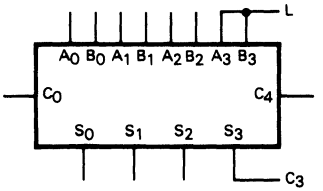


FIGURE C — 2-Bit and 1-Bit Adders

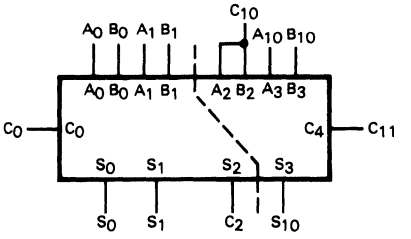


FIGURE D — 5-Input Encoder

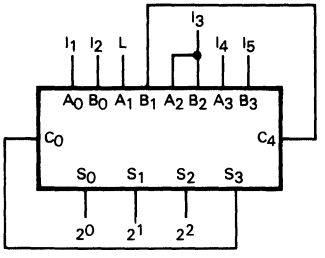
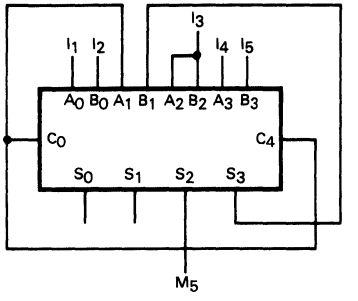


FIGURE E — 5-Input Majority Gate



DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current C_0 Input				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	A and B Inputs				-1.2	mA		
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			36	55	mA	Inputs = 4.5 V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF			54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF		74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	3.5	7.0	9.5	3.5	14	3.5	10.5	ns
t_{PHL}	C_0 to S_n	4.0	7.0	9.5	4.0	14	4.0	10.5	
t_{PLH}	Propagation Delay	4.0	7.0	9.5	4.0	14	4.0	10.5	ns
t_{PHL}	A_n or B_n to S_n	3.5	7.0	9.5	3.5	14	3.5	10.5	
t_{PLH}	Propagation Delay	3.5	5.7	7.5	3.5	10.5	3.5	8.5	ns
t_{PHL}	C_0 to C_4	3.0	5.4	7.0	3.0	10	3.0	8.0	
t_{PLH}	Propagation Delay	3.5	5.7	7.5	3.5	10.5	3.5	8.5	ns
t_{PHL}	A_n or B_n to C_4	3.0	5.3	7.0	3.0	10	3.0	8.0	

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MOTOROLA

MC54F350
MC74F350

Advance Information

4-BIT SHIFTER
(With 3-State Outputs)

DESCRIPTION — MC54F/74F350 is a specialized multiplexer that accepts a 4-bit word and shifts it 0, 1, 2 or 3 places, as determined by two Select (S_0, S_1) inputs. For expansion to longer words, three linking inputs are provided for lower-order bits; thus two packages can shift an 8-bit word, four packages a 16-bit word, etc. Shifting by more than three places is accomplished by paralleling the 3-state outputs of different packages and using the Output Enable ($\overline{OE}$) inputs as a third Select level. With appropriate interconnections, the 'F350 can perform zero-backfill, sign-extend or end-around (barrel) shift functions.

- **Linking Inputs for Word Expansion**
- **3-State Outputs for Extending Shift Range**

FUNCTIONAL DESCRIPTION — The 'F350 is operationally equivalent to a 4-input multiplexer with the inputs connected so that the select code causes successive one-bit shifts of the data word. This internal connection makes it possible to perform shifts of 0, 1, 2 or 3 places on words of any length.

A 7-bit data word is introduced at the I_n inputs and is shifted according to the code applied to the select inputs S_0, S_1. Outputs O_0-O_3 are 3-state, controlled by an active-LOW output enable ($\overline{OE}$). When $\overline{OE}$ is LOW, data outputs will follow selected data inputs; when HIGH, the data outputs will be forced to the high-impedance state. This feature allows shifters to be cascaded on the same output lines or to a common bus. The shift function can be logical, with zeros pulled in at either or both ends of the shifting field; arithmetic, where the sign bit is repeated during a shift down; or end around, where the data word forms a continuous loop.

LOGIC EQUATIONS

$$O_0 = \overline{S}_0\,\overline{S}_1\,I_0 + S_0\,\overline{S}_1\,I_{-1} + \overline{S}_0\,S_1\,I_{-2} + S_0\,S_1\,I_{-3}$$
$$O_1 = \overline{S}_0\,\overline{S}_1\,I_1 + S_0\,\overline{S}_1\,I_0 + \overline{S}_0\,S_1\,I_{-1} + S_0\,S_1\,I_{-2}$$
$$O_2 = \overline{S}_0\,\overline{S}_1\,I_2 + S_0\,\overline{S}_1\,I_1 + \overline{S}_0\,S_1\,I_0 + S_0\,S_1\,I_{-1}$$
$$O_3 = \overline{S}_0\,\overline{S}_1\,I_3 + S_0\,\overline{S}_1\,I_2 + \overline{S}_0\,S_1\,I_1 + S_0\,S_1\,I_0$$

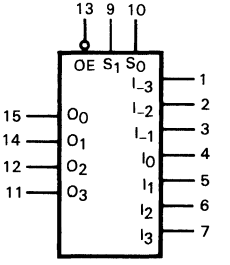
FAST is a trademark of Fairchild Camera and Instrument Corporation.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

4-BIT SHIFTER
(With 3-State Outputs)

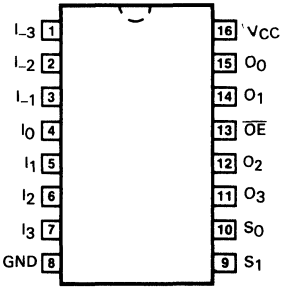
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

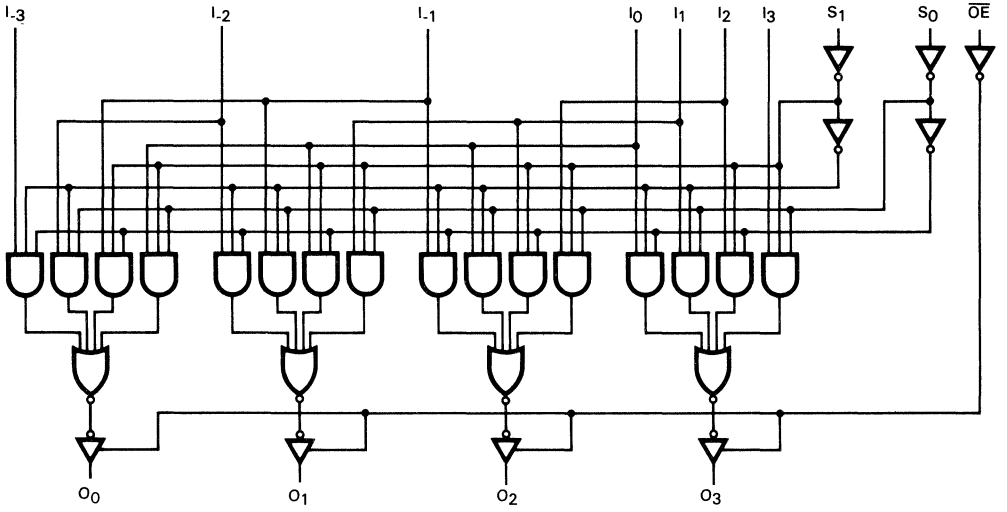
6

TRUTH TABLE

INPUTS			OUTPUTS			
$\overline{OE}$	S_1	S_0	O_0	O_1	O_2	O_3
H	X	X	Z	Z	Z	Z
L	L	L	I_0	I_1	I_2	I_3
L	L	H	I_{-1}	I_0	I_1	I_2
L	H	L	I_{-2}	I_{-1}	I_0	I_1
L	H	H	I_{-3}	I_{-2}	I_{-1}	I_0

H = HIGH Voltage Level
L = LOW Voltage Level
Z = High Impedance
X = Immaterial

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74	—	—	-3.0	mA
I_{OL}	Output Current — Low	54, 74	—	—	20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-1.2	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			22	35	mA	Outputs HIGH	V_{CC} = Max
I_{CCL}				26	41		Outputs LOW	
I_{CCZ}				26	42		Outputs OFF	

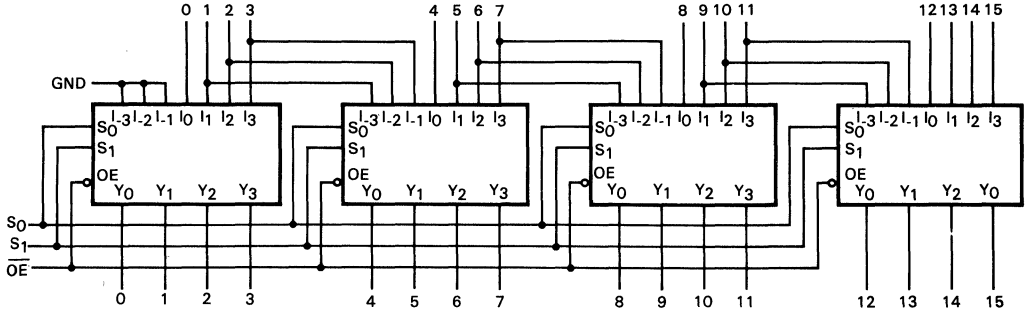
NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	3.0	4.5	6.0	3.0	7.5	3.0	7.0	ns
t_{PHL}	I_n to O_n	2.5	4.0	5.5	2.5	7.0	2.5	6.5	
t_{PLH}	Propagation Delay	4.0	7.8	10	4.0	13	4.0	11	ns
t_{PHL}	S_n to O_n	3.0	6.5	8.5	3.0	10	3.0	9.5	
t_{PZH}	Output Enable Time	2.5	5.0	7.0	2.5	8.5	2.5	8.0	ns
t_{PZL}		4.0	7.0	9.0	4.0	11	4.0	10	
t_{PHZ}	Output Disable Time	2.0	3.9	5.5	2.0	7.0	2.0	6.5	ns
t_{PLZ}		2.0	4.0	5.5	2.0	8.5	2.0	6.5	

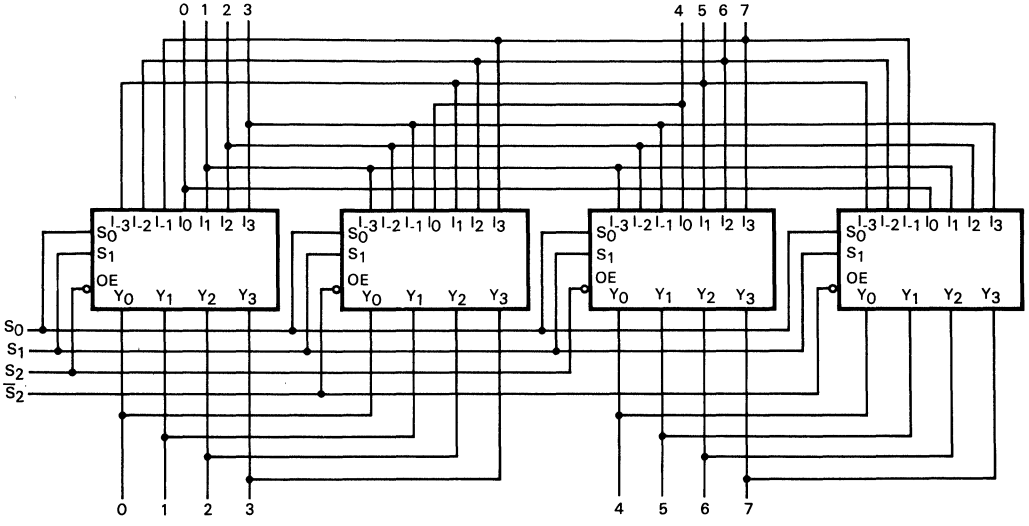
APPLICATIONS

16-Bit Shift-Up 0 to 3 Places, Zero Backfill



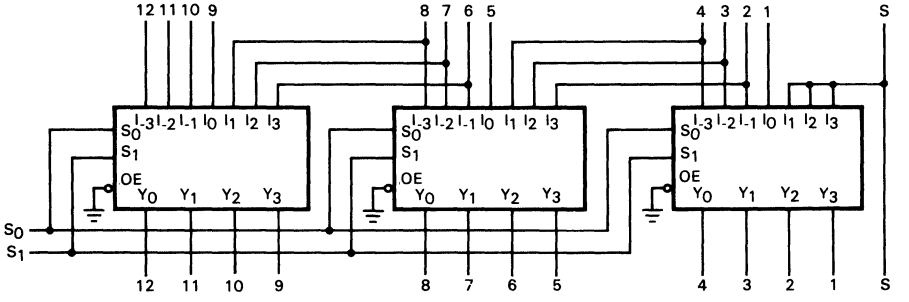
S_1	S_0	
L	L	NO SHIFT
L	H	SHIFT 1 PLACE
H	L	SHIFT 2 PLACES
H	H	SHIFT 3 PLACES

8-Bit End Around Shift 0 to 7 Places



S_2	S_1	S_0	
L	L	L	NO SHIFT
L	L	H	SHIFT END AROUND 1
L	H	L	SHIFT END AROUND 2
L	H	H	SHIFT END AROUND 3
H	L	L	SHIFT END AROUND 4
H	L	H	SHIFT END AROUND 5
H	H	L	SHIFT END AROUND 6
H	H	H	SHIFT END AROUND 7

13-Bit Twos Complement Scaler



S_1	S_0	SCALE
L	L ÷ 8	1/8
L	H÷4	1/4
H	L ÷ 2	1/2
H	H NO CHANGE	1

6

MOTOROLA

MC54F352
MC74F352

Advance Information

DUAL 4-INPUT MULTIPLEXER

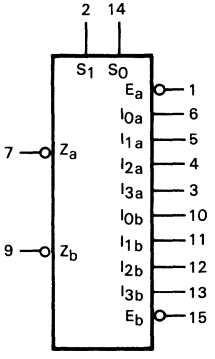
DESCRIPTION — The MC54F/74F352 is a very high speed dual 4-input multiplexer with common Select inputs and individual Enable inputs for each section. It can select two bits of data from four sources. The two buffered outputs present data in the inverted (complementary) form. The 'F352 is the functional equivalent of the 'F153 except with inverted outputs.

- **Inverted Version of the 'F153**
- **Separate Enables for Each Multiplexer**
- **Input Clamp Diode Limits High Speed Termination Effects**

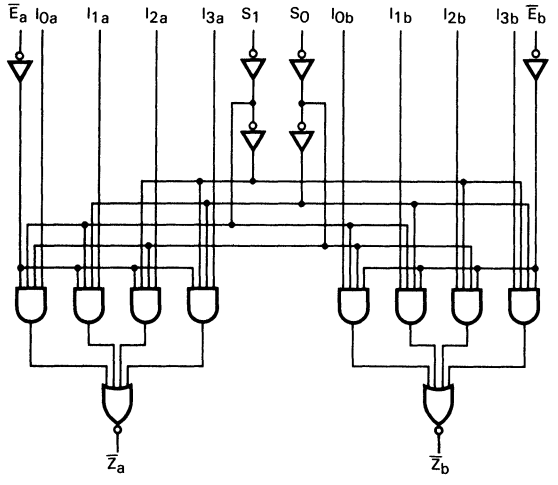
DUAL 4-INPUT MULTIPLEXER

FAST™ SCHOTTKY TTL

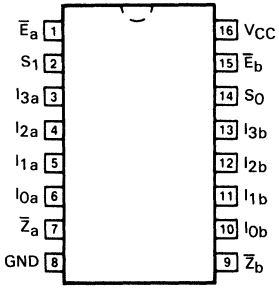
LOGIC SYMBOL



LOGIC DIAGRAM



CONNECTION DIAGRAM



J Suffix — Case 620-08
(Ceramic)
N Suffix — Case 648-05
(Plastic)

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GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74	—	—	-1.0	mA
I_{OL}	Output Current — Low	54, 74	—	—	20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FUNCTIONAL DESCRIPTION — The 'F352 is a dual 4-input multiplexer. It selects two bits of data from up to four sources under the control of the common Select inputs (S_0, S_1). The two 4-input multiplexer circuits have individual active-LOW Enables ($\overline{E}_a$, $\overline{E}_b$) which can be used to strobe the outputs independently. When the Enables ($\overline{E}_a$, $\overline{E}_b$) are HIGH, the corresponding outputs ($\overline{Z}_a$, $\overline{Z}_b$) are forced HIGH.

The logic equations for the outputs are shown below:

$$\overline{Z}_a = \overline{E_a \bullet (I_{0a} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1a} \bullet \overline{S}_1 \bullet S_0 \bullet I_{2a} \bullet S_1 \bullet \overline{S}_0 + I_{3a} \bullet S_1 \bullet S_0)}$$

$$\overline{Z}_b = \overline{E_b \bullet (I_{0b} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1b} \bullet \overline{S}_1 \bullet S_0 \bullet I_{2b} \bullet S_1 \bullet \overline{S}_0 + I_{3b} \bullet S_1 \bullet S_0)}$$

The 'F352 can be used to move data from a group of registers to a common output bus. The particular register from which the data came would be determined by the state of the Select inputs. A less obvious application is as a function generator. The 'F352 can generate two functions of three variables. This is useful for implementing highly irregular random logic.

TRUTH TABLE

SELECT INPUTS		INPUTS (a or b)					OUTPUT
S_0	S_1	$\overline{E}$	I_0	I_1	I_2	I_3	$\overline{Z}$
X	X	H	X	X	X	X	H
L	L	L	L	X	X	X	H
L	L	L	H	X	X	X	L
H	L	L	X	L	X	X	H
H	L	L	X	H	X	X	L
L	H	L	X	X	L	X	H
L	H	L	X	X	H	X	L
H	H	L	X	X	X	L	H
H	H	L	X	X	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

6

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			9.3	14	mA	V_{IN} = Gnd	V_{CC} = MAX
I_{CCL}				13.3	20		V_{IN} = HIGH	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	4.0	7.4	13	3.5	14.5	4.0	14	ns
t_{PHL}	S_n to $\overline{Z}_n$	4.0	7.0	13	3.5	15	4.0	14	
t_{PLH}	Propagation Delay	5.0	8.7	14	4.5	17	5.0	15	ns
t_{PHL}	$\overline{E}_n$ to $\overline{Z}_n$	4.0	8.6	11	4.0	13	4.0	12	
t_{PLH}	Propagation Delay	2.0	4.9	7.0	2.0	9.0	2.0	8.0	ns
t_{PHL}	I_n to $\overline{Z}_n$	2.0	3.0	6.0	2.0	7.5	2.0	7.0	

6

MOTOROLA

MC54F353
MC74F353

Advance Information

DUAL 4-INPUT MULTIPLEXER
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F353 is a dual 4-input multiplexer with 3-state outputs. It can select two bits of data from four sources using common Select inputs. The outputs may be individually switched to a high impedance state with a HIGH on the respective Output Enable ($\overline{OE}$) inputs, allowing the outputs to interface directly with bus oriented systems.

- **Inverted Version of 'F253**
- **Multifunction Capability**
- **Separate Enables for Each Multiplexer**

FUNCTIONAL DESCRIPTION — The 'F353 contains two identical 4-input multiplexers with 3-state outputs. They select two bits from four sources selected by common Select inputs (S_0, S_1). The 4-input multiplexers have individual Output enable ($\overline{OE}_a$, $\overline{OE}_b$) inputs which, when HIGH, force the outputs to a high impedance (high Z) state. The logic equations for the outputs are shown below:

$$\overline{Z}_a = \overline{OE}_a \bullet (I_{0a} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1a} \bullet \overline{S}_1 \bullet S_0 + I_{2a} \bullet S_1 \bullet \overline{S}_0 + I_{3a} \bullet S_1 \bullet S_0)$$

$$\overline{Z}_b = \overline{OE}_b \bullet (I_{0b} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1b} \bullet \overline{S}_1 \bullet S_0 + I_{2b} \bullet S_1 \bullet \overline{S}_0 + I_{3b} \bullet S_1 \bullet S_0)$$

If the outputs of 3-state devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to 3-state devices whose outputs are tied together are designed so that there is no overlap.

TRUTH TABLE

SELECT INPUTS		DATA INPUTS				OUTPUT ENABLE	OUTPUT
S_0	S_1	I_0	I_1	I_2	I_3	$\overline{OE}$	$\overline{Z}$
X	X	X	X	X	X	H	(Z)
L	L	L	X	X	X	L	H
L	L	H	X	X	X	L	L
H	L	X	L	X	X	L	H
H	L	X	H	X	X	L	L
L	H	X	X	L	X	L	H
L	H	X	X	H	X	L	L
H	H	X	X	X	L	L	H
H	H	X	X	X	H	L	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
(Z) = High Impedance

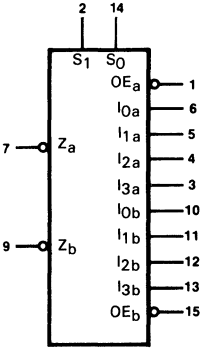
Address inputs S_0 and S_1 are common to both sections.

FAST is a trademark of Fairchild Camera and Instrument Corporation

This document contains information on a new product. Specifications and information herein are subject to change without notice.

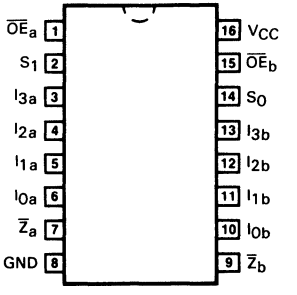
DUAL 4-INPUT MULTIPLEXER
(With 3-State Outputs)

LOGIC SYMBOL



V_{CC} = Pin 16
GND = Pin 8

CONNECTION DIAGRAM



J Suffix — Case 620-08 (Ceramic)
N Suffix — Case 648-05 (Plastic)

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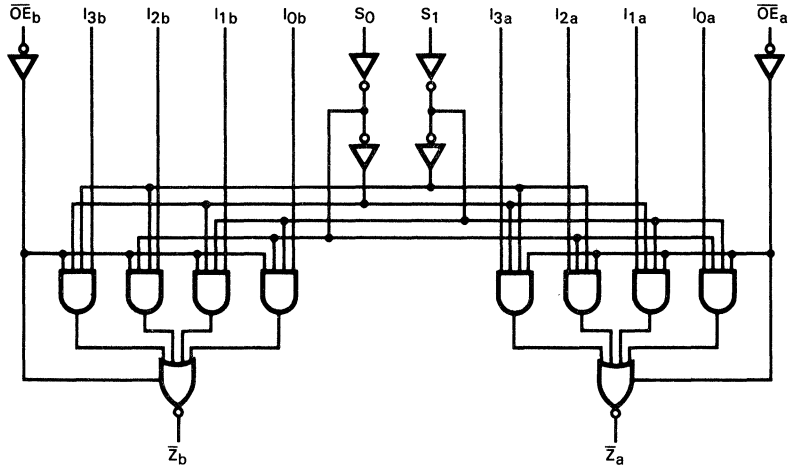
LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF			54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF		74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay S_n to $\overline{Z}_n$	5.0 4.0	8.8 7.4	14 11	5.0 4.0	16 14	5.0 4.0	15 12	ns
t_{PLH} t_{PHL}	Propagation Delay I_n to $\overline{Z}_n$	3.0 2.0	5.6 2.8	7.0 6.0	3.0 2.0	9.0 7.5	3.0 2.0	8.0 7.0	ns
t_{PZH} t_{PZL}	Output Enable Time	3.0 3.0	6.8 7.2	9.0 9.5	3.0 3.0	11 12	3.0 3.0	10 10.5	ns
t_{PHZ} t_{PLZ}	Output Disable Time	2.0 2.0	3.7 4.4	5.0 6.0	2.0 2.0	6.5 8.5	2.0 2.0	6.0 7.0	

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			9.3	14	mA	I_n, S_n, $\overline{OE}_n$=Gnd	V_{CC} = Max
I_{CCL}				13.3	20		I_n, S_n = Gnd	
I_{CCZ}				15	23		$\overline{OE}_n$ = 4.5 V	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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MC54F373
MC74F373

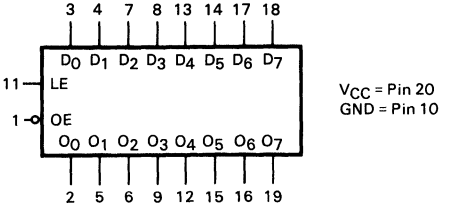
Advance Information

OCTAL TRANSPARENT LATCH
(With 3-State Inputs)

DESCRIPTION — The MC54F/74F373 consists of eight latches with 3-state outputs for bus organized system applications. The flip-flops appear transparent to the data when Latch Enable (Le) is HIGH. When LE is LOW, the data that meets the setup times is latched. Data appears on the bus when the Output Enable ($\overline{OE}$) is LOW. When $\overline{OE}$ is HIGH the bus output is in the high impedance state.

- **Eight Latches in a Single Package**
- **3-State Outputs for Bus Interfacing**

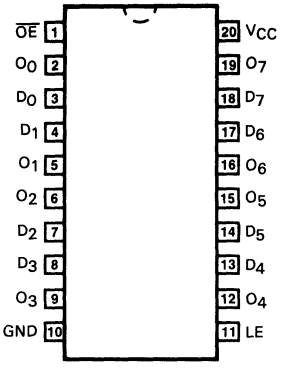
LOGIC SYMBOL



OCTAL TRANSPARENT LATCH
(With 3-State Inputs)

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



J Suffix — Case 732-03
(Ceramic)
N Suffix — Case 738-01
(Plastic)

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GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

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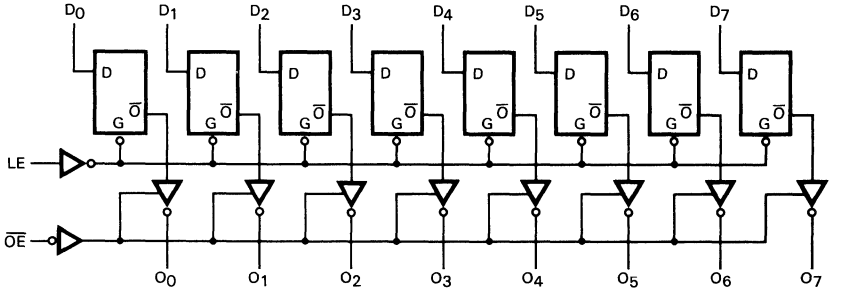
FUNCTIONAL DESCRIPTION — The 'F373 contains eight D-type latches with 3-state output buffers. When the Latch Enable (LE) input is HIGH, data on the D_n inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The 3-state buffers are controlled by the Output Enable ($\overline{OE}$) input. When $\overline{OE}$ is LOW, the buffers are in the bi-state mode. When $\overline{OE}$ is HIGH the buffers are in the high impedance mode but this does not interfere with entering new data into the latches.

LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCZ}	Power Supply Current (All Outputs OFF)			35	55	mA	$\overline{OE}$ = 4.5 V	V_{CC} = MAX
							D_n, LE = Gnd	

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay D_n to O_n	3.0 2.0	5.3 3.7	7.0 5.0	3.0 2.0	8.5 6.0	3.0 2.0	8.0 6.0	ns
t_{PLH} t_{PHL}	Propagation Delay LE to O_n	5.0 3.0	9.0 5.2	11.5 7.0	5.0 3.0	15 8.5	5.0 3.0	13 8.0	ns
t_{PZH} t_{PZL}	Output Enable Time	2.0 2.0	5.0 5.6	11 7.5	2.0 2.0	13.5 10	2.0 2.0	12 8.5	ns
t_{PHZ} t_{PLZ}	Output Disable Time	2.0 2.0	4.5 3.8	6.5 5.0	2.0 2.0	10 7.0	2.0 2.0	7.5 6.0	ns

AC OPERATING REQUIREMENTS:

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = −55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Setup Time, HIGH or LOW D_n to LE	2.0 2.0			2.0 2.0		2.0 2.0		ns
t_h (H) t_h (L)	Hold Time, High or LOW D_n to LE	3.0 3.0			3.0 3.0		3.0 3.0		
t_w (H)	LE Pulse Width HIGH	6.0			6.0		6.0		ns

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MOTOROLA

MC54F374
MC74F374

Advance Information

OCTAL D-TYPE FLIP-FLOP
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F374 is a high-speed, low-power octal D-type flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus oriented applications. A buffered Clock (CP) and Output Enable ($\overline{OE}$) are common to all flip-flops.

- **Edge-triggered D-Type Inputs**
- **Buffered Positive Edge-triggered Clock**
- **3-State Outputs for Bus Oriented Applications**

FUNCTIONAL DESCRIPTION — the 'F374 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-state true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable ($\overline{OE}$) LOW, the contents of the eight flip-flops are available at the outputs. When the $\overline{OE}$ is HIGH, the outputs go to the high impedance state. Operation of the $\overline{OE}$ input does not affect the state of the flip-flops.

TRUTH TABLE

INPUTS		OUTPUTS	
D_n	CP	$\overline{OE}$	O_n
H	↑	L	H
L	↑	L	L
X	X	H	Z

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance

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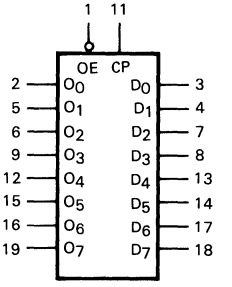
This document contains information on a new product. Specifications and information herein are subject to change without notice.

OCTAL D-TYPE FLIP-FLOP
(With 3-State Outputs)

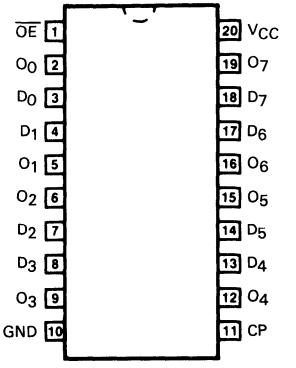
FAST™ SCHOTTKY TTL

LOGIC SYMBOL



V_{CC} = Pin 20
GND = Pin 10

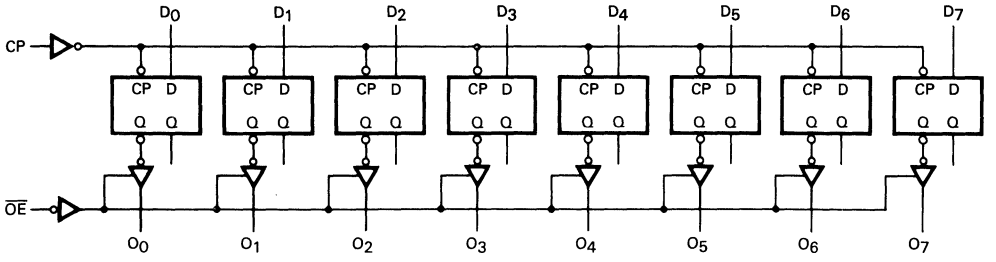
CONNECTION DIAGRAM



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

6

LOGIC DIAGRAM



GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4			I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCL}	Power Supply Current (All Outputs OFF)			55	86	mA	D_n = Gnd, $\overline{OE}$ = 4.5V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	Maximum Clock Frequency	100			60		70		MHz
t_{PLH} t_{PHL}	Propagation Delay CP to O_n	4.0 4.0	6.5 6.5	8.5 8.5	4.0 4.0	10.5 11	4.0 4.0	10 10	ns
t_{PZH} t_{PZL}	Output Enable Time	2.0 2.0	9.0 5.8	11.5 7.5	2.0 2.0	14 10	2.0 2.0	12.5 8.5	ns
t_{PHZ} t_{PLZ}	Output Disable Time	2.0 2.0	5.3 4.3	7.0 5.5	2.0 2.0	8.0 7.5	2.0 2.0	8.0 6.5	ns

AC OPERATING REQUIREMENTS:

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Setup Time, HIGH or LOW D_n to CP	2.0 2.0			2.5 2.0		2.0 2.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW D_n to CP	2.0 2.0			2.0 2.5		2.0 2.0		ns
$t_{w(H)}$ $t_{w(L)}$	CP Pulse Width, HIGH or LOW	7.0 6.0			7.0 6.0		7.0 6.0		ns

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MOTOROLA

MC54F381
MC74F381

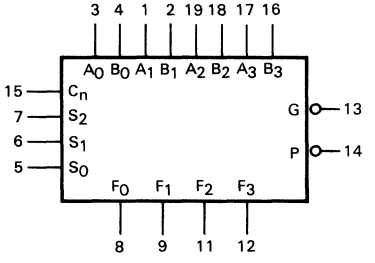
Advance Information

4-BIT ARITHMETIC LOGIC UNIT

DESCRIPTION — The MC54F/74F381 performs three arithmetic and three logic operations on two 4-bit words, A and B. Two additional Select input codes force the Function outputs LOW or HIGH. Carry Propagate and Generate outputs are provided for use with the 'F182 Carry Lookahead Generator for high-speed expansion to longer word lengths. For ripple expansion, refer to the 'F382 ALU data sheet.

- **Low Input Loading Minimizes Drive Requirements**
- **Performs Six Arithmetic and Logic Functions**
- **Selectable Low (Clear) and High (Preset) Functions**
- **Carry Generate and Propagate Outputs for use with Carry Lookahead Generator**

LOGIC SYMBOL

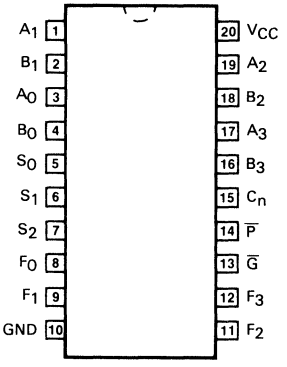


V_{CC} = Pin 20
GND = Pin 10

4-BIT ARITHMETIC LOGIC UNIT

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



J Suffix — Case 732-03 (Ceramic)

N Suffix — Case 738-01 (Plastic)

GUARANTEED OPERATING RANGES

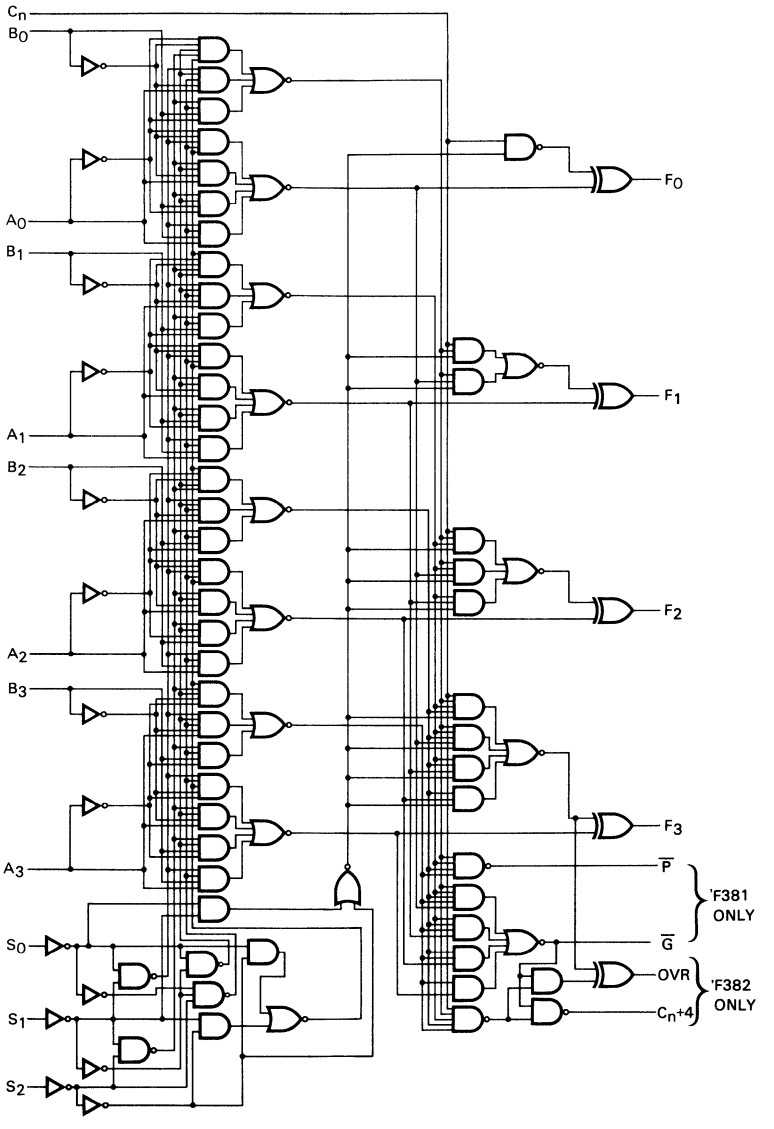
SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FAST is a trademark of Fairchild Camera and Instrument Corporation.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

LOGIC DIAGRAM



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DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current $S_0 - S_2$ Inputs				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
	Other Inputs				-2.4	mA	V_{IN} = 0.5 V	
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CC}	Power Supply Current			59	89	mA	$S_0 - S_3$ = GND; Other Inputs HIGH	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

FUNCTIONAL DESCRIPTION — Signals applied to the Select inputs $S_0 - S_2$ determine the mode of operation, as indicated in the Function Select Table. An extensive listing of input and output levels is shown in the Truth Table. The circuit performs the arithmetic functions for either active-HIGH or active-LOW operands, with output levels in the same convention. In the Subtract operating modes, it is necessary to force a carry (HIGH for active-HIGH operands, LOW for active-LOW operands) into the C_n input of the least significant package.

The Carry Generate ($\overline{G}$) and Carry Propagate ($\overline{P}$) outputs supply input signals to the 'F182 carry lookahead generator for expansion to longer word length, as shown in Figure A. Note that an 'F382 ALU is used for the most significant package. Typical delays for Figure A are given in Figure B.

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FUNCTION SELECT TABLE

SELECT S_0	SELECT S_1	SELECT S_2	OPERATION
L	L	L	Clear
H	L	L	B Minus A
L	H	L	A Minus B
H	H	L	A Plus B
L	L	H	A⊕B
H	L	H	A + B
L	H	H	AB
H	H	H	Preset

H = HIGH Voltage Level L = LOW Voltage Level

FIGURE A — 16-Bit Lookahead Carry ALU Expansion

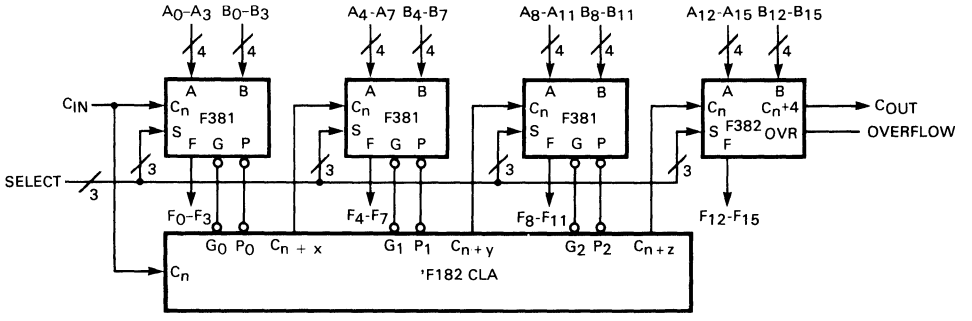

FIGURE B — 16-Bit Delay Tabulation

PATH SEGMENT	TOWARD F	OUTPUT C_{n+4}, OVR
A_i or B_i to $\overline{P}$	7.2 ns	7.2 ns
$\overline{P}_i$ to C_{n+1} ('F182)	6.2 ns	6.2 ns
C_n to F	8.1 ns	—
C_n to C_{n+4}, OVR	—	8.0 ns
Total Delay	21.5 ns	21.4 ns

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF			54F T_A = −55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF		74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Propagation Delay	2.5	8.1	10.5	2.5	15	2.5	11.5	ns
t_{PHL}	C_n to F_i	2.5	5.7	8.0	2.5	11.5	2.5	9.0	
t_{PLH}	Propagation Delay	4.0	10.4	13.5	4.0	19	4.0	14.5	ns
t_{PHL}	Any A or B to Any F	3.5	8.2	11	3.5	15.5	3.5	12	
t_{PLH}	Propagation Delay	4.5	8.3	11	4.5	15.5	4.5	12	ns
T_{PHL}	S_i to F_i	4.0	8.2	11	4.0	15.5	4.0	12	
t_{PLH}	Propagation Delay	3.5	6.4	9.0	3.5	12.5	3.5	10	ns
t_{PHL}	A_i or B_i to $\overline{G}$	4.0	6.8	10	4.0	14	4.0	11	
t_{PLH}	Propagation Delay	4.0	7.2	10.5	4.0	15	4.0	11.5	ns
t_{PHL}	A_i or B_i to $\overline{P}$	3.5	6.5	9.5	3.5	13	3.5	10.5	
t_{PLH}	Propagation Delay	4.0	7.8	10.5	4.0	15	4.0	11.5	ns
t_{PHL}	S_i to $\overline{G}$ or $\overline{P}$	4.5	10.2	13.5	4.5	19	4.5	14.5	

TRUTH TABLE

	INPUTS						OUTPUTS					
FUNCTION	S_0	S_1	S_2	C_n	A_n	B_n	F_0	F_1	F_2	F_3	$\overline{G}$	$\overline{P}$
CLEAR	0	0	0	X	X	X	0	0	0	0	0	0
B MINUS A	1	0	0	0	0	0	1	1	1	1	1	0
				0	0	1	0	1	1	1	0	0
				0	1	0	0	0	0	0	1	1
				0	1	1	1	1	1	1	1	0
				1	0	0	0	0	0	0	1	0
				1	0	1	1	1	1	1	0	0
				1	1	0	1	0	0	0	1	1
				1	1	1	0	0	0	0	1	0
A MINUS B	0	1	0	0	0	0	1	1	1	1	1	0
				0	0	1	0	0	0	0	1	1
				0	1	0	0	1	1	1	0	0
				0	1	1	1	1	1	1	1	0
				1	0	0	0	0	0	0	1	0
				1	0	1	1	0	0	0	1	1
				1	1	0	1	1	1	1	0	0
				1	1	1	0	0	0	0	1	0
A PLUS B	1	1	0	0	0	0	0	0	0	0	1	1
				0	0	1	1	1	1	1	1	0
				0	1	0	1	1	1	1	1	0
				0	1	1	0	1	1	1	0	0
				1	0	0	1	0	0	0	1	1
				1	0	1	0	0	0	0	1	0
				1	1	0	0	0	0	0	1	0
				1	1	1	1	1	1	1	0	0
A⊕B	0	0	1	X	0	0	0	0	0	0	0	0
				X	0	1	1	1	1	1	1	1
				X	1	0	1	1	1	1	1	0
				X	1	1	0	0	0	0	0	0
A + B	1	0	1	X	0	0	0	0	0	0	0	0
				X	0	1	1	1	1	1	1	1
				X	1	0	1	1	1	1	1	1
				X	1	1	1	1	1	1	1	0
AB	0	1	1	X	0	0	0	0	0	0	0	0
				X	0	1	0	0	0	0	1	1
				X	1	0	0	0	0	0	0	0
				X	1	1	1	1	1	1	1	0
PRESET	1	1	1	X	0	0	1	1	1	1	1	1
				X	0	1	1	1	1	1	1	1
				X	1	0	1	1	1	1	1	1
				X	1	1	1	1	1	1	1	0

1 = HIGH Voltage Level
0 = LOW Voltage Level
X = Immaterial

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MOTOROLA

MC54F521
MC74F521

Advance Information

8-BIT IDENTITY COMPARATOR

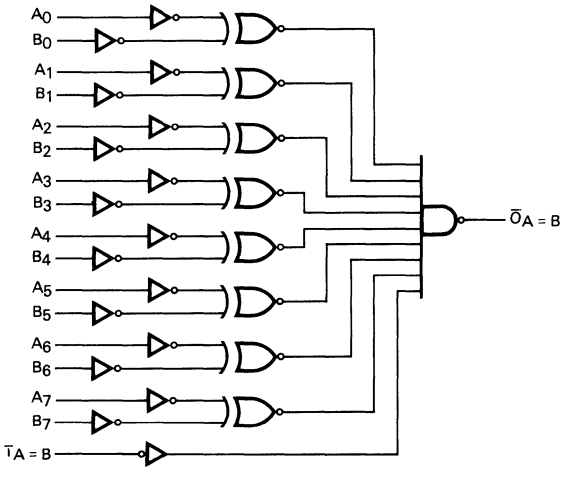
DESCRIPTION — The MC54F/74F521 is an expandable 8-bit comparator. It compares two words of up to eight bits each and provides a LOW output when the two words match bit for bit. The expansion input $\overline{I}_{A=B}$ also serves as an active-LOW enable input.

- **Compares Two 8-Bit Words in 6.5 ns Typ**
- **Expandable to Any Word Length**
- **20-Pin Package**

8-BIT IDENTITY COMPARATOR

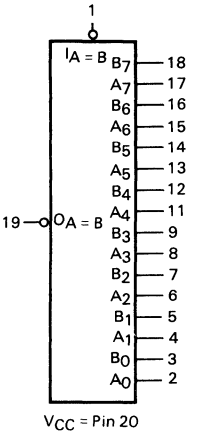
FAST™ SCHOTTKY TTL

LOGIC DIAGRAM



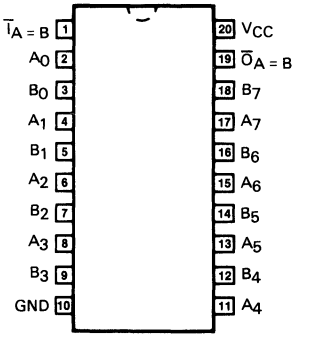
Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

LOGIC SYMBOL



V_{CC} = Pin 20
GND = Pin 10

CONNECTION DIAGRAM



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

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This document contains information on a new product. Specifications and information herein are subject to change without notice.

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-1.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0mA	V_{CC} = MIN
		74	2.7	3.4		V	I_{OH} = -1.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100	μA	V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCH}	Power Supply Current			24	36	mA	$\overline{I}_A$ = B = Gnd	V_{CC} = MAX
I_{CCL}				15.5	23			

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

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TRUTH TABLE

Inputs		Output
$\overline{I}_{A=B}$	A, B	$\overline{O}_{A=B}$
L	A = B*	L
L	A ≠ B	H
H	A = B*	H
H	A ≠ B	H

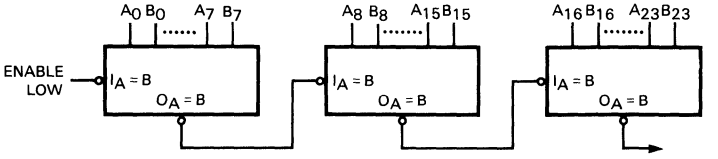
H = HIGH Voltage Level
L = LOW Voltage Level
*$A_0 = B_0$, $A_1 = B_1$, $A_2 = B_2$, etc.

AC CHARACTERISTICS

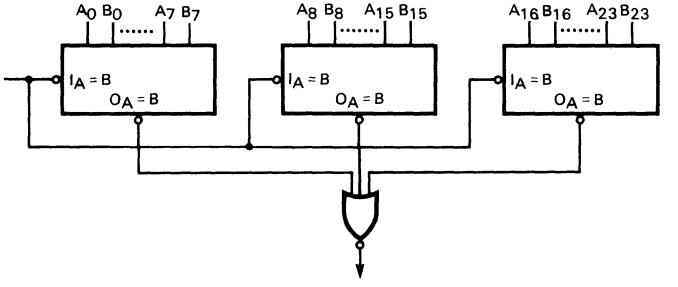
SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V C_L = 50 pF			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10% C_L = 50 pF		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5% C_L = 50 pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH} t_{PHL}	Propagation Delay A_n or B_n to $\overline{O}_A = B$	3.5 4.0	6.5 6.5	9.5 9.0	3.5 4.0	15 12	3.5 4.0	11 10.5	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{I}_A = B$ to $\overline{O}_A = B$	3.0 3.5	4.5 5.0	6.5 7.0	3.0 3.5	8.5 9.0	3.0 3.5	7.5 8.0	ns

APPLICATIONS

Ripple Expansion



Parallel Expansion



6

MOTOROLA

MC54F533
MC74F533

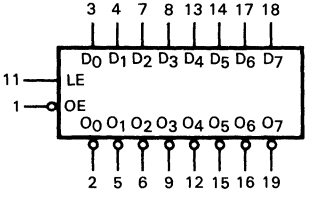
Advance Information

OCTAL TRANSPARENT LATCH
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F533 consists of eight latches with 3-state outputs for bus organized system applications. The flip-flops appear transparent to the data when Latch Enable (LE) is HIGH. When LE is LOW, the data that meets the setup times is latched. Data appears on the bus when the Output Enable ($\overline{OE}$) is LOW. When $\overline{OE}$ is HIGH the bus output is in the high-impedance state. The F533 is the same as the F373, except that the outputs are inverted. For description and logic diagram please see the F373 data sheet.

- **Eight Latches in a Single Package**
- **3-State Outputs for Bus Interfacing**

LOGIC SYMBOL

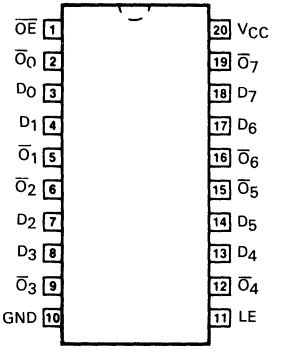


V_{CC} = Pin 20
GND = Pin 10

OCTAL TRANSPARENT LATCH
(With 3-State Outputs)

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



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GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

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DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCZ}	Power Supply Current			41	61	mA	$\overline{OE}$ = 4.5 V, D_n, LE = Gnd	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C, V_{CC} = +5.0 V, C_L = 50 pF MIN	TYP	MAX	54F T_A = -55 to +125°C, V_{CC} = 5.0 V ±10%, C_L = 50 pF MIN	MAX	74F T_A = 0 to +70°C, V_{CC} = 5.0 V ±5%, C_L = 50 pF MIN	MAX	UNITS
t_{PLH}	Propagation Delay	4.0	6.9	9.0	4.0	12	4.0	10	ns
t_{PHL}	D_n to $\overline{O}_n$	3.0	5.2	7.0	3.0	9.0	3.0	8.0	
t_{PLH}	Propagation Delay	5.0	8.5	11	5.0	14	5.0	13	ns
t_{PHL}	LE to $\overline{O}_n$	3.0	5.6	7.0	3.0	9.0	3.0	8.0	
t_{PZH}	Output Enable Time	2.0	7.7	10	2.0	12.5	2.0	11	ns
t_{PZL}		2.0	5.1	6.5	2.0	9.0	2.0	7.5	
t_{PHZ}	Output Disable Time	2.0	4.7	6.0	2.0	8.5	2.0	7.0	ns
t_{PLZ}		2.0	4.1	5.5	2.0	7.5	2.0	6.5	

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F T_A = +25°C V_{CC} = +5.0 V			54F T_A = -55 to +125°C V_{CC} = 5.0 V ±10%		74F T_A = 0 to +70°C V_{CC} = 5.0 V ±5%		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Setup Time, HIGH or LOW D_n to LE	2.0 2.0			2.0 2.0		2.0 2.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW D_n to LE	3.0 3.0			3.0 3.0		3.0 3.0		ns
t_w (H)	LE Pulse Width HIGH	6.0			6.0		6.0		ns

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MOTOROLA

MC54F534
MC74F534

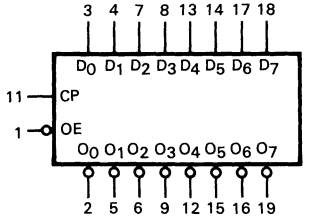
Advance Information

OCTAL D-TYPE FLIP-FLOP
(With 3-State Outputs)

DESCRIPTION — The MC54F/74F534 is a high-speed, low-power octal D-type flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus oriented applications. A buffered Clock (CP) and Output Enable ($\overline{OE}$) are common to all flip-flops. The 'F534 is the same as the 'F374 except that the outputs are inverted.

- **Edge-triggered D-Type Inputs**
- **Buffered Positive Edge-triggered Clock**
- **3-State Outputs for Bus Oriented Applications**

LOGIC SYMBOL

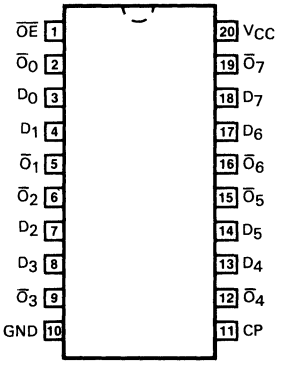


V_{CC} = Pin 20
GND = Pin 10

OCTAL D-TYPE FLIP-FLOP
(With 3-State Outputs)

FAST™ SCHOTTKY TTL

CONNECTION DIAGRAM



J Suffix — Case 732-03 (Ceramic)
N Suffix — Case 738-01 (Plastic)

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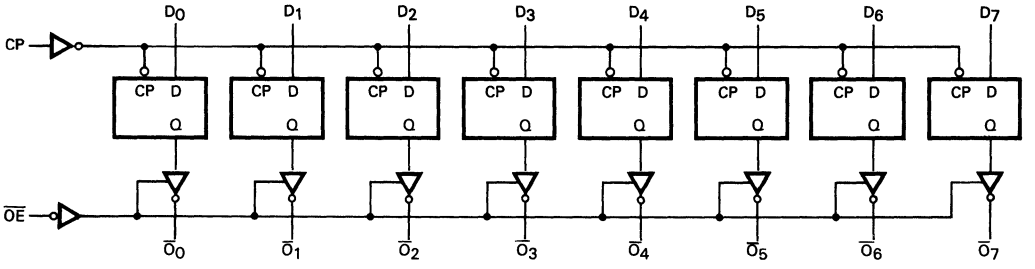
GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage*	54	4.50	5.0	5.50	V
		74	4.75	5.0	5.25	
T_A	Operating Ambient Temperature Range	54	-55	25	125	°C
		74	0	25	70	
I_{OH}	Output Current — High	54, 74			-3.0	mA
I_{OL}	Output Current — Low	54, 74			20	mA

*74F devices may be operated over the 4.5 to 5.5 V supply range where they will meet the specifications of 54F devices over the 0° to 70°C temperature range.

FAST is a trademark of Fairchild Camera and Instrument Corporation.
This document contains information on a new product. Specifications and information herein are subject to change without notice.

LOGIC DIAGRAM



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

FUNCTIONAL DESCRIPTION — The 'F534 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-state true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable ($\overline{OE}$) LOW, the contents of the eight flip-flops are available at the outputs. When the $\overline{OE}$ is HIGH, the outputs go to the high impedance state. Operation of the $\overline{OE}$ input does not affect the state of the flip-flops.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS	
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage	
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage	
V_{IK}	Input Clamp Diode Voltage				-1.2	V	I_{IN} = -18 mA	V_{CC} = MIN
V_{OH}	Output HIGH Voltage	54	2.5	3.4		V	I_{OH} = -1.0 mA	V_{CC} = MIN
		54	2.4	3.3		V	I_{OH} = -3.0 mA	
		74	2.7	3.3		V	I_{OH} = -3.0 mA	
V_{OL}	Output LOW Voltage			0.35	0.5	V	I_{OL} = 20 mA	V_{CC} = MIN
I_{OZH}	Output OFF Current — HIGH				50	μA	V_{OUT} = 2.4 V	V_{CC} = MAX
I_{OZL}	Output OFF Current — LOW				-50	μA	V_{OUT} = 0.5 V	V_{CC} = MAX
I_{IH}	Input HIGH Current				20	μA	V_{IN} = 2.7 V	V_{CC} = MAX
					100		V_{IN} = 7.0 V	
I_{IL}	Input LOW Current				-0.6	mA	V_{IN} = 0.5 V	V_{CC} = MAX
I_{OS}	Output Short Circuit Current (Note 2)		-60		-150	mA	V_{OUT} = 0 V	V_{CC} = MAX
I_{CCZ}	Power Supply Current (All Outputs OFF)			55	86	mA	D_n = Gnd, $\overline{OE}$ = 4.5 V	V_{CC} = MAX

NOTES:
1. For conditions such as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time, nor for more than 1 second.

AC CHARACTERISTICS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$, $V_{CC} = +5.0$ V, $C_L = 50$ pF			54F $T_A = -55$ to $+125°C$, $V_{CC} = 5.0$ V $\pm 10\%$, $C_L = 50$ pF		74F $T_A = 0$ to $+70°C$, $V_{CC} = 5.0$ V $\pm 5\%$, $C_L = 50$ pF		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	Maximum Clock Frequency	100			60		70		MHz
t_{PLH} t_{PHL}	Propagation Delay CP to $\overline{O}_n$	4.0 4.0	6.5 6.5	8.5 8.5	4.0 4.0	10.5 11	4.0 4.0	10 10	ns
t_{PZH} t_{PZL}	Output Enable Time	2.0 2.0	9.0 5.8	11.5 7.5	2.0 2.0	14 10	2.0 2.0	12.5 8.5	ns
t_{PHZ} t_{PLZ}	Output Disable Time	2.0 2.0	5.3 4.3	7.0 5.5	2.0 2.0	8.0 7.5	2.0 2.0	8.0 6.5	ns

AC OPERATING REQUIREMENTS

SYMBOL	PARAMETER	54/74F $T_A = +25°C$, $V_{CC} = +5.0$ V			54F $T_A = -55$ to $+125°C$, $V_{CC} = 5.0$ V $\pm 10\%$		74F $T_A = 0$ to $+70°C$, $V_{CC} = 5.0$ V $\pm 5\%$		UNITS
		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_s (H) t_s (L)	Setup Time, HIGH or LOW D_n to CP	2.0 2.0			2.5 2.0		2.0 2.0		ns
t_h (H) t_h (L)	Hold Time, HIGH or LOW D_n to CP	2.0 2.0			2.0 2.5		2.0 2.0		ns
t_w (H) t_w (L)	CP Pulse Width HIGH or LOW	7.0 6.0			7.0 6.0		7.0 6.0		ns

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MOTOROLA

MC74F2960
(Formerly SN74ALS790)

Product Preview

ERROR DETECTION AND CORRECTION CIRCUIT

DESCRIPTION — The MC74F2960 Error Detection and Correction Unit (EDAC) contains the logic necessary to generate check bits on a 16-bit data field according to a modified Hamming Code, and to correct the data word when check bits are supplied. Operating on data read from memory, the MC74F2960 will correct any single bit error* and will detect all double and some triple bit errors. For 16-bit words, 6 check bits are used. The MC74F2960 is expandable to operate on 32-bit words (7 check bits) and 64-bit words (8 check bits). In all configurations, the device makes the error syndrome available on separate outputs for data logging.

The MC74F2960 also features two diagnostic modes, in which diagnostic data can be forced into portions of the chip to simplify device testing and to execute system diagnostic functions. The product will be supplied in a 48-lead DIP package.

*Double bit errors can also be corrected if at least one of the two errors is a hard error. This requires extra processor cycles.

- PIN AND FUNCTIONALLY COMPATIBLE WITH THE Am2960
- BOOSTS MEMORY RELIABILITY
- EXPANDABLE TO 64-BIT DATA WORDS
- BUILT-IN DIAGNOSTICS PERMITS SOFTWARE SYSTEM CHECK
- SEPARATE BYTE CONTROLS FACILITATE BYTE OPERATIONS
- COMPATIBLE WITH MC68000 AND OTHER PROCESSORS

16-BIT TIMING (WORST CASE)

CHECK BIT GENERATION — 23 ns

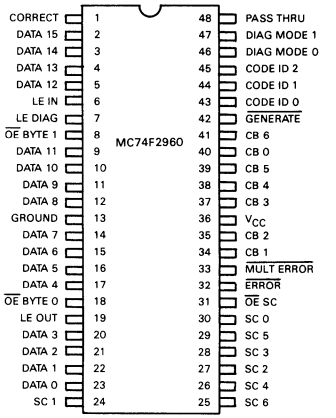
SINGLE ERROR DETECTION — 23 ns

SINGLE ERROR CORRECTION — 48 ns

ERROR DETECTION AND CORRECTION CIRCUIT

ADVANCED LOW POWER SCHOTTKY

CONNECTION DIAGRAM
Top View



J Suffix - Case 740-02 (Ceramic)

GUARANTEED OPERATING RANGES

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
V_{CC}	Supply Voltage	4.75	5.0	5.25	V
T_A	Operating Ambient Temperature Range	0	25	70	°C
I_{OH}	Output Current — High			-0.8	mA
I_{OL}	Output Current — Low			8.0	mA

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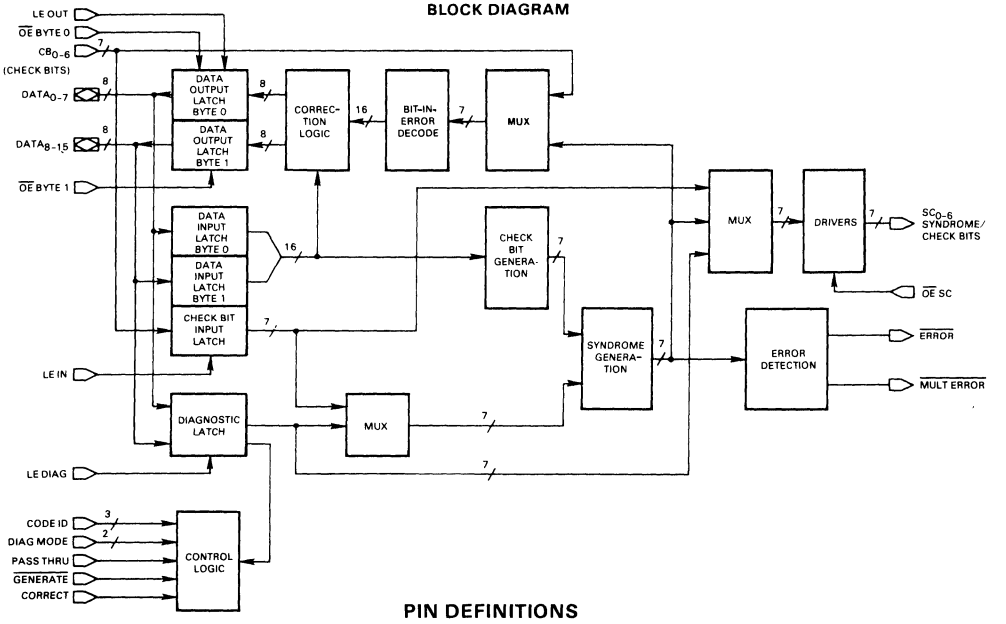
BLOCK DIAGRAM



PIN DEFINITIONS

$DATA_{0-15}$

16 bidirectional data lines. They provide input to the Data Input Latch and Diagnostic Latch, and receive output from the Data Output Latch, $DATA_0$ is the least significant bit; $DATA_{15}$ the most significant.

CB_{0-6}

Seven Check Bit input lines. The check bit lines are used to input check bits for error detection. They are also used to input syndrome bits for error correction in 32 and 64-bit configurations.

LE IN

Latch Enable — Data Input Latch. Controls latching of the input data. When HIGH the Data Input Latch and Check Bit Input Latch follow the input data and input check bits. When LOW, the Data Input Latch and Check Bit Input Latch are latched to their previous state.

$\overline{\text{GENERATE}}$

Generate Check Bits input. When this input is LOW the EDAC is in the Check Bit Generate Mode. When HIGH the EDAC is in the Detect Mode or Correct Mode.

In the Generate Mode the circuit generates the check bits or partial check bits specific to the data in the Data Input Latch. The generated check bits are placed on the SC outputs.

In the Detect or Correct Modes the EDAC detects single and multiple errors, and generates syndrome bits based upon the contents of the Data Input Latch and Check Bit Input Latch. In Correct Mode, single-bit errors are also automatically corrected — corrected data is placed at the inputs of the Data Output Latch. The syndrome result is placed on the SC outputs and indicates in a coded form the number of errors and the bit-in-error.

SC_{0-6}

Syndrome/Check Bit outputs. These seven lines hold the check/partial-check bits when the EDAC is in Generate Mode, and will hold the syndrome/partial syndrome bits when the device is in Detect or Correct Modes. These are 3-state outputs.

$\overline{\text{OE}}$ SC

Output Enable — Syndrome/Check Bits. When LOW, the 3-state output lines SC_{0-6} are enabled. When HIGH, the SC outputs are in the high impedance state.

$\overline{\text{ERROR}}$

Error Detected output. When the EDAC is in Detect or Correct Mode, this output will go LOW if one or more syndrome bits are asserted, meaning there are one or more bit errors in the data or check bits. If no syndrome bits are asserted, there are no errors detected and the output will be HIGH. In Generate Mode, $\overline{\text{ERROR}}$ is forced HIGH. (In a 64-bit configuration, $\overline{\text{ERROR}}$ must be externally implemented.)

$\overline{\text{MULT ERROR}}$

Multiple Errors Detected output. When the EDAC is in Detect or Correct Mode, this output if LOW indicates that there are two or more bit errors that have been detected. If HIGH this indicates that either one or no errors have been detected. In Generate mode, $\overline{\text{MULT ERROR}}$ is forced HIGH. (In a 64-bit configuration, $\overline{\text{MULT ERROR}}$ must be externally implemented.)

CORRECT

Correct input. When HIGH this signal allows the correction network to correct any single-bit error in the Data Input Latch (by complementing the bit-in-error) before putting it onto the Data Output Latch. When LOW the EDAC will drive data directly from the Data Input Latch to the Data Output Latch without correction.

PIN DEFINITIONS (continued)

LE OUT

Latch Enable — Data Output Latch. Controls the latching of the Data Output Latch. When LOW the Data Output Latch is latched to its previous state. When HIGH the Data Output Latch follows the output of the Data Input Latch as modified by the correction logic network. In Correct Mode, single-bit errors are corrected by the network before loading into the Data Output Latch. In Detect Mode, the contents of the Data Input Latch are passed through the correction network unchanged into the Data Output Latch. The inputs to the Data Output Latch are unspecified if the EDAC is in Generate Mode.

$\overline{OE}$ BYTE 0, $\overline{OE}$ BYTE 1

Output Enable — Bytes 0 and 1, Data Output Latch. These lines control the 3-state outputs for each of the two bytes of the Data Output Latch. When LOW these lines enable the Data Output Latch and when HIGH these lines force the Data Output Latch into the high impedance state. The two enable lines can be separately activated to enable only one byte of the Data Output Latch at a time.

PASS THRU

Pass Thru input. This line when HIGH forces the contents of the Check Bit Input Latch onto the Syndrome/Check Bit outputs (SC_{0-6}) and the unmodified contents of the Data Input Latch onto the inputs of the Data Output Latch.

DIAG $MODE_{0-1}$

Diagnostic Mode Select. These two lines control the initialization and diagnostic operation of the EDAC.

CODE ID_{0-2}

Code Identification inputs. These three bits identify the size of the total data word to be processed and which 16-bit slice of larger data words a particular EDAC is processing. The three allowable data word sizes are 16, 32 and 64-bits and their respective modified Hamming codes are designated 16/22, 32/39 and 64/72. Special CODE ID input 001 (ID_2, ID_1, ID_0) is also used to instruct the EDAC that the signals CODE ID_{0-2}, DIAG $MODE_{0-1}$, CORRECT and PASS THRU are to be taken from the Diagnostic Latch, rather than from the input control lines.

LE DIAG

Latch Enable — Diagnostic Latch. When HIGH the Diagnostic Latch follows the 16-bit data on the input lines. When LOW the outputs of the Diagnostic Latch are latched to their previous states. The Diagnostic Latch holds diagnostic check bits, and internal control signals for CODE ID_{0-2}, DIAG $MODE_{0-1}$, CORRECT and PASS THRU.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

SYMBOL	PARAMETER		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNITS	TEST CONDITIONS
V_{IH}	Input HIGH Voltage		2.0			V	Guaranteed Input HIGH Voltage
V_{IL}	Input LOW Voltage				0.8	V	Guaranteed Input LOW Voltage
V_{IK}	Input Clamp Diode Voltage				-1.5	V	V_{CC} = MIN, I_{IN} = -18 mA
V_{OH}	Output HIGH Voltage		2.7			V	V_{CC} = MIN, I_{OH} = -0.8 mA
V_{OL}	Output LOW Voltage				0.5	V	V_{CC} = MIN, I_{OL} = 8.0 mA
I_{OZH}	Output Off Current-HIGH	$DATA_{0-15}$			70	µA	V_{CC} = MAX, V_{OUT} = 2.4 V
		SC_{0-6}			50	µA	
I_{OZL}	Output Off Current-LOW	$DATA_{0-15}$			-410	µA	V_{CC} = MAX, V_{OUT} = 0.5 V
		SC_{0-6}			-50	µA	
I_{IH}	Input High Current	$DATA_{0-15}$			70	µA	V_{CC} = MAX, V_{IN} = 2.7 V
		OTHERS			50	µA	
		ALL			1.0	mA	V_{CC} = MAX, V_{IN} = 5.5 V
I_{IL}	Input Low Current	$DATA_{0-15}$			-410	µA	V_{CC} = MAX, V_{IN} = 0.5 V
		OTHERS			-360	µA	
I_{OS}	Short Circuit Current (1)		-25		-85	mA	V_{CC} = MAX, V_O = 0.0 V
I_{CC}	Power Supply Current				400	mA	V_{CC} = MAX

(1) Not more than one output should be shorted at a time.

FUNCTIONAL DESCRIPTION

The MC74F2960 contains the necessary logic to generate check bits on a 16-bit data field according to a modified Hamming code. This code allows the EDAC to 1) be cascaded, 2) detect all double bit errors, 3) detect RAM failure (all 1 or 0 data).

The EDAC may be configured to work on data words from 8- to 64-bits in length. When cascaded for word lengths in excess of 16 bits, each EDAC must know which bits it is processing. This is done with Code ID inputs as shown in Table I. The Internal Control Mode is described later.

MODE SELECTION

The device control lines are $\overline{\text{GENERATE}}$, CORRECT, PASS THRU, DIAG MODE_{0-1} and CODE ID_{0-2}. Table II lists the MC74F2960 modes of operation.

PASS THRU MODE

In this mode, the unmodified contents of the Data Input Latch are placed on the inputs of the Data Output Latch and the contents of the Check Bit Input Latch are placed on the SC outputs. $\overline{\text{ERROR}}$ and $\overline{\text{MULT ERROR}}$ are forced HIGH in this mode.

GENERATE MODE

In this mode check bits will be generated that correspond to the contents of the Data Input Latch. The check bits generated are placed on the SC outputs.

DETECT MODE

In this mode the device examines the contents of the Data Input Latch against the Check Bit Input Latch, and will detect all single-bit errors, all double-bit errors and some triple-bit errors. If one or more errors are detected, $\overline{\text{ERROR}}$ goes LOW. If two or more errors are detected, $\overline{\text{MULT ERROR}}$ goes LOW. Both error indicators are HIGH if there are no errors.

Also available on the SC outputs are the syndrome bits generated by the error detection step. The syndrome bits may be decoded to determine if a bit error was detected and, for single-bit errors, which of the data or check bits is in error.

In Detect Mode, the contents of the Data Input Latch are driven directly to the inputs of the Data Output Latch without correction.

CORRECT MODE

In this mode, the EDAC functions the same as in Detect Mode except that the correction network is allowed to correct (complement) any single-bit error of the Data Input Latch before putting it onto the inputs of the Data Output Latch. If multiple errors are detected, the output of the correction network is unspecified.

DIAGNOSTIC GENERATE
DIAGNOSTIC DETECT
DIAGNOSTIC CORRECT

These are special diagnostic modes where check bits loaded into the Diagnostic Latch are substituted for either normal check bit inputs or outputs.

INITIALIZE

The inputs of the Data Output Latch are forced to zeroes. The check bit outputs (SC) are generated to correspond to the all-zero data. $\overline{\text{ERROR}}$ and $\overline{\text{MULT ERROR}}$ are forced HIGH in the initialize Mode.

Initialize Mode is useful after power up when RAM contents are random. The EDAC may be placed in initialize mode and its' outputs written into all memory locations by the processor.

INTERNAL CONTROL MODE

When in the internal control mode, the EDAC takes the CODE ID_{0-2}, DIAG MODE_{0-1}, CORRECT and PASS THRU control signals from the Internal Diagnostic Latch rather than from the external input lines.

TABLE I. HAMMING CODE AND SLICE IDENTIFICATION

CODE ID_2	CODE ID_1	CODE ID_0	Hamming Code and Slice Selected
0	0	0	Code 16/22
0	0	1	Internal Control Mode
0	1	0	Code 32/39, Bytes 0 and 1
0	1	1	Code 32/39, Bytes 2 and 3
1	0	0	Code 64/72, Bytes 0 and 1
1	0	1	Code 64/72, Bytes 2 and 3
1	1	0	Code 64/72, Bytes 4 and 5
1	1	1	Code 64/72, Bytes 6 and 7

TABLE II. INTERNAL CONTROL MODE

	CONTROL INPUTS				
OPERATING MODE	DIAG MODE 1	DIAG MODE 0	PASS THRU	$\overline{\text{GENERATE}}$	CORRECT
PASS THRU	X	X	1	X	X
GENERATE	X	0	0	0	X
DETECT	0	X	0	1	0
CORRECT	0	X	0	1	1
DIAGNOSTIC GENERATE	0	1	0	0	X
DIAGNOSTIC DETECT	1	0	0	1	0
DIAGNOSTIC CORRECT	1	0	0	1	1
INITIALIZE	1	1	0	X	X

6

MC74F2968
MC74F2969
MC74F2970

Product Preview

A NEW GENERATION OF MEMORY SUPPORT PRODUCTS

Motorola and Advanced Micro Devices have agreed to cooperate on the development of the next generation of the F2960 Family of Memory Support products. These devices are designed to maximize the speed and minimize the cost of memory systems based on the new generation of high performance 64K and 256K MOS Dynamic RAMs (DRAMs).

The products included in this joint development and alternate sourcing agreement are a Dynamic Memory Controller (DMC), the F2968, and two Memory Timing Controllers (MTC), the F2969 and F2970. These functions are partitioned such that address generation and refresh are provided by the F2968. Memory timing and control is achieved with either the F2969 or F2970. This partitioning allows greater design flexibility and higher system performance than would be possible by combining the DMC and MTC functions on a single chip. All three devices will be fabricated using the high performance, oxide-isolated bipolar technologies with TTL compatible I/O levels.

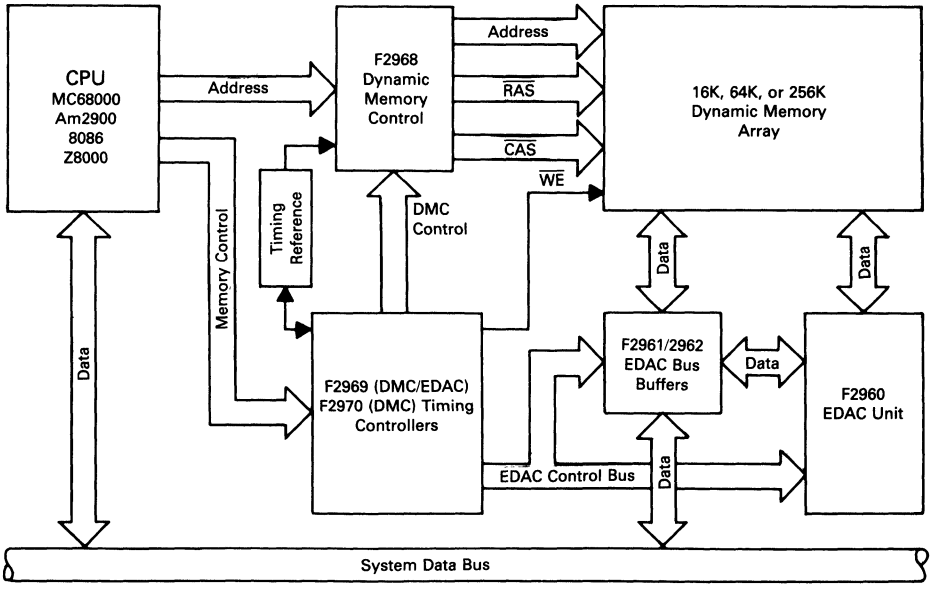
The Dynamic Memory Controller, F2968, will provide complete address multiplexing, refreshing, and output drive for up to 88 Dynamic Random Access Memories (DRAMs). The F2968 will be packaged in a 48-pin DIP and will interface with 16K, 64K, or 256K DRAMs.

The memory timing controller will be available in two versions. The F2969, a 48-pin version, will provide all control signals for both the F2968 Memory Controller and the F2960 Error Detection and Correction circuit (EDAC). The F2969 Timing Controller will support error logging and also handle memory initialization, refresh timing, and memory cycle arbitration. The general purpose microprocessor interface on the F2969 will facilitate its use with most microprocessors with minimal external logic. The MC68000 AMD/Intel iAPX86, and AMD 2900 bit-slice and 29116 devices are notable examples. System timing for all memory functions is derived from an external delay line to provide maximum performance and flexibility.

For systems not utilizing the F2960 Error Detection and Correction circuit (EDAC), a second version of the timing controller, the F2970, will be available without (EDAC) interface/functions. The F2970 will save on IC cost and board space as it will be packaged in 24-pin, 300-mil wide DIP.

Sample quantities on the F2968, F2969, and the F2970 are expected in the fourth quarter 1983, with production commencing early in 1984. F2960 samples are expected in the third quarter of 1983.

HIGH PERFORMANCE COMPUTER MEMORY



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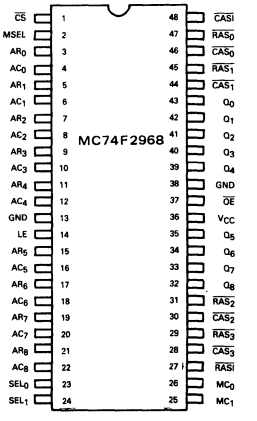
DYNAMIC MEMORY CONTROLLER

The MC74F2968 Dynamic Memory Controller is intended to be used with today's high performance memory systems. It has two 9-bit address latches which allow the chip to be used with 16K, 64K, or 256K dynamic RAMs. A two-bit bank select latch for the two high order address bits is provided to select one each of the four $\overline{RAS}$ and $\overline{CAS}$ outputs.

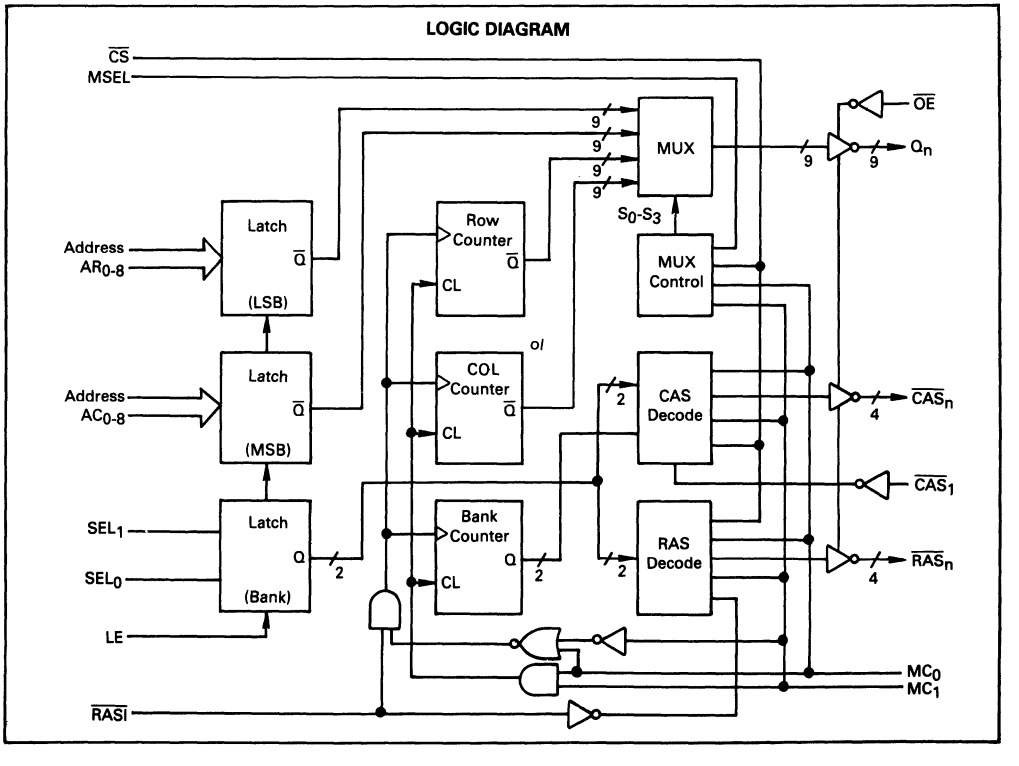
In the refresh mode, two counters cycle through the refresh address. Only the ROW counter is used for refresh without scrubbing, generating up to 512 addresses to refresh a 512-cycle-refresh DRAM. The column counter is used only for refresh with scrubbing. In this mode all $\overline{RAS}$ outputs are generated with only one $\overline{CAS}$ output.

- **Provides Control for 16K, 64K, or 256K Dynamic RAM Systems**
- **Outputs Directly Drive Up to 88 DRAMs**
- **Highest Order Two Address Bits Select One of Four Banks of RAMs**
- **Separate $\overline{RAS}$ and $\overline{CAS}$ Lines for Each Bank of DRAM**
- **Supports Memory Scrubbing During Refresh**
- **Supports Nibble Mode Access**
- **Separate Output Enable for Multi-Channel Access-to-Memory**
- **Chip Select for Easy Expansion**
- **48-Pin Dual In-Line Package**

PIN ASSIGNMENT



LOGIC DIAGRAM



DYNAMIC MEMORY TIMING CONTROLLERS

The MC74F2969/2970 Dynamic Memory Timing Controllers are intended to be used with today's high performance memory systems. They have been designed to offer the system designer maximum flexibility and performance. Timing for both circuits is derived from an external delay line.

The F2969 is designed to control the timing for systems incorporating the MC74F2960 Error Detection And Correction circuit, the MC74F2961/62 EDAC Bus Buffers, and the MC74F2968 Dynamic Memory Controller.

For memory systems not utilizing the F2960 EDAC unit, the F2970 will provide all control signals for the F2968 while reducing IC cost and circuit board area. The F2970 supports functions which are a subset of the F2969. By choosing not to utilize EDAC support functions, the F2970 can be packaged in a 24-pin DIP.

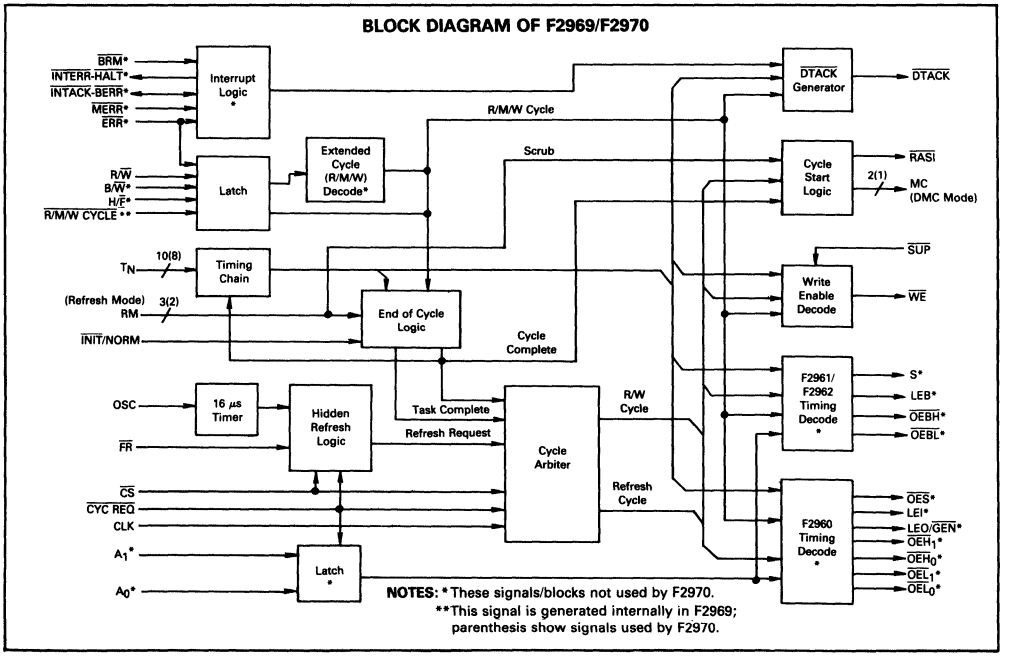
MC74F2969

- **Provides Complete Timing Control for 16K, 64K, or 256K Dynamic RAM Systems Which Utilize F2960, F2961/2962, and F2968**
- **$\overline{WE}$ Output Directly Drives Up to 88 DRAMs**
- **Delay-Line Controlled Timing for Maximum Performance**
- **Synchronous or Asynchronous Arbitration of Memory Cycles**
- **Supports Memory Scrubbing During Refresh**
- **Internal or External Control of Refresh**
- **Burst or Distributed Refresh Modes**
- **128-, 256-, or 512-Cycle Burst Refresh**
- **Performs Hidden Refresh When Processor Accesses Other Devices (Distributed Mode)**
- **Supports Byte-Writes for Memory Up to 32-Bits Wide**
- **Supports the Bus Retry Feature of the MC68010**
- **Initializes Memory**
- **48-Pin Dual In-Line Package**

MC74F2970

- **Provides Complete Timing Control for 16K, 64K, or 256K Dynamic RAM Systems Which Utilize the F2968**
- **$\overline{WE}$ Output Directly Drives Up to 88 DRAMs**
- **Delay-Line Controlled Timing for Maximum Performance**
- **Synchronous or Asynchronous Arbitration of Memory Cycles**
- **Internal or External Control of Refresh**
- **Burst or Distributed Refresh Modes**
- **128-, 256-, or 512-Cycle Burst Refresh**
- **Performs Hidden Refresh When Processor Accesses Other Devices (Distributed Mode)**
- **24-Pin, 300 Mil Wide Dual In-Line Package**

BLOCK DIAGRAM OF F2969/F2970



NOTES: * These signals/blocks not used by F2970.
** This signal is generated internally in F2969; parenthesis show signals used by F2970.

SCHOTTKY TTL

RAM/PROM Data Sheets

7

MCM7621
MCM7621A

TTL

2048-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM7621,A — 512 × 4 THREE-STATE

2048-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM7621 and MCM7621A, together with various other 76xx series TTL PROMS, have common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable ROMs and are available with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

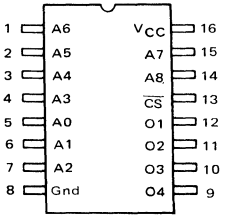
All pinouts are compatible to industry-standard PROMs and ROMs.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2.0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Over Commercial Temperature and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM7621DC/ADC
MCM7621PC/APC



ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7.0	Vdc
Input Voltage	V_{in}	+5.5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM7621xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

NOTE.
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability (While programming, follow the programming specifications.)

7

GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS

				Three-State Output			
Symbol	Parameter		Test Conditions	Min	Typ	Max	Unit
I_{IH}	Address/Enable	"1"	V_{IH} = V_{CC} Max	—	—	40	μAdc
I_{IL}	Input Current	"0"	V_{IL} = 0.45 V	—	-0.1	-0.25	mAdc
V_{OH}	Output Voltage	"1"	I_{OH} = -2.0 mA, V_{CC} Min	2.4	3.4	—	Vdc
V_{OL}		"0"	I_{OL} = +16 mA, V_{CC} Min	—	0.35	0.45	Vdc
I_{OHE}	Output Disabled	"1"	V_{OH} = +5.25 V, V_{CC} Max	—	—	40	μAdc
I_{OLE}	Current	"0"	V_{OL} = +0 3 V, V_{CC} Max	—	—	-40	μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1 2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0 0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	60	100	mAdc

CAPACITANCE (f = 1 0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

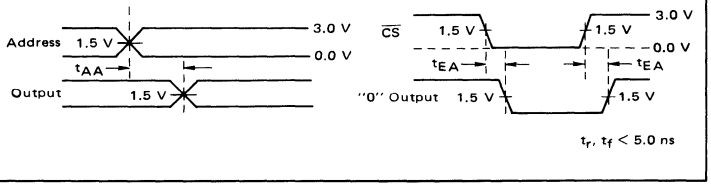
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

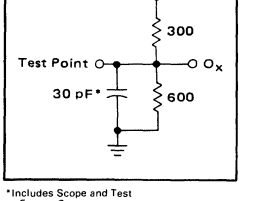
		MCM7621		MCM7621A		
		0 to +75°C		0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	45	70	45	60	ns
Chip Enable Access Time	t_{EA}	15	25	15	25	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

7

PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

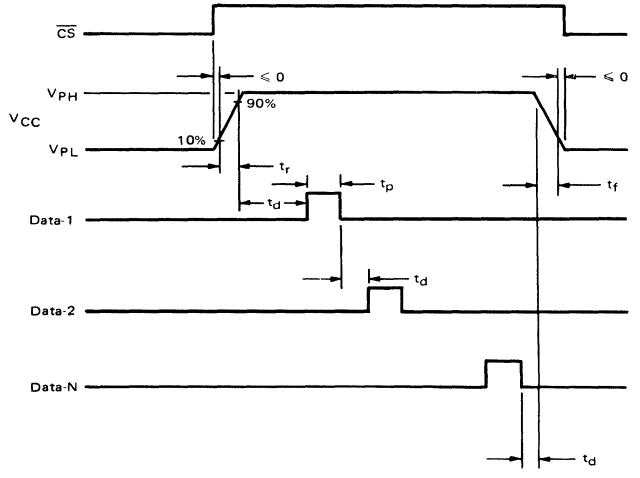
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5 0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	10.0 4.5	10.5 5.0	11.0 5.5	V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}
(2) Disable condition will be met with output open circuit

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



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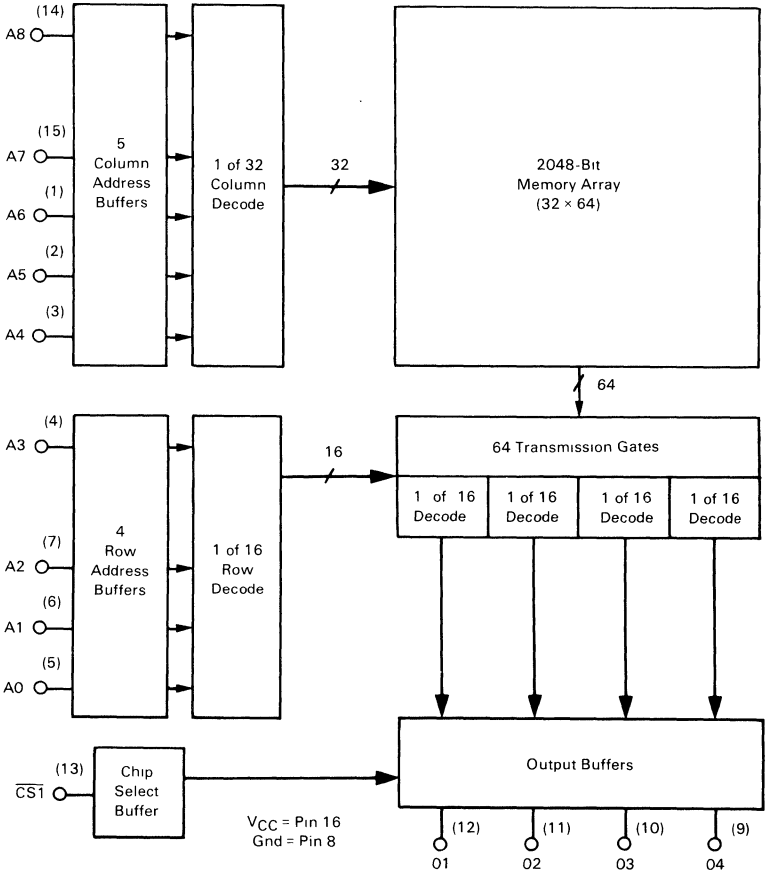
MCM7621/21A BLOCK DIAGRAM



7

MCM7641
MCM7641A

TTL

4096-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM7641,A — 512 × 8 THREE-STATE

4096-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM7641 and MCM7641A, together with various other 76xx series TTL PROMS, comprise a complete and compatible family having common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable ROMs and are available in commonly used organizations, with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

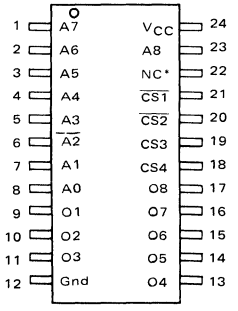
All pinouts are compatible to industry-standard PROMs and ROMs.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2.0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Over Commercial Temperature and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM7641DC/ADC
MCM7641PC/APC



*No Connection

ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7.0	Vdc
Input Voltage	V_{in}	+5.5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM7641xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

NOTE
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability. (While programming, follow the programming specifications.)

7

GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS — Three-State Output

Symbol	Parameter		Test Conditions	Min	Typ	Max	Unit
I_{IH}	Address/Enable	"1"	$V_{IH} = V_{CC}$ Max	—	—	40	μAdc
I_{IL}	Input Current	"0"	V_{IL} = 0.45 V	—	-0.1	-0.25	mAdc
V_{OH}	Output Voltage	"1"	I_{OH} = -2.0 mA, V_{CC} Min	2.4	3.4	—	Vdc
V_{OL}		"0"	I_{OL} = +16 mA, V_{CC} Min	—	0.35	0.45	Vdc
I_{OHE}	Output Disabled	"1"	V_{OH} = +5.25 V, V_{CC} Max	—	—	40	μAdc
I_{OLE}	Current	"0"	V_{OL} = +0.3 V, V_{CC} Max	—	—	-40	μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1.2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0.0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	60	140	mAdc

CAPACITANCE (f = 1.0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

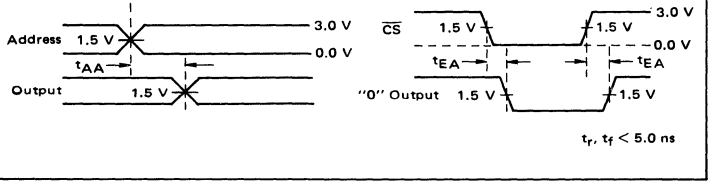
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

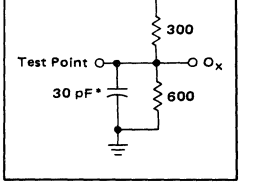
		MCM7641		MCM7641A		
		0 to +75°C		0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	45	70	45	60	ns
Chip Enable Access Time	t_{EA}	30	40	30	40	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

7

PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

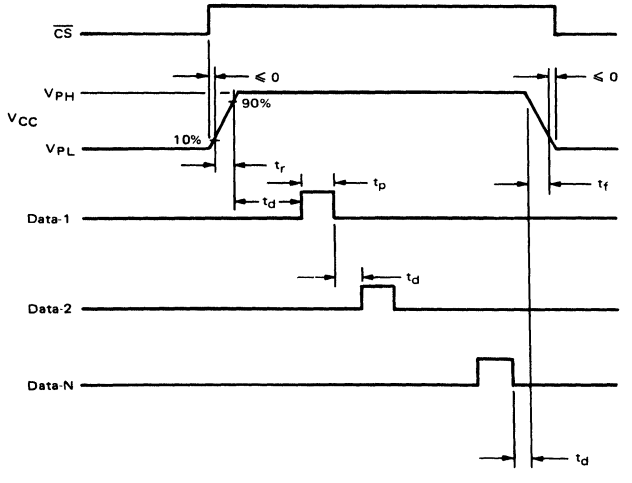
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

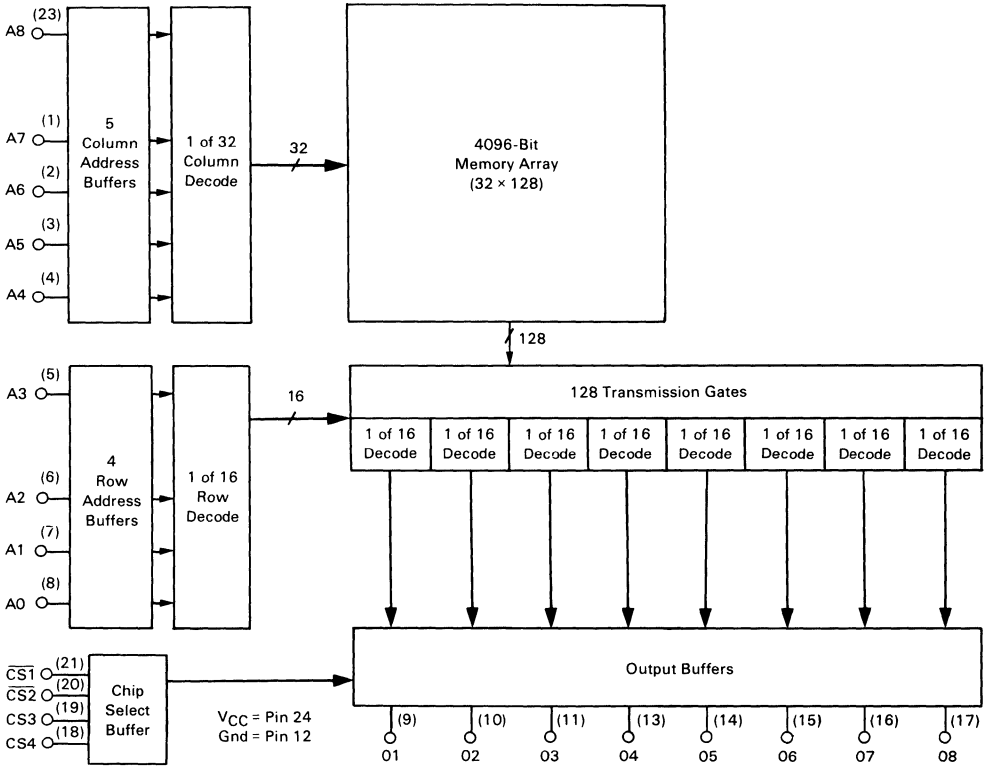
Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5.0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
 V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	 10.0 4.5	 10.5 5.0	 11.0 5.5	 V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}.
(2) Disable condition will be met with output open circuit.

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



MCM7641/41A BLOCK DIAGRAM



7

MOTOROLA

MCM7643
MCM7643A

TTL

4096-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM7643,A — 1024 × 4 THREE-STATE

4096-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM7643 and MCM7643A, together with various other 76xx series TTL PROMS, comprise a complete and compatible family having common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable ROMs and are available in commonly used organizations, with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

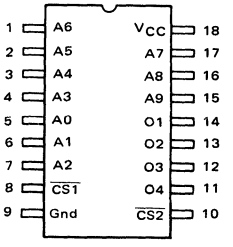
All pinouts are compatible to industry-standard PROMs and ROMs.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2.0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Over Commercial Temperature and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM7643DC/ADC
MCM7643PC/APC



ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7.0	Vdc
Input Voltage	V_{in}	+5.5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM7643xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

NOTE:
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability. (While programming, follow the programming specifications.)

7

GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS

Symbol	Parameter		Test Conditions	Three-State Output Min	Three-State Output Typ	Three-State Output Max	Unit
I_{IH}	Address/Enable	"1"	V_{IH} = V_{CC} Max	—	—	40	μAdc
I_{IL}	Input Current	"0"	V_{IL} = 0.45 V	—	-0.1	-0.25	mAdc
V_{OH}	Output Voltage	"1"	I_{OH} = -2.0 mA, V_{CC} Min	2.4	3.4	—	Vdc
V_{OL}		"0"	I_{OL} = +16 mA, V_{CC} Min	—	0.35	0.45	Vdc
I_{OHE}	Output Disabled	"1"	V_{OH} = +5.25 V, V_{CC} Max	—	—	40	μAdc
I_{OLE}	Current	"0"	V_{OL} = +0.3 V, V_{CC} Max	—	—	-40	μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1.2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0.0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	100	140	mAdc

CAPACITANCE (f = 1.0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

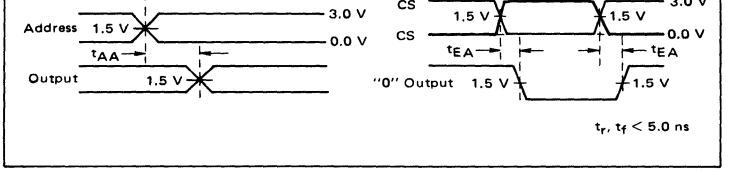
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

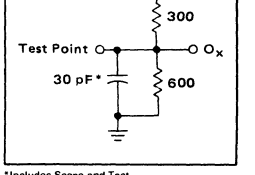
		MCM7643		MCM7643A		
		0 to +75°C		0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	50	70	40	50	ns
Chip Enable Access Time	t_{EA}	25	30	25	30	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

7

PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

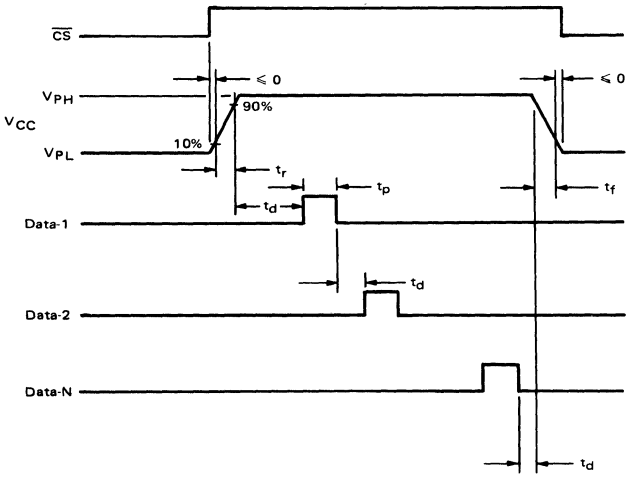
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5.0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	10.0 4.5	10.5 5.0	11.0 5.5	V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}.
(2) Disable condition will be met with output open circuit.

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



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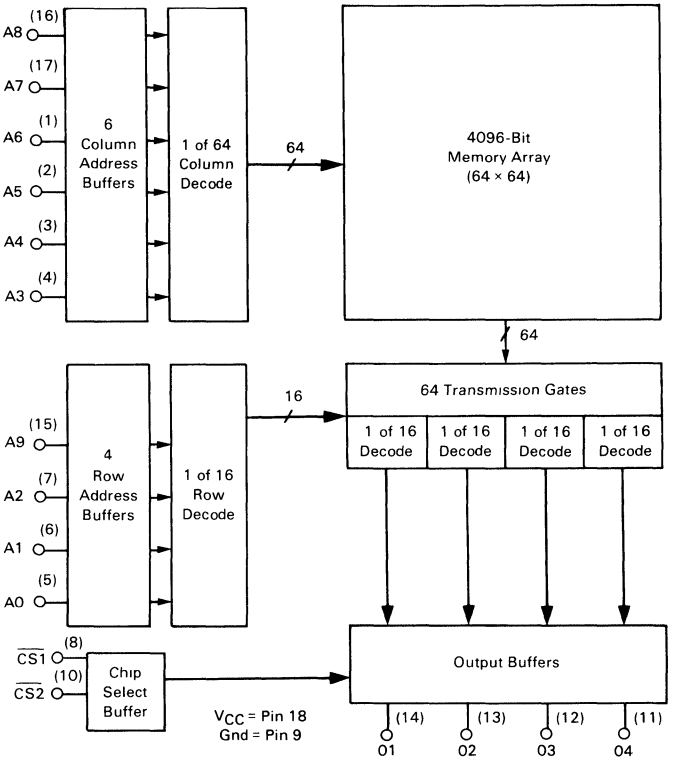
MCM7643/43A BLOCK DIAGRAM



7

MOTOROLA

MCM7681
MCM7681A

TTL

8192-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM7681,A — 1024 × 8 THREE-STATE

8192-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM7681 and MCM7681A, together with various other 76xx series TTL PROMS, comprise a complete and compatible family having common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable ROMs and are available in commonly used organizations, with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

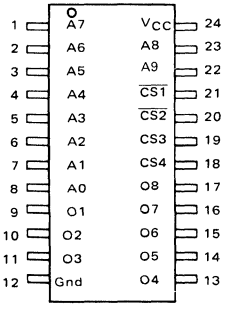
Pinouts are compatible to industry-standard PROMs and ROMs. In addition, the MCM7681 is a pin compatible replacement for the 512 × 8 with Pin 22 connected as A9 on the 1024 × 8.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2.0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Over Commercial Temperature Ranges and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM7681DC/ADC
MCM7681PC/APC



ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7.0	Vdc
Input Voltage	V_{in}	+5.5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM7681xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

NOTE
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability. (While programming, follow the programming specifications.)

7

GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS

				Three-State Output			
Symbol	Parameter		Test Conditions	Min	Typ	Max	Unit
I_{IH}	Address/Enable	"1"	V_{IH} = V_{CC} Max	—	—	40	μAdc
I_{IL}	Input Current	"0"	V_{IL} = 0.45 V	—	-0.1	-0.25	mAdc
V_{OH}	Output Voltage	"1"	I_{OH} = -2.0 mA, V_{CC} Min	2.4	3.4	—	Vdc
V_{OL}		"0"	I_{OL} = +16 mA, V_{CC} Min	—	0.35	0.45	Vdc
I_{OHE}	Output Disabled	"1"	V_{OH} = +5.25 V, V_{CC} Max	—	—	40	μAdc
I_{OLE}	Current	"0"	V_{OL} = +0.3 V, V_{CC} Max	—	—	-40	μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1.2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0.0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	110	150	mAdc

CAPACITANCE (f = 1.0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

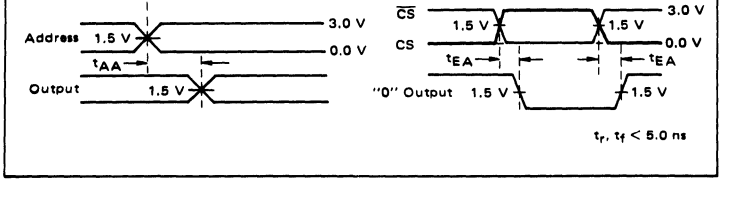
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

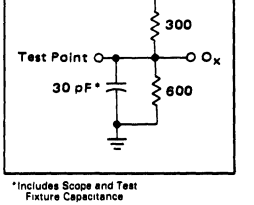
		MCM7681		MCM7681A		
		0 to +75°C		0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	—	70	—	50	ns
Chip Enable Access Time	t_{EA}	30	40	30	40	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

7

PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

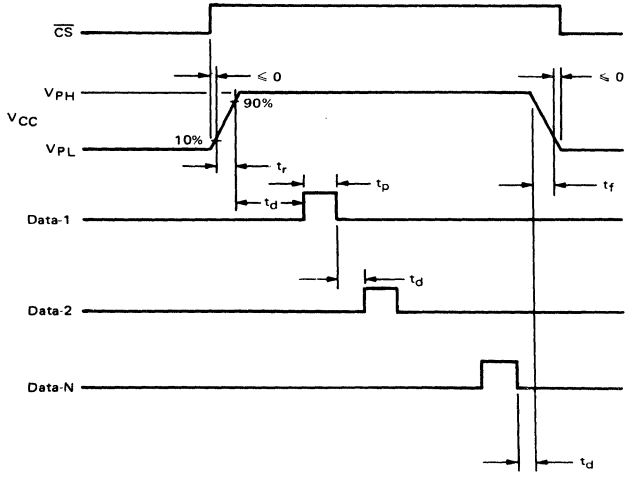
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5.0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	10.0 4.5	10.5 5.0	11.0 5.5	V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}.
(2) Disable condition will be met with output open circuit.

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



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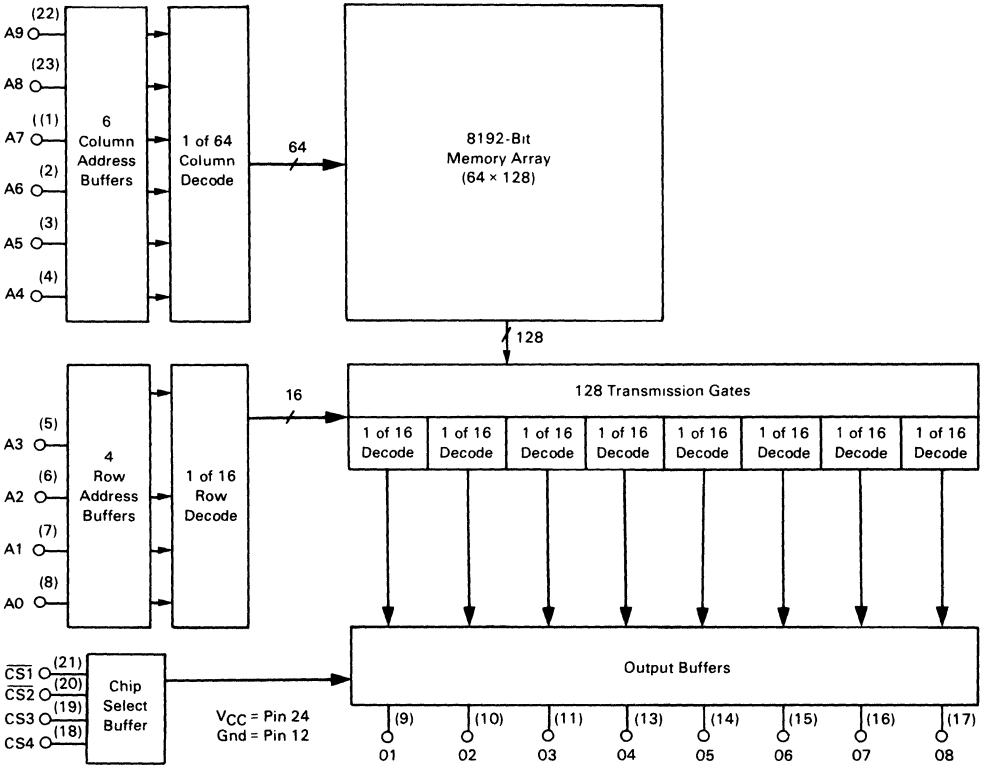
MCM7681/81A BLOCK DIAGRAM



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MOTOROLA

MCM7685
MCM7685A

TTL

8192-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM7685,A — 2048 × 4 THREE-STATE

8192-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM7685 and MCM7685A, together with various other 76xx series TTL PROMS, comprise a complete and compatible family having common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable PROMs and are available in commonly used organizations, with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

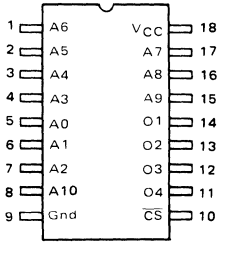
Pinouts are compatible to industry-standard PROMs and ROMs. The MCM7685 is a pin compatible replacement for the 1024 × 4 organization with Pin 8 connected as A10 on the 2048 × 4.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2.0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Commercial Temperature Ranges and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM7685DC/ADC
MCM7685PC/APC



ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7.0	Vdc
Input Voltage	V_{in}	+5.5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM7685xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

NOTE.
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS Exposure to higher than recommended voltages for extended periods of time could affect device reliability (While programming, follow the programming specifications.)

7

GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS

Symbol	Parameter		Test Conditions	Three-State Output Min	Typ	Max	Unit
I_{IH}	Address/Enable	"1"	V_{IH} = V_{CC} Max	—	—	40	μAdc
I_{IL}	Input Current	"0"	V_{IL} = 0.45 V	—	-0.1	-0.25	mAdc
V_{OH}	Output Voltage	"1"	I_{OH} = -2.0 mA, V_{CC} Min	2.4	3.4	—	Vdc
V_{OL}		"0"	I_{OL} = +16 mA, V_{CC} Min	—	0.35	0.45	Vdc
I_{OHE}	Output Disabled	"1"	V_{OH} = +5.25 V, V_{CC} Max	—	—	40	μAdc
I_{OLE}	Current	"0"	V_{OL} = +0.3 V, V_{CC} Max	—	—	-40	μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1.2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0.0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	80	150	mAdc

CAPACITANCE (f = 1.0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

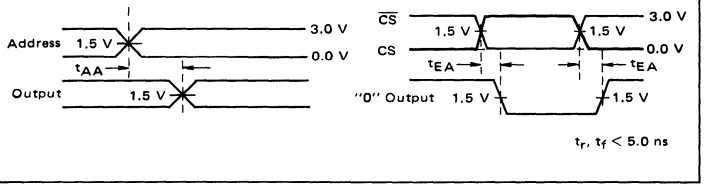
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

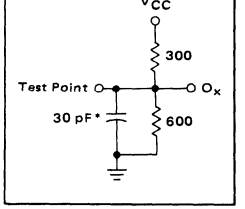
		MCM7685 0 to +75°C		MCM7685A 0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	45	70	40	55	ns
Chip Enable Access Time	t_{EA}	30	40	30	40	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

7

PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

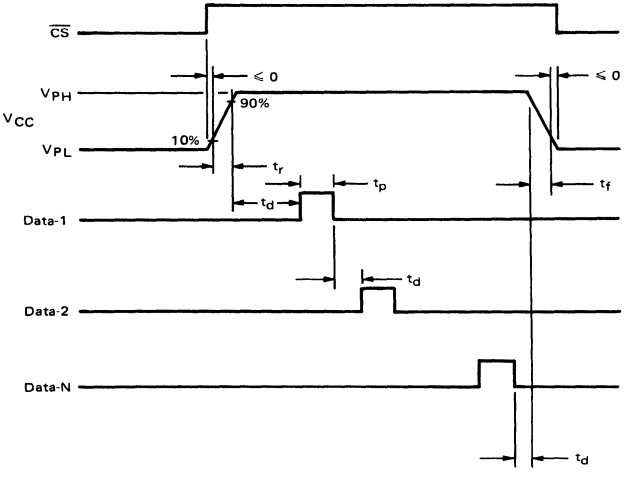
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

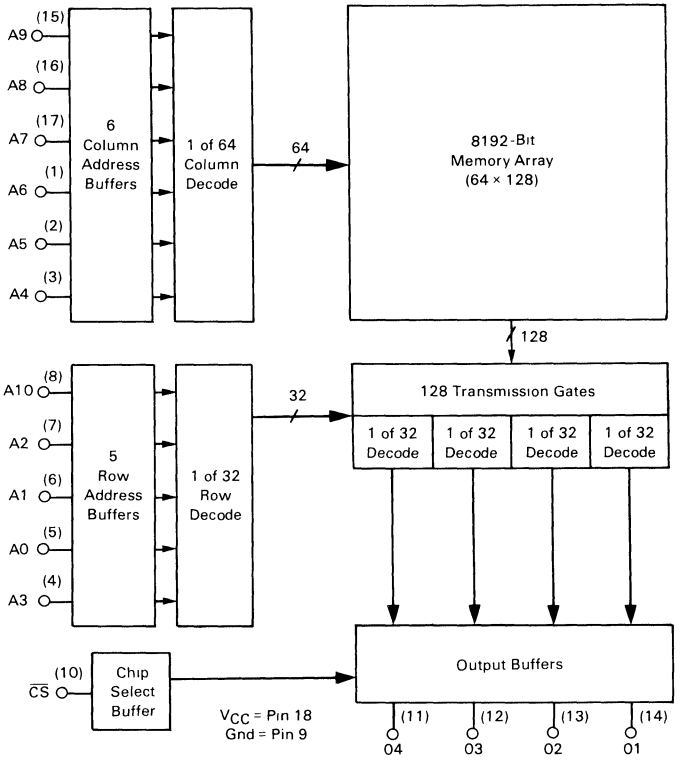
Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5.0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	10.0 4.5	10.5 5.0	11.0 5.5	V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}.
(2) Disable condition will be met with output open circuit.

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



MCM7685/85A BLOCK DIAGRAM



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MOTOROLA

MCM76161
MCM76161A

TTL

16384-BIT PROGRAMMABLE READ ONLY MEMORIES

MCM76161,A — 2048 × 8 THREE-STATE

16384-BIT PROGRAMMABLE READ ONLY MEMORY

The MCM76161 and MC76161A, together with various other 76xx series TTL PROMS, comprise a complete and compatible family having common dc electrical characteristics and identical programming requirements. They are fully decoded, high-speed, field-programmable ROMs and are available in commonly used organizations, with three-state outputs. All bits are manufactured storing a logical "1" (outputs high), and can be selectively programmed for logical "0" (outputs low).

The field-programmable PROM can be custom-programmed to any pattern using a simple programming procedure. Schottky bipolar circuitry provides fast access time.

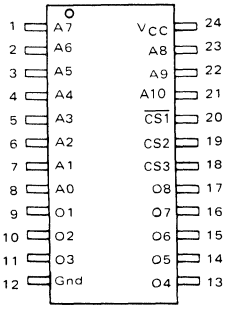
Pinouts are compatible to industry-standard PROMs and ROMs. The MCM76161 is a pin compatible replacement for the 1024 × 8 with Pin 21 connected as A10 on the 2048 × 8.

In addition to the conventional storage array, extra test rows and columns are included to assure high programmability, and guarantee parametric and ac performance. Fuses in these test rows and columns are blown prior to shipment.

- Common dc Electrical Characteristics and Programming Procedure
- Simple, High-Speed Programming Procedure (1.0 Second per 1024 Bits, Typical)
- Expandable — Three-State Outputs and Chip Enable Inputs
- Inputs and Outputs TTL-Compatible
  Low Input Current — 250 μA Logic "0", 40 μA Logic "1"
  Full Output Drive — 16 mA Sink, 2 0 mA Source
- Fast Access Time — Guaranteed for Worst-Case N^2 Sequencing, Over Commercial Temperature and Voltage Ranges
- Pin-Compatible with Industry-Standard PROMs and ROMs

PIN ASSIGNMENT

MCM76161DC/ADC
MCM76161PC/APC



ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Operating Supply Voltage	V_{CC}	+7 0	Vdc
Input Voltage	V_{in}	+5 5	Vdc
Operating Output Voltage	V_{OH}	+7.0	Vdc
Supply Current	I_{CC}	650	mAdc
Input Current	I_{in}	-20	mAdc
Output Sink Current	I_o	100	mAdc
Operating Temperature Range MCM76161xxx	T_A	0 to +75	°C
Storage Temperature Range	T_{stg}	-55 to +150	°C
Maximum Junction Temperature	T_J	+175	°C

Note

Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS Exposure to higher than recommended voltages for extended periods of time could affect device reliability (While programming, follow the programming specifications)

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GUARANTEED OPERATING RANGE (T_A = 0°C to +75°C)

Parameter	Symbol	Min	Nom	Max	Unit
Supply Voltage	V_{CC}	4.75	5.0	5.25	Vdc
Input High Voltage	V_{IH}	2.0	—	—	Vdc
Input Low Voltage	V_{IL}	—	—	0.8	Vdc

DC OPERATING CONDITIONS AND CHARACTERISTICS

Symbol	Parameter		Test Conditions	Three-State Output Min	Three-State Output Typ	Three-State Output Max	Unit
I_{IH} I_{IL}	Address/Enable Input Current	"1" "0"	$V_{IH} = V_{CC}$ Max V_{IL} = 0.45 V	— —	— -0.1	40 -0.25	μAdc mAdc
V_{OH} V_{OL}	Output Voltage	"1" "0"	I_{OH} = -2.0 mA, V_{CC} Min I_{OL} = +16 mA, V_{CC} Min	2.4 —	3.4 0.35	— 0.45	Vdc Vdc
I_{OHE} I_{OLE}	Output Disabled Current	"1" "0"	V_{OH} = +5.25 V, V_{CC} Max V_{OL} = +0.3 V, V_{CC} Max	— —	— —	40 -40	μAdc μAdc
V_{IK}	Input Clamp Voltage		I_{in} = -18 mA	—	—	-1.2	Vdc
I_{OS}	Output Short Circuit Current		V_{CC} Max, V_{out} = 0.0 V One Output Only for 1.0 s Max	-15	—	-70	mAdc
I_{CC}	Power Supply Current		V_{CC} Max All Inputs Grounded	—	130	180	mAdc

CAPACITANCE (f = 1.0 MHz, T_A = 25°C, periodically sampled rather than 100% tested.)

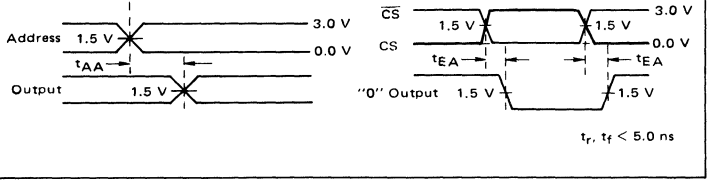
Characteristic	Symbol	Typ	Unit
Input Capacitance	C_{in}	8.0	pF
Output Capacitance	C_{out}	10	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS (Full operating voltage and temperature)

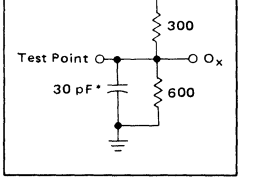
		MCM76161		MCM76161A		
		0 to +75°C		0 to +75°C		
Characteristic	Symbol	Typ	Max	Typ	Max	Unit
Address to Output Access Time	t_{AA}	45	70	35	60	ns
Chip Enable Access Time	t_{EA}	30	40	30	40	ns

NOTE: AC limits guaranteed for worst case N^2 sequential with maximum test frequency of 5.0 MHz.

TIMING DIAGRAM



AC TEST LOAD



*Includes Scope and Test Fixture Capacitance

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PROGRAMMING

The PROMs are manufactured with all bits/outputs Logical "1" (Output High). Any desired bit/output can be programmed to a Logical "0" (Output Low) by following the simple procedure shown below. One may build his own programmer to satisfy the specifications described in Table 1, or buy any of the commercially available programmers which meet these specifications. These PROMs can be programmed automatically or by the manual procedure shown below.

PROGRAMMING PROCEDURE

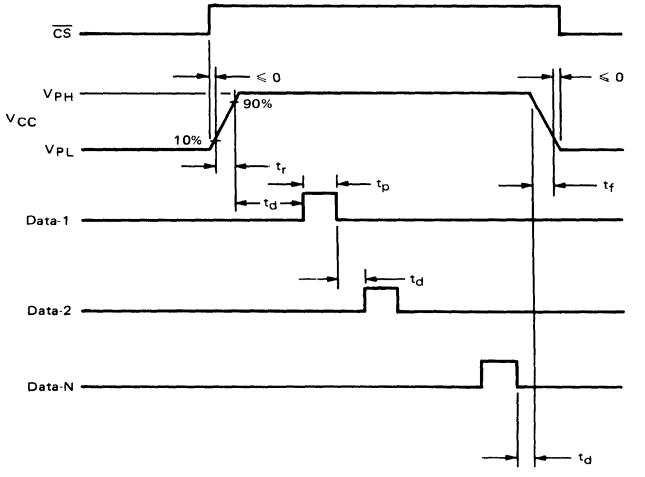
1. Address the PROM with the binary address of the selected word to be programmed. Address inputs are TTL-compatible. An open circuit should not be used to address the PROM.
2. Disable the chip by applying input high (V_{IH}) to the $\overline{CS}$ input. $\overline{CS}$ input must remain at V_{IH} for programming. The chip select is TTL-compatible. An open circuit should not be used to disable the chip.
3. Disable the programming circuitry by applying an Output Voltage Disable of less than V_{OPD} to the output of the PROM. The output may be left open to achieve the disable.
4. Raise V_{CC} to V_{PH} with rise time equal to t_r.
5. After a delay equal to or greater than t_d, apply a pulse with amplitude of V_{OPE} and duration of t_p to the output selected for programming. Note that the PROM is supplied with fuses intact generating an output high. Programming a fuse will cause the output to go low in the verify mode.
6. Other bits in the same word may be programmed while the V_{CC} input is raised to V_{PH} by applying output enable pulses to each output which is to be programmed. The output enable pulses must be separated by a minimum interval of t_d.
7. Lower V_{CC} to 4.5 Volts following a delay of t_d from the last programming enable pulse applied to an output.
8. Enable the PROM for verification by applying a logic "0" (V_{IL}) to the $\overline{CS}$ input.
9. If any bit does not verify as programmed, repeat Steps 2 through 8 until the bit has received a total of 1.0 ms of programming time. Bits which do not program within 1.0 ms may be considered programming rejects. Multiple pulse of durations shorter than 1.0 ms may be used to enhance programming speed.
10. Repeat Steps 1 through 9 for all other bits to be programmed in the PROM.
11. Programming rejects returned to the factory must be accompanied by data giving address with desired and actual output data of a location in which a programming failure has occured.

TABLE 1 — PROGRAMMING SPECIFICATIONS

Symbol	Parameter	Min	Typ	Max	Unit
V_{IH} V_{IL}	Address Input Voltage (1)	2.4 0.0	5.0 0.4	5.0 0.8	V V
V_{PH} V_{PL}	Programming/Verify Voltage to V_{CC}	11.75 4.5	12.0 4.5	12.25 5.5	V V
I_{CCP}	Programming Voltage Current Limit with V_{PH} Applied	600	600	650	mA
t_r t_f	Voltage Rise and Fall Time	1.0 1.0	1.0 1.0	10 10	μs μs
t_d	Programming Delay	10	10	100	μs
t_p	Programming Pulse Width	100	—	1000	μs
DC	Programming Duty Cycle	—	50	90	%
V_{OPE} V_{OPD}	Output Voltage Enable Disable (2)	10.0 4.5	10.5 5.0	11.0 5.5	V V
I_{OPE}	Output Voltage Enable Current	2.0	4.0	10	mA
T_A	Ambient Temperature	—	25	75	°C

(1) Address and chip select should not be left open for V_{IH}.
(2) Disable condition will be met with output open circuit.

FIGURE 1 — TYPICAL PROGRAMMING WAVEFORMS



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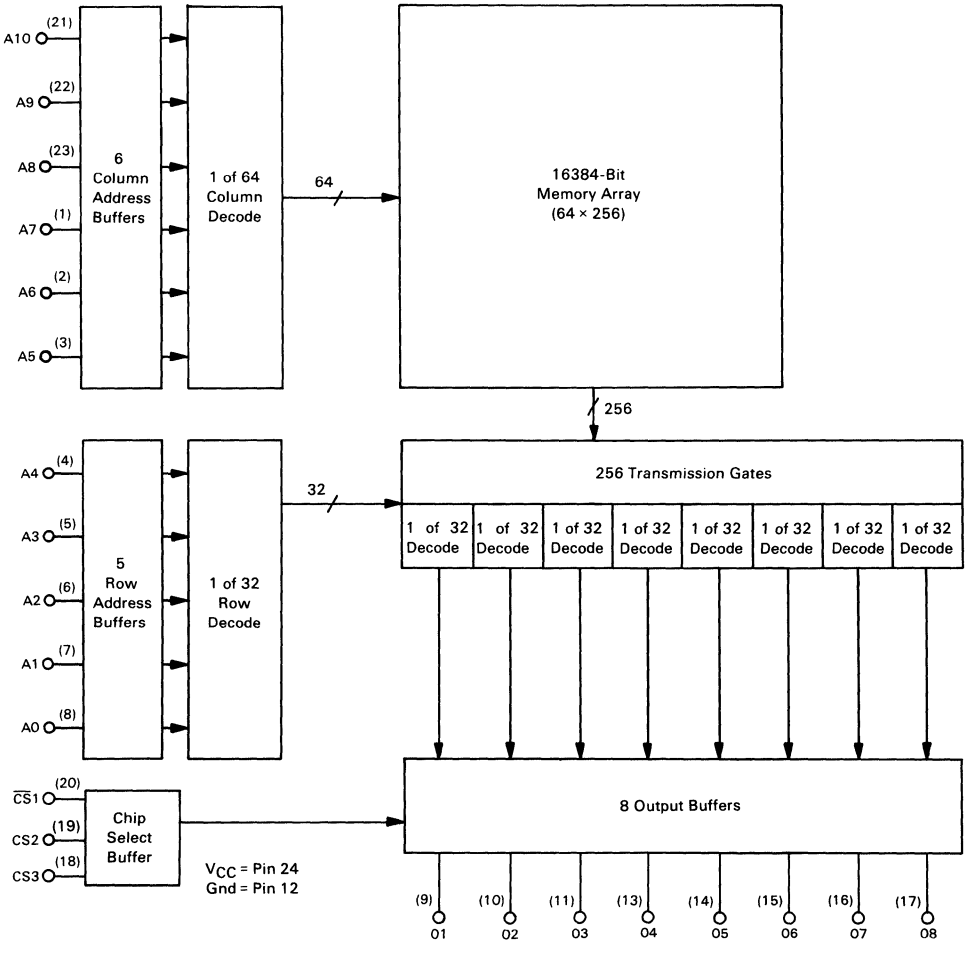
MCM76161/161A BLOCK DIAGRAM



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MCM93415

1024-BIT RANDOM ACCESS MEMORY

TTL
1024 X 1 BIT
RANDOM ACCESS MEMORY

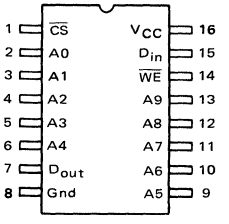
The MCM93415 is a 1024-bit Read/Write RAM organized 1024 words by 1 bit.

The MCM93415 is designed for buffer control storage and high performance main memory applications, and has a typical access time of 35 ns.

The MCM93415 has full decoding on-chip, separate data input and data output lines, and an active low chip select. The device is fully compatible with standard DTL and TTL logic families and features an uncommitted collector output for ease of memory expansion.

- Uncommitted Collector Output
- TTL Inputs and Output
- Non-Inverting Data Output
- High Speed –
  - Access Time – 35 ns Typical
  - Chip Select – 15 ns Typical
- Power Dissipation Decreases with Increasing Temperature
- Power Dissipation 0.5 mW/Bit Typical
- Organized 1024 Words X 1 Bit

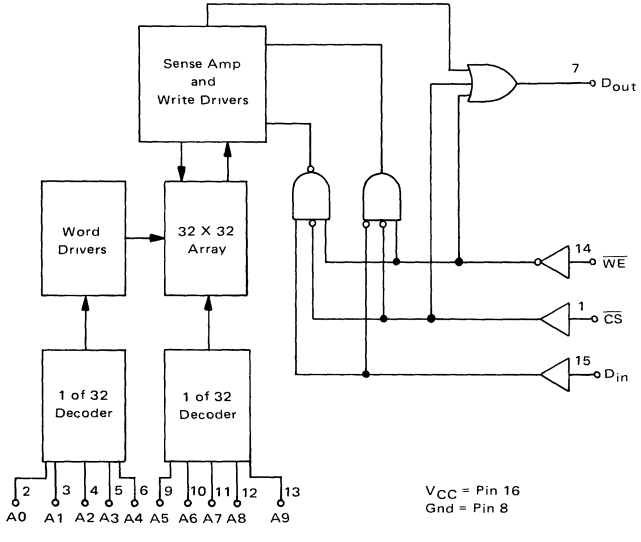
PIN ASSIGNMENT



Pin Designation

$\overline{CS}$	Chip Select
A0 – A9	Address Inputs
$\overline{WE}$	Write Enable
D_{in}	Data Input
D_{out}	Data Output

BLOCK DIAGRAM



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FUNCTIONAL DESCRIPTION

The MCM93415 is a fully decoded 1024-bit Random Access Memory organized 1024 words by one bit. Bit selection is achieved by means of a 10-bit address, A0 to A9.

The Chip Select input provides for memory array expansion. For large memories, the fast chip select access time permits the decoding of Chip Select ($\overline{CS}$) from the address without affecting system performance.

The read and write operations are controlled by the state of the active low Write Enable ($\overline{WE}$, Pin 14). With $\overline{WE}$ held low and the chip selected, the data at D_{in} is written into the addressed location. To read, $\overline{WE}$ is held high and the chip selected. Data in the specified location is presented at D_{out} and is non-inverted.

Uncommitted collector outputs are provided to allow wired-OR applications. In any application an external pull-up resistor of R_L value must be used to provide a high at the output when it is off. Any R_L value within the range specified below may be used.

$$\frac{V_{CC}(Min)}{I_{OL} - FO(1.6)} \leqslant R_L \leqslant \frac{V_{CC}(Min) - V_{OH}}{n(I_{CEX}) + FO(0.04)}$$

R_L is in kΩ
n = number of wired-OR outputs tied together
FO = number of TTL Unit Loads (UL) driven
I_{CEX} = Memory Output Leakage Current
V_{OH} = Required Output High Level at Output Node
I_{OL} = Output Low Current

The minimum R_L value is limited by output current sinking ability. The maximum R_L value is determined by the output and input leakage current which must be supplied to hold the output at V_{OH}. One Unit Load = 40 μA High/1.6 mA Low.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Storage Temperature Ceramic Package (D and F Suffix) Plastic Package (P Suffix)	 −55°C to +165°C −55°C to +125°C
Operating Junction Temperature, T_J Ceramic Package (D and F Suffix) Plastic Package (P Suffix)	 <165°C <125°C
V_{CC} Pin Potential to Ground Pin	−0.5 V to +7.0 V
Input Voltage (dc)	−0.5 V to +5.5 V
Voltage Applied to Outputs (Output High)	−0.5 V to +5.5 V
Output Current (dc) (Output Low)	+20 mA
Input Current (dc)	−12 mA to +5.0 mA

TRUTH TABLE

Inputs			Output	
$\overline{CS}$	$\overline{WE}$	D_{in}	Open Collector	Mode
H	X	X	H	Not Selected
L	L	L	H	Write "0"
L	L	H	H	Write "1"
L	H	X	D_{out}	Read

H = High Voltage Level
L = Low Voltage Level
X = Don't Care (High or Low)

NOTE 1 Device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded.

GUARANTEED OPERATING RANGES (Note 2)

Part Number	Supply Voltage (V_{CC}) Min	Nom	Max	Ambient Temperature (T_A)
MCM93415DC, PC	4.75 V	5.0 V	5.25 V	0°C to +75°C
MCM93415FM, DM	4.50 V	5.0 V	5.50 V	−55°C to +125°C

DC OPERATING CONDITIONS AND CHARACTERISTICS

(Full operating voltage and temperature range unless otherwise noted)

Symbol	Characteristic	Limits Min	Max	Unit	Conditions
V_{OL}	Output Low Voltage		0.45	Vdc	V_{CC} = Min, I_{OL} = 16 mA
V_{IH}	Input High Voltage	2.1		Vdc	Guaranteed Input High Voltage for All Inputs
V_{IL}	Input Low Voltage		0.8	Vdc	Guaranteed Input Low Voltage for All Inputs
I_{IL}	Input Low Current		−400	μAdc	V_{CC} = Max, V_{in} = 0.4 V
I_{IH}	Input High Current		40	μAdc	V_{CC} = Max, V_{in} = 4.5 V
			1.0	mAdc	V_{CC} = Max, V_{in} = 5.25 V
I_{CEX}	Output Leakage Current		100	μAdc	V_{CC} = Max, V_{out} = 4.5 V
V_{CD}	Input Diode Clamp Voltage		−1.5	Vdc	V_{CC} = Max, I_{in} = −10 mA
I_{CC}	Power Supply Current		130	mAdc	T_A = Max; V_{CC} = Max, All Inputs Grounded
			155	mAdc	T_A = 0°C; V_{CC} = Max, All Inputs Grounded
			170	mAdc	T_A = Min; V_{CC} = Max, All Inputs Grounded

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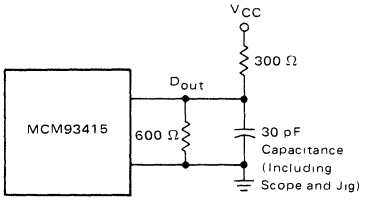
AC OPERATING CONDITIONS AND CHARACTERISTICS

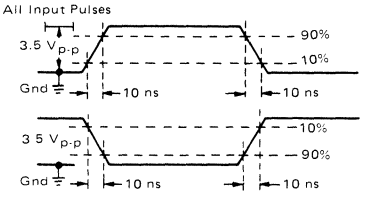
(Full operating voltage and temperature unless otherwise noted)

AC TEST LOAD AND WAVEFORM

Loading Condition



Input Pulses



Symbol	Characteristic (Notes 2, 3)	MCM93415DC,PC Min	MCM93415DC,PC Max	MCM93415DM, FM Min	MCM93415DM, FM Max	Unit	Conditions
READ MODE	DELAY TIMES					ns	
t_{ACS}	Chip Select Time		35		45		See Test Circuit
t_{RCS}	Chip Select Recovery Time		35		50		and Waveforms
t_{AA}	Address Access Time		45		60		
WRITE MODE	DELAY TIMES					ns	
t_{WS}	Write Disable Time		35		45		See Test Circuit
t_{WR}	Write Recovery Time		40		50		and Waveforms
	INPUT TIMING REQUIREMENTS					ns	
t_W	Write Pulse Width (to guarantee write)	30		40			See Test Circuit
t_{WSD}	Data Setup Time Prior to Write	5		5			and Waveforms
t_{WHD}	Data Hold Time After Write	5		5			
t_{WSA}	Address Setup Time (at t_W = Min)	10		15			
t_{WHA}	Address Hold Time	10		10			
t_{WSCS}	Chip Select Setup Time	5		5			
t_{WHCS}	Chip Select Hold Time	5		5			

NOTE 2 DC and AC specifications limits guaranteed with 500 linear feet per minute blown air Contact your Motorola Sales Representative if extended temperature or modified operating conditions are desired.

NOTE 3. The AC limits are guaranteed to be the worst case bit in the memory

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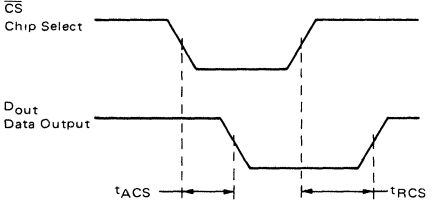
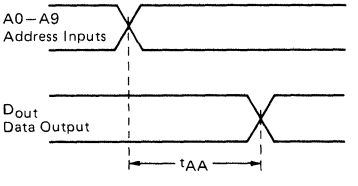
READ OPERATION TIMING DIAGRAM

Propagation Delay from Chip Select

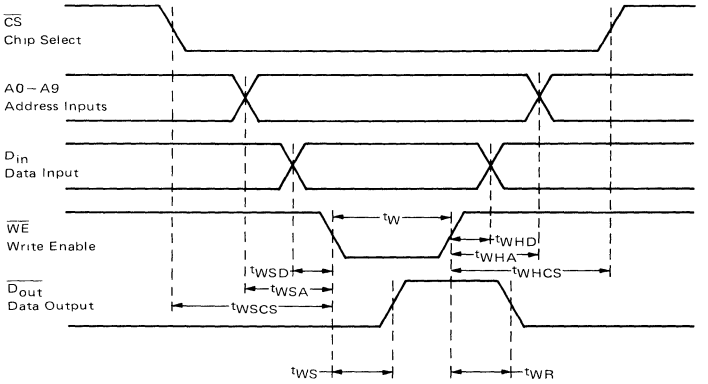


Propagation Delay from Address Inputs



(All Time Measurements Referenced to 1.5 V)

WRITE CYCLE TIMING



(All Time Measurements Referenced to 1.5 V)

Package	θ_{JA} (Junction to Ambient)		θ_{JC} (Junction to Case)
	Blown	Still	
D Suffix	50°C/W	85°C/W	15°C/W
F Suffix	55°C/W	90°C/W	15°C/W
P Suffix	65°C/W	100°C/W	25°C/W

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MCM93422
MCM93L422

1024-BIT RANDOM ACCESS MEMORY

The MCM93422/MCM93L422 are 1024-bit Read/Write RAMs, organized 256 words by 4 bits, designed for high performance main memory and control storage applications.

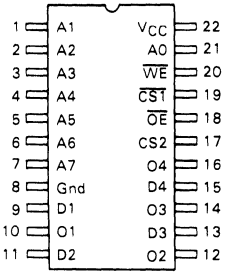
They have full decoding on-chip, separate data input and data output lines, an active low-output enable, write enable, and two chip selects, one active high, one active low. These memories are fully compatible with standard TTL logic families. A three-state output is provided to drive bus-organized systems and/or highly capacitive loads.

- Three-State Outputs
- TTL Inputs and Outputs
- Non-Inverting Data Outputs
- High Speed —
  Access Time — 30 ns Typical
  Chip Select — 15 ns Typical
- Power Dissipation — 0.26 mW/Bit Typical
- Standard 22-Pin, 400 Mil Wide Package
- Power Dissipation Decreases with Increasing Temperature
- Organized 256 Words × 4 Bits
- Two Chip Select Lines for Memory Expansion

TTL
256 × 4-BIT
RANDOM ACCESS MEMORY

MCM93422 — THREE-STATE
MCM93L422 — THREE-STATE

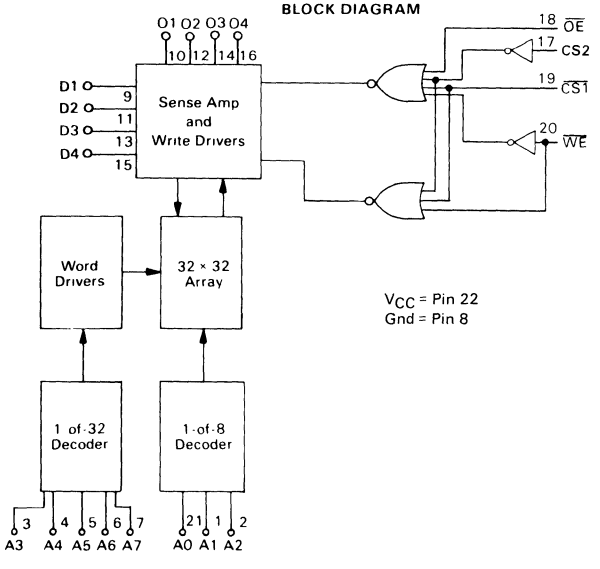
PIN ASSIGNMENT



Pin Description

$\overline{CS1}$, CS2	Chip Selects
A0-A7	Address Inputs
$\overline{OE}$	Output Enable
$\overline{WE}$	Write Enable
D1-D4	Data Inputs
O1-O4	Data Outputs

BLOCK DIAGRAM



V_{CC} = Pin 22
Gnd = Pin 8

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FUNCTIONAL DESCRIPTION

The MCM93422/MCM93L422 are fully decoded 1024-bit random access memories organized 256 words by 4 bits. Word selections are achieved by means of an 8-bit address, A0–A7.

The Chip Select ($\overline{CS1}$ and CS2) inputs provide for memory array expansion. For large memories, the fast chip select time permits the decoding of chip select from the address without increasing address access time.

The read and write operations are controlled by the state of the active low Write Enable ($\overline{WE}$, Pin 20). With $\overline{WE}$ and $\overline{CS1}$ held low and the CS2 held high, the data at D_n is written into the addressed location. To read, $\overline{WE}$ and CS2 are held high and $\overline{CS1}$ is held low. Data in the specified location is presented at the output (O1–O4) and is non-inverted.

The three-state outputs of the MCM93422/MCM93L422 provide drive capability for higher speeds with capacitive load systems. The third state (high impedance) allows bus-organized systems where multiple outputs are connected to a common bus.

During writing, the output is held in a high-impedance state.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Storage Temperature Ceramic Package (D Suffix) Plastic Package (P Suffix)	 −65°C to +150°C −55°C to +125°C
Operating Junction Temperature, T_J Ceramic Package (D Suffix) Plastic Package (P Suffix)	 <165°C <125°C
V_{CC} Pin Potential to Ground Pin	−0.5 V to +7.0 V
Input Voltage (dc)	−0.5 V to +5.5 V
Voltage Applied to Outputs (Output High)	−0.5 V to +5.5 V
Output Current (dc) (Output Low)	+20 mA
Input Current (dc)	−12 mA to +5.0 mA

NOTE 1 Device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded

GUARANTEED OPERATING RANGES

Part Number	Supply Voltage (V_{CC})			Ambient Temperature (T_A)
	Min	Nom	Max	
MCM93422DC, PC MCM93L422DC, PC	4.75 V	5.0 V	5.25 V	0°C to +75°C

DC OPERATING CONDITIONS AND CHARACTERISTICS

(Full operating voltage and temperature range)

Symbol	Characteristic		Limits Min	Limits Max	Units	Conditions	
V_{OL}	Output Low Voltage		—	0.45	Vdc	V_{CC} = Min, I_{OL} = 8.0 mA	
V_{IH}	Input High Voltage		2.1	—	Vdc	Guaranteed Input High Voltage for all Inputs	
V_{IL}	Input Low Voltage		—	0.8	Vdc	Guaranteed Input Low Voltage for all Inputs	
I_{IL}	Input Low Current		—	−300	μAdc	V_{CC} = Max, V_{in} = 0.4 V	
I_{IH}	Input High Current		— —	40 1.0	μAdc mAdc	V_{CC} = Max, V_{in} = 4.5 V V_{CC} = Max, V_{in} = 5.25 V	
I_{off}	Output Current (High Z)			50 −50	μAdc	V_{CC} = Max, V_{out} = 2.4 V V_{CC} = Max, V_{out} = 0.5 V	
I_{OS}	Output Current Short Circuit to Ground		—	−70	mAdc	V_{CC} = Max (Note 2)	
V_{OH}	Output High Voltage		2.4	—	Vdc	V_{CC} = Min, I_{OH} = −5.2 mA	
V_{IK}	Input Diode Clamp Voltage		—	−1.5	Vdc	V_{CC} = Max, I_{in} = −10 mA	
I_{CC}	Power Supply Current	MCM93422	— —	130 155	mAdc mAdc	T_A = Max T_A = Min	V_{CC} = Max, All Inputs Grounded
		MCM93L422	— —	75 80	mAdc mAdc	T_A = Max T_A = Min	

TRUTH TABLE

Inputs					Output	Mode
$\overline{OE}$	$\overline{CS1}$	CS2	$\overline{WE}$	D1-D4	O1-O4	
X	H	X	X	X	High Z	Not Selected
X	X	L	X	X	High Z	Not Selected
X	L	H	L	L	High Z	Write "0"
X	L	H	L	H	High Z	Write "1"
H	X	X	X	X	High Z	Output Disabled
L	L	H	H	X	O1-O4	Read

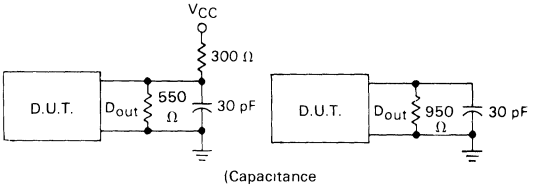
H = High Voltage Level
L = Low Voltage Level
X = Don't Care (High or Low)

AC OPERATING CONDITIONS AND CHARACTERISTICS

(Full operating voltage and temperature range)

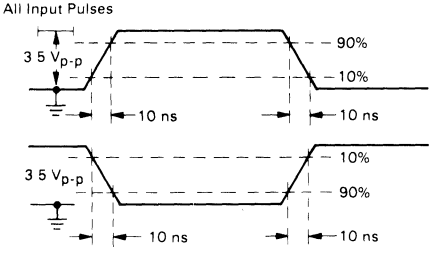
AC TEST LOAD AND WAVEFORMS

Loading Conditions



Load A (Capacitance Includes Scope and Test Fixture) Load B

Input Pulses



Symbol	Characteristic (Notes 2, 3, 4, 5)	MCM93422DC,PC		MCM93L422DC,PC		Units	Conditions
		Min	Max	Min	Max		
READ MODE	DELAY TIMES					ns	
t_{ACS}	Chip Select Time	—	30	—	35		See Test Circuit
t_{ZRCS}	Chip Select to High Z	—	30	—	35		and Waveforms
t_{AOS}	Output Enable Time	—	30	—	35		
T_{ZROS}	Output Enable to High Z	—	30	—	35		
t_{AA}	Address Access Time	—	45	—	60		
WRITE MODE	DELAY TIMES					ns	See Test Circuit
t_{ZWS}	Write Disable to High Z	—	35	—	40		and Waveform
t_{WR}	Write Recovery Time	—	40	—	45		
	INPUT TIMING REQUIREMENTS					ns	
t_W	Write Pulse Width (to guarantee write)	30	—	45	—		See Test Circuit
t_{WSD}	Date Setup Time Prior to Write	5.0	—	5.0	—		and Waveforms
t_{WHD}	Data Hold Time After Write	5 0	—	5.0	—		
t_{WSA}	Address Setup Time (at t_W = Min)	10	—	10	—		
t_{WHA}	Address Hold Time	5.0	—	5.0	—		
t_{WSCS}	Chip Select Setup Time	5 0	—	5.0	—		
t_{WHCS}	Chip Select Hold Time	5 0	—	5 0	—		

NOTE 2 Output short circuit conditions must not exceed 1 second duration

3: The maximum address access time is guaranteed to be the worst-case bit in the memory

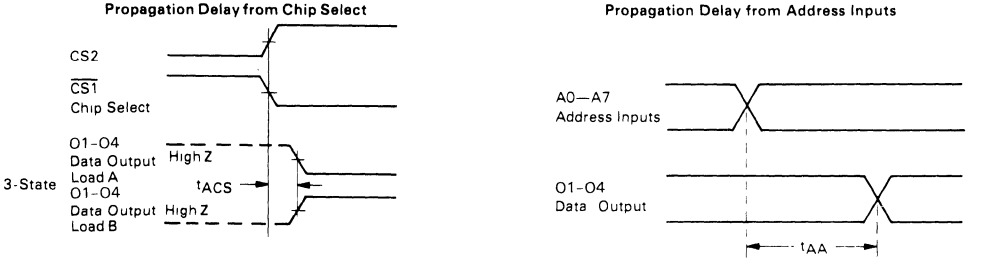
4: Load A used to measure transitions between logic levels and from High Z state to logic Low state.
Load B used to measure transitions between High Z state to logic High state.
Load C used to measure transitions from either logic High or Low state to High Z state

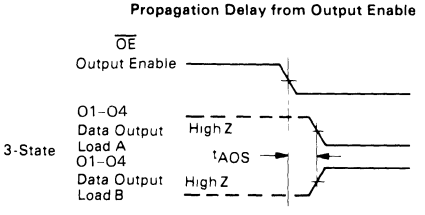
5 All time measurements are referenced to +1 5 Vdc except transitions into the High Z state where outputs are referenced to a delta of 0 5 Vdc from the logic level using Load C.

7

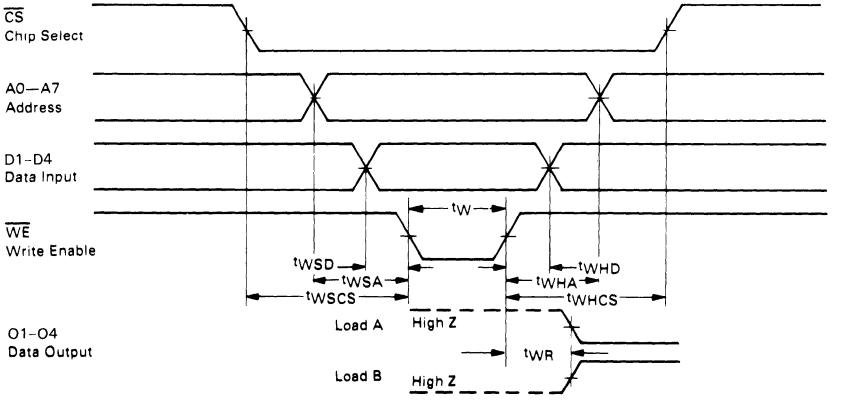
READ OPERATION TIMING DIAGRAM

(All Time Measurements Referenced to 1.5 V)





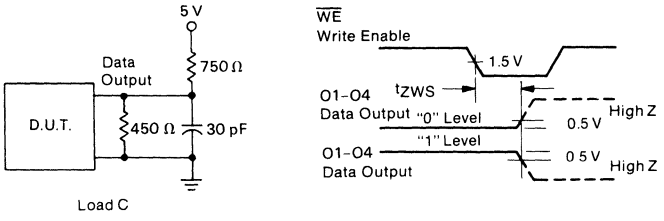
WRITE CYCLE TIMING



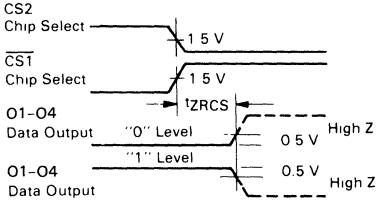
(All above measurements reference to 1.5 V)

7

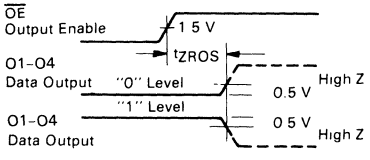
WRITE ENABLE TO HIGH Z DELAY



Propagation Delay from Chip Select to High Z



Propagation Delay from Output Enable to High Z



(All t_{ZXX} parameters are measured at a delta of 0.5 V from the logic level and using Load C.)

Package	θ_{JA} (Junction to Ambient)		θ_{JC} (Junction to Case)
	Blown*	Still	
D Suffix	50°C/W	85°C/W	15°C/W
P Suffix	50°C/W	85°C/W	15°C/W

*500 linear ft. per minute blown air

7

MOTOROLA

MCM93425

1024-BIT RANDOM ACCESS MEMORY

The MCM93425 is a 1024-bit Read/Write RAM, organized 1024 words by 1 bit.

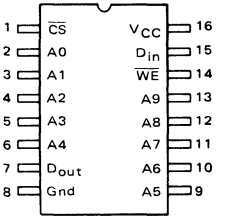
The MCM93425 is designed for high performance main memory and control storage applications and has a typical address time of 35 ns.

The MCM93425 has full decoding on-chip, separate data input and data output lines, and an active low-chip select and write enable. The device is fully compatible with standard DTL and TTL logic families. A three-state output is provided to drive bus-organized systems and/or highly capacitive loads.

- Three-State Output
- TTL Inputs and Output
- Non-Inverting Data Output
- High Speed –
  Access Time – 35 ns Typical
  Chip Select – 15 ns Typical
- Power Dissipation – 0.5 mW/Bit Typical
- Power Dissipation Decreases With Increasing Temperature

TTL
1024 X 1 BIT
RANDOM ACCESS MEMORY

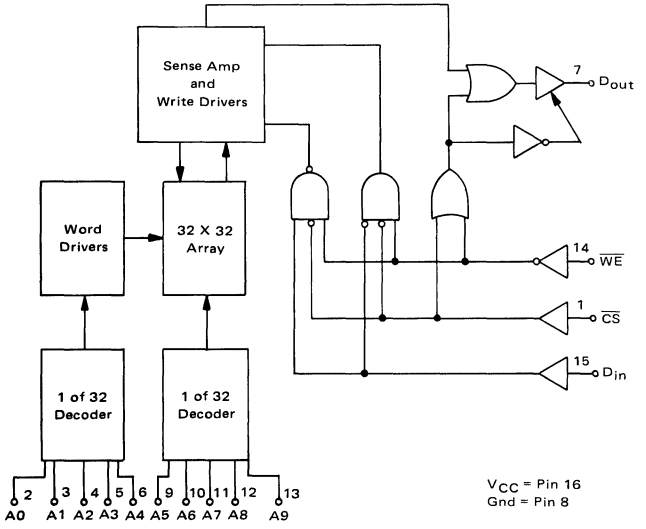
PIN ASSIGNMENT



Pin Description

$\overline{CS}$	Chip Select
A0 - A9	Address Inputs
$\overline{WE}$	Write Enable
D_{in}	Data Input
D_{out}	Data Output

BLOCK DIAGRAM



NOTE: Logic driving sense amp/write drivers depicts negative-only write used on C4m.

7

FUNCTIONAL DESCRIPTION

The MCM93425 is a fully decoded 1024-bit Random Access Memory organized 1024 words by one bit. Word selection is achieved by means of a 10-bit address, A0—A9.

The Chip Select ($\overline{CS}$) input provides for memory array expansion. For large memories, the fast chip select time permits the decoding of chip select from the address without increasing address access time.

The read and write operations are controlled by the state of the active low Write Enable ($\overline{WE}$, Pin 14). With $\overline{WE}$ and $\overline{CS}$ held low, the data at D_{in} is written into the addressed location. To read, $\overline{WE}$ is held high and $\overline{CS}$ held low. Data in the specified location is presented at D_{out} and is non-inverted.

The three-state output provides drive capability for higher speeds with capacitive load systems. The third state (high impedance) allows bus organized systems where multiple outputs are connected to a common bus.

During writing, the output is held in the high-impedance state.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Storage Temperature Ceramic Package (D and F Suffix) Plastic Package (P Suffix)	 −55°C to +165°C −55°C to +125°C
Operating Junction Temperature, T_J Ceramic Package (D and F Suffix) Plastic Package (P Suffix)	 < 165°C < 125°C
V_{CC} Pin Potential to Ground Pin	−0.5 V to +7.0 V
Input Voltage (dc)	−0.5 V to +5.5 V
Voltage Applied to Outputs (Output High)	−0.5 V to +5.5 V
Output Current (dc) (Output Low)	+20 mA
Input Current (dc)	−12 mA to +5.0 mA

NOTE 1: Device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded.

TRUTH TABLE

Inputs			Output	
$\overline{CS}$	$\overline{WE}$	D_{in}	D_{out}	Mode
H	X	X	High Z	Not Selected
L	L	L	High Z	Write "0"
L	L	H	High Z	Write "1"
L	H	X	D_{out}	Read

H = High Voltage Level
L = Low Voltage Level
X = Don't Care (High or Low)

GUARANTEED OPERATING RANGES (Notes 2 and 3)

Part Number	Supply Voltage (V_{CC}) Min	Nom	Max	Ambient Temperature (T_A)
MCM93425DC, PC	4.75 V	5.0 V	5.25 V	0°C to +75°C
MCM93425FM, DM	4.50 V	5.0 V	5.50 V	−55°C to +125°C

DC OPERATING CONDITIONS AND CHARACTERISTICS

(Full operating voltage and temperature range unless otherwise noted)

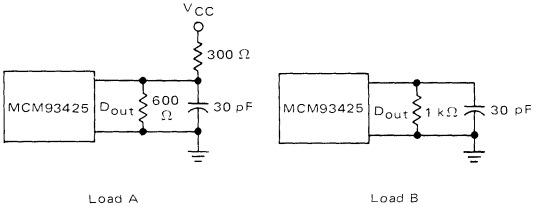
Symbol	Characteristic		Limits Min	Max	Units	Conditions	
V_{OL}	Output Low Voltage			0.45	Vdc	V_{CC} = Min, I_{OL} = 16 mA	
V_{IH}	Input High Voltage		2.1		Vdc	Guaranteed Input High Voltage for all Inputs	
V_{IL}	Input Low Voltage			0.8	Vdc	Guaranteed Input Low Voltage for all Inputs	
I_{IL}	Input Low Current			−400	μAdc	V_{CC} = Max, V_{in} = 0.4 V	
I_{IH}	Input High Current			40	μAdc	V_{CC} = Max, V_{in} = 4.5 V	
				1.0	mAdc	V_{CC} = Max, V_{in} = 5.25 V	
I_{off}	Output Current (High Z)			50	μAdc	V_{CC} = Max, V_{out} = 2.4 V	
				−50		V_{CC} = Max, V_{out} = 0.5 V	
I_{OS}	Output Current Short Circuit to Ground			−100	mAdc	V_{CC} = Max	
V_{OH}	Output High Voltage	MCM93425DC, PC	2.4		Vdc	I_{OH} = −10.3 mA, V_{CC} = 5.0 V ±5%	
		MCM93425FM, DM	2.4		Vdc	I_{OH} = −5.2 mA	
V_{CD}	Input Diode Clamp Voltage			−1.5	Vdc	V_{CC} = Max, I_{in} = −10 mA	
I_{CC}	Power Supply Current			130	mAdc	T_A = Max	V_{CC} = Max, All Inputs Grounded
				155	mAdc	T_A = 0°C	
				170	mAdc	T_A = Min	

AC OPERATING CONDITIONS AND CHARACTERISTICS

(Full operating voltage and temperature unless otherwise noted)

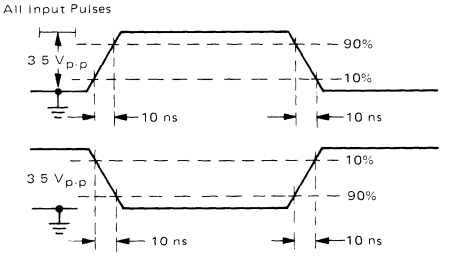
AC TEST LOAD AND WAVEFORMS

Loading Conditions



Load A Load B

Input Pulses



Symbol	Characteristic (Notes 2, 4)	MCM93425DC, PC Min	MCM93425DC, PC Max	MCM93425DM, FM Min	MCM93425DM, FM Max	Units	Conditions
READ MODE	DELAY TIMES					ns	
t_{ACS}	Chip Select Time		35		45		See Test Circuit
t_{ZRCS}	Chip Select to High Z		35		50		and Waveforms
t_{AA}	Address Access Time		45		60		
WRITE MODE	DELAY TIMES					ns	
t_{ZWS}	Write Disable to High Z		35		45		See Test Circuit
t_{WR}	Write Recovery Time		40		50		and Waveforms
	INPUT TIMING REQUIREMENTS					ns	
t_W	Write Pulse Width (to guarantee write)	30		40			See Test Circuit
t_{WSD}	Data Setup Time Prior to Write	5		5			and Waveforms
t_{WHD}	Data Hold Time After Write	5		5			
t_{WSA}	Address Setup Time (at t_W = Min)	10		15			
t_{WHA}	Address Hold Time	10		10			
t_{WSCS}	Chip Select Setup Time	5		5			
t_{WHCS}	Chip Select Hold Time	5		5			

NOTE 2 DC and AC specifications limits guaranteed with 500 linear feet per minute blown air. Contact your Motorola Sales Representative if extended temperature or modified operating conditions are desired.

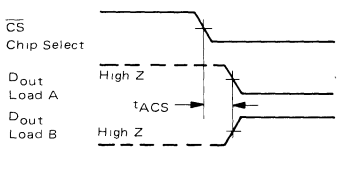
NOTE 3 Output short circuit conditions must not exceed 1 second duration

NOTE 4 The maximum address access time is guaranteed to be the worst case bit in the memory.

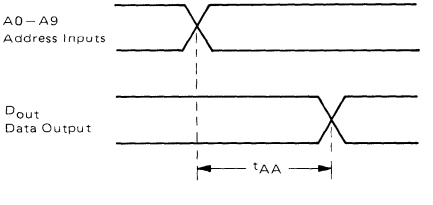
7

READ OPERATION TIMING DIAGRAM

Propagation Delay from Chip Select

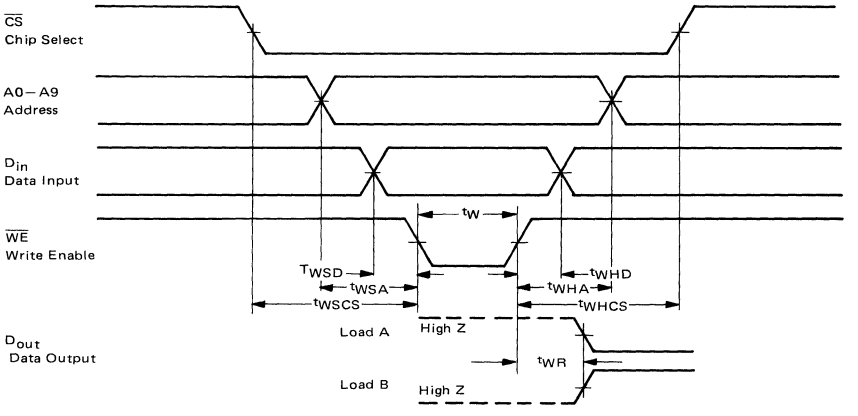


Propagation Delay from Address Inut



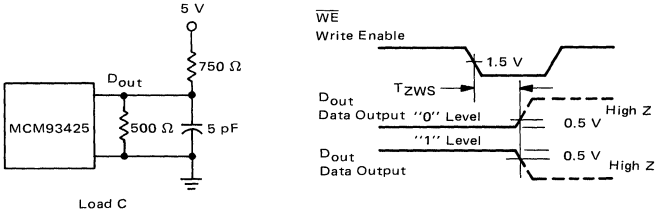
(All time measurements referenced to 1.5 V)

WRITE CYCLE TIMING

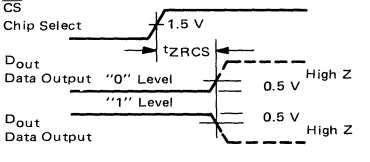


(All above measurements reference to 1.5 V)

WRITE ENABLE TO HIGH Z DELAY



Propagation Delay from Chip Select to High Z



(All t_{ZXX} parameters are measured at a delta of 0.5 V from the logic level and using Load C)

Package	θ_{JA} (Junction to Ambient)		θ_{JC} (Junction to Case)
	Blown	Still	
D Suffix	50°C/W	85°C/W	15°C/W
F Suffix	55°C/W	90°C/W	15°C/W
P Suffix	65°C/W	100°C/W	25°C/W

SCHOTTKY TTL

Reliability Data 8

STANDARD PROGRAMS

MIL-STD-883 OPERATIONS METHOD	PROCESSING PER 5004/5005	HI-REL JEDEC[6] PROCESSED PROGRAMS		MIL-M-38510 JAN QUALIFIED
SCREEN	CLASS B METHOD	CLASS B	CLASS C	CLASS B
Internal Visual (Precap)	2010 Condition B and 38510	100%	100%	100%
Stabilization Bake	1008 Condition C or Equivalent	100%	100%	100%
Temperature Cycling	1010 Condition C	100%	100%	100%
Constant Acceleration	2001 Condition E (min.) Y_1 Plane	100%	100%	100%
Seal (a) Fine (b) Gross	1014, Condition B 1014, Condition C	100% 100%	100% 100%	100% 100%
Interim Electrical Parameters	Per applicable device specification	Optional[1]		Optional[1]
Burn-in Test	1015 160 Hrs. @ 125° C Min. (4)	100%		100%
Final Electrical Tests (a) Static tests (1) 25°C (subgroup 1, table 1, 5005) (2) Max. and min. rated operating temp. (subgroups 2 and 3, table 1, 5005) (b) Dynamic tests and/or switching tests @ 25°C (subgroup 4 and 9, table 1, 5005) (c) Functional test @ 25°C (subgroup 7, table 1, 5005)	Per applicable device specification	 100% 100%[5] 100% 100%	 100% (2) (2) 100%	 100% 100%[5] 100% 100%
Qualification or Quality Conformance Inspection	5005	Group A[3]	Group A[3]	per 38510[3]
External Visual	2009	100%	100%	100%

1. When specified in the applicable device specification, 100% of the devices shall be tested at Manufacturer's option.
2. Sample at Group A.
3. Full 5005 Conformance testing performed on Jan qualified product. Group A performed on Motorola HI-REL JEDEC processed product with either Generic or group B, C, D testing available.
4. Optional 0.44 eV time-temperature "equivalent" burn-in per Figure 1015-1.
5. AC sample testing at +125°C and −55°C on those types which require subgroup 10 and 11 testing per MIL-M-38510 Slash Sheet Specifications.
6. Devices Processed to earlier HI-REL "SNC" and "SNJ" program still available — contact nearest Motorola Sales Office for ordering information.

ORDERING & MARKING
FOR JEDEC HI-REL PROCESSING PROGRAM

54LS00	/	B	C	B	JC
↑	↑	↑	↑	↑	↑
Device Type	Slash	Device Class	Case Outline	Lead Finish	JEDEC Designator

ORDERING & MARKING FOR JAN QUALIFIED PROGRAM

JM38510/30001BCB

MILITARY DESIGNATOR

device type
as designated by
the applicable military
specification
(slash sheet)

CLASS

LEAD FINISH

1. A—HOT SOLDER DIP
2. B—TIN PLATE
3. C—GOLD PLATE
4. X—DON'T CARE

CASE OUTLINE

1. A—¼″ × ¼″ flat pack, 14-pin
2. B—⅛″ × ¼″ flat pack, 14-pin
3. C—¼″ × ¾″ dual-in-line, 14-pin
4. D—¼″ × ⅜″ flat pack, 14-pin
5. E—¼″ × ¾″ dual-in-line, 16-pin
6. F—¼″ × ⅜″ flat pack, 16-pin
7. G—8-lead can
8. H—¼″ × ¼″ flat pack, 10-lead
9. I—10-lead can
10. J—½″ × 1¼″ dual-in-line, 24-pin
11. K—⅜″ × ⅝″ flat pack, 24-pin
12. L—⅜″ × ½″ flat pack, 24-pin
13. M—12-lead can
14. N—(Size *N/D) flat pack, 24-pin
15. P—¼″ × ⅜″ dual-in-line, 8-pin
16. Q—0.60″ × 2.00″ dual-in-line, 40-pin
17. R—(Size *N/D) dual-in-line, 20-pin
18. S—(Size *N/D) flat pack, 20-pin
19. T—(Size *N/D) flat pack, 22-pin
20. U—0.40″ × 0.40″ leadless flat pack, 24-pin
21. V—0.30″ × 1.00″ dual-in-line, 18-pin
22. W—0.40″ × 1.10″ dual-in-line, 22-pin
23. X } Variable per applicable slash sheet
24. Y }
25. Z—¼″ × ⅜″ flat pack, 24-pin

*N/D — NOT DEFINED

8

THE "BETTER" PROGRAM

Motorola's reliability and quality-enhancement program was developed to provide improved levels of quality and reliability for standard commercial products.

The "BETTER" program is offered on TTL/LS, in dual-in-line ceramic and plastic packages.

Motorola standard commercial integrated circuits are manufactured under stringent in-process controls and quality inspections combined with the industries' finest outgoing quality inspections. The "BETTER" program offers three levels of extra processing, each tailored to meet different user needs at nominal costs.

The program is designed to:

- Eliminate incoming electrical inspection
- Eliminate need for independent test labs and associated extra time and costs
- Reduce field failures
- Reduce service calls
- Reduce equipment downtime
- Reduce board and system rework
- Reduce infant mortality
- Save time and money
- Increase end-customer satisfaction

BETTER PROCESSING — STANDARD PRODUCT PLUS:

LEVEL I (Suffix S)

- 100% temperature cycling per MIL-STD-883. Method 1010C, ten cycles from — 65°C to+150°C.
- 100% functional and dc parametric tests at maximum rated temperature.

LEVEL II (Suffix D)

- 100% burn-in to MIL-STD-883 test conditions — 160 hours at +125°C or 1.0 eV Arrhenius time/temperature equivalent.
- 100% post burn-in functional and dc parametric tests at 25°C (or max rated T_A at Motorola's option).

LEVIL III (Suffix DS)

- Combination of Levels I and II above. (Post burn-in functional and dc parametric tests at maximum rated temperature.)

"BETTER" AQL GUARANTEES

TEST	CONDITION	AQL[1]		
		LEVEL I	LEVEL II	LEVEL III
HIGH TEMPERATURE FUNCTIONAL	T_A = MAX	0.078		0.078
DC PARAMETRIC	T_A = 25°C	0.078	0.078	0.078
DC PARAMETRIC	T_A MIN, T_A MAX	0.39	0.39	0.39
AC PARAMETRIC	T_A = 25°C	0.078	0.078	0.078
EXTERNAL VISUAL AND MECHANICAL	MAJOR/MINOR	0.078	0.078	0.078
HERMETICITY (NOT APPLICABLE TO PLASTIC PACKAGES)	GROSS/FINE	0.15	0.15	0.15

1. "AQL" values shown are for references only—"LTPD" type sampling plans are used that are equal to or tighter than values indicated. Also, the guaranteed electrical and visual/mechanical AQL levels will be tightened each quarter through 1985. Contact nearest Motorola sales office for latest values.

8

HOW TO ORDER

SN74LS00 — **Part Identification**

N — **Standard Package Suffix**

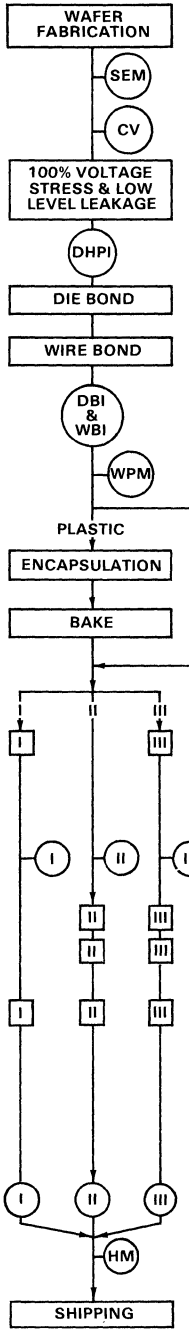
S — **BETTER PROCESSING**
LEVEL I = SUFFIX S
LEVEL II = SUFFIX D
LEVEL III = SUFFIX DS

PART MARKING

The Standard Motorola part number with the corresponding "BETTER" suffix can be ordered from your local authorized Motorola distributor or Motorola sales offices. "BETTER" pricing will be quoted as an adder to standard commercial product price.

GENERALIZED PRODUCT FLOW

Generalized product flow for all Motorola Bipolar Integrated Circuits purchased to the 'BETTER" program.



Scanning Electron Microscope Wafer Process Control Monitor. To control oxide step profiles, contact coverage, and metallization integrity. (Engineering option.)

CV Plot Wafer Process Control Monitor: To control field inversion potential, base inversion — surface channel formation, and to detect any spurious contamination problems. (Engineering option.)

Performed at final wafer probe (or, optionally, at final electrical test) to screen out potential pinhole shorts, interlayer metal shorts, N+ crossunder shorts, diffusion faults, and similar defects that cannot be detected by visual die high-power inspection

Die High-Power Sample Gate Inspection: Performed by in-process Q.A. to an 5.5% AQL to detect any damage caused by 100% wafer probe or mechanical scribe and break operation, or any scratches, metallization smears, or glass on bonding pads.

Combined Die Bond and Wire Bond Sample Gate Inspection: Performed by in-process Q.A. to 0.65% AQL to detect any misaligned or lifted die, to assure adequate "wetting" for low thermal resistance and high die shear strength, and to detect any improper wire bonds or wire dress, and any wire bonder damage

Wire Pull Monitor: Performed by in-process Q.A. to maintain process control of bond strength values per MIL-STD-883. Method 2011, Condition D.

Motorola Proprietary Epoxy Molding Compound: Meets or exceeds U.L. flame-retarding level UL94V-1.

Post Encapsulation Bake: Eight hours at 150°C (or six hours at 175°C). Final cure for molding compound; also stresses wire and die bonds and helps eliminate marginal devices.

100% Temperature Cycling: MIL-STD-883, Method 1010C, ten cycles — 65° to +150°C. Exercising circuits ten times over a 215°C range stresses the die and wire bonds and generally eliminates any marginal bonds and also screens out some types of wafer defects (pinholes, interlayer metal shorts, marginal step coverage, N+ crossunder shorts) and marginal seals in hermetic packages. This screening is superior to thermal shock screening because it does not introduce latent failures in ceramic packages (microcracks in seals) in plastic packages (entrapped liquid) that can result from liquid-to-liquid thermal shock.

Hermeticity Monitor: Hermetic packages only — combination fine/gross leak test per modification of MIL-STD-883, Method 1014B. (5 x 10^{-8} ATM CC/SEC to 1 x 10^{-4} ATM CC/SEC.) Sampled to a 0.15% AQL.

100% Electrical: Functional and dc parametrics at 70°C or max rated T_A (optional).

100% Burn-In: MIL-STD-883, Method 1015, for 160 hours minimum at T_A of 125°C minimum (or equivalent, per Arrhenius equation with 1.0eV activation energy) Test condition depends on device type, but generally condition A or C.

100% Electrical: Functional and dc parametrics: At 70°C (Level II) and max rated T_A (Level I and III).

100% High-Temperature Functional and Parametric: Devices are tested at maximum rated operating temperatures assuring reliable operation at elevated temperatures and screening out marginally performing devices that could otherwise lower field reliability. Although epoxy molding compounds have essentially eliminated the thermal intermittent failure mode, this screen provides protection from any "maverick" intermittent device being shipped to a customer This screening is more effective than hot rail "continuity" testing because non-functional devices can often pass a continuity test.

Q.A. Electrical and Mechanical Final Acceptance Tests: Sampled to the tightened AQL levels of Table 1.

Hermeticity Monitor: Hermetic packages only. Combination fine/gross leak test per modification of MIL-STD-883, Method 1014B (5 x 10^{-8} ATM CC/SEC to 1 x 10^{-4} ATM CC/SEC). Sampled to a 0.15% AQL.

8

"RAP"
RELIABILITY AUDIT PROGRAM
for
BIPOLAR DIGITAL
INTEGRATED CIRCUITS

1.0 INTRODUCTION

In January, 1977, Motorola Bipolar Digital Reliability Engineering implemented "RRAP" (Rapid Reliability Assessment Program) to provide rapid assessment of the reliability of newly introduced TTL Low-Power Schottky (LS) devices. This RRAP concept permits rapid feedback of information on any reliability problems to the Product Engineering group so that corrective action can be quickly implemented. The RRAP program is performed by the Reliability Engineering Department on samples submitted by Product, Process, or Package Engineering for obtaining a rapid look at the reliability of new products, processes, or packages. This program has been extended to standard ALS, 74F (FAST), TTL, TTL Memories, MDTL, MHTL, MECL III, MECL 10K and 10KH, MECL Memories, Macrocell Arrays, and Phase Lock Loop (PLL) product families. The details of the RRAP program are outlined in Section 2.0

In March, 1977, an addition was made to the RRAP program for the purpose of auditing the reliability of outgoing TTL Low-Power Schottky (LS) product. This audit, called the Reliability Audit Program ("RAP"), is performed weekly by the Quality Assurance Group and reported monthly by Bipolar Digital Reliability Engineering. The details of this "RAP" program are outlined in Section 3.0.

2.0 RAPID RELIABILITY ASSESSMENT PROGRAM (RRAP)

2.1 Hermetic Packaged Devices (50 Units minimum per Evaluation Sample)

a. Electrical I (initial rejects removed from test)
b. Temp Cycling −100 cycles (−65°C/+150°C) per Method 1010C
c. Electrical I (plus Hermeticity per Method 1014 B & C for package evaluations only)
d. "Equivalent" Burn-In for 40 hrs at 145°C per Method 1015 A or C
e. Electrical I

2.2 Plastic Packaged Devices (100 Units minimum per Evaluation Sample)

S/G 1 (30 Units)

a. Electrical I
b. Thermal Shock −200 cycles (−55°C/+125°C −30 Sec. dwell) Method 1011B, modified
c. Electrical I

S/G 2 (40 Units)

a. Electrical I
b. 16 hrs, PTHB; Rated V_{CC} (15 psig, 100%RH, 121°C) Motorola test method
c. Electrical I

S/G 3 (30 Units)

a. Electrical I
b. Temp Cycling −100 cycles (−65°C/+150°C). Method 1010C
c. Electrical I
d. "Equivalent" Burn-In (40 hrs @ 145°C) per Method 1015 A or C
e. Electrical I

NOTES:

1. All tests per MIL-STD-883 unless stated otherwise.
2. Electrical I = DC @ 25°C and functional @ 25°C — Go/No/Go
3. 40 hr/145°C burn-in is "equivalent" to 160 hr/125°C burn-in using 1.0 eV activation energy and the Arrhenius equation for determining acceleration factor.
4. 16 hrs of PTHB testing is equivalent to approximately 800 hrs of standard 85°C/85% RH THB testing for $V_{CC} \leqslant 15$ V, based on comparative tests performed by Motorola Reliability Engineering.
5. For each evaluation, the goal is zero failures. Any indicated failure is first verified and then submitted to the Product Analysis Lab for detailed analysis. Results of evaluation, along with analysis of any failure(s), are reviewed promptly with responsible design, product, process and package engineers.

3.0 RELIABILITY AUDIT PROGRAM (RAP)
(per Motorola specification 12 MRM15301A)

3.1 PTHB — 15 psig/121°C/100% RH at rated V_{CC} for 16 hours — performed on a weekly basis — 0 rejects allowed out of 45 devices. (To be performed on plastic encapsulated devices only.) 48 hours read out included for reliability engineering information only.

3.2 Temp Cycling — MIL-STD-833, Method 1010, 1000 cycles, Condition C, −65°C/+150°C. Interim readout at 100 cycles (plastic and hermetic packages). Sample pulled on weekly basis — 0 rejects allowed out of 45 devices after 100 cycles; 1 reject allowed out of 45 devices after 1000 cycles.

3.3 Op. Life Test — MIL-STD-883, Method 1005, Condition A (Reverse Bias) or C (Power plus Reverse Bias), T_A = 145°C; readouts at 40 hrs and 250 hrs (plastic and hermetic packages). Sample pulled on weekly basis — 1 reject allowed out of 55 devices at 40 hr readout. No additional rejects allowed at 250 hrs. If no rejects at 40 hrs, 1 reject allowed at 250 hrs.

3.4 Report — Monthly Reliability Engineering computer printout summarizing test results.

NOTES:
1. All standard 25°C dc and functional parameters will be measured Go/No/Go at each readout.
2. Any indicated failure is first verified and then submitted to the Product Analysis Lab for detailed analysis.
3. If both plastic and hermetic packages are available, package type will be alternated weekly.
4. Device types sampled will be by generic type within each digital I/C product family (MDTL, MTTL, MTTL-LS, etc.) and will include all major package assembly options (U/S bond, TC bond, ball bond, T.A.B., etc.) and all assembly locations (Korea, Malaysia, etc.).
5. 16 hrs PTHB is equivalent to approximately 800 hrs of 85°C/85% RH THB for $V_{CC} \leqslant$ 15 V.
6. Only moisture related failures (like corrosion) are criteria for failure on PTHB test.
7. 40 hr/145°C Op Life is equivalent to 160 hr/125°C using 1.0 eV in Arrhenius equation.
8. 250 hrs/145°C Op Life is equivalent to 1000 hrs/125°C using 1.0 eV in Arrhenius equation.
9. Special device specifications (48A's) for digital products will reference 12MRM15301A as source of generic data for any customer required monthly audit reports.

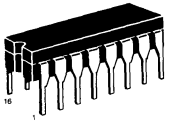
SCHOTTKY TTL

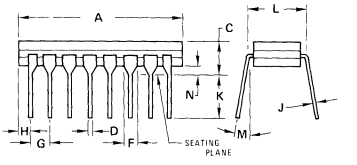
Package Outlines

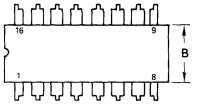
PACKAGE OUTLINES

CERAMIC DUAL IN-LINE

Case 620-08
16-Pin Ceramic Dual In-Line





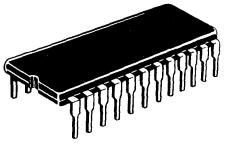


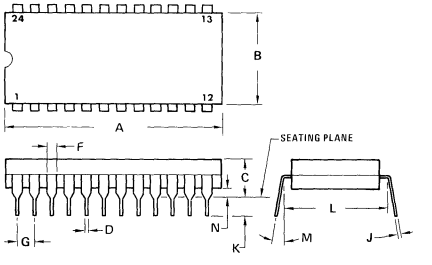
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	19.05	19.94	0.750	0.785
B	6.10	7.49	0.240	0.295
C	–	5.08	–	0.200
D	0.38	0.53	0.015	0.021
F	1.40	1.78	0.055	0.070
G	2.54 BSC		0.100 BSC	
H	0.51	1.14	0.020	0.045
J	0.20	0.30	0.008	0.012
K	3.18	4.32	0.125	0.170
L	7.62 BSC		0.300 BSC	
M	–	15°	–	15°
N	0.51	1.02	0.020	0.040

CASE 620-08

1. LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION
2. PACKAGE INDEX NOTCH IN LEAD NOTCH IN CERAMIC OR INK DOT
3. DIM "L" TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIM "A" AND "B" DO NOT INCLUDE GLASS RUN-OUT
5. DIM "F" MAY NARROW TO 0.76 mm (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY

Case 623-05
24-Pin Ceramic Dual In-Line



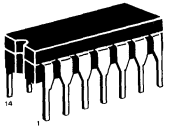


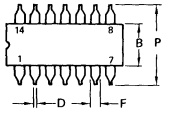
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	31.24	32.77	1.230	1.290
B	12.70	15.49	0.500	0.610
C	4.06	5.59	0.160	0.220
D	0.41	0.51	0.016	0.020
F	1.27	1.52	0.050	0.060
G	2.54 BSC		0.100 BSC	
J	0.20	0.30	0.008	0.012
K	3.18	4.06	0.125	0.160
L	15.24 BSC		0.600 BSC	
M	0°	15°	0°	15°
N	0.51	1.27	0.020	0.050

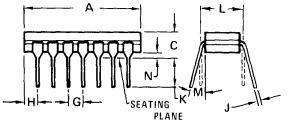
CASE 623-05

NOTES
1. DIM "L" TO CENTER OF LEADS WHEN FORMED PARALLEL
2. LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION. (WHEN FORMED PARALLEL).

Case 632-07
14-Pin Ceramic Dual In-Line







DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	19.05	19.94	0.750	0.785
B	6.10	7.49	0.240	0.295
C	–	5.08	–	0.200
D	0.38	0.58	0.015	0.023
F	1.40	1.77	0.055	0.070
G	2.54 BSC		0.100 BSC	
H	1.91	2.29	0.075	0.090
J	0.20	0.38	0.008	0.015
K	3.18	4.32	0.125	0.170
L	7.62 BSC		0.300 BSC	
M	–	15°	–	15°
N	0.51	1.02	0.020	0.040

CASE 632-07

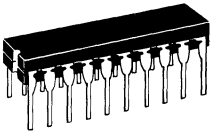
NOTES
1. ALL RULES AND NOTES ASSOCIATED WITH MO-001 AA OUTLINE SHALL APPLY
2. DIMENSION "L" TO CENTER OF LEADS WHEN FORMED PARALLEL
3. DIMENSION "A" AND "B" (632-07) DO NOT INCLUDE GLASS RUN-OUT
4. LEADS WITHIN 0.25 mm (0.010) DIA OF TRUE POSITION AT SEATING PLANE AND MAXIMUM MATERIAL CONDITION

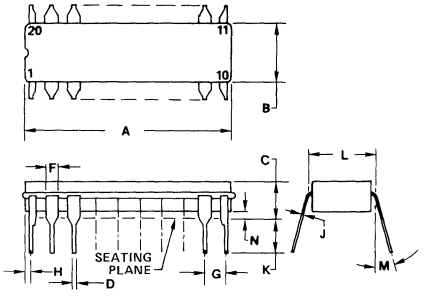
9

PACKAGE OUTLINES

CERAMIC DUAL IN-LINE (continued)

Case 732-03
20-Pin Ceramic Dual In-Line



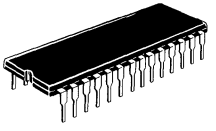


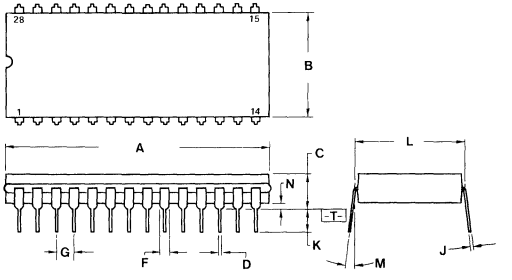
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	23.88	25.15	0.940	0.990
B	6.60	7.49	0.260	0.295
C	3.81	5.08	0.150	0.200
D	0.38	0.56	0.015	0.022
F	1.40	1.65	0.055	0.065
G	2.54 BSC		0.100 BSC	
H	0.51	1.27	0.020	0.050
J	0.20	0.30	0.008	0.012
K	3.18	4.06	0.125	0.160
L	7.62 BSC		0.300 BSC	
M	0°	15°	0°	15°
N	0.25	1.02	0.010	0.040

CASE 732-03

NOTES:
1. LEADS WITHIN 0.25 mm (0.010) DIA., TRUE POSITION AT SEATING PLANE, AT MAXIMUM MATERIAL CONDITION.
2. DIM L TO CENTER OF LEADS WHEN FORMED PARALLEL.
3. DIM A AND B INCLUDES MENISCUS.

Case 733-02
28-Pin Ceramic Dual In-Line



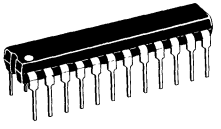


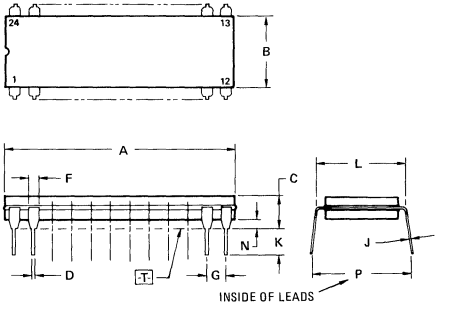
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	36.45	37.85	1.435	1.490
B	12.70	15.37	0.500	0.605
C	4.06	5.84	0.160	0.230
D	0.38	0.56	0.015	0.022
F	1.27	1.65	0.050	0.065
G	2.54 BSC		0.100 BSC	
J	0.20	0.30	0.008	0.012
K	2.54	4.06	0.100	0.160
L	15.24 BSC		0.600 BSC	
M	5°	15°	5°	15°
N	0.51	1.27	0.020	0.050

CASE 733-02

NOTES
1. DIM -A- IS DATUM.
2. POSITIONAL TOL FOR LEADS
   ⌖ | Ø 0.25 (0.010) Ⓜ | T | A Ⓜ
3. -T- IS SEATING PLANE
4. DIM A AND B INCLUDES MENISCUS.
5. DIM -L- TO CENTER OF LEADS WHEN FORMED PARALLEL
6. DIMENSIONING AND TOLERANCING PER ANSI Y14.5, 1973

Case 758-01
24-Pin Ceramic Dual In-Line





DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	31.50	32.64	1.240	1.285
B	7.24	7.75	0.285	0.305
C	3.68	4.44	0.145	0.175
D	0.38	0.53	0.015	0.021
F	1.14	1.57	0.045	0.062
G	2.54 BSC		0.100 BSC	
J	0.20	0.33	0.008	0.013
K	2.54	4.19	0.100	0.165
L	7.62	7.87	0.300	0.310
N	0.51	1.27	0.020	0.050
P	9.14	10.16	0.360	0.400

CASE 758-01

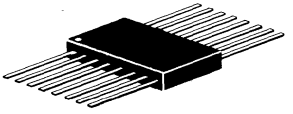
NOTES
1. DIMENSION A IS DATUM.
2. POSITIONAL TOLERANCE FOR LEADS 24 PLACES
   ⌖ | 0.25 (0.010) Ⓜ | T | A Ⓜ
3. -T- IS SEATING PLANE.
4. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL
5. DIMENSIONING AND TOLERANCING PER ANSI Y14.5, 1973.

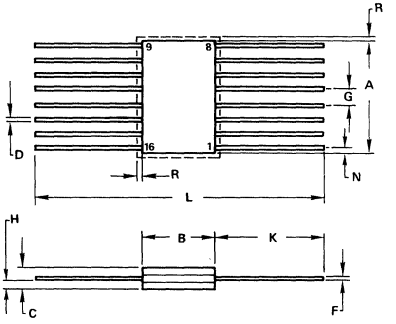
9

PACKAGE OUTLINES

CERAMIC FLATPAK

Case 650-03
16-Pin Ceramic Flatpak



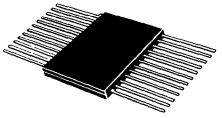


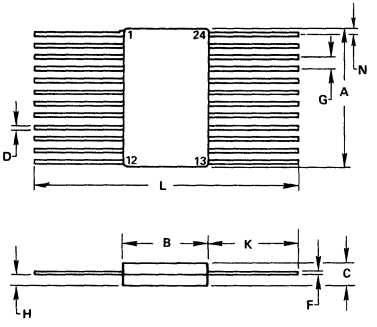
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	9.40	10.16	0.370	0.400
B	6.22	7.24	0.245	0.285
C	1.52	2.03	0.060	0.080
D	0.41	0.48	0.016	0.019
F	0.08	0.15	0.003	0.006
G	1.27 BSC		0.050 BSC	
H	0.64	0.89	0.025	0.035
K	6.35	9.40	0.250	0.370
L	18.92	–	0.745	–
N	–	0.51	–	0.020
R	–	0.38	–	0.015

CASE 650-03

NOTES:
1. LEAD NO. 1 IDENTIFIED BY TAB ON LEAD OR DOT ON COVER.
2. LEADS WITHIN 0.13 mm (0.005) TOTAL OF TRUE POSITION AT MAXIMUM MATERIAL CONDITION.

Case 652-02
24-Pin Ceramic Flatpak



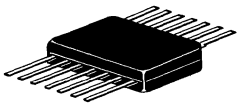


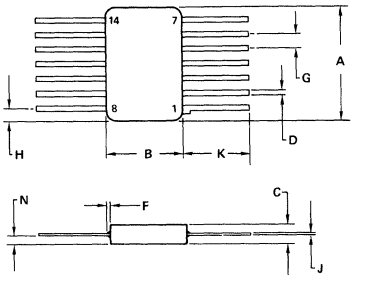
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	14.99	15.49	0.590	0.610
B	9.27	9.91	0.365	0.390
C	1.27	2.03	0.050	0.080
D	0.38	0.48	0.015	0.019
F	0.08	0.15	0.003	0.006
G	1.27 BSC		0.050 BSC	
H	0.69	1.02	0.027	0.040
K	6.35	9.40	0.250	0.370
L	21.97	–	0.865	–
N	0.25	0.63	0.010	0.025

CASE 652-02

NOTE:
1. LEADS WITHIN 0.25 mm (0.010) TOTAL OF TRUE POSITION AT MAXIMUM MATERIAL CONDITION.

Case 717-02
14-Pin Ceramic Flatpak





DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	–	9.91	–	0.390
B	–	6.73	–	0.265
C	–	2.03	0.060	0.080
D	0.38	0.48	0.015	0.019
F	–	0.25	–	0.010
G	1.27 BSC		0.050 BSC	
H	0.38	0.89	0.015	0.035
J	0.08	0.15	0.003	0.006
K	–	8.26	–	0.325
N	0.64	0.89	0.025	0.035

CASE 717-02

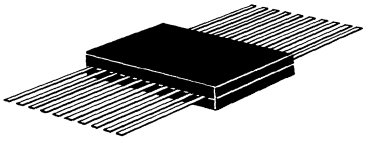
NOTES:
1. DIM "F" IS FOR GLASS OVERRUN.
2. LEADS, TRUE POSITIONED WITHIN 0.25 mm (0.010) DIA TO DIM "A" & "B" AT MAXIMUM MATERIAL CONDITION.

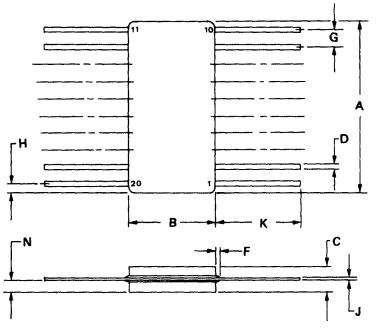
9

PACKAGE OUTLINES

CERAMIC FLATPAK (continued)

Case 737-02
20-Pin Ceramic Flatpak



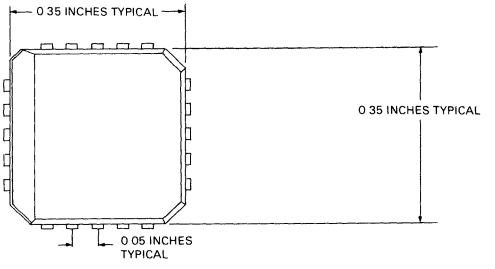


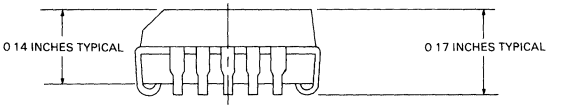
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	–	13.08	–	0.515
B	5.84	7.11	0.230	0.280
C	1.52	2.16	0.060	0.085
D	0.41	0.46	0.016	0.018
F	–	0.25	–	0.010
G	1.27 BSC		0.050 BSC	
H	1.14	1.40	0.045	0.055
J	0.08	0.13	0.003	0.005
K	–	9.14	–	0.360
N	–	1.02	–	0.040

CASE 737-02

NOTE.
1. LEADS WITHIN 0.25 mm (0.010) TOTAL OF TRUE POSITION AT MAXIMUM MATERIAL CONDITION.

QUAD PLASTIC CHIP CARRIER



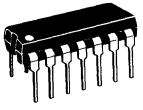


9

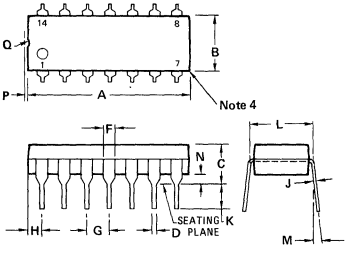
PACKAGE OUTLINES

PLASTIC

Case 646-05
14-Pin Plastic



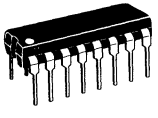
NOTES:
1. LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION.
2. DIMENSION "L" TO CENTER OF LEADS WHEN FORMED PARALLEL.
3. DIMENSION "B" DOES NOT INCLUDE MOLD FLASH.
4. ROUNDED CORNERS OPTIONAL.



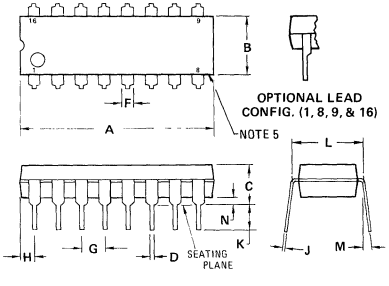
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	18.16	19.56	0.715	0.770
B	6.10	6.60	0.240	0.260
C	4.06	5.08	0.160	0.200
D	0.38	0.53	0.015	0.021
F	1.02	1.78	0.040	0.070
G	2.54 BSC		0.100 BSC	
H	1.32	2.41	0.052	0.095
J	0.20	0.38	0.008	0.015
K	2.92	3.43	0.115	0.135
L	7.62 BSC		0.300 BSC	
M	0°	10°	0°	10°
N	0.51	1.02	0.020	0.040

CASE 646-05

Case 648-05
16-Pin Plastic



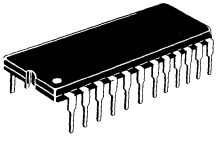
NOTES:
1. LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION.
2. DIMENSION "L" TO CENTER OF LEADS WHEN FORMED PARALLEL.
3. DIMENSION "B" DOES NOT INCLUDE MOLD FLASH.
4. "F" DIMENSION IS FOR FULL LEADS. "HALF" LEADS ARE OPTIONAL AT LEAD POSITIONS 1, 8, 9, and 16).
5. ROUNDED CORNERS OPTIONAL.



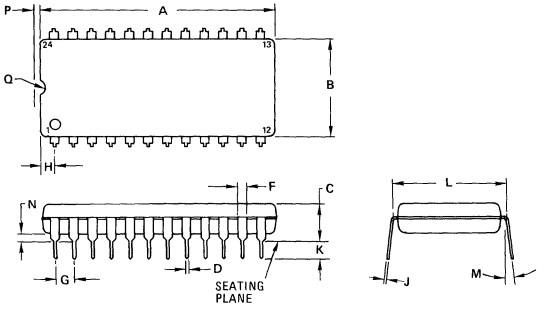
DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	18.80	21.34	0.740	0.840
B	6.10	6.60	0.240	0.260
C	4.06	5.08	0.160	0.200
D	0.38	0.53	0.015	0.021
F	1.02	1.78	0.040	0.070
G	2.54 BSC		0.100 BSC	
H	0.38	2.41	0.015	0.095
J	0.20	0.38	0.008	0.015
K	2.92	3.43	0.115	0.135
L	7.62 BSC		0.300 BSC	
M	0°	10°	0°	10°
N	0.51	1.02	0.020	0.040

CASE 648-05

Case 649-03
24-Pin Plastic



NOTES:
1. LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION.
2. DIMENSION "L" TO CENTER OF LEADS WHEN FORMED PARALLEL.



DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	31.50	32.13	1.240	1.265
B	13.21	13.72	0.520	0.540
C	4.70	5.21	0.185	0.205
D	0.38	0.51	0.015	0.020
F	1.02	1.52	0.040	0.060
G	2.54 BSC		0.100 BSC	
H	1.65	2.16	0.065	0.085
J	0.20	0.30	0.008	0.012
K	2.92	3.43	0.115	0.135
L	14.99	15.49	0.590	0.610
M	–	10°	–	10°
N	0.51	1.02	0.020	0.040
P	0.13	0.38	0.005	0.015
Q	0.51	0.76	0.020	0.030

CASE 649-03

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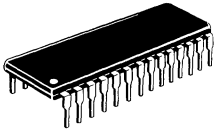
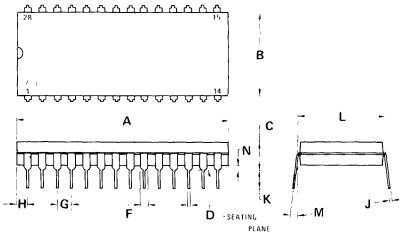
PACKAGE OUTLINES

PLASTIC (continued)

Case 710-02
28-Pin Plastic



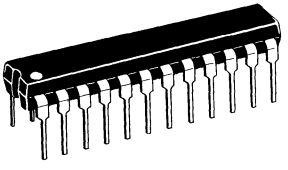


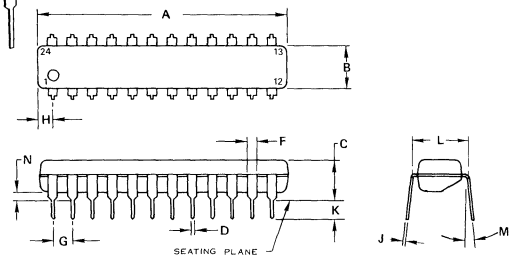
DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	36.45	37.21	1.435	1.465
B	13.72	14.22	0.540	0.560
C	3.94	5.08	0.155	0.200
D	0.36	0.56	0.014	0.022
F	1.02	1.52	0.040	0.060
G	2.54 BSC		0.100 BSC	
H	1.65	2.16	0.065	0.085
J	0.20	0.38	0.008	0.015
K	2.92	3.43	0.115	0.135
L	15.24 BSC		0.600 BSC	
M	0°	15°	0°	15°
N	0.51	1.02	0.020	0.040

CASE 710-02

NOTES:
1. POSITIONAL TOLERANCE OF LEADS (D), SHALL BE WITHIN 0.25mm(0.010) AT MAXIMUM MATERIAL CONDITION, IN RELATION TO SEATING PLANE AND EACH OTHER.
2. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
3. DIMENSION B DOES NOT INCLUDE MOLD FLASH.

Case 724-02
24-Pin Plastic



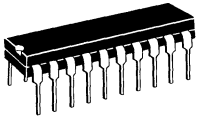


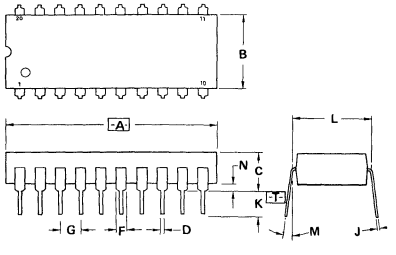
DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	31.24	32.13	1.230	1.265
B	6.35	6.86	0.250	0.270
C	4.06	4.57	0.160	0.180
D	0.38	0.51	0.015	0.020
F	1.02	1.52	0.040	0.060
G	2.54 BSC		0.100 BSC	
H	1.60	2.11	0.063	0.083
J	0.18	0.30	0.007	0.012
K	2.92	3.43	0.115	0.135
L	7.37	7.87	0.290	0.310
M	–	10°	–	10°
N	0.51	1.02	0.020	0.040

CASE 724-02

NOTE
1. LEADS, TRUE POSITIONED WITHIN 0.25 mm (0.010) DIA AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION (DIM D)

Case 738-01
20-Pin Plastic





DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	25.65	27.18	1.010	1.070
B	6.10	6.60	0.240	0.260
C	3.94	4.19	0.155	0.165
D	0.38	0.56	0.015	0.022
F	1.27	1.78	0.050	0.070
G	2.54 BSC		0.100 BSC	
J	0.20	0.38	0.008	0.015
K	2.79	3.56	0.110	0.140
L	7.62 BSC		0.300 BSC	
M	0°	15°	0°	15°
N	0.51	1.02	0.020	0.040

CASE 738-01

NOTES:
1. DIM -A- IS DATUM.
2. POSITIONAL TOL FOR LEADS,
   ⌖ | Ø 0.25 (0.010) Ⓜ | T | A Ⓜ |
3. -T- IS SEATING PLANE.
4. DIM "B" DOES NOT INCLUDE MOLD FLASH.
5. DIM -L- TO CENTER OF LEADS WHEN FORMED PARALLEL.
6. DIMENSIONING AND TOLERANCING PER ANSI Y14.5, 1973.

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SCHOTTKY TTL

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